

DSP

DIGITAL SIGNAL  
PROCESSING

DATABOOK

1993



**HARRIS**  
SEMICONDUCTOR





## **HARRIS SEMICONDUCTOR DSP PRODUCTS**

This Digital Signal Processing databook represents the full line of Harris Semiconductor DSP products for commercial and military applications and supersedes previously published DSP material under the Harris, GE, RCA or Intersil names. For a complete listing of all Harris Semiconductor products, please refer to the Product Selection Guide (PSG-201S; ordering information below.)

For complete, current and detailed technical specifications on any Harris devices please contact the nearest Harris sales, representative or distributor office; or direct literature requests to:

**Harris Semiconductor Literature Department**  
**P.O. Box 883, MS CB1-25**  
**Melbourne, FL 32901**  
**FAX 407-724-3937**

### **U.S. HEADQUARTERS**

Harris Semiconductor  
1301 Woody Burke Road  
Melbourne, Florida 32902  
TEL: (407) 724-3000

### **EUROPEAN HEADQUARTERS**

Harris Semiconductor  
Mercure Centre  
100, Rue de la Fusee  
1130 Brussels, Belgium  
TEL: (32) 2-246-21.11

### **SOUTH ASIA**

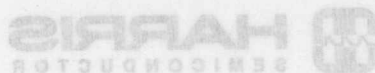
Harris Semiconductor H.K. Ltd  
13/F Fourseas Building  
208-212 Nathan Road  
Tsimshatsui, Kowloon  
Hong Kong  
TEL: (852) 723-6339

### **NORTH ASIA**

Harris K.K.  
Shinjuku NS Bldg. Box 6153  
2-4-1 Nishi-Shinjuku  
Shinjuku-ku, Tokyo 163 Japan  
TEL: 81-3-3345-8911

See our  
specs in **CAPS**

Copyright © Harris Corporation 1992  
(All Rights Reserved)  
Printed in USA, 9/1992



## HARRIS SEMICONDUCTOR DSP PRODUCTS

This Digital Signal Processing databook represents the full line of Harris Semiconductor DSP products for commercial and military applications and supersedes previously published DSP material under the Harris, GE, RCA or Intel names. For a complete listing of all Harris Semiconductor products, please refer to the Product Selection Guide (PSG-2012; ordering information below).

For complete, current and detailed technical specifications on any Harris devices please contact the nearest Harris sales, representative or distributor office; or direct literature requests to:

Harris Semiconductor Literature Department  
P.O. Box 883, MS CB-25  
Melbourne, FL 32901  
FAX 407-724-3837

EUROPEAN HEADQUARTERS  
Harris Semiconductor  
Metorex Center  
100, Rue de la Fosse  
1120 Brussels, Belgium  
TEL: (32) 2-245-2111

U.S. HEADQUARTERS  
Harris Semiconductor  
1301 Woody Buks Road  
Melbourne, Florida 32902  
TEL: (407) 724-3000

*Harris Semiconductor products are sold by description only. All specifications in this product guide are applicable only to packaged products; specifications for die are available upon request. Harris reserves the right to make changes in circuit design, specifications and other information at any time without prior notice. Accordingly, the reader is cautioned to verify that information in this publication is current before placing orders. Reference to products of other manufacturers are solely for convenience of comparison and do not imply total equivalency of design, performance, or otherwise.*

TEL: (888) 724-6339



Copyright © Harris Corporation 1992  
(All Rights Reserved)  
Printed in USA 9/1992

# DIGITAL SIGNAL PROCESSING

## FOR COMMERCIAL AND MILITARY APPLICATIONS

### General Information 1

### Multipliers 2

### One Dimensional Filters 3

### Two Dimensional Filters 4

### Signal Synthesizers 5

### Special Function 6

### Development Tools 7

### Application Notes 8

### Quality and Reliability 9

### Packaging and Ordering Information 10

### Sales Offices 11



## DIGITAL SIGNAL PROCESSING PRODUCT TECHNICAL ASSISTANCE

For technical assistance on the Harris products listed in this databook, please contact Field Applications Engineering staff available at one of the following Harris Sales Offices:

### UNITED STATES

CALIFORNIA	Woodland Hills . . . . .	818-992-0686
	San Jose . . . . .	408-922-0977
FLORIDA	Melbourne . . . . .	407-724-3576
GEORGIA	Duluth . . . . .	404-476-2034
ILLINOIS	Schaumburg . . . . .	708-240-3499
NEW JERSEY	Mt. Laurel . . . . .	609-727-1909
NEW YORK	Great Neck . . . . .	516-824-9441

### INTERNATIONAL

FRANCE	Paris . . . . .	33-1-346-54090
GERMANY	Munich . . . . .	49-8-963-813-117
HONG KONG	Kowloon . . . . .	852-723-6339
ITALY	Milano . . . . .	39-2-262-0761
JAPAN	Tokyo . . . . .	81-3-345-8911
KOREA	Seoul . . . . .	82-2-551-0931
U.K.	Camberley . . . . .	44-2-766-86886

# DSP

# 1

## GENERAL INFORMATION

### ALPHA NUMERIC PRODUCT INDEX

		PAGE
DECI • MATE™	Harris HSP43220 Decimating Digital Filter Development Software	7-3
HMA510	16 x 16-Bit CMOS Parallel Multiplier Accumulator	2-3
HMA510/883	16 x 16-Bit CMOS Parallel Multiplier Accumulator	2-10
HMU16/HMU17	16 x 16-Bit CMOS Parallel Multipliers	2-15
HMU16/883	16 x 16-Bit CMOS Parallel Multiplier	2-25
HMU17/883	16 x 16-Bit CMOS Parallel Multiplier	2-31
HSP-EVAL	DSP Evaluation Platform <b>NEW PRODUCT</b>	7-7
HSP43168	Dual FIR Filter <b>NEW PRODUCT</b>	3-3
HSP43168/883	Dual FIR Filter <b>NEW PRODUCT</b>	3-19
HSP43216	Halfband Filter <b>NEW PRODUCT</b>	3-116
HSP43220	Decimating Digital Filter	3-27
HSP43220/883	Decimating Digital Filter	3-47
HSP43481	Digital Filter	3-54
HSP43481/883	Digital Filter	3-69
HSP43881	Digital Filter	3-74
HSP43881/883	Digital Filter	3-89
HSP43891	Digital Filter	3-95
HSP43891/883	Digital Filter	3-110
HSP45102	12 Bit Numerically Controlled Oscillator	5-3
HSP45106	16 Bit Numerically Controlled Oscillator	5-10
HSP45106/883	16 Bit Numerically Controlled Oscillator	5-20
HSP45116	Numerically Controlled Oscillator/Modulator	5-26
HSP45116/883	Numerically Controlled Oscillator/Modulator	5-41
HSP45116-DB	HSP45116 Daughter Board <b>NEW PRODUCT</b>	7-8
HSP45240	Address Sequencer	6-3
HSP45240/883	Address Sequencer	6-15
HSP45256	Binary Correlator <b>NEW PRODUCT</b>	6-21
HSP45256/883	Binary Correlator <b>NEW PRODUCT</b>	6-34
HSP48410	Histogrammer/Accumulating Buffer <b>NEW PRODUCT</b>	6-42
HSP48901	3 x 3 Image Filter	4-3
HSP48908	Two Dimensional Convolver	4-12
HSP48908/833	Two Dimensional Convolver	4-28
HSP50016	Digital Down Converter <b>NEW PRODUCT</b>	5-48
HSP9501	Programmable Data Buffer	6-53
HSP9520/9521	Multilevel Pipeline Register	6-60
ISP9520/9521		

DECI • MATE™ is a Trademark of Harris Corporation

## PRODUCT INDEX BY FAMILY

### MULTIPLIERS

		PAGE
HMA510	16 x 16-Bit CMOS Parallel Multiplier Accumulator .....	2-3
HMA510/883	16 x 16-Bit CMOS Parallel Multiplier Accumulator .....	2-10
HMU16/HMU17	16 x 16-Bit CMOS Parallel Multipliers .....	2-15
HMU16/883	16 x 16-Bit CMOS Parallel Multiplier .....	2-25
HMU17/883	16 x 16-Bit CMOS Parallel Multiplier .....	2-31

### ONE DIMENSIONAL FILTERS

HSP43168	Dual FIR Filter <b>NEW PRODUCT</b> .....	3-3
HSP43168/883	Dual FIR Filter <b>NEW PRODUCT</b> .....	3-19
HSP43216	Halfband Filter <b>NEW PRODUCT</b> .....	3-116
HSP43220	Decimating Digital Filter .....	3-27
HSP43220/883	Decimating Digital Filter .....	3-47
HSP43481	Digital Filter .....	3-54
HSP43481/883	Digital Filter .....	3-69
HSP43881	Digital Filter .....	3-74
HSP43881/883	Digital Filter .....	3-89
HSP43891	Digital Filter .....	3-95
HSP43891/883	Digital Filter .....	3-110

### TWO DIMENSIONAL FILTERS

HSP48901	3 x 3 Image Filter .....	4-3
HSP48908	Two Dimensional Convolver .....	4-12
HSP48908/833	Two Dimensional Convolver .....	4-28

### SIGNAL SYNTHESIZERS

HSP45102	12 Bit Numerically Controlled Oscillator .....	5-3
HSP45106	16 Bit Numerically Controlled Oscillator .....	5-10
HSP45106/883	16 Bit Numerically Controlled Oscillator .....	5-20
HSP45116	Numerically Controlled Oscillator/Modulator .....	5-26
HSP45116/883	Numerically Controlled Oscillator/Modulator .....	5-41
HSP50016	Digital Down Converter <b>NEW PRODUCT</b> .....	5-48

### SPECIAL FUNCTION

HSP45240	Address Sequencer .....	6-3
HSP45240/883	Address Sequencer .....	6-15
HSP45256	Binary Correlator <b>NEW PRODUCT</b> .....	6-21
HSP45256/883	Binary Correlator <b>NEW PRODUCT</b> .....	6-34
HSP48410	Histogrammer/Accumulating Buffer <b>NEW PRODUCT</b> .....	6-42
HSP9501	Programmable Data Buffer .....	6-53
HSP9520/9521	Multilevel Pipeline Register .....	6-60
ISP9520/9521		

### DEVELOPMENT TOOLS

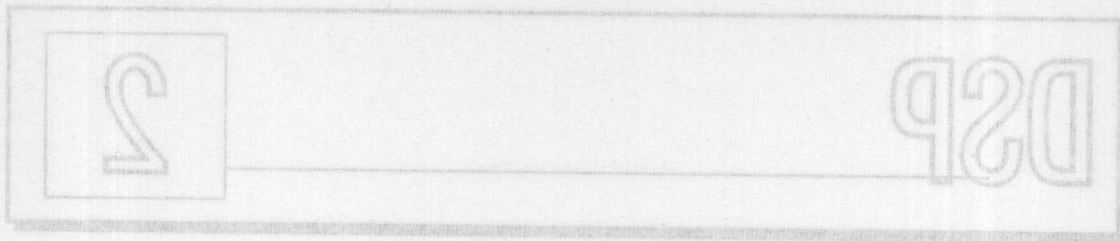
DECI • MATE	Harris HSP43220 Decimating Digital Filter Development Software .....	7-3
HSP-EVAL	DSP Evaluation Platform <b>NEW PRODUCT</b> .....	7-7
HSP45116-DB	HSP45116 Daughter Board <b>NEW PRODUCT</b> .....	7-8

/883 Data Sheet Format - In the interests of conserving space, data sheets for /883 qualified products have been printed without the Pinouts, Pin Description, Waveforms, AC Test Load Circuit and Design Information sections. The information in these sections can be obtained from the corresponding portion of the commercial data sheet.



## MULTIPLIERS

DATA SHEETS		PAGE
HMA510	16 x 16-Bit CMOS Parallel Multiplier Accumulator .....	2-3
HMA510/883	16 x 16-Bit CMOS Parallel Multiplier Accumulator .....	2-10
HMU16/HMU17	16 x 16-Bit CMOS Parallel Multipliers .....	2-15
HMU16/883	16 x 16-Bit CMOS Parallel Multiplier .....	2-25
HMU17/883	16 x 16-Bit CMOS Parallel Multiplier .....	2-31



# MULTIPLIERS

PAGE

## DATA SHEETS

HMU17V83	16 x 16-Bit CMOS Parallel Multiplier	2-31
HMU18V83	16 x 16-Bit CMOS Parallel Multiplier	2-32
HMU18VHMU17	16 x 16-Bit CMOS Parallel Multiplier	2-15
HMA210V83	16 x 16-Bit CMOS Parallel Multiplier Accumulator	2-10
HMA210	16 x 16-Bit CMOS Parallel Multiplier Accumulator	2-9

DATA SHEETS

## 16 x 16-Bit CMOS Parallel Multiplier Accumulator

August 1992

### Features

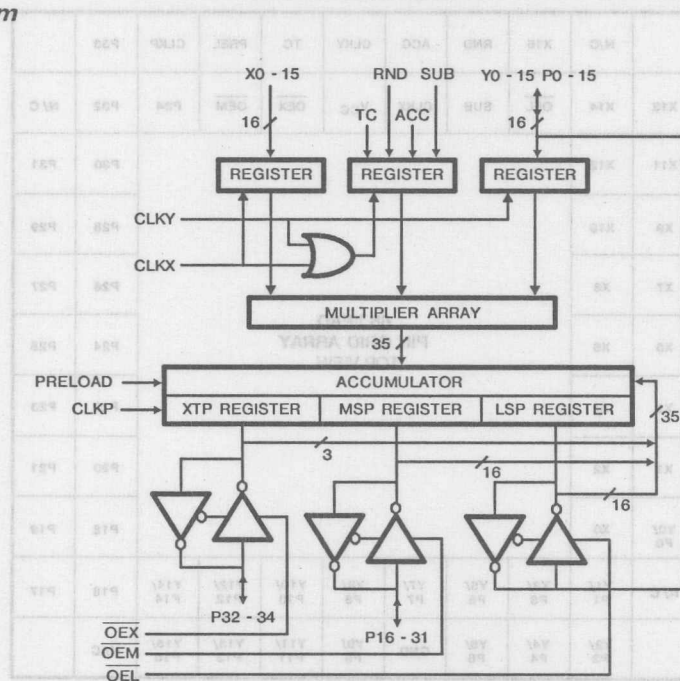
- 16 x 16-bit Parallel Multiplication with Accumulation to a 35-Bit Result
- High-Speed (45ns) Multiply Accumulate Time
- Low Power CMOS Operation:
  - ICCSB = 500 $\mu$ A Maximum
  - ICCOP = 7.0mA Maximum @ 1.0MHz
- HMA510 is Compatible with the CY7C510 and the IDT7210
- Supports Two's Complement or Unsigned Magnitude Operations
- TTL Compatible Inputs/Outputs
- Three-State Outputs
- Available in 68 Pin Plastic Leaded Chip Carrier (PLCC) and 68 Lead Pin Grid Array (PGA)

### Description

The HMA510 is a high speed, low power CMOS 16 x 16-bit parallel multiplier accumulator capable of operating at 45ns clocked multiply-accumulate cycles. The 16-bit X and Y operands may be specified as either two's complement or unsigned magnitude format. Additional inputs are provided for the accumulator functions which include: loading the accumulator with the current product, adding or subtracting the accumulator contents and the current product, and preloading the accumulator registers from the external inputs.

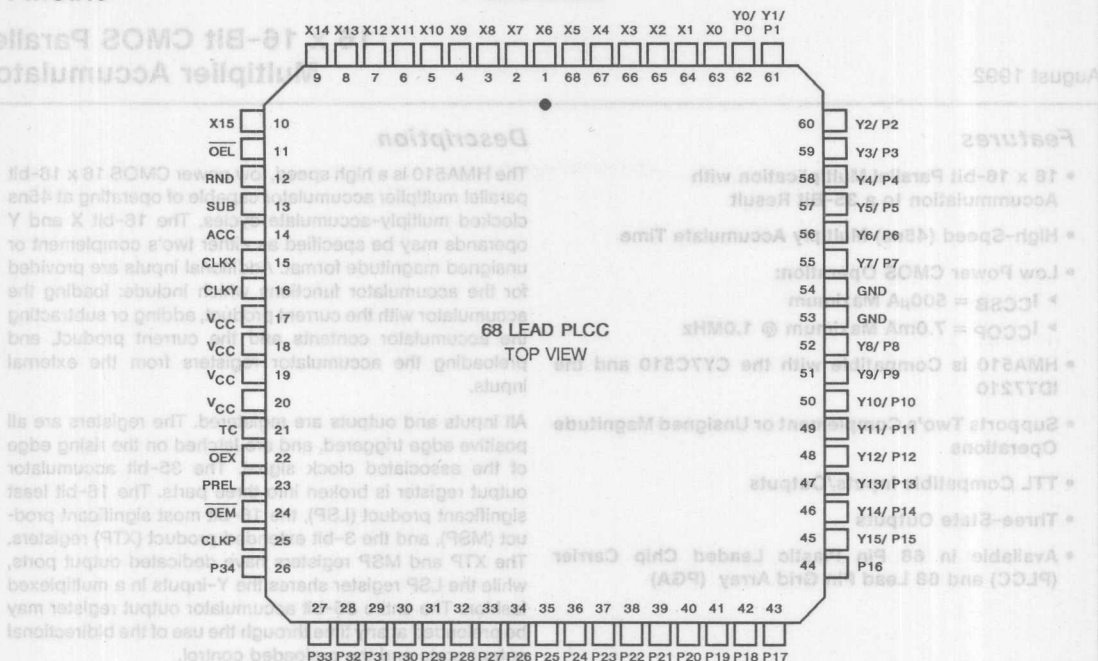
All inputs and outputs are registered. The registers are all positive edge triggered, and are latched on the rising edge of the associated clock signal. The 35-bit accumulator output register is broken into three parts. The 16-bit least significant product (LSP), the 16-bit most significant product (MSP), and the 3-bit extended product (XTP) registers. The XTP and MSP registers have dedicated output ports, while the LSP register shares the Y-inputs in a multiplexed fashion. The entire 35-bit accumulator output register may be preloaded at any time through the use of the bidirectional output ports and the preloaded control.

### Block Diagram

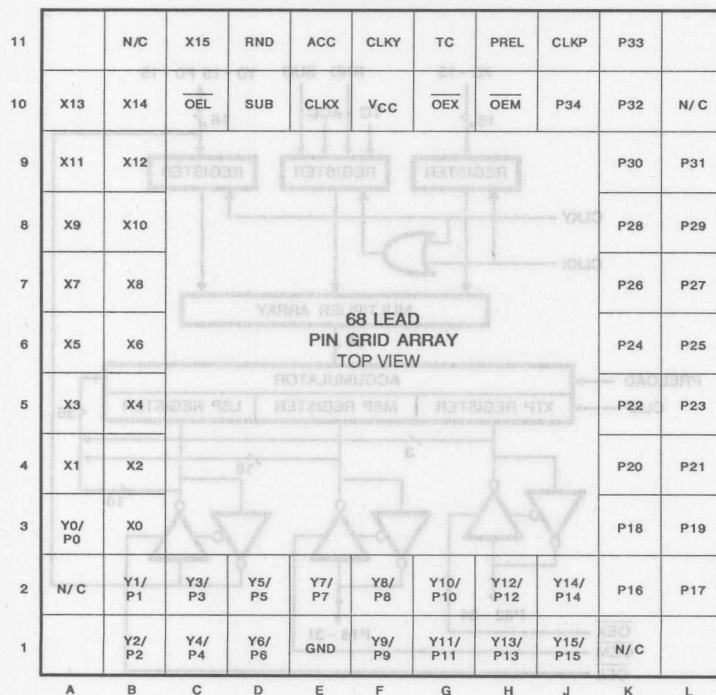




## HMA510 PLCC



## HMA510 CERAMIC PGA



## Pin Descriptions

NAME	PLCC PIN NUMBER	TYPE	DESCRIPTION
V <sub>CC</sub>	17-20		The +5V power supply pins. 0.1µF capacitors between the V <sub>CC</sub> and GND pins are recommended.
GND	53,54		The device ground.
X0-X15	1-10, 63-68	I	X-Input Data. These 16 data inputs provide the multiplicand which may be in two's complement or unsigned magnitude format.
Y0-Y15/ P0-P15	45-52, 55-62	I/O	Y-Input/LSP Output Data. This 16-bit port is used to provide the multiplier which may be in two's complement or unsigned magnitude format. It may also be used for output of the Least Significant Product (P0-P15) or for preloading the LSP register.
P16-P3	29-44	I/O	MSP Output Data. This 16-Bit port is used to provide the Most Significant Product Output (P16-P31). It may also be used to preload the MSP register.
P32-P34	26-28	I/O	XTP Output Data. This 3-Bit port is used to provide the Extended Product Output (P32-P34). It may also be used to preload the XTP register.
TC	21	I	Two's Complement Control. Input data is interpreted as two's complement when this control is HIGH. A LOW indicates the data is to be interpreted as unsigned magnitude format. This control is latched on the rising edge of CLKX or CLKY.
ACC	14	I	Accumulate Control. When this control is HIGH, the accumulator output register contents are added to or subtracted from the current product, and the result is stored back into the accumulator output register.  When LOW, the product is loaded into the accumulator output register overwriting the current contents. This control is also latched on the rising edge of CLKX or CLKY.
SUB	13	I	Subtract Control. When both SUB and ACC are HIGH, the accumulator register contents are subtracted from the current product. When ACC is HIGH and SUB is LOW, the accumulator register contents and the current product are summed. The SUB control input is latched on the rising edge of CLKX or CLKY.
RND	12	I	Round Control. When this control is HIGH, a one is added to the most significant bit of the LSP. When LOW, the product is unchanged.
PREL	23	I	Preload Control. When this control is HIGH, the three bidirectional ports may be used to preload the accumulator registers. The three-state controls (OEX, OEM, OEL) must be HIGH, and the data will be preloaded on the rising edge of CLKP. When this control is LOW, the accumulator registers function in a normal manner.
OEL	11	I	Y-Input/LSP Output Port Three-state Control. When OEL is HIGH, the output drivers are in the high impedance state. This state is required for Y-data input or preloading the LSP register. When OEL is LOW, the port is enabled for LSP output.
OEM	24	I	MSP Output Port Three-state Control. A LOW on this control line enables the port for output. When OEM is HIGH, the output drivers are in the high impedance state. This control must be HIGH for preloading the MSP register.
OEX	22	I	XTP Output Port Three-state Control. A LOW on this control line enables the port for output. When OEX is HIGH, the output drivers are in the high impedance state. This control must be HIGH for preloading the XTP register.
CLKX	15	I	X-Register Clock. The rising edge of this clock latches the X-data input register along with the TC, ACC, SUB and RND inputs.
CLKY	16	I	Y-Register Clock. The rising edge of this clock latches the Y-data input register along with the TC, ACC, SUB and RND inputs.
CLKP	25	I	Product Register Clock. The rising edge of CLKP latches the LSP, MSP and XTP registers. If the preload control is active, the data on the I/O ports is loaded into these registers. If preload is not active, the accumulated product is loaded into the registers.

## Functional Description

The HMA510 is a high speed 16 x 16-bit multiplier accumulator (MAC). It consists of a 16-bit parallel multiplier followed by a 35-bit accumulator. All inputs and outputs are registered and are latched on the rising edge of the associated clock signal. The HMA510 is divided into four sections: the input section, the multiplier array, the accumulator and the output/preload section.

The input section has two 16-bit operand input registers for the X and Y operands which are latched on the rising edge of CLKX and CLKY respectively. A four bit control register (TC, RND, ACC, SUB) is also included and is latched from either of the input clock signals.

The 16 x 16 multiplier array produces the 32-bit product of the input operands. Two's complement or unsigned magnitude operation can be selected by the use of the TC control. The 32-bit result may also be rounded through the use of the RND control. In this case, a '1' is added to the MSB of the LSP (bit P15). The 32-bit product is zero-filled or sign-extended as appropriate and passed as a 35-bit number to the accumulator section.

The accumulator functions are controlled by the ACC, SUB and PREL control inputs. Four functions may be selected: the accumulator may be loaded with the current product; the product may be added to the accumulator contents; the accumulator contents may be subtracted from the current product; or the accumulator may be loaded from the bidirectional ports. The accumulator registers are updated at the rising edge of the CLKP signal.

The output/preload section contains the accumulator/output register and the bidirectional ports. This section is controlled by the signals PREL,  $\overline{\text{OEX}}$ ,  $\overline{\text{OEM}}$  and  $\overline{\text{OEL}}$ . When PREL is high, the output buffers are in a high impedance state. When one of the controls  $\overline{\text{OEX}}$ ,  $\overline{\text{OEM}}$  or  $\overline{\text{OEL}}$  are also high, data present at the outputs will be preloaded into the associated register on the rising edge of CLKP. When PREL is low, the signals  $\overline{\text{OEX}}$ ,  $\overline{\text{OEM}}$  and  $\overline{\text{OEL}}$  are enable controls for their respective three-state output ports.

### PRELOAD FUNCTION TABLE

PREL	$\overline{\text{OEX}}$	$\overline{\text{OEM}}$	$\overline{\text{OEL}}$	OUTPUT REGISTERS		
				XTP	MSP	LSP
0	0	0	0	Q	Q	Q
0	0	0	1	Q	Q	Z
0	0	1	0	Q	Z	Q
0	0	1	1	Q	Z	Z
0	1	0	0	Z	Q	Q
0	1	0	1	Z	Q	Z
0	1	1	0	Z	Z	Q
0	1	1	1	Z	Z	Z
1	0	0	0	Z	Z	Z
1	0	0	1	Z	Z	PL
1	0	1	0	Z	PL	Z
1	0	1	1	Z	PL	PL
1	1	0	0	PL	Z	Z
1	1	0	1	PL	Z	PL
1	1	1	0	PL	PL	Z
1	1	1	1	PL	PL	PL

Z = Output Buffers at High Impedance (Disabled).

Q = Output Buffers at LOW Impedance. Contents of Output Register Available Through Output Ports.

PL = Output disabled. Preload data supplied to the output pins will be loaded into the register at the rising edge of CLKP.

### ACCUMULATOR FUNCTION TABLE

PREL	ACC	SUB	P	OPERATION
L	L	X	Q	Load
L	H	L	Q	Add
L	H	H	Q	Subtract
H	X	X	PL	Preload



## INPUT FORMATS

## Fractional Two's Complement Input

X	Y
15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0	15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0
-20 2-1 2-2 2-3 2-4 2-5 2-6 2-7 2-8 2-9 2-10 2-11 2-12 2-13 2-14 2-15	-20 2-1 2-2 2-3 2-4 2-5 2-6 2-7 2-8 2-9 2-10 2-11 2-12 2-13 2-14 2-15
(Sign)	(Sign)

## Integer Two's Complement Input

X	Y
15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0	15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0
-215 214 213 212 211 210 29 28 27 26 25 24 23 22 21 20	-215 214 213 212 211 210 29 28 27 26 25 24 23 22 21 20
(Sign)	(Sign)

## Unsigned Fractional Input

X	Y
15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0	15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0
2-1 2-2 2-3 2-4 2-5 2-6 2-7 2-8 2-9 2-10 2-11 2-12 2-13 2-14 2-15 2-16	2-1 2-2 2-3 2-4 2-5 2-6 2-7 2-8 2-9 2-10 2-11 2-12 2-13 2-14 2-15 2-16

## Unsigned Integer Input

X	Y
15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0	15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0
215 214 213 212 211 210 29 28 27 26 25 24 23 22 21 20	215 214 213 212 211 210 29 28 27 26 25 24 23 22 21 20

## OUTPUT FORMATS

## Two's Complement Fractional Output

XTP	MSP	LSP
34 33 32	31 30 29 28 27 26 25 24 23 22 21 20 19 18 17 16	15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0
-24 23 22	21 20 2-1 2-2 2-3 2-4 2-5 2-6 2-7 2-8 2-9 2-10 2-11 2-12 2-13 2-14	2-15 2-16 2-17 2-18 2-19 2-20 2-21 2-22 2-23 2-24 2-25 2-26 2-27 2-28 2-29 2-30
(Sign)		

## Two's Complement Integer Output

XTP	MSP	LSP
34 33 32	31 30 29 28 27 26 25 24 23 22 21 20 19 18 17 16	15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0
-234 233 232	231 230 229 228 227 226 225 224 223 222 221 220 219 218 217 216	215 214 213 212 211 210 29 28 27 26 25 24 23 22 21 20
(Sign)		

## Unsigned Fractional Output

XTP	MSP	LSP
34 33 32	31 30 29 28 27 26 25 24 23 22 21 20 19 18 17 16	15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0
22 21 20	2-1 2-2 2-3 2-4 2-5 2-6 2-7 2-8 2-9 2-10 2-11 2-12 2-13 2-14 2-15 2-16	2-17 2-18 2-19 2-20 2-21 2-22 2-23 2-24 2-25 2-26 2-27 2-28 2-29 2-30 2-31 2-32

## Unsigned Integer Output

XTP	MSP	LSP
34 33 32	31 30 29 28 27 26 25 24 23 22 21 20 19 18 17 16	15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0
234 233 232	231 230 229 228 227 226 225 224 223 222 221 220 219 218 217 216	215 214 213 212 211 210 29 28 27 26 25 24 23 22 21 20

## Open

Operating Voltage Range ..... +4.75V to +5.25V  
Operating Temperature Range ..... 0°C to +70°C

$\theta_{ja}$ .....	43.2°C/W (PLCC), 42.69°C/W (PGA)
$\theta_{jc}$ .....	15.1°C/W (PLCC), 10.0°C/W (PGA)
Maximum Package Power Dissipation at 70°C .....	1.7W (PLCC) 2.46/W (PGA)

0C to +70°C)

5 pF

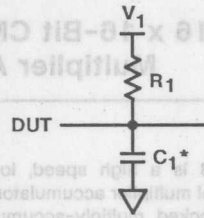
2. Not tested, but characterized at initial design and at major process/design changes.

--	--

2. For A.C. Test load, refer to A.C. Test Circuit with  $V_1 = 2.4V$ ,  $R_1 = 500\Omega$  and  $C_1 = 40pF$ .

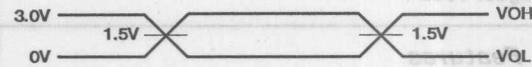
2-8

## A.C. Test Circuit



\*Includes Stray and Jig Capacitance

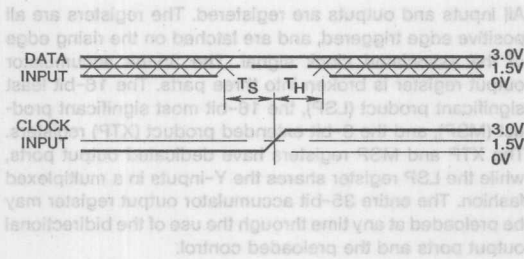
## A.C. Testing Input, Output Waveforms



A.C. Testing: All Parameters tested as per test circuit.  
Input rise and fall times are driven at 1ns/V.

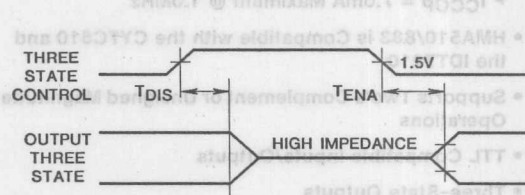
## Timing Diagram

## SET-UP AND HOLD TIME

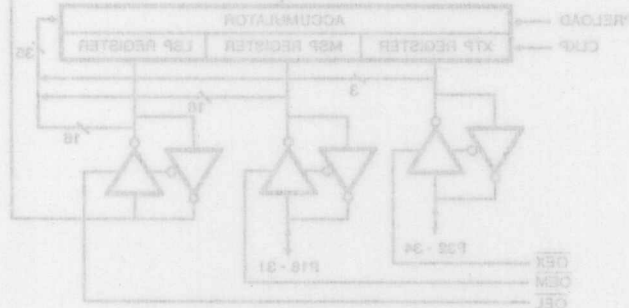
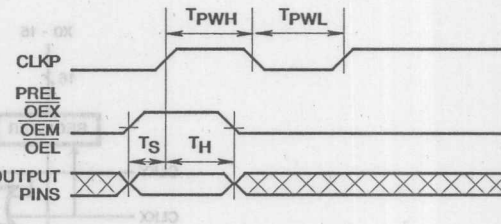
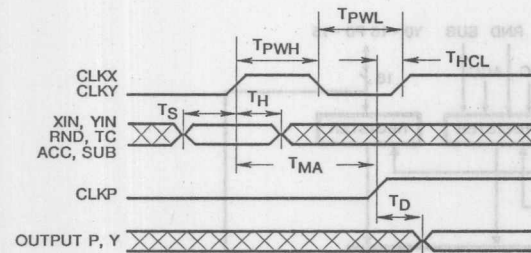


HMA510 TIMING DIAGRAM

## THREE STATE CONTROL



PRELOAD TIMING DIAGRAM



**HARRIS**

# HMA510/883

## 16 x 16-Bit CMOS Parallel Multiplier Accumulator

August 1992

### Features

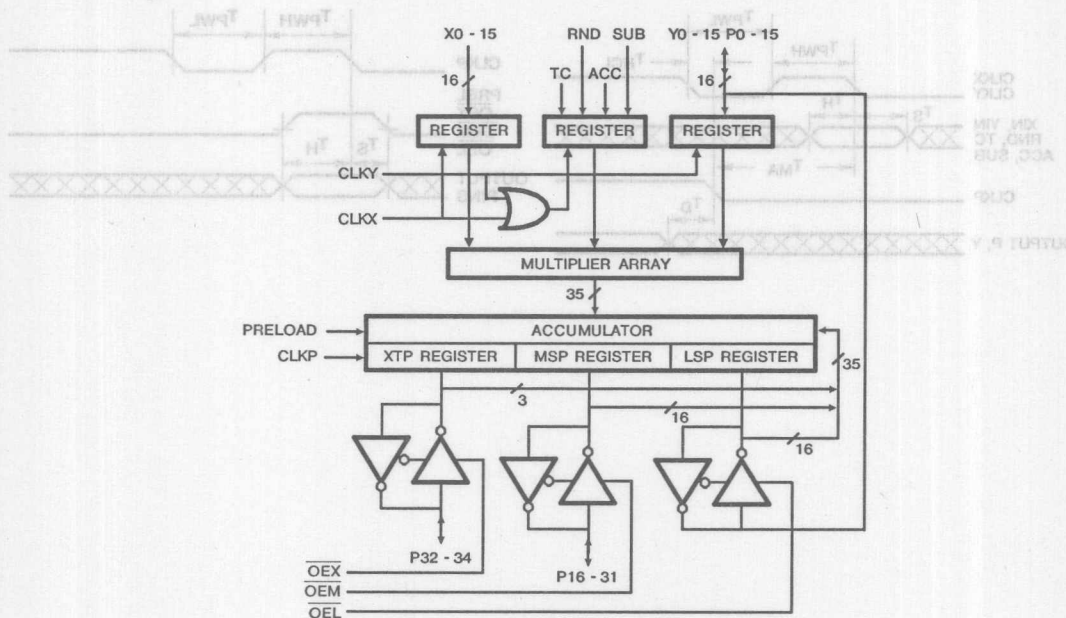
- This Circuit is Processed in Accordance to Mil-Std-883 and is Fully Conformant Under the Provisions of Paragraph 1.2.1.
- 16 x 16-bit Parallel Multiplication with Accumulation to a 35-Bit Result
- High-Speed (55ns) Multiply Accumulate Time
- Low Power CMOS Operation:
  - ICCSB = 500 $\mu$ A Maximum
  - ICCOP = 7.0mA Maximum @ 1.0MHz
- HMA510/883 is Compatible with the CY7C510 and the IDT7210
- Supports Two's Complement or Unsigned Magnitude Operations
- TTL Compatible Inputs/Outputs
- Three-State Outputs
- Available in 68 Lead Pin Grid Array (PGA) Package

### Description

The HMA510/883 is a high speed, low power CMOS 16 x 16-bit parallel multiplier accumulator capable of operating at 55ns clocked multiply-accumulate cycles. The 16-bit X and Y operands may be specified as either two's complement or unsigned magnitude format. Additional inputs are provided for the accumulator functions which include: loading the accumulator with the current product, adding or subtracting the accumulator contents and the current product, and preloading the accumulator registers from the external inputs.

All inputs and outputs are registered. The registers are all positive edge triggered, and are latched on the rising edge of the associated clock signal. The 35-bit accumulator output register is broken into three parts. The 16-bit least significant product (LSP), the 16-bit most significant product (MSP), and the 3-bit extended product (XTP) registers. The XTP and MSP registers have dedicated output ports, while the LSP register shares the Y-inputs in a multiplexed fashion. The entire 35-bit accumulator output register may be preloaded at any time through the use of the bidirectional output ports and the preloaded control.

### Block Diagram



CAUTION: These devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
Copyright © Harris Corporation 1992

File Number **2807.1**



# Specifications HMA510/883

## Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input or Output Voltage Applied .....	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range .....	-65°C to +150°C
Junction Temperature .....	+175°C
Lead Temperature (Soldering 10 sec) .....	300°C
ESD Classification .....	Class 1

## Reliability Information

Thermal Resistance	$\theta_{ja}$	$\theta_{jc}$
Ceramic PGA Package .....	43°C/W	10°C/W
Maximum Package Power Dissipation at +125°C		
Ceramic PGA Package .....	1.17 Watt	
Gate Count .....	4800 Gates	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range .....	+4.5V to +5.5V
Operating Temperature Range .....	-55°C to +125°C

TABLE 1. HMA510/883 D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +4.0mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output or I/O Leakage Current	$I_O$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.5V$ , Outputs Open	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 1.0MHz$ , $V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ (Note 2)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	7.0	mA
Functional Test	FT	(Note 3)	7, 8	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	-	

### NOTES:

- Interchanging of force and sense conditions is permitted.
- Operating Supply Current is proportional to frequency, typical rating is 5mA/MHz.
- Tested as follows:  $f = 1MHz$ ,  $V_{IH}$  (clock inputs) = 3.2V,  $V_{IH}$  (all other inputs) = 2.6V,  $V_{IL} = 0.4V$ ,  $V_{OH} \geq 1.5V$ , and  $V_{OL} \leq 1.5V$ .

TABLE 4. APPLICABLE SUBGROUPS

CONFORMANCE GROUP	METHOD	SUBGROUPS
Initial Test	100V/2004	-
Interim Test	100V/2004	-
PDA	100V	1
Final Test	100V	2, 3, 4, 5, 6, 7, 8, 9, 10, 11
Group A	-	1, 2, 3, 4, 5, 6, 7, 8, 9, 10, 11
Groups C & D	Sampled/500V	1, 2, 3

CAUTION: These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.

# Specifications HMA510/883

TABLE 2. HMA510/883 A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	(NOTE 1) CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	-55		-65		-75		UNITS
					MIN	MAX	MIN	MAX	MIN	MAX	
Multiply Accumulate Time	T <sub>MA</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	55	-	65	-	75	ns
Input Setup Time	T <sub>S</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	25	-	25	-	ns
Clock HIGH Pulse Width	T <sub>PWH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	25	-	25	-	ns
Clock LOW Pulse Width	T <sub>PWL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	25	-	25	-	ns
Output Delay	T <sub>D</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	30	-	35	-	35	ns
3-State Enable Time	T <sub>ENA</sub>	(Note 2)	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	30	-	30	-	35	ns

NOTES:

1. AC Testing as follows: V<sub>CC</sub> = 4.5V and 5.5V. Input levels 0V and 3.0V (0V and 3.2V for clock inputs). Timing reference levels = 1.5V, Output load per test load circuit, with V<sub>I</sub> = 2.4V, R<sub>I</sub> = 500Ω and C<sub>L</sub> = 40pF.
2. Transition is measured at ±200mV from steady state voltage, Output loading per test load circuit, with V<sub>I</sub> = 1.5V, R<sub>I</sub> = 500Ω and C<sub>L</sub> = 40pF.

TABLE 3. HMA510/883 ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETER	SYMBOL	CONDITIONS	NOTE	TEMPERATURE	-55		-65		-75		UNITS
					MIN	MAX	MIN	MAX	MIN	MAX	
Input Capacitance	C <sub>IN</sub>	V <sub>CC</sub> = Open, f = 1MHz All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	10	-	10	-	10	pF
Output Capacitance	C <sub>OUT</sub>		1	T <sub>A</sub> = +25°C	-	10	-	10	-	10	pF
I/O Capacitance	C <sub>I/O</sub>		1	T <sub>A</sub> = +25°C	-	15	-	15	-	15	pF
Input Hold Time	T <sub>H</sub>		1	-55°C ≤ T <sub>A</sub> ≤ +125°C	3	-	3	-	3	-	ns
3-State Disable Time	T <sub>DIS</sub>		1	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	30	-	30	-	30	ns
Output Rise Time	T <sub>R</sub>	From 0.8V to 2.0V	1	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	10	-	10	-	10	ns
Output Fall Time	T <sub>F</sub>	From 2.0V to 0.8V	1	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	10	-	10	-	10	ns

NOTE:

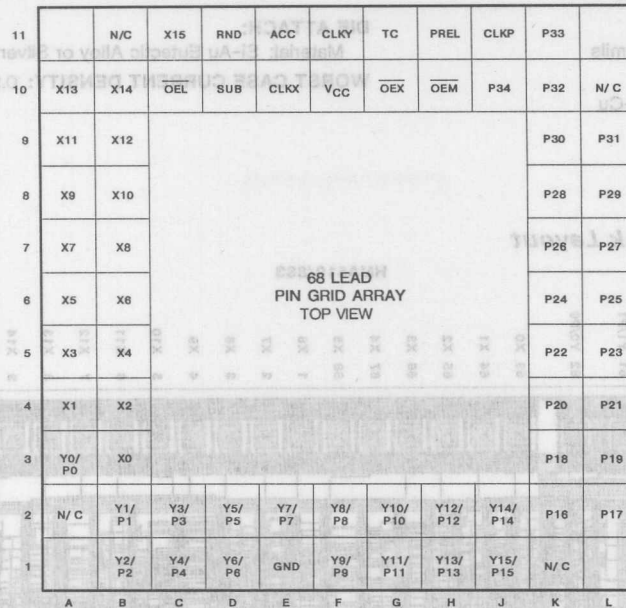
1. The parameters listed in Table 3 are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design and after major process and/or design changes.

TABLE 4. APPLICABLE SUBGROUPS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9

CAUTION: These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.

## Burn-In Circuit



PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
B6	X6	F1	F1	Y9/P9	F2	K7	P26	V <sub>CC</sub> /2	E11	ACC	F1
A6	X5	F2	G2	Y10/P10	F3	L7	P27	V <sub>CC</sub> /2	D10	SUB	F2
B5	X4	F3	G1	Y11/P11	F5	K8	P28	V <sub>CC</sub> /2	D11	RND	F3
A5	X3	F4	H2	Y12/P12	F4	L8	P29	V <sub>CC</sub> /2	C10	$\overline{\text{OEL}}$	V <sub>CC</sub>
B4	X2	F5	H1	Y13/P13	F4	K9	P30	V <sub>CC</sub> /2	C11	X15	F8
A4	X1	F6	J2	Y14/P14	F8	L9	P31	V <sub>CC</sub> /2	B10	X14	F9
B3	X0	F7	J1	Y15/P15	F9	K10	P32	V <sub>CC</sub> /2	A10	X13	F10
A3	Y0/P0	F8	K2	P16	V <sub>CC</sub> /2	K11	P33	V <sub>CC</sub> /2	B9	X12	F11
B2	Y1/P1	F9	L2	P17	V <sub>CC</sub> /2	J10	P34	V <sub>CC</sub> /2	A9	X11	F12
B1	Y2/P2	F10	K3	P18	V <sub>CC</sub> /2	J11	CLKP	F0	B8	X10	F13
C2	Y3/P3	F11	L3	P19	V <sub>CC</sub> /2	H10	$\overline{\text{OEM}}$	GND	A8	X9	F14
C1	Y4/P4	F12	K4	P20	V <sub>CC</sub> /2	H11	PREL	F6	B7	X8	F15
D2	Y5/P5	F13	L4	P21	V <sub>CC</sub> /2	G10	$\overline{\text{OEX}}$	GND	A7	X7	F7
D1	Y6/P6	F14	K5	P22	V <sub>CC</sub> /2	G11	TC	F5	A2	N.C.	N.C.
E2	Y7/P7	F15	L5	P23	V <sub>CC</sub> /2	F10	V <sub>CC</sub>	V <sub>CC</sub>	K1	N.C.	N.C.
E1	GND	GND	K6	P24	V <sub>CC</sub> /2	F11	CLKY	F0	L10	N.C.	N.C.
F2	Y8/P8	F1	L6	P25	V <sub>CC</sub> /2	E10	CLKX	F0	B11	N.C.	N.C.

## NOTES:

1. V<sub>CC</sub> = 5.5V +0.5V/-0.0V with 0.1μF decoupling capacitor to GND
2. F0 = 100kHz, F1 = F0/2, F2 = F1/2, . . . . ., 10%
3. V<sub>IH</sub> = V<sub>CC</sub> - 1V ± 0.5V (Min), V<sub>IL</sub> = 0.8V (Max)
4. 47kΩ load resistors used on all pins except V<sub>CC</sub> and GND (Pin-Grid identifiers F10, G10, G11 and H11)

**DIE ATTACH:**

Material: Si-Au Eutectic Alloy or Silver-Glass

**WORST CASE CURRENT DENSITY:**  $0.9 \times 10^5 \text{ A/cm}^2$

**WORST CASE CURRENT DENSITY:**  $0.9 \times 10^5 \text{ A/cm}^2$

**WORST CASE CURRENT DENSITY:**  $0.9 \times 10^5 \text{ A/cm}^2$

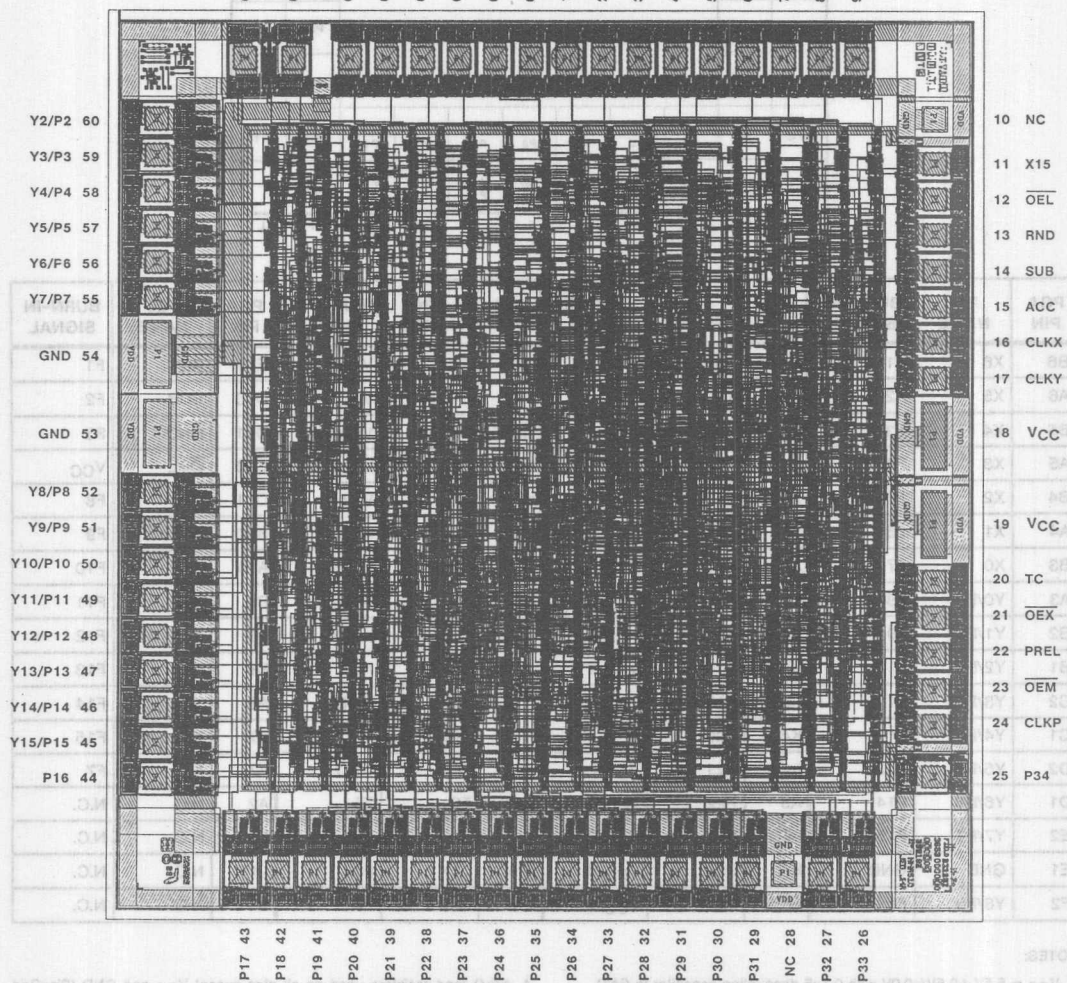
**WORST CASE CURRENT DENSITY:**  $0.9 \times 10^5 \text{ A/cm}^2$

**WORST CASE CURRENT DENSITY:**  $0.9 \times 10^5 \text{ A/cm}^2$

**WORST CASE CURRENT DENSITY:**  $0.9 \times 10^5 \text{ A/cm}^2$

**WORST CASE CURRENT DENSITY:**  $0.9 \times 10^5 \text{ A/cm}^2$

61	Y1/P1
62	Y0/P0
63	X0
64	X1
65	X2
66	X3
67	X4
68	X5
1	X6
2	X7
3	X8
4	X9
5	X10
6	X11
7	X12
8	X13
9	X14





**HARRIS**

# HMU16/HMU17

**16 x 16-Bit CMOS  
Parallel Multipliers**

August 1992

**Features**

- 16 x 16-Bit Parallel Multiplier with Full 32-Bit Product
- High-Speed (35ns) Clocked Multiply Time
- Low Power Operation:
  - ICCSB = 500 $\mu$ A Maximum
  - ICCOP = 7.0mA Maximum @ 1MHz
- Supports Two's Complement, Unsigned Magnitude and Mixed Mode Multiplication
- HMU16 is Compatible with the AM29516, LMU16, IDT7216 and the CY7C516
- HMU17 is Compatible with the AM29517, LMU17, IDT7217 and the CY7C517
- TTL Compatible Inputs/Outputs
- Three-State Outputs
- Available in a Ceramic 68 Pin Grid Array (PGA) and 68 Pin Plastic Leaded Chip Carrier (PLCC)

**Applications**

- Fast Fourier Transform Analysis
- Digital Filtering
- Graphic Display Systems
- Image Processing
- Radar and Sonar
- Speech Synthesis and Recognition

**Description**

The HMU16/HMU17 are high speed, low power CMOS 16 x 16-bit multipliers ideal for fast, real time digital signal processing applications.

The X and Y operands along with their mode controls (TCX and TCY) have 17-bit input registers. The mode controls independently specify the operands as either two's complement or unsigned magnitude format, thereby allowing mixed mode multiplication operations.

Two 16-bit output registers are provided to hold the most and least significant halves of the result (MSP and LSP). For asynchronous output these registers may be made transparent through the use of the feedthrough control (FT).

Additional inputs are provided for format adjustment and rounding. The format adjust control (FA) allows the user to select either a left shifted 31-bit product or a full 32-bit product, whereas the round control (RND) provides the capability of rounding the most significant portion of the result.

The HMU16 has independent clocks (CLKX, CLKY, CLKL, CLKM) associated with each of these registers to maximize throughput and simplify bus interfacing. The HMU17 has only a single clock input (CLK), but makes use of three register enables ( $\overline{\text{ENX}}$ ,  $\overline{\text{ENY}}$  and  $\overline{\text{ENP}}$ ). The  $\overline{\text{ENX}}$  and  $\overline{\text{ENY}}$  inputs control the X and Y input registers, while  $\overline{\text{ENP}}$  controls both the MSP and LSP output registers. This configuration facilitates the use of the HMU17 for microprogrammed systems.

The two halves of the product may be routed to a single 16-bit three-state output port via a multiplexer, and in addition, the LSP is connected to the Y-input port through a separate three-state buffer.

All outputs of the HMU16/HMU17 multipliers also offer three-state control for multiplexing results onto multi-use busses.

**2****MULTIPLIERS**



# HMU16/HMU17

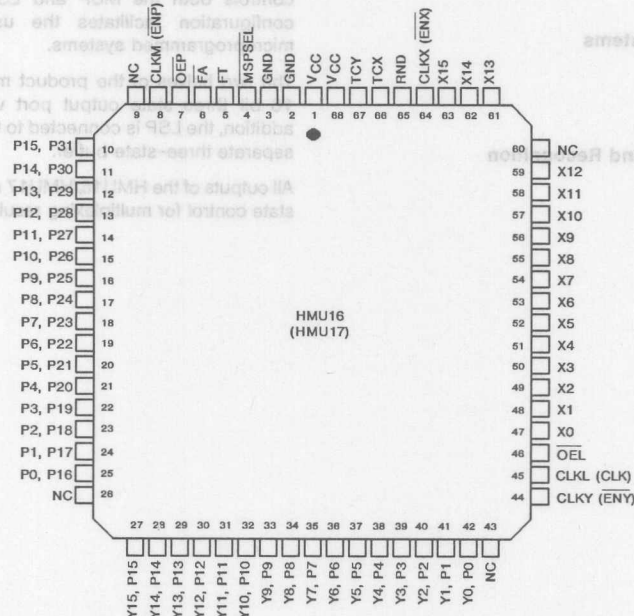
## Package Pinouts

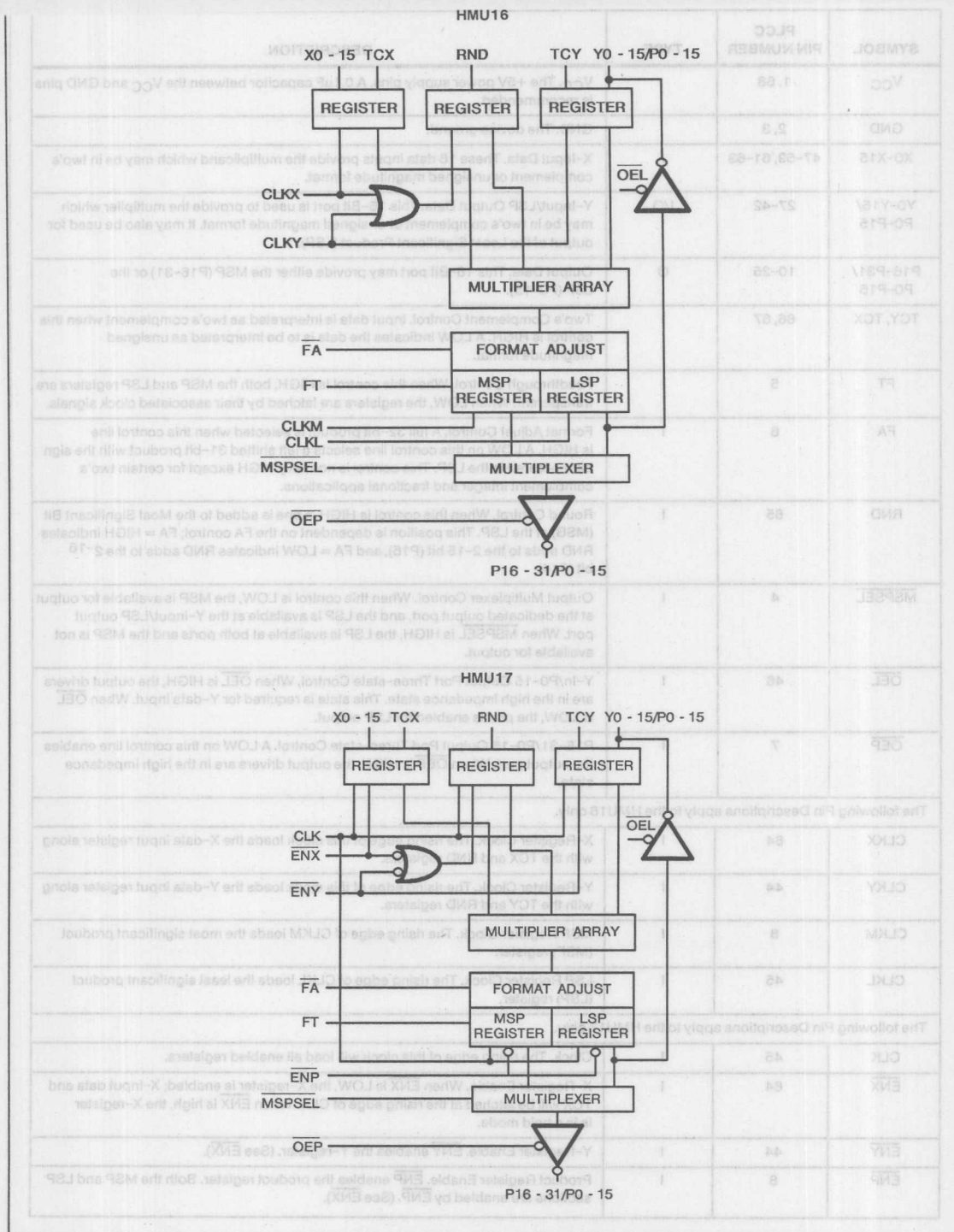
### CERAMIC 68 PIN GRID ARRAY (PGA) TOP VIEW

		N/C	X13	X15	RND	TCY	V <sub>CC</sub>	GND	FT	OEP	
11											
10	X11	X12	X14	CLKX (ENX)	TCX	V <sub>CC</sub>	GND	MSPSEL	FA	CLKM (ENP)	N/C
9	X9	X10								P30/ P14	P31/ P15
8	X7	X8								P28/ P12	P29/ P13
7	X5	X6								P26/ P10	P27/ P11
6	X3	X4								P24/ P8	P25/ P9
5	X1	X2								P22/ P6	P23/ P7
4	OEL	X0								P20/ P4	P21/ P5
3	CLKY (ENY)	CLKL (CLK)								P18/ P2	P19/ P3
2	N/C	Y0/ P0	Y2/ P2	Y4/ P4	Y6/ P6	Y8/ P8	Y10/ P10	Y12/ P12	Y14/ P14	P16/ P0	P17/ P1
1		Y1/ P1	Y3/ P3	Y5/ P5	Y7/ P7	Y9/ P9	Y11/ P11	Y13/ P13	Y15/ P15	N/C	
	A	B	C	D	E	F	G	H	J	K	L

### 68 LEAD PIN GRID ARRAY TOP VIEW

### 68 PIN PLASTIC LEADED CHIP CARRIER (PLCC) TOP VIEW





Pin Description

SYMBOL	PLCC PIN NUMBER	TYPE	DESCRIPTION
V <sub>CC</sub>	1, 68		V <sub>CC</sub> . The +5V power supply pins. A 0.1 $\mu$ F capacitor between the V <sub>CC</sub> and GND pins is recommended.
GND	2, 3		GND. The device ground.
X0-X15	47-59, 61-63	I	X-Input Data. These 16 data inputs provide the multiplicand which may be in two's complement or unsigned magnitude format.
Y0-Y15/ P0-P15	27-42	I/O	Y-Input/LSP Output Data. This 16-Bit port is used to provide the multiplier which may be in two's complement or unsigned magnitude format. It may also be used for output of the Least Significant Product (LSP).
P16-P31/ P0-P15	10-25	O	Output Data. This 16-Bit port may provide either the MSP (P16-31) or the LSP (P0-15).
TCY, TCX	66, 67	I	Two's Complement Control. Input data is interpreted as two's complement when this control is HIGH. A LOW indicates the data is to be interpreted as unsigned magnitude format.
FT	5	I	Feedthrough Control. When this control is HIGH, both the MSP and LSP registers are transparent. When LOW, the registers are latched by their associated clock signals.
FA	6	I	Format Adjust Control. A full 32-bit product is selected when this control line is HIGH. A LOW on this control line selects a left shifted 31-bit product with the sign bit replicated in the LSP. This control is normally HIGH except for certain two's complement integer and fractional applications.
RND	65	I	Round Control. When this control is HIGH, a one is added to the Most Significant Bit (MSB) of the LSP. This position is dependent on the FA control; FA = HIGH indicates RND adds to the 2-15 bit (P15), and FA = LOW indicates RND adds to the 2-16 bit (P14).
MSPSEL	4	I	Output Multiplexer Control. When this control is LOW, the MSP is available for output at the dedicated output port, and the LSP is available at the Y-input/LSP output port. When MSPSEL is HIGH, the LSP is available at both ports and the MSP is not available for output.
OEL	46	I	Y-In/P0-15 Output Port Three-state Control. When OEL is HIGH, the output drivers are in the high impedance state. This state is required for Y-data input. When OEL is LOW, the port is enabled for LSP output.
OEP	7	I	P16-31/P0-15 Output Port Three-state Control. A LOW on this control line enables the output port. When OEP is HIGH, the output drivers are in the high impedance state.
The following Pin Descriptions apply to the HMU16 only.			
CLKX	64	I	X-Register Clock. The rising edge of this clock loads the X-data input register along with the TCX and RND registers.
CLKY	44	I	Y-Register Clock. The rising edge of this clock loads the Y-data input register along with the TCY and RND registers.
CLKM	8	I	MSP Register Clock. The rising edge of CLKM loads the most significant product (MSP) register.
CLKL	45	I	LSP Register Clock. The rising edge of CLKL loads the least significant product (LSP) register.
The following Pin Descriptions apply to the HMU17 only.			
CLK	45	I	Clock. The rising edge of this clock will load all enabled registers.
ENX	64	I	X-Register Enable. When ENX is LOW, the X-register is enabled; X-input data and TCX will be latched at the rising edge of CLK. When ENX is high, the X-register is in a hold mode.
ENY	44	I	Y-Register Enable. ENY enables the Y-register. (See ENX).
ENP	8	I	Product Register Enable. ENP enables the product register. Both the MSP and LSP sections are enabled by ENP. (See ENX).

# Functional Description

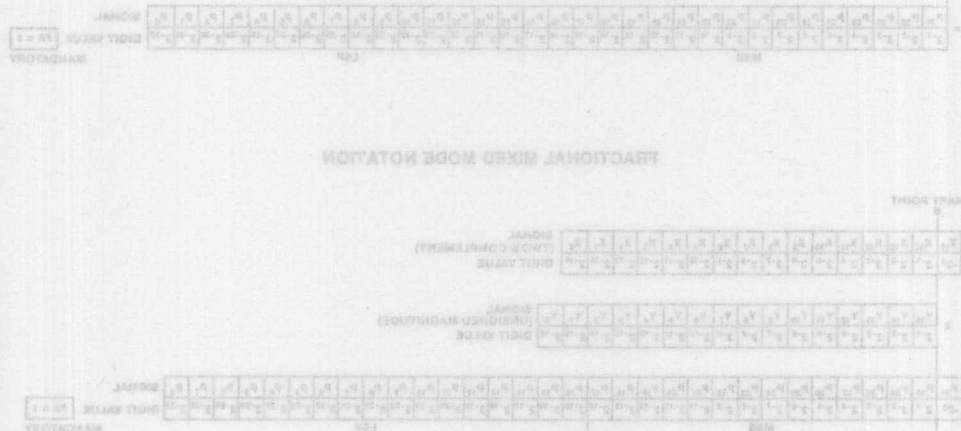
The HMU16/HMU17 are high speed 16 X 16-bit multipliers designed to perform very fast multiplication of two 16-bit binary numbers. The two 16-bit operands (X and Y) may be independently specified as either two's complement or unsigned magnitude format by the two's complement controls (TCX and TCY). When either of these control lines is LOW, the respective operand is treated as an unsigned 16-bit value; and when it is HIGH, the operand is treated as a signed value represented in two's complement format. The operands along with their respective controls are latched at the rising edge of the associated clock signal. The HMU16 accomplishes this through the use of independent clock inputs for each of the input registers (CLKX and CLKY), while the HMU17 utilizes a single clock signal (CLK) along with the X and Y register enable inputs (ENX and ENY).

Input controls are also provided for rounding and format adjustment of the 32-bit product. The Round input (RND) is provided to accommodate rounding of the most significant portion of the product by adding one to the Most Significant Bit (MSB) of the LSP register. The position of the MSB is dependent on the state of the Format Adjust Control (See Pin Descriptions and Multiplier Input/Output Format Tables). The Round input is latched into the RND register whenever either of the input registers is clocked. The Format Adjust control (FA) allows the product output to be formatted. When the FA control is HIGH, a full 32-bit product is output; and when FA is LOW, a left-shifted 31-bit product is output with the sign bit replicated in bit position 15 of the LSP. The FA control must be HIGH for unsigned magnitude, and mixed mode multiplication

operations. It may be LOW for certain two's complement integer and fractional operations only (See Multiplier Input/Output Formats Table).

The HMU16/HMU17 multipliers are equipped with two 16-bit output registers (MSP and LSP) which are provided to hold the most and least significant portions of the resultant product respectively. The HMU16 uses independent clocks (CLKM and CLKL) for latching the two output registers, while the HMU17 uses a single clock input (CLK) along with the Product Latch Enable (ENP). The MSP and LSP registers may also be made transparent for asynchronous output through the use of the Feedthrough control (FT).

There are two output configurations which may be selected when using the HMU16/HMU17 multipliers. The first configuration allows the simultaneous access of the most and least significant halves of the product. When the MSPSEL input is LOW, the Most Significant Product will be available at the dedicated output port (P16-31/P0-15). The Least Significant Product is simultaneously available at the bi-directional port shared with the Y-inputs (Y0-15/P0-15) through the use of the LSP output enable (OEL). The other output configuration involves multiplexing the MSP and LSP registers onto the dedicated output port through the use of the MSPSEL control. When the MSPSEL control is LOW, the Most Significant Product will be available at the dedicated output port; and when MSPSEL is HIGH, the Least Significant Product will be available at this port. This configuration allows access of the entire 32-bit product by a 16-bit wide system bus.







**Multiplier Input/Output Formats Table** (Continued)

## INTEGER TWO'S COMPLEMENT NOTATION

The diagram illustrates a 16-bit adder circuit for two's complement notation. It features two 16-bit inputs, A and B, and a carry-in (Cin). The circuit is composed of a series of full adders. The output of the adder is a 16-bit signal. The diagram is labeled "INTEGER TWO'S COMPLEMENT NOTATION".

\* =

P <sub>31</sub>	P <sub>30</sub>	P <sub>29</sub>	P <sub>28</sub>	P <sub>27</sub>	P <sub>26</sub>	P <sub>25</sub>	P <sub>24</sub>	P <sub>23</sub>	P <sub>22</sub>	P <sub>21</sub>	P <sub>20</sub>	P <sub>19</sub>	P <sub>18</sub>	P <sub>17</sub>	P <sub>16</sub>	P <sub>15</sub>	P <sub>14</sub>	P <sub>13</sub>	P <sub>12</sub>	P <sub>11</sub>	P <sub>10</sub>	P <sub>9</sub>	P <sub>8</sub>	P <sub>7</sub>	P <sub>6</sub>	P <sub>5</sub>	P <sub>4</sub>	P <sub>3</sub>	P <sub>2</sub>	P <sub>1</sub>	P <sub>0</sub>	SIGNAL	
-230	229	228	227	226	225	224	223	222	221	220	219	218	217	216	215	-210	214	213	212	211	210	209	208	207	206	205	204	203	202	201	200	DIGIT VALUE	FA = 0
MSP																LSP																	

$$= \begin{matrix} & P_{31} & P_{30} & P_{29} & P_{28} & P_{27} & P_{26} & P_{25} & P_{24} & P_{23} & P_{22} & P_{21} & P_{20} & P_{19} & P_{18} & P_{17} & P_{16} & P_{15} & P_{14} & P_{13} & P_{12} & P_{11} & P_{10} & P_9 & P_8 & P_7 & P_6 & P_5 & P_4 & P_3 & P_2 & P_1 & P_0 \\ \begin{matrix} -2^{31} & -2^{30} & -2^{29} & -2^{28} & -2^{27} & -2^{26} & -2^{25} & -2^{24} & -2^{23} & -2^{22} & -2^{21} & -2^{20} & -2^{19} & -2^{18} & -2^{17} & -2^{16} & -2^{15} & -2^{14} & -2^{13} & -2^{12} & -2^{11} & -2^{10} & -2^9 & -2^8 & -2^7 & -2^6 & -2^5 & -2^4 & -2^3 & -2^2 & -2^1 & -2^0 \end{matrix} \end{matrix} \begin{matrix} \text{MSP} \\ \text{LSP} \end{matrix} \begin{matrix} \text{SIGNAL} \\ \text{DIGIT VALUE} \end{matrix} \quad \boxed{FA \approx 1}$$

\* In this format an overflow occurs in the attempted multiplication of the two's complement number 1,000 . . . 0 with 1,000 . . . 0 yielding an erroneous product of -1 in the fraction case and  $-2^{30}$  in the integer case.

## INTEGER UNSIGNED MAGNITUDE NOTATION

with 1,000 ... 0 yielding an erroneous product of -1 in the fraction case and  $-2^{30}$  in the integer case.

X																Y																Z																W																V																U																T																S																R																Q																P																O																N																M																L																K																J																I																H																G																F																E																D																C																B																A																9																8																7																6																5																4																3																2																1																0																-1																-2																-3																-4																-5																-6																-7																-8																-9																-10																-11																-12																-13																-14																-15																-16																-17																-18																-19																-20																-21																-22																-23																-24																-25																-26																-27																-28																-29																-30																-31																-32																-33																-34																-35																-36																-37																-38																-39																-40																-41																-42																-43																-44																-45																-46																-47																-48																-49																-50																-51																-52																-53																-54																-55																-56																-57																-58																-59																-60																-61																-62																-63																-64																-65																-66																-67																-68																-69																-70																-71																-72																-73																-74																-75																-76																-77																-78																-79																-80																-81																-82																-83																-84																-85																-86																-87																-88																-89																-90																-91																-92																-93																-94																-95																-96																-97																-98																-99																-100																-101																-102																-103																-104																-105																-106																-107																-108																-109																-110																-111																-112																-113																-114																-115																-116																-117																-118																-119																-120																-121																-122																-123																-124																-125																-126																-127																-128																-129																-130																-131																-132																-133																-134																-135																-136																-137																-138																-139																-140																-141																-142																-143																-144																-145																-146																-147																-148																-149																-150																-151																-152																-153																-154																-155																-156																-157																-158																-159																-160																-161																-162																-163																-164																-165																-166																-167																-168																-169																-170																-171																-172																-173																-174																-175																-176																-177																-178																-179																-180																-181																-182																-183																-184																-185																-186																-187																-188																-189																-190																-191																-192																-193																-194																-195																-196																-197																-198																-199																-200																-201																-202																-203																-204																-205																-206																-207																-208																-209																-210																-211																-212																-213																-214																-215																-216																-217																-218																-219																-220																-221																-222																-223																-224																-225																-226																-227																-228																-229																-230																-231																-232																-233																-234																-235																-236																-237																-238																-239																-240																-241																-242																-243																-244																-245																-246																-247																-248																-249																-250																-251																-252																-253																-254																-255															
---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--

INTEGER UNSIGNED MAGNITUDE NOTATION

X																Y																Z																W																V																U																T																S																R																Q																P																O																N																M																L																K																J																I																H																G																F																E																D																C																B																A																9																8																7																6																5																4																3																2																1																0																-1																-2																-3																-4																-5																-6																-7																-8																-9																-10																-11																-12																-13																-14																-15																-16																-17																-18																-19																-20																-21																-22																-23																-24																-25																-26																-27																-28																-29																-30																-31																-32																-33																-34																-35																-36																-37																-38																-39																-40																-41																-42																-43																-44																-45																-46																-47																-48																-49																-50																-51																-52																-53																-54																-55																-56																-57																-58																-59																-60																-61																-62																-63																-64																-65																-66																-67																-68																-69																-70																-71																-72																-73																-74																-75																-76																-77																-78																-79																-80																-81																-82																-83																-84																-85																-86																-87																-88																-89																-90																-91																-92																-93																-94																-95																-96																-97																-98																-99																-100																-101																-102																-103																-104																-105																-106																-107																-108																-109																-110																-111																-112																-113																-114																-115																-116																-117																-118																-119																-120																-121																-122																-123																-124																-125																-126																-127																-128																-129																-130																-131																-132																-133																-134																-135																-136																-137																-138																-139																-140																-141																-142																-143																-144																-145																-146																-147																-148																-149																-150																-151																-152																-153																-154																-155																-156																-157																-158																-159																-160																-161																-162																-163																-164																-165																-166																-167																-168																-169																-170																-171																-172																-173																-174																-175																-176																-177																-178																-179																-180																-181																-182																-183																-184																-185																-186																-187																-188																-189																-190																-191																-192																-193																-194																-195																-196																-197																-198																-199																-200																-201																-202																-203																-204																-205																-206																-207																-208																-209																-210																-211																-212																-213																-214																-215																-216																-217																-218																-219																-220																-221																-222																-223																-224																-225																-226																-227																-228																-229																-230																-231																-232																-233																-234																-235																-236																-237																-238																-239																-240																-241																-242																-243																-244																-245																-246																-247																-248																-249																-250																-251																-252																-253																-254																-255															
---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--

BINARY POINT

X																Y																Z																W																V																U																T																S																R																Q																P																O																N																M																L																K																J																I																H																G																F																E																D																C																B																A																9																8																7																6																5																4																3																2																1																0																-1																-2																-3																-4																-5																-6																-7																-8																-9																-10																-11																-12																-13																-14																-15																-16																-17																-18																-19																-20																-21																-22																-23																-24																-25																-26																-27																-28																-29																-30																-31																-32																-33																-34																-35																-36																-37																-38																-39																-40																-41																-42																-43																-44																-45																-46																-47																-48																-49																-50																-51																-52																-53																-54																-55																-56																-57																-58																-59																-60																-61																-62																-63																-64																-65																-66																-67																-68																-69																-70																-71																-72																-73																-74																-75																-76																-77																-78																-79																-80																-81																-82																-83																-84																-85																-86																-87																-88																-89																-90																-91																-92																-93																-94																-95																-96																-97																-98																-99																-100																-101																-102																-103																-104																-105																-106																-107																-108																-109																-110																-111																-112																-113																-114																-115																-116																-117																-118																-119																-120																-121																-122																-123																-124																-125																-126																-127																-128																-129																-130																-131																-132																-133																-134																-135																-136																-137																-138																-139																-140																-141																-142																-143																-144																-145																-146																-147																-148																-149																-150																-151																-152																-153																-154																-155																-156																-157																-158																-159																-160																-161																-162																-163																-164																-165																-166																-167																-168																-169																-170																-171																-172																-173																-174																-175																-176																-177																-178																-179																-180																-181																-182																-183																-184																-185																-186																-187																-188																-189																-190																-191																-192																-193																-194																-195																-196																-197																-198																-199																-200																-201																-202																-203																-204																-205																-206																-207																-208																-209																-210																-211																-212																-213																-214																-215																-216																-217																-218																-219																-220																-221																-222																-223																-224																-225																-226																-227																-228																-229																-230																-231																-232																-233																-234																-235																-236																-237																-238																-239																-240																-241																-242																-243																-244																-245																-246																-247																-248																-249																-250																-251																-252																-253																-254																-255															
---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--

SIGNAL

DIGIT VALUE

X																Y																Z																W																V																U																T																S																R																Q																P																O																N																M																L																K																J																I																H																G																F																E																D																C																B																A																9																8																7																6																5																4																3																2																1																0																-1																-2																-3																-4																-5																-6																-7																-8																-9																-10																-11																-12																-13																-14																-15																-16																-17																-18																-19																-20																-21																-22																-23																-24																-25																-26																-27																-28																-29																-30																-31																-32																-33																-34																-35																-36																-37																-38																-39																-40																-41																-42																-43																-44																-45																-46																-47																-48																-49																-50																-51																-52																-53																-54																-55																-56																-57																-58																-59																-60																-61																-62																-63																-64																-65																-66																-67																-68																-69																-70																-71																-72																-73																-74																-75																-76																-77																-78																-79																-80																-81																-82																-83																-84																-85																-86																-87																-88																-89																-90																-91																-92																-93																-94																-95																-96																-97																-98																-99																-100																-101															
---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	---	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	-----	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--	------	--	--	--	--	--	--	--	--	--	--	--	--	--	--	--

### INTEGER MIXED MODE NOTATION

TEST CONDITIONS		UNITS	TYPICAL	PARAMETER	SYMBOL
Frequency = 1 MHz All measurements referenced to device Ground	df		$X_{15} \ X_{14} \ X_{13} \ X_{12} \ X_{11} \ X_{10} \ X_9 \ X_8 \ X_7 \ X_6 \ X_5 \ X_4 \ X_3 \ X_2 \ X_1 \ X_0$ $-2^{15} \ 2^{14} \ 2^{13} \ 2^{12} \ 2^{11} \ 2^{10} \ 2^9 \ 2^8 \ 2^7 \ 2^6 \ 2^5 \ 2^4 \ 2^3 \ 2^2 \ 2^1 \ 2^0$	SIGNAL (TWO'S COMPLEMENT) DIGIT VALUE	
	df		$X \ Y_{15} \ Y_{14} \ Y_{13} \ Y_{12} \ Y_{11} \ Y_{10} \ Y_9 \ Y_8 \ Y_7 \ Y_6 \ Y_5 \ Y_4 \ Y_3 \ Y_2 \ Y_1 \ Y_0$ $2^{15} \ 2^{14} \ 2^{13} \ 2^{12} \ 2^{11} \ 2^{10} \ 2^9 \ 2^8 \ 2^7 \ 2^6 \ 2^5 \ 2^4 \ 2^3 \ 2^2 \ 2^1 \ 2^0$	SIGNAL (UNSIGNED MAGNITUDE) DIGIT VALUE	
$P_{31} \ P_{30} \ P_{29} \ P_{28} \ P_{27} \ P_{26} \ P_{25} \ P_{24} \ P_{23} \ P_{22} \ P_{21} \ P_{20} \ P_{19} \ P_{18} \ P_{17} \ P_{16} \ P_{15} \ P_{14} \ P_{13} \ P_{12} \ P_{11} \ P_{10} \ P_9 \ P_8 \ P_7 \ P_6 \ P_5 \ P_4 \ P_3 \ P_2 \ P_1 \ P_0$ $-2^{31} \ 2^{30} \ 2^{29} \ 2^{28} \ 2^{27} \ 2^{26} \ 2^{25} \ 2^{24} \ 2^{23} \ 2^{22} \ 2^{21} \ 2^{20} \ 2^{19} \ 2^{18} \ 2^{17} \ 2^{16} \ 2^{15} \ 2^{14} \ 2^{13} \ 2^{12} \ 2^{11} \ 2^{10} \ 2^9 \ 2^8 \ 2^7 \ 2^6 \ 2^5 \ 2^4 \ 2^3 \ 2^2 \ 2^1 \ 2^0$		MSP	LSP	SIGNAL DIGIT VALUE	FA = 1

# Specifications HMU16/HMU17

## Absolute Maximum Ratings

Supply Voltage .....	+8.0 Volts
Input, Output or I/O Voltage Applied .....	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range .....	-65°C to +150°C
Gate Count .....	4500 Gates
$\theta_{ja}$ .....	43.2°C/W (PLCC), 42.69°C/W (PGA)
$\theta_{jc}$ .....	15.1°C/W (PLCC), 10.0°C/W (PGA)
Maximum Package Power Dissipation at 70°C .....	1.7W (PLCC), 2.46 (PGA)
Junction Temperature .....	+150°C (PLCC), +175°C (PGA)
Lead Temperature (Soldering, Ten Seconds) .....	+300°C

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating, and operation at these or any other conditions above those indicated in the operations sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range .....	+4.75V to +5.25V
Operating Temperature Range .....	0°C to +70°C

## D.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C)

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
$V_{IH}$	Logical One Input Voltage	2.0	-	V	$V_{CC} = 5.25V$
$V_{IL}$	Logical Zero Input Voltage	-	0.8	V	$V_{CC} = 4.75V$
$V_{OH}$	Output High Voltage	2.6	-	V	$I_{OH} = -400\mu A$ , $V_{CC} = 4.75V$
$V_{OL}$	Output Low Voltage	-	0.4	V	$I_{OL} = +4.0mA$ , $V_{CC} = 4.75V$
$I_I$	Input Leakage Current	-10	10	$\mu A$	$V_I = V_{CC}$ or GND, $V_{CC} = 5.25V$
$I_O$	Output or I/O Leakage Current	-10	10	$\mu A$	$V_O = V_{CC}$ or GND, $V_{CC} = 5.25V$
$I_{CCSB}$	Standby Power Supply Current	-	500	$\mu A$	$V_I = V_{CC}$ or GND, $V_{CC} = 5.25V$ Outputs Open
$I_{CCOP}$	Operating Power Supply Current	-	7.0	mA	$V_I = V_{CC}$ or GND, $V_{CC} = 5.25V$ $f = 1MHz$ (Note 1)

## Capacitance ( $T_A = +25^\circ C$ , Note 2)

SYMBOL	PARAMETER	TYPICAL	UNITS	TEST CONDITIONS
$C_{IN}$	Input Capacitance	15	pF	Frequency = 1MHz. All measurements referenced to device Ground.
$C_{OUT}$	Output Capacitance	10	pF	
$C_{I/O}$	I/O Capacitance	10	pF	

### NOTES:

- Operating Supply Current is proportional to frequency. Typical rating is 5mA/MHz.
- Not tested, but characterized at initial design and at major process/design changes.

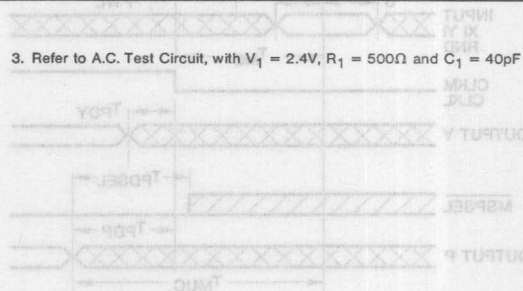
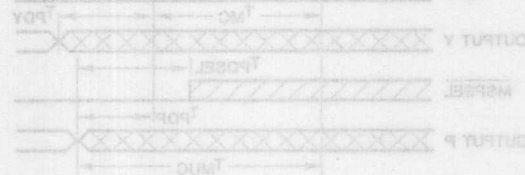
# Specifications HMU16/HMU17

## A.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to $+70^\circ C$ , Note 3)

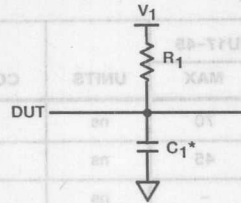
SYMBOL	PARAMETER	HMU16/HMU17-35		HMU16/HMU17-45		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
$T_{MUC}$	Unlocked Multiply Time	-	55	-	70	ns	
$T_{MC}$	Clocked Multiply Time	-	35	-	45	ns	
$T_S$	X, Y, RND Setup Time	15	-	18	-	ns	
$T_H$	X, Y, RND Hold Time	2	-	2	-	ns	
$T_{PWH}$	Clock Pulse Width High	10	-	15	-	ns	
$T_{PWL}$	Clock Pulse Width Low	10	-	15	-	ns	
$T_{PDSEL}$	MSPSEL to Product Out	-	22	-	25	ns	
$T_{PDP}$	Output Clock to P	-	22	-	25	ns	
$T_{PDY}$	Output Clock to Y	-	22	-	25	ns	
$T_{ENA}$	3-State Enable Time	-	22	-	25	ns	Note 1
$T_{DIS}$	3-State Disable Time	-	22	-	25	ns	
$T_{SE}$	Clock Enable Setup Time (HMU17 only)	15	-	15	-	ns	
$T_{HE}$	Clock Enable Hold Time (HMU17 only)	2	-	2	-	ns	
$T_{HCL}$	Clock Low Hold Time CLKXY Relative to CLKML (HMU16 only)	0	-	0	-	ns	Note 2
$T_R$	Output Rise Time	-	8	-	8	ns	From 0.8V to 2.0V
$T_F$	Output Fall Time	-	8	-	8	ns	From 2.0V to 0.8V

### NOTES:

1. Transition is measured at  $\pm 200mV$  from steady state voltage with loading specified in A.C. Test Circuit,  $V_1 = 1.5V$ ,  $R_1 = 500\Omega$  and  $C_1 = 40pF$
2. To ensure the correct product is entered in the output registers, new data may not be entered into the input registers before the output registers have been clocked.
3. Refer to A.C. Test Circuit, with  $V_1 = 2.4V$ ,  $R_1 = 500\Omega$  and  $C_1 = 40pF$

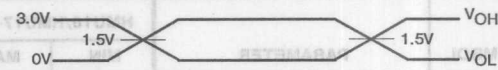


### A.C. Test Circuit



\* Includes Stray and Jig Capacitance

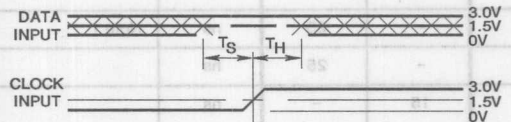
### A.C. Testing Input, Output Waveforms



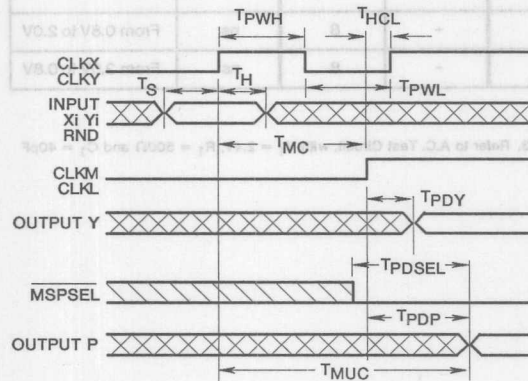
A.C. Testing: All parameters tested as per test circuit. Input rise and fall times are driven at 1ns/V.

### Timing Diagram

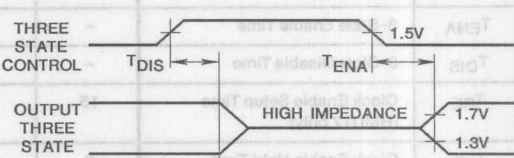
#### SET-UP AND HOLD TIME



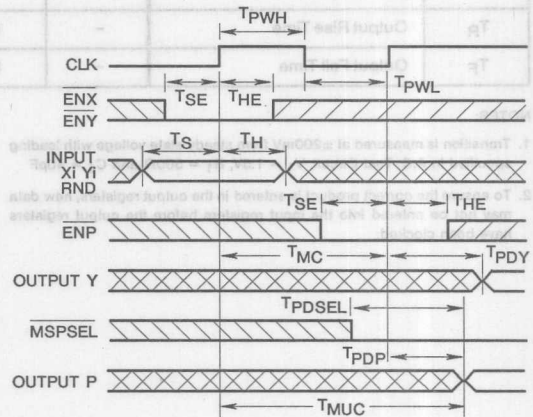
#### HMU16 TIMING DIAGRAM



#### THREE STATE CONTROL



#### HMU17 TIMING DIAGRAM



August 1992

## 16 x 16-Bit CMOS Parallel Multiplier

### Features

- This Circuit is Processed in Accordance to Mil-Std-883 and is Fully Conformant Under the Provisions of Paragraph 1.2.1.
- 16 x 16-Bit Parallel Multiplier with Full 32-Bit Product
- High-Speed (45ns) Clocked Multiply Time
- Low Power CMOS Operation:
  - ICCSB = 500 $\mu$ A Maximum
  - ICCOP = 7.0mA Maximum @ 1MHz
- HMU16 is compatible with the AM29516, LMU16, IDT7216, and the CY7C516
- Supports Two's Complement, Unsigned Magnitude and Mixed Mode Multiplication
- TTL Compatible Inputs/Outputs
- Three-State Outputs
- Available in a 68 Lead Pin Grid Array Package

### Description

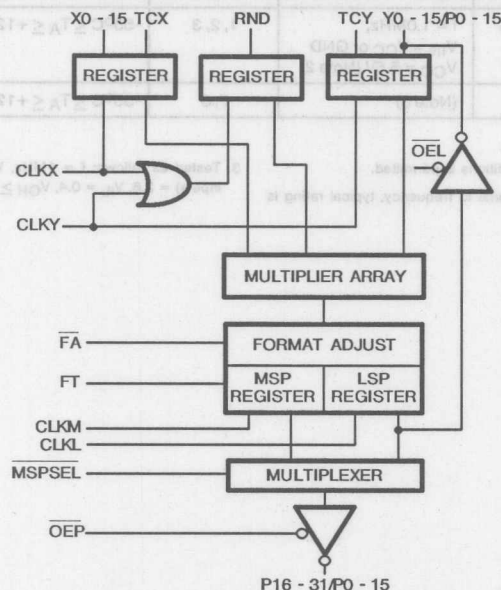
The HMU16 is a high speed, low power CMOS 16 x 16-bit parallel multiplier ideal for fast, real time digital signal processing applications. The 16-bit X and Y operands may be independently specified as either two's complement or unsigned magnitude format, thereby allowing mixed mode multiplication operations.

Additional inputs are provided to accommodate format adjustment and rounding of the 32-bit product. The Format Adjust control allows the user to select a 31-bit product with the sign bit replicated in the LSP. The Round control provides for rounding the most significant portion of the result by adding one to the most significant bit of the LSP.

Two 16-bit output registers (MSP and LSP) are provided to hold the most and least significant portions of the result, respectively. These registers may be made transparent for asynchronous operation through the use of the feedthrough control (FT). The two halves of the product may be routed to a single 16-bit three-state output port via the output multiplexer control, and in addition, the LSP is connected to the Y-input port through a separate three-state buffer.

The HMU16 utilizes independent clock signals (CLKX, CLKY, CLKL, CLKM) to latch the input operands and output product registers. This configuration maximizes throughput and simplifies bus interfacing. All outputs of the HMU16 also offer three-state control for multiplexing onto multi-use system busses.

### Functional Diagram





# Specifications HMU16/883

## Absolute Maximum Ratings

Supply Voltage	+8.0V
Input or Output Voltage Applied	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range	-65°C to +150°C
Junction Temperature	+175°C
Lead Temperature (Soldering 10 sec)	300°C
ESD Classification	Class 1

## Reliability Information

Thermal Resistance	$\theta_{ja}$	$\theta_{jc}$
Ceramic PGA Package	42.69°C/W	10.0°C/W
Maximum Package Power Dissipation at +125°C		
Ceramic PGA Package	1.17 Watt	
Gate Count	4500 Gates	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range	+4.5V to +5.5V
Operating Temperature Range	-55°C to +125°C

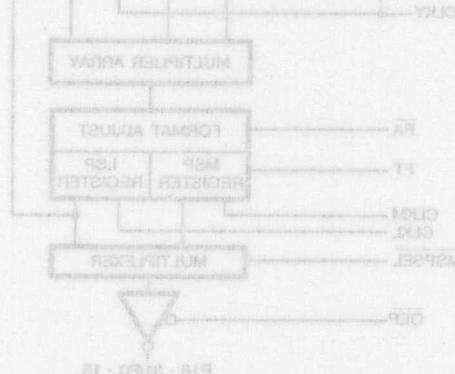
TABLE 1. HMU16/883 D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +4.0mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output or I/O Leakage Current	$I_O$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.5V$ , Outputs Open	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 1.0MHz$ , $V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ (Note 2)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	7.0	mA
Functional Test	FT	(Note 3)	7, 8	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	-	

## NOTES:

- Interchanging of force and sense conditions is permitted.
- Operating Supply Current is proportional to frequency, typical rating is 5mA/MHz.
- Tested as follows:  $f = 1MHz$ ,  $V_{IH}$  (Clock Inputs) = 3.0,  $V_{IH}$  (All other inputs) = 2.6,  $V_{IL} = 0.4$ ,  $V_{OH} \geq 1.5V$ , and  $V_{OL} \leq 1.5V$ .



CAUTION: These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.

# Specifications HMU16/883

TABLE 2. HMU16/883 A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	(NOTE 1) CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	-45		-60		UNITS
					MIN	MAX	MIN	MAX	
Unclocked Multiply Time	T <sub>MUC</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	70	-	90	ns
Clocked Multiply Time	T <sub>MC</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	45	-	60	ns
X, Y, RND Setup Time	T <sub>S</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	18	-	20	-	ns
Clock HIGH Pulse Width	T <sub>PWH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
Clock LOW Pulse Width	T <sub>PWL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
MSPSEL to Product Out	T <sub>PDSEL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	25	-	30	ns
Output Clock to P	T <sub>PDP</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	25	-	30	ns
Output Clock to Y	T <sub>PDY</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	25	-	30	ns
3-State Enable Time	T <sub>ENA</sub>	(Note 2)	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	25	-	30	ns
Clock Low Hold Time CLKXY Relative to CLKML	T <sub>HCL</sub>	(Note 3)	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns

## NOTES:

1. AC Testing as follows: V<sub>CC</sub> = 4.5V and 5.5V. Input levels 0V and 3.0V. Timing reference levels = 1.5V. Output load per test load circuit, with V<sub>I</sub> = 2.4V, R<sub>I</sub> = 500Ω and C<sub>L</sub> = 40pF.
2. Transition is measured at ± 200 mV from steady state voltage. Output loading per test load circuit, with V<sub>I</sub> = 1.5V, R<sub>I</sub> = 500Ω and C<sub>L</sub> = 40pF.
3. To ensure the correct product is entered in the output registers, new data may not be entered into the input registers before the output registers have been clocked.

# Specifications HMU16/883

TABLE 3. HMU16/883 ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETER	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	-45		-60		UNITS
					MIN	MAX	MIN	MAX	
Input Capacitance	$C_{IN}$	$V_{CC} = \text{Open}, f = 1\text{MHz}$ All Measurements are referenced to device GND.	1	$T_A = +25^\circ\text{C}$	-	15	-	15	pF
Output Capacitance	$C_{OUT}$		1	$T_A = +25^\circ\text{C}$	-	10	-	10	pF
I/O Capacitance	$C_{I/O}$		1	$T_A = +25^\circ\text{C}$	-	10	-	10	pF
X, Y, RND Hold Time	$T_H$		1, 2	$-55^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	3	-	3	-	ns
3-State Disable Time	$T_{DIS}$		1, 2, 3	$-55^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	-	25	-	30	ns
Output Rise Time	$T_R$	From 0.8V to 2.0V	1, 2, 4	$-55^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	-	10	-	10	ns
Output Fall Time	$T_F$	From 2.0V to 0.8V	1, 2, 4	$-55^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	-	10	-	10	ns

NOTES: 1. The parameters listed in table 3 are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design and after major process and/or design changes.

2. Guaranteed, but not 100% tested.

3. Transition is measured at  $\pm 200\text{mV}$  from steady state voltage, Output loading per test load circuit, with  $V_1 = 1.5\text{V}$ ,  $R_1 = 500\Omega$  and  $C_L = 40\text{pF}$ .

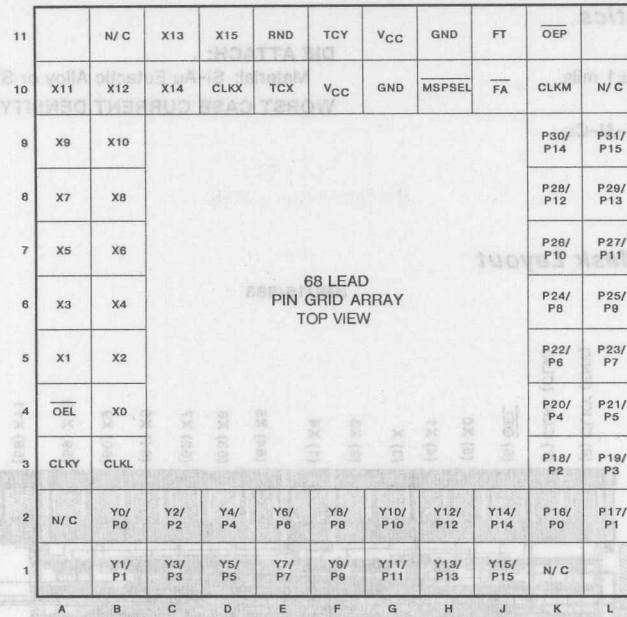
4. Loading is as specified in the test load circuit, with  $V_1 = 2.4\text{V}$ ,  $R_1 = 500\Omega$  and  $C_L = 40\text{pF}$ .

TABLE 4. APPLICABLE SUBGROUPS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9

CAUTION: These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.

**Burn-In Circuit**



PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
B6	X4	F6	F1	Y9/P9	F11	K7	P10/P26	V <sub>CC</sub> /2	E11	RND	F1
A6	X3	F5	G2	Y10/P10	F12	L7	P11/P27	V <sub>CC</sub> /2	D10	CLKX	F0
B5	X2	F4	G1	Y11/P11	F13	K8	P12/P28	V <sub>CC</sub> /2	D11	X15	F3
A5	X1	F3	H2	Y12/P12	F14	L8	P13/P29	V <sub>CC</sub> /2	C10	X14	F2
B4	X0	F2	H1	Y13/P13	F15	K9	P14/P30	V <sub>CC</sub> /2	C11	X13	F15
A4	OEL	V <sub>CC</sub>	J2	Y14/P14	F4	L9	P15/P31	V <sub>CC</sub> /2	B10	X12	F14
B3	CLKL	F0	J1	Y15/P15	F5	K10	CLKM	F0	A10	X11	F13
A3	CLKY	F0	K2	P0/P16	V <sub>CC</sub> /2	K11	$\overline{\text{OEP}}$	F1	B9	X10	F12
B2	Y0/P0	F2	L2	P1/P17	V <sub>CC</sub> /2	J10	$\overline{\text{FA}}$	F14	A9	X9	F11
B1	Y1/P1	F3	K3	P2/P18	V <sub>CC</sub> /2	J11	FT	F15	B8	X8	F10
C2	Y2/P2	F4	L3	P3/P19	V <sub>CC</sub> /2	H10	MSPSEL	F14	A8	X7	F9
C1	Y3/P3	F5	K4	P4/P20	V <sub>CC</sub> /2	H11	GND	GND	B7	X6	F8
D2	Y4/P4	F6	L4	P5/P21	V <sub>CC</sub> /2	G10	GND	GND	A7	X5	F7
D1	Y5/P5	F7	K5	P6/P22	V <sub>CC</sub> /2	G11	V <sub>CC</sub>	V <sub>CC</sub>	A2	N.C.	NONE
E2	Y6/P6	F8	L5	P7/P23	V <sub>CC</sub> /2	F10	V <sub>CC</sub>	V <sub>CC</sub>	K1	N.C.	NONE
E1	Y7/P7	F9	K6	P8/P24	V <sub>CC</sub> /2	F11	TCY	F15	L10	N.C.	NONE
F2	Y8/P8	F10	L6	P9/P25	V <sub>CC</sub> /2	E10	TCX	F15	B11	N.C.	NONE

**NOTES:**

1. V<sub>CC</sub> = 5.0V +0.5V/-0.0V with 0.1μF decoupling capacitor to GND.
2. F0 = 100kHz, F1 = F0/2, F2 = F1/2, . . . . .
3. V<sub>IH</sub> = V<sub>CC</sub> - 1V ± 0.5V (Min), V<sub>IL</sub> = 0.8V (Max)
4. 47kΩ load resistors used on all pins except V<sub>CC</sub> and GND (Pin-Grid identifiers F10, G10, G11 and H11).



# Die Characteristics

## DIE DIMENSIONS:

179 x 169 x 19 ±1 mils

## METALLIZATION:

Type: Si-Al or Si-Al-Cu

Thickness: 8kÅ

## GLASSIVATION:

Type: Nitrox

Thickness: 10kÅ

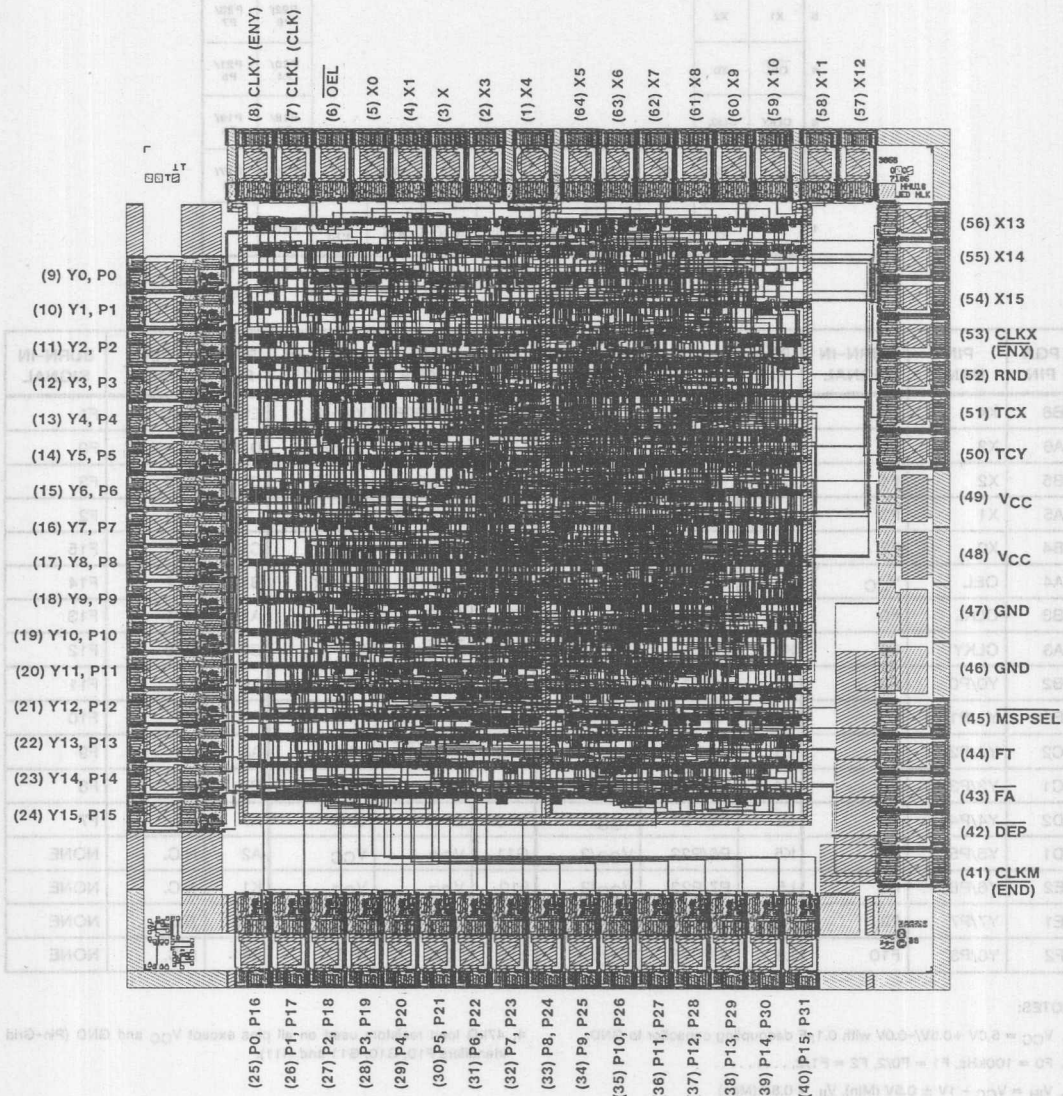
## DIE ATTACH:

Material: Si-Au Eutectic Alloy or Silver-Glass

WORST CASE CURRENT DENSITY:  $1.2 \times 10^5 \text{A/cm}^2$

## Metallization Mask Layout

HMU16/883



August 1992

**16 x 16-Bit CMOS Parallel Multiplier**

## Features

- This Circuit is Processed in Accordance to Mil-Std-883 and is Fully Conformant Under the Provisions of Paragraph 1.2.1.
- 16 x 16-Bit Parallel Multiplier with Full 32-Bit Product
- High-Speed (45ns) Clocked Multiply Time
- Low Power CMOS Operation:
  - ▶ ICCSB = 500μA Maximum
  - ▶ ICCOP = 7.0mA Maximum @ 1MHz
- HMU17 is compatible with the AM29517, LMU17, IDT7217, and the CY7C517
- Supports Two's Complement, Unsigned Magnitude and Mixed Mode Multiplication
- TTL Compatible Inputs/Outputs
- Three-State Outputs
- Available in a 68 Lead Pin Grid Array Package

## Description

The HMU17 is a high speed, low power CMOS 16 x 16-bit parallel multiplier ideal for fast, real time digital signal processing applications. The 16-bit X and Y operands may be independently specified as either two's complement or unsigned magnitude format, thereby allowing mixed mode multiplication operations.

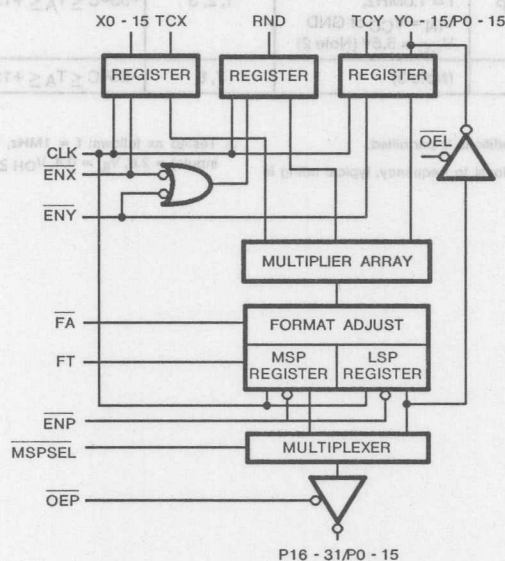
Additional inputs are provided to accommodate format adjustment and rounding of the 32-bit product. The Format Adjust control allows the user the option of selecting a 31-bit product with the sign bit replicated LSP. The Round control is provided to accommodate rounding of the most significant portion of the result. This is accomplished by adding one to the most significant bit of the LSP.

Two 16-bit output registers (MSP and LSP) are provided to hold the most and least significant portions of the result, respectively. These registers may be made transparent for asynchronous operation through the use of the feedthrough control (FT). The two halves of the product may be routed to a single 16-bit three-state output port via the output multiplexer control, and in addition, the LSP is connected to the Y-input port through a separate three-state buffer.

The HMU17 utilizes a single clock signal (CLK) along with three register enables (ENX, ENY, and ENP) to latch the input operands and the output product registers. The ENX and ENY inputs enable the X and Y input registers, while ENP enables both the LSP and MSP output registers. This configuration facilitates the use of the HMU17 for micro-programmed systems.

All outputs of the HMU17 also offer three-state control for multiplexing onto multi-use system busses.

## Functional Diagram



## Specifications HMU17/883

### Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input or Output Voltage Applied .....	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range .....	-65°C to +150°C
Junction Temperature .....	+175°C
Lead Temperature (Soldering 10 sec) .....	300°C
ESD Classification .....	Class 1

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### Reliability Information

Thermal Resistance	$\theta_{ja}$	$\theta_{jc}$
Ceramic PGA Package .....	42.69°C/W	10.0°C/W
Maximum Package Power Dissipation at +125°C		
Ceramic PGA Package .....	1.17 Watt	
Gate Count .....	4500 Gates	

### Operating Conditions

Operating Voltage Range .....	+4.5V to +5.5V
Operating Temperature Range .....	-55°C to +125°C

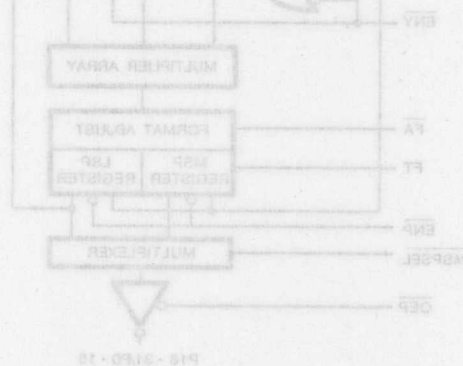
TABLE 1. HMU16/883 D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +4.0mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output or I/O Leakage Current	$I_O$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.5V$ , Outputs Open	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 1.0MHz$ , $V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ (Note 2)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	7.0	mA
Functional Test	FT	(Note 3)	7, 8	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	-	

#### NOTES:

- Interchanging of force and sense conditions is permitted.
- Operating Supply Current is proportional to frequency, typical rating is 5mA/MHz.
- Tested as follows:  $f = 1MHz$ ,  $V_{IH}$  (Clock Inputs) = 3.0,  $V_{IH}$  (All other inputs) = 2.6,  $V_{IL} = 0.4$ ,  $V_{OH} \geq 1.5V$ , and  $V_{OL} \leq 1.5V$ .



CAUTION: These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.

# Specifications HMU17/883

TABLE 2. HMU17/883 A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	(NOTE 1) CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	-45		-60		UNITS
					MIN	MAX	MIN	MAX	
Unlocked Multiply Time	T <sub>MUC</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	70	-	90	ns
Clocked Multiply Time	T <sub>MC</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	45	-	60	ns
X, Y, RND Setup Time	T <sub>S</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	18	-	20	-	ns
Clock HIGH Pulse Width	T <sub>PWH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
Clock LOW Pulse Width	T <sub>PWL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
MSPSEL to Product Out	T <sub>PDSEL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	25	-	30	ns
Output Clock to P	T <sub>PD</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	25	-	30	ns
Output Clock to Y	T <sub>PDY</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	25	-	30	ns
3-State Enable Time	T <sub>ENA</sub>	(Note 2)	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	25	-	30	ns
Clock Enable Setup	T <sub>SE</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	15	-	ns

## NOTES:

- AC Testing as follows: V<sub>CC</sub> = 4.5V and 5.5V. Input levels 0V and 3.0V. Timing reference levels = 1.5V. Output load per test load circuit, with V<sub>I</sub> = 2.4V, R<sub>I</sub> = 500Ω and C<sub>L</sub> = 40pF.
- Transition is measured at ± 200mV from steady state voltage. Output loading per test load circuit, with V<sub>I</sub> = 1.5V, R<sub>I</sub> = 500Ω and C<sub>L</sub> = 40pF.

CONFORMANCE GROUP	METHOD	SUBGROUPS
Initial Test	100% P001	-
Interim Test	100% P004	-
PDA	100%	1
Final Test	100%	2, 3, 4A, 5B, 10, 11
Group A	-	1, 2, 3, 4A, 5B, 9, 10, 11
Group C & D	100% P002	1, 7, 8

CAUTION: These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.



# Specifications HMU17/883

TABLE 3. HMU17/883 ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETER	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	-45		-60		UNITS
					MIN	MAX	MIN	MAX	
Input Capacitance	$C_{IN}$	$V_{CC} = \text{Open}, f = 1\text{MHz}$ All Measurements are referenced to device GND.	1	$T_A = +25^\circ\text{C}$	-	15	-	15	pF
Output Capacitance	$C_{OUT}$		1	$T_A = +25^\circ\text{C}$	-	10	-	10	pF
I/O Capacitance	$C_{I/O}$		1	$T_A = +25^\circ\text{C}$	-	10	-	10	pF
X, Y, RND Hold Time	$T_H$		1, 2	$-55^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	3	-	3	-	ns
3-State Disable Time	$T_{DIS}$		1, 2, 3	$-55^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	-	25	-	30	ns
Clock Enable Hold Time	$T_{HE}$		1, 2, 3	$-55^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	3	-	3	-	ns
Output Rise Time	$T_R$	From 0.8V to 2.0V	1, 2, 4	$-55^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	-	10	-	10	ns
Output Fall Time	$T_F$	From 2.0V to 0.8V	1, 2, 4	$-55^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$	-	10	-	10	ns

## NOTES:

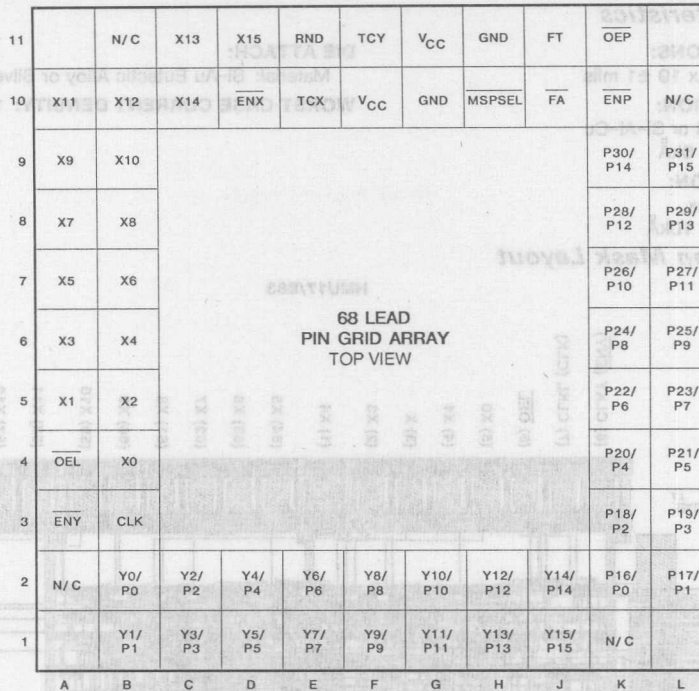
1. The parameters listed in Table 3 are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design and after major process and/or design changes.
2. Guaranteed, but not 100% tested.
3. Transition is measured at  $\pm 200\text{mV}$  from steady state voltage. Output loading per test load circuit, with  $V_1 = 1.5\text{V}$ ,  $R_1 = 500\Omega$  and  $C_L = 40\text{pF}$ .
4. Loading is as specified in the test load circuit, with  $V_1 = 2.4\text{V}$ ,  $R_1 = 500\Omega$  and  $C_L = 40\text{pF}$ .

TABLE 4. APPLICABLE SUBGROUPS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9

CAUTION: These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.

**Burn-In Circuit**



PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
B6	X4	F6	F1	Y9/P9	F11	K7	P10/P26	V <sub>CC</sub> /2	E11	RND	F1
A6	X3	F5	G2	Y10/P10	F12	L7	P11/P27	V <sub>CC</sub> /2	D10	ENX	F0
B5	X2	F4	G1	Y11/P11	F13	K8	P12/P28	V <sub>CC</sub> /2	D11	X15	F3
A5	X1	F3	H2	Y12/P12	F14	L8	P13/P29	V <sub>CC</sub> /2	C10	X14	F2
B4	X0	F2	H1	Y13/P13	F15	K9	P14/P30	V <sub>CC</sub> /2	C11	X13	F15
A4	OEL	V <sub>CC</sub>	J2	Y14/P14	F4	L9	P15/P31	V <sub>CC</sub> /2	B10	X12	F14
B3	CLK	F0	J1	Y15/P15	F5	K10	ENP	F0	A10	X11	F13
A3	ENY	F0	K2	P0/P16	V <sub>CC</sub> /2	K11	OEP	F1	B9	X10	F12
B2	Y0/P0	F2	L2	P1/P17	V <sub>CC</sub> /2	J10	FA	F14	A9	X9	F11
B1	Y1/P1	F3	K3	P2/P18	V <sub>CC</sub> /2	J11	FT	F15	B8	X8	F10
C2	Y2/P2	F4	L3	P3/P19	V <sub>CC</sub> /2	H10	MSPSEL	F14	A8	X7	F9
C1	Y3/P3	F5	K4	P4/P20	V <sub>CC</sub> /2	H11	GND	GND	B7	X6	F8
D2	Y4/P4	F6	L4	P5/P21	V <sub>CC</sub> /2	G10	GND	GND	A7	X5	F7
D1	Y5/P5	F7	K5	P6/P22	V <sub>CC</sub> /2	G11	V <sub>CC</sub>	V <sub>CC</sub>	A2	N.C.	NONE
E2	Y6/P6	F8	L5	P7/P23	V <sub>CC</sub> /2	F10	V <sub>CC</sub>	V <sub>CC</sub>	K1	N.C.	NONE
E1	Y7/P7	F9	K6	P8/P24	V <sub>CC</sub> /2	F11	TCY	F15	L10	N.C.	NONE
F2	Y8/P8	F10	L6	P9/P25	V <sub>CC</sub> /2	E10	TCX	F15	B11	N.C.	NONE

**NOTES:**

- V<sub>CC</sub> = 5.0V +0.5V/-0.0V with 0.1μF decoupling capacitor to GND.
- F0 = 100kHz, F1 = F0/2, F2 = F1/2, .....
- V<sub>IH</sub> = V<sub>CC</sub> - 1V ± 0.5V (Min), V<sub>IL</sub> = 0.8V (Max).
- 47kΩ load resistors used on all pins except V<sub>CC</sub> and GND (Pin-Grid identifiers F10, G10, G11 and H11).

# **Die Characteristics**

## **DIE DIMENSIONS:**

179 x 169 x 19 ±1 mils

## **METALLIZATION:**

Type: Si-Al or Si-Al-Cu

Thickness: 8kÅ

## **GLASSIVATION:**

Type: Nitrox

Thickness: 10kÅ

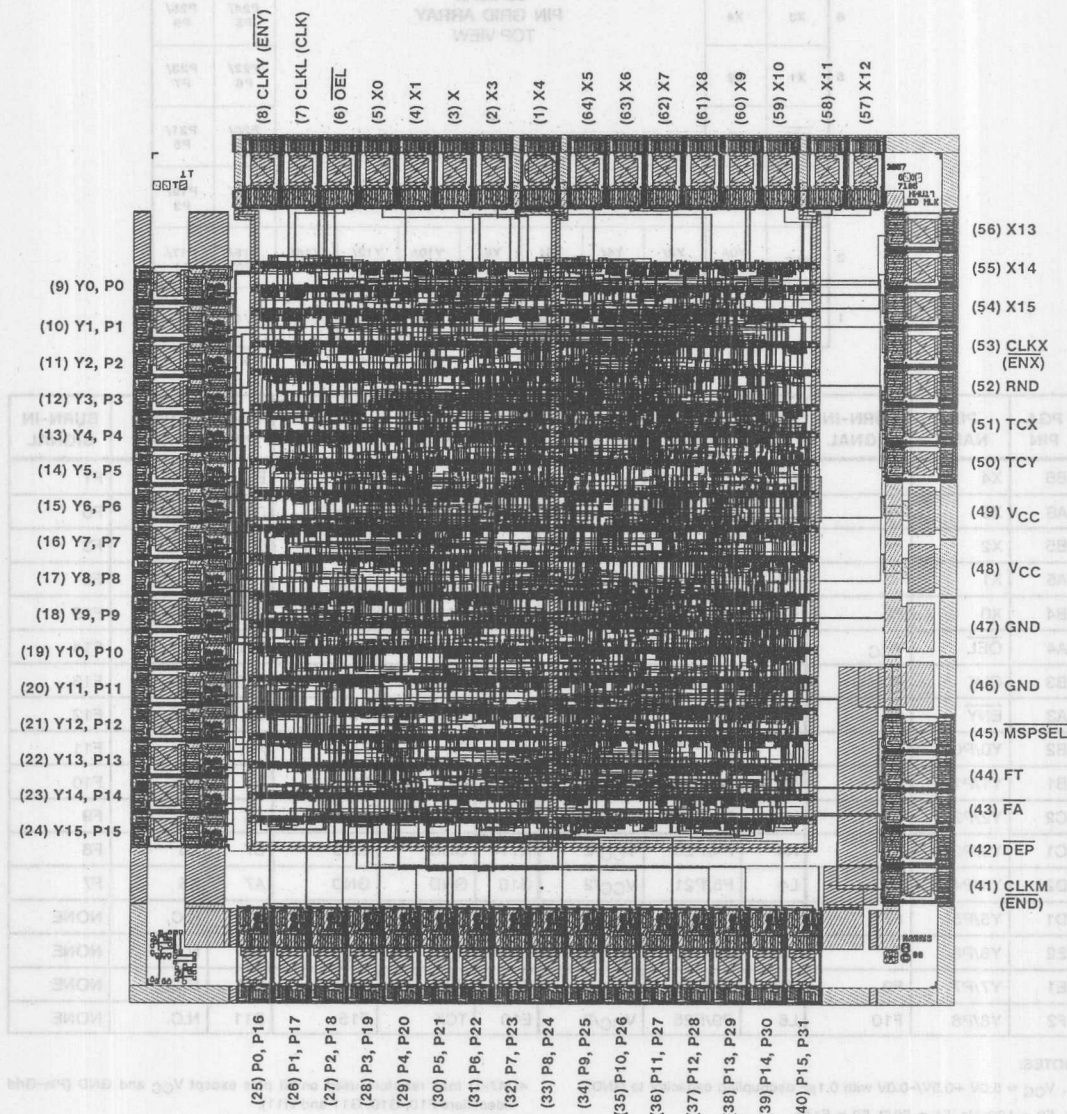
# **Metallization Mask Layout**

## **DIE ATTACH:**

Material: Si-Au Eutectic Alloy or Silver-Glass

**WORST CASE CURRENT DENSITY:** 1.2 x 10<sup>5</sup>A/cm<sup>2</sup>

HMU17/883



## ONE DIMENSIONAL FILTERS

DATA SHEETS		PAGE
HSP43168	Dual FIR Filter .....	3-3
HSP43168/883	Dual FIR Filter .....	3-19
HSP43220	Decimating Digital Filter .....	3-27
HSP43220/883	Decimating Digital Filter .....	3-47
HSP43481	Digital Filter .....	3-54
HSP43481/883	Digital Filter .....	3-69
HSP43881	Digital Filter .....	3-74
HSP43881/883	Digital Filter .....	3-89
HSP43891	Digital Filter .....	3-95
HSP43891/883	Digital Filter .....	3-110
HSP43216	Halfband Filter .....	3-116





August 1992

Dual FIR Filter

## Features

- Two Independent 8-Tap FIR Filters Configurable as a Single 16-Tap FIR
- 10 Bit Data & Coefficients
- On-Board Storage for 32 Programmable Coefficient Sets
- Up To: 256 FIR Taps, 16 x 16 2-D Kernels, or 10 x 19 Bit Data and Coefficients
- Programmable Decimation to 16
- Programmable Rounding on Output
- Mixed Mode Arithmetic
- Standard Microprocessor Interface
- 33MHz, 45MHz Versions
- 84-Pin PGA And PLCC Packages

## Applications

- Quadrature Filtering
- Correlation
- Image Processing
- Complex Filtering
- PolyPhase Filtering
- Adaptive Filtering

## Description

The HSP43168 Dual FIR Filter consists of two independent 8-tap FIR filters. Each filter supports decimation from 1 to 16 and provides on-board storage for 32 sets of coefficients. The Block Diagram shows two FIR cells each fed by a separate coefficient bank and one of two separate inputs. The outputs of the FIR cells are either summed or multiplexed by the MUX/Adder. The compute power in the FIR Cells can be configured to provide quadrature filtering, complex filtering, 2-D convolution, 1-D/2-D correlations, and interpolating/decimating filters.

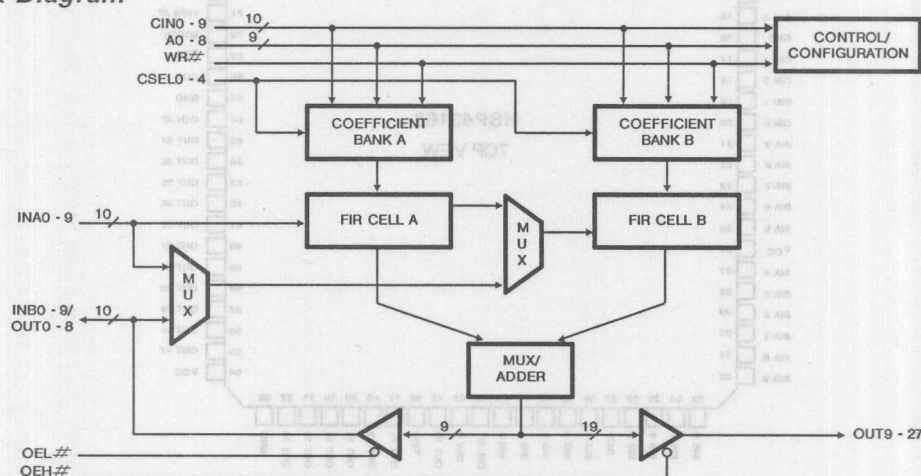
The FIR cells take advantage of symmetry in FIR coefficients by pre-adding data samples prior to multiplication. This allows an 8-tap FIR to be implemented using only 4 multipliers per filter cell. These cells can be configured as either a single 16-tap FIR filter or dual 8-tap FIR filters. Asymmetric filtering is also supported.

Decimation of up to 16 is provided to boost the effective number of filter taps from 2 to 16 times. Further, the decimation registers provide the delay necessary for fractional data conversion and 2-D filtering with kernels to 16x16.

The flexibility of the Dual is further enhanced by 32 sets of user programmable coefficients. Coefficient selection may be changed asynchronously from clock to clock. The ability to toggle between coefficient sets further simplifies applications such as polyphase or adaptive filtering.

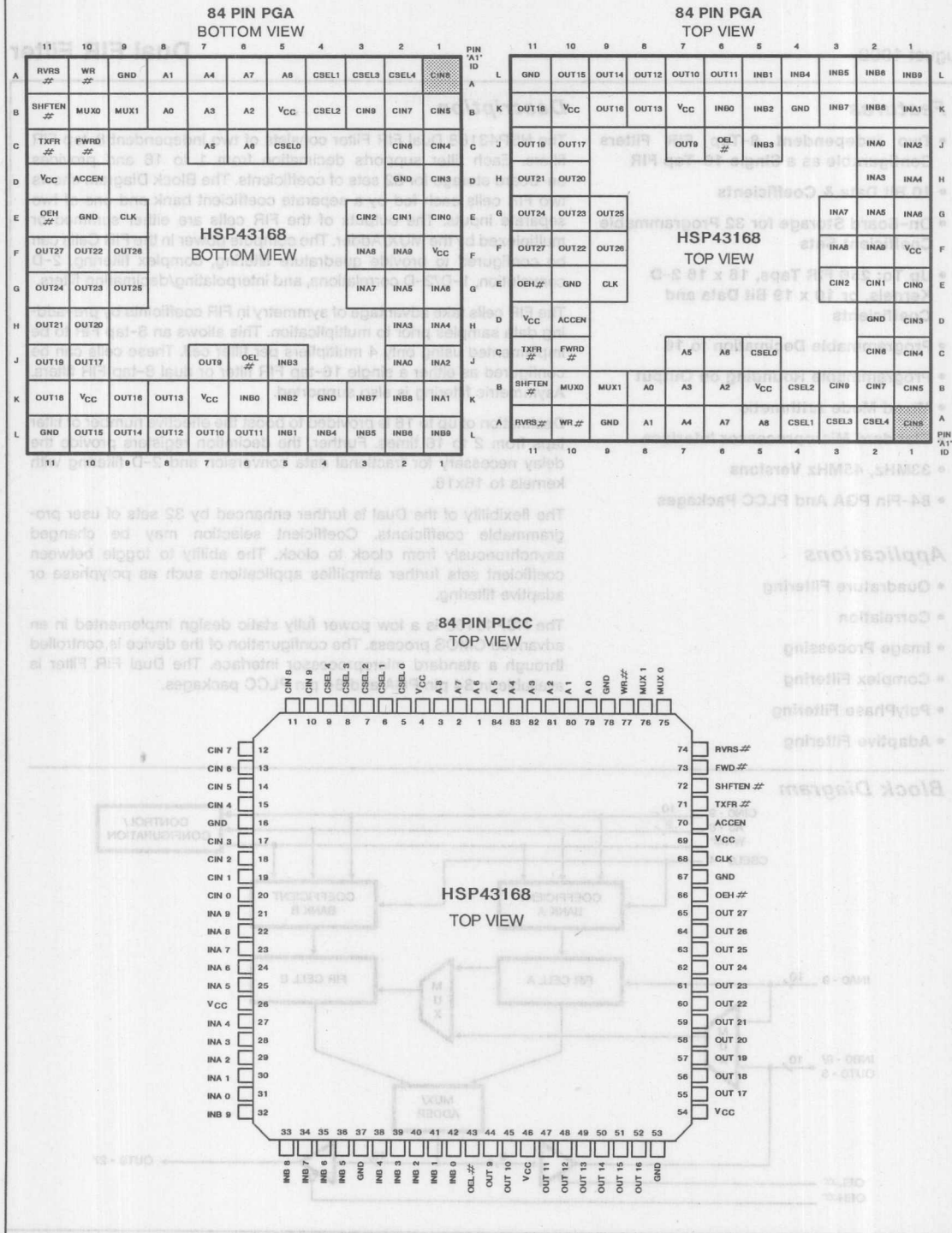
The HSP43168 is a low power fully static design implemented in an advanced CMOS process. The configuration of the device is controlled through a standard microprocessor interface. The Dual FIR Filter is available in 84 pin PGA and 84 pin PLCC packages.

## Block Diagram



# HSP43168

## Pinouts

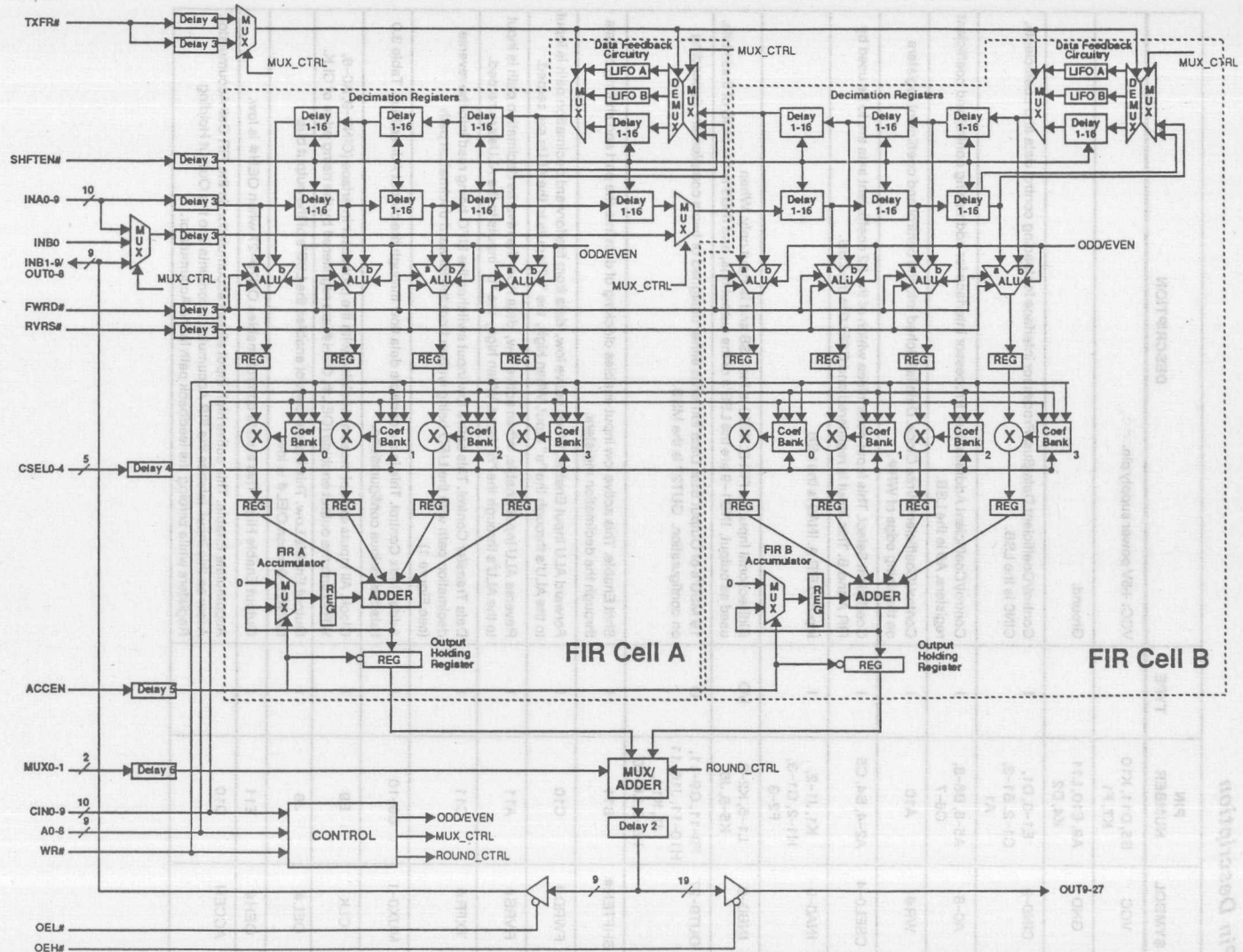


## Pin Description

SYMBOL	PIN NUMBER	TYPE	DESCRIPTION
VCC	B5, D11, K10 K7, F1		VCC: +5V power supply pin.
GND	A9, E10, L11 K4, D2		Ground.
CIN0-9	E1-3, D1, C1-2, B1-3, A1	I	Control/Coefficient Data Bus. Processor interface for loading control data and coefficients. CIN0 is the LSB.
A0-8	A5-8, B6-8, C6-7	I	Control/Coefficient Address Bus. Processor interface for addressing control and coefficient registers. A0 is the LSB.
WR#	A10	I	Control/Coefficient Write Clock. Data is latched into the control and coefficient registers on the rising edge of WR#.
CSEL0-4	A2-4, B4, C5	I	Coefficient Select. This input determines which of the 32 coefficient sets are to be used by FIR A and B. This input is registered and CSEL0 is the LSB.
INA0-9	K1, J1-2, H1-2, G1-3, F2-3	I	Input to FIR A. INA0 is the LSB
INB0-9	L1-5, K2-3 K5-6, J5	I/O	Bidirectional Input for FIR B. INB0 is the LSB and is input only. When used as output, INB1-9 are the LSB's of the output bus, and INB9 is the MSB of these bits.
OUT9-27	F9-11, G9-11, H10-11, J10-11 J7, K11, K8-9, L6-10	O	19 MSB's of Output Bus. Data format is either unsigned or two's complement depending on configuration. OUT27 is the MSB.
SHFTEN#	B11	I	Shift Enable. This active low input enables clocking of data into the part and shifting of data through the decimation registers.
FWRD#	C10	I	Forward ALU Input Enable. When active low, data from the forward decimation path is input to the ALU's through the "a" input. When high, the "a" inputs to the ALUs are zeroed.
RVR#	A11	I	Reverse ALU Input Enable. When active low, data from the reverse decimation path is input to the ALU's through the "b" input. When high, the "b" inputs to the ALUs are zeroed.
TXFR#	C11	I	Data Transfer Control. This active low input switches the LIFO being read into the reverse decimation path with the LIFO being written from the forward decimation path (see Figure 1).
MUX0-1	B9-10	I	Adder/Mux Control. This input controls data flow through the output Adder/Mux. Table 3.0 lists the various configurations.
CLK	E9	I	Clock. All inputs except those associated with the processor interface (CIN0-9, A0-8, WR#) and the output enables (OEL#, OEH#) are registered by the rising edge of CLK.
OEL#	J6	I	Output Enable Low. This tristate control enables the LSB's of the output bus to INB1-9 when OEL# is low.
OEH#	E11	I	Output Enable High. This tristate control enables OUT9-27 when OEH# is low.
ACCEN	D10	I	Accumulate Enable. This active high input allows accumulation in the FIR Cell Accumulator. A low on this input latches the FIR Accumulator contents into the Output Holding Registers while zeroing the feedback path in the Accumulator.



FIGURE 1. DUAL FIR FILTER



## Functional Description

As shown in Figure 1.0, the HSP43168 consists of two 4-multiplier FIR filter cells which process 10 bit data and coefficients. The FIR cells can operate as two independent 8-tap FIR filters or two 4-tap asymmetric filters at maximum I/O rates. A single filter mode is provided which allows the FIR cells to operate as one 16-tap FIR filter or one 8-tap asymmetric filter. On board coefficient storage for up to 32 sets of 8 coefficients is provided. The coefficient sets are user selectable and are programmed through a microprocessor interface. Programmable decimation to 16 is also provided. By utilizing decimation registers together with the coefficient sets, polyphase filters are realizable which allow the user to trade data rate for filter taps. The MUX/ Adder can be configured to either add or multiplex the outputs of the filter cells depending upon whether the cells are operating in single or dual filter mode. In addition, a shifter in the MUX/Adder is provided for implementation of filters with 10 bit data and 20 bit coefficients or vice versa.

## Microprocessor Interface

The Dual has a 20 pin write only microprocessor interface for loading data into the Control Block and Coefficient Bank. The interface consists of a 10-bit data bus (CIN0-9), a 9 bit address bus (AO-8), and a write input (WR#) to latch the data into the on-board registers. The control and coefficient data can be loaded asynchronously to CLK.

## Control Block

The Dual FIR is configured by writing to the registers within the Control Block. These registers are memory mapped to address 000H (H = Hexadecimal) and 001H on A0-8. The format of these registers is shown in Table 1 and Table 2. Writing the Control/Configuration registers causes a reset which lasts for 6 CLK cycles following the assertion of WR#. The reset caused by writing registers in the Control Block will not clear the contents of the Coefficient Bank.

TABLE 1

CONTROL ADDRESS 000H		
BITS	FUNCTION	DESCRIPTION
3-0	Decimation Factor	0000=No Decimation 1111=Decimation by 16
4	Mode Select	0 = Single Filter Mode 1 = Dual Filter Mode
5	Odd/Even Symmetry	0 = Even symmetric coefficients 1 = Odd symmetric coefficients
6	FIR A odd/even taps	0 = Odd number of taps in filter 1 = Even number of taps in filter
7	FIR B odd/even taps	(Defined same as FIR A above)
8	FIR B Input Source	0 = Input from INA0-9 1 = Input from INB0-9
9	Not Used	Set to 0 for proper operation

The 4 LSBs of the control word loaded at address 000H are used to select the decimation factor. For example, if the 4

LSBs are programmed with a value of 0010, the forward and reverse shifting decimation registers are each configured with a delay of 3. Bit 4 is used to select whether the FIR cells operate as two independent filters or one extended length filter. Coefficient symmetry is selected by bit 5. Bits 6 and 7 are programmed to configure the FIR cells for odd or even filter lengths. Bit 8 selects the FIR B input source when the FIR cells are configured for independent operation. Bit 9 must be programmed to 0.

The 4 LSB's of the control word loaded at address 001H are used to configure the format of the FIR cell's data and coefficients. Bit 4 is programmed to enable or disable the reversal of data sample order prior to entering the backward shifting decimation registers. Bits 5-9 are used to support programmable rounding on the output.

TABLE 2

CONTROL ADDRESS 001H		
BITS	FUNCTION	DESCRIPTION
0	FIR A Input Format	0 = Unsigned 1 = Two's Complement
1	FIR A Coefficient Format	(Defined same as FIR A input)
2	FIR B Input Format	(Defined same as FIR A input)
3	FIR B Coefficient	(Defined same as FIR A input)
4	Data Reversal Enable	0 = Enabled 1 = Disabled
8-5	Round Position	0000 = 2 <sup>-10</sup> 1011 = 2 <sup>1</sup>
9	Round Enable	0 = Enabled 1 = Disabled

NOTE: Address locations 002H to 1fH are reserved, and writing to these locations will have unpredictable effects on part configuration.

## FIR Filter Cells

Each FIR filter cell is based on an array of four 11x10 bit two's complement multipliers. The multipliers get one input from the ALUs which combine data shifting through the forward and backward decimation registers. The second input comes from the user programmable coefficient bank. The multiplier outputs feed an accumulator whose result is passed to the output section where it is multiplexed or added.

## Decimation Registers

The forward and backward shifting registers are configurable for decimation by 1 to 16 (see Table 1). The backward shifting registers are used to take advantage of symmetry in linear phase filters by aligning data at the ALU's for pre-addition prior to multiplication by the common coefficient. When the FIR cells are configured in single filter mode, the decimation registers in each cell are cascaded. This lengthened delay path allows computation of a filter which is twice the size of that capable in a single cell. The decimation registers also provide data storage for poly-phase or 2-D filtering applications (See Applications Examples section).

The Data Feedback Circuitry in each FIR cell is responsible for transferring data from the forward to the backward shifting decimation registers. This circuitry feeds blocks of samples into the backward shifting decimation path in either reversed or non-reversed sample order. The MUX/DEMUX structure at the input to the Feedback Circuitry routes data to the LIFO's or the delay stage depending on configuration. The MUX on the Feedback Circuitry Output selects the storage element which feeds the backward shifting decimation registers.

In applications requiring reversal of sample order, such as FIR filtering with decimation, the FIR cells are configured with data reversal enabled (see Table 2). In this mode, data is transferred from the forward to the backward shifting registers through a ping-ponged LIFO structure. While one LIFO is being read into the backward shifting path, the other is written with data samples. The MUX/DEMUX controls which LIFO is being written, and the MUX on the Feedback Circuitry output controls which LIFO is being read. A low on TXFR# and SHFTEN#, switches the LIFO's being read and written, which causes the block of data read from the structure to be reversed in sample order (See Example 4 in the Application Examples section).

The frequency with which TXFR# is asserted determines size of the data blocks in which sample order is reversed. For example, if TXFR# is asserted once every three CLK's, blocks of 3 data samples with order reversed, would be fed into the backward decimation registers. Note: altering the frequency or phase of TXFR# assertion once a filtering operation has been started will cause unknown results.

In applications which do not require sample order reversal, the FIR cells must be configured with data reversal disabled (see Table 2). In addition, TXFR# must be asserted to ensure proper data flow. In this configuration, data to the backward shifting decimation path is routed through a delay stage instead of the ping-pong LIFO's. The number of registers in the delay stage is based on the programmed decimation factor. Note: data reversal must be disabled and TXFR# must be asserted for filtering applications which do not use decimation.

The shifting of data through the forward and reverse decimation registers is enabled by asserting the SHFTEN# input. When SHFTEN# transitions high, data shifting is disabled, and the data sample latched into the part on the previous clock is the last input to the forward decimation path. When SHFTEN# is asserted, shifting of data through the decimation paths is enabled. The data sample at the part input when SHFTEN# is asserted will be the next data sample into the forward decimation path.

When operating the FIR cells as two independent filters, FIR A receives input data via INA0-9 and FIR B receives data from either INA0-9 or INB0-9 depending on the configuration (Table 1). When the FIR cells are configured as a single extended length filter, the forward and backward decimation paths are cascaded. In this mode, data is transferred from the forward decimation path to the backward decimation path by the Data Feedback Circuitry in FIR B. Thus, the manner in which data is read into the backward shifting decimation path is determined by FIR B's configuration.

When the decimation paths are cascaded, data is routed through the delay stage in FIR A's Data Feedback Circuitry.

The configuration of the FIR cells as even or odd length filters determines the point in the forward decimation path from which data is multiplexed to the Data Feedback Circuitry. For example, if the FIR cell is configured as an odd length filter, data prior to the last register in the third forward decimation stage is routed to the Feedback Circuitry. If the FIR cell is configured as an even length filter, data output from the third forward decimation stage is multiplexed to the Feedback Circuitry. This is required to insure proper data alignment with symmetric filter coefficients (See Application Examples).

## ALUs

Data shifting through the forward and reverse decimation path feeds the "a" and "b" inputs of the ALUs respectively. The ALU's perform an "b+a" operation if the FIR cell is configured for even symmetric coefficients or an "b-a" operation if configured for odd symmetric coefficients.

For applications in which a pre-add or subtract is not required, the "a" or "b" input can be zeroed by disabling FWRD# or RVRS# respectively. This has the effect of producing an ALU output which is either "a", "-a", or "b" depending on the filter symmetry chosen. For example, if the FIR cell is configured for an even symmetric filter with FWRD# low and RVRS# high, the data shifting through the forward decimation registers would appear on the ALU output.

## Coefficient Bank

The output of the ALU is multiplied by a coefficient from one of 32 user programmable coefficient sets. Each set consists of 8 coefficients (4 coefficients for FIR A and 4 for FIR B). The active coefficient set is selected using CSEL0-4. The coefficient set may be switched every clock to support polyphase filtering operations.

The coefficients are loaded into on-board registers using the microprocessor interface, CINO-9, AO-8, and WR#. Each multiplier within the FIR Cells is driven by a coefficient bank with one of 32 coefficients. These coefficients are addressed as shown in Table 3. The inputs AO-1 specify the Coefficient Bank for one of the four multipliers in each FIR Cell; A2 specifies FIR Cell A or B; Bits A7-3 specify one of 32 sets in which the coefficient is to be stored. For example, an address of 10dH would access the coefficient for the second multiplier in FIR B in the second coefficient set.

TABLE 3

A8	A7-3	A2	A1-0	FIR	BANK
1	xxxxx	0	00	A	0
1	xxxxx	0	01	A	1
1	xxxxx	0	10	A	2
1	xxxxx	0	11	A	3
1	xxxxx	1	00	B	0
1	xxxxx	1	01	B	1
1	xxxxx	1	10	B	2
1	xxxxx	1	11	B	3

feed the FIR cells accumulator. The ACCEN input controls each accumulator's running sum and the latching of data from the accumulator into the Output Holding Registers. When ACCEN is low, feedback from the accumulator adder is zeroed which disables accumulation. Also, output from the accumulator is latched into the Output Holding Registers. When ACCEN is asserted, accumulation is enabled and the contents of the Output Holding Registers remain unchanged.

### Output MUX/Adder

The contents of each FIR Cell's Output Holding Register is summed or multiplexed in the Mux/Adder. The operation of the Mux/Adder is controlled by the MUX0-1 inputs as shown in Table 4. Applications requiring 10 bit data and 20 bit coefficients or 20 bit data and 10 bit coefficients are made possible by configuring the MUX/Adder to scale FIR B's output by  $2^{-10}$  prior to summing with FIR A. When the Dual FIR is configured as two independent filters, the MUX0-1 inputs would be used to multiplex the filter outputs of each cell. For applications in which FIR A and B are configured as a single filter, the MUX/Adder is configured to sum the output of each FIR cell.

TABLE 4

MUX0-1 DECODING	
MUX1-0	OUT0-27
00	FIRA + FIRB (FIR B Scaled by $2^{-10}$ )
01	FIRA + FIRB
10	FIRA
11	FIRB

### Input/Output Formats

The Dual FIR supports mixed mode arithmetic with both unsigned and two's complement data and coefficients. The input and output formats for both data types is shown below. If the Dual FIR is configured as an even symmetric filter with unsigned data and coefficients, the output will be unsigned. Otherwise, the output will be two's complement.

INPUT DATA FORMAT INA0-9, INB0-9  
FRACTIONAL TWO'S COMPLEMENT

9	8	7	6	5	4	3	2	1	0
$2^0$	$2^{-1}$	$2^{-2}$	$2^{-3}$	$2^{-4}$	$2^{-5}$	$2^{-6}$	$2^{-7}$	$2^{-8}$	$2^{-9}$

27	26	25	24	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9
$2^{-9}$	$2^{-8}$	$2^{-7}$	$2^{-6}$	$2^{-5}$	$2^{-4}$	$2^{-3}$	$2^{-2}$	$2^{-1}$	$2^0$	$2^{-1}$	$2^{-2}$	$2^{-3}$	$2^{-4}$	$2^{-5}$	$2^{-6}$	$2^{-7}$	$2^{-8}$	$2^{-9}$

OUTPUT DATA FORMAT OUT0-8  
FRACTIONAL TWO'S COMPLEMENT

8	7	6	5	4	3	2	1	0
$2^{-10}$	$2^{-11}$	$2^{-12}$	$2^{-13}$	$2^{-14}$	$2^{-15}$	$2^{-16}$	$2^{-17}$	$2^{-18}$

INPUT DATA FORMAT INA0-9, INB0-9  
FRACTIONAL UNSIGNED

9	8	7	6	5	4	3	2	1	0
$2^0$	$2^{-1}$	$2^{-2}$	$2^{-3}$	$2^{-4}$	$2^{-5}$	$2^{-6}$	$2^{-7}$	$2^{-8}$	$2^{-9}$

OUTPUT DATA FORMAT OUT9-27  
FRACTIONAL UNSIGNED

27	26	25	24	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9
$2^{-9}$	$2^{-8}$	$2^{-7}$	$2^{-6}$	$2^{-5}$	$2^{-4}$	$2^{-3}$	$2^{-2}$	$2^{-1}$	$2^0$	$2^{-1}$	$2^{-2}$	$2^{-3}$	$2^{-4}$	$2^{-5}$	$2^{-6}$	$2^{-7}$	$2^{-8}$	$2^{-9}$

OUTPUT DATA FORMAT OUT0-8  
FRACTIONAL UNSIGNED

8	7	6	5	4	3	2	1	0
$2^{-10}$	$2^{-11}$	$2^{-12}$	$2^{-13}$	$2^{-14}$	$2^{-15}$	$2^{-16}$	$2^{-17}$	$2^{-18}$

The MUX/Adder can be configured to implement programmable rounding at bit locations  $2^{-10}$  through  $2^{-1}$ . The round is implemented by adding a 1 to the specified location (see Table 2.0). For example, to configure the part such that the output is rounded to the 10 MSBs, OUT18-27, the round position would be chosen to be  $2^{-1}$ .

### Application Examples

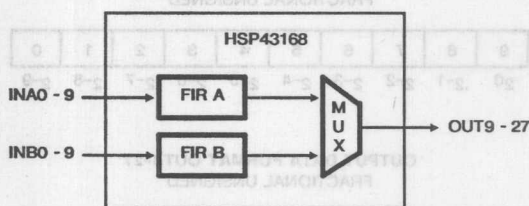
In this section a number of examples which show even, odd, symmetric, asymmetric and decimating filters are presented. These examples are intended to show different operational modes of the HSP43168. The examples are all based on a dual filter configuration. However, the same principles apply when the part is configured with both FIR cells operating as a single filter.



**Example 1. Even-Tap Symmetric Filter Example**

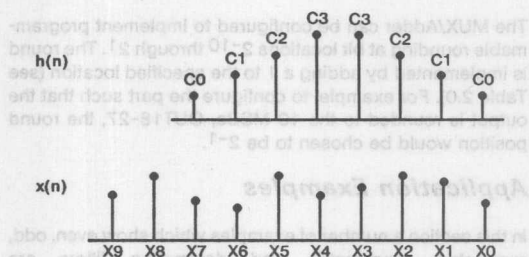
The HSP43168 may be configured as two independent 8-tap symmetric filters as shown by the block diagram in Figure 2. Each of the FIR cells takes advantage of symmetric filter coefficients by pre-adding data samples common to a given coefficient. As a result, each FIR cell can implement an 8-tap symmetric filter using only four multipliers. Similarly, when the HSP43168 is configured in single filter mode a 16-tap symmetric filter is possible by using the multipliers in both cells.

The operation of the FIR cell is better understood by comparing the data and coefficient alignment for a given filter output, Figure 3, with the data flow through the FIR cell, as shown in Figure 4. The block diagrams in Figure 4 are a simplification of the FIR cell shown in Figure 1. For simplicity, the ALU's and FIR Cell Accumulators were replaced by adders, and the pipeline delay registers were omitted.



**FIGURE 2. USING HSP43168 AS TWO INDEPENDENT FILTERS**

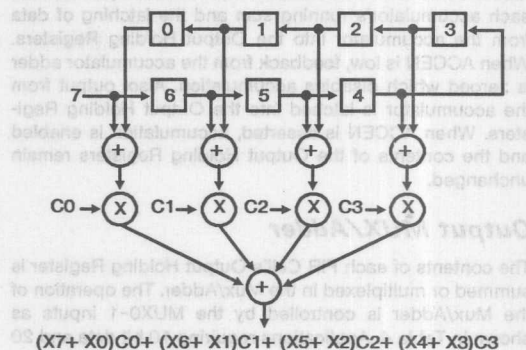
In Figure 4, the order of the data samples within the filter cell is shown by the numbers in the forward and backward shifting decimation paths. The output of the filter cell is given by the equation at the bottom of each block diagram. Figure 4a shows the data sample alignment at the pre-adders for the data/coefficient alignment shown in Figure 3.



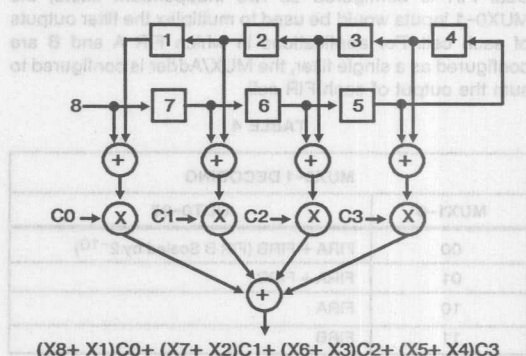
**FIGURE 3. DATA/COEFFICIENT ALIGNMENT FOR 8-TAP EVEN SYMMETRIC FILTER**

The dual filter application is configured by writing 1d0H to address 000H via the microprocessor interface, CIN0-9, A0-8, and WR#. Since this application does not use decimation, the 4th bit of the control register at address 001H must be set to disable data reversal (see Table 2). Failure to disable data reversal will produce erroneous results.

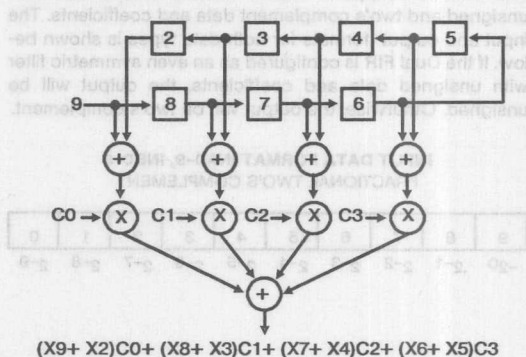
**A. DATA FLOW AS DATA SAMPLE 7 IS CLOCKED INTO THE FEED FORWARD STAGE.**



**B. DATA FLOW AS DATA SAMPLE 8 IS CLOCKED INTO THE FEED FORWARD STAGE.**



**C. DATA FLOW AS DATA SAMPLE 9 IS CLOCKED INTO THE FEED FORWARD STAGE.**



**FIGURE 4. DATA FLOW DIAGRAMS FOR 8-TAP SYMMETRIC FILTER**

Using this architecture, only the unique coefficients need to be stored in the Coefficient Bank. For example, the above filter would be stored in the first coefficient set for FIR A by writing C0, C1, C2, and C3 to address 100H, 101H, 102H, and 103H respectively. To write the same filter to the first coefficient set for FIR B, the address sequence would change to 104H, 105H, 106H, and 107H.

To operate the HSP43168 in this mode, TXFR# is tied low to ensure proper data flow; both FWRD# and RVRS# are tied low to enable data samples from the forward and reverse data paths to the ALU's for pre-adding; ACCEN is tied low to prevent accumulation over multiple CLK's; SHFTEN# is tied low to allow shifting of data through the decimation registers; MUX0-1 is programmed to multiplex the output of either FIR A or FIR B; CSEL0-4 is programmable to access the stored coefficient set, in this example CSEL = 0000.

### Example 2. Odd-Tap Symmetric Filter Example

The HSP43168 may be configured as two independent 7-tap symmetric filters with a functional block diagram resembling Figure 2. As in the 8-tap filter example, the HSP43168 implements the filtering operation by summing data samples sharing a common coefficient prior to multiplication by that coefficient. However, for odd length filters the pre-addition requires that the center coefficient be scaled by 1/2.

The operation of the FIR cell for odd length filters is better understood by comparing the data/coefficient alignment in Figure 5 with the data flow diagrams in Figure 6. The block diagrams in Figure 6 are a simplification of the FIR cell shown in Figure 1.

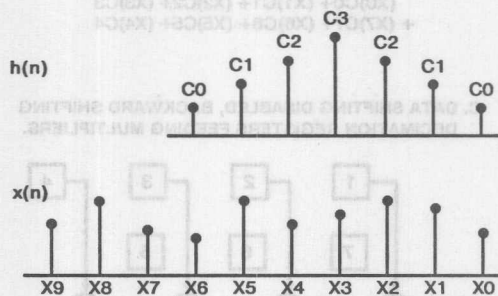
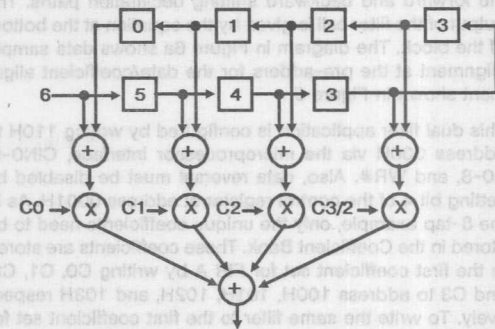


FIGURE 5. DATA/COEFFICIENT ALIGNMENT FOR 7-TAP SYMMETRIC FILTER

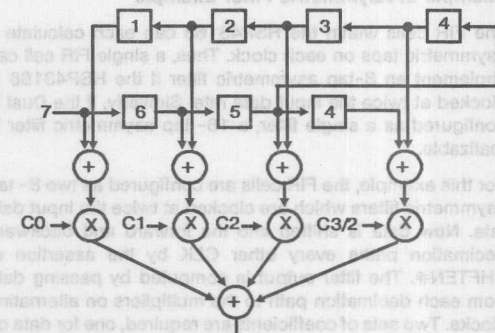
For odd length filters, proper data/coefficient alignment is ensured by routing data entering the last register in the third forward decimation stage to the backward shifting registers. In this configuration, the center coefficient must be scaled by 1/2 to compensate for the summation of the same data sample from both the forward and backward shifting registers.

### A. DATA FLOW AS DATA SAMPLE 6 IS CLOCKED INTO THE FEED FORWARD STAGE.



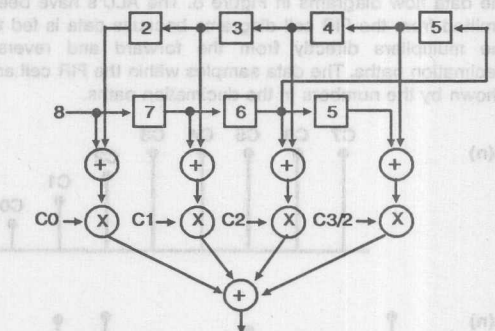
$$(X6 + X0)C0 + (X5 + X1)C1 + (X4 + X2)C2 + (X3 + X3)C3/2$$

### B. DATA FLOW AS DATA SAMPLE 7 IS CLOCKED INTO THE FEED FORWARD STAGE.



$$(X7 + X1)C0 + (X6 + X2)C1 + (X5 + X3)C2 + (X4 + X4)C3/2$$

### C. DATA FLOW AS DATA SAMPLE 8 IS CLOCKED INTO THE FEED FORWARD STAGE.



$$(X8 + X2)C0 + (X7 + X3)C1 + (X6 + X4)C2 + (X5 + X5)C3/2$$

FIGURE 6. DATA FLOW DIAGRAMS FOR 7-TAP SYMMETRIC FILTER.

In the data flow diagrams of Figure 6, the order of the data samples input to the filter cell is shown by the numbers in the forward and backward shifting decimation paths. The output of the filter cell is given by the equation at the bottom of the block. The diagram in Figure 6a shows data sample alignment at the pre-adders for the data/coefficient alignment shown in Figure 5.

This dual filter application is configured by writing 110H to address 000H via the microprocessor interface, CIN0-9, A0-8, and WR#. Also, data reversal must be disabled by setting bit 4 of the control register at address 0001H. As in the 8-tap example, only the unique coefficients need to be stored in the Coefficient Bank. These coefficients are stored in the first coefficient set for FIR A by writing C0, C1, C2, and C3 to address 100H, 101H, 102H, and 103H respectively. To write the same filter to the first coefficient set for FIR B, the address sequence would change to 104H, 105H, 106H, and 107H. The control signals TXFR#, FWRD#, RVRS#, ACCEN, SHFTEN#, and CSEL0-4 are controlled as described in Example 1.

### Example 3. Asymmetric Filter Example

The FIR cells within the HSP43168 can each calculate 4 asymmetric taps on each clock. Thus, a single FIR cell can implement an 8-tap asymmetric filter if the HSP43168 is clocked at twice the input data rate. Similarly, if the Dual is configured as a single filter, a 16-tap asymmetric filter is realizable.

For this example, the FIR cells are configured as two 8-tap asymmetric filters which are clocked at twice the input data rate. New data is shifted into the forward and backward decimation paths every other CLK by the assertion of SHFTEN#. The filter output is computed by passing data from each decimation path to the multipliers on alternating clocks. Two sets of coefficients are required, one for data on the forward decimation path, and one for data on the reverse path. The filter output is generated by accumulating the multiplier outputs for two CLKs.

The operation of this configuration is better understood by comparing the data/coefficient alignment in Figure 7 with the data flow diagrams in Figure 8. The ALU's have been omitted from the FIR cell diagrams because data is fed to the multipliers directly from the forward and reverse decimation paths. The data samples within the FIR cell are shown by the numbers in the decimation paths.

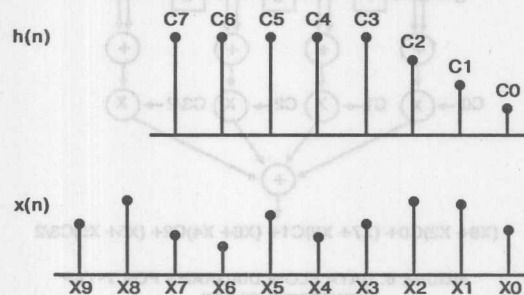
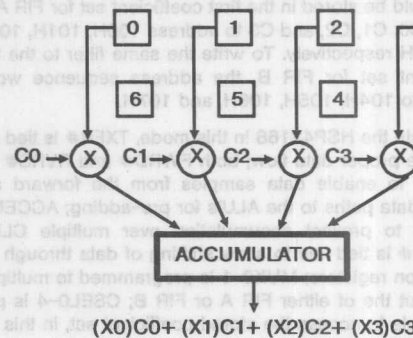
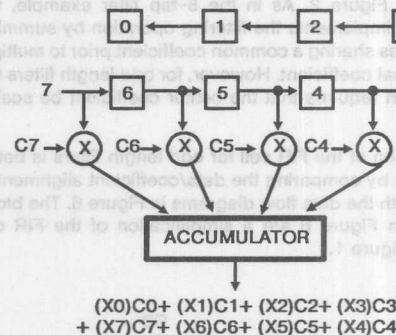


FIGURE 7. DATA/COEFFICIENT ALIGNMENT FOR 8-TAP ASYMMETRIC FILTER

### A. DATA SHIFTING DISABLED, BACKWARD SHIFTING DECIMATION REGISTERS FEEDING MULTIPLIERS.



### B. SHIFTING OF DATA SAMPLE 7 INTO FIR CELL ENABLED, FORWARD SHIFTING REGISTERS FEEDING MULTIPLIERS.



### C. DATA SHIFTING DISABLED, BACKWARD SHIFTING DECIMATION REGISTERS FEEDING MULTIPLIERS.

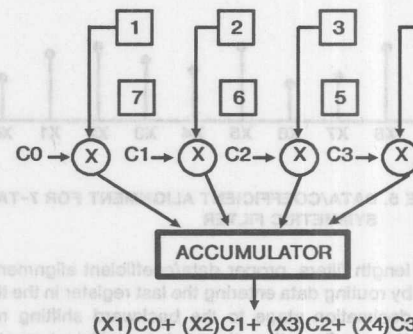
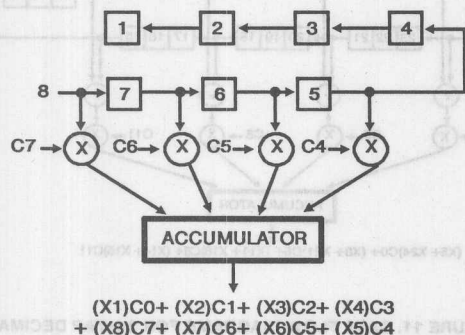


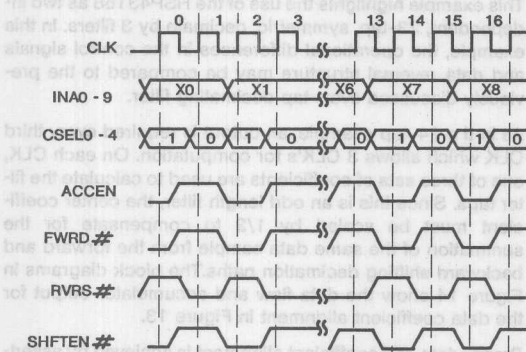
FIGURE 8. DATA FLOW DIAGRAMS FOR 8-TAP ASYMMETRIC FILTER



**FIGURE 8. DATA FLOW DIAGRAMS FOR 8-TAP ASYMMETRIC FILTER CONTINUED**

For this application, each filter cell is configured as an odd length filter by writing 110H to the control register at address 000H. Even though an even tap filter is being implemented, the filter cells must be configured as odd length to ensure proper data flow. Also, the 4th bit at control address 001H must be set to disable data reversal, and TXFR# must be tied low. Since an 8-tap asymmetric filter is being implemented, two sets of coefficients must be stored. These eight coefficients could be loaded into the first two coefficient sets for FIR A by writing C0, C1, C2, C3, C7, C6, C5, and C4 to address 100H, 101H, 102H, 103H, 108H, 109H, 10aH, and 10bH respectively.

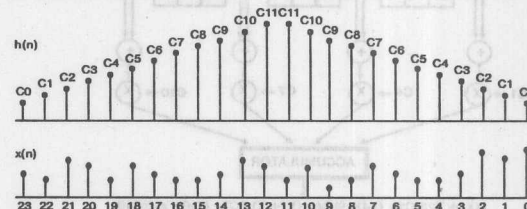
The sum of products required for this 8-tap filter require dynamic control over FWRD#, RVRS#, ACCEN, and CSEL0-4. The relative timing of these signals is shown in Figure 9.



**FIGURE 9. CONTROL TIMING FOR 8-TAP ASYMMETRIC FILTER**

is reduced by a factor of N. As a result, N clock cycles can be used for the computation of the filter output. For example, each FIR cell can calculate 8 symmetric or 4 asymmetric taps in one clock. If the application requires decimation by two, the filter output can be calculated over two clocks thus boosting the number of taps per FIR cell to 16 symmetric or 8 asymmetric. For this example, each FIR cell is configured as an independent 24-tap decimate x3 filter.

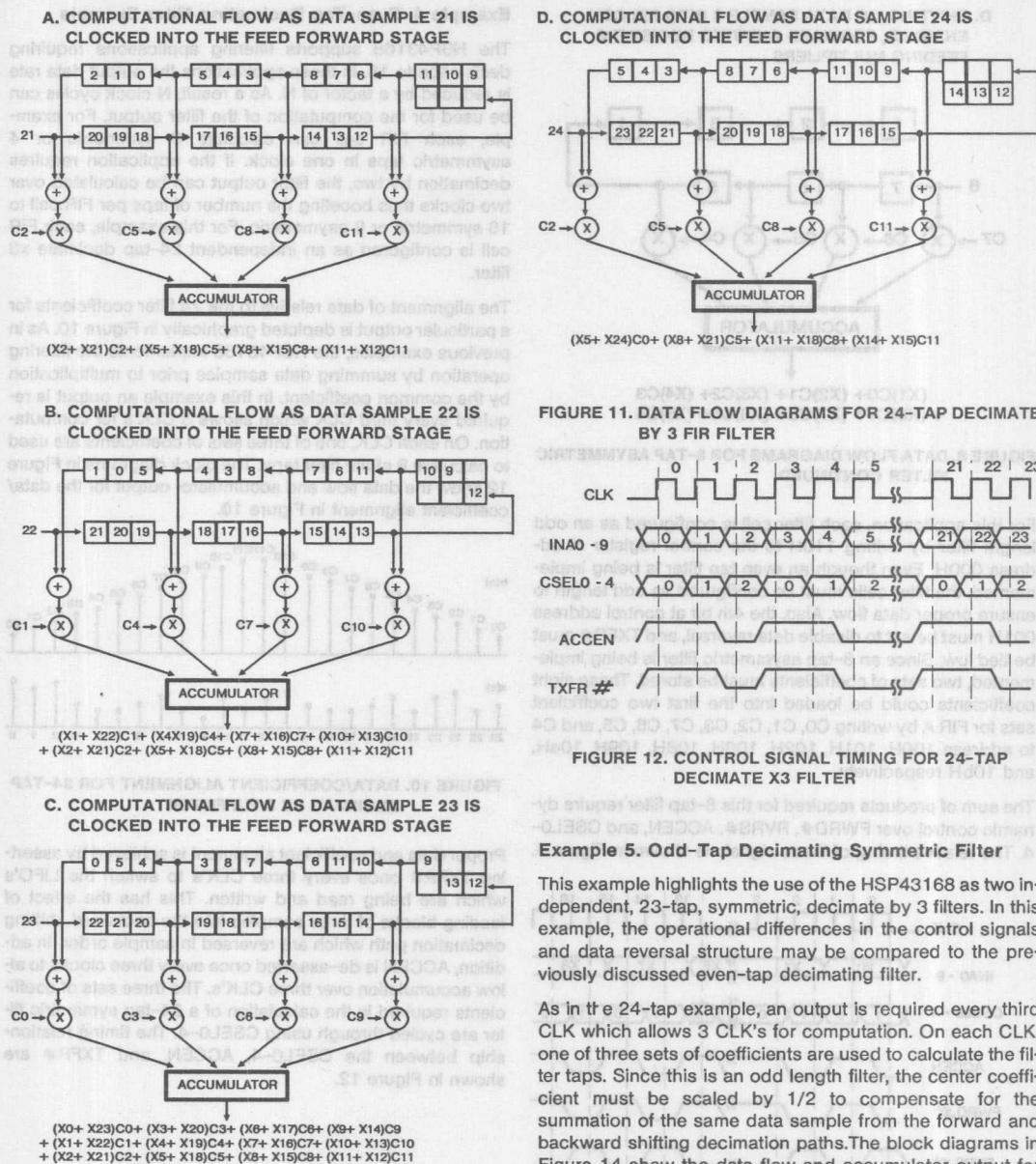
The alignment of data relative to the 24 filter coefficients for a particular output is depicted graphically in Figure 10. As in previous examples, the HSP43168 implements the filtering operation by summing data samples prior to multiplication by the common coefficient. In this example an output is required every third CLK which allows 3 CLK's for computation. On each CLK, one of three sets of coefficients are used to calculate 8 of the filter taps. The block diagrams in Figure 12 show the data flow and accumulator output for the data/coefficient alignment in Figure 10.



**FIGURE 10. DATA/COEFFICIENT ALIGNMENT FOR 24-TAP DECIMATE BY 3 FIR FILTER**

Proper data and coefficient alignment is achieved by asserting TXFR# once every three CLK's to switch the LIFO's which are being read and written. This has the effect of feeding blocks of three samples into the backward shifting decimation path which are reversed in sample order. In addition, ACCEN is de-asserted once every three clocks to allow accumulation over three CLK's. The three sets of coefficients required in the calculation of a 24-tap symmetric filter are cycled through using CSEL0-4. The timing relationship between the CSEL0-4, ACCEN, and TXFR# are shown in Figure 12.





To operate in this mode the Dual is configured by writing 1d2 to address 000H via the microprocessor interface, CINO-9, A0-8, and WR#. Data reversal must be enabled see (Table 2.0). The 12 unique coefficients for this example are stored as three sets of coefficients for either FIR cell. For FIR A, the coefficients are loaded into the Coefficient Bank by writing C2, C5, C8, C11, C1, C4, C7, C10, C0, C3, C6, and C9 to address 100H, 101H, 102H, 103H, 108H, 109H, 10aH, 10bH, 110H, 111H, 112H, and 113H respectively.

#### Example 5. Odd-Tap Decimating Symmetric Filter

This example highlights the use of the HSP43168 as two independent, 23-tap, symmetric, decimate by 3 filters. In this example, the operational differences in the control signals and data reversal structure may be compared to the previously discussed even-tap decimating filter.

As in the 24-tap example, an output is required every third CLK which allows 3 CLK's for computation. On each CLK, one of three sets of coefficients are used to calculate the filter taps. Since this is an odd length filter, the center coefficient must be scaled by 1/2 to compensate for the summation of the same data sample from the forward and backward shifting decimation paths. The block diagrams in Figure 14 show the data flow and accumulator output for the data coefficient alignment in Figure 13.

Proper data and coefficient alignment is achieved by asserting TXFR# once every three CLK's to switch the LIFO's which are being read and written. For odd length filters, data prior to the last register in the forward decimation path is routed to the Feedback Circuitry. As a result, TXFR# should be asserted one cycle prior to the input data samples which align with the center tap. The timing relationship between the CSEL0-5, ACCEN, and TXFR# are shown in Figure 15.

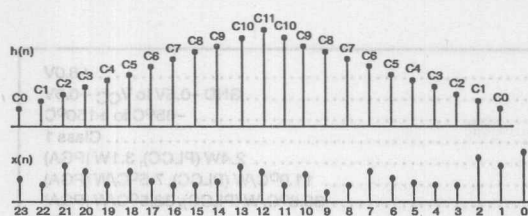
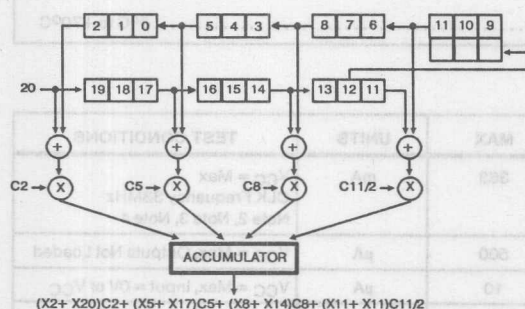
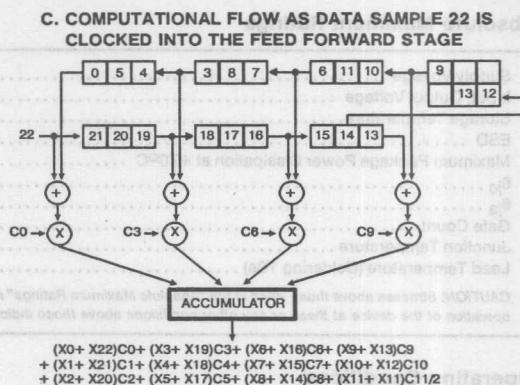
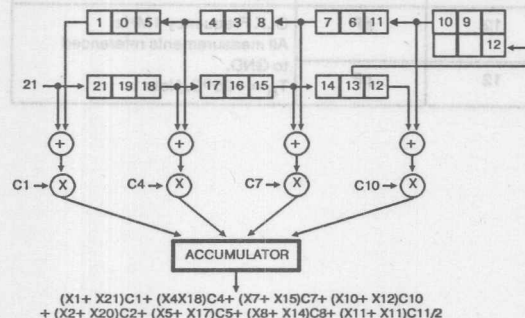


FIGURE 13. DATA/COEFFICIENT ALIGNMENT FOR 23-TAP DECIMATE BY 3 SYMMETRIC FILTER



A. COMPUTATIONAL FLOW AS DATA SAMPLE 20 IS CLOCKED INTO THE FEED FORWARD STAGE



B. COMPUTATIONAL FLOW AS DATA SAMPLE 21 IS CLOCKED INTO THE FEED FORWARD STAGE

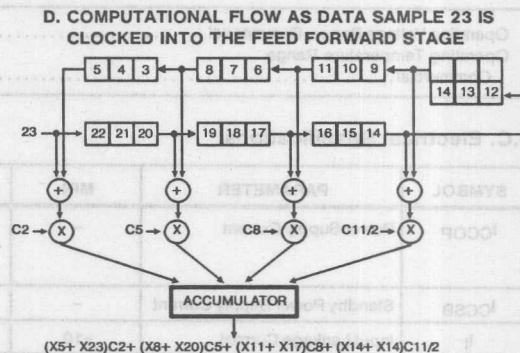


FIGURE 14. DATA FLOW DIAGRAMS FOR 23-TAP DECIMATE BY 3 SYMMETRIC FILTER

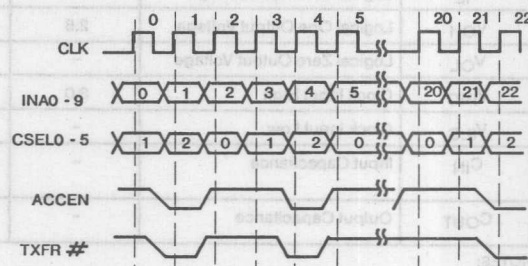


FIGURE 15. CONTROL SIGNAL TIMING FOR 23-TAP SYMMETRIC FILTER

To operate in this mode, the Dual is configured by writing 132H to address 000H via the microprocessor interface, CINO-9, A0-8, and WR#. Data reversal must be enabled (see Table 2.0). The 12 unique coefficients for this example are stored as three sets of coefficients for either FIR cell. For FIR A, the coefficients are loaded into the Coefficient Bank by writing C2, C5, C8, (C11)/ 2, C1, C4, C7, C10, C0, C3, C6, and C9 to address 100H, 101H, 102H, 103H, 108H, 109H, 10aH, 10bH, 110H, 111H, 112H, and 113H respectively.

# Specifications HSP43168

## Absolute Maximum Ratings

Supply Voltage	+8.0V
Input, Output Voltage	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature	-65°C to +150°C
ESD	Class 1
Maximum Package Power Dissipation at +70°C	2.4W (PLCC), 3.1W (PGA)
$\theta_{JC}$	11.0°C/W (PLCC), 7.5°C/W (PGA)
$\theta_{JA}$	33.6°C/W (PLCC), 33.5°C/W (PGA)
Gate Count	32529
Junction Temperature	+175°C (PGA), +150°C (PLCC)
Lead Temperature (Soldering 10s)	+300°C

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range, Commercial	5V $\pm$ 5%
Operating Temperature Range Commercial	0°C to +70°C

## D.C. Electrical Specifications

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
$I_{CCOP}$	Power Supply Current	-	363	mA	$V_{CC}$ = Max CLK Frequency 33MHz Note 2, Note 3, Note 4
$I_{CCSB}$	Standby Power Supply Current	-	500	$\mu A$	$V_{CC}$ = Max, Outputs Not Loaded
$I_I$	Input Leakage Current	-10	10	$\mu A$	$V_{CC}$ = Max, Input = 0V or $V_{CC}$
$I_O$	Output Leakage Current	-10	10	$\mu A$	$V_{CC}$ = Max, Input = 0V or $V_{CC}$
$V_{IH}$	Logical One Input Voltage	2.0	-	V	$V_{CC}$ = Max
$V_{IL}$	Logical Zero Input Voltage	-	0.8	V	$V_{CC}$ = Min
$V_{OH}$	Logical One Output Voltage	2.6	-	V	$I_{OH}$ = -400 $\mu A$ , $V_{CC}$ = Min
$V_{OL}$	Logical Zero Output Voltage	-	0.4	V	$I_{OL}$ = 2mA, $V_{CC}$ = Min
$V_{IHC}$	Clock Input High	3.0	-	V	$V_{CC}$ = Max
$V_{ILC}$	Clock Input Low	-	0.8	V	$V_{CC}$ = Min
$C_{IN}$	Input Capacitance	-	12	pF	CLK Frequency 1MHz All measurements referenced to GND.
$C_{OUT}$	Output Capacitance	-	12	pF	$T_A$ = +25°C, Note 1

### NOTES:

- Controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or changes.
- Power Supply current is proportional to operating frequency. Typical rating for  $I_{CCOP}$  is 11mA/MHz.
- Output load per test load circuit and  $C_L$  = 40pF.
- Maximum junction temperature must be considered when operating part at high clock frequencies.

## Specifications HSP43168

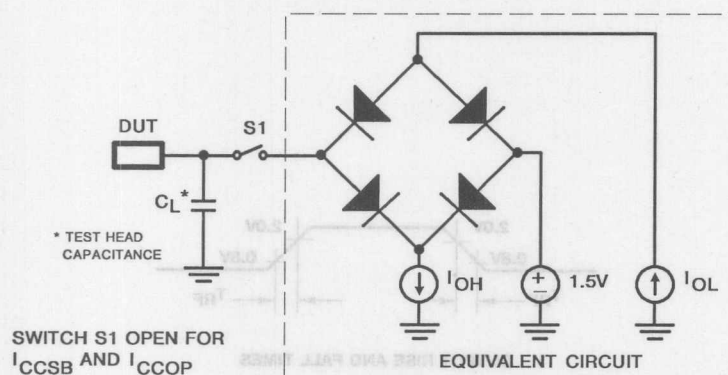
### A.C. Electrical Specifications $V_{CC} = +4.75V$ to $+5.25V$ , $T_A = 0^{\circ}C$ to $+70^{\circ}C$ (Note 1)

SYMBOL	PARAMETER	33MHz		45MHz		COMMENTS
		MIN	MAX	MIN	MAX	
$T_{CP}$	CLK Period	30	-	22	-	ns
$T_{CH}$	CLK High	12	-	8	-	ns
$T_{CL}$	CLK Low	12	-	8	-	ns
$T_{WP}$	WR# Period	30	-	22	-	ns
$T_{WH}$	WR# High	12	-	10	-	ns
$T_{WL}$	WR# Low	12	-	10	-	ns
$T_{AWS}$	Set-up Time A0-8 to WR# Going Low	10	-	8	-	ns
$T_{AWH}$	Hold Time A0-8 from WR# Going High	0	-	0	-	ns
$T_{CWS}$	Set-up Time CINO-9 to WR# Going High	12	-	10	-	ns
$T_{CWH}$	Hold Time CINO-9 from WR# Going High	1	-	1	-	ns
$T_{WLCL}$	Set-up Time WR# Low to CLK Low	5	-	3	-	ns, Note 2
$T_{CVCL}$	Set-up Time CINO-9 to CLK Low	7	-	7	-	ns, Note 2
$TECS$	Set-up Time CSELO-5, SHFTEN#, FWRD#, RVRS#, TXFR#, MUX0-1 to CLK Going High	15	-	12	-	ns
$TECH$	Hold Time CSELO-5, SHFTEN#, FWRD#, RVRS#, TXFR#, MUX0-1 to CLK Going High	0	-	0	-	ns
$TDO$	CLK to Output Delay OUT0-27	-	14	-	12	ns
$TOE$	Output Enable Time	-	12	-	12	ns
$TOD$	Output Disable Time	-	12	-	12	ns, Note 3
$TRF$	Output Rise, Fall Time	-	6	-	6	ns, Note 3

#### NOTES:

1. AC tests performed with  $C_L = 40pF$ ,  $I_{OL} = 2mA$ , and  $I_{OH} = -400\mu A$ . Input reference level CLK = 2.0V. Input reference level for all other inputs is 1.5V. Test  $V_{IH} = 3.0V$ ,  $V_{IHC} = 4.0V$ ,  $V_{IL} = 0V$ ,  $V_{ILC} = 0V$ .
2. Set-up time requirement for loading of data on CINO-9 to guarantee recognition on the following clock.
3. Controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or changes.

### A.C. Test Load Circuit





### OUTPUT ENABLE, DISABLE TIMING

July 1992

## Dual FIR Filter

### Features

- Two Independent 8-Tap FIR Filters Configurable as a Single 16-Tap FIR
- 10 Bit Data & Coefficients
- On-Board Storage for 32 Programmable Coefficient Sets
- Up To: 256 FIR Taps, 16 x 16 2-D Kernels, or 10 x 20 Bit Data and Coefficients
- Programmable Decimation to 16
- Programmable Rounding on Output
- Mixed Mode Arithmetic
- Standard Microprocessor Interface
- 33MHz, 25.6MHz Versions
- 84-Pin PGA

### Applications

- Quadrature Filtering
- Correlation
- Image Processing
- Complex Filtering
- PolyPhase Filtering
- Adaptive Filtering

### Description

The HSP43168 Dual FIR Filter consists of two independent 8-tap FIR filters. Each filter supports decimation from 1 to 16 and provides on-board storage for 32 sets of coefficients. The Block Diagram shows two FIR cells each fed by a separate coefficient bank and one of two separate inputs. The outputs of the FIR cells are either summed or multiplexed by the MUX/Adder. The compute power in the FIR Cells can be configured to provide quadrature filtering, complex filtering, 2-D convolution, 1-D/2-D correlations, and interpolating/decimating filters.

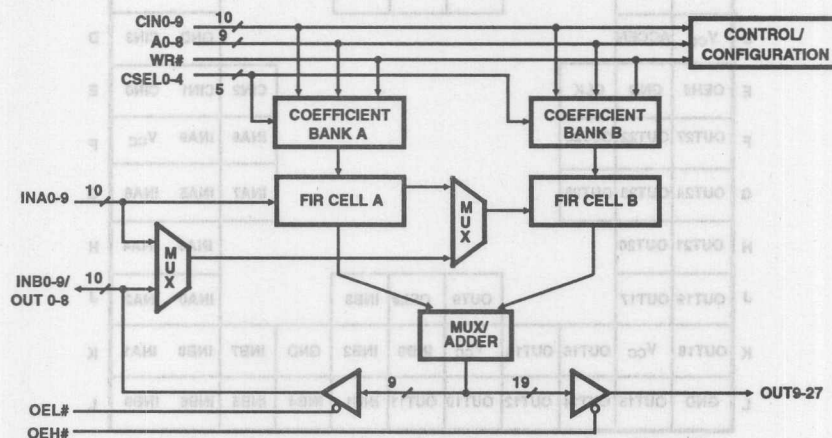
The FIR cells take advantage of symmetry in FIR coefficients by pre-adding data samples prior to multiplication. This allows an 8-tap FIR to be implemented using only 4 multipliers per filter cell. These cells can be configured as either a single 16-tap FIR filter or dual 8-tap FIR filters. Asymmetric filtering is also supported.

Decimation of up to 16 is provided to boost the effective number of filter taps from 2 to 16 times. Further, the decimation registers provide the delay necessary for fractional data conversion and 2-D filtering with kernels to 16x16.

The flexibility of the Dual is further enhanced by 32 sets of user programmable coefficients. Coefficient selection may be changed asynchronously from clock to clock. The ability to toggle between coefficient sets further simplifies applications such as polyphase or adaptive filtering.

The HSP43168 is a low power fully static design implemented in an advanced CMOS process. The configuration of the device is controlled through a standard microprocessor interface. The Dual FIR Filter is available in 84 pin PGA.

### Block Diagram



## Pinouts

84 PIN PGA  
TOP VIEW

	11	10	9	8	7	6	5	4	3	2	1	
L	GND	OUT15	OUT14	OUT12	OUT10	OUT11	INB1	INB4	INB5	INB6	INB9	L
K	OUT18	V <sub>CC</sub>	OUT16	OUT13	V <sub>CC</sub>	INB0	INB2	GND	INB7	INB8	INA1	K
J	OUT19	OUT17		OUT9	OEL#	INB3				INA0	INA2	J
H	OUT21	OUT20								INA3	INA4	H
G	OUT24	OUT23	OUT25						INA7	INA5	INA6	G
F	OUT27	OUT22	OUT26						INA8	INA9	V <sub>CC</sub>	F
E	OE#	GND	CLK						CIN2	CIN1	CIN0	E
D	V <sub>CC</sub>	ACCEN								GND	CIN3	D
C	TXFR#	FWRD#		A5	A6	CSEL0				CIN6	CIN4	C
B	SHFT EN#	MUX0	MUX1	A0	A3	A2	V <sub>CC</sub>	CSEL2	CIN9	CIN7	CIN5	B
A	RVRS#	WR#	GND	A1	A4	A7	A8	CSEL1	CSEL3	CSEL4	CIN8	A

84 PIN PGA  
BOTTOM VIEW

	11	10	9	8	7	6	5	4	3	2	1	
A	RVRS#	WR#	GND	A1	A4	A7	A8	CSEL1	CSEL3	CSEL4	CIN8	A
B	SHFT EN#	MUX0	MUX1	A0	A3	A2	V <sub>CC</sub>	CSEL2	CIN9	CIN7	CIN5	B
C	TXFR#	FWRD#		A5	A6	CSEL0				CIN6	CIN4	C
D	V <sub>CC</sub>	ACCEN								GND	CIN3	D
E	OE#	GND	CLK						CIN2	CIN1	CIN0	E
F	OUT27	OUT22	OUT26						INA8	INA9	V <sub>CC</sub>	F
G	OUT24	OUT23	OUT25						INA7	INA5	INA6	G
H	OUT21	OUT20							INA3	INA4		H
J	OUT19	OUT17		OUT9	OEL#	INB3				INA0	INA2	J
K	OUT18	V <sub>CC</sub>	OUT16	OUT13	V <sub>CC</sub>	INB0	INB2	GND	INB7	INB8	INA1	K
L	GND	OUT15	OUT14	OUT12	OUT10	OUT11	INB1	INB4	INB5	INB6	INB9	L

# Specifications HSP43168/883

## Absolute Maximum Ratings

Supply Voltage	+8.0V
Input, Output or I/O Voltage	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range	-65°C to +150°C
Junction Temperature	+175°C
Lead Temperature (Soldering 10s)	+300°C
ESD Classification	Class 1

## Reliability Information

Thermal Resistance	$\theta_{JA}$	$\theta_{JC}$
Ceramic PGA Package	33.5°C/W	7.5°C/W
Maximum Package Power Dissipation at +125°C		
Ceramic PGA Package	1.49 W	
Gate Count		32529 Gates

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range	+4.5V to +5.5V	Operating Temperature Range	-55°C to +125°C
-------------------------	----------------	-----------------------------	-----------------

TABLE 1. DC ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUB- GROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	0.8	V
Logical One Input Voltage Clock	$V_{IHC}$	$V_{CC} = 5.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	3.0	-	V
Logical Zero Input Voltage Clock	$V_{ILC}$	$V_{CC} = 4.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +2.0mA$ $V_{CC} = 4.5V$ (Note 1)	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output Leakage Current	$I_O$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ , Outputs Open	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 25.6MHz$ , $V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.5V$ (Note 2)	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	281.6	mA
Functional Test	FT	(Note 3)	7,8	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	-	-

## NOTES:

- Interchanging of force and sense conditions is permitted.
- Operating Supply Current is proportional to frequency, typical rating is 11mA/MHz.
- Tested as follows:  $f = 1MHz$ ,  $V_{IH}(\text{clock inputs}) = 3.4V$ ,  $V_{IH}(\text{all other inputs}) = 2.6V$ ,  $V_{IL} = 0.4V$ ,  $V_{OH} \geq 1.5V$ , and  $V_{OL} \leq 1.5V$ .

3

1-D FILTERS



# Specifications HSP43168/883

TABLE 2. AC ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	(NOTE 1) CONDITIONS	GROUP A SUB- GROUPS	TEMPERATURE	(-33MHz)		(-25MHz)		UNITS
					MIN	MAX	MIN	MAX	
CLK Period	$T_{CP}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	30	-	39	-	ns
CLK High	$T_{CH}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	12	-	15	-	ns
CLK Low	$T_{CL}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	12	-	15	-	ns
WR# Period	$T_{WP}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	30	-	39	-	ns
WR# High	$T_{WH}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	12	-	15	-	ns
WR# Low	$T_{WL}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	12	-	15	-	ns
Set-up Time; A0-8 to WR# Low	$T_{AWS}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	10	-	10	-	ns
Hold Time; A0-8 to WR# High	$T_{AWH}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	1	-	1	-	ns
Set-up Time; CIN0-9 to WR# High	$T_{CWS}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	12	-	15	-	ns
Hold Time; CIN0-9 to WR# High	$T_{CWH}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	1.5	-	1.5	-	ns
Set-up Time; WR# Low to CLK Low	$T_{WLCL}$	Note 3	9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	5	-	8	-	ns
Set-up Time; CIN0-9 to CLK Low	$T_{CVCL}$	Note 3	9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	8	-	8	-	ns
Set-up Time; CSEL0-5, SHFTEN#, FWRD#, RVRS#, TXFR#, MUX0-1 to CLK High	$T_{ECS}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	15	-	17	-	ns
Hold Time; CSEL0-5, SHFTEN#, FWRD#, RVRS#, TXFR#, MUX0-1 to CLK High	$T_{ECH}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	0	-	0	-	ns
CLK to Output Delay OUT0-27	$T_{DO}$		9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	15	-	17	-	ns
Output Enable Time	$T_{OE}$	Note 2	9, 10, 11	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	12	-	12	-	ns

## NOTES:

1. AC testing is performed as follows: Input levels (CLK Input) 4.0V and 0V; Input levels (all other inputs) 3.0V and 0V; Timing reference levels (CLK) 2.0V; All others 1.5V.  $V_{CC} = 4.5V$  and  $5.5V$ . Output load per test load circuit with  $C_L = 40$  pF. Output transition is measured at  $V_{OH} > 1.5V$  and  $V_{OL} < 1.5V$ .
2. Transition is measured at  $\pm 200mV$  from steady state voltage, Output loading per test load circuit,  $C_L = 40pF$ .
3. Set-up time requirements for loading of data on CIN0-9 to guarantee recognition on the following clock.

# Specifications HSP43168/883

TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETER	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	(-33MHz)		(-25MHz)		UNITS
					MIN	MAX	MIN	MAX	
Input Capacitance	$C_{IN}$	$V_{CC}$ = Open, $f=1$ MHz All measurements are referenced to device GND.	1	$T_A = +25^\circ\text{C}$	-	12	-	12	pF
Output Capacitance	$C_{OUT}$		1	$T_A = +25^\circ\text{C}$	-	12	-	12	pF
Output Disable Time	$T_{OD}$		1, 2	$-55^\circ \leq T_A \leq +125^\circ\text{C}$	-	12	-	12	ns
Output Rise Time	$T_R$	From 0.8V to 2.0V	1, 2	$-55^\circ \leq T_A \leq +125^\circ\text{C}$	-	8	-	8	ns
Output Fall Time	$T_F$	From 2.0V to 0.8V	1, 2	$-55^\circ \leq T_A \leq +125^\circ\text{C}$	-	8	-	8	ns

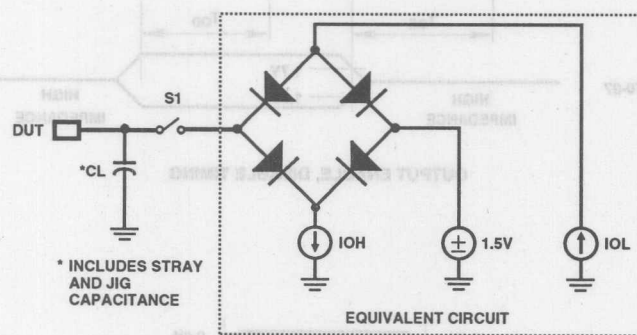
NOTE:

1. The parameters in Table 3 are controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.
2. Loading is as specified in the test load circuit with  $C_L = 40\text{pF}$ .

TABLE 4. APPLICABLE SUBGROUPS

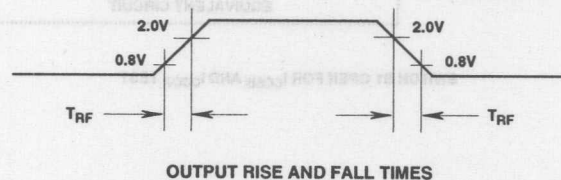
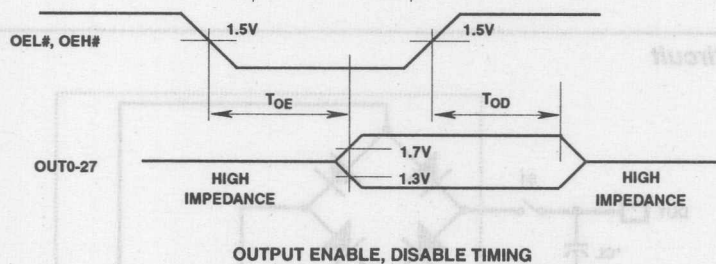
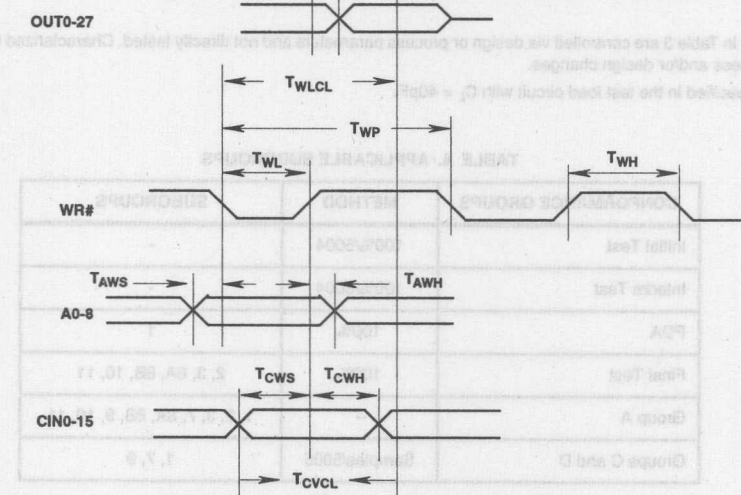
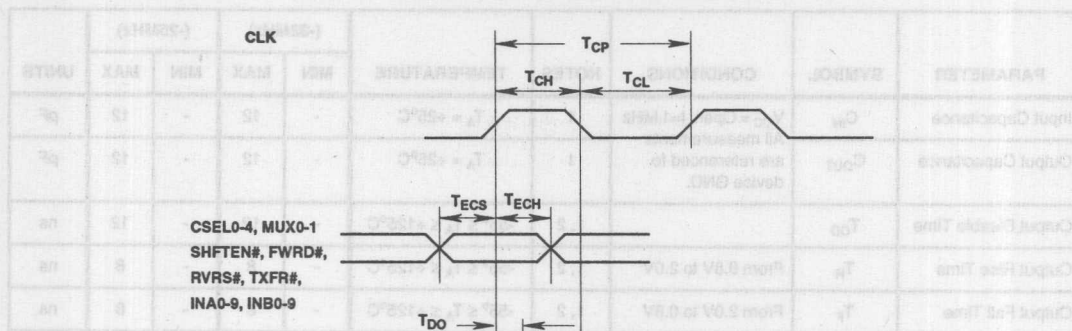
CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C and D	Samples/5005	1, 7, 9

## AC Test Load Circuit



SWITCH S1 OPEN FOR  $I_{CCSB}$  AND  $I_{CCOP}$  TEST

## Waveforms



## Burn-In Circuit

84 PIN PGA  
BOTTOM VIEW

	11	10	9	8	7	6	5	4	3	2	1	
A	RVRS#	WR#	GND	A1	A4	A7	A8	CSEL1	CSEL3	CSEL4	CIN8	A PIN 'A1' ID
B	SHFT EN#	MUX0	MUX1	A0	A3	A2	V <sub>CC</sub>	CSEL2	CIN9	CIN7	CIN5	B
C	TXFR#	FWRD#			A5	A6	CSEL0			CIN6	CIN4	C
D	V <sub>CC</sub>	ACCEN								GND	CIN3	D
E	OE#	GND	CLK						CIN2	CIN1	CIN0	E
F	OUT27	OUT22	OUT26						INA8	INA9	V <sub>CC</sub>	F
G	OUT24	OUT23	OUT25						INA7	INA5	INA6	G
H	OUT21	OUT20								INA3	INA4	H
J	OUT19	OUT17			OUT9	OEL#	INB3			INA0	INA2	J
K	OUT18	V <sub>CC</sub>	OUT16	OUT13	V <sub>CC</sub>	INB0	INB2	GND	INB7	INB8	INA1	K
L	GND	OUT15	OUT14	OUT12	OUT10	OUT11	INB1	INB4	INB5	INB6	INB9	L
	11	10	9	8	7	6	5	4	3	2	1	

## NOTES:

1.  $V_{CC}/2$  (2.7V  $\pm 10\%$ ) used for outputs only.
2. 47K $\Omega$  ( $\pm 20\%$ ) resistor connected to all pins except  $V_{CC}$  and GND
3.  $V_{CC} = 5.5 \pm 0.5V$ .
4. 0.1 $\mu f$  (Min) capacitor between  $V_{CC}$  and GND per position.

5.  $F_0 = 100KHz \pm 10\%$ ,  $F_1 = F_0/2$ ,  $F_2 = F_1/2 \dots$ ,  $F_{16} = F_{15}/2$ , 40 to 60% duty cycle.

6. Input voltage limits:  
 $V_{IL} = 0.8V$  Max,  $V_{IH} = 4.5 \pm 10\%$

PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
A1	CIN8	F9	B11	SHFTEN	F14	F9	SUM26	$V_{CC}/2$	K2	INB8	F9
A2	CSEL4	F12	C1	CIN4	F7	F10	SUM22	$V_{CC}/2$	K3	INB7	F8
A3	CSEL3	F11	C2	CIN6	F9	F11	SUM27	$V_{CC}/2$	K4	GND	GND
A4	CSEL1	F9	C5	CSEL0	F8	G1	INA6	F7	K5	INB2	F3
A5	A8	F12	C6	A6	F11	G2	INA5	F6	K6	INB0	F1
A6	A7	F10	C7	A5	F12	G3	INA7	F8	K7	V <sub>CC</sub>	V <sub>CC</sub>
A7	A4	F11	C10	FWRD	F13	G9	SUM25	$V_{CC}/2$	K8	SUM13	$V_{CC}/2$
A8	A1	F12	C11	TXFR	F11	G10	SUM23	$V_{CC}/2$	K9	SUM16	$V_{CC}/2$
A9	GND	GND	D1	CIN3	F10	G11	SUM24	$V_{CC}/2$	K10	V <sub>CC</sub>	V <sub>CC</sub>
A10	WRB	F6	D2	GND	GND	H1	INA4	F5	K11	SUM18	$V_{CC}/2$
A11	RVRS	F12	D10	ACCEN	F13	H2	INA3	F4	L1	INB9	F10
B1	CIN5	F8	D11	V <sub>CC</sub>	V <sub>CC</sub>	H10	SUM20	$V_{CC}/2$	L2	INB6	F7
B2	CIN7	F10	E1	CIN0	F7	H11	SUM21	$V_{CC}/2$	L3	INB5	F6
B3	CIN9	F10	E2	CIN1	F8	J1	INA2	F3	L4	INB4	F5
B4	CSEL2	F10	E3	CIN2	F9	J2	INA0	F1	L5	INB1	F2
B5	V <sub>CC</sub>	V <sub>CC</sub>	E9	CLK	F0	J5	INB3	F4	L6	SUM11	$V_{CC}/2$
B6	A2	F11	E10	GND	GND	J6	OELB	F13	L7	SUM10	$V_{CC}/2$
B7	A3	F10	E11	OEHB	F14	J7	SUM9	$V_{CC}/2$	L8	SUM12	$V_{CC}/2$
B8	A0	F13	F1	V <sub>CC</sub>	V <sub>CC</sub>	J10	SUM17	$V_{CC}/2$	L9	SUM14	$V_{CC}/2$
B9	MUX1	F13	F2	INA9	F10	J11	SUM19	$V_{CC}/2$	L10	SUM15	$V_{CC}/2$
B10	MUX0	F12	F3	INA8	F9	K1	INA1	F2	L11	GND	GND



# HSP43168/883

## Metallization Topology

### DIE DIMENSIONS:

314 x 348 x 19 ± 1 mils

### METALLIZATION:

Type: Si-Al or Si-Al-Cu  
Thickness: 8kÅ

### GLASSIVATION:

Type: Nitrox  
Thickness: 10kÅ

### DIE ATTACH:

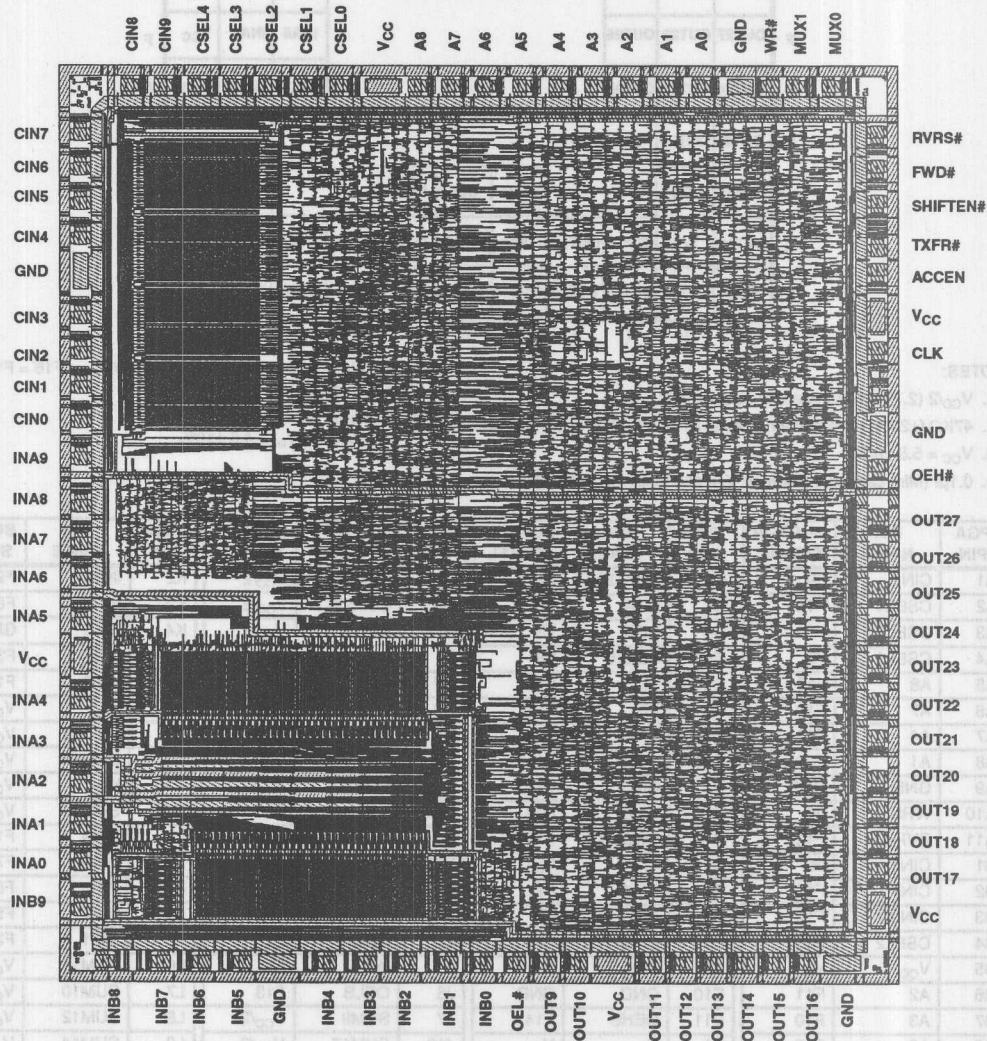
Material: Silver Glass

### WORST CASE CURRENT DENSITY:

$1.93 \times 10^5 \text{ A/cm}^2$

## Metallization Mask Layout

HSP43168/883



August 1992

## Decimating Digital Filter

### Features

- Single Chip Narrow Band Filter with up to 96dB Attenuation
- DC to 33MHz Clock Rate
- 16 Bit 2's Complement Input
- 20 Bit Coefficients in FIR
- 24 Bit Extended Precision Output
- Programmable Decimation up to a Maximum of 16,384
- Standard 16 Bit Microprocessor Interface
- Filter Design Software Available DECI•MATE™
- Available in 84 Pin PGA and PLCC

### Applications

- Very Narrow Band Filters
- Zoom Spectral Analysis
- Channelized Receivers
- Large Sample Rate Converter
- Instrumentation
- 512 Tap Symmetric FIR filtering

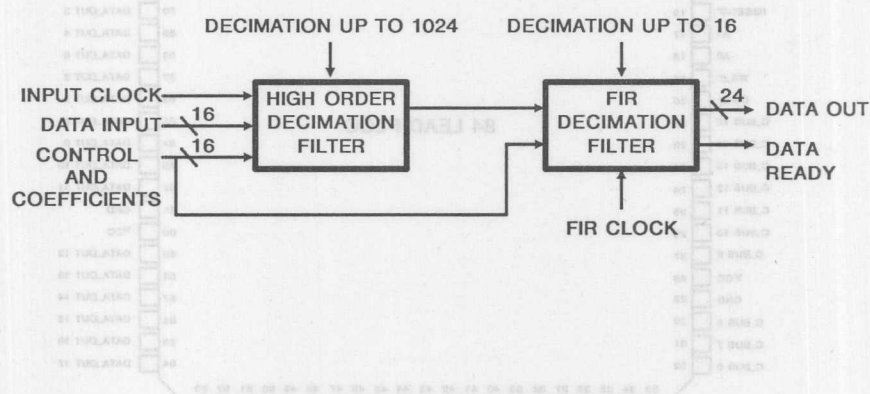
### Description

The HSP43220 Decimating Digital Filter is a linear phase low pass decimation filter which is optimized for filtering narrow band signals in a broad spectrum of a signal processing applications. The HSP43220 offers a single chip solution to signal processing application which have historically required several boards of IC's. This reduction in component count results in faster development times as well as reduction of hardware costs.

The HSP43220 is implemented as a two stage filter structure. As seen in the block diagram, the first stage is a high order decimation filter (HDF) which utilizes an efficient decimation (sample rate reduction) technique to obtain decimation up to 1024 through a coarse low-pass filtering process. The HDF provides up to 96dB aliasing rejection in the signal pass band. The second stage consists of a finite impulse response (FIR) decimation filter structured as a transversal FIR filter with up to 512 symmetric taps which can implement filters with sharp transition regions. The FIR can perform further decimation by up to 16 if required while preserving the 96dB aliasing attenuation obtained by the HDF. The combined total decimation capability is 16,384.

The HSP43220 accepts 16 bit parallel data in 2's complement format at sampling rates up to 33MSPS. It provides a 16 bit microprocessor compatible interface to simplify the task of programming and three-state outputs to allow the connection of several IC's to a common bus. The HSP43220 also provides the capability to bypass either the HDF or the FIR for additional flexibility.

### Block Diagram



DECI•MATE™ is a registered trademark of Harris Corporation.  
IBM PC™, XT™, AT™, PS/2™ are registered trademarks of International Business Machines, Inc.

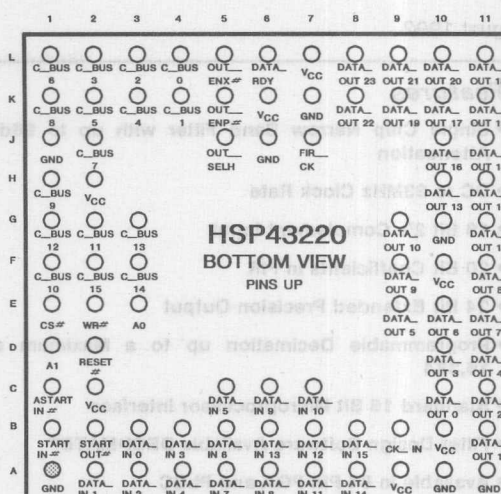
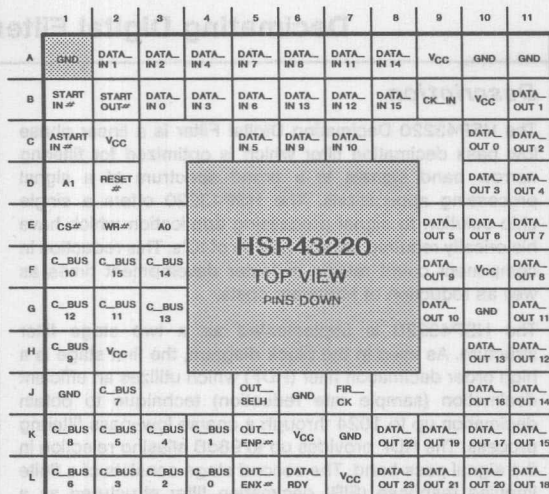
CAUTION: These devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
Copyright © Harris Corporation 1992

File Number **2486.3**

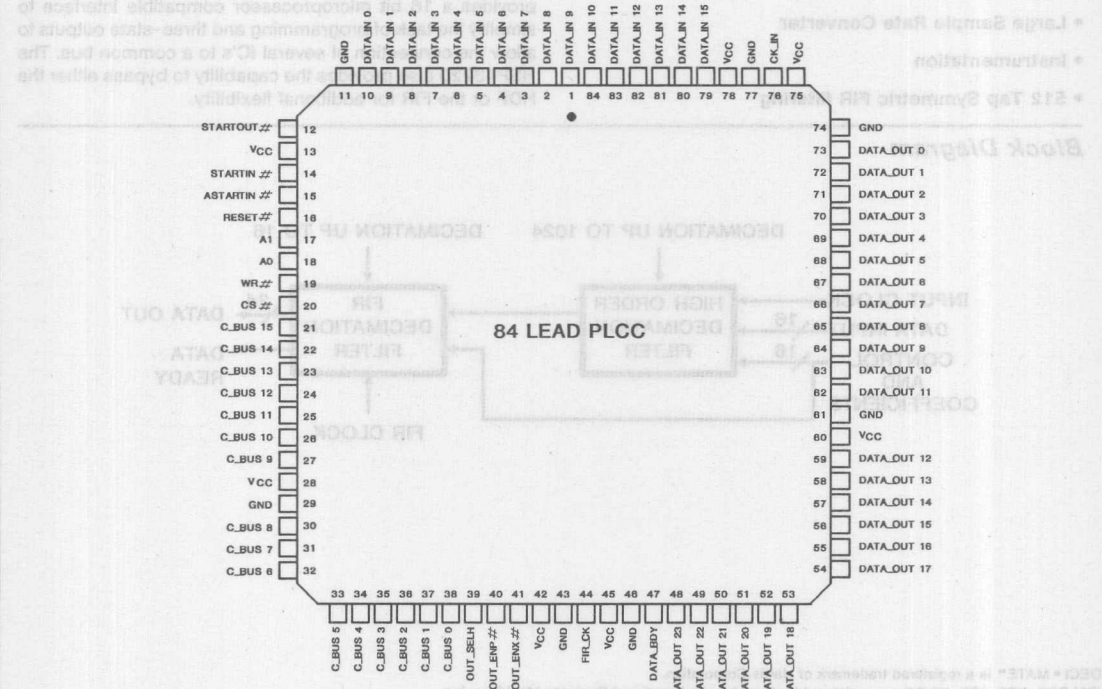
# HSP43220

## Package Pinouts

### 84 PIN GRID ARRAY (PGA)



### 84 PLASTIC LEADED CHIP CARRIER (PLCC)



## Pin Description

NAME	PLCC PIN	TYPE	DESCRIPTION
V <sub>CC</sub>	13, 28, 42, 45, 60, 75, 78		The +5V power supply pins.
GND	11, 29, 43, 46, 61, 74, 77		The device ground.
CK_IN	76	I	Input sample clock. Operations in the HDF are synchronous with the rising edge of this clock signal. The maximum clock frequency is 33MHz. CK_IN is synchronous with FIR_CK and thus the two clocks may be tied together if required, or CK_IN can be divided down from FIR_CK. CK_IN is a CMOS level signal.
FIR_CK	44	I	Input clock for the FIR filter. This clock must be synchronous with CK_IN. Operations in the FIR are synchronous with the rising edge of this clock signal. The maximum clock frequency is 33 MHz. FIR_CK is a CMOS level signal.
DATA_IN0-15	1-10, 79-84	I	Input Data bus. This bus is used to provide the 16-bit input data to the HSP43220. The data must be provided in a synchronous fashion, and is latched on the rising edge of the CK_IN signal. The data bus is in 2's complement fractional format.
C_BUS0-15	21-27, 30-38	I	Control Input bus. This input bus is used to load all the filter parameters. The pins WR#, CS# and A0, A1 are used to select the destination of the data on the Control bus and write the Control bus data into the appropriate register as selected by A0 and A1.
DATA_OUT0-23	48-59, 62-73	O	Output Data bus. This 24-Bit output port is used to provide the filtered result in 2's complement format. The upper 8 bits of the output, DATA_OUT16-23 will provide extension or growth bits depending on the state of OUT_SELH and whether the FIR has been put in bypass mode. Output bits DATA_OUT0-15 will provide bits 2 <sup>0</sup> through 2 <sup>-15</sup> when the FIR is not bypassed and will provide the bits 2 <sup>-16</sup> through 2 <sup>-31</sup> when the FIR is in bypass mode.
DATA_RDY	47	O	An active high output strobe that is synchronous with FIR_CK that indicates that the result of the just completed FIR cycle is available on the data bus.
RESET#	16	I	RESET# is an asynchronous signal which requires that the input clocks CK_IN and FIR_CK are active when RESET# is asserted. RESET# disables the clock divider and clears all of the internal data registers in the HDF. The FIR filter data path is not initialized. The control register bits that are cleared are F_BYF, H_STAGES, and H_DRATE. The F_DIS bit is set. In order to guarantee consistent operation of the part, the user must reset the DDF after power up.
WR#	19	I	Write strobe. WR# is used for loading the internal registers of the HSP43220. When CS# and WR# are asserted, the rising edge of WR# will latch the C_BUS0-15 data into the register specified by A0 and A1.
CS#	20	I	Chip Select. The Chip Select input enables loading of the internal registers. When CS# and WR# are low, the A0 and A1 address lines are decoded to determine the destination of the data on C_BUS0-15. The rising edge of WR# then loads the appropriate register as specified by A0 and A1.
A0, A1	18, 17	I	Control Register Address. These lines are decoded to determine which control register is the destination for the data on C_BUS0-15. Register loading is controlled by the A0 and A1, WR# and CS# inputs.
ASTARTIN#	15	I	ASTARTIN# is an asynchronous signal which is sampled on the rising edge of CK_IN. It is used to put the DDF in operational mode. ASTARTIN# is internally synchronized to CK_IN and is used to generate STARTOUT#.
STARTOUT#	12	O	STARTOUT# is a pulse generated from the internally synchronized version of ASTARTIN#. It is provided as an output for use in multi-chip configurations to synchronously start multiple HSP43220's. The width of STARTOUT# is equal to the period of CK_IN.
STARTIN#	14	I	STARTIN# is a synchronous input. A high to low transition of this signal is required to start the part. STARTIN# is sampled on the rising edge of CK_IN. This synchronous signal can be used to start single or multiple HSP43220's.
OUT_SELH	39	I	Output Select. The OUT_SELH input controls which bits are provided at output pins DATA_OUT16-23. A HIGH on this control line selects bits 2 <sup>8</sup> through 2 <sup>1</sup> from the accumulator output. A LOW on this control line selects bits 2 <sup>-16</sup> through 2 <sup>-23</sup> from the accumulator output. Processing is not interrupted by this pin.
OUT_ENP#	40	I	Output Enable. The OUT_ENP# input controls the state of the lower 16 bits of the output data bus, DATA_OUT0-15. A LOW on this control line enables the lower 16 bits of the output bus. When OUT_ENP# is HIGH, the output drivers are in the high impedance state. Processing is not interrupted by this pin.
OUT_ENX#	41	I	Output Enable. The OUT_ENX# input controls the state of the upper 8 bits of the output data bus, DATA_OUT16-23. A LOW on this control line enables the upper 8 bits of the output bus. When OUT_ENX# is HIGH, the output drivers are in the high impedance state. Processing is not interrupted by this pin.

3

1-D FILTERS



## The HDF

The first filter section is called the High Order Decimation Filter (HDF) and is optimized to perform decimation by large factors. It implements a low pass filter using only adders and delay elements instead of a large number of multiplier/accumulators that would be required using a standard FIR filter.

The HDF is divided into 4 sections: the HDF filter section, the clock divider, the control register logic and the start logic (Figure 1).

### Data Shifter

After being latched into the Input Register the data enters the Data Shifter. The data is positioned at the output of the shifter to prevent errors due to overflow occurring at the output of the HDF. The number of bits to shift is controlled by H\_GROWTH.

### Integrator Section

The data from the shifter goes to the Integrator section. This is a cascade of 5 integrator (or accumulator) stages, which implement a low pass filter. Each accumulator is

implemented as an adder followed by a register in the feed forward path. The integrator is clocked by the sample clock, CK\_IN as shown in Figure 2. The bit width of each integrator stage goes from 66 bits at the first integrator down to 26 bits at the output of the fifth integrator. Bit truncation is performed at each integrator stage because the data in the integrator stages is being accumulated and thus is growing, therefore the lower bits become insignificant, and can be truncated without losing significant data.

There are three signals that control the integrator section; they are H\_STAGES, H\_BYP and RESET#. In Figure 2 these control signals have been decoded and are labelled INT\_EN1 - INT\_EN5. The order of the filter is loaded via the control bus and is called H\_STAGES. H\_STAGES is decoded to provide the enables for each integrator stage. When a given integrator stage is selected, the feedback path is enabled and the integrator accumulates the current data sample with the previous sum. The integrator section can be put in bypass mode by the H\_BYP bit. When H\_BYP or RESET# is asserted, the feedback paths in all integrator stages are cleared.

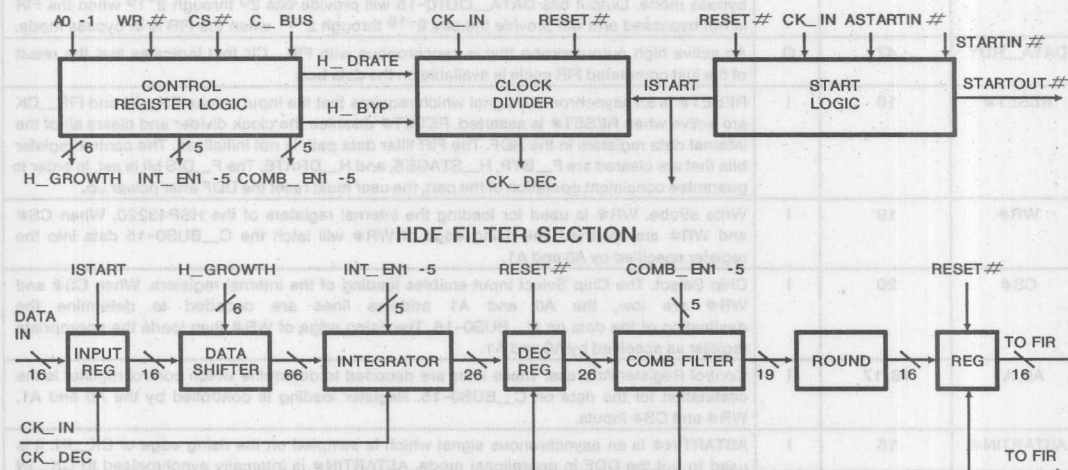


FIGURE 1. HIGH ORDER DECIMATION FILTER

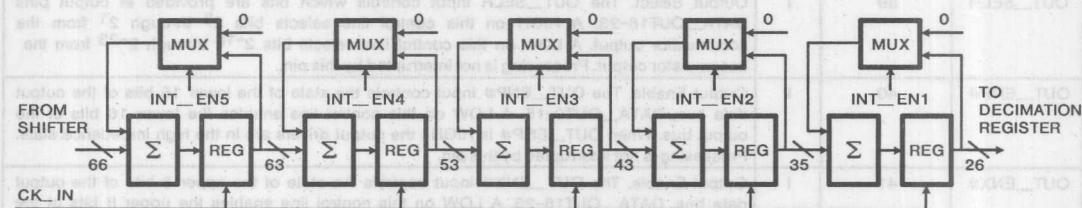


FIGURE 2. INTEGRATOR

### Decimation Register

The output of the Integrator section is latched into the Decimation Register by CK\_DEC. The output of the Decimation register is cleared when RESET# is asserted. The HDF decimation rate = H\_DRATE + 1, which is defined as Hdec for convenience.

### Comb Filter Section

The output of the Decimation Register is passed to the Comb Filter Section. The Comb section consists of 5 cascaded Comb filters or differentiators. Each Comb filter section calculates the difference between the current and previous integrator output. Each Comb filter consists of a register which is clocked by CK\_DEC, followed by an subtractor, where the subtractor calculates the difference between the input and output of the register. Bit truncations are done at each stage as shown in Figure 3. The first stage bit width is 26 bits and the output of the fifth stage is 19 bits.

There are three signals that control the Comb Filter; H\_STAGES, H\_BYP and RESET#. In Figure 3 these control signals are decoded as COMB\_EN1 - COMB\_EN5. The order of the Comb filter is controlled by H\_STAGES, which is programmed over the control bus. H\_BYP is used to put the comb section in bypass mode. RESET# causes the register output in each Comb stage to be cleared. The H\_BYP and RESET# control pins, when asserted force the output of all registers to zero so data is passed through the subtractor unaltered. When the H\_STAGES control bits enable a given stage the output of the register is subtracted from the input.

It is important to note that the Comb filter section has a speed limitation. The Input sampling rate divided by the decimation factor in the HDF (CK\_IN/Hdec) should not exceed 4MHz. Violating this condition causes the output of the filter to be incorrect. When the HDF is put in bypass mode this limitation does not apply. Equation 1.0 describes the relationship between F\_TAPS, F\_DRATE, H\_DRATE, CK\_IN and FIR\_CK.

### Rounder

The filter accuracy is limited by the 16 bit data input. To maintain the maximum accuracy, the output of the comb is rounded to 16 bits.

The Rounder performs a symmetric round of the 19 bit output of the last Comb stage. Symmetric rounding is done to prevent the synthesis of a 0Hz spectral component by the rounding process and thus causing a reduction in spurious free dynamic range. Saturation logic is also provided to prevent roll over from the largest positive value to the most negative value after rounding. The output of the last comb filter stage in the HDF section has a 16 bit integer portion with a 3 bit fractional part in 2's complement format.

The rounding algorithm is as follows:

POSITIVE NUMBERS	
Fractional Portion Greater Than or Equal to 0.5	Round Up
Fractional Portion Less Than 0.5	Truncate

NEGATIVE NUMBERS	
Fractional Portion Less Than or Equal to 0.5	Round Up
Fractional Portion Greater Than 0.5	Truncate

The output of the rounder is latched into the HDF output register with CK\_DEC. CK\_DEC is generated by the Clock Divider section. The output of the register is cleared when RESET# is asserted.

### Clock Divider and Control Logic

The clock divider divides CK\_IN by the decimation factor Hdec to produce CK\_DEC. CK\_DEC clocks the Decimation Register, Comb Filter section, HDF output register. In the FIR filter CK\_DEC is used to indicate that a new data sample is available for processing. The clock generator is cleared by RESET# and is not enabled until the DDF is started by an internal start signal (see Start Logic).

The Control Register Logic enables the updating of the Control registers which contain all of the filter parameter data. When WR# and CS# are asserted, the control register addressed by bits A0 and A1 is loaded with the data on the C\_BUS.

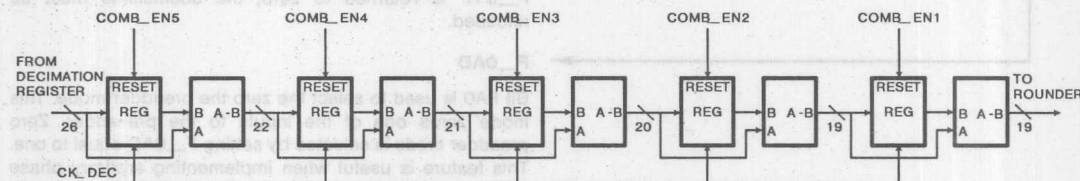


FIGURE 3. COMB FILTER

**DDF Control Registers**

F\_Register (A1 = 0, A0 = 0)

F_OAD		F_BYP	F_ESYM	F_DRATE				F_TAPS							
FA0	FB0	ES0	D3	D2	D1	D0	T8	T7	T6	T5	T4	T3	T2	T1	T0
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0

**F\_TAPS**

Bits T0-T8 are used to specify the number of FIR filter taps. The number entered is one less than the number of taps required. For example, to specify a 511 tap filter F\_TAPS would be programmed to 510.

**F\_DRATE**

Bits D0-D3 are used to specify the amount of FIR decimation. The number entered is one less than the decimation required. For example, to specify decimation of 16, F\_DRATE would be programmed to 15. For no FIR decimation, F\_DRATE would be set equal to 0. FDRATE + 1 is defined as Fdec.

**F\_ESYM**

Bit ES0 is used to select the FIR symmetry. F\_ESYM is set equal to one to select even symmetry and set equal to zero to select odd symmetry. When F\_ESYM is one, data is added in the pre-adder; when it is zero, data is subtracted. Normally set to one.

**F\_BYP**

Bit FB0 is used to select FIR bypass mode. FIR bypass mode is selected by setting F\_BYP=1. When FIR bypass mode is selected, the FIR is internally set up for a 3 tap even symmetric filter, no decimation (F\_DRATE=0) and F\_OAD is set equal to one to zero one side of the preadder. In FIR bypass mode all FIR filter parameters, except F\_CLA, are ignored, including the contents of the FIR coefficient RAM. In FIR bypass mode the output data is brought output on the lower 16 bits of the output bus DATA\_OUT 0-15. To disable FIR bypass mode, F\_BYP is set equal to zero. When F\_BYP is returned to zero, the coefficients must be reloaded.

**F\_OAD**

Bit FA0 is used to select the zero the preadder mode. This mode zeros one of the inputs to the pre-adder. Zero preadder mode is selected by setting F\_OAD equal to one. This feature is useful when implementing arbitrary phase filters or can be used to verify the filter coefficients. To disable the Zero Preadder mode F\_OAD is set equal to zero.

FIGURE 4.

**DDF Control Registers (Continued)****FC\_Register (A1 = 0, A0 = 1)**

F_CF															
C19	C18	C17	C16	C15	C14	C13	C12	C11	C10	C9	C8	C7	C6	C5	C4
X	X	X	X	X	X	X	X	X	X	X	X	C3	C2	C1	C0
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0

**F\_CF**

Bits C0-C19 represent the coefficient data, where C19 is the MSB. Two writes are required to write each coefficient which is 2's complement fractional format. The first write loads C19 through C4; C3 through C0 are loaded on the second write cycle. As the coefficients are written into this register they are formatted into a 20 bit coefficient and written into the Coefficient RAM sequentially starting with address location zero. The coefficients must be loaded sequentially, with the center tap being the last coefficient to be loaded. See coefficient RAM, below.

**FIGURE 5.****H\_Register 1 (A1 = 1, A0 = 0)**

RESERVED			F_DIS	F_CLA	H_BYP	H_DRATE									
			FD0	FC0	HB0	R9	R8	R7	R6	R5	R4	R3	R2	R1	R0
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0

**H\_DRATE**

Bits R0-R9 are used to select the amount of decimation in the HDF. The amount of decimation selected is programmed as the required decimation minus one; for instance to select decimation of 1024 H\_DRATE is set equal to 1023. HDRATE +1 is defined as Hdec.

**H\_BYP**

Bit HB0 is used to select HDF bypass mode. This mode is selected by setting H\_BYP =1. When this mode is selected the input data passes through the HDF unfiltered. Internally H\_STAGES and H\_DRATE are both set to zero and H\_GROWTH is set to 50. H\_REGISTER 2 must be reloaded when H\_BYP is returned to 0. To disable HDF bypass mode H\_BYP=0. The relationship between CK\_IN and FIR\_CK in this and all other modes is defined by equation 1.0.

**F\_CLA**

Bit FC0 is used to select the clear accumulator mode in the FIR. This mode is enabled by setting F\_CLA=1 and is disabled by setting F\_CLA=0. In normal operation this bit should be set equal to zero. This mode zeros the feedback path in the accumulator of the multiplier/accumulator (MAC). It also allows the multiplier output to be clocked off the chip by FIR\_CK, thus DATA\_RDY has no meaning in this mode. This mode can be used in conjunction with the F\_OAD bit to read out the FIR coefficients from the coefficient RAM.

**F\_DIS**

Bit FD0 is used to select the FIR disable mode. This feature enables the FIR parameters to be changed. This feature is selected by setting F\_DIS=1. This mode terminates the current FIR cycle. While this feature is selected, the HDF continues to process data and write it into the FIR data RAM. When the FIR re-programming is completed, the FIR can be re-enabled either by clearing F\_DIS, or by asserting one of the start inputs, which automatically clears F\_DIS.

**FIGURE 6**



**DDF Control Registers (Continued)****H\_Register 2 (A1 = 1, A0 = 1)**

RESERVED							H_GROWTH						H_STAGES		
							G5	G4	G3	G2	G1	G0	N2	N1	N0
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0

**H\_STAGES**

Bits N0-N2 are used to select the number of stages or order of the HDF filter. The number that is programmed in is equal to the required number of stages. For a 5th order filter, H\_STAGES would be set equal to 5.

**H\_GROWTH**

Bits G0-G5 are used to select the proper amount of growth bits. H\_GROWTH is calculated using the following equation:

$$H\_GROWTH = 50 - \text{CEILING} \{ H\_STAGES \times \log (Hdec) / \log(2) \}$$

where the CEILING { } means use the next largest integer of the result of the value in brackets and log is the log to the base 10.

The value of H\_GROWTH represents the position of the LSB on the output of the data shifter.

**FIGURE 7**

### Start Logic

The Start Logic generates a start signal that is used internally to synchronously start the DDF. If  $ASTARTIN\#$  is asserted ( $STARTIN\#$  must be tied high) the Start Logic synchronizes it to  $CK\_IN$  by double latching the signal and generating the signal  $STARTOUT\#$ , which is shown in Figure 8. The  $STARTOUT\#$  signal is then used to synchronously start other DDFs in a multi-chip configuration (the  $STARTOUT\#$  signal of the first DDF would be tied to the  $STARTIN\#$  of the second DDF). The NAND gate shown in Figure 8 then passes this synchronized signal to be used on chip to provide a synchronous start. Once started, the chip requires a  $RESET\#$  to halt operation.

When  $STARTIN\#$  is asserted ( $ASTARTIN\#$  must be tied high) the NAND gate passes  $STARTIN\#$  which is used to provide the internal start,  $ISTART$ , for the DDF. When  $RESET\#$  is asserted the internal start signal is held inactive, thus it is necessary to assert either  $ASTARTIN\#$  or  $STARTIN\#$  in order to start the DDF. The timing of the first valid  $DATA\_IN$  with respect to  $START\_IN\#$  is shown in the Timing Waveforms below.

In using  $ASTARTIN\#$  or  $STARTIN\#$  a high to low transition must be detected by the rising edge of  $CK\_IN$ , therefore these signals must have been high for more than one  $CK\_IN$  cycle and then taken low.

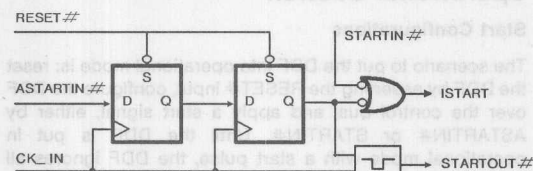


FIGURE 8. START LOGIC

### The FIR Section

The second filter in the top level block diagram is a Finite Impulse Response (FIR) filter which performs the final shaping of the signal spectrum and suppresses the aliasing components in the transition band of the HDF. This enables the DDF to implement filters with narrow pass bands and sharp transition bands.

The FIR is implemented in a transversal structure using a single multiplier/accumulator (MAC) and RAM for storage of the data and filter coefficients as shown in Figure 9. The FIR can implement up to 512 symmetric taps and decimation up to 16.

The FIR is divided into 2 sections: the FIR filter section and the FIR control logic.

#### Coefficient RAM

The Coefficient RAM stores the coefficients for the current FIR filter being implemented. The coefficients are loaded into the Coefficient RAM over the control bus ( $C\_BUS$ ). The coefficients are written into the Coefficient RAM sequentially, starting at location zero. It is only necessary to write one half of the coefficients when symmetric filters are being implemented, where the last coefficient to be written in is the center tap.

The coefficients are loaded into address 01 in two writes. The first write loads the upper 16 bits of the 20 bit coefficient, C4 through C19. The second write loads the lower 4 bits of the coefficient, C0 through C3, where C19 is the MSB. The two 16 bit writes are then formatted into the 20 bit coefficient that is then loaded into the Coefficient RAM starting at RAM address location zero, where the coefficient at this location is the outer tap (or the first coefficient value).

To reload coefficients, the Coefficient RAM Address pointer must be reset to location zero so that the coefficients will be loaded in the order the FIR filter expects. There are two methods that can be used to reset the Coefficient RAM address pointer. The first is to assert  $RESET\#$ , which automatically resets the pointer, but also clears the HDF and alters some of the control register bits. ( $RESET\#$  does not change any of the coefficient values.) The second method is to set the  $F\_DIS$  bit in control register  $H\_REGISTER1$ . This control bit allows any of the FIR control register bits to be re-programmed, but does not automatically modify any control registers. When the programming is completed, the FIR is re-started by clearing the  $F\_DIS$  bit or by asserting one of the start inputs ( $ASTARTIN\#$  or  $STARTIN\#$ ). The  $F\_DIS$  bit allows the filter parameters to be changed more quickly and is thus the recommended reprogramming method.

#### Data RAM

The Data RAM stores the data needed for the filter calculation. The format of the data is:

20.2-12-22-32-42-52-62-72-82-92-102-112-122-132-142-15

where the sign bit is in the 2<sup>0</sup> location.

The 16 bit output of the HDF Output Register is written into the Data Ram on the rising edge of  $CK\_DEC$ .

$RESET\#$  initializes the write pointer to the data RAM. After a  $RESET\#$  occurs, the output of the FIR will not be valid until the number of new data samples written to the Data RAM equals TAPS.

The filter always operates on the most current sample and the taps-1 previous samples. Thus if the  $F\_DIS$  bit is set, data continues to be written into the data RAM coming from the HDF section. When the FIR is enabled again the filter will be operating on the most current data samples and thus another transient response will not occur.

The maximum throughput of the FIR filter is limited by the use of a single Multiplier/Accumulator (MAC). The data output from the HDF being clocked into the FIR filter by  $CK\_DEC$  must not be at a rate that causes an erroneous result being calculated because data is being overwritten.

The equation shown below describes the relationship between,  $FIR\_CK$ ,  $CK\_DEC$ , the number of taps that can be implemented in the FIR, the decimation rate in the HDF and the decimation rate in the FIR. (In the Design Considerations section of the OPERATIONAL SECTION there is a chart that shows the tradeoffs between these parameters.)

$$FIR\_CK \geq \frac{CK\_IN[(TAPS/2)+4+Fdec]}{Hdec Fdec} \quad (1.0)$$

This equation expresses the minimum FIR\_CK. The minimum FIR\_CK is the smallest integer multiple of CK\_IN that satisfies equation 1.0. In addition, the T<sub>SK</sub> specification must be met (see A.C. Electrical Specifications). Fdec is the decimation rate in the FIR (Fdec = F<sub>DRATE</sub> + 1), where TAPS = the number of taps in the FIR for even length filters and equals the number of taps+1 for odd length filters.

Solving the above equation for the maximum number of taps:

$$\text{TAPS} = 2 \left( \frac{\text{FIR\_CK Hdec Fdec}}{\text{CK\_IN}} - \text{Fdec} - 4 \right) \quad (2.0)$$

In using this equation, it must be kept in mind that CK\_IN/Hdec must be less than or equal to 4MHz (unless the HDF is in bypass mode in which case this limitation in the HDF does not apply). In the OPERATIONAL SECTION under the Design Considerations, there is a table that shows the trade-offs of these parameters. In addition, Harris provides a software package called DECI • MATE™ which designs the DDF filter from System specifications.

The registered outputs of the data RAM are added or subtracted in the 17 bit pre-adder. The F<sub>OAD</sub> control bit allows zeros to be input into one side of the pre-adder. This provides the capability to implement non-symmetric filters.

The selection of adding the register outputs for an even symmetric filter or for subtracting the register outputs for odd symmetric filter is provided by the control bit F<sub>ESYM</sub>, which is programmed over the control bus. When subtraction is selected, the new data is subtracted from the old data. The 17 bit output of the adder forms one input of the multiplier/accumulator.

A control bit F<sub>CLA</sub> provides the capability to clear the feedback path in the accumulator such that multiplier output will not be accumulated, but will instead flow directly to the output register. The bit weightings of the data and coefficients as they are processed in the FIR is shown below.

Input Data (from HDF) 2<sup>0</sup>.2<sup>-1</sup> ... 2<sup>-15</sup>

Pre-adder Output 2<sup>12</sup>0.2<sup>-1</sup> ... 2<sup>-15</sup>

Coefficient 2<sup>0</sup>.2<sup>-1</sup> ... 2<sup>-19</sup>

Accumulator 2<sup>8</sup> ... 2<sup>0</sup>.2<sup>-1</sup> ... 2<sup>-34</sup>

#### FIR Output

The 40 most significant bits of the accumulator are latched into the output register. The lower 3 bits are not brought to the output. The 40 bits out of the output register are selected to be output by a pair of multiplexers. This register is clocked by FIR\_CK (see Figure 9).

There are two multiplexers that route 24 of the 40 output bits from the output register to the output pins. The first multiplexer selects the output register bits that will be routed to output pins DATA\_OUT16-23 and the second multiplexer selects the output register bits that will be routed to output pins DATA\_OUT0-15.

The multiplexers are controlled by the control signal F<sub>BYP</sub> and the OUT\_SELH pin. F<sub>BYP</sub> and OUT\_SELH both control the first multiplexer that selects the upper 8 bits of the output bus, DATA\_OUT16-23. F<sub>BYP</sub> controls the second multiplexer that selects the lower 16 bits of the output bus, DATA\_OUT0-15. The output formatter is shown in detail in Figure 10.

#### FIR Control Logic

The DATA\_RDY strobe indicates that new data is available on the output of the FIR. The rising edge of DATA\_RDY can be used to load the output data into an external register or RAM.

#### Data Format

The DDF maintains 16 bits of accuracy in both the HDF and FIR filter stages. The data formats and bit weightings are shown in Figure 11.

### Operational Section

#### Start Configurations

The scenario to put the DDF into operational mode is: reset the DDF by asserting the RESET# input, configure the DDF over the control bus, and apply a start signal, either by ASTARTIN# or STARTIN#. Until the DDF is put in operational mode with a start pulse, the DDF ignores all data inputs.

To use the asynchronous start, an asynchronous active low pulse is applied to the ASTARTIN# input. ASTARTIN# is internally synchronized to the sample clock, CK\_IN, and generates STARTOUT#. This signal is also used internally when the asynchronous mode is selected. It puts the DDF in operational mode and allows the DDF to begin accepting data. When the ASTARTIN# input is being used, the STARTIN# input must be tied high to ensure proper operation.

To start the DDF synchronously, the STARTIN# is asserted with a active low pulse that has been externally synchronized to CK\_IN. Internally the DDF then uses this start pulse to put the DDF in operate mode and start accepting data inputs. When STARTIN# is used to start the DDF the ASTARTIN# input must be tied high to prevent false starts.

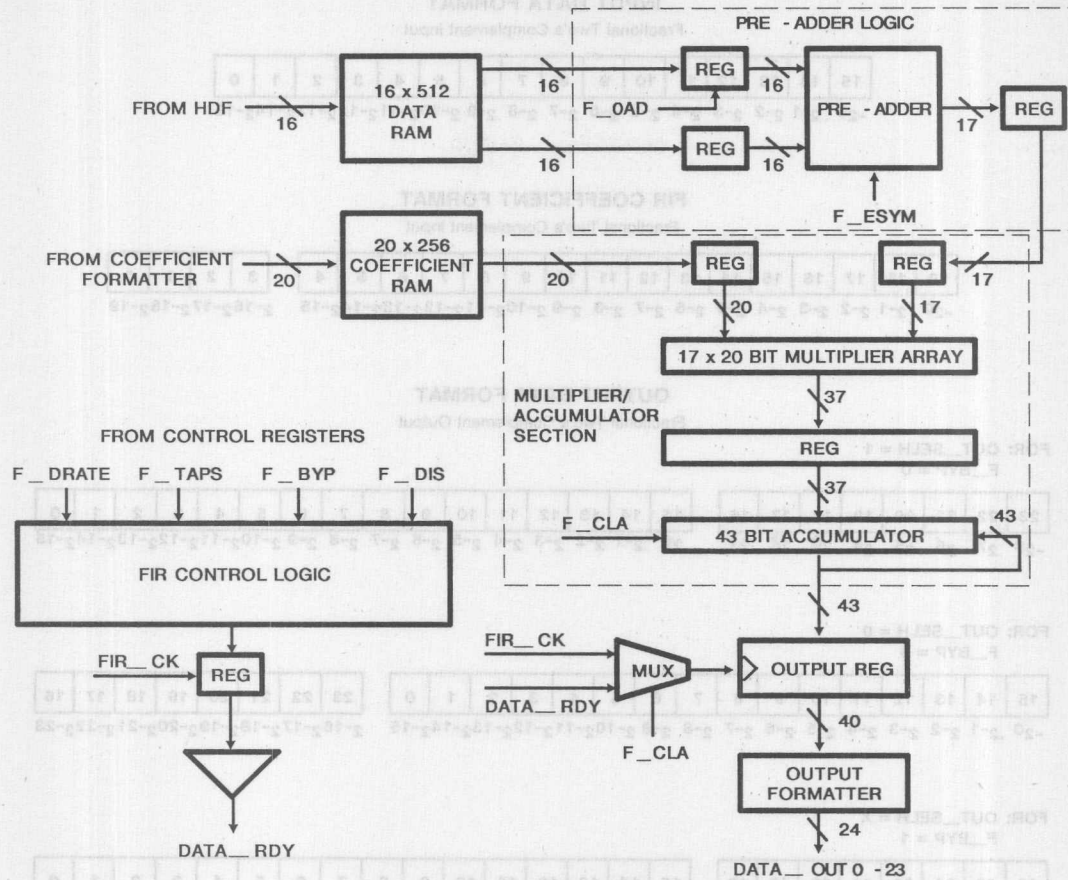


FIGURE 9. FIR FILTER

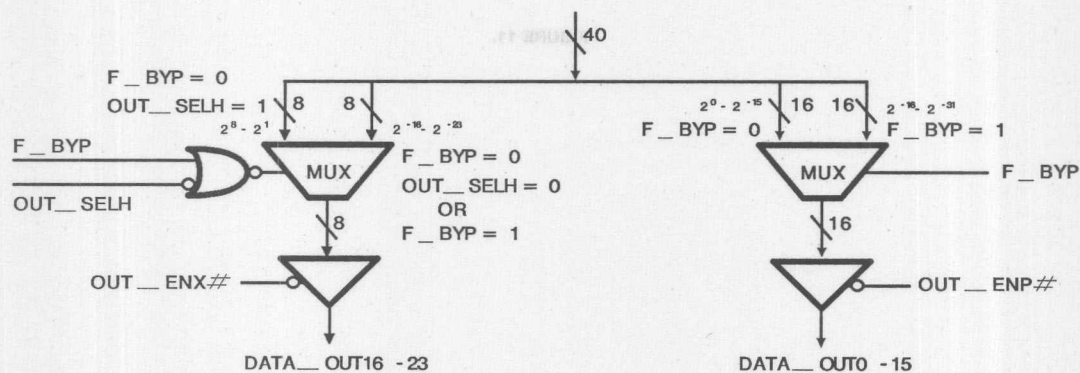


FIGURE 10. FIR OUTPUT FORMATTER



## INPUT DATA FORMAT

Fractional Two's Complement Input

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
-2 <sup>0</sup>	2 <sup>-1</sup>	2 <sup>-2</sup>	2 <sup>-3</sup>	2 <sup>-4</sup>	2 <sup>-5</sup>	2 <sup>-6</sup>	2 <sup>-7</sup>	2 <sup>-8</sup>	2 <sup>-9</sup>	2 <sup>-10</sup>	2 <sup>-11</sup>	2 <sup>-12</sup>	2 <sup>-13</sup>	2 <sup>-14</sup>	2 <sup>-15</sup>

## FIR COEFFICIENT FORMAT

Fractional Two's Complement Input

19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4
-2 <sup>0</sup>	2 <sup>-1</sup>	2 <sup>-2</sup>	2 <sup>-3</sup>	2 <sup>-4</sup>	2 <sup>-5</sup>	2 <sup>-6</sup>	2 <sup>-7</sup>	2 <sup>-8</sup>	2 <sup>-9</sup>	2 <sup>-10</sup>	2 <sup>-11</sup>	2 <sup>-12</sup>	2 <sup>-13</sup>	2 <sup>-14</sup>	2 <sup>-15</sup>

3	2	1	0
2 <sup>-16</sup>	2 <sup>-17</sup>	2 <sup>-18</sup>	2 <sup>-19</sup>

## OUTPUT DATA FORMAT

Fractional Two's Complement Output

FOR: OUT\_SELH = 1  
F\_BYP = 0

23	22	21	20	19	18	17	16
-2 <sup>8</sup>	2 <sup>7</sup>	2 <sup>6</sup>	2 <sup>5</sup>	2 <sup>4</sup>	2 <sup>3</sup>	2 <sup>2</sup>	2 <sup>1</sup>

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
2 <sup>0</sup>	2 <sup>-1</sup>	2 <sup>-2</sup>	2 <sup>-3</sup>	2 <sup>-4</sup>	2 <sup>-5</sup>	2 <sup>-6</sup>	2 <sup>-7</sup>	2 <sup>-8</sup>	2 <sup>-9</sup>	2 <sup>-10</sup>	2 <sup>-11</sup>	2 <sup>-12</sup>	2 <sup>-13</sup>	2 <sup>-14</sup>	2 <sup>-15</sup>

FOR: OUT\_SELH = 0  
F\_BYP = 0

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
-2 <sup>0</sup>	2 <sup>-1</sup>	2 <sup>-2</sup>	2 <sup>-3</sup>	2 <sup>-4</sup>	2 <sup>-5</sup>	2 <sup>-6</sup>	2 <sup>-7</sup>	2 <sup>-8</sup>	2 <sup>-9</sup>	2 <sup>-10</sup>	2 <sup>-11</sup>	2 <sup>-12</sup>	2 <sup>-13</sup>	2 <sup>-14</sup>	2 <sup>-15</sup>

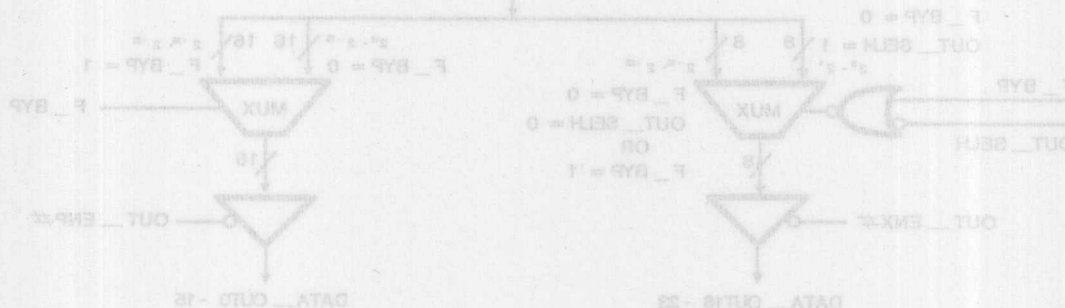
23	22	21	20	19	18	17	16
2 <sup>-16</sup>	2 <sup>-17</sup>	2 <sup>-18</sup>	2 <sup>-19</sup>	2 <sup>-20</sup>	2 <sup>-21</sup>	2 <sup>-22</sup>	2 <sup>-23</sup>

FOR: OUT\_SELH = X  
F\_BYP = 1

23	22	21	20	19	18	17	16
2 <sup>-16</sup>	2 <sup>-17</sup>	2 <sup>-18</sup>	2 <sup>-19</sup>	2 <sup>-20</sup>	2 <sup>-21</sup>	2 <sup>-22</sup>	2 <sup>-23</sup>

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
2 <sup>-16</sup>	2 <sup>-17</sup>	2 <sup>-18</sup>	2 <sup>-19</sup>	2 <sup>-20</sup>	2 <sup>-21</sup>	2 <sup>-22</sup>	2 <sup>-23</sup>	2 <sup>-24</sup>	2 <sup>-25</sup>	2 <sup>-26</sup>	2 <sup>-27</sup>	2 <sup>-28</sup>	2 <sup>-29</sup>	2 <sup>-30</sup>	2 <sup>-31</sup>

FIGURE 11.



### Multi-Chip Start Configurations

Since there are two methods to start up the DDF, there are also two configurations that can be used to start up multiple chips.

The first method is shown in Figure 12. The timing of the STARTOUT# circuitry starts the second DDF on the same clock as the first. If more DDF's are also to be started synchronously, STARTOUT# is connected to their STARTIN#'s.

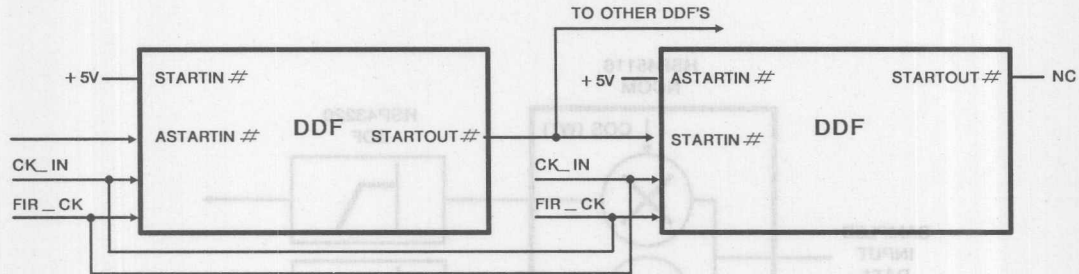


FIGURE 12. ASYNCHRONOUS START UP

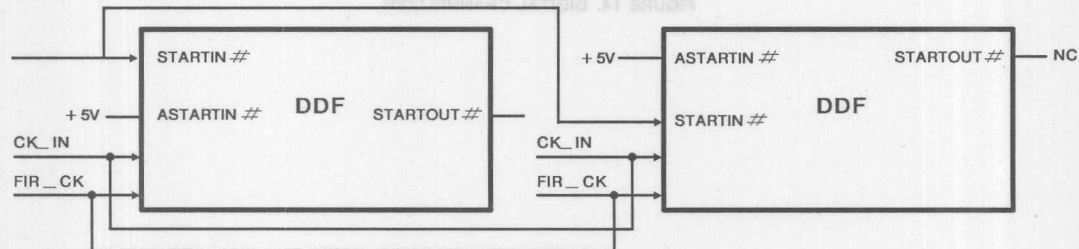


FIGURE 13. SYNCHRONOUS START UP

The second method to start up DDF's in a multiple chip configuration is to use the synchronous start scenario.

The STARTIN# input is wired to all the chips in the chain, and is asserted by a active low synchronous pulse that has been externally synchronized to CK\_IN. In this way all DDF's are synchronously started. The ASTARTIN# input on all the chips is tied high to prevent false starts. The STARTOUT# outputs are all left unconnected. This configuration is illustrated in Figure 13.

### Chip Set Application

The HSP43220 is ideally suited for narrow band filtering in Communications, Instrumentation and Signal Processing applications. The HSP43220 provides a fully integrated solution to high order decimation filtering.

The combination of the HSP43220 and the HSP45116 (which is a NCOM Numerically Controlled Oscillator/Modulator) provides a complete solution to digital receivers. The diagram in Figure 14 illustrates this concept.

The HSP45116 down converts the signal of interest to baseband, generating a real component and an imaginary

component. A HSP43220 then performs low pass filtering and reduces the sampling rate of each of the signals.

The system scenario for the use of the DDF involves a narrow band signal that has been over-sampled. The signal is over-sampled in order to capture a wide frequency band containing many narrow band signals. The NCOM is "tuned" to the frequency of the signal of interest and performs a complex down conversion to baseband of this signal, which results in a complex signal centered at baseband. A pair of DDF's then low pass filters the NCOM output, extracting the signal of interest.

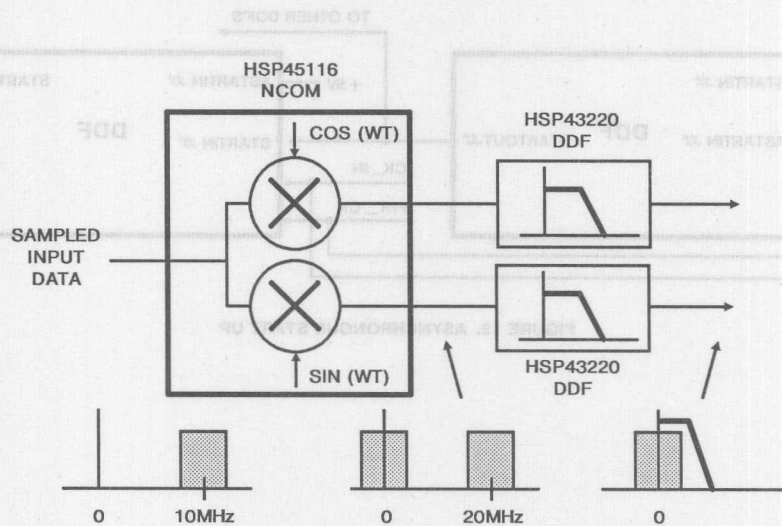


FIGURE 14. DIGITAL CHANNELIZER

## Design Trade-Off Considerations

Equation 2.0 in the Functional Description section expresses the relationship between the number of TAPS which can be implemented in the FIR as a function of CK\_IN, FIR\_CK, Hdec, Fdec. Figure 15 provides a tradeoff of these parameters. For a given speed grade and the ratio of the clocks, and assuming minimum decimation in the HDF, the number of FIR taps that can be implemented is given in equation 2.0.

SPEED GRADE (MHz)	FIR_CK CK_IN	MIN Hdec	TAPS				
			Fdec = 1	Fdec = 2	Fdec = 4	Fdec = 8	Fdec = 16
33	1	9	8	24	56	120	248
25.6	1	7	4	16	40	88	184
15	1	4	*	4	16	40	88
33	2	5	10	28	64	136	280
25.6	2	4	6	20	48	104	216
15	2	2	*	4	16	40	88
33	4	3	14	36	80	168	344
25.6	4	2	6	20	48	104	216
15	4	1	*	4	16	40	88
33	8	2	22	52	112	232	472
25.6	8	1	6	20	48	104	216
15	8	1	6	20	48	104	216

\* Filter Not Realizable

FIGURE 15. DESIGN TRADE OFF FOR MINIMUM Hdec

## DECI•MATE

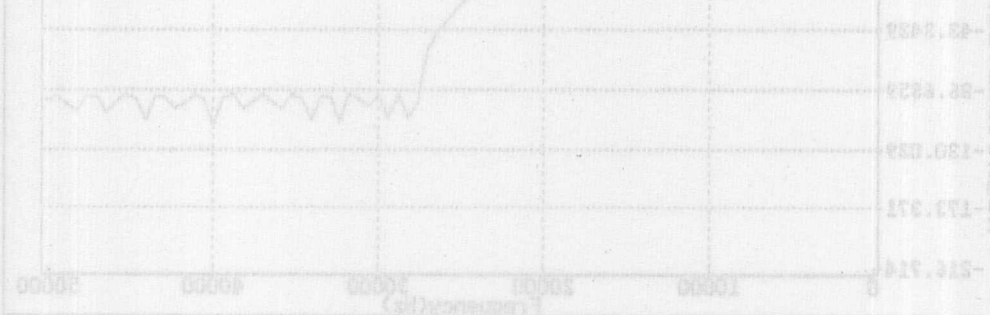
Harris provides a development system which assists the design engineer to utilizing this filter. The DECI•MATE software package provides the user with both filter design and simulation environments for filter evaluation and design. These tools are integrated within one standard DSP CAD environment, The Athena Group's Monarch Professional DSP Software package.

The software package is designed specifically for the DDF. It provides all the filter design software for this proprietary architecture. It provides a user-friendly menu driven interface to allow the user to input system level filter requirements. It provides the frequency response curves and a data flow simulation of the specified filter design (Figure 16). It also creates all the information necessary to program the DDF, including a PROM file for programming the control registers.

This software package runs on an IBM™ PC™, XT™, AT™, PS/2™ computer or 100% compatible with the following configuration:

640K RAM  
5.25" or 3.5" Floppy drive  
hard disk  
math co-processor  
MS/PC-DOS 2.0 or higher  
CGA, MCGA, EGA, VGA and  
Hercules graphics adapters

For more information, see the description of DECI-MATE in the Development Tools Section of this databook.





## HSP43220 DDF FILTER SPECIFICATION

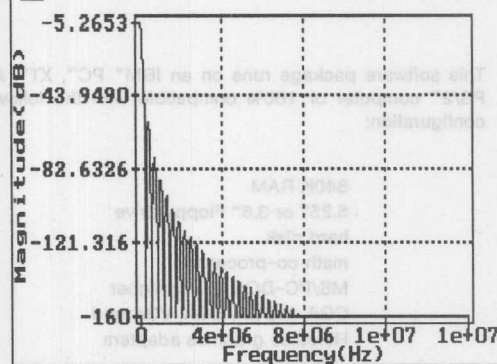
Filter File	:	vectors\example.DDF			
Input Sample Rate	:	33 MHz	Design Mode	:	AUTO
Output Rate	:	100 kHz	Generate Report	:	YES
Passband	:	20 kHz	Display Response	:	LOG
Transition Band	:	7.5 kHz	Save Freq Responses	:	YES
Passband Atten	:	0.5 dB	Save FIR Response	:	YES
Stopband Atten	:	80 dB			

FIR Type : PRECOMP

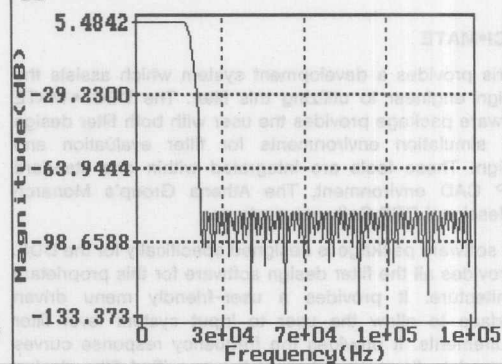
HDF Order	:	4	FIR Input Rate	:	300 kHz
HDF Decimation	:	110	FIR Clock (min)	:	33 MHz
HDF Scale Factor	:	0.54542	FIR Order	:	135
			FIR Decimation	:	3

(C) Harris Semiconductor 1990

HDF Frequency Response



FIR Frequency Response



System Frequency Response

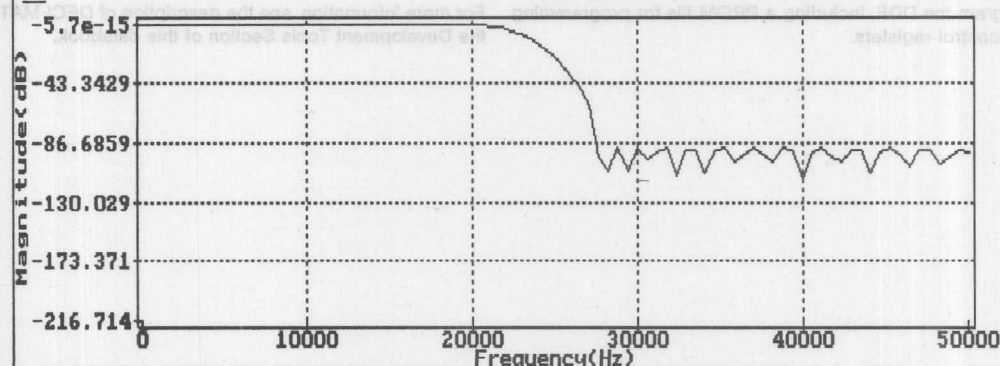


FIGURE 16. DECI\*MATE DESIGN MODULE SCREENS

# Specifications HSP43220

## Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input, Output or I/O Voltage Applied .....	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature Range .....	-65°C to +150°C
Maximum Package Power Dissipation .....	2.4W (PLCC), 3.2W (PGA)
$\theta_{jc}$ .....	10.9°C/W (PLCC), 7.2°C/W (PGA)
$\theta_{ja}$ .....	33.8°C/W (PLCC), 32.9°C/W (PGA)
Device Count .....	193,000 Transistors
Junction Temperature .....	150°C (PLCC), +175°C (PGA)
Lead Temperature (Soldering, Ten Seconds) .....	+300°C
ESD Classification .....	Class 1

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range .....	+4.75V to +5.25V
Operating Temperature Range .....	0°C to +70°C

## D.C. Electrical Specifications $V_{CC} = +4.75V$ to $+5.25V$ ( $V_{CC} = 5.0V \pm 5\%$ ), $T_A = 0^\circ C$ to $+70^\circ C$

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Logical One Input Voltage	$V_{IH}$	2.0	-	V	$V_{CC} = 5.25V$
Logical Zero Input Voltage	$V_{IL}$	-	0.8	V	$V_{CC} = 4.75V$
High Level Clock Input	$V_{IHC}$	3.0	-	V	$V_{CC} = 5.25V$
Low Level Clock Input	$V_{ILC}$	-	0.8	V	$V_{CC} = 4.75V$
Output HIGH Voltage	$V_{OH}$	2.6	-	V	$I_{OH} = -400\mu A$ $V_{CC} = 4.75V$
Output LOW Voltage	$V_{OL}$	-	0.4	V	$I_{OL} = +2.0mA$ $V_{CC} = 4.75V$
Input Leakage Current	$I_I$	-10	10	$\mu A$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.25V$
I/O Leakage Current	$I_O$	-10	10	$\mu A$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.25V$
Standby Power Supply Current	$I_{CCSB}$	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Note 3
Operating Power Supply Current	$I_{CCOP}$	-	120	mA	$f = 15 MHz$ , $V_{IN} = V_{CC}$ or GND $V_{CC} = 5.25V$ , Note 1, Note 3

## Capacitance ( $T_A = +25^\circ C$ , Note 2)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Input Capacitance	$C_{IN}$		12	pF	FREQ = 1 MHz, $V_{CC}$ = Open, all measurements are referenced to device ground.
Output Capacitance	$C_O$		10	pF	

### NOTES:

- Power supply current is proportional to operating frequency. Typical rating for  $I_{CCOP}$  is 8mA/MHz.
- Not tested, but characterized at initial design and at major process/design changes.
- Output load per test load circuit and  $C_L = 40pF$ .

3

1-D FILTERS

# Specifications HSP43220

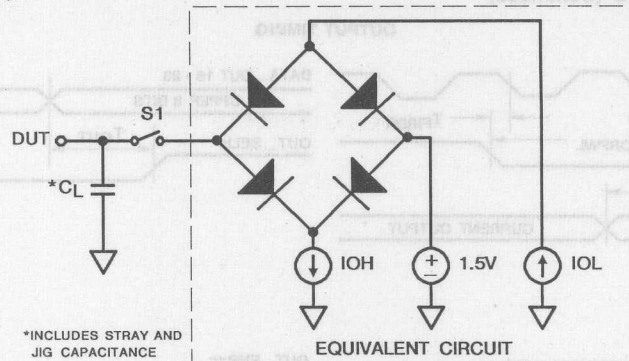
## A.C. Electrical Specifications $V_{CC} = +4.75V$ to $+5.25V$ , $T_A = 0^{\circ}C$ to $+70^{\circ}C$

PARAMETER	SYMBOL	-15		-25		-33		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX	MIN	MAX		
Input Clock Frequency	$F_{CK}$	0	15	0	25.6	0	33	MHz	
FIR Clock Frequency	$F_{FIR}$	0	15	0	25.6	0	33	MHz	
Input Clock Period	$T_{CK}$	66	-	39	-	30	-	ns	
FIR Clock Period	$T_{FIR}$	66	-	39	-	30	-	ns	
Clock Pulse Width Low	$T_{SPWL}$	26	-	16	-	13	-	ns	
Clock Pulse Width High	$T_{SPWH}$	26	-	16	-	13	-	ns	
Clock Skew Between $FIR\_CK$ and $CK\_IN$	$T_{SK}$	0	$T_{FIR}-25$	0	$T_{FIR}-15$	0	$T_{FIR}-15$	ns	
$CK\_IN$ Pulse Width Low	$T_{CH1L}$	29	-	19	-	19	-	ns	Note 1, Note 4
$CK\_IN$ Pulse Width High	$T_{CH1H}$	29	-	19	-	19	-	ns	Note 1, Note 4
$CK\_IN$ Setup to $FIR\_CK$	$T_{CIS}$	27	-	17	-	17	-	ns	Note 1, Note 4
$CK\_IN$ Hold from $FIR\_CK$	$T_{CIH}$	2	-	2	-	2	-	ns	Note 1, Note 4
RESET# Pulse Width Low	$T_{RSPW}$	$4T_{CK}$	-	$4T_{CK}$	-	$4T_{CK}$	-	ns	
Recovery Time on RESET#	$T_{RTRS}$	$8T_{CK}$	-	$8T_{CK}$	-	$8T_{CK}$	-	ns	
ASTARTIN# Pulse Width Low	$T_{AST}$	$T_{CK}+10$	-	$T_{CK}+10$	-	$T_{CK}+10$	-	ns	
STARTOUT# Delay from $CK\_IN$	$T_{STOD}$	-	35	-	20	-	18	ns	
STARTIN# Setup to $CK\_IN$	$T_{STIC}$	25	-	15	-	10	-	ns	
Setup Time on $DATA\_IN$	$T_{SET}$	20	-	15	-	14	-	ns	
Hold Time on All inputs	$T_{HOLD}$	0	-	0	-	0	-	ns	
Write Pulse Width Low	$T_{WL}$	26	-	15	-	12	-	ns	
Write Pulse Width High	$T_{WH}$	26	-	20	-	18	-	ns	
Setup Time on Address Bus Before the Rising Edge of Write	$T_{STADD}$	26	-	20	-	20	-	ns	
Setup Time on Chip Select Before the Rising Edge of Write	$T_{STCS}$	26	-	20	-	20	-	ns	
Setup Time on Control Bus Before the Rising Edge of Write	$T_{STCB}$	26	-	20	-	20	-	ns	
$DATA\_RDY$ Pulse Width Low	$T_{DRPWL}$	$2T_{FIR}-20$	-	$2T_{FIR}-10$	-	$2T_{FIR}-10$	-	ns	
$DATA\_OUT$ Delay Relative to $FIR\_CK$	$T_{FIRDV}$	-	50	-	35	-	28	ns	
$DATA\_RDY$ Valid Delay Relative to $FIR\_CK$	$T_{FIRDR}$	-	35	-	25	-	20	ns	
$DATA\_OUT$ Delay Relative to $OUT\_SELH$	$T_{OUT}$	-	25	-	20	-	20	ns	
Output Enable to Data Out Valid	$T_{OEV}$	-	15	-	15	-	15	ns	Note 2
Output Disable to Data Out Three State	$T_{OEZ}$	-	15	-	15	-	15	ns	Note 1
Output Rise, Output Fall Times	$T_{R,Tf}$	-	8	-	8	-	6	ns	from .8V to 2V, Note 1

### NOTES:

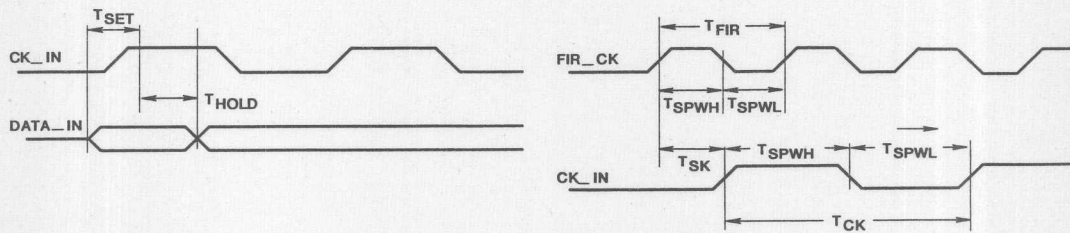
- Controlled by design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.
- Transition is measured at  $\pm 200mV$  from steady state voltage with loading as specified in test load circuit with and  $C_L = 40pF$ .
- A.C. Testing is performed as follows: Input levels (CLK Input) 4.0V and 0V, Input levels (all other Inputs) 0V and 3.0V, Timing reference levels (CLK) = 2.0V, (Others) = 1.5V, Output load per test load circuit and  $C_L = 40pF$ .
- Applies only when  $H\_BYP = 1$  or  $H\_DRATE = 0$ .

## Test Load Circuit

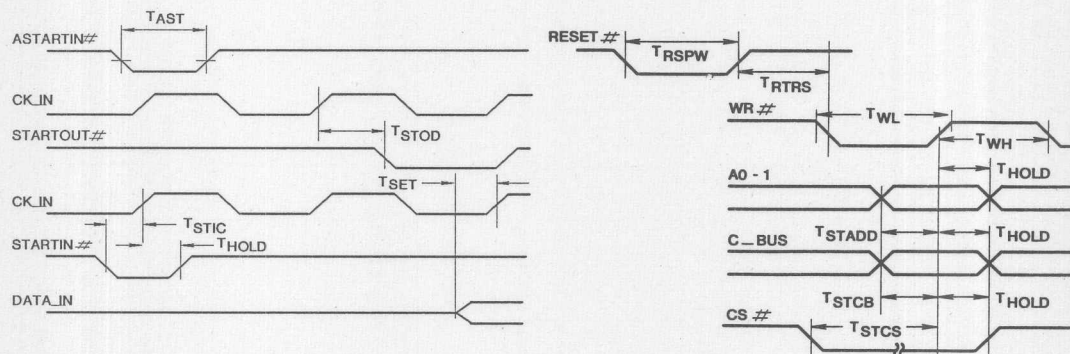
Switch S1 Open for  $I_{CCSB}$  and  $I_{CCOP}$  Tests

## Timing Waveforms

## INPUT TIMING

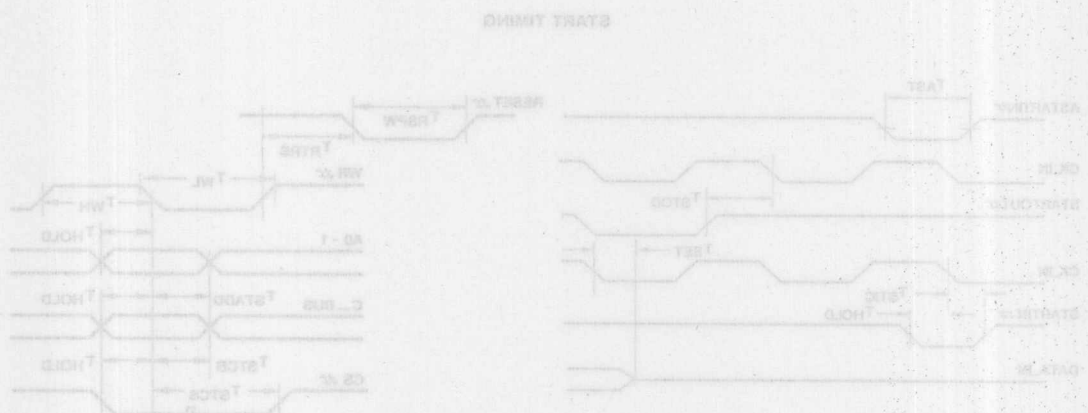
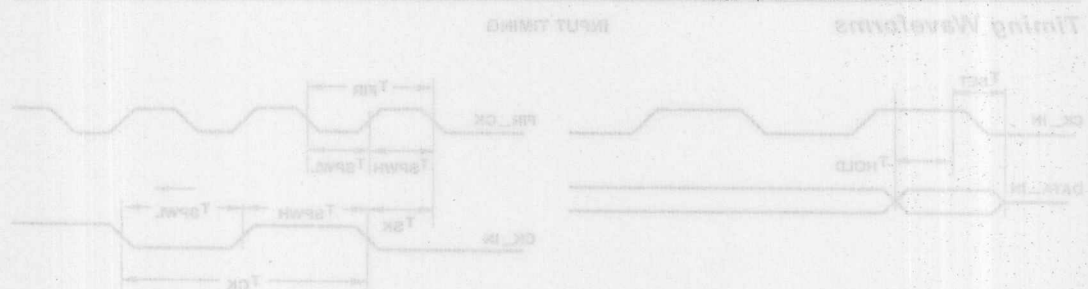
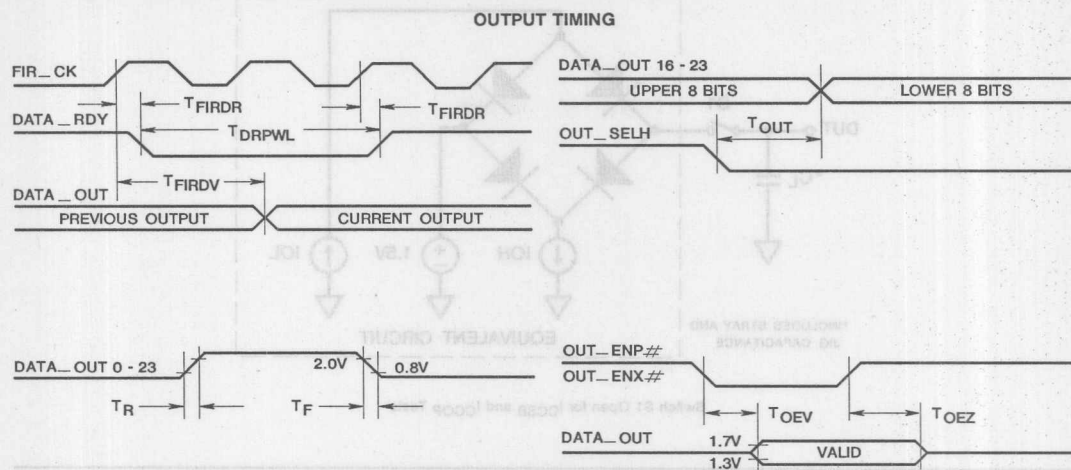


## START TIMING





## Timing Waveforms (Continued)



# **HARRIS HSP43220/883**

August 1992

## **Decimating Digital Filter**

### **Features**

- This Circuit is Processed in Accordance to Mil-Std-883 and is Fully Conformant Under the Provisions of Paragraph 1.2.1.
- Single Chip Narrow Band Filter with up to 96dB Attenuation
- DC to 25.6MHz Clock Rate
- 16 Bit 2's Complement Input
- 20 Bit Coefficients in FIR
- 24 Bit Extended Precision Output
- Programmable Decimation up to a Maximum of 16,384
- Standard 16 Bit Microprocessor Interface
- Filter Design Software Available DECI•MATE™
- Available in 84 Pin PGA

### **Applications**

- Very Narrow Band Filters
- Zoom Spectral Analysis
- Channelized Receivers
- Sample Rate Converter
- Instrumentation
- 512 Tap Symmetric FIR Filtering

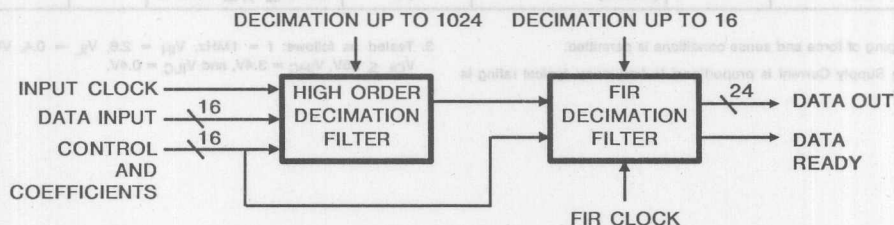
### **Description**

The HSP43220/883 Decimating Digital Filter is a linear phase low pass decimation filter which is optimized for filtering narrow band signals in a broad spectrum of a signal processing applications. The HSP43220/883 offers a single chip solution to signal processing application which have historically required several boards of IC's. This reduction in component count results in faster development times as well as reduction of hardware costs.

The HSP43220/883 is implemented as a two stage filter structure. As seen in the block diagram, the first stage is a high order decimation filter (HDF) which utilizes an efficient decimation (sample rate reduction) technique to obtain decimation up to 1024 through a coarse low-pass filtering process. The HDF provides up to 96 dB aliasing rejection in the signal pass band. The second stage consists of a finite impulse response (FIR) decimation filter structured as a transversal FIR filter with up to 512 symmetric taps which can implement filters with sharp transition regions. The FIR can perform further decimation by up to 16 if required while preserving the 96 dB aliasing attenuation obtained by the HDF. The combined total decimation capability is 16,384.

The HSP43220/883 accepts 16 bit parallel data in 2's complement format at sampling rates up to 30MSPS. It provides a 16 bit microprocessor compatible interface to simplify the task of programming and three-state outputs to allow the connection of several IC's to a common bus. The HSP43220/883 also provides the capability to bypass either the HDF or the FIR for additional flexibility.

### **Block Diagram**



DECI•MATE™ is a registered trademark of Harris Corporation.  
IBM PC™, XT™, AT™, PS/2™ are registered trademarks of International Business Machines, Inc.

CAUTION: These devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
Copyright © Harris Corporation 1992

File Number **2802.1**

# Specifications HSP43220/883

## Absolute Maximum Ratings

Supply Voltage	+8.0V
Input, Output Voltage Applied	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range	-65°C to +150°C
Junction Temperature	+175°C
Lead Temperature (Soldering, Ten Seconds)	+300°C
ESD Classification	Class 1

## Reliability Information

Thermal Resistance	$\theta_{ja}$	$\theta_{jc}$
Ceramic PGA Package	32.9°C/W	7.2°C/W
Maximum Package Power Dissipation at +125°C		
Ceramic PGA Package	1.52 Watt	
Gate Count	48,250 Gates	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range	+4.5V to +5.5V
Operating Temperature Range	-55°C to +125°C

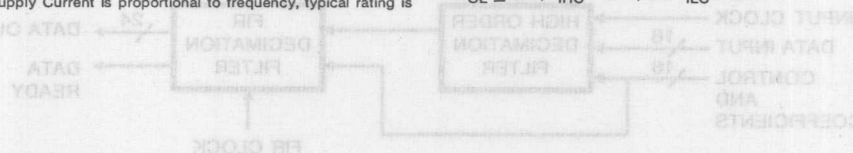
TABLE 1. D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Devices Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +2.0mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output Leakage Current	$I_O$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Clock Input High	$V_{IHC}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	3.0	-	V
Clock Input Low	$V_{ILC}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ , Outputs Open	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 15.0MHz$ $V_{CC} = 5.5V$ (Note 2)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	120.0	mA
Functional Test	FT	(Note 3)	7, 8	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	-	

### NOTES:

- Interchanging of force and sense conditions is permitted.
- Operating Supply Current is proportional to frequency, typical rating is 8mA/MHz.
- Tested as follows:  $f = 1MHz$ ,  $V_{IH} = 2.6$ ,  $V_{IL} = 0.4$ ,  $V_{OH} \geq 1.5V$ ,  $V_{OL} \leq 1.5V$ ,  $V_{IHC} = 3.4V$ , and  $V_{ILC} = 0.4V$ .



# Specifications HSP43220/883

TABLE 2. A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	(NOTE 1) CONDI- TIONS	GROUP A SUB- GROUPS	TEMPERATURE	LIMITS				UNITS
					-15 (15MHz)		-25 (25.6MHz)		
					MIN	MAX	MIN	MAX	
Input Clock Period	T <sub>CK</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	66	-	39	-	ns
FIR Clock Period	T <sub>FIR</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	66	-	39	-	ns
Clock Pulse Width Low	T <sub>SPWL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	26	-	16	-	ns
Clock Pulse Width High	T <sub>SPWH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	26	-	16	-	ns
Clock Skew Between FIR__CK and CK__IN	T <sub>SK</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	T <sub>FIR</sub> - 25	0	T <sub>FIR</sub> - 19	ns
RESET# Pulse Width Low	T <sub>RSPW</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	4T <sub>CK</sub>	-	4T <sub>CK</sub>	-	ns
Recovery Time On RESET#	T <sub>RTRS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	8T <sub>CK</sub>	-	8T <sub>CK</sub>	-	ns
ASTARTIN# Pulse Width Low	T <sub>AST</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	T <sub>CK</sub> + 10	-	T <sub>CK</sub> + 10	-	ns
STARTOUT# Delay From CK__IN	T <sub>STOD</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	35	-	20	ns
STARTIN# Setup To CK__IN	T <sub>STIC</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	25	-	15	-	ns
Setup Time on DATA__IN	T <sub>SET</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	16	-	ns
Hold Time on All Inputs	T <sub>HOLD</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
Write Pulse Width Low	T <sub>WL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	26	-	15	-	ns
Write Pulse Width High	T <sub>WH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	26	-	20	-	ns
Setup Time on Address Bus Before the Rising Edge of Write	T <sub>STADD</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	28	-	24	-	ns
Setup Time on Chip Select Before the Rising Edge of Write	T <sub>STCS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	28	-	24	-	ns
Setup Time on Control Bus Before the Rising Edge of Write	T <sub>STCB</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	28	-	24	-	ns
DATA__RDY Pulse Width Low	T <sub>DRPWL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	2T <sub>FIR</sub> - 20	-	2T <sub>FIR</sub> - 10	-	ns
DATA__OUT Delay Relative to FIR__CK	T <sub>FIRDV</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	50	-	35	ns
DATA__RDY Valid Delay Relative to FIR__CK	T <sub>FIRDR</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	35	-	25	ns
DATA__OUT Delay Relative to OUT__SELH	T <sub>OUT</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	30	-	25	ns
Output Enable to Data Out Valid	T <sub>OEV</sub>	Note 2	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	20	-	20	ns

NOTES:

1. A.C. Testing: VCC = 4.5V and 5.5V. Inputs are driven at 3.0V for a Logic "1" and 0.0V for a Logic "0". Input and output timing measurements are made at 1.5V for both a Logic "1" and "0". CLK is driven at 4.0V and 0V and measured at 2.0V.

2. Transition is measured at ±200mV from steady state voltage with loading as specified by test load circuit and C<sub>L</sub> = 40pF.

3

1-D FILTERS



TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETERS	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	LIMITS				UNITS
					-15 (15MHz)		-25 (25.6MHz)		
					MIN	MAX	MIN	MAX	
CK_IN Pulse Width Low	T <sub>CH1L</sub>		1, 3	-55°C ≤ T <sub>A</sub> ≤ +125°C	29	-	19	-	ns
CK_IN Pulse Width High	T <sub>CH1H</sub>		1, 3	-55°C ≤ T <sub>A</sub> ≤ +125°C	29	-	19	-	ns
CK_IN Setup to FIR_CK	T <sub>CIS</sub>		1, 3	-55°C ≤ T <sub>A</sub> ≤ +125°C	27	-	17	-	ns
CK_IN Hold from FIR_CK	T <sub>CIH</sub>		1, 3	-55°C ≤ T <sub>A</sub> ≤ +125°C	2	-	2	-	ns
Input Capacitance	C <sub>IN</sub>	V <sub>CC</sub> = Open, f = 1MHz, All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	12	-	12	pF
Output Capacitance	C <sub>OUT</sub>	V <sub>CC</sub> = Open, f = 1MHz, All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	10	-	10	pF
Output Disable Delay	T <sub>OEZ</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	20	-	20	ns
Output Rise Time	T <sub>OR</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	8	-	8	ns
Output Fall Time	T <sub>OF</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	8	-	8	ns

## NOTES:

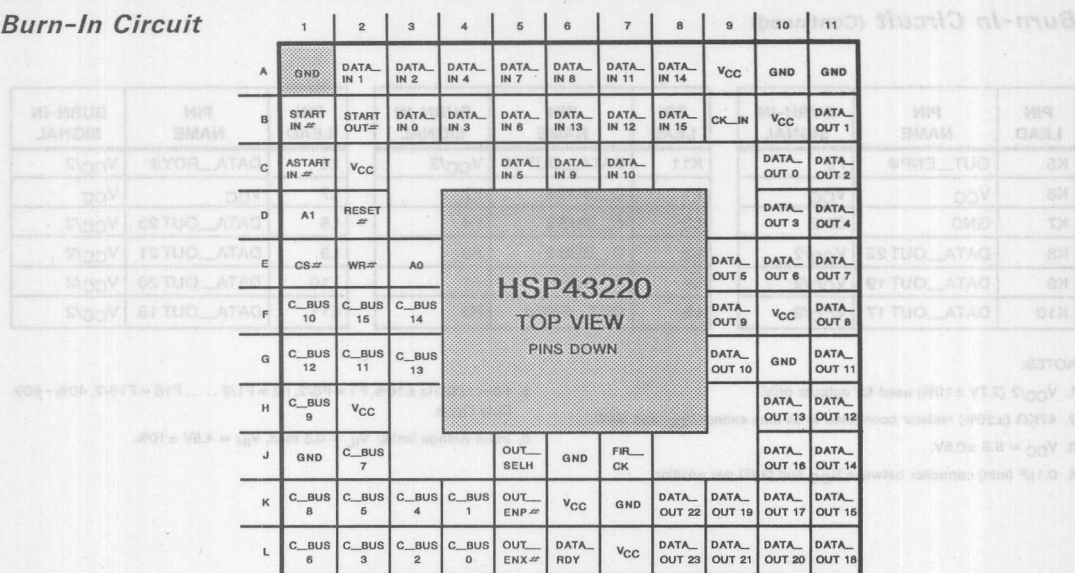
- Parameters listed in Table 3 are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design and after major process and/or design changes.
- Loading is as specified in the test load circuit with C<sub>L</sub> = 40pF.
- Applies only when H\_BYP = 1 or H\_DRATE = 0.

TABLE 4. APPLICABLE SUBGROUPS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	—	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9

NOTES:  
 1. AC Test: V<sub>CC</sub> = 4.5V and 5.0V, inputs are driven at 50V for a logic "1" and 0V for a logic "0". Input and output timing measurements are made at 1.5V for both a logic "1" and "0". CLK is driven at 4.5V and V<sub>CE</sub> is measured at 2.0V.  
 2. Through-hole is measured at ±200mV from steady state voltage with loading as specified by test load circuit and C<sub>L</sub> = 40pF.

## Burn-In Circuit



## Burn-In Circuit (Continued)

PIN LEAD	PIN NAME	BURN-IN SIGNAL
K5	OUT_ENP#	F9
K6	V <sub>CC</sub>	V <sub>CC</sub>
K7	GND	GND
K8	DATA_OUT 22	V <sub>CC</sub> /2
K9	DATA_OUT 19	V <sub>CC</sub> /2
K10	DATA_OUT 17	V <sub>CC</sub> /2

PIN LEAD	PIN NAME	BURN-IN SIGNAL
K11	DATA_OUT 15	V <sub>CC</sub> /2
L1	C_BUS 6	F7
L2	C_BUS 3	F4
L3	C_BUS 2	F3
L4	C_BUS 0	F1
L5	OUT_ENP#	F9

PIN LEAD	PIN NAME	BURN-IN SIGNAL
L6	DATA_RDY#	V <sub>CC</sub> /2
L7	V <sub>CC</sub>	V <sub>CC</sub>
L8	DATA_OUT 23	V <sub>CC</sub> /2
L9	DATA_OUT 21	V <sub>CC</sub> /2
L10	DATA_OUT 20	V <sub>CC</sub> /2
L11	DATA_OUT 18	V <sub>CC</sub> /2

## NOTES:

1. V<sub>CC</sub>/2 (2.7V ±10%) used for outputs only.
2. 47KΩ (±20%) resistor connected to all pins except V<sub>CC</sub> and GND.
3. V<sub>CC</sub> = 5.5 ±0.5V.
4. 0.1μF (min) capacitor between V<sub>CC</sub> and GND per position.
5. F0 = 100kHz ±10%, F1 = F0/2, F2 = F1/2 ..... F16 = F15/2, 40% - 60% Duty Cycle.
6. Input voltage limits: V<sub>IL</sub> = 0.8 max, V<sub>IH</sub> = 4.5V ±10%.

PIN LEAD	PIN NAME	BURN-IN SIGNAL
F11	DATA_OUT 3	V <sub>CC</sub> /2
F1	C_BUS 15	F2
G2	C_BUS 11	F4
G3	C_BUS 13	F5
G8	DATA_OUT 10	V <sub>CC</sub> /2
G10	GND	GND
G11	DATA_OUT 11	V <sub>CC</sub> /2
H1	C_BUS 9	F2
H2	V <sub>CC</sub>	V <sub>CC</sub>
H10	DATA_OUT 13	V <sub>CC</sub> /2
H11	DATA_OUT 12	V <sub>CC</sub> /2
J1	GND	GND
J2	C_BUS 7	F2
J2	OUT_SELH	F10
J6	GND	GND
J8	PR_CK	F3
J10	DATA_OUT 16	V <sub>CC</sub> /2
J11	DATA_OUT 14	V <sub>CC</sub> /2
K1	C_BUS 8	F3
K3	C_BUS 6	F2
K3	C_BUS 4	F2
K4	C_BUS 1	F2

PIN LEAD	PIN NAME	BURN-IN SIGNAL
C1	DATA_OUT 1	V <sub>CC</sub> /2
C2	V <sub>CC</sub>	V <sub>CC</sub>
C3	DATA_OUT 2	F2
C3	DATA_OUT 5	F2
C7	DATA_OUT 10	F2
C10	DATA_OUT 1	V <sub>CC</sub> /2
C11	DATA_OUT 2	V <sub>CC</sub> /2
D1	A1	F14
D2	RESET	F18
D10	DATA_OUT 3	V <sub>CC</sub> /2
D11	DATA_OUT 4	V <sub>CC</sub> /2
E1	CS	F11
E2	WR	F11
E3	AO	F13
E8	DATA_OUT 5	V <sub>CC</sub> /2
E10	DATA_OUT 6	V <sub>CC</sub> /2
E11	DATA_OUT 7	V <sub>CC</sub> /2
F1	C_BUS 10	F2
F2	C_BUS 13	F2
F3	C_BUS 14	F3
F8	DATA_OUT 8	V <sub>CC</sub> /2
F10	V <sub>CC</sub>	V <sub>CC</sub>

PIN LEAD	PIN NAME	BURN-IN SIGNAL
A1	GND	GND
A2	DATA_OUT 1	F2
A3	DATA_OUT 2	F3
A4	DATA_OUT 3	F2
A5	DATA_OUT 7	F2
A6	DATA_OUT 8	F1
A7	DATA_OUT 11	F4
A8	DATA_OUT 14	F7
A9	V <sub>CC</sub>	V <sub>CC</sub>
A10	GND	GND
A11	GND	GND
B1	STARTUP	F18
B2	DATA_OUT 6	V <sub>CC</sub> /2
B3	DATA_OUT 9	F1
B4	DATA_OUT 8	F4
B5	DATA_OUT 9	F7
B6	DATA_OUT 12	F6
B7	DATA_OUT 13	F2
B8	DATA_OUT 16	F2
B9	CK_IN	F3
B10	V <sub>CC</sub>	V <sub>CC</sub>
B11	DATA_OUT 1	V <sub>CC</sub> /2

- NOTES:
1. V<sub>CC</sub> = 5.5 ±0.5V used for outputs only.
  2. 47KΩ (±20%) resistor connected to all pins except V<sub>CC</sub> and GND.
  3. V<sub>CC</sub> = 5.5 ±0.5V.
  4. 0.1μF (min) capacitor between V<sub>CC</sub> and GND per position.
  5. Input voltage limits: V<sub>IL</sub> = 0.8 max, V<sub>IH</sub> = 4.5V ±10%.
  6. Duty Cycle.
  7. F0 = 100kHz ±10%, F1 = F0/2, F2 = F1/2 ..... F16 = F15/2, 40% - 60% Duty Cycle.

**Metal Topology****DIE DIMENSIONS:**

348 x 349.2 x 19±1 mils

**METALLIZATION:**

Type: Si - Al or Si - Al - Cu

Thickness: 8kÅ

**DIE ATTACH:**

Material: Silver-Glass

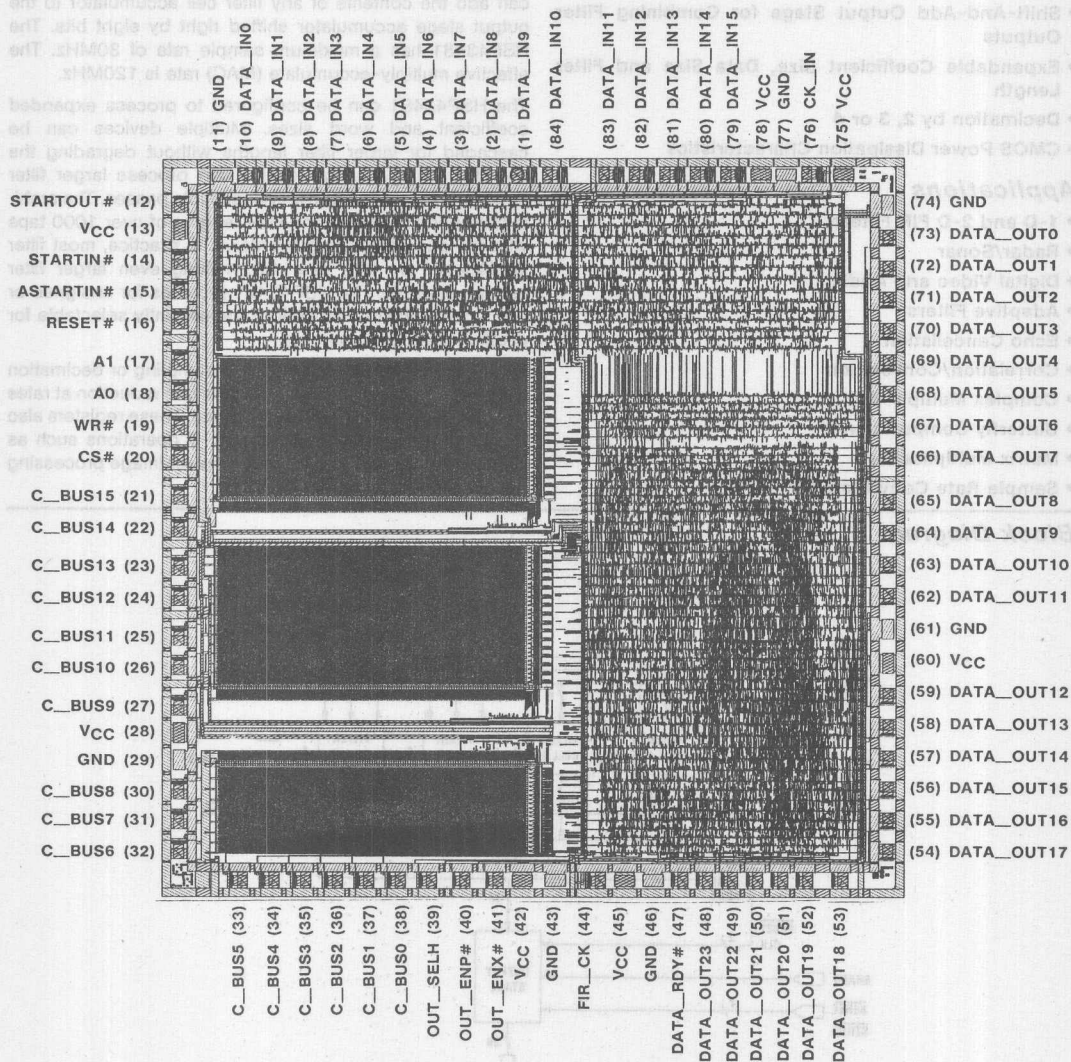
**WORST CASE CURRENT DENSITY:** $1.18 \times 10^5 \text{ A/cm}^2$ **GLASSIVATION:**

Type: Nitrox

Thickness: 10kÅ

**Metallization Mask Layout**

HSP43220/883



3

1-D FILTERS



August 1992

**Digital Filter**

## Features

- Four Filter Cells
- 0 to 30MHz Sample Rate
- 8 Bit Coefficients and Signal Data
- 26 Bit Accumulator per Stage
- Filter Lengths Up to 1032 Tap
- Shift-And-Add Output Stage for Combining Filter Outputs
- Expandable Coefficient Size, Data Size and Filter Length
- Decimation by 2, 3 or 4
- CMOS Power Dissipation Characteristics

## Applications

- 1-D and 2-D FIR Filters
- Radar/Sonar
- Digital Video and Audio
- Adaptive Filters
- Echo Cancellation
- Correlation/Convolution
- Complex Multiply-Add
- Butterfly Computation
- Matrix Multiplication
- Sample Rate Converters

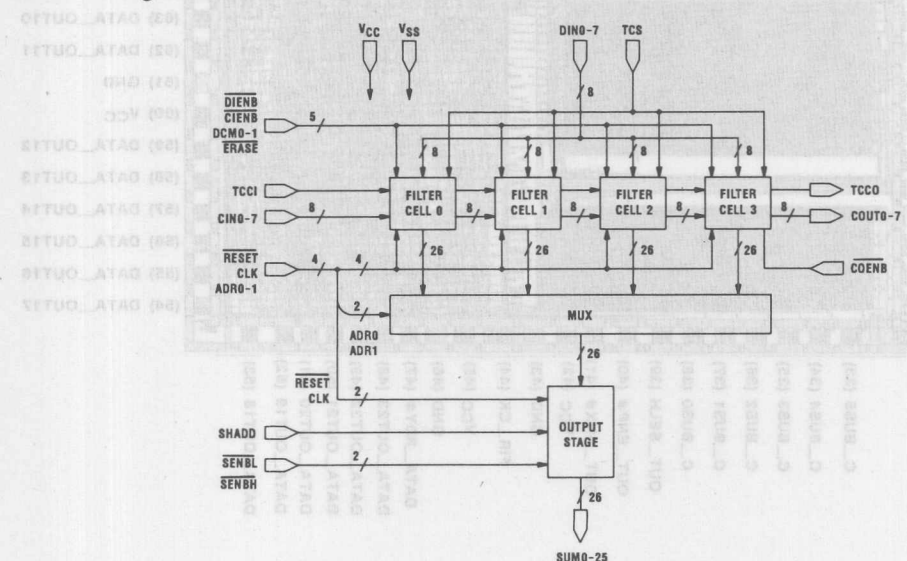
## Description

The HSP43481 is a video-speed Digital Filter (DF) designed to efficiently implement vector operations such as FIR digital filters. It is comprised of four filter cells cascaded internally and a shift-and-add output stage, all in a single integrated circuit. Each filter cell contains an 8x8 multiplier, three decimation registers and a 26 bit accumulator which can add the contents of any filter cell accumulator to the output stage accumulator shifted right by eight bits. The HSP43481 has a maximum sample rate of 30MHz. The effective multiply-accumulate (MAC) rate is 120MHz.

The HSP43481 can be configured to process expanded coefficient and word sizes. Multiple devices can be cascaded for larger filter lengths without degrading the sample rate or a single device can process larger filter lengths at less than 30MHz with multiple passes. The architecture permits processing filter lengths of over 1000 taps with the guarantee of no overflows. In practice, most filter coefficients are less than 1.0, making even larger filter lengths possible. The HSP43481 provides for unsigned or two's complement arithmetic, independently selectable for coefficients and signal data.

Each DF filter cell contains three resampling or decimation registers which permit output sample rate reduction at rates of 1/2, 1/3 or 1/4 the input sample rate. These registers also provide the capability to perform 2-D operations such as NxN spatial correlations/convolutions for image processing applications.

## Block Diagram



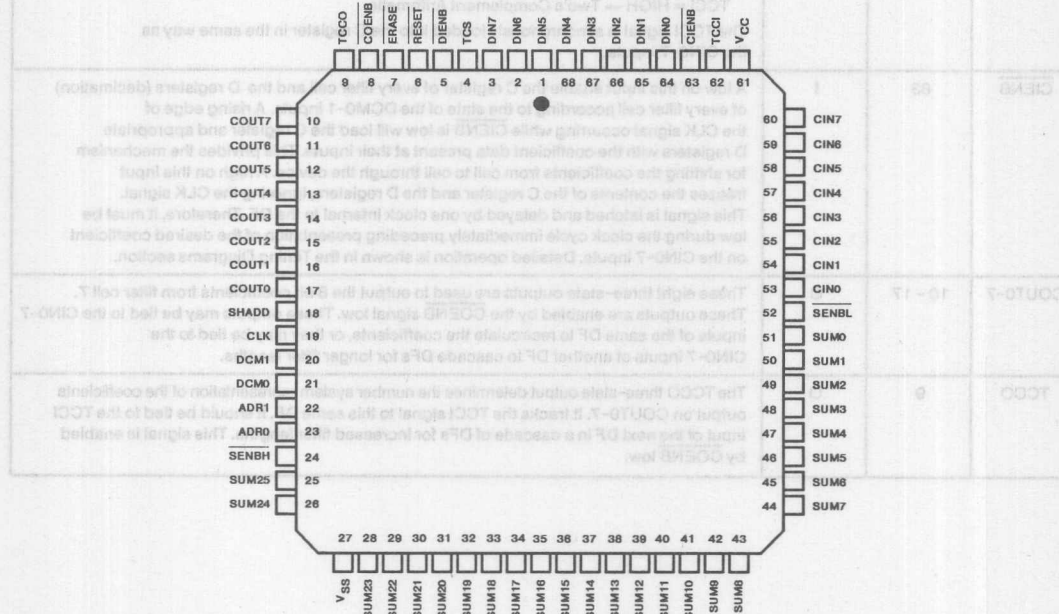
## Pinouts

68 PIN CERAMIC PIN GRID ARRAY (PGA)  
BOTTOM VIEW

L		COUT7	COUT5	COUT3	COUT1	CLK	ADDR1	ADDR0	SUM25		
K	TCCO	COENB	COUT6	COUT4	COUT2	SHADD	DCM1	DCM0	SENBH	SUM24	SUM23
J	ERASE	V <sub>CC</sub>								SUM21	SUM22
H	RESET	DIENB								SUM19	SUM20
G	TCS	DIN7								SUM17	SUM18
F	DIN5	DIN6								SUM15	SUM16
E	DIN3	DIN4							V <sub>SS</sub>	SUM14	
D	DIN1	DIN2								SUM12	SUM13
C	DIN0	CIENB								SUM10	SUM11
B	TCCI	CIN6	CIN4	CIN2	CIN0	SUM0	SUM2	SUM4	SUM6	SUM8	SUM9
A		CIN7	CIN5	CIN3	CIN1	SENB	SUM1	SUM3	SUM5	SUM7	

68 PIN CERAMIC PIN GRID ARRAY (PGA)  
TOP VIEW

L		SUM25	ADDR0	ADDR1	CLK	COUT0	COUT1	COUT3	COUT5	COUT7	
K	SUM23	SUM24	SENBH	DCM0	DCM1	SHADD	COUT2	COUT4	COUT6	COENB	TCCO
J	SUM22	SUM21								V <sub>CC</sub>	ERASE
H	SUM30	SUM19								DIENB	RESET
G	SUM18	SUM17								DIN7	TCS
F	SUM16	SUM15								DIN6	DIN5
E	SUM14	V <sub>SS</sub>								DIN4	DIN3
D	SUM13	SUM12								DIN2	DIN1
C	SUM11	SUM10								CIENB	DIN0
B	SUM9	SUM8	SUM6	SUM4	SUM2	SUM0	CIN0	CIN2	CIN4	CIN6	TCCI
A		SUM7	SUM5	SUM3	SUM1	SENB	CIN1	CIN3	CIN5	CIN7	

68 PIN PLASTIC LEADED CHIP CARRIER (PLCC)  
TOP VIEW

## Pin Description

SYMBOL	PIN NUMBER	TYPE	NAME AND FUNCTION
VCC	61		+5V Power Supply Input
VSS	27		Power Supply Ground Input
CLK	19	I	The CLK input provides the DF system sample clock. The maximum clock frequency is 30MHz.
DINO-7	64-68 1-3	I	These eight inputs are the data sample input bus. Eight bit data samples are synchronously loaded through these pins to the X register of each filter cell simultaneously. The DIENB signal enables loading, which is synchronous on the rising edge of the clock signal.
TCS	4	I	The TCS input determines the number system interpretation of the data input samples on pins DINO-7 as follows: TCS = Low → Unsigned Arithmetic TCS = High → Two's Complement Arithmetic The TCS signal is synchronously loaded into the X register in the same way as the DINO-7 inputs.
DIENB	5	I	A low on this enables the data sample input bus (DINO-7) to all the filter cells. A rising edge of the CLK signal occurring while DIENB is low will load the X register of every filter cell with the 8 bit value present on DINO-7. A high on this input forces all the bits of the data sample input bus to zero; a rising CLK edge when DIENB is high will load the X register of every filter cell with all zeros. This signal is latched inside the DF, delaying its effect by one clock internal to the DF. Therefore, it must be low during the clock cycle immediately preceding presentation of the desired data on the DINO-7 inputs. Detailed operation is shown in later timing diagrams.
CINO-7	53-60	I	These eight inputs are used to input the 8 bit coefficients. The coefficients are synchronously loaded into the C register of filter Cell 0 if a rising edge of CLK occurs while CIENB is low. The CIENB signal is delayed by one clock as discussed below.
TCCI	62	I	The TCCI input determines the number system interpretation of the coefficient inputs on pins CINO-7 as follows: TCCI = LOW → Unsigned Arithmetic TCCI = HIGH → Two's Complement Arithmetic The TCCI signal is synchronously loaded into the C register in the same way as the CINO-7 inputs.
CIENB	63	I	A low on this input enable the C register of every filter cell and the D registers (decimation) of every filter cell according to the state of the DCM0-1 inputs. A rising edge of the CLK signal occurring while CIENB is low will load the C register and appropriate D registers with the coefficient data present at their inputs. This provides the mechanism for shifting the coefficients from cell to cell through the device. A high on this input freezes the contents of the C register and the D registers, ignoring the CLK signal. This signal is latched and delayed by one clock internal to the DF. Therefore, it must be low during the clock cycle immediately preceding presentation of the desired coefficient on the CINO-7 inputs. Detailed operation is shown in the Timing Diagrams section.
COUT0-7	10-17	O	These eight three-state outputs are used to output the 8 bit coefficients from filter cell 7. These outputs are enabled by the COENB signal low. These outputs may be tied to the CINO-7 inputs of the same DF to recirculate the coefficients, or they may be tied to the CINO-7 inputs of another DF to cascade DFs for longer filter lengths.
TCCO	9	O	The TCCO three-state output determines the number system representation of the coefficients output on COUT0-7. It tracks the TCCI signal to this same DF. It should be tied to the TCCI input of the next DF in a cascade of DFs for increased filter lengths. This signal is enabled by COENB low.

## Pin Descriptions

SYMBOL	PIN NUMBER	TYPE	NAME FUNCTION															
COENB	8	I	A low on the COENB input enables the COUT0-7 and the TCCO output. A high on this input places all these outputs in their high impedance state.															
DCM0-1	20-21	I	<p>These two inputs determine the use of the internal decimation registers as follows:</p> <table><tr><th>DCM1</th><th>DCM0</th><th>Decimation Function</th></tr><tr><td>0</td><td>0</td><td>Decimation registers not used</td></tr><tr><td>0</td><td>1</td><td>One decimation register is used</td></tr><tr><td>1</td><td>0</td><td>Two decimation registers are used</td></tr><tr><td>1</td><td>1</td><td>Three decimation registers are used</td></tr></table> <p>The coefficients pass from cell to cell at a rate determined by the number of decimation registers used. When no decimation registers are used, coefficients move from cell to cell on each clock. When one decimation register is used, coefficients move from cell to cell on every other clock, etc. These signals are latched and delayed by one clock internal to the DF.</p>	DCM1	DCM0	Decimation Function	0	0	Decimation registers not used	0	1	One decimation register is used	1	0	Two decimation registers are used	1	1	Three decimation registers are used
DCM1	DCM0	Decimation Function																
0	0	Decimation registers not used																
0	1	One decimation register is used																
1	0	Two decimation registers are used																
1	1	Three decimation registers are used																
SUM0-25	25, 26, 28-51	O	These 26 three-state outputs are used to output the results of the internal filter cell computations. Individual filter cell results or the result of the shift-and-add output stage can be output. If an individual filter cell result is to be output, the ADRO-1 signals select the filter cell result. The SHADD signal determines whether the selected filter cell result or the output stage adder result is output. The signals SENBH and SENBL enable the most significant and least significant bits of the SUM0-25 result, respectively. Both SENBH and SENBL may be enabled simultaneously if the system has a 26 bit or larger bus. However, individual enables are provided to facilitate use with a 16 bit bus.															
SENBH	24	I	A low on this input enables result bits SUM16-25. A high on this input places these bits in their high impedance state.															
SENL	52	I	A low on this input enables result bits SUM0-15. A high on this input places these bits on their high impedance state.															
ADRO-1	22, 23	I	These two inputs select the one cell whose accumulator will be read through the output bus (SUM0-25) or added to the output stage accumulator. They also determine which accumulator will be cleared when ERASE is low. For selection of which accumulator to read through the output bus (SUM0-25) or which to add of the output stage accumulator, these inputs are latched in the DF and delayed by one clock internal to the device. If the ADRO-1 lines remain at the same address for more than one clock, the output at SUM0-25 will not change to reflect any subsequent accumulator updates in the addressed cell. Only the result available during the first clock, when ADRO-1 selects the cell, will be output. This does not hinder normal operation since the ADRO-1 lines are changed sequentially. This feature facilitates the interface with slow memories where the output is required to be fixed for more than one clock.															
SHADD	18	I	The SHADD input controls the activation of the shift-and-add operation in the output stage. This signal is latched in the DF and delayed by one clock internal to the device. A detailed explanation is given in the DF Output Stage section.															
RESET	6	I	A low on this input synchronously clears all the internal registers, except the cell accumulators. It can be used with ERASE to also clear all the accumulators simultaneously. This signal is latched in the DF and delayed by one clock internal to the DF.															
ERASE	7	I	A low on this input synchronously clears the cell accumulator selected by the ADRO-1 signals. If RESET is also low simultaneously, all cell accumulators are cleared.															

3

1-D FILTERS



## Functional Description

The Digital Filter (DF) is composed of four filter cells cascaded together and an output stage for combining or selecting filter cell outputs (see Block Diagram). Each filter cell contains a multiplier-accumulator and several registers (Figure 1). Each 8 bit coefficient is multiplied by a 8 bit data sample, with the result added to the 26 bit accumulator contents. The coefficient output of each cell is cascaded to the coefficient input of the next cell to its right.

### DF Filter Cell

An 8 bit coefficient (CIN0-7, TCCI) enters each cell through the C register on the left and exits the cell on the right as signals COUT0-7 and TCCO. With no decimation, the coefficient moves directly from the C register to the output, and is valid on the clock following its entrance. When decimation is selected the coefficient exit is delayed by 1, 2 or 3 clocks by passing through one or more decimation registers (D1, D2 or D3).

The combination of D registers through which the coefficient passes is determined by the state of DCM0 and DCM1. The output signals (COUT0-7, TCCO) are connected to the CIN0-7 and TCCI of the next cell to its right. The COENB input signal enables the COUT0-7 and TCCO outputs of the right-most cell to the COUT0-7 and TCCO pins of the DF.

The C and D registers are enabled for loading by CIENB. Loading is synchronous with CLK when CIENB is low. Note that CIENB is latched internally. It enables the register for loading after the next CLK following the onset of CIENB low. Actual loading occurs on the second CLK following the onset of CIENB low. Therefore, CIENB must be low during the clock cycle immediately preceding presentation of the coefficient on the CIN0-7 inputs. In most basic FIR operations, CIENB will be low throughout the process, so this latching and delay sequence is only important during the initialization phase. When CIENB is high, the coefficients are frozen.

These registers are cleared synchronously under control of RESET, which is latched and delayed exactly like CIENB.

The output of the C register is one input of the multiplier.

The other input of the multiplier comes from the output of the X register. This register is loaded with a data sample from the DF input signals. DINO-7 and TCS discussed above. The X register is enabled for loading by DIENB. Loading is synchronous with CLK when DIENB is low. Note that DIENB is latched internally. It enables the register for loading after the next CLK following the onset of DIENB low. Therefore, DIENB must be low during the clock cycle immediately preceding presentation of the sample on the DINO-7 inputs. In most basic FIR operations, DIENB will be low throughout the process, so this latching and delay sequence is only important during the initialization phase. When DIENB is high, the X register is loaded with all zeros.

The multiplier is pipelined and is modeled as a multiplier core followed by two pipeline registers, MREG0 and MREG1. The multiplier output is sign extended and input as one operand of the 26 bit adder. The other adder operand is the output of the 26 bit accumulator. The adder output

is loaded synchronously into both the accumulator and the TREG.

The TREG loading is disabled by the cell select signal, Celln, where n is the cell number. The cell select is decoded from the ADRO-1 signals to generate the TREG load enable. The cell select is inverted and applied as the load enable to the TREG. Operation is such that the TREG is loaded whenever the cell is not selected. Therefore, TREG is loaded every other clock except the clock following cell selection. The purpose of the TREG is to hold the result of a sum-of-products calculation during the clock when the accumulator is cleared to prepare for the next sum-of-products calculation. This allows continuous accumulation without wasting clocks.

The accumulator is loaded with the adder output every clock unless it is cleared. It is cleared synchronously in two ways. When RESET and ERASE are both low, the accumulator is cleared along with all other registers in the DF. Since both ERASE and RESET are latched and delayed one clock internally, clearing occurs on the second CLK following the onset of both ERASE and RESET low.

The second accumulator clearing mechanism clears a single accumulator in a selected cell. The cell select signal, Celln, decoded from ADRO-1 and ERASE signal, Celln enable clearing of the accumulator on the next CLK.

The ERASE and RESET signals clear the DF internal registers and states as follows:

ERASE	RESET	CLEARING EFFECT
1	1	No clearing occurs, internal state remains same.
1	0	RESET only active, all registers except accumulators are cleared, including the internal pipeline registers.
0	1	ERASE only active, the accumulator whose address is given by the ADRO-1 inputs is cleared.
0	0	Both RESET and ERASE active, all accumulators as well as all other registers are cleared.

### The DF Output Stage

The output stage consists of a 26 bit adder, 26 bit register, feedback multiplexer from the register to the adder, an output multiplexer and a 26 bit three-state driver stage (Figure 2).

The 26 bit output adder can add any filter cell accumulator result to the 18 most significant bits of the output buffer. This operation takes place in one clock period. The eight LSBs are lost. The filter cell accumulator is selected by the ADRO-1 inputs.

The 18 MSBs of the output buffer actually pass through the zero mux on their way to the output adder input. The zero mux is controlled by the SHADD input signal and selects either the 18 MSBs of the output buffer or all zeros for the adder input. A low on the SHADD input selects zero. A high on the SHADD input selects the output buffer MSBs, thus activating the shift-and-add operation. SHADD signal is latched and delayed by one clock internally.

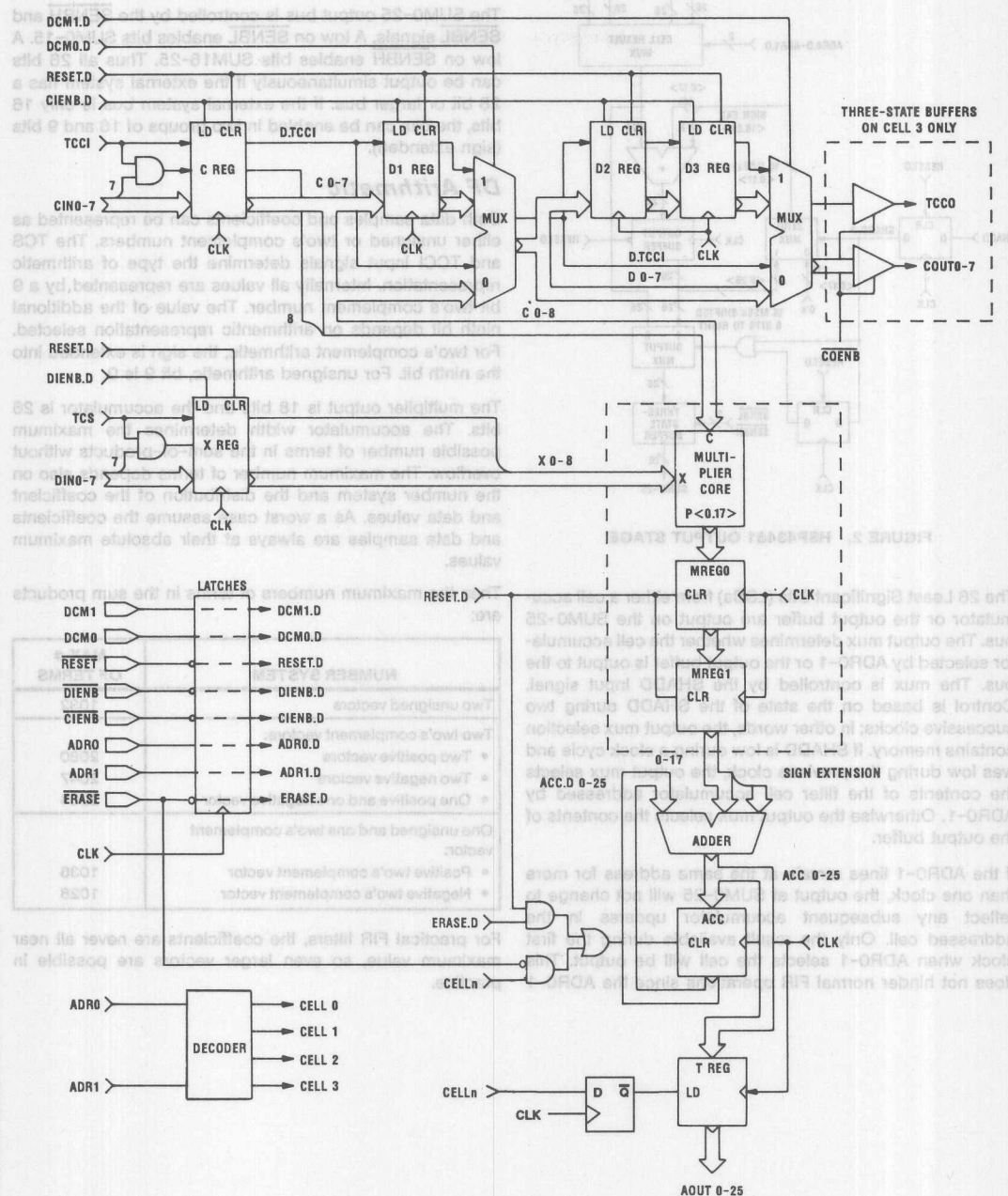


FIGURE 1. HSP43481 FILTER CELL



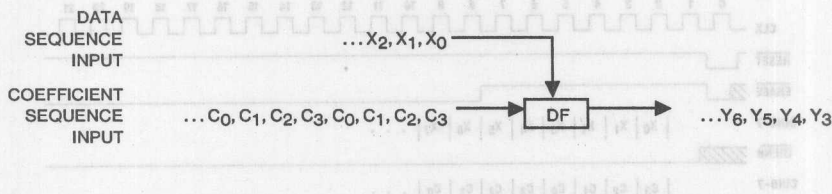
### Basic FIR Operation

A simple 30MHz 4 tap filter example serves to illustrate more clearly the operation of the DF. Table 1 shows the results of the multiply accumulate in each cell after each clock. The coefficient sequence,  $C_n$ , enters the DF on the left and moves from left to right through the cells. The data sample sequence,  $X_n$ , enters the DF from the top, with each cell receiving the same sample simultaneously. Each cell

accumulates the sum-of-products for one output point. Four sums-of-products are calculated simultaneously, but staggered in time so that a new output is available every system clock.

Detailed operation of the DF to perform a basic 4 tap, 8 bit coefficient, 8 bit data, 30MHz FIR filter is best understood by observing the schematic (Figure 3) and timing diagram

TABLE 1. 25MHz, 4 TAP FIR FILTER SEQUENCE



CLK	CELL 0	CELL 1	CELL 2	CELL 3	SUM/CLR
0	$C_3 \times X_0$	0	0	0	-
1	$+C_2 \times X_1$	$C_3 \times X_1$	0	0	-
2	$+C_1 \times X_2$	$+C_2 \times X_2$	$C_3 \times X_2$	0	-
3	$+C_0 \times X_3$	$+C_1 \times X_3$	$+C_2 \times X_3$	$C_3 \times X_3$	Cell 0 ( $Y_3$ )
4	$C_3 \times X_4$	$+C_0 \times X_4$	$+C_1 \times X_4$	$+C_2 \times X_4$	Cell 1 ( $Y_4$ )
5	$+C_2 \times X_5$	$C_3 \times X_5$	$+C_0 \times X_5$	$+C_1 \times X_5$	Cell 2 ( $Y_5$ )
6	$+C_1 \times X_6$	$+C_2 \times X_6$	$C_3 \times X_6$	$+C_0 \times X_6$	Cell 3 ( $Y_6$ )
7	$+C_0 \times X_7$	$+C_1 \times X_7$	$+C_2 \times X_7$	$C_3 \times X_7$	Cell 0 ( $Y_7$ )

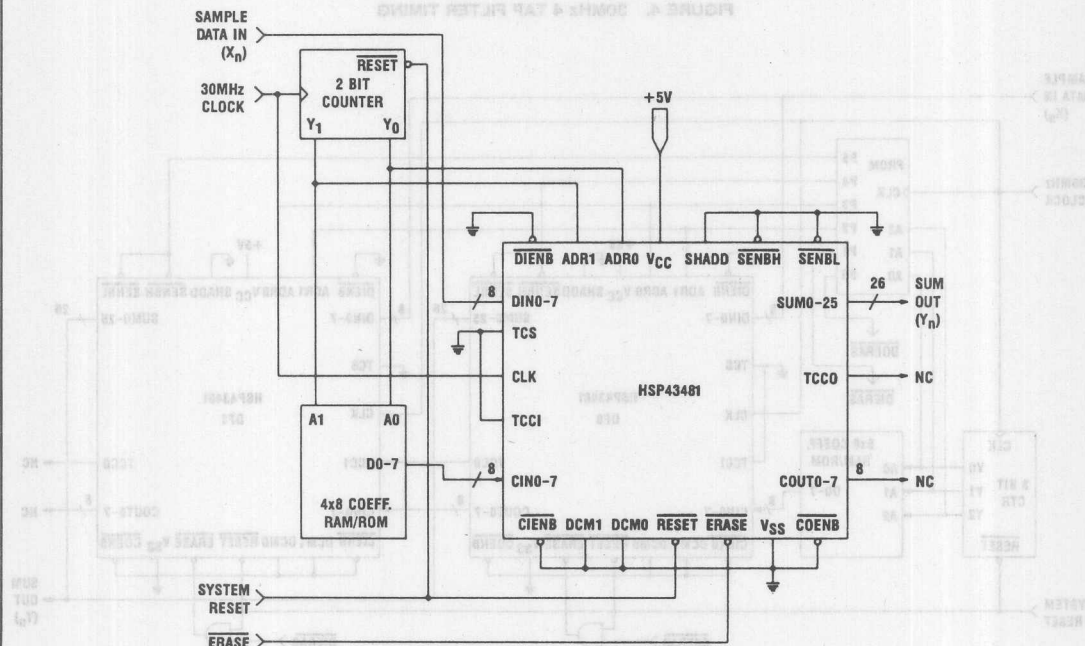


FIGURE 3. 30MHz, 4 TAP FIR FILTER APPLICATION SCHEMATIC



## HSP43481

(Figure 4). The internal pipeline length of the DF is four (4) clock cycles, corresponding to the register levels CREG (or XREG), MREG0, MREG1, and TREG (Figures 1 and 2). Therefore, the delay from presentation of data and coefficients at the DIN0-7 and CIN0-7 inputs to a sum appearing at the SUM0-25 output is:

$k + T_d$  where

$k$  = filter length

$T_d = 4$ , the internal pipeline delay of DF

After the pipeline has filled, a new output sample is available every clock. The delay to last sample output from last sample input is  $T_d$ .

The output sums,  $Y(n)$ , shown in the timing diagram are derived from the sum-of-products equation:

$$Y(n) = C(0) \times X(n) + C(1) \times X(n-1) + C(2) \times X(n-2) + C(3) \times X(n-3)$$

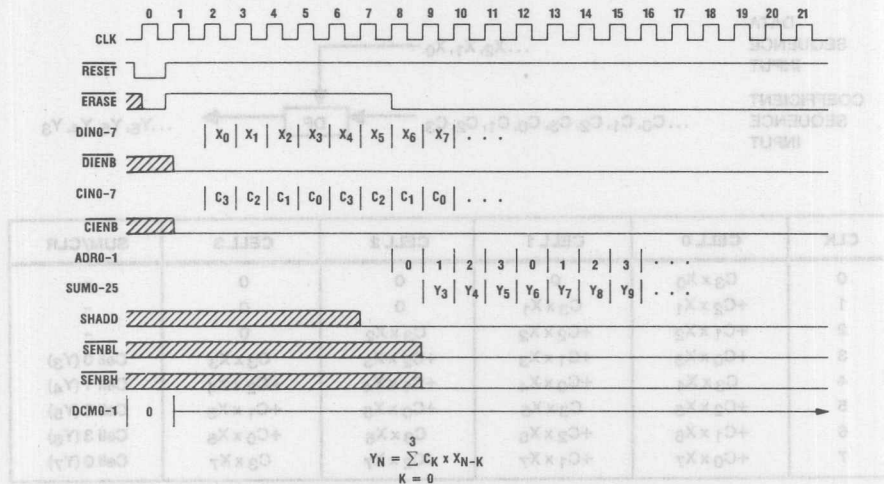


FIGURE 4. 30MHz 4 TAP FILTER TIMING

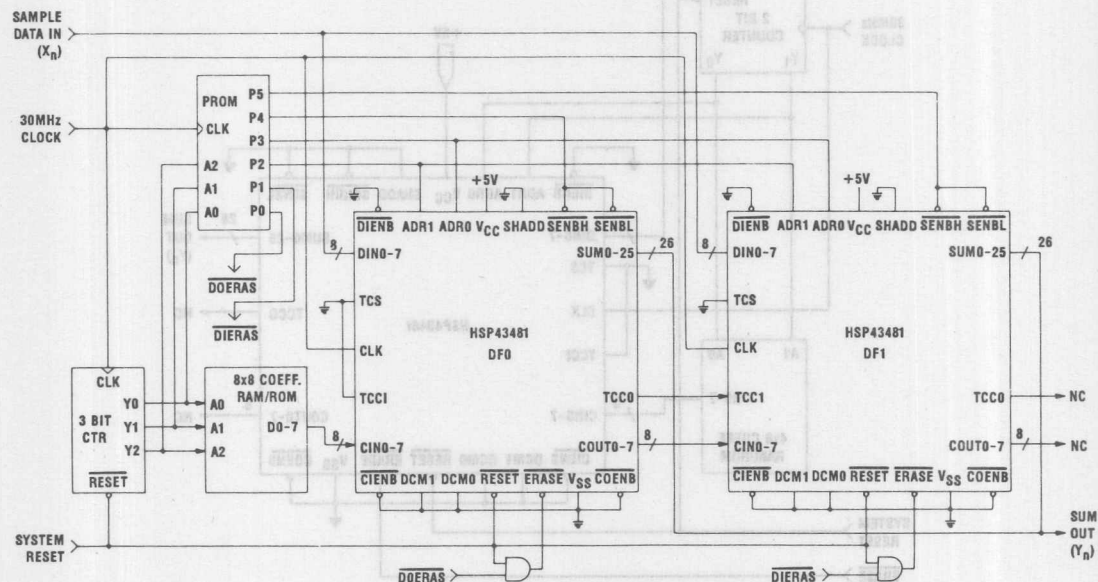


FIGURE 5. 30MHz 8 TAP FILTER USING TWO CASCADED HSP43481s

### Extended FIR Filter Length

Filter lengths greater than four taps can be created by either cascading together multiple DFs or "reusing" a single DF. Using multiple devices, an FIR filter of over 1024 taps can be constructed to operate at a 30MHz sample rate. Using a single DF clocked at 30MHz, an FIR filter of over 1024 taps can be constructed to operate at less than a 30MHz sample rate. Combinations of these two techniques are also possible.

### Cascade Configuration

To design a filter length  $L > 4$ ,  $L/4$  DFs are cascaded by connecting the COUT0-7 outputs of the (i)th DF to the CIN0-7 inputs of the (i + 1)th DF. The DIN0-7 inputs and SUM0-25 outputs of all the DFs are also tied together. A specific example of two cascaded DFs illustrates the technique (Figure 5). Timing (Figure 6) is similar to the simple 4 tap FIR, except the  $\overline{\text{ERASE}}$  and  $\overline{\text{SENBL}}/\overline{\text{SENBH}}$  signals must be enabled independently of the two DFs in order to clear the correct accumulators and enable the SUM0-25 output signals at the proper times.

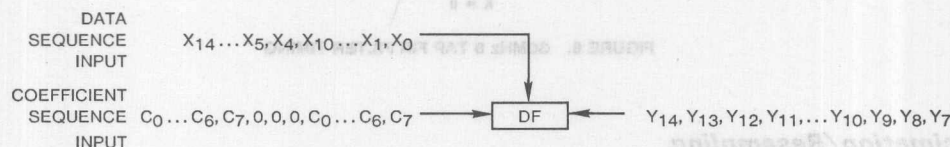
### Single DF Configuration

Using a DF, a filter of length  $L > 4$  can be constructed by processing in  $L/4$  passes as illustrated in Table 2 for an 8 tap FIR. Each pass is composed of  $T_p = 7 + L$  cycles and computes four output samples. In pass i, the samples with indices  $i \times 4$  to  $i \times 4 + (L+2)$  enter the DIN0-7 inputs. The coefficients  $C_0 - C_{L-1}$  enter the CIN0-7 inputs, followed by three zeros. As these zeros are entered, the result samples are output and the accumulators reset. Initial filling of the pipeline is not shown in this sequence table. Filter outputs can be put through a FIFO to even out the sample rate.

### Extended Coefficient And Data Sample Word Size

The sample and coefficient word size can be extended by utilizing several DFs in parallel to get the maximum sample rate or a single DF with resulting lower sample rates. The technique is to compute partial products of  $8 \times 8$  and combine these partial products by shifting and adding to obtain the final result. The shifting and adding can be accomplished with external adders (for full speed) or with the DFs shift-and-add mechanism contained in its output stage (at reduced speed).

TABLE 2. 8 TAP FIR FILTER SEQUENCE USING SINGLE DF



CLK	CELL 0	CELL 1	CELL 2	CELL 3	SUM/CLR
0	$C_7 \times X_0$	0	0	0	-
1	$+C_6 \times X_1$	$C_7 \times X_1$	0	0	-
2	$+C_5 \times X_2$	$+C_6 \times X_2$	$C_7 \times X_2$	0	-
3	$+C_4 \times X_3$	$+C_5 \times X_3$	$+C_6 \times X_3$	$C_7 \times X_3$	-
4	$+C_3 \times X_4$	$+C_4 \times X_4$	$+C_5 \times X_4$	$+C_6 \times X_4$	-
5	$+C_2 \times X_5$	$+C_3 \times X_5$	$+C_4 \times X_5$	$+C_5 \times X_5$	-
6	$+C_1 \times X_6$	$+C_2 \times X_6$	$+C_3 \times X_6$	$+C_4 \times X_6$	-
7	$+C_0 \times X_7$	$+C_1 \times X_7$	$+C_2 \times X_7$	$+C_3 \times X_7$	Cell 0 (Y7)
8	0	$+C_0 \times X_8$	$+C_1 \times X_8$	$+C_2 \times X_8$	Cell 1 (Y8)
9	0	0	$+C_0 \times X_9$	$+C_1 \times X_9$	Cell 2 (Y9)
10	0	0	0	$+C_0 \times X_{10}$	Cell 3 (Y10)
11	$C_7 \times X_4$	0	0	0	-
12	$+C_6 \times X_5$	$C_7 \times X_5$	0	0	-
13	$+C_5 \times X_6$	$+C_6 \times X_6$	$C_7 \times X_6$	0	-
14	$+C_4 \times X_7$	$+C_5 \times X_7$	$+C_6 \times X_7$	$C_7 \times X_7$	-
15	$+C_3 \times X_8$	$+C_4 \times X_8$	$+C_5 \times X_8$	$+C_6 \times X_8$	-
16	$+C_2 \times X_9$	$+C_3 \times X_9$	$+C_4 \times X_9$	$+C_5 \times X_9$	-
17	$+C_1 \times X_{10}$	$+C_2 \times X_{10}$	$+C_3 \times X_{10}$	$+C_4 \times X_{10}$	-
18	$+C_0 \times X_{11}$	$+C_1 \times X_{11}$	$+C_2 \times X_{11}$	$+C_3 \times X_{11}$	Cell 0 (Y11)
19	0	$+C_0 \times X_{12}$	$+C_1 \times X_{12}$	$+C_2 \times X_{12}$	Cell 1 (Y12)
20	0	0	$+C_0 \times X_{13}$	$+C_1 \times X_{13}$	Cell 2 (Y13)
21	0	0	0	$+C_0 \times X_{14}$	Cell 3 (Y14)



The HSP43481 provides a mechanism for decimating by factors of 2, 3 or 4. From the DF filter cell block diagram (Figure 1), note the three D registers and two multiplexers in the coefficient pass through the cell. These allow the coefficients to be delayed by 1, 2 or 3 clocks through the cell. The

Detailed timing for a 30MHz input sample rate, 15MHz output sample rate (i.e., decimate-by-two), 8 tap FIR filter, including pipelining, is shown in Figure 7.

TABLE 3. 8 TAP DECIMATE-BY-TWO FIR FILTER SEQUENCE, 30MHz IN, 15MHz OUT

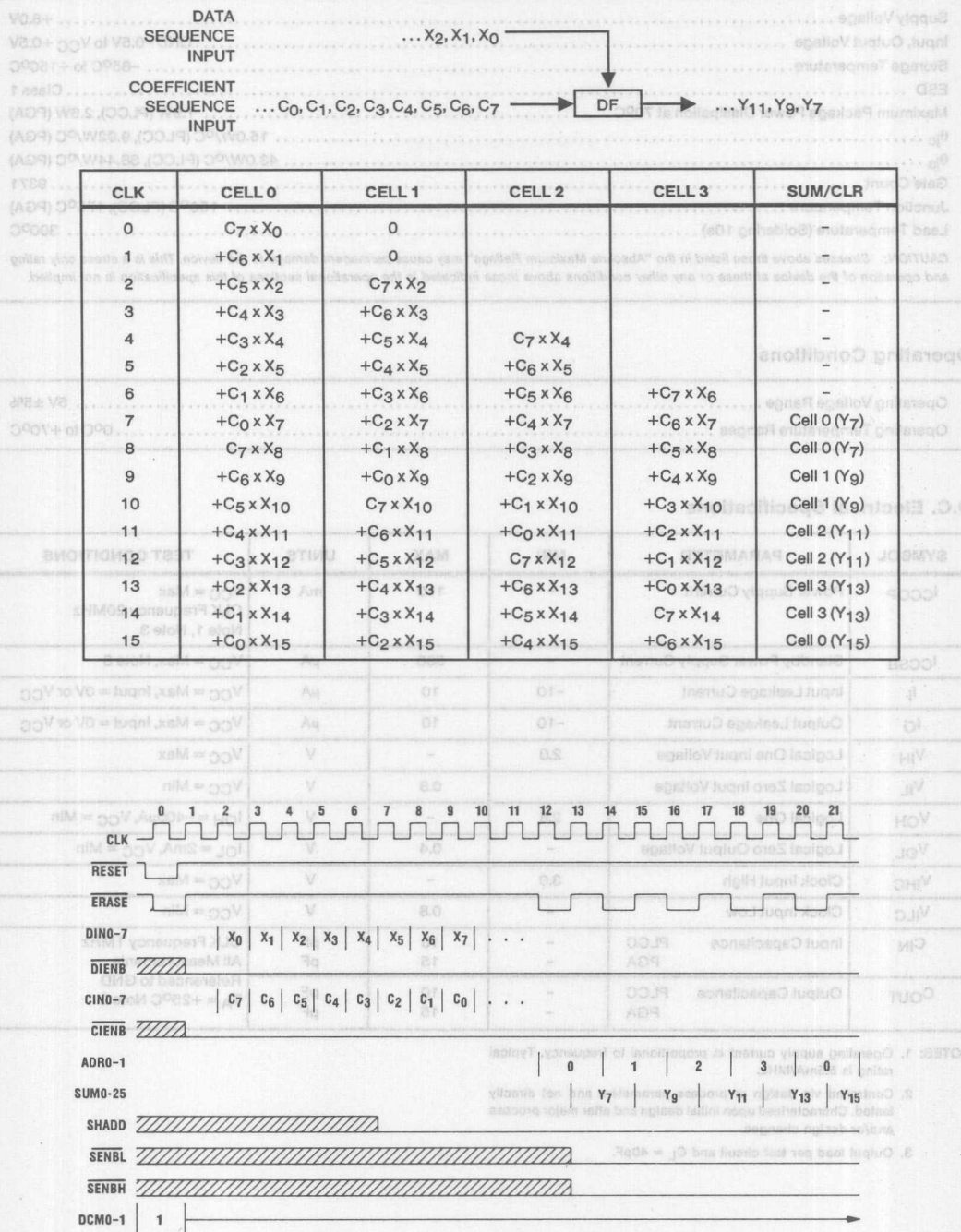


FIGURE 7. 8 TAP DECIMATE-BY-TWO FIR FILTER TIMING, 30MHz IN, 15MHz OUT



## Specifications HSP43481

### Absolute Maximum Ratings

Supply Voltage	+8.0V
Input, Output Voltage	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature	-65°C to +150°C
ESD	Class 1
Maximum Package Power Dissipation at 70°C	1.9W (PLCC), 2.6W (PGA)
$\theta_{jc}$	15.0W/°C (PLCC), 9.92W/°C (PGA)
$\theta_{ja}$	43.0W/°C (PLCC), 38.44W/°C (PGA)
Gate Count	9371
Junction Temperature	150°C (PLCC), 175°C (PGA)
Lead Temperature (Soldering 10s)	300°C

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### Operating Conditions

Operating Voltage Range	5V $\pm$ 5%
Operating Temperature Ranges	0°C to +70°C

### D.C. Electrical Specifications

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
$I_{CCOP}$	Power Supply Current	-	110	mA	$V_{CC}$ = Max CLK Frequency 20MHz Note 1, Note 3
$I_{CCSB}$	Standby Power Supply Current	-	500	$\mu A$	$V_{CC}$ = Max, Note 3
$I_I$	Input Leakage Current	-10	10	$\mu A$	$V_{CC}$ = Max, Input = 0V or $V_{CC}$
$I_O$	Output Leakage Current	-10	10	$\mu A$	$V_{CC}$ = Max, Input = 0V or $V_{CC}$
$V_{IH}$	Logical One Input Voltage	2.0	-	V	$V_{CC}$ = Max
$V_{IL}$	Logical Zero Input Voltage	-	0.8	V	$V_{CC}$ = Min
$V_{OH}$	Logical One	2.6	-	V	$I_{OH}$ = -400 $\mu A$ , $V_{CC}$ = Min
$V_{OL}$	Logical Zero Output Voltage	-	0.4	V	$I_{OL}$ = 2mA, $V_{CC}$ = Min
$V_{IHC}$	Clock Input High	3.0	-	V	$V_{CC}$ = Max
$V_{ILC}$	Clock Input Low	-	0.8	V	$V_{CC}$ = Min
$C_{IN}$	Input Capacitance				
	PLCC	-	10	pF	CLK Frequency 1MHz
	PGA	-	15	pF	All Measurements
$C_{OUT}$	Output Capacitance				
	PLCC	-	10	pF	Referenced to GND
	PGA	-	15	pF	$T_A$ = +25°C Note 2

NOTES: 1. Operating supply current is proportional to frequency. Typical rating is 5.5mA/MHz.

2. Controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.

3. Output load per test circuit and  $C_L$  = 40pF.

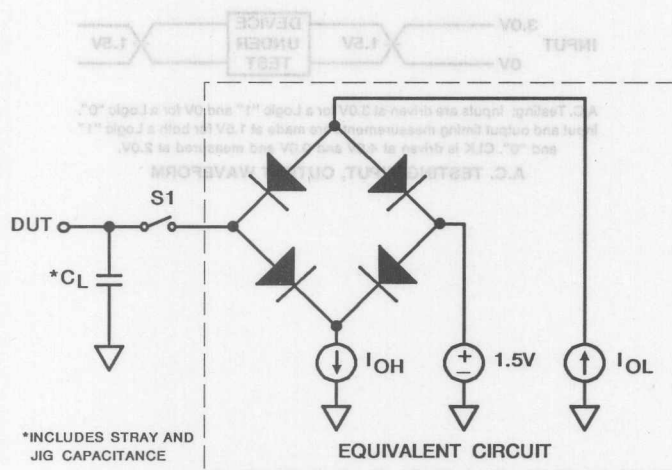
## Specifications HSP43481

**A.C. Electrical Specifications**  $V_{CC} = +4.75V$  to  $+5.25V$ ,  $T_A = 0^{\circ}C$  to  $+70^{\circ}C$

SYMBOL	PARAMETER	-20 (20MHz)		-25 (25.6MHz)		-30 (30MHz)		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX	MIN	MAX		
$T_{CP}$	Clock Period	50	-	39	-	33	-	ns	
$T_{CL}$	Clock Low	20	-	16	-	13	-	ns	
$T_{CH}$	Clock High	20	-	16	-	13	-	ns	
$T_{IS}$	Input Setup	16	-	14	-	13	-	ns	
$T_{IH}$	Input Hold	0	-	0	-	0	-	ns	
$T_{ODC}$	CLK to Coefficient Output Delay	-	26	-	22	-	19	ns	
$T_{OED}$	Output Enable Delay	-	20	-	15	-	15	ns	
$T_{ODD}$	Output Disable Delay	-	20	-	15	-	15	ns	Note 1
$T_{ODS}$	CLK to SUM Output Delay	-	30	-	26	-	21	ns	
$T_{OR}$	Output Rise	-	6	-	6	-	6	ns	Note 1
$T_{OF}$	Output Fall	-	6	-	6	-	6	ns	Note 1

NOTE: 1. Controlled by design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.

### Test Load Circuit

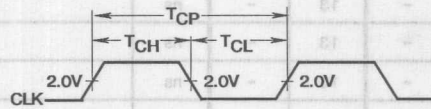


Switch S1 Open for  $I_{CCSB}$  and  $I_{CCOP}$  Tests

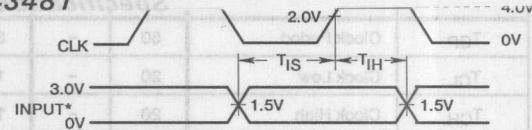
3

1-D FILTERS

# HSP43481

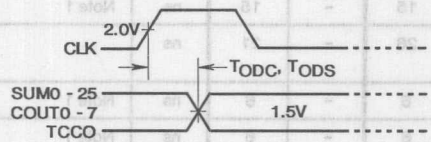


CLOCK AC PARAMETERS

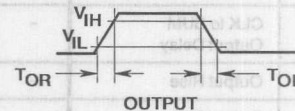


\* Input includes: DIN0-7, CIN0-7, DIENB, CIENB, ERASE, RESET, DCM0-1, ADRO-1, TCS, TCCI, SHADD

INPUT SETUP AND HOLD

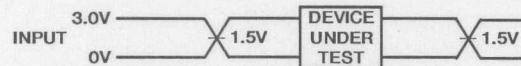


SUM0-25, COUT0-7, TCCO OUTPUT DELAYS



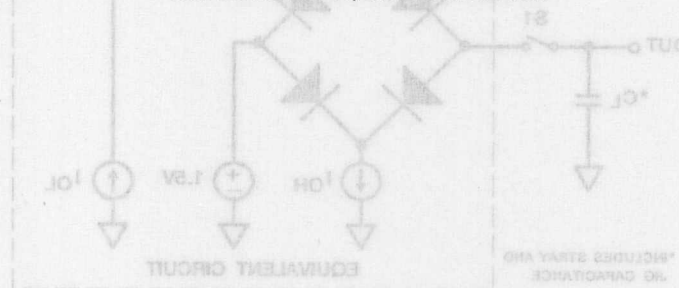
RISE AND FALL TIMES

NOTE: 1. Controlled by internal logic and not directly tested. Characterized upon initial design and after major process and/or design changes.



A.C. Testing: Inputs are driven at 3.0V for a Logic "1" and 0V for a Logic "0". Input and output timing measurements are made at 1.5V for both a Logic "1" and "0". CLK is driven at 4.0V and 0.0V and measured at 2.0V.

## A.C. TESTING INPUT, OUTPUT WAVEFORM



Switch S1 Open for TCCO and TCCO Tests

# **HARRIS** **HSP43481/883**

August 1992

**Digital Filter**

## **Features**

- This Circuit is Processed in accordance to Mil-Std-883C and is Fully Conformant Under the Provisions of Paragraph 1.2.1
- 0 to 25.6MHz Sample Rate
- Four Filter Cells
- 8 Bit Coefficients and Signal Data
- Low Power CMOS Operation
  - ICCSB = 500 $\mu$ A Maximum
  - ICCOP = 110 $\mu$ A Maximum @ 20MHz
- 26 Bit Accumulator Per Stage
- Filter Lengths Up To 1032 Taps
- Shift-And-Add Output Stage for Combining Filter Outputs
- Expandable Coefficient Size, Data Size and Filter Length
- Decimation by 2, 3 or 4

## **Applications**

- 1-D and 2-D FIR Filters
- Radar/Sonar
- Digital Video and Audio
- Adaptive Filters
- Echo Cancellation
- Correlation/Convolution
- Complex Multiply-Add
- Butterfly Computation
- Matrix Multiplication
- Sample Rate Converters

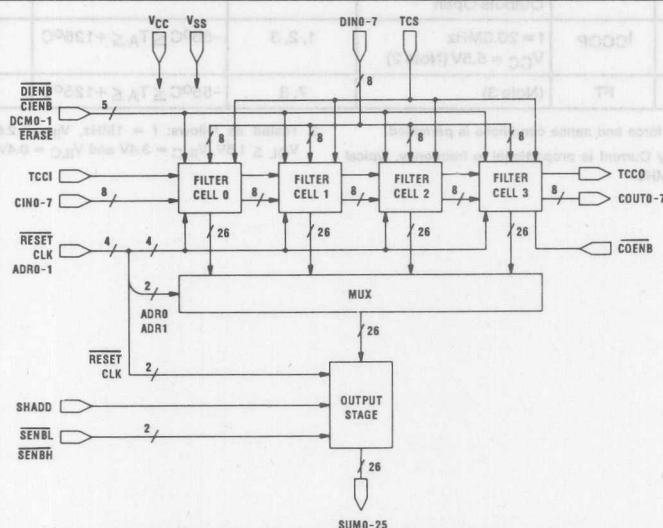
## **Description**

The HSP43481/883 is a video-speed Digital Filter (DF) designed to efficiently implement vector operations such as FIR digital filters. It is comprised of four filter cells cascaded internally and a shift-and-add output stage, all in a single integrated circuit. Each filter cell contains an 8x8 multiplier, three decimation registers and a 26 bit accumulator which can add the contents of any filter cell accumulator to the output stage accumulator shifted right by eight bits. The HSP43481/883 has a maximum sample rate of 25.6MHz. The effective multiply-accumulate (MAC) rate is 102MHz.

The HSP43481/883 can be configured to process expanded coefficient and word sizes. Multiple devices can be cascaded for larger filter lengths without degrading the sample rate or a single device can process larger filter lengths at less than 25.6MHz with multiple passes. The architecture permits processing filter lengths of over 1000 taps with the guarantee of no overflows. In practice, most filter coefficients are less than 1.0, making even larger filter lengths possible. The HSP43481/883 provides for unsigned or two's complement arithmetic, independently selectable for coefficients and signal data.

Each DF filter cell contains three resampling or decimation registers which permit output sample rate reduction at rates of 1/2, 1/3 or 1/4 the input sample rate. These registers also provide the capability to perform 2-D operations such as NxN spatial correlations/convolutions for image processing applications.

## **Block Diagram**



CAUTION: These devices are sensitive to electrostatic discharge. Users should follow proper IC Handling Procedures.  
Copyright © Harris Corporation 1992

File Number **2450.2**



# Specifications HSP43481/883

## Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input, Output Voltage Applied .....	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range .....	-65°C to +150°C
Junction Temperature .....	+175°C
Lead Temperature (Soldering, Ten Seconds) .....	+300°C
ESD Classification .....	Class 1

## Reliability Information

Thermal Resistance	$\theta_{ja}$	$\theta_{jc}$
Ceramic PGA Package .....	38.44°C/W	9.92°C/W
Maximum Package Power Dissipation at +125°C		
Ceramic PGA Package .....	1.30 Watt	
Gate Count .....	9370 Gates	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range .....	+4.5V to +5.5V
Operating Temperature Range .....	-55°C to +125°C

TABLE 1. HSP43481/883 D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Devices Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +2.0mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output Leakage Current	$I_O$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Clock Input High	$V_{IHC}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	3.0	-	V
Clock Input Low	$V_{ILC}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ , Outputs Open	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 20.0MHz$ $V_{CC} = 5.5V$ (Note 2)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	110.0	mA
Functional Test	FT	(Note 3)	7, 8	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	-	

NOTES: 1. Interchanging of force and sense conditions is permitted.

2. Operating Supply Current is proportional to frequency, typical rating is 5.5mA/MHz.

3. Tested as follows:  $f = 1MHz$ ,  $V_{IH} = 2.6$ ,  $V_{IL} = 0.4$ ,  $V_{OH} \geq 1.5V$ ,  $V_{OL} \leq 1.5V$ ,  $V_{IHC} = 3.4V$  and  $V_{ILC} = 0.4V$ .

# Specifications HSP43481/883

TABLE 2. HSP43481/883 A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	-20 (20MHz)		-25 (25.6MHz)		UNITS
					MIN	MAX	MIN	MAX	
Clock Period	T <sub>CP</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	50	-	39	-	ns
Clock Low	T <sub>CL</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	16	-	ns
Clock High	T <sub>CH</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	16	-	ns
Input Setup	T <sub>IS</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	17	-	ns
Input Hold	T <sub>IH</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
CLK to Coefficient Output Delay	T <sub>ODC</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	24	-	20	ns
Output Enable Delay	T <sub>OED</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	20	-	15	ns
CLK to SUM Output Delay	T <sub>ODS</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	31	-	25	ns

NOTE: 1. A.C. Testing: V<sub>CC</sub> = 4.5V and 5.5V. Inputs are driven at 3.0V for a Logic "1" and 0.0V for a Logic "0". Input and output timing measurements are made at 1.5V for both a Logic "1" and "0". CLK is driven at 4.0V and 0V and measured at 2.0V.

TABLE 3. HSP43481/883 A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETER	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	-20 (20MHz)		-25 (25.6MHz)		UNITS
					MIN	MAX	MIN	MAX	
Input Capacitance	C <sub>IN</sub>	V <sub>CC</sub> =Open, f=1MHz All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	15	-	15	pF
Output Capacitance	C <sub>OUT</sub>		1	T <sub>A</sub> = +25°C	-	15	-	15	pF
Output Disable Delay	T <sub>ODD</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	20	-	15	ns
Output Rise Time	T <sub>OR</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	7	-	6	ns
Output Fall Time	T <sub>OF</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	7	-	6	ns

NOTES: 1. The parameters listed in Table 3 are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design and after major process and/or design changes.

2. Loading is as specified in the test load circuit, C<sub>L</sub> = 40pF.

TABLE 4. APPLICABLE SUBGROUPS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9

3

1-D FILTERS

# Burn-In Circuit

L		COUT7	COUT5	COUT3	COUT1	COUT0	CLK	ADDR1	ADDR0	SUM25		
K	TCCO	COENB	COUT6	COUT4	COUT2	SHADD	DCM1	DCM0	SENBH	SUM24	SUM23	
J	ERASE	V <sub>CC</sub>								SUM21	SUM22	
H	RESET	DIENB								SUM19	SUM20	
G	TCS	DIN7								SUM17	SUM18	
F	DIN5	DIN6								SUM15	SUM16	
E	DIN3	DIN4								V <sub>SS</sub>	SUM14	
D	DIN1	DIN2								SUM12	SUM13	
C	DINO	CIENB								SUM10	SUM11	
B	TCCI	CIN6	CIN4	CIN2	CIN0	SUM0	SUM2	SUM4	SUM6	SUM8	SUM9	
A		CIN7	CIN5	CIN3	CIN1	SENB	SUM1	SUM3	SUM5	SUM7		

68 LEAD  
PIN GRID ARRAY  
BOTTOM VIEW

PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
K1	TCCO	V <sub>CC</sub> /2	C2	CIENB	F10	B6	SUM0	V <sub>CC</sub> /2	H10	SUM19	V <sub>CC</sub> /2
J1	ERASE	F10	B2	CIN6	F6	A6	SENB	F10	G10	SUM17	V <sub>CC</sub> /2
H1	RESET	F11	A2	CIN7	F7	L7	CLK	F0	F10	SUM15	V <sub>CC</sub> /2
G1	TCS	F7	L3	COUT5	V <sub>CC</sub> /2	K7	DCM1	F6	E10	V <sub>SS</sub>	GND
F1	DIN5	F5	K3	COUT6	V <sub>CC</sub> /2	B7	SUM2	V <sub>CC</sub> /2	D10	SUM12	V <sub>CC</sub> /2
E1	DIN3	F3	B3	CIN4	F4	A7	SUM1	V <sub>CC</sub> /2	C10	SUM10	V <sub>CC</sub> /2
D1	DIN1	F1	A3	CIN5	F5	L8	ADDR1	F1	B10	SUM8	V <sub>CC</sub> /2
C1	DINO	F0	L4	COUT3	V <sub>CC</sub> /2	K8	DCM0	F5	A10	SUM7	V <sub>CC</sub> /2
B1	TCCI	F8	K4	COUT4	V <sub>CC</sub> /2	B8	SUM4	V <sub>CC</sub> /2	K11	SUM23	V <sub>CC</sub> /2
L2	COUT7	V <sub>CC</sub> /2	B4	CIN2	F2	A8	SUM3	V <sub>CC</sub> /2	J11	SUM22	V <sub>CC</sub> /2
K2	COENB	F10	A4	CIN3	F3	L9	ADDR0	F0	H11	SUM20	V <sub>CC</sub> /2
J2	V <sub>CC</sub>	V <sub>CC</sub>	L5	COUT1	V <sub>CC</sub> /2	K9	SENBH	F10	G11	SUM18	V <sub>CC</sub> /2
H2	DIENB	F10	K5	COUT2	V <sub>CC</sub> /2	B9	SUM6	V <sub>CC</sub> /2	F11	SUM16	V <sub>CC</sub> /2
G2	DIN7	F8	B5	CIN0	F0	A9	SUM5	V <sub>CC</sub> /2	E11	SUM14	V <sub>CC</sub> /2
F2	DIN6	F6	A5	CIN1	F1	L10	SUM25	V <sub>CC</sub> /2	D11	SUM13	V <sub>CC</sub> /2
E2	DIN4	F4	L6	COUT0	V <sub>CC</sub> /2	K10	SUM24	V <sub>CC</sub> /2	C11	SUM11	V <sub>CC</sub> /2
D2	DIN2	F2	K6	SHADD	F9	J10	SUM21	V <sub>CC</sub> /2	B11	SUM9	V <sub>CC</sub> /2

NOTES: 1. V<sub>CC</sub>/2 (2.7V ±10%) used for outputs only.

2. 47KΩ (±20%) resistor connected to all pins except V<sub>CC</sub> and GND.

3. V<sub>CC</sub> = 5.5 ±0.5V.

4. 0.1μF (min) capacitor between V<sub>CC</sub> and GND per position.

5. F0 = 100KHz ±10%, F1 = F0/2, F2 = F1/2 . . . . . , F11 = F10/2, 40% - 60% Duty Cycle.

6. Input voltage limits: V<sub>IL</sub> = 0.8V max., V<sub>IH</sub> = 4.5V ±10%.

**Metallization Topology****DIE DIMENSIONS:**

253 x 230 x 19 ±1 mils

**METALLIZATION:**

Type: Si - Al or Si - Al - Cu

Thickness: 8kÅ

**GLASSIVATION:**

Type: Nitrox

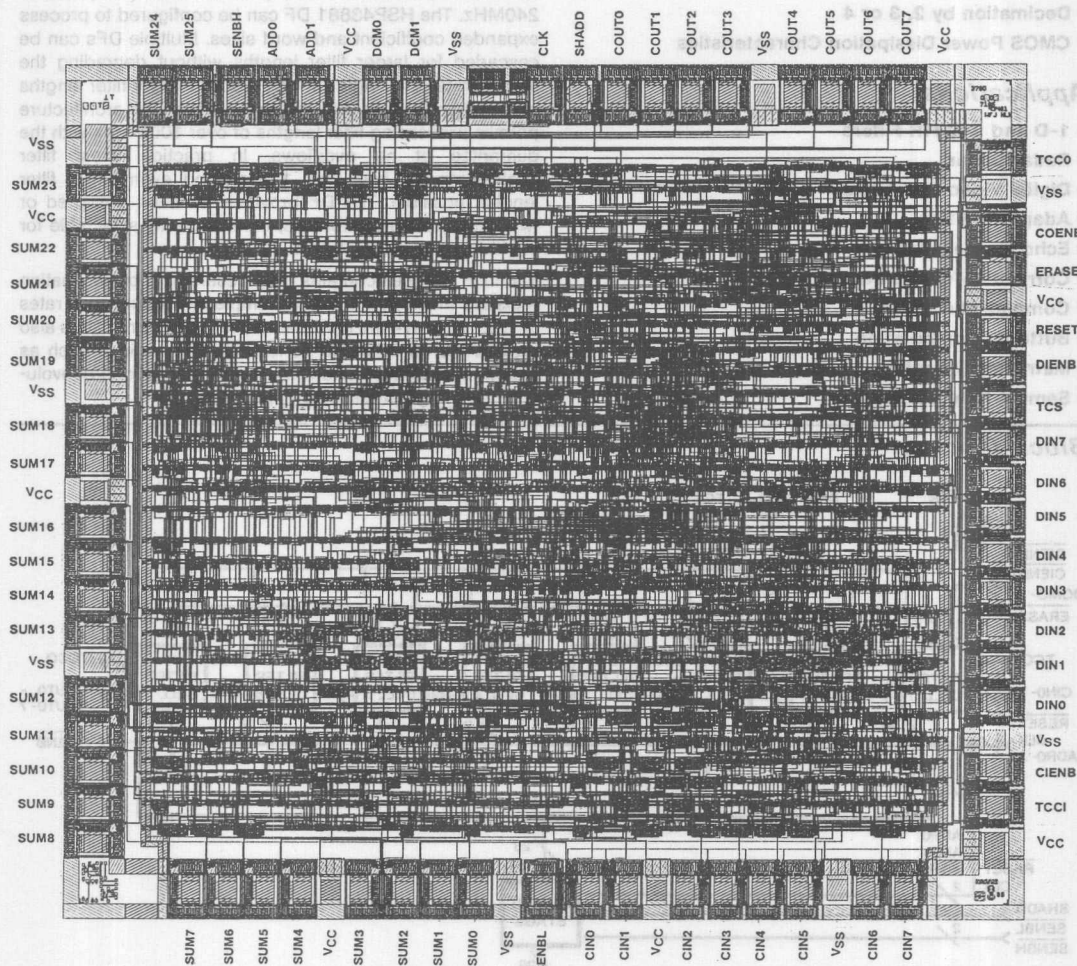
Thickness: 10kÅ

**DIE ATTACH:**

Material: Gold/Silicon Eutectic Alloy or Silver-Glass

**WORST CASE CURRENT DENSITY:** $1.2 \times 10^5 \text{A/cm}^2$ **Metallization Mask Layout**

HSP43481/883



3

1-D FILTERS



August 1992

Digital Filter

## Features

- Eight Filter Cells
- 0 to 30MHz Sample Rate
- 8-Bit Coefficients and Signal Data
- 26-Bit Accumulator Per Stage
- Filter Lengths Over 1000 Taps
- Shift and Add Output Stage for Combining Filter Outputs
- Expandable Coefficient Size, Data Size and Filter Length
- Decimation by 2, 3 or 4
- CMOS Power Dissipation Characteristics

## Applications

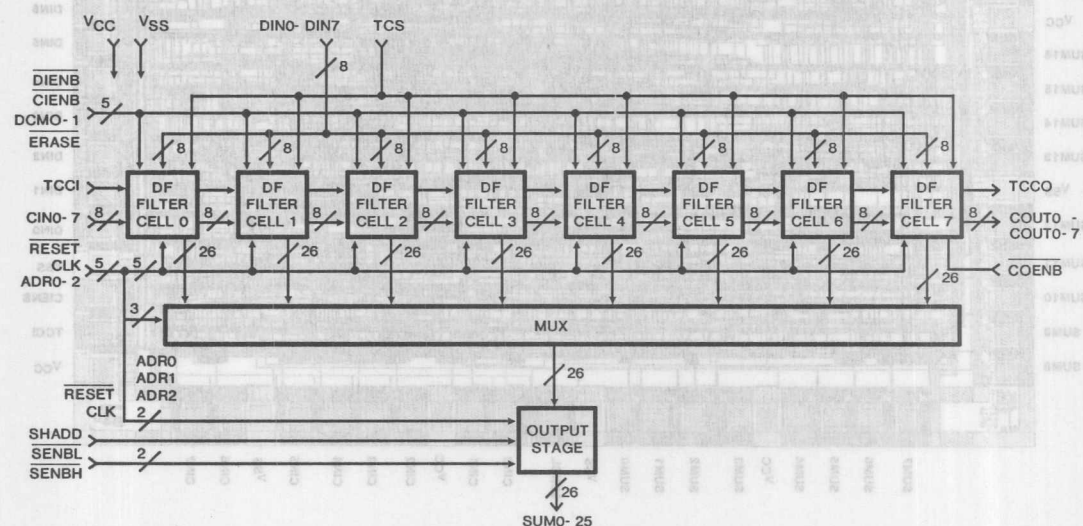
- 1-D and 2-D FIR Filters
- Radar/Sonar
- Digital Video and Audio
- Adaptive Filters
- Echo Cancellation
- Correlation/Convolution
- Complex Multiply-Add
- Butterfly Computation
- Matrix Multiplication
- Sample Rate Converters

## Description

The HSP43881 is a video speed Digital Filter (DF) designed to efficiently implement vector operations such as FIR digital filters. It is comprised of eight filter cells cascaded internally and a shift and add output stage, all in a single integrated circuit. Each filter cell contains a 8x8 bit multiplier, three decimation registers and a 26-bit accumulator. The output stage contains an additional 26-bit accumulator which can add the contents of any filter cell accumulator to the output stage accumulator shifted right by 8 bits. The HSP43881 has a maximum sample rate of 30MHz. The effective multiply accumulate (mac) rate is 240MHz. The HSP43881 DF can be configured to process expanded coefficient and word sizes. Multiple DFs can be cascaded for larger filter lengths without degrading the sample rate or a single DF can process larger filter lengths at less than 30MHz with multiple passes. The architecture permits processing filter lengths of over 1000 taps with the guarantee of no overflows. In practice, most filter coefficients are less than 1.0, making even larger filter lengths possible. The DF provides for 8-bit unsigned or two's complement arithmetic, independently selectable for coefficients and signal data.

Each DF filter cell contains three resampling or decimation registers which permit output sample rate reduction at rates of 1/2, 1/3 or 1/4 the input sample rate. These registers also provide the capability to perform 2-D operations such as matrix multiplication and NxN spatial correlations/convolutions for image processing applications.

## Block Diagram



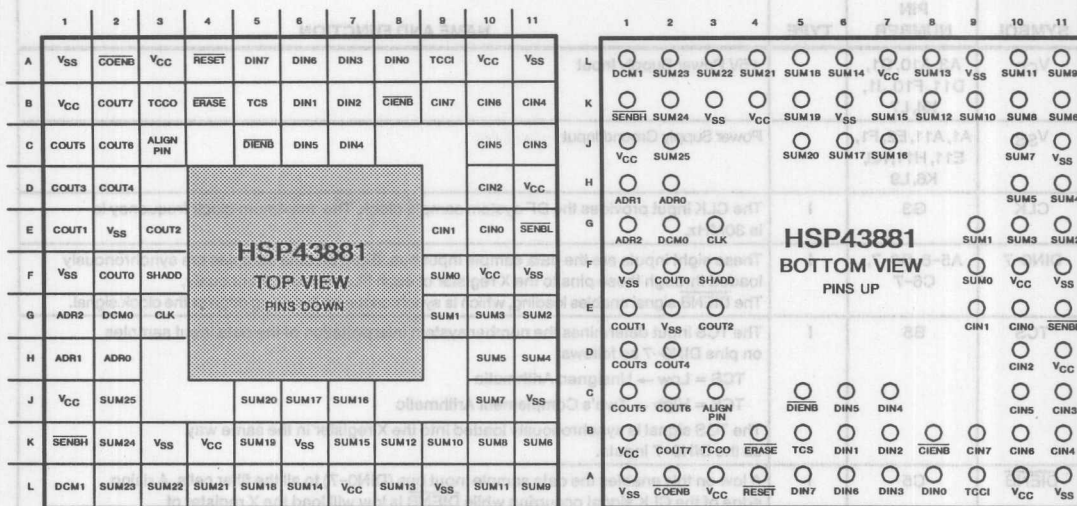
CAUTION: These devices are sensitive to electrostatic discharge. Users should follow proper IC Handling Procedures.  
Copyright © Harris Corporation 1992

File Number 2758.2

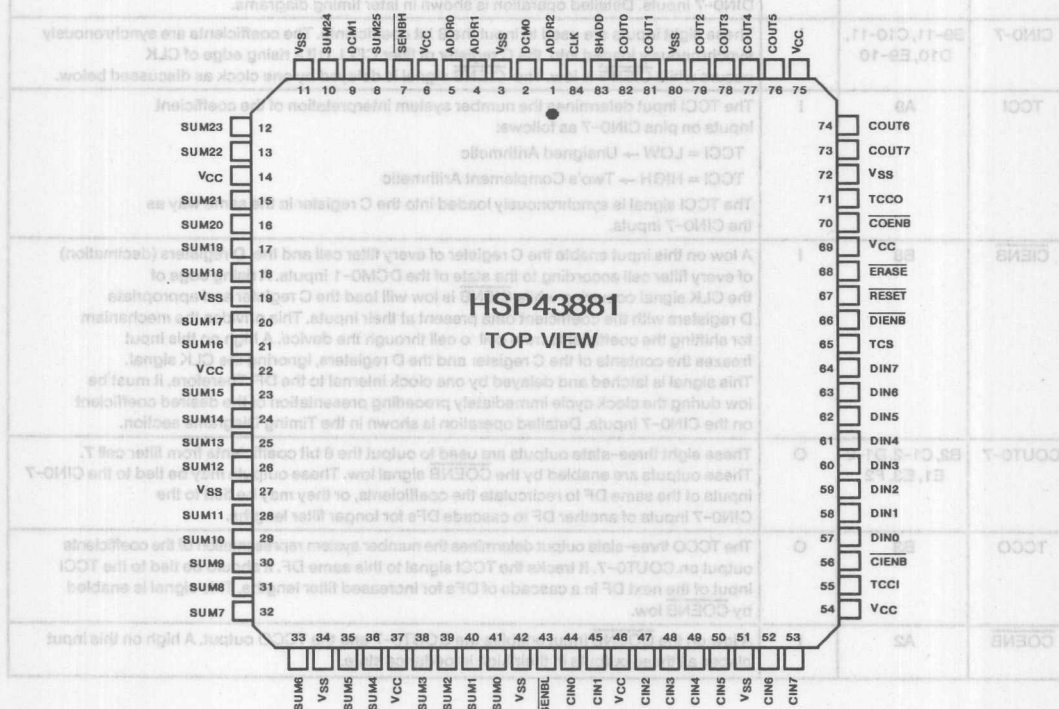
## HSP43881

## Pinouts

### 85 PIN GRID ARRAY (PGA)



## 84 LEAD PLCC PACKAGE



**NOTE:** An overbar on a signal name represents an active LOW signal.

## Pin Description

SYMBOL	PIN NUMBER	TYPE	NAME AND FUNCTION
VCC	A3, A10, B1, D11, F10, J1, K4, L7	I	+5V Power Supply Input
VSS	A1, A11, E2, F1, E11, H11, K3, K6, L9	I	Power Supply Ground Input
CLK	G3	I	The CLK input provides the DF system sample clock. The maximum clock frequency is 30MHz.
DINO-7	A5-8, B6-7, C6-7	I	These eight inputs are the data sample input bus. Eight bit data samples are synchronously loaded through these pins to the X register of each filter cell simultaneously. The DIENB signal enables loading, which is synchronous on the rising edge of the clock signal.
TCS	B5	I	The TCS input determines the number system interpretation of the data input samples on pins DINO-7 as follows: TCS = Low → Unsigned Arithmetic TCS = High → Two's Complement Arithmetic The TCS signal is synchronously loaded into the X register in the same way as the DINO-7 inputs.
DIENB	C5	I	A low on this enables the data sample input bus (DINO-7) to all the filter cells. A rising edge of the CLK signal occurring while DIENB is low will load the X register of every filter cell with the 8 bit value present on DINO-7. A high on this input forces all the bits of the data sample input bus to zero; a rising CLK edge when DIENB is high will load the X register of every filter cell with all zeros. This signal is latched inside the DF, delaying its effect by one clock internal to the DF. Therefore, it must be low during the clock cycle immediately preceding presentation of the desired data on the DINO-7 inputs. Detailed operation is shown in later timing diagrams.
CINO-7	B9-11, C10-11, D10, E9-10	I	These eight inputs are used to input the 8 bit coefficients. The coefficients are synchronously loaded into the C register of filter CELL 0 if a rising edge of CLK occurs while CIENB is low. The CIENB signal is delayed by one clock as discussed below.
TCCI	A9	I	The TCCI input determines the number system interpretation of the coefficient inputs on pins CINO-7 as follows: TCCI = LOW → Unsigned Arithmetic TCCI = HIGH → Two's Complement Arithmetic The TCCI signal is synchronously loaded into the C register in the same way as the CINO-7 inputs.
CIENB	B8	I	A low on this input enable the C register of every filter cell and the D registers (decimation) of every filter cell according to the state of the DCM0-1 inputs. A rising edge of the CLK signal occurring while CIENB is low will load the C register and appropriate D registers with the coefficient data present at their inputs. This provides the mechanism for shifting the coefficients from cell to cell through the device. A high on this input freezes the contents of the C register and the D registers, ignoring the CLK signal. This signal is latched and delayed by one clock internal to the DF. Therefore, it must be low during the clock cycle immediately preceding presentation of the desired coefficient on the CINO-7 inputs. Detailed operation is shown in the Timing Diagrams section.
COUT0-7	B2, C1-2, D1-2, E1, E3, F2	O	These eight three-state outputs are used to output the 8 bit coefficients from filter cell 7. These outputs are enabled by the COENB signal low. These outputs may be tied to the CINO-7 inputs of the same DF to recirculate the coefficients, or they may be tied to the CINO-7 inputs of another DF to cascade DFs for longer filter lengths.
TCCO	B3	O	The TCCO three-state output determines the number system representation of the coefficients output on COUT0-7. It tracks the TCCI signal to this same DF. It should be tied to the TCCI input of the next DF in a cascade of DFs for increased filter lengths. This signal is enabled by COENB low.
COENB	A2	I	A low on the COENB input enables the COUT0-7 and the TCCO output. A high on this input places all these outputs in their high impedance state.

## Pin Description (Continued)

SYMBOL	PIN NUMBER	TYPE	NAME FUNCTION															
DCM0-1	G2, L1	I	<p>These two inputs determine the use of the internal decimation registers as follows:</p> <table><tr><th>DCM1</th><th>DCM0</th><th>Decimation Function</th></tr><tr><td>0</td><td>0</td><td>Decimation registers not used</td></tr><tr><td>0</td><td>1</td><td>One decimation register is used</td></tr><tr><td>1</td><td>0</td><td>Two decimation registers are used</td></tr><tr><td>1</td><td>1</td><td>Three decimation registers are used</td></tr></table> <p>The coefficients pass from cell to cell at a rate determined by the number of decimation registers used. When no decimation registers are used, coefficients move from cell to cell on each clock. When one decimation register is used, coefficients move from cell to cell on every other clock, etc. These signals are latched and delayed by one clock internal to the DF.</p>	DCM1	DCM0	Decimation Function	0	0	Decimation registers not used	0	1	One decimation register is used	1	0	Two decimation registers are used	1	1	Three decimation registers are used
DCM1	DCM0	Decimation Function																
0	0	Decimation registers not used																
0	1	One decimation register is used																
1	0	Two decimation registers are used																
1	1	Three decimation registers are used																
SUM0-25	J2, J5-8, J10, K2, K5-11, L2-6, L8, L10-11	O	<p>These 26 three-state outputs are used to output the results of the internal filter cell computations. Individual filter cell results or the result of the shift-and-add output stage can be output. If an individual filter cell result is to be output, the ADRO-2 signals select the filter cell result. The SHADD signal determines whether the selected filter cell result or the output stage adder result is output. The signals SENBH and SENBL enable the most significant and least significant bits of the SUM0-25 result, respectively. Both SENBH and SENBL may be enabled simultaneously if the system has a 26 bit or larger bus. However, individual enables are provided to facilitate use with a 16 bit bus.</p>															
SENBH	K1	I	<p>A low on this input enables result bits SUM16-25. A high on this input places these bits in their high impedance state.</p>															
SENL	E11	I	<p>A low on this input enables result bits SUM0-15. A high on this input places these</p>															
ADRO-2	G1, H1-2	I	<p>These inputs select the one cell whose accumulator will be read through the output bus (SUM0-25) or added to the output stage accumulator. They also determine which accumulator will be cleared when ERASE is low. For selection of which accumulator to read through the output bus (SUM0-25) or which to add of the output stage accumulator, these inputs are latched in the DF and delayed by one clock internal to the device. If the ADRO-2 lines remain at the same address for more than one clock, the output at SUM0-25 will not change to reflect any subsequent accumulator updates in the addressed cell. Only the result available during the first clock, when ADRO-1 selects the cell, will be output. This does not hinder normal operation since the ADRO-1 lines are changed sequentially. This feature facilitates the interface with slow memories where the output is required to be fixed for more than one clock.</p>															
SHADD	F3	I	<p>The SHADD input controls the activation of the shift-and-add operation in the output stage. This signal is latched in the DF and delayed by one clock internal to the device. A detailed explanation is given in the DF Output Stage section.</p>															
RESET	A4	I	<p>A low on this input synchronously clears all the internal registers, except the cell accumulators. It can be used with ERASE to also clear all the accumulators simultaneously. This signal is latched in the DF and delayed by one clock internal to the DF.</p>															
ERASE	B4	I	<p>A low on this input synchronously clears the cell accumulator selected by the ADRO-1 signals. If RESET is also low simultaneously, all cell accumulators are cleared.</p>															
ALIGN PIN	C3		<p>Used for aligning chip in socket or printed circuit board. Must be left as a no connect in circuit.</p>															

3

1-D FILTERS



## Functional Description

The Digital Filter Processor (DF) is composed of eight filter cells cascaded together and an output stage for combining or selecting filter cell outputs (See Block Diagram). Each filter cell contains a multiplier-accumulator and several registers (Figure 1). Each 8-bit coefficient is multiplied by a 8-bit data sample, with the result added to the 26-bit accumulator contents. The coefficient output of each cell is cascaded to the coefficient input of the next cell to its right.

### DF Filter Cell

A 8-bit coefficient (CINO-7) enters each cell through the C register on the left and exits the cell on the right as signals COUT0-7. With no decimation, the coefficient moves directly from the C register to the output, and is valid on the clock following its entrance. When decimation is selected the coefficient exit is delayed by 1, 2 or 3 clocks by passing through one or more decimation registers (D1, D2 or D3).

The combination of D registers through which the coefficient passes is determined by the state of DCM0 and DCM1. The output signals (COUT0-7) are connected to the CINO-7 inputs of the next cell to its right. The COENB input signal enables the COUT0-7 outputs of the right most cell to the COUT0-7 pins of the device.

The C and D registers are enabled for loading by  $\overline{\text{CIENB}}$ . Loading is synchronous with CLK when  $\overline{\text{CIENB}}$  is low. Note that  $\overline{\text{CIENB}}$  is latched internally. It enables the register for loading after the next CLK following the onset of  $\overline{\text{CIENB}}$  low. Actual loading occurs on the second CLK following the onset of  $\overline{\text{CIENB}}$  low. Therefore  $\overline{\text{CIENB}}$  must be low during the clock cycle immediately preceding presentation of the coefficient on the CINO-7 inputs. In most basic FIR operations,  $\overline{\text{CIENB}}$  will be low throughout the process, so this latching and delay sequence is only important during the initialization phase. When  $\overline{\text{CIENB}}$  is high, the coefficients are frozen.

These registers are cleared synchronously under control of  $\overline{\text{RESET}}$ , which is latched and delayed exactly like  $\overline{\text{CIENB}}$ .

The output of the C register (CO-8) is one input to 8 x 8 multiplier.

The other input to the 8x8 multiplier comes from the output of the X register. This register is loaded with a data sample from the device input signals DINO-7 discussed above. The X register is enabled for loading by  $\overline{\text{DIENB}}$ . Loading is synchronous with CLK when  $\overline{\text{DIENB}}$  is low. Note that  $\overline{\text{DIENB}}$  is latched internally. It enables the register for loading after the next CLK following the onset of  $\overline{\text{DIENB}}$  low. Actual loading occurs on the second CLK following the onset of  $\overline{\text{DIENB}}$  low; therefore,  $\overline{\text{DIENB}}$  must be low during the clock cycle immediately preceding presentation of the data sample on the DINO-7 inputs. In most basic FIR operations,  $\overline{\text{DIENB}}$  will be low throughout the process, so this latching and delay sequence is only important during the initialization phase. When  $\overline{\text{DIENB}}$  is high, the X register is loaded with all zeros.

The multiplier is pipelined and is modeled as a multiplier core followed by two pipeline registers, MREG0 and MREG1 (Figure 1). The multiplier output is sign extended and input as one operand of the 26-bit adder. The other

adder operand is the output of the 26-bit accumulator. The adder output is loaded synchronously into both the accumulator and the TREG.

The TREG loading is disabled by the cell select signal,  $\text{CELLn}$ , where n is the cell number. The cell select is decoded from the ADRO-2 signals to generate the TREG load enable. The cell select is inverted and applied as the load enable to the TREG. Operation is such that the TREG is loaded whenever the cell is not selected. Therefore, TREG is loaded every clock except the clock following cell selection. The purpose of the TREG is to hold the result of a sum-of-products calculation during the clock when the accumulator is cleared to prepare for the next sum-of-products calculation. This allows continuous accumulation without wasting clocks.

The accumulator is loaded with the adder output every clock unless it is cleared. It is cleared synchronously in two ways. When  $\overline{\text{RESET}}$  and  $\overline{\text{ERASE}}$  are both low, the accumulator is cleared along with all other registers on the device. Since  $\overline{\text{ERASE}}$  and  $\overline{\text{RESET}}$  are latched and delayed one clock internally, clearing occurs on the second CLK following the onset of both  $\overline{\text{ERASE}}$  and  $\overline{\text{RESET}}$  low.

The second accumulator clearing mechanism clears a single accumulator in a selected cell. The cell select signal,  $\text{CELLn}$ , decoded from ADRO-2 and the  $\overline{\text{ERASE}}$  signal enable clearing of the accumulator on the next CLK.

The  $\overline{\text{ERASE}}$  and  $\overline{\text{RESET}}$  signals clear the DF internal registers and states as follows:

$\overline{\text{ERASE}}$	$\overline{\text{RESET}}$	CLEARING EFFECT
1	1	No clearing occurs, internal state remains same
1	0	$\overline{\text{RESET}}$ only active, all registers except accumulators are cleared, including the internal pipeline registers.
0	1	$\overline{\text{ERASE}}$ only active, the accumulator whose address is given by the ADRO-2 inputs is cleared.
0	0	Both $\overline{\text{RESET}}$ and $\overline{\text{ERASE}}$ active, all accumulators as well as all other registers are cleared.

### The DF Output Stage

The output stage consists of a 26-bit adder, 26-bit register, feedback multiplexer from the register to the adder, an output multiplexer and a 26-bit three-state driver stage (Figure 2).

The 26-bit output adder can add any filter cell accumulator result to the 18 most significant bits of the output buffer. This result is stored back in the output buffer. This operation takes place in one clock period. The eight LSBs of the output buffer are lost. The filter cell accumulator is selected by the ADRO-2 inputs.

The 18 MSBs of the output buffer actually pass through the zero mux on their way to the output adder input. The zero mux is controlled by the SHADD input signal and selects either the output buffer 18 MSBs or all zeros for the adder input. A low on the SHADD input selects zero. A high on the SHADD input selects the output buffer MSBs, thus activating the shift-and-add operation. The SHADD signal is latched and delayed by one clock internally.

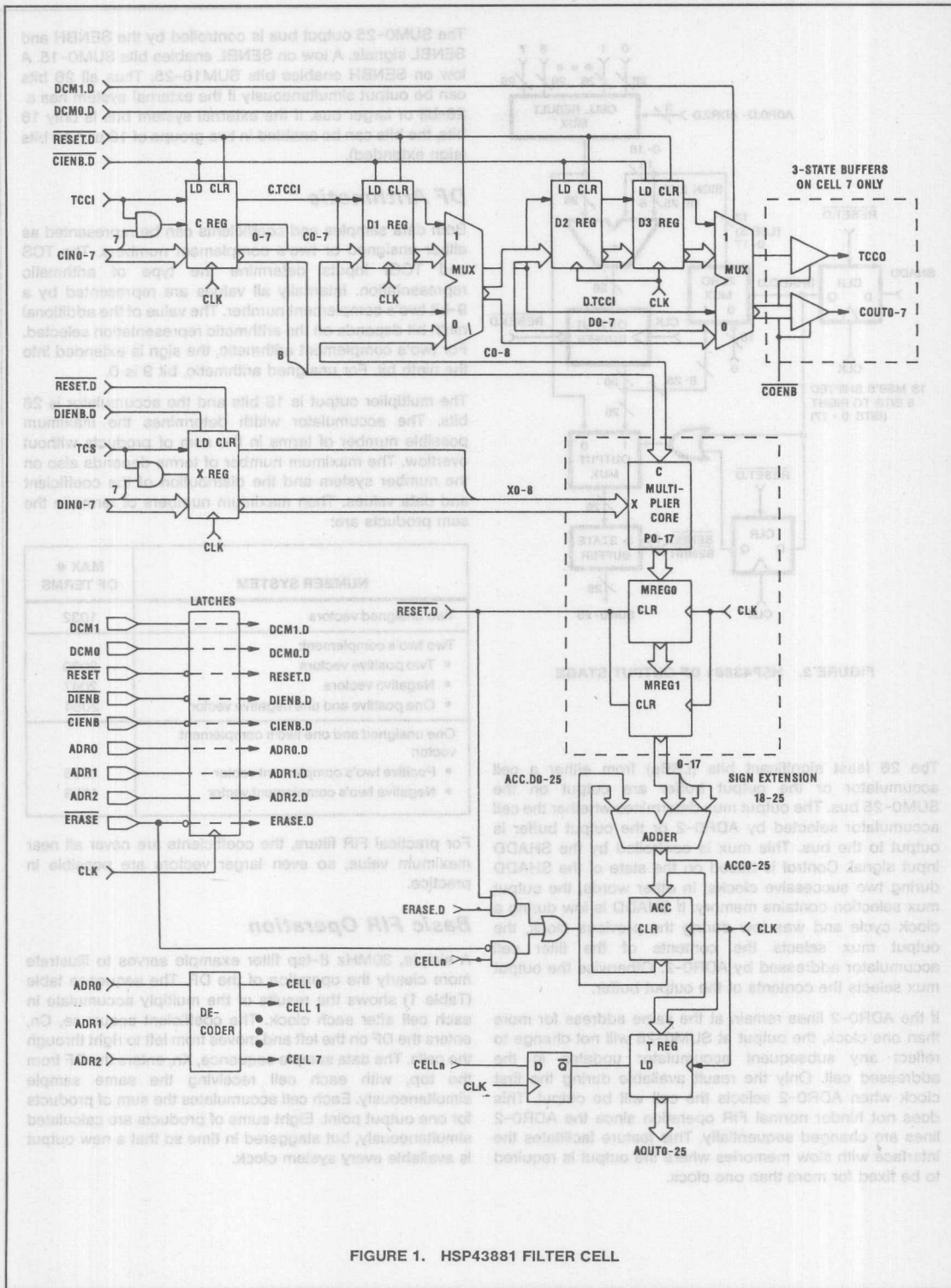


FIGURE 1. HSP43881 FILTER CELL

If the ADRO-2 lines remain at the same address for more than one clock, the output at SUM0-25 will not change to reflect any subsequent accumulator updates in the addressed cell. Only the result available during the first clock when ADRO-2 selects the cell will be output. This does not hinder normal FIR operation since the ADRO-2 lines are changed sequentially. This feature facilitates the interface with slow memories where the output is required to be fixed for more than one clock.

### DF Arithmetic

The multiplier output is 18 bits and the accumulator is 26 bits. The accumulator width determines the maximum possible number of terms in the sum of products without overflow. The maximum number of terms depends also on the number system and the distribution of the coefficient and data values. Then maximum numbers of terms in the sum products are:

For practical FIR filters, the coefficients are never all near maximum value, so even larger vectors are possible in practice.

### Basic FIR Operation

A simple, 30MHz 8-tap filter example serves to illustrate more clearly the operation of the DF. The sequence table (Table 1) shows the results of the multiply accumulate in each cell after each clock. The coefficient sequence, Cn, enters the DF on the left and moves from left to right through the cells. The data sample sequence, Xn, enters the DF from the top, with each cell receiving the same sample simultaneously. Each cell accumulates the sum of products for one output point. Eight sums of products are calculated simultaneously, but staggered in time so that a new output is available every system clock.

TABLE 1. HSP43881 30MHz, 8 TAP FIR FILTER SEQUENCE

CLK	CELL 0	CELL 1	CELL 2	CELL 3	CELL 4	CELL 5	CELL 6	CELL 7	SUM/CLR
0	$C_7 \times X_0$	0	0	0					
1	$+C_6 \times X_1$	$C_7 \times X_1$	0	0					
2	$+C_5 \times X_2$	$+C_6 \times X_2$	$C_7 \times X_2$	0					
3	$+C_4 \times X_3$	$+C_5 \times X_3$	$+C_6 \times X_3$	$C_7 \times X_3$					
4	$+C_3 \times X_4$	$+C_4 \times X_4$	$+C_5 \times X_4$	$+C_6 \times X_4$	$C_7 \times X_4$				
5	$+C_2 \times X_5$	$C_3 \times X_5$	$+C_4 \times X_5$	$+C_5 \times X_5$	$+C_6 \times X_5$	$C_7 \times X_5$			
6	$+C_1 \times X_6$	$+C_2 \times X_6$	$+C_3 \times X_6$	$+C_4 \times X_6$	$+C_5 \times X_6$	$+C_6 \times X_6$	$C_7 \times X_6$		
7	$+C_0 \times X_7$	$+C_1 \times X_7$	$+C_2 \times X_7$	$+C_3 \times X_7$	$+C_4 \times X_7$	$+C_5 \times X_7$	$+C_6 \times X_7$	$C_7 \times X_7$	Cell 0 (Y7)
8	$C_7 \times X_8$	$+C_0 \times X_8$	$+C_1 \times X_8$	$+C_2 \times X_8$	$+C_3 \times X_8$	$+C_4 \times X_8$	$+C_5 \times X_8$	$+C_6 \times X_8$	Cell 1 (Y8)
9	$+C_6 \times X_9$	$C_7 \times X_9$	$+C_0 \times X_9$	$+C_1 \times X_9$	$+C_2 \times X_9$	$+C_3 \times X_9$	$+C_4 \times X_9$	$+C_5 \times X_9$	Cell 2 (Y9)
10	$+C_5 \times X_{10}$	$+C_6 \times X_{10}$	$C_7 \times X_{10}$	$+C_0 \times X_{10}$	$+C_1 \times X_{10}$	$+C_2 \times X_{10}$	$+C_3 \times X_{10}$	$+C_4 \times X_{10}$	Cell 3 (Y10)
11	$+C_4 \times X_{11}$	$+C_5 \times X_{11}$	$+C_6 \times X_{11}$	$C_7 \times X_{11}$	$+C_0 \times X_{11}$	$+C_1 \times X_{11}$	$+C_2 \times X_{11}$	$+C_3 \times X_{11}$	Cell 4 (Y11)
12	$+C_3 \times X_{12}$	$+C_4 \times X_{12}$	$+C_5 \times X_{12}$	$+C_6 \times X_{12}$	$C_7 \times X_{12}$	$+C_0 \times X_{12}$	$+C_1 \times X_{12}$	$+C_2 \times X_{12}$	Cell 5 (Y12)
13	$+C_2 \times X_{13}$	$+C_3 \times X_{13}$	$+C_4 \times X_{13}$	$+C_5 \times X_{13}$	$+C_6 \times X_{13}$	$C_7 \times X_{13}$	$+C_0 \times X_{13}$	$+C_1 \times X_{13}$	Cell 6 (Y13)
14	$+C_1 \times X_{14}$	$+C_2 \times X_{14}$	$+C_3 \times X_{14}$	$+C_4 \times X_{14}$	$+C_5 \times X_{14}$	$+C_6 \times X_{14}$	$+C_7 \times X_{14}$	$+C_0 \times X_{14}$	Cell 7 (Y14)
15	$+C_0 \times X_{15}$	$+C_1 \times X_{15}$	$+C_2 \times X_{15}$	$+C_3 \times X_{15}$	$+C_4 \times X_{15}$	$+C_5 \times X_{15}$	$+C_6 \times X_{15}$	$C_7 \times X_{15}$	Cell 0 (Y15)

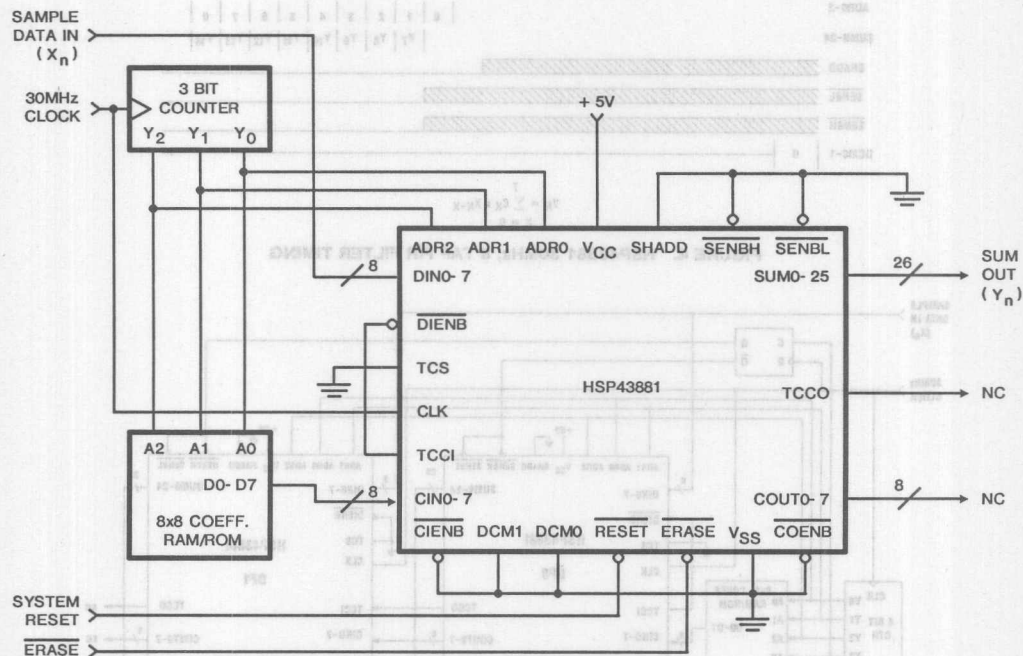


FIGURE 3. HSP43881 30MHz, 8 TAP FIR FILTER APPLICATION SCHEMATIC



Detailed operation of the DF to perform a basic 8-tap, 8-bit coefficient, 8-bit data, 30MHz FIR filter is best understood by observing the schematic (Figure 3) and timing diagram (Figure 4). The internal pipeline length of the DF is four (4) clock cycles, corresponding to the register levels CREG (or XREG), MREG0, MREG1, and TREG (Figures 1 and 2). Therefore the delay from presentation of data and coefficients at the DINO-7 and CIN0-7 inputs to a sum appearing at the SUM0-25 output is:

$$k + T_d$$

where

$$k = \text{filter length}$$

$T_d = 4$ , the internal pipeline delay of DF

After the pipeline has filled, a new output sample is available every clock. The delay to last sample output from last sample input is  $T_d$ .

The output sums,  $Y_n$ , shown in the timing diagram are derived from the sum-of-products equation:

$$Y(n) = C(0) \times X(n) + C(1) \times X(n-1) + C(2) \times X(n-2) + C(3) \times X(n-3) + C(4) \times X(n-4) + C(5) \times X(n-5) + C(6) \times X(n-6) + C(7) \times X(n-7)$$

### Extended FIR Filter Length

Filter lengths greater than eight taps can be created by either cascading together multiple DF devices or "reusing" a single device. Using multiple devices, an FIR filter of over 1000 taps can be constructed to operate at a 30MHz sample rate. Using a single device clocked at 30MHz, an FIR filter of over 1000 taps can be constructed to operate at less than a 30MHz sample rate. Combinations of these two techniques are also possible.

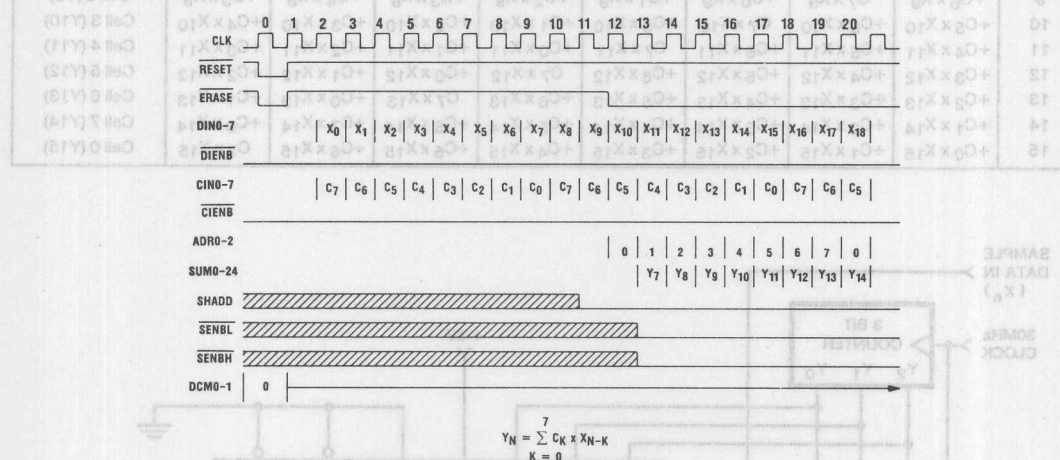


FIGURE 4. HSP43881 30MHz, 8 TAP FIR FILTER TIMING

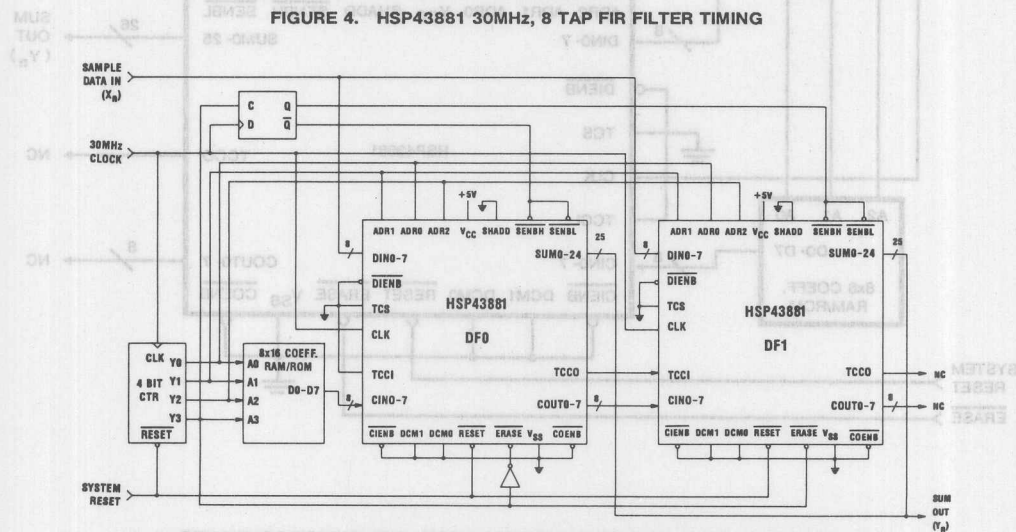


FIGURE 5. HSP43881 30MHz, 16 TAP FIR FILTER CASCADE APPLICATION SCHEMATIC.

### Cascade Configuration

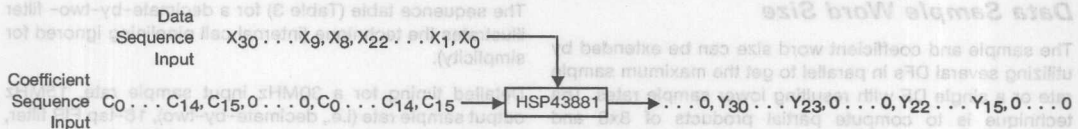
To design a filter length  $L > 8$ ,  $L/8$  DFs are cascaded by connecting the COUT0-7 outputs of the (i)th DF to the CINO-7 inputs of the (i+1)th DF. The DINO-7 inputs and SUM0-25 outputs of all the DFs are also tied together. A specific example of two cascaded DFs illustrates the technique (Figure 5). Timing (Figure 6) is similar to the simple 8-tap FIR, except the  $\overline{\text{ERASE}}$  and  $\overline{\text{SENBL}}/\overline{\text{SENBH}}$

signals must be enabled independently for the two DFs in order to clear the correct accumulators and enable the SUM0-25 output signals at the proper times.

### Single DF Configuration

Using a single DF, a filter of length  $L > 8$  can be constructed by processing in  $L/8$  passes as illustrated in the following table (Table 2) for a 16-tap FIR. Each pass is composed of

TABLE 2. HSP43881 16-TAP FIR FILTER SEQUENCE USING A SINGLE DF



CLK	CELL 0	CELL 1	CELL 2	CELL 3	CELL 4	CELL 5	CELL 6	CELL 7	SUM/CLR
6	$C_{15} \times X_0$	0	0	0					-
7	$+C_{14} \times X_1$	$C_{15} \times X_1$	0	0					-
8	$+C_{13} \times X_2$		$C_{15} \times X_2$	0					-
9	$+C_{12} \times X_3$			$C_{15} \times X_3$					-
10	$+C_{11} \times X_4$			$+C_{14} \times X_4$	$C_{15} \times X_4$				-
11	$+C_{10} \times X_5$			$+C_{13} \times X_5$		$C_{15} \times X_5$			-
12	$+C_9 \times X_6$			$+C_{12} \times X_6$			$C_{15} \times X_6$		-
13	$+C_8 \times X_7$			$+C_{11} \times X_7$				$C_{15} \times X_7$	-
14	$+C_7 \times X_8$			$+C_{10} \times X_8$				$+C_{14} \times X_8$	-
15	$+C_6 \times X_9$			$+C_9 \times X_9$				$+C_{13} \times X_9$	-
16	$+C_5 \times X_{10}$			$+C_8 \times X_{10}$				$+C_{12} \times X_{10}$	-
17	$+C_4 \times X_{11}$			$+C_7 \times X_{11}$				$+C_{11} \times X_{11}$	-
18	$+C_3 \times X_{12}$			$+C_6 \times X_{12}$				$+C_{10} \times X_{12}$	-
19	$+C_2 \times X_{13}$			$+C_5 \times X_{13}$				$+C_9 \times X_{13}$	-
20	$+C_1 \times X_{14}$			$+C_4 \times X_{14}$				$+C_8 \times X_{14}$	-
21	$+C_0 \times X_{15}$			$+C_3 \times X_{15}$				$+C_7 \times X_{15}$	CELL 0 (Y15)
22	0	$C_0 \times X_{16}$		$+C_2 \times X_{16}$				$+C_6 \times X_{16}$	CELL 1 (Y16)
23	0	0	$C_0 \times X_{17}$	$+C_1 \times X_{17}$				$+C_5 \times X_{17}$	CELL 2 (Y17)
24	0	0	0	$+C_0 \times X_{18}$				$+C_4 \times X_{18}$	CELL 3 (Y18)
25	0	0	0	0	$C_0 \times X_{19}$			$+C_3 \times X_{19}$	CELL 4 (Y19)
26	0	0	0	0	0	$C_0 \times X_{20}$		$+C_2 \times X_{20}$	CELL 5 (Y20)
27	0	0	0	0	0	0	$C_0 \times X_{21}$	$+C_1 \times X_{21}$	CELL 6 (Y21)
28	0	0	0	0	0	0	0	$+C_0 \times X_{22}$	CELL 7 (Y22)
29	$C_{15} \times X_8$	0	0	0	0	0	0	0	-
30	$+C_{14} \times X_9$	$C_{15} \times X_9$	0	0	0	0	0	0	-
31	$+C_{13} \times X_{10}$		$C_{15} \times X_{10}$	0	0	0	0	0	-
32	$+C_{12} \times X_{11}$			$C_{15} \times X_{11}$	0	0	0	0	-
33	$+C_{11} \times X_{12}$				$C_{15} \times X_{12}$	0	0	0	-
34	$+C_{10} \times X_{13}$					$C_{15} \times X_{13}$	0	0	-
35	$+C_9 \times X_{14}$						$C_{15} \times X_{14}$	0	-
36	$+C_8 \times X_{15}$							$C_{15} \times X_{15}$	-
37	$+C_7 \times X_{16}$							$+C_{14} \times X_{16}$	-
38	$+C_6 \times X_{17}$							$+C_{13} \times X_{17}$	-
39	$+C_5 \times X_{18}$							$+C_{12} \times X_{18}$	-
40	$+C_4 \times X_{19}$							$+C_{11} \times X_{19}$	-
41	$+C_3 \times X_{20}$							$+C_{10} \times X_{20}$	-
42	$+C_2 \times X_{21}$							$+C_9 \times X_{21}$	-
43	$+C_1 \times X_{22}$							$+C_8 \times X_{22}$	-
44	$+C_0 \times X_{23}$							$+C_7 \times X_{23}$	CELL 0 (Y23)
45	0	$C_0 \times X_{24}$						$+C_6 \times X_{24}$	CELL 1 (Y24)
46	0	0	$C_0 \times X_{25}$					$+C_5 \times X_{25}$	CELL 2 (Y25)
47	0	0	0	$C_0 \times X_{26}$				$+C_4 \times X_{26}$	CELL 3 (Y26)
48	0	0	0	0	$C_0 \times X_{27}$			$+C_3 \times X_{27}$	CELL 4 (Y27)

$T_p = 7 + L$  cycles and computes eight output samples. In pass  $i$ , the sample with indices  $i*8$  to  $i*8 + (L-1)$  enter the DINO-7 inputs. The coefficients  $C_0 - C_{L-1}$  enter the CINO-7 inputs, followed by seven zeros. As these zeros are entered, the result samples are output and the accumulators reset. Initial filling of the pipeline is not shown in this sequence table. Filter outputs can be put through a FIFO to even out the sample rate.

### Extended Coefficient and Data Sample Word Size

The sample and coefficient word size can be extended by utilizing several DFs in parallel to get the maximum sample rate or a single DF with resulting lower sample rates. The technique is to compute partial products of  $8 \times 8$  and combine these partial products by shifting and adding to obtain the final result. The shifting and adding can be

accomplished with external adders (at full speed) or with the DF's shift-and-add mechanism contained in its output stage (at reduced speed).

### Decimation/Resampling

The HSP43881 DF provides a mechanism for decimating by factors of 2, 3, or 4. From the DF filter cell block diagram (Figure 1), note the three D registers and two multiplexers in the coefficient path through the cell. These allow the coefficients to be delayed by 1, 2, or 3 clocks through the cell. The sequence table (Table 3) for a decimate-by-two filter illustrates the technique (internal cell pipelining ignored for simplicity).

Detailed timing for a 30MHz input sample rate, 15MHz output sample rate (i.e., decimate-by-two), 16-tap FIR filter, including pipelining, is shown in Figure 7. This filter requires only a single HSP43881 DF.

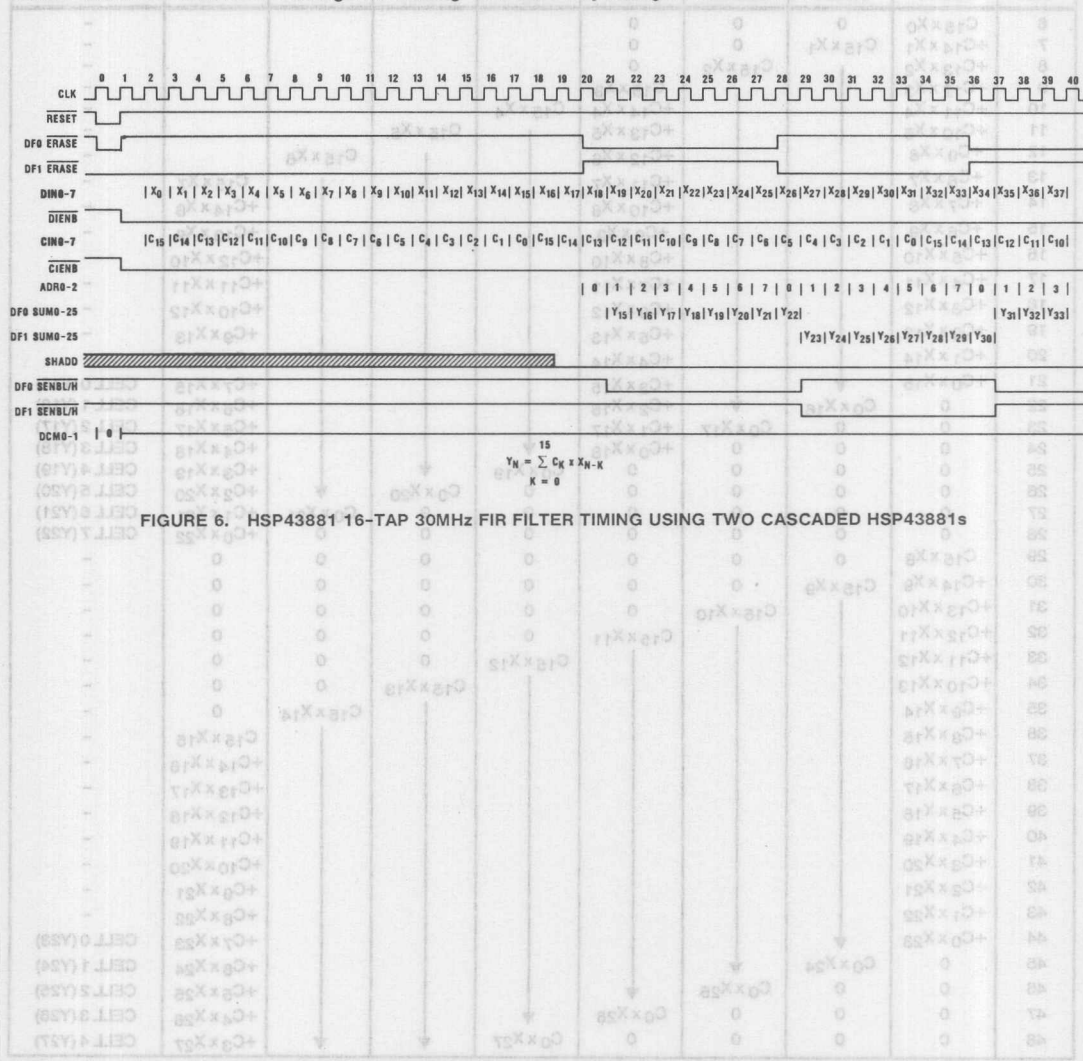


FIGURE 6. HSP43881 16-TAP 30MHz FIR FILTER TIMING USING TWO CASCADED HSP43881s

TABLE 3. HSP43881 16-TAP DECIMATE-BY-TWO FIR FILTER SEQUENCE; 30MHz IN, 15MHz OUT

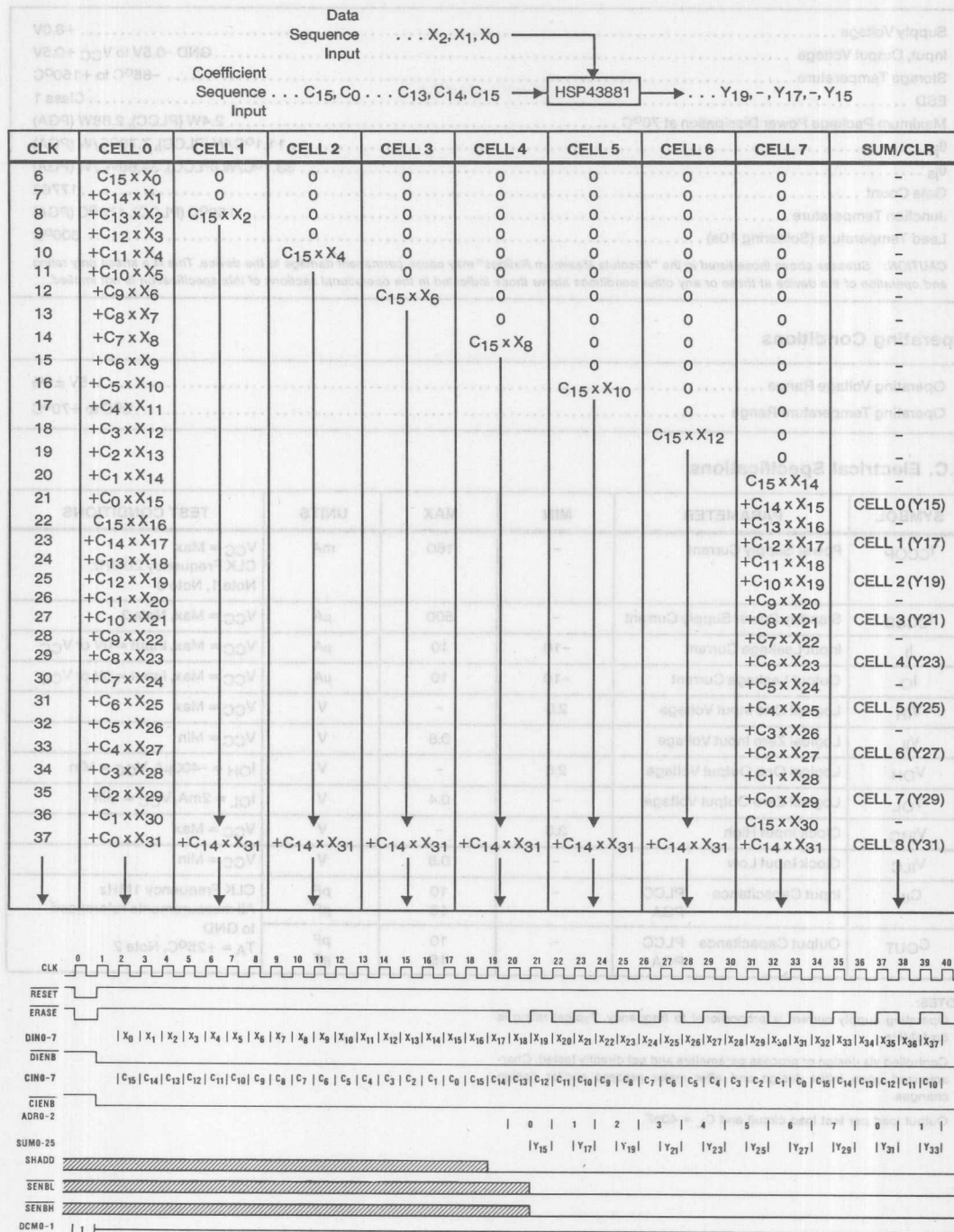


FIGURE 7. HSP43881 16-TAP DECIMATE-BY-TWO FIR FILTER TIMING; 30MHz IN, 15MHz OUT

3

1-D FILTERS



# Specifications HSP43881

## Absolute Maximum Ratings

Supply Voltage	+8.0V
Input, Output Voltage	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature	-65°C to +150°C
ESD	Class 1
Maximum Package Power Dissipation at 70°C	2.4W (PLCC), 2.88W (PGA)
$\theta_{jc}$	11.1°C/W (PLCC), 7.78°C/W (PGA)
$\theta_{ja}$	33.7°C/W (PLCC), 34.66°C/W (PGA)
Gate Count	17763
Junction Temperature	150°C (PLCC), 175°C (PGA)
Lead Temperature (Soldering 10s)	300°C

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range	5V $\pm$ 5%
Operating Temperature Range	0°C to +70°C

## D.C. Electrical Specifications

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
$I_{CCOP}$	Power Supply Current	-	160	mA	$V_{CC}$ = Max CLK Frequency 20MHz Note 1, Note 3
$I_{CCSB}$	Standby Power Supply Current	-	500	$\mu A$	$V_{CC}$ = Max, Note 3
$I_I$	Input Leakage Current	-10	10	$\mu A$	$V_{CC}$ = Max, Input = 0V or $V_{CC}$
$I_O$	Output Leakage Current	-10	10	$\mu A$	$V_{CC}$ = Max, Input = 0V or $V_{CC}$
$V_{IH}$	Logical One Input Voltage	2.0	-	V	$V_{CC}$ = Max
$V_{IL}$	Logical Zero Input Voltage	-	0.8	V	$V_{CC}$ = Min
$V_{OH}$	Logical One Output Voltage	2.6	-	V	$I_{OH}$ = -400 $\mu A$ , $V_{CC}$ = Min
$V_{OL}$	Logical Zero Output Voltage	-	0.4	V	$I_{OL}$ = 2mA, $V_{CC}$ = Min
$V_{IHC}$	Clock Input High	3.0	-	V	$V_{CC}$ = Max
$V_{ILC}$	Clock Input Low	-	0.8	V	$V_{CC}$ = Min
$C_{IN}$	Input Capacitance	PLCC	10	pF	CLK Frequency 1MHz All measurements referenced to GND $T_A$ = +25°C, Note 2
			15	pF	
$C_{OUT}$	Output Capacitance	PLCC	10	pF	
		PGA	15	pF	

### NOTES:

- Operating supply current is proportional to frequency. Typical rating is 8mA/MHz.
- Controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.
- Output load per test load circuit and  $C_L$  = 40pF.

# Specifications HSP43881

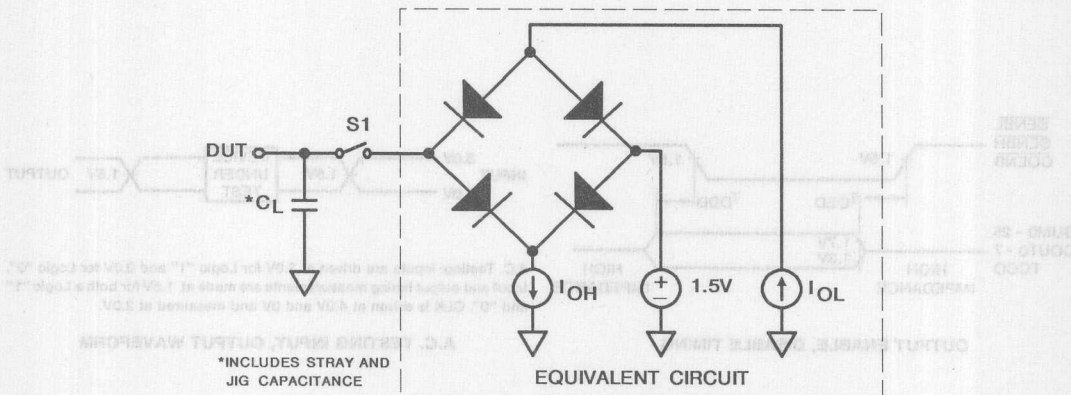
## A.C. Electrical Specifications $V_{CC} = 5V \pm 5\%$ , $T_A = 0^\circ C$ to $+70^\circ C$

SYMBOL	PARAMETER	-20 (20MHz)		-25 (25.6MHz)		-30 (30MHz)		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX	MIN	MAX		
$T_{CP}$	Clock Period	50	-	39	-	33	-	ns	
$T_{CL}$	Clock Low	20	-	16	-	13	-	ns	
$T_{CH}$	Clock High	20	-	16	-	13	-	ns	
$T_{IS}$	Input Setup	16	-	14	-	13	-	ns	
$T_{IH}$	Input Hold	0	-	0	-	0	-	ns	
$T_{ODC}$	CLK to Coefficient Output Delay	-	24	-	20	-	18	ns	
$T_{OED}$	Output Enable Delay	-	20	-	15	-	15	ns	
$T_{ODD}$	Output Disable Delay	-	20	-	15	-	15	ns	Note 1
$T_{ODS}$	CLK to SUM Output Delay	-	27	-	25	-	21	ns	
$T_{OR}$	Output Rise	-	6	-	6	-	6	ns	Note 1
$T_{OF}$	Output Fall	-	6	-	6	-	6	ns	Note 1

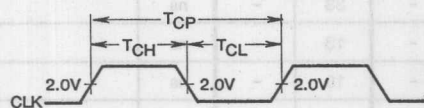
### NOTE:

- Controlled by design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.

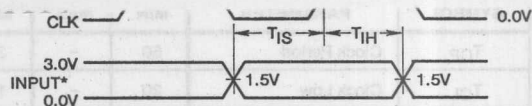
## Test Load Circuit



Switch S1 Open for  $I_{CCSB}$  and  $I_{CCOP}$  Tests

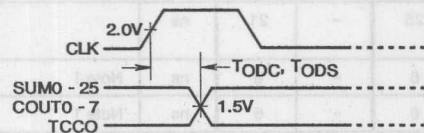


**CLOCK AC PARAMETERS**



\* Input includes: DINO-7, CINO-7, DIENB, CIENB, ERASE, RESET, DCM0-1, ADRO-2, TCS, TCCI, SHADD

**INPUT SETUP AND HOLD**

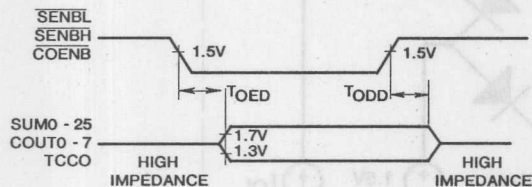


\* SUM0-25, COUT0-7, TCC0 are assumed not to be in high-impedance state

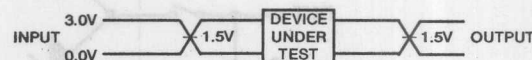
**SUM0-25, COUT0-7, TCC0 OUTPUT DELAYS**



**OUTPUT RISE AND FALL TIMES**



**OUTPUT ENABLE, DISABLE TIMING**



A.C. Testing: Inputs are driven at 3.0V for Logic "1" and 0.0V for Logic "0". Input and output timing measurements are made at 1.5V for both a Logic "1" and "0". CLK is driven at 4.0V and 0V and measured at 2.0V.

**A.C. TESTING INPUT, OUTPUT WAVEFORM**

**HARRIS**

# HSP43881/883

August 1992

**Digital Filter**

## Features

- This Circuit is Processed in Accordance to Mil-Std-883C and is Fully Conformant Under the Provisions of Paragraph 1.2.1.
- 0 to 25.6MHz Sample Rate
- Eight Filter Cells
- 8-Bit Coefficients and Signal Data
- Low Power CMOS Operation
  - ICCSB 500 $\mu$ A Maximum
  - ICCOP 160 $\mu$ A Maximum @ 20MHz
- 26-Bit Accumulator Per Stage
- Filter Lengths Up to 1032 Taps
- Shift and Add Output Stage for Combining Filter Outputs
- Expandable Coefficient Size, Data Size and Filter Length
- Decimation by 2, 3 or 4

## Applications

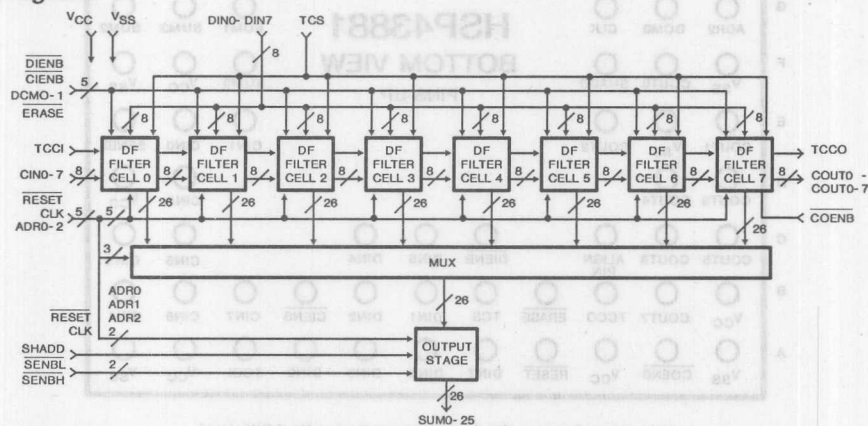
- 1-D and 2-D FIR Filters
- Radar/Sonar
- Digital Video and Audio
- Adaptive Filters
- Echo Cancellation
- Correlation/Convolution
- Complex Multiply-Add
- Butterfly Computation
- Matrix Multiplication
- Sample Rate Converters

## Description

The HSP43881/883 is a video speed Digital Filter (DF) designed to efficiently implement vector operations such as FIR digital filters. It is comprised of eight filter cells cascaded internally and a shift and add output stage, all in a single integrated circuit. Each filter cell contains a 8x8 bit multiplier, three decimation registers and a 26-bit accumulator. The output stage contains an additional 26-bit accumulator which can add the contents of any filter cell accumulator to the output stage accumulator shifted right by 8 bits. The HSP43881/883 has a maximum sample rate of 25.6MHz. The effective multiply accumulate (mac) rate is 204MHz. The HSP43881/883 DF can be configured to process expanded coefficient and word sizes. Multiple DFs can be cascaded for larger filter lengths without degrading the sample rate or a single DF can process larger filter lengths at less than 25.6MHz with multiple passes. The architecture permits processing filter lengths of over 1000 taps with the guarantee of no overflows. In practice, most filter coefficients are less than 1.0, making even larger filter lengths possible. The DF provides for 8-bit unsigned or two's complement arithmetic, independently selectable for coefficients and signal data.

Each DF filter cell contains three resampling or decimation registers which permit output sample rate reduction at rates of 1/2, 1/3 or 1/4 the input sample rate. These registers also provide the capability to perform 2-D operations such as matrix multiplication and NxN spatial correlations/convolutions for image processing applications.

## Block Diagram



CAUTION: These devices are sensitive to electrostatic discharge. Users should follow proper IC Handling Procedures.  
Copyright © Harris Corporation 1992

File Number **2449.2**



## Pinouts

## 85 PIN GRID ARRAY (PGA)

	1	2	3	4	5	6	7	8	9	10	11
A	V <sub>SS</sub>	COENB	V <sub>CC</sub>	RESET	DIN7	DIN6	DIN3	DIN0	TCCI	V <sub>CC</sub>	V <sub>SS</sub>
B	V <sub>CC</sub>	COUT7	TCCO	ERASE	TCS	DIN1	DIN2	CIENB	CIN7	CIN6	CIN4
C	COUT5	COUT6	ALIGN PIN		DIENB	DIN5	DIN4			CIN5	CIN3
D	COUT3	COUT4								CIN2	V <sub>CC</sub>
E	COUT1	V <sub>SS</sub>	COUT2						CIN1	CIN0	SENBL
F	V <sub>SS</sub>	COUT0	SHADD						SUM0	V <sub>CC</sub>	V <sub>SS</sub>
G	ADR2	DCM0	CLK						SUM1	SUM3	SUM2
H	ADR1	ADR0								SUM5	SUM4
J	V <sub>CC</sub>	SUM25			SUM20	SUM17	SUM16			SUM7	V <sub>SS</sub>
K	SENBH	SUM24	V <sub>SS</sub>	V <sub>CC</sub>	SUM19	V <sub>SS</sub>	SUM15	SUM12	SUM10	SUM8	SUM6
L	DCM1	SUM23	SUM22	SUM21	SUM18	SUM14	V <sub>CC</sub>	SUM13	V <sub>SS</sub>	SUM11	SUM9

HSP43881/883

TOP VIEW

PINS DOWN

	1	2	3	4	5	6	7	8	9	10	11
L	DCM1	SUM23	SUM22	SUM21	SUM18	SUM14	V <sub>CC</sub>	SUM13	V <sub>SS</sub>	SUM11	SUM9
K	SENBH	SUM24	V <sub>SS</sub>	V <sub>CC</sub>	SUM19	V <sub>SS</sub>	SUM15	SUM12	SUM10	SUM8	SUM6
J	V <sub>CC</sub>	SUM25			SUM20	SUM17	SUM16			SUM7	V <sub>SS</sub>
H	ADR1	ADR0								SUM5	SUM4
G	ADR2	DCM0	CLK						SUM1	SUM3	SUM2
F	V <sub>SS</sub>	COUT0	SHADD						SUM0	V <sub>CC</sub>	V <sub>SS</sub>
E	COUT1	V <sub>SS</sub>	COUT2						CIN1	CIN0	SENBL
D	COUT3	COUT4								CIN2	V <sub>CC</sub>
C	COUT5	COUT6	ALIGN PIN		DIENB	DIN5	DIN4			CIN5	CIN3
B	V <sub>CC</sub>	COUT7	TCCO	ERASE	TCS	DIN1	DIN2	CIENB	CIN7	CIN6	CIN4
A	V <sub>SS</sub>	COENB	V <sub>CC</sub>	RESET	DIN7	DIN6	DIN3	DIN0	TCCI	V <sub>CC</sub>	V <sub>SS</sub>

HSP43881

BOTTOM VIEW

PINS UP

Note: An overbar on a signal name represents an active LOW signal.

# Specifications HSP43881/883

## Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input, Output Voltage Applied .....	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range .....	-65°C to +150°C
Junction Temperature .....	+175°C
Lead Temperature (Soldering, Ten Seconds) .....	+300°C
ESD Classification .....	Class 1

## Reliability Information

Thermal Resistance $\theta_{ja}$ $\theta_{jc}$	
Ceramic PGA Package .....	34.66°C/W 7.78°C/W
Maximum Package Power Dissipation at +125°C	
Ceramic PGA Package .....	1.44 Watt
Gate Count .....	17762 Gates

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range .....	+4.5V to +5.5V
Operating Temperature Range .....	-55°C to +125°C

TABLE 1. HSP43881/883 D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Devices Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +2.0mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output Leakage Current	$I_O$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Clock Input High	$V_{IHC}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	3.0	-	V
Clock Input Low	$V_{ILC}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ , Outputs Open	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 20.0MHz$ $V_{CC} = 5.5V$ (Note 2)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	160.0	mA
Functional Test	FT	(Note 3)	7, 8	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	-	

### NOTES:

- Interchanging of force and sense conditions is permitted.
- Operating Supply Current is proportional to frequency, typical rating is 8.0mA/MHz.
- Tested as follows:  $f = 1MHz$ ,  $V_{IH} = 2.6$ ,  $V_{IL} = 0.4$ ,  $V_{OH} \geq 1.5V$ ,  $V_{OL} \leq 1.5V$ ,  $V_{IHC} = 3.4V$ , and  $V_{ILC} = 0.4V$ .

GROUPS	METHOD	PERFORMANCE GROUPS
1	100% TEST	100% TEST
2	100% TEST	100% TEST
3	100% TEST	100% TEST
4	100% TEST	100% TEST
5	100% TEST	100% TEST
6	100% TEST	100% TEST
7	100% TEST	100% TEST
8	100% TEST	100% TEST

3

1-D FILTERS

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	-20 (20MHz)		-25 (25.6MHz)		UNITS
					MIN	MAX	MIN	MAX	
Clock Period	T <sub>CP</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	50	-	39	-	ns
Clock Low	T <sub>CL</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	16	-	ns
Clock High	T <sub>CH</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	16	-	ns
Input Setup	T <sub>IS</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	17	-	ns
Input Hold	T <sub>IH</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
CLK to Coefficient Output Delay	T <sub>ODC</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	24	-	20	ns
Output Enable Delay	T <sub>OED</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	20	-	15	ns
CLK to SUM Output Delay	T <sub>ODS</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	31	-	25	ns

NOTE: 1. A.C. Testing: V<sub>CC</sub> = 4.5V and 5.5V. Inputs are driven at 3.0V for a Logic "1" and 0.0V for a Logic "0". Input and output timing measurements are made at 1.5V for both a Logic "1" and "0". CLK is driven at 4.0V and 0V and measured at 2.0V.

TABLE 3. HSP43881/883 A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETER	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	-20		-25		UNITS
					MIN	MAX	MIN	MAX	
Input Capacitance	C <sub>IN</sub>	V <sub>CC</sub> =Open, f=1MHz All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	15	-	15	pF
Output Capacitance	C <sub>OUT</sub>		1	T <sub>A</sub> = +25°C	-	15	-	15	pF
Output Disable Delay	T <sub>ODD</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	20	-	15	ns
Output Rise Time	T <sub>OR</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	7	-	6	ns
Output Fall Time	T <sub>OF</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	7	-	6	ns

NOTES:

1. The parameters listed in Table 3 are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design and after major process and/or design changes.

2. Loading is as specified in the test load circuit, C<sub>L</sub> = 40pF.

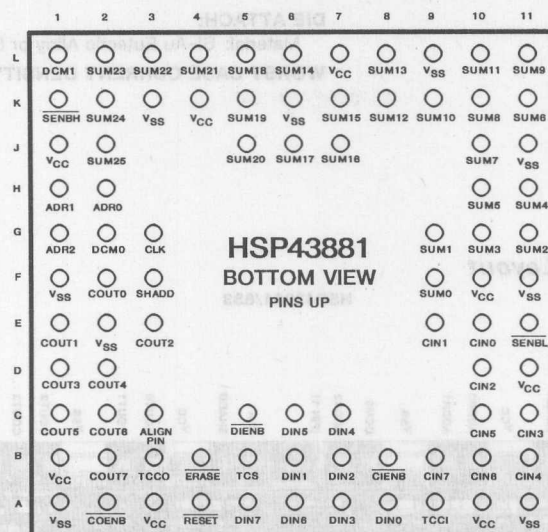
TABLE 4. APPLICABLE SUBGROUPS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9

**HSP43881/883**

### Burn-In Circuit

**HSP43881/883 PIN GRID ARRAY (PGA)**



PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
A1	V <sub>SS</sub>	GND	C1	COUT5	V <sub>CC</sub> /2	F10	V <sub>CC</sub>	V <sub>CC</sub>	K4	V <sub>CC</sub>	V <sub>CC</sub>
A2	COENB	F10	C2	COUT6	V <sub>CC</sub> /2	F11	V <sub>SS</sub>	GND	K5	SUM19	V <sub>CC</sub> /2
A3	V <sub>CC</sub>	V <sub>CC</sub>	C3	ALIGN	NC	G1	ADR2	F2	K6	V <sub>SS</sub>	GND
A4	RESET	F11	C5	DIENB	F10	G2	DCM0	F5	K7	SUM15	V <sub>CC</sub> /2
A5	DIN7	F8	C6	DIN5	F5	G3	CLK	F0	K8	SUM12	V <sub>CC</sub> /2
A6	DIN6	F6	C7	DIN4	F4	G9	SUM1	V <sub>CC</sub> /2	K9	SUM10	V <sub>CC</sub> /2
A7	DIN3	F3	C10	CIN5	F5	G10	SUM3	V <sub>CC</sub> /2	K10	SUM8	V <sub>CC</sub> /2
A8	DIN0	F0	C11	CIN3	F3	G11	SUM2	V <sub>CC</sub> /2	K11	SUM6	V <sub>CC</sub> /2
A9	CIN8/TCCI	F8	D1	COUT3	V <sub>CC</sub> /2	H1	ADR1	F1	L1	DCM1	F6
A10	V <sub>CC</sub>	V <sub>CC</sub>	D2	COUT4	V <sub>CC</sub> /2	H2	ADR0	F0	L2	SUM23	V <sub>CC</sub> /2
A11	V <sub>SS</sub>	GND	D10	CIN2	F2	H10	SUM5	V <sub>CC</sub> /2	L3	SUM22	V <sub>CC</sub> /2
B1	V <sub>CC</sub>	V <sub>CC</sub>	D11	V <sub>CC</sub>	V <sub>CC</sub>	H11	SUM4	V <sub>CC</sub> /2	L4	SUM21	V <sub>CC</sub> /2
B2	COUT7	V <sub>CC</sub> /2	E1	COUT1	V <sub>CC</sub> /2	J1	V <sub>CC</sub>	V <sub>CC</sub>	L5	SUM18	V <sub>CC</sub> /2
B3	COUT8/TCC0	V <sub>CC</sub> /2	E2	V <sub>SS</sub>	GND	J2	SUM25	V <sub>CC</sub> /2	L6	SUM14	V <sub>CC</sub> /2
B4	ERASE	F10	E3	COUT2	V <sub>CC</sub> /2	J5	SUM20	V <sub>CC</sub> /2	L7	V <sub>CC</sub>	V <sub>CC</sub>
B5	DIN8/TCS	F7	E9	CIN1	F1	J6	SUM17	V <sub>CC</sub> /2	L8	SUM13	V <sub>CC</sub> /2
B6	DIN1	F1	E10	CIN0	F0	J7	SUM16	V <sub>CC</sub> /2	L9	V <sub>SS</sub>	GND
B7	DIN2	F2	E11	SENB	F10	J10	SUM7	V <sub>CC</sub> /2	L10	SUM11	V <sub>CC</sub> /2
B8	CIENB	F10	F1	V <sub>SS</sub>	GND	J11	V <sub>SS</sub>	GND	L11	SUM9	V <sub>CC</sub> /2
B9	CIN7	F7	F2	COUT0	V <sub>CC</sub> /2	K1	SENBH	F10			
B10	CIN6	F6	F3	SHADD	F9	K2	SUM24	V <sub>CC</sub> /2			
B11	CIN4	F4	F9	SUM0	V <sub>CC</sub> /2	K3	V <sub>SS</sub>	GND			

## NOTES:

1.  $V_{CC}/2$  ( $2.7V \pm 10\%$ ) used for outputs only.
2.  $47K\Omega$  ( $\pm 20\%$ ) resistor connected to all pins except  $V_{CC}$  and GND.
3.  $V_{CC} = 5.5V \pm 0.5V$ .
4.  $0.1\mu F$  (min) capacitor between  $V_{CC}$  and GND per device.
5.  $F0 = 100kHz \pm 10\%$ ,  $F1 = F0/2$ ,  $F2 = F1/2 \dots$ ,  $F11 = F10/2$ , 40% - 60% Duty Cycle.
6. Input voltage Limits:  $V_{IH} = 0.8V$  Max,  $V_{IL} = 4.5V \pm 10\%$



**Die Characteristics****DIE DIMENSIONS:**

328 x 283 x 19 ±1 mils

**METALLIZATION:**

Type: Si-Al or Si-Al-Cu

Thickness: 8kÅ

**GLASSIVATION:**

Type: Nitrox

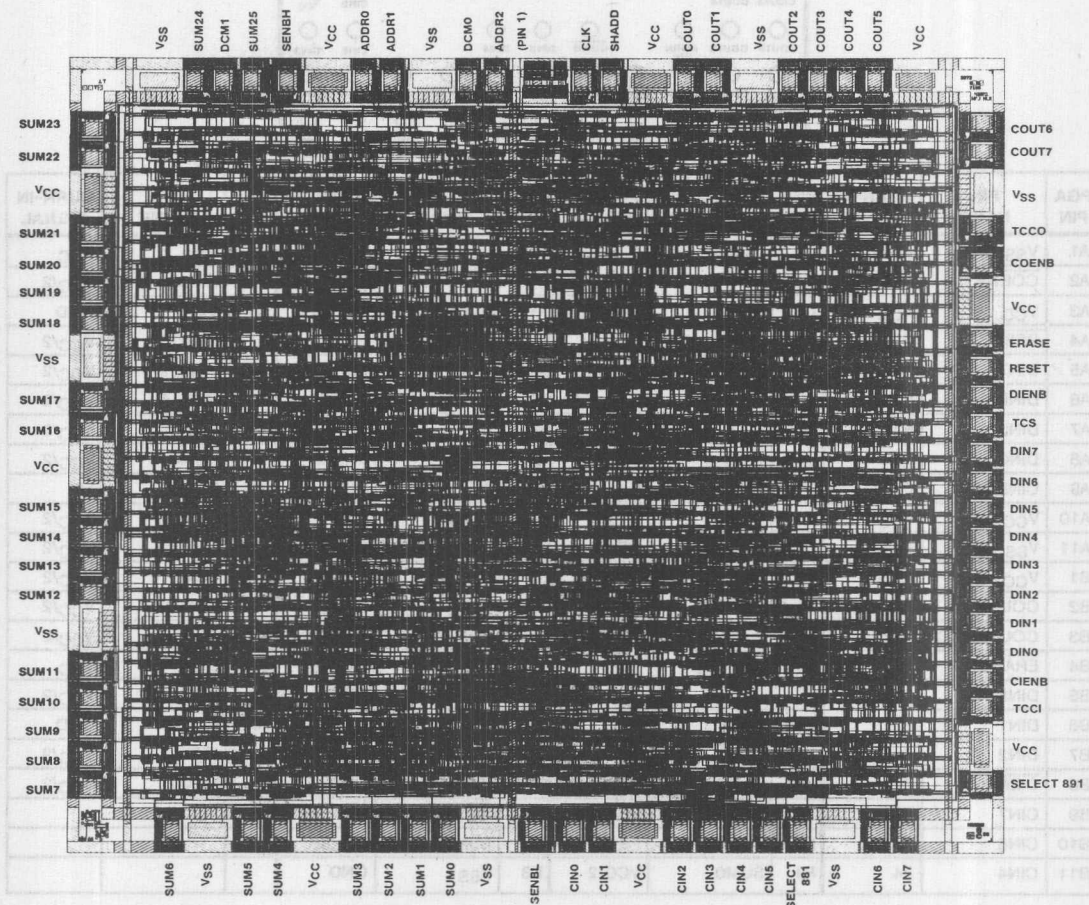
Thickness: 10kÅ

**DIE ATTACH:**

Material: Si-Au Eutectic Alloy or Silver-Glass

**WORST CASE CURRENT DENSITY:**  $1.2 \times 10^5 \text{ A/cm}^2$ **Metallization Mask Layout**

HSP43881/883



August 1992

Digital Filter

## Features

- Eight Filter Cells
- 0 to 30MHz Sample Rate
- 9-Bit Coefficients and Signal Data
- 26-Bit Accumulator per Stage
- Filter Lengths Over 1000 Taps
- Shift-and-Add Output Stage for Combining Filter Outputs
- Expandable Coefficient Size, Data Size and Filter Length
- Decimation by 2, 3 or 4
- CMOS Power Dissipation Characteristics

## Applications

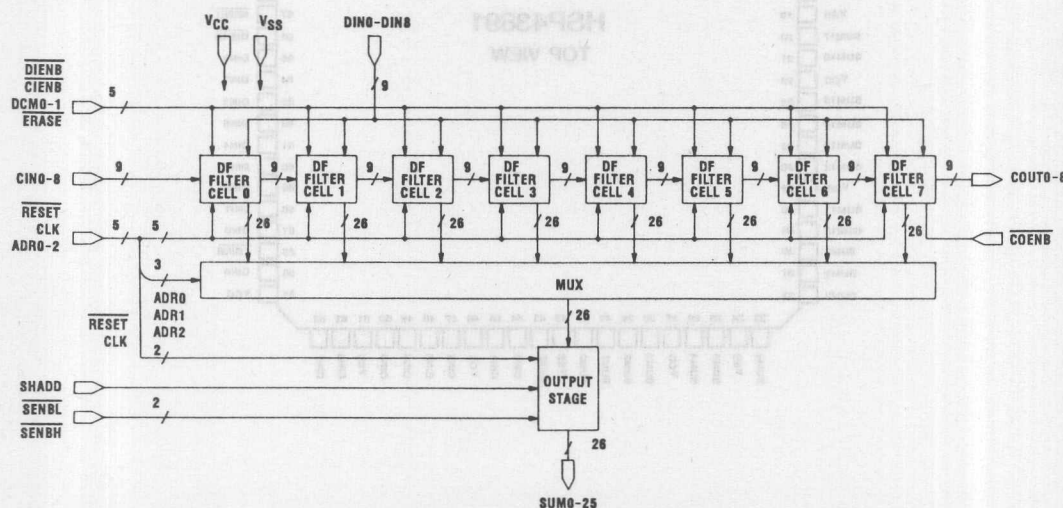
- 1-D and 2-D FIR Filters
- Radar/Sonar
- Digital Video and Audio
- Adaptive Filters
- Echo Cancellation
- Correlation/Convolution
- Complex Multiply-Add
- Butterfly Computation
- Matrix Multiplication
- Sample Rate Converters

## Description

The HSP43891 is a video-speed Digital Filter (DF) designed to efficiently implement vector operations such as FIR digital filters. It is comprised of eight filter cells cascaded internally and a shift and add output stage, all in a single integrated circuit. Each filter cell contains a 9x9 two's complement multiplier, three decimation registers and a 26-bit accumulator. The output stage contains an additional 26-bit accumulator which can add the contents of any filter cell accumulator to the output stage accumulator shifted right by 8 bits. The HSP43891 has a maximum sample rate of 30MHz. The effective multiply-accumulate (mac) rate is 240MHz. The HSP43891 DF can be configured to process expanded coefficient and word sizes. Multiple DFs can be cascaded for larger filter lengths without degrading the sample rate or a single DF can process larger filter lengths at less than 30MHz with multiple passes. The architecture permits processing filter lengths of over 1000 taps with the guarantee of no overflows. In practice, most filter coefficients are less than 1.0, making even larger filter lengths possible. The DF provides for 8-bit unsigned or 9-bit two's complement arithmetic, independently selectable for coefficients and signal data.

Each DF filter cell contains three re-sampling or decimation registers which permit output sample rate reduction at rates of 1/2, 1/3 or 1/4 the input sample rate. These registers also provide the capability to perform 2-D operations such as matrix multiplication and NxN spatial correlations/convolutions for image processing applications.

## Block Diagram



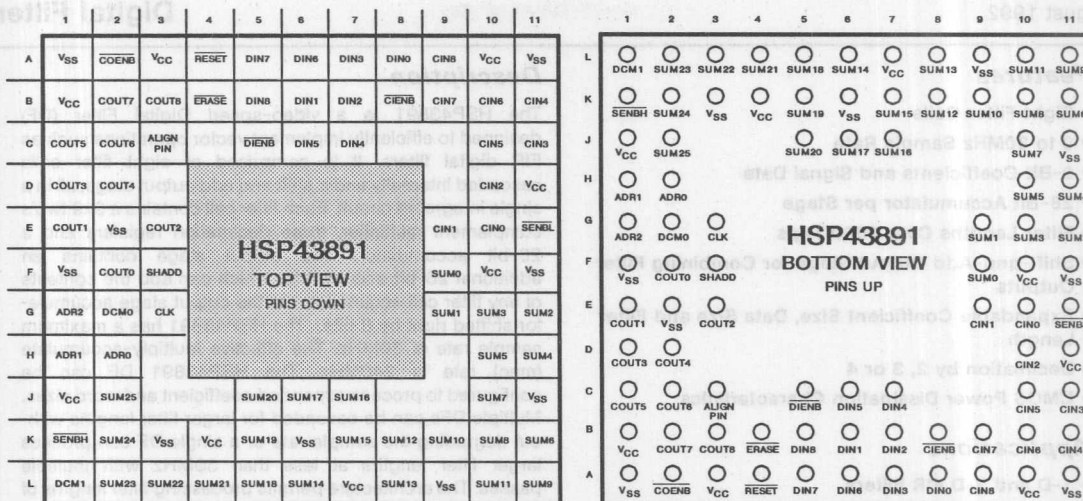
CAUTION: These devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
Copyright © Harris Corporation 1992

File Number **2785.2**

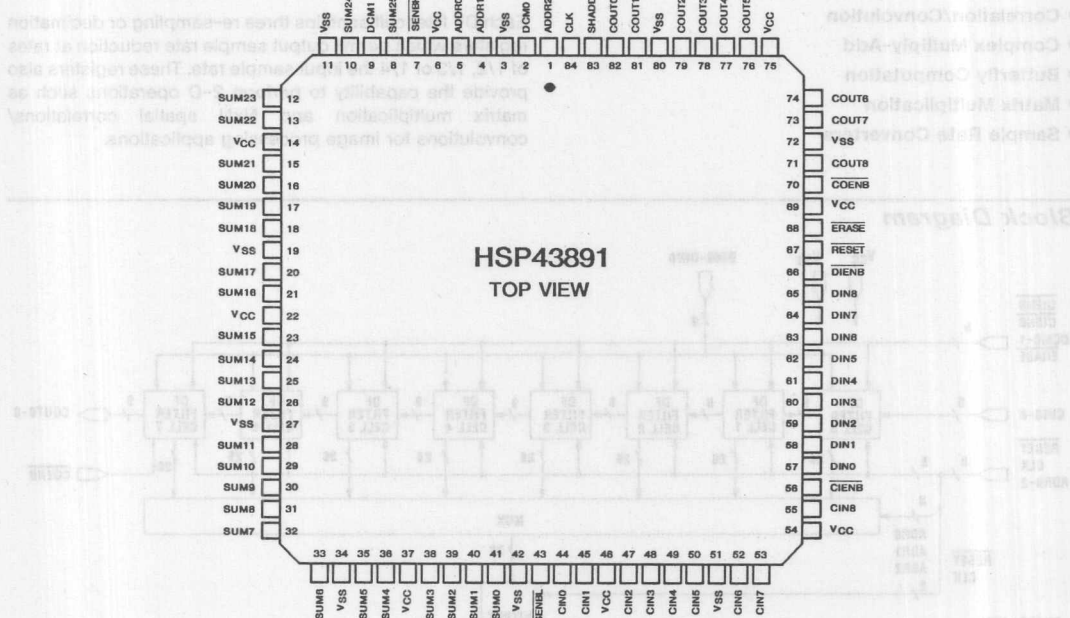
# HSP43891

## Pinouts

### 85 PIN GRID ARRAY (PGA)



### 84 PIN PLASTIC LEADED CHIP CARRIER (PLCC)



## Pin Description

SYMBOL	PIN NUMBER	TYPE	NAME AND FUNCTION															
V <sub>CC</sub>	B1, J1, A3, K4, L7, A10, F10, D11	I	+5 power supply input															
V <sub>SS</sub>	A1, F1, E2, K3, K6, L9, A11, E11, H11	I	Power supply ground input.															
CLK	G3	I	The CLK input provides the DF system sample clock. The maximum clock frequency is 30MHz.															
DINO-8	A5-8, B5-7, C6, C7	I	<p>These nine inputs are the data sample input bus. Nine-bit data samples are synchronously loaded through these pins to the X register of each filter cell of the DF simultaneously. The DIENB signal enables loading, which is synchronous on the rising edge of the clock signal.</p> <p>The data samples can be either 9-bit two's complement or 8-bit unsigned values. For 9-bit two's complement values, DIN8 is the sign bit. For 8-bit unsigned values, DIN8 must be held at logical zero.</p>															
DIENB	C5	I	A low on this input enables the data sample input bus (DINO-8) to all the filter cells. A rising edge of the CLK signal occurring while DIENB is low will load the X register of every filter cell with the 9-bit value present on DINO-8. A high on this input forces all the bits of the data sample input bus to zero; a rising CLK edge when DIENB is high will load the X register of every filter cell with all zeros. This signal is latched inside the device, delaying its effect by one clock internal to the device. Therefore it must be low during the clock cycle immediately preceding presentation of the desired data on the DINO-8 inputs. Detailed operation is shown in later timing diagrams.															
CINO-8	A9, B9-11, C10, C11, D10, E9, E10	I	<p>These nine inputs are used to input the 9-bit coefficients. The coefficients are synchronously loaded into the C register of filter CELL0 if a rising edge of CLK occurs while CIENB is low. The CIENB signal is delayed by one clock as discussed below.</p> <p>The coefficients can be either 9-bit two's complement or 8-bit unsigned values. For 9-bit two's complement values, CIN8 is the sign bit. For 8-bit unsigned values, CIN8 must be held at logical zero.</p>															
ALIGN PIN	C3		Used for aligning chip on socket or printed circuit board. This pin must be left as a no connect in circuit.															
CIENB	B8	I	A low on this input enables the C register of every filter cell and the D (decimation) registers of every filter cell according to the state of the DCM0-1 inputs. A rising edge of the CLK signal occurring while CIENB is low will load the C register and appropriate D registers with the coefficient data present at their inputs. This provides the mechanism for shifting coefficients from cell to cell through the device. A high on this input freezes the contents of the C register and the D registers, ignoring the CLK signal. This signal is latched and delayed by one clock internal to the DF. Therefore it must be low during the clock cycle immediately preceding presentation of the desired coefficient on the CINO-8 inputs. Detailed operation is shown in later timing diagrams.															
COUT0-8	B2, B3, C1, D1, E1, C2, D2, F2, E3	O	These nine three-state outputs are used to output the 9-bit coefficients from filter CELL7. These outputs are enabled by the COENB signal low. These outputs may be tied to the CINO-8 inputs of the same DF to recirculate to coefficients, or they may be tied to the CINO-8 inputs of another DF to cascade DFs for longer filter lengths.															
COENB	A2	I	A low on the COENB input enables the COUT0-8 outputs. A high on this input places all these outputs in their high impedance state.															
DCM0-1	L1, G2	I	<p>These two inputs determine the use of the internal decimation registers as follows:</p> <table><tr><th>DCM1</th><th>DCM0</th><th>DECIMATION FUNCTION</th></tr><tr><td>0</td><td>0</td><td>Decimation registers not used</td></tr><tr><td>0</td><td>1</td><td>One decimation register is used</td></tr><tr><td>1</td><td>0</td><td>Two decimation registers are used</td></tr><tr><td>1</td><td>1</td><td>Three decimation registers are used</td></tr></table>	DCM1	DCM0	DECIMATION FUNCTION	0	0	Decimation registers not used	0	1	One decimation register is used	1	0	Two decimation registers are used	1	1	Three decimation registers are used
DCM1	DCM0	DECIMATION FUNCTION																
0	0	Decimation registers not used																
0	1	One decimation register is used																
1	0	Two decimation registers are used																
1	1	Three decimation registers are used																



## Pin Description (Continued)

SYMBOL	PIN NUMBER	TYPE	NAME AND FUNCTION
DCM0-1 (Cont.)	L1, G2	I	The coefficients pass from cell to cell at a rate determined by the number of decimation registers used. When no decimation registers are used, coefficients move from cell to cell on each clock. When one decimation register is used, coefficients move from cell to cell on every other clock, etc. These signals are latched and delayed by one clock internal to the device.
SUM0-25	J2, J5-8, J10, K2, K5-11 L2-6, L8, L10, L11	O	These 26 three-state outputs are used to output the results of the internal filter cell computations. Individual filter cell results or the result of the shift-and-add output stage can be output. If an individual filter cell result is to be output, the ADRO-2 signals select the filter cell result. The SHADD signal determines whether the selected filter cell result or the output stage adder result is output. The signals SENBH and SENBL enable the most significant and least significant bits of the SUM0-25 result respectively. Both SENBH and SENBL may be enabled simultaneously if the system has a 26-bit or larger bus. However individual enables are provided to facilitate use with a 16-bit bus.
SENBH	K1	I	A low on this input enables result bits SUM16-25. A high on this input places these bits in their high impedance state.
SENL	E11	I	A low on this input enables result bits SUM0-15. A high on this input places these bits in their high impedance state.
ADRO-2	G1, H1, H2	I	These three inputs select the one cell whose accumulator will be read through the output bus (SUM0-25) or added to the output stage accumulator. They also determine which accumulator will be cleared when ERASE is low. These inputs are latched in the DF and delayed by one clock internal to the device. If ADRO-2 remains at the same address for more than one clock, the output at SUM0-25 will not change to reflect any subsequent accumulator updates in the addressed cell. Only the result available during the first clock, when ADRO-2 selects the cell, will be output. This does not hinder normal operation since the ADRO-2 lines are changed sequentially. This feature facilitates the interface with slow memories where the output is required to be fixed for more than one clock.
SHADD	F3	I	The SHADD input controls the activation of the shift and add operation in the output stage. This signal is latched on chip and delayed by one clock internal to the device. Detailed explanation is given in the DF Output Stage section.
RESET	A4	I	A low on this input synchronously clears all the internal registers, except the cell accumulators. It can be used with ERASE to also clear all the accumulators simultaneously. This signal is latched in the DF and delayed by one clock internal to the device.
ERASE	B4	I	A low on this input synchronously clears the cell accumulator selected by the ADRO-2 signals. If RESET is also low simultaneously, all cell accumulators are cleared.

## Functional Description

The Digital Filter Processor (DF) is composed of eight filter cells cascaded together and an output stage for combining or selecting filter cell outputs (See Block Diagram). Each filter cell contains a multiplier-accumulator and several registers (Figure 1). Each 9-bit coefficient is multiplied by a 9-bit data sample, with the result added to the 26-bit accumulator contents. The coefficient output of each cell is cascaded to the coefficient input of the next cell to its right.

### DF Filter Cell

A 9-bit coefficient (CINO-8) enters each cell through the C register on the left and exits the cell on the right as signals COUT0-8. With no decimation, the coefficient moves directly from the C register to the output, and is valid on the clock following its entrance. When decimation is selected the coefficient exit is delayed by 1, 2 or 3 clocks by passing through one or more decimation registers (D1, D2 or D3).

The combination of D registers through which the coefficient passes is determined by the state of DCM0 and DCM1. The output signals (COUT0-8) are connected to the CINO-8 inputs of the next cell to its right. The  $\overline{\text{COENB}}$  input signal enables the COUT0-8 outputs of the right most cell to the COUT0-8 pins of the device.

The C and D registers are enabled for loading by  $\overline{\text{CIENB}}$ . Loading is synchronous with CLK when  $\overline{\text{CIENB}}$  is low. Note that  $\overline{\text{CIENB}}$  is latched internally. It enables the register for loading after the next CLK following the onset of  $\overline{\text{CIENB}}$  low. Actual loading occurs on the second CLK following the onset of  $\overline{\text{CIENB}}$  low. Therefore  $\overline{\text{CIENB}}$  must be low during the clock cycle immediately preceding presentation of the coefficient on the CINO-8 inputs. In most basic FIR operations,  $\overline{\text{CIENB}}$  will be low throughout the process, so this latching and delay sequence is only important during the initialization phase. When  $\overline{\text{CIENB}}$  is high, the coefficients are frozen.

These registers are cleared synchronously under control of  $\overline{\text{RESET}}$ , which is latched and delayed exactly like  $\overline{\text{CIENB}}$ .

The output of the C register (C0-8) is one input to 9x9 multiplier.

The other input to the 9x9 multiplier comes from the output of the X register. This register is loaded with a data sample from the device input signals DINO-8 discussed above. The X register is enabled for loading by  $\overline{\text{DIENB}}$ . Loading is synchronous with CLK when  $\overline{\text{DIENB}}$  is low. Note that  $\overline{\text{DIENB}}$  is latched internally. It enables the register for loading after the next CLK following the onset of  $\overline{\text{DIENB}}$  low. Actual loading occurs on the second CLK following the onset of  $\overline{\text{DIENB}}$  low; therefore,  $\overline{\text{DIENB}}$  must be low during the clock cycle immediately preceding presentation of the data sample on the DINO-8 inputs. In most basic FIR operations,  $\overline{\text{DIENB}}$  will be low throughout the process, so this latching and delay sequence is only important during the initialization phase. When  $\overline{\text{DIENB}}$  is high, the X register is loaded with all zeros.

The multiplier is pipelined and is modeled as a multiplier core followed by two pipeline registers, MREG0 and MREG1 (Figure 1). The multiplier output is sign extended and input as one operand of the 26-bit adder. The other adder operand is the output of the 26-bit accumulator. The

adder output is loaded synchronously into both the accumulator and the TREG.

The TREG loading is disabled by the cell select signal,  $\text{CELLn}$ , where n is the cell number. The cell select is decoded from the ADRO-2 signals to generate the TREG load enable. The cell select is inverted and applied as the load enable to the TREG. Operation is such that the TREG is loaded whenever the cell is not selected. Therefore, TREG is loaded every clock except the clock following cell selection. The purpose of the TREG is to hold the result of a sum-of-products calculation during the clock when the accumulator is cleared to prepare for the next sum-of-products calculation. This allows continuous accumulation without wasting clocks.

The accumulator is loaded with the adder output every clock unless it is cleared. It is cleared synchronously in two ways. When  $\overline{\text{RESET}}$  and  $\overline{\text{ERASE}}$  are both low, the accumulator is cleared along with all other registers on the device. Since  $\overline{\text{ERASE}}$  and  $\overline{\text{RESET}}$  are latched and delayed one clock internally, clearing occurs on the second CLK following the onset of both  $\overline{\text{ERASE}}$  and  $\overline{\text{RESET}}$  low.

The second accumulator clearing mechanism clears a single accumulator in a selected cell. The cell select signal,  $\text{CELLn}$ , decoded from ADRO-2 and the  $\overline{\text{ERASE}}$  signal enable clearing of the accumulator on the next CLK.

The  $\overline{\text{ERASE}}$  and  $\overline{\text{RESET}}$  signals clear the DF internal registers and states as follows:

ERASE	RESET	CLEARING EFFECT
1	1	No clearing occurs, internal state remains same.
1	0	$\overline{\text{RESET}}$ only active, all registers except accumulators are cleared, including the internal pipeline registers.
0	1	$\overline{\text{ERASE}}$ only active, the accumulator whose address is given by the ADRO-2 inputs is cleared.
0	0	Both $\overline{\text{RESET}}$ and $\overline{\text{ERASE}}$ active, all accumulators as well as all other registers are cleared.

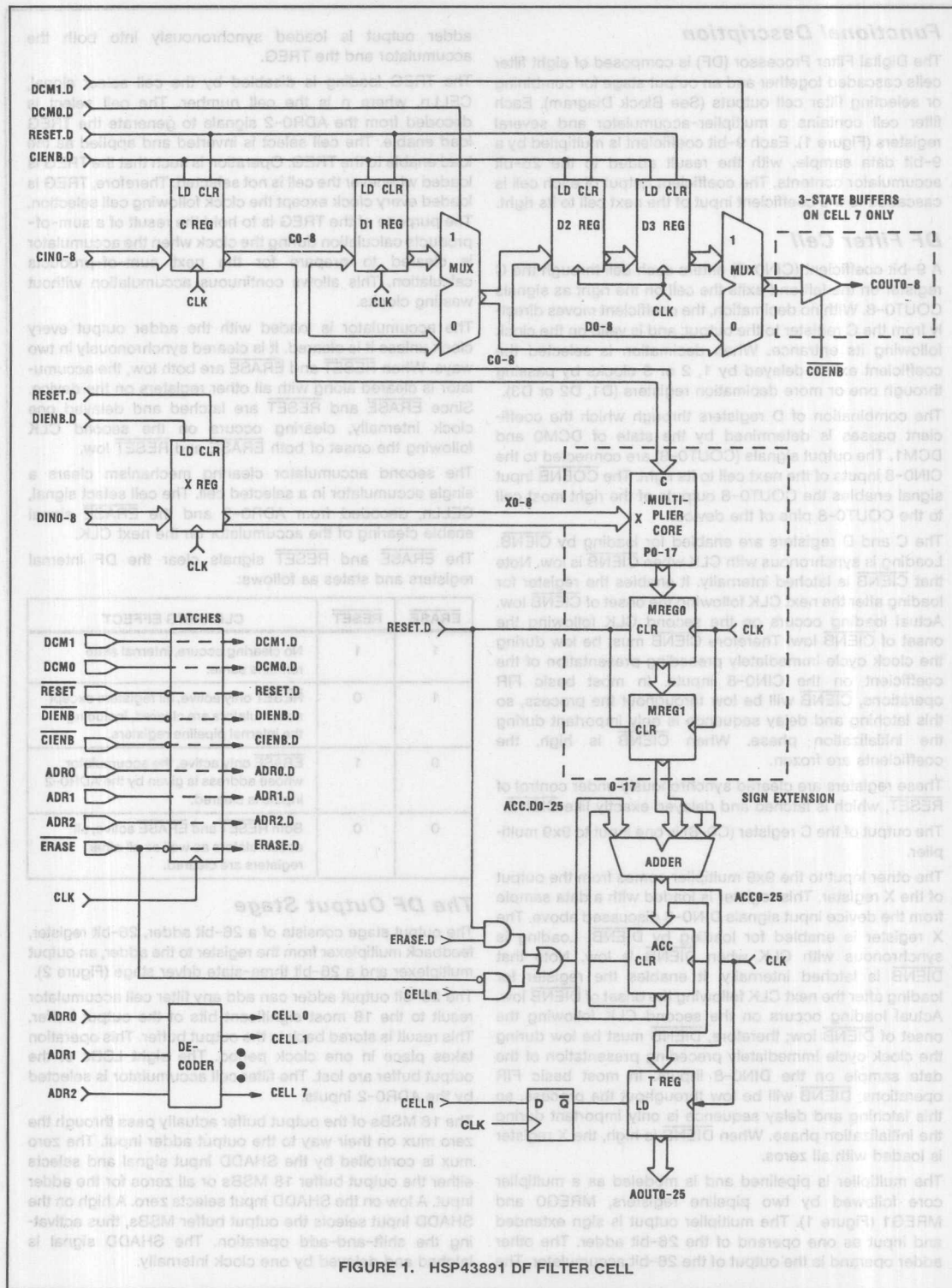
### The DF Output Stage

The output stage consists of a 26-bit adder, 26-bit register, feedback multiplexer from the register to the adder, an output multiplexer and a 26-bit three-state driver stage (Figure 2).

The 26-bit output adder can add any filter cell accumulator result to the 18 most significant bits of the output buffer. This result is stored back in the output buffer. This operation takes place in one clock period. The eight LSBs of the output buffer are lost. The filter cell accumulator is selected by the ADRO-2 inputs.

The 18 MSBs of the output buffer actually pass through the zero mux on their way to the output adder input. The zero mux is controlled by the SHADD input signal and selects either the output buffer 18 MSBs or all zeros for the adder input. A low on the SHADD input selects zero. A high on the SHADD input selects the output buffer MSBs, thus activating the shift-and-add operation. The SHADD signal is latched and delayed by one clock internally.

# HSP43891



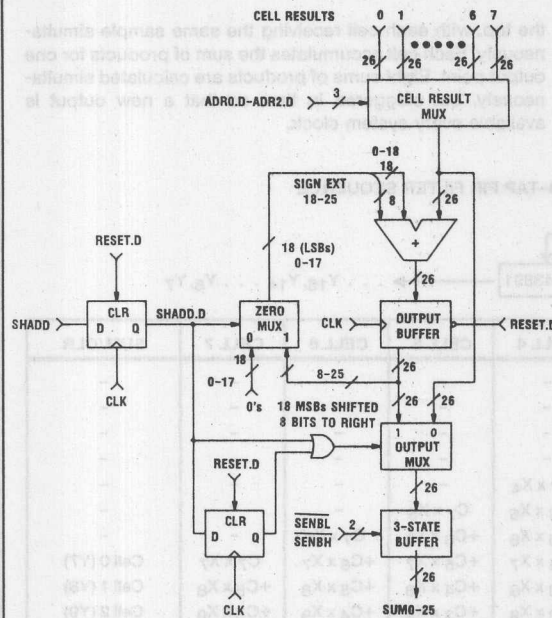


FIGURE 2. HSP43891 DFP OUTPUT STAGE

The 26 least significant bits (LSBs) from either a cell accumulator or the output buffer are output on the SUM0-25 bus. The output mux determines whether the cell accumulator selected by ADRO-2 or the output buffer is output to the bus. This mux is controlled by the SHADD input signal. Control is based on the state of the SHADD during two successive clocks; in other words, the output mux selection contains memory. If SHADD is low during a clock cycle and was low during the previous clock, the output mux selects the contents of the filter cell accumulator addressed by ADRO-2. Otherwise the output mux selects the contents of the output buffer.

If the ADRO-2 lines remain at the same address for more than one clock, the output at SUM0-25 will not change to reflect any subsequent accumulator updates in the addressed cell. Only the result available during the first clock when ADRO-2 selects the cell will be output.

This does not hinder normal FIR operation since the ADRO-2 lines are changed sequentially. This feature facilitates the interface with slow memories where the output is required to be fixed for more than one clock.

The SUM0-25 output bus is controlled by the SENBH and SENBL signals. A low on SENBL enables bits SUM0-15. A low on SENBH enables bits SUM16-25. Thus all 26 bits can be output simultaneously if the external system has a 26-bit or larger bus. If the external system bus is only 16 bits, the bits can be enabled in two groups of 16 and 10 bits (sign extended).

### DF Arithmetic

Both data samples and coefficients can be represented as either 8-bit unsigned or 9-bit two's complement numbers. The 9x9 bit multiplier in each cell expects 9-bit two's complement operands. The binary format of 8-bit two's complement is shown below. Note that if the most significant or sign bit is held at logical zero, the 9-bit two's complement multiplier can multiply 8-bit unsigned operands. Only the upper (positive) half of the two's complement binary range is used.

The multiplier output is 18 bits and the accumulator is 26 bits. The accumulator width determines the maximum possible number of terms in the sum of products without overflow. The maximum number of terms depends also on the number system and the distribution of the coefficient and data values. Then maximum numbers of terms in the sum products are:

NUMBER SYSTEM	MAX # OF TERMS	
	8-BIT	9-BIT
Two unsigned vectors	1032	N/A
Two two's complement vectors:		
• Two positive vectors	2080	1032
• Negative vectors	2047	1024
• One positive and one negative vector	2064	1028
One unsigned 8 bit vector and one two's complement vector:		
• Positive two's complement vector	1036	1032
• Negative two's complement vector	1028	1028

For practical FIR filters, the coefficients are never all near maximum value, so even larger vectors are possible in practice.



### Basic FIR Operation

A simple, 30MHz 8-tap filter example serves to illustrate more clearly the operation of the DF. The sequence table (Table 1) shows the results of the multiply accumulate in each cell after each clock. The coefficient sequence,  $C_n$ , enters the DF on the left and moves from left to right through the cells. The data sample sequence,  $X_n$ , enters the DF from

the top, with each cell receiving the same sample simultaneously. Each cell accumulates the sum of products for one output point. Eight sums of products are calculated simultaneously, but staggered in time so that a new output is available every system clock.

TABLE 1. HSP43891 30MHz, 8-TAP FIR FILTER SEQUENCE

$X_{15} \dots X_9, X_8, X_7 \dots X_1, X_0$   
 $C_0 \dots C_6, C_7, C_0 \dots C_6, C_7 \rightarrow$

CLK	CELL 0	CELL 1	CELL 2	CELL 3	CELL 4	CELL 5	CELL 6	CELL 7	SUM/CLR
0	$C_7 \times X_0$	0	0	0	-	-	-	-	-
1	$+C_6 \times X_1$	$C_7 \times X_1$	0	0	-	-	-	-	-
2	$+C_5 \times X_2$	$+C_6 \times X_2$	$C_7 \times X_2$	0	-	-	-	-	-
3	$+C_4 \times X_3$	$+C_5 \times X_3$	$+C_6 \times X_3$	$C_7 \times X_3$	-	-	-	-	-
4	$+C_3 \times X_4$	$+C_4 \times X_4$	$+C_5 \times X_4$	$+C_6 \times X_4$	$C_7 \times X_4$	-	-	-	-
5	$+C_2 \times X_5$	$+C_3 \times X_5$	$+C_4 \times X_5$	$+C_5 \times X_5$	$+C_6 \times X_5$	$C_7 \times X_5$	-	-	-
6	$+C_1 \times X_6$	$+C_2 \times X_6$	$+C_3 \times X_6$	$+C_4 \times X_6$	$+C_5 \times X_6$	$+C_6 \times X_6$	$C_7 \times X_6$	-	-
7	$+C_0 \times X_7$	$+C_1 \times X_7$	$+C_2 \times X_7$	$+C_3 \times X_7$	$+C_4 \times X_7$	$+C_5 \times X_7$	$+C_6 \times X_7$	$C_7 \times X_7$	Cell 0 (Y7)
8	$C_7 \times X_8$	$+C_0 \times X_8$	$+C_1 \times X_8$	$+C_2 \times X_8$	$+C_3 \times X_8$	$+C_4 \times X_8$	$+C_5 \times X_8$	$+C_6 \times X_8$	Cell 1 (Y8)
9	$+C_6 \times X_9$	$C_7 \times X_9$	$+C_0 \times X_9$	$+C_1 \times X_9$	$+C_2 \times X_9$	$+C_3 \times X_9$	$+C_4 \times X_9$	$+C_5 \times X_9$	Cell 2 (Y9)
10	$+C_5 \times X_{10}$	$+C_6 \times X_{10}$	$C_7 \times X_{10}$	$+C_0 \times X_{10}$	$+C_1 \times X_{10}$	$+C_2 \times X_{10}$	$+C_3 \times X_{10}$	$+C_4 \times X_{10}$	Cell 3 (Y10)
11	$+C_4 \times X_{11}$	$+C_5 \times X_{11}$	$+C_6 \times X_{11}$	$C_7 \times X_{11}$	$+C_0 \times X_{11}$	$+C_1 \times X_{11}$	$+C_2 \times X_{11}$	$+C_3 \times X_{11}$	Cell 4 (Y11)
12	$+C_3 \times X_{12}$	$+C_4 \times X_{12}$	$+C_5 \times X_{12}$	$+C_6 \times X_{12}$	$C_7 \times X_{12}$	$+C_0 \times X_{12}$	$+C_1 \times X_{12}$	$+C_2 \times X_{12}$	Cell 5 (Y12)
13	$+C_2 \times X_{13}$	$+C_3 \times X_{13}$	$+C_4 \times X_{13}$	$+C_5 \times X_{13}$	$+C_6 \times X_{13}$	$C_7 \times X_{13}$	$+C_0 \times X_{13}$	$+C_1 \times X_{13}$	Cell 6 (Y13)
14	$+C_1 \times X_{14}$	$+C_2 \times X_{14}$	$+C_3 \times X_{14}$	$+C_4 \times X_{14}$	$+C_5 \times X_{14}$	$+C_6 \times X_{14}$	$+C_7 \times X_{14}$	$+C_0 \times X_{14}$	Cell 7 (Y14)
15	$+C_0 \times X_{15}$	$+C_1 \times X_{15}$	$+C_2 \times X_{15}$	$+C_3 \times X_{15}$	$+C_4 \times X_{15}$	$+C_5 \times X_{15}$	$+C_6 \times X_{15}$	$C_7 \times X_{15}$	Cell 0 (Y15)

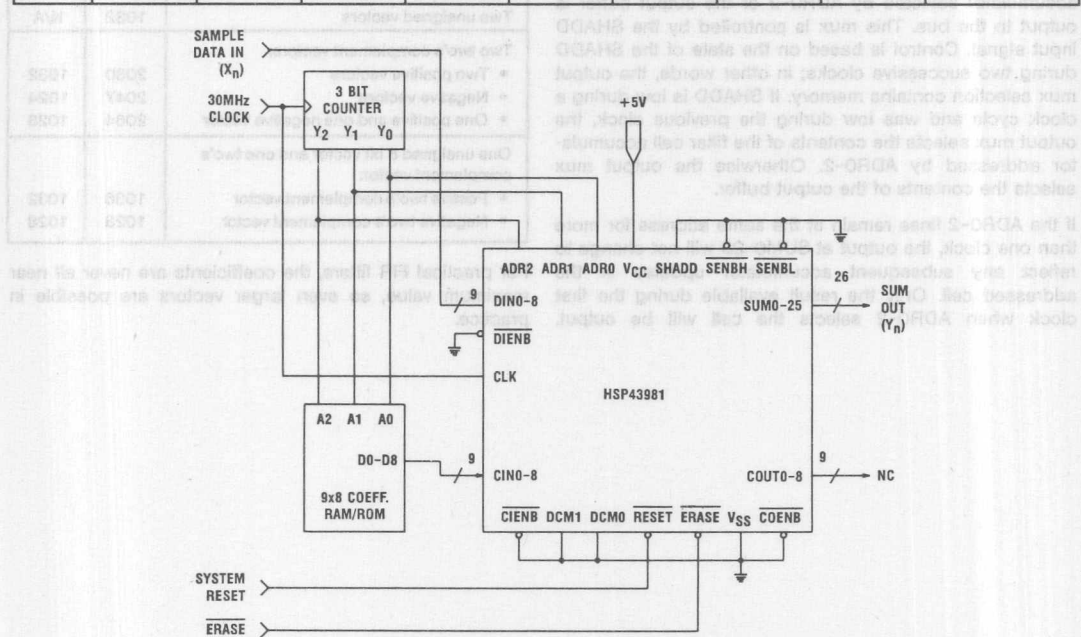


FIGURE 3. HSP43891 30MHz, 8-TAP FIR FILTER APPLICATION SCHEMATIC

Detailed operation of the DF to perform a basic 8-tap, 9-bit coefficient, 9-bit data, 30MHz FIR filter is best understood by observing the schematic (Figure 3) and timing diagram (Figure 4). The internal pipeline length of the DF is four (4) clock cycles, corresponding to the register levels CREG (or XREG), MREG0, MREG1, and TREG (Figures 1 and 2). Therefore the delay from presentation of data and coefficients at the DINO-8 and CINO-8 inputs to a sum appearing at the SUM0-25 output is:  $k + T_d$ , where  $k$  = filter length and  $T_d = 4$ , the internal pipeline delay of the DF.

After the pipeline has filled, a new output sample is available every clock. The delay to last sample output from last sample input is  $T_d$ .

The output sums,  $Y_n$ , shown in the timing diagram are derived from the sum-of-products equation:

$$Y(n) = C(0) \times X(n) + C(1) \times X(n-1) + C(2) \times X(n-2) + C(3) \times X(n-3) + C(4) \times X(n-4) + C(5) \times X(n-5) + C(6) \times X(n-6) + C(7) \times X(n-7)$$

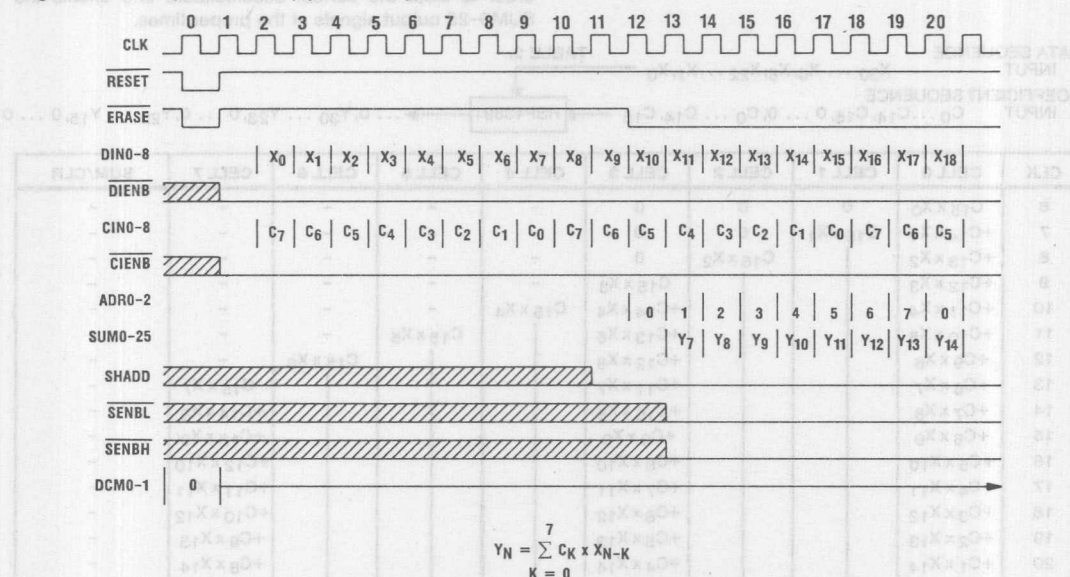


FIGURE 4. HSP43891 30MHz, 8-TAP FIR FILTER TIMING

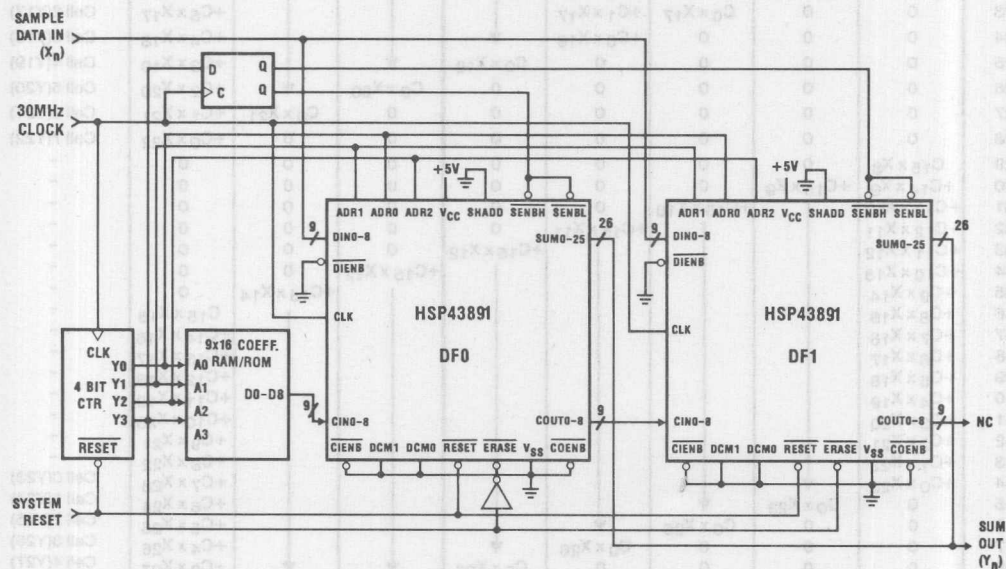


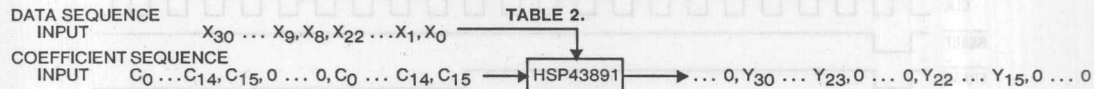
FIGURE 5. HSP43891 30MHz, 16-TAP FIR FILTER CASCADE APPLICATION SCHEMATIC

**Extended FIR Filter Length**

Filter lengths greater than eight taps can be created by either cascading together multiple DF devices or "reusing" a single device. Using multiple devices, an FIR filter of over 1000 taps can be constructed to operate at a 30MHz sample rate. Using a single device clocked at 30MHz, an FIR filter of over 500 taps can be constructed to operate at less than a 30MHz sample rate. Combinations of these two techniques are also possible.

**Cascade Configuration**

To design a filter length  $L > 8$ , L/8 DFs are cascaded by connecting the COUT0-8 outputs of the (i)th DF to the CINO-8 inputs of the (i+1)th DF. The DINO-8 inputs and SUM0-25 outputs of all the DFs are also tied together. A specific example of two cascaded DFs illustrates the technique (Figure 5). Timing (Figure 6) is similar to the simple 8-tap FIR, except the ERASE and SENBL/SENBH signals must be enabled independently for the two DFs in order to clear the correct accumulators and enable the SUM0-25 output signals at the proper times.



CLK	CELL 0	CELL 1	CELL 2	CELL 3	CELL 4	CELL 5	CELL 6	CELL 7	SUM/CLR
6	$C_{15} \times X_0$	0	0	0	-	-	-	-	-
7	$+C_{14} \times X_1$	$C_{15} \times X_1$	0	0	-	-	-	-	-
8	$+C_{13} \times X_2$		$C_{15} \times X_2$	0	-	-	-	-	-
9	$+C_{12} \times X_3$			$C_{15} \times X_3$	-	-	-	-	-
10	$+C_{11} \times X_4$			$+C_{14} \times X_4$	$C_{15} \times X_4$	-	-	-	-
11	$+C_{10} \times X_5$			$+C_{13} \times X_5$		$C_{15} \times X_5$	-	-	-
12	$+C_9 \times X_6$			$+C_{12} \times X_6$			$C_{15} \times X_6$	-	-
13	$+C_8 \times X_7$			$+C_{11} \times X_7$				$C_{15} \times X_7$	-
14	$+C_7 \times X_8$			$+C_{10} \times X_8$				$+C_{14} \times X_8$	-
15	$+C_6 \times X_9$			$+C_9 \times X_9$				$+C_{13} \times X_9$	-
16	$+C_5 \times X_{10}$			$+C_8 \times X_{10}$				$+C_{12} \times X_{10}$	-
17	$+C_4 \times X_{11}$			$+C_7 \times X_{11}$				$+C_{11} \times X_{11}$	-
18	$+C_3 \times X_{12}$			$+C_6 \times X_{12}$				$+C_{10} \times X_{12}$	-
19	$+C_2 \times X_{13}$			$+C_5 \times X_{13}$				$+C_9 \times X_{13}$	-
20	$+C_1 \times X_{14}$			$+C_4 \times X_{14}$				$+C_8 \times X_{14}$	-
21	$+C_0 \times X_{15}$			$+C_3 \times X_{15}$				$+C_7 \times X_{15}$	Cell 0(Y15)
22	0	$C_0 \times X_{16}$		$+C_2 \times X_{16}$				$+C_6 \times X_{16}$	Cell 1(Y16)
23	0	0	$C_0 \times X_{17}$	$+C_1 \times X_{17}$				$+C_5 \times X_{17}$	Cell 2(Y17)
24	0	0	0	$+C_0 \times X_{18}$				$+C_4 \times X_{18}$	Cell 3(Y18)
25	0	0	0	0	$C_0 \times X_{19}$			$+C_3 \times X_{19}$	Cell 4(Y19)
26	0	0	0	0	0	$C_0 \times X_{20}$		$+C_2 \times X_{20}$	Cell 5(Y20)
27	0	0	0	0	0	0	$C_0 \times X_{21}$	$+C_1 \times X_{21}$	Cell 6(Y21)
28	0	0	0	0	0	0	0	$+C_0 \times X_{22}$	Cell 7(Y22)
29	$C_{15} \times X_8$	0	0	0	0	0	0	0	-
30	$+C_{14} \times X_9$	$+C_{15} \times X_9$	0	0	0	0	0	0	-
31	$+C_{13} \times X_{10}$		$+C_{15} \times X_{10}$	0	0	0	0	0	-
32	$+C_{12} \times X_{11}$			$+C_{15} \times X_{11}$	0	0	0	0	-
33	$+C_{11} \times X_{12}$				$+C_{15} \times X_{12}$	0	0	0	-
34	$+C_{10} \times X_{13}$					$+C_{15} \times X_{12}$	0	0	-
35	$+C_9 \times X_{14}$						$+C_{15} \times X_{14}$	0	-
36	$+C_8 \times X_{15}$							$C_{15} \times X_{15}$	-
37	$+C_7 \times X_{16}$							$+C_{14} \times X_{16}$	-
38	$+C_6 \times X_{17}$							$+C_{13} \times X_{17}$	-
39	$+C_5 \times X_{18}$							$+C_{12} \times X_{18}$	-
40	$+C_4 \times X_{19}$							$+C_{11} \times X_{19}$	-
41	$+C_3 \times X_{20}$							$+C_{10} \times X_{20}$	-
42	$+C_2 \times X_{21}$							$+C_9 \times X_{21}$	-
43	$+C_1 \times X_{22}$							$+C_8 \times X_{22}$	-
44	$+C_0 \times X_{23}$							$+C_7 \times X_{23}$	Cell 0(Y23)
45	0	$C_0 \times X_{23}$						$+C_6 \times X_{24}$	Cell 1(Y24)
46	0	0	$C_0 \times X_{25}$					$+C_5 \times X_{25}$	Cell 2(Y25)
47	0	0	0	$C_0 \times X_{26}$				$+C_4 \times X_{26}$	Cell 3(Y26)
48	0	0	0	0	$C_0 \times X_{27}$			$+C_3 \times X_{27}$	Cell 4(Y27)

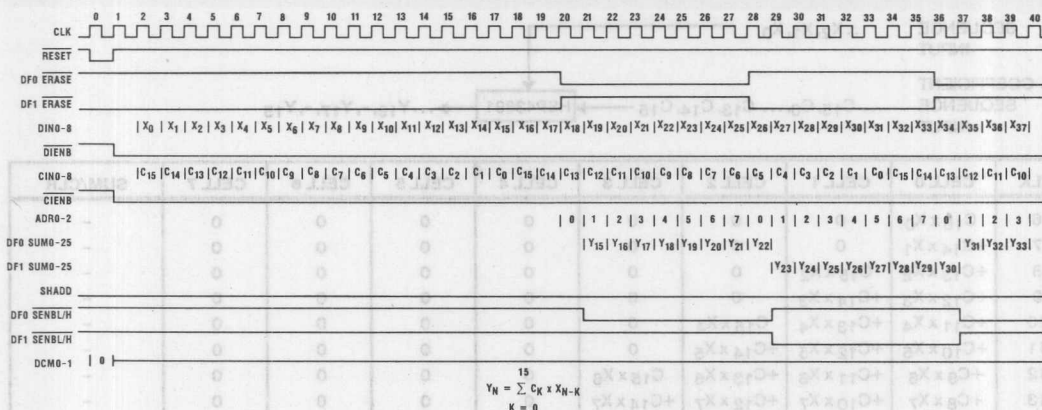


FIGURE 6. HSP43891 16-TAP 30MHz FILTER TIMING USING TWO CASCADED HSP43891s

### Single DF Configuration

Using a single DF, a filter of length  $L > 8$  can be constructed by processing in  $L/8$  passes, as illustrated in Table 2, for a 16-tap FIR. Each pass is composed of  $T_p = 7 + L$  cycles and computes eight output samples. In pass  $i$ , the sample with indices  $i*8$  to  $i*8 + (L-1)$  enter the DINO-8 inputs. The coefficients  $C_0 - C_{L-1}$  enter the CINO-8 inputs, followed by seven zeros. As these zeros are entered, the result samples are output and the accumulators reset. Initial filling of the pipeline is not shown in this sequence table. Filter outputs can be put through a FIFO to even out the sample rate.

### Extended Coefficient and Data Sample Word Size

The sample and coefficient word size can be extended by utilizing several DFs in parallel to get the maximum sample rate or a single DF with resulting lower sample rates. The technique is to compute partial products of  $9 \times 9$  and com-

bine these partial products by shifting and adding to obtain the final result. The shifting and adding can be accomplished with external adders (at full speed) or with the DF's shift-and-add mechanism contained in its output stage (at reduced speed).

### Decimation/Resampling

The HSP43891 DF provides a mechanism for decimating by factors of 2, 3, or 4. From the DF filter cell block diagram (Figure 1), note the three D registers and two multiplexers in the coefficient path through the cell. These allow the coefficients to be delayed by 1, 2, or 3 clocks through the cell. The sequence table (Table 3) for a decimate-by-two filter illustrates the technique (internal cell pipelining ignored for simplicity).

Detailed timing for a 30MHz input sample rate, 15MHz output sample rate (i.e., decimate-by-two), 16-tap FIR filter, including pipelining, is shown in Figure 7. This filter requires only a single HSP43891 DF.

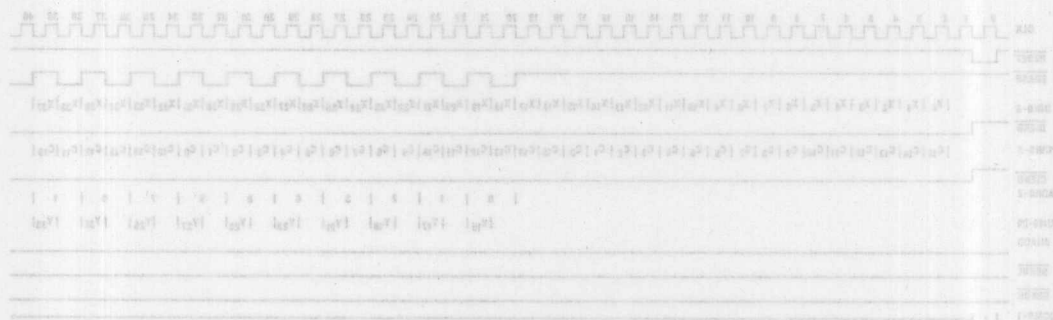


FIGURE 7. HSP43891 16-TAP DECIMATE-BY-TWO FIR FILTER TIMING, 30MHz IN, 15MHz OUT



# HSP43891

TABLE 3. HSP43891 16-TAP DECIMATE-BY-TWO FIR FILTER SEQUENCE; 30MHz IN, 15MHz OUT

CLK	CELL 0	CELL 1	CELL 2	CELL 3	CELL 4	CELL 5	CELL 6	CELL 7	SUM/CLR
6	$C_{15} \times X_0$	0	0	0	0	0	0	0	-
7	$+C_{14} \times X_1$	0	0	0	0	0	0	0	-
8	$+C_{13} \times X_2$	$C_{15} \times X_2$	0	0	0	0	0	0	-
9	$+C_{12} \times X_3$	$+C_{14} \times X_3$	0	0	0	0	0	0	-
10	$+C_{11} \times X_4$	$+C_{13} \times X_4$	$C_{15} \times X_4$	0	0	0	0	0	-
11	$+C_{10} \times X_5$	$+C_{12} \times X_5$	$+C_{14} \times X_5$	0	0	0	0	0	-
12	$+C_9 \times X_6$	$+C_{11} \times X_6$	$+C_{13} \times X_6$	$C_{15} \times X_6$	0	0	0	0	-
13	$+C_8 \times X_7$	$+C_{10} \times X_7$	$+C_{12} \times X_7$	$+C_{14} \times X_7$	0	0	0	0	-
14	$+C_7 \times X_8$	$+C_9 \times X_8$	$+C_{11} \times X_8$	$+C_{13} \times X_8$	$C_{15} \times X_8$	0	0	0	-
15	$+C_6 \times X_9$	$+C_8 \times X_9$	$+C_{10} \times X_9$	$+C_{12} \times X_9$	$+C_{14} \times X_9$	0	0	0	-
16	$+C_5 \times X_{10}$	$+C_7 \times X_{10}$	$+C_9 \times X_{10}$	$+C_{11} \times X_{10}$	$+C_{13} \times X_{10}$	$C_{15} \times X_{10}$	0	0	-
17	$+C_4 \times X_{11}$	$+C_6 \times X_{11}$	$+C_8 \times X_{11}$	$+C_{10} \times X_{11}$	$+C_{12} \times X_{11}$	$+C_{14} \times X_{11}$	0	0	-
18	$+C_3 \times X_{12}$	$+C_5 \times X_{12}$	$+C_7 \times X_{12}$	$+C_9 \times X_{12}$	$+C_{11} \times X_{12}$	$+C_{13} \times X_{12}$	$C_{15} \times X_{12}$	0	-
19	$+C_2 \times X_{13}$	$+C_4 \times X_{13}$	$+C_6 \times X_{13}$	$+C_8 \times X_{13}$	$+C_{10} \times X_{13}$	$+C_{12} \times X_{13}$	$+C_{14} \times X_{13}$	0	-
20	$+C_1 \times X_{14}$	$+C_3 \times X_{14}$	$+C_5 \times X_{14}$	$+C_7 \times X_{14}$	$+C_9 \times X_{14}$	$+C_{11} \times X_{14}$	$+C_{13} \times X_{14}$	$C_{15} \times X_{14}$	-
21	$+C_0 \times X_{15}$	$+C_2 \times X_{15}$	$+C_4 \times X_{15}$	$+C_6 \times X_{15}$	$+C_8 \times X_{15}$	$+C_{10} \times X_{15}$	$+C_{12} \times X_{15}$	$+C_{14} \times X_{15}$	Cell 0(Y15)
22	$C_{15} \times X_{16}$	$+C_1 \times X_{16}$	$+C_3 \times X_{16}$	$+C_5 \times X_{16}$	$+C_7 \times X_{16}$	$+C_9 \times X_{16}$	$+C_{11} \times X_{16}$	$+C_{13} \times X_{16}$	-
23	$+C_{14} \times X_{17}$	$+C_0 \times X_{17}$	$+C_2 \times X_{17}$	$+C_4 \times X_{17}$	$+C_6 \times X_{17}$	$+C_8 \times X_{17}$	$+C_{10} \times X_{17}$	$+C_{12} \times X_{17}$	Cell 1(Y17)
24	$+C_{13} \times X_{18}$	$C_{15} \times X_{18}$	$+C_1 \times X_{18}$	$+C_3 \times X_{18}$	$+C_5 \times X_{18}$	$+C_7 \times X_{18}$	$+C_9 \times X_{18}$	$+C_{11} \times X_{18}$	-
25	$+C_{12} \times X_{19}$	$+C_0 \times X_{19}$	$+C_2 \times X_{19}$	$+C_4 \times X_{19}$	$+C_6 \times X_{19}$	$+C_8 \times X_{19}$	$+C_{10} \times X_{19}$	$+C_{12} \times X_{19}$	Cell 2(Y19)
26	$+C_{11} \times X_{20}$	$+C_{13} \times X_{20}$	$C_{15} \times X_{20}$	$+C_1 \times X_{20}$	$+C_3 \times X_{20}$	$+C_5 \times X_{20}$	$+C_7 \times X_{20}$	$+C_9 \times X_{20}$	-
27	$+C_{10} \times X_{21}$	$+C_{12} \times X_{21}$	$+C_{14} \times X_{21}$	$+C_0 \times X_{21}$	$+C_2 \times X_{21}$	$+C_4 \times X_{21}$	$+C_6 \times X_{21}$	$+C_8 \times X_{21}$	Cell 3(Y21)
28	$+C_9 \times X_{22}$	$+C_{11} \times X_{22}$	$+C_{13} \times X_{22}$	$C_{15} \times X_{22}$	$+C_1 \times X_{22}$	$+C_3 \times X_{22}$	$+C_5 \times X_{22}$	$+C_7 \times X_{22}$	-
29	$+C_8 \times X_{23}$	$+C_{10} \times X_{23}$	$+C_{12} \times X_{23}$	$+C_{14} \times X_{23}$	$+C_0 \times X_{23}$	$+C_2 \times X_{23}$	$+C_4 \times X_{23}$	$+C_6 \times X_{23}$	Cell 4(Y23)
30	$+C_7 \times X_{24}$	$+C_9 \times X_{24}$	$+C_{11} \times X_{24}$	$+C_{13} \times X_{24}$	$+C_{15} \times X_{24}$	$+C_1 \times X_{24}$	$+C_3 \times X_{24}$	$+C_5 \times X_{24}$	-
31	$+C_6 \times X_{25}$	$+C_8 \times X_{25}$	$+C_{10} \times X_{25}$	$+C_{12} \times X_{25}$	$+C_{14} \times X_{25}$	$+C_0 \times X_{25}$	$+C_2 \times X_{25}$	$+C_4 \times X_{25}$	Cell 5(Y25)
32	$+C_5 \times X_{26}$	$+C_7 \times X_{26}$	$+C_9 \times X_{26}$	$+C_{11} \times X_{26}$	$+C_{13} \times X_{26}$	$+C_{15} \times X_{26}$	$+C_1 \times X_{26}$	$+C_3 \times X_{26}$	-
33	$+C_4 \times X_{27}$	$+C_6 \times X_{27}$	$+C_8 \times X_{27}$	$+C_{10} \times X_{27}$	$+C_{12} \times X_{27}$	$+C_{14} \times X_{27}$	$+C_0 \times X_{27}$	$+C_2 \times X_{27}$	Cell 6(Y27)
34	$+C_3 \times X_{28}$	$+C_5 \times X_{28}$	$+C_7 \times X_{28}$	$+C_9 \times X_{28}$	$+C_{11} \times X_{28}$	$+C_{13} \times X_{28}$	$+C_{15} \times X_{28}$	$+C_1 \times X_{28}$	-
35	$+C_2 \times X_{29}$	$+C_4 \times X_{29}$	$+C_6 \times X_{29}$	$+C_8 \times X_{29}$	$+C_{10} \times X_{29}$	$+C_{12} \times X_{29}$	$+C_{14} \times X_{29}$	$+C_0 \times X_{29}$	Cell 7(Y29)
36	$+C_1 \times X_{30}$	$+C_3 \times X_{30}$	$+C_5 \times X_{30}$	$+C_7 \times X_{30}$	$+C_9 \times X_{30}$	$+C_{11} \times X_{30}$	$+C_{13} \times X_{30}$	$C_{15} \times X_{30}$	-
37	$+C_0 \times X_{31}$	$+C_2 \times X_{31}$	$+C_4 \times X_{31}$	$+C_6 \times X_{31}$	$+C_8 \times X_{31}$	$+C_{10} \times X_{31}$	$+C_{12} \times X_{31}$	$+C_{14} \times X_{31}$	Cell 8(Y31)

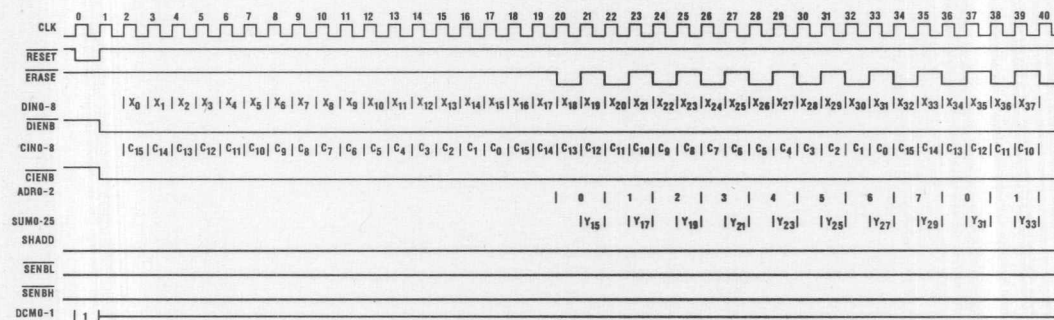


FIGURE 7. HSP43891 16-TAP DECIMATE-BY-TWO FIR FILTER TIMING; 30MHz IN, 15MHz OUT

# Specifications HSP43891

## Absolute Maximum Ratings

Supply Voltage	+8.0V
Input, Output Voltage	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature	-65°C to +150°C
ESD	Class 1
Maximum Package Power Dissipation at 70°C	2.4W (PLCC), 2.88W (PGA)
$\theta_{jc}$	11.1°C/W (PLCC), 7.78°C/W (PGA)
$\theta_{ja}$	33.7°C/W (PLCC), 34.66°C/W (PGA)
Gate Count	17763
Junction Temperature	150°C (PLCC), 175°C (PGA)
Lead Temperature (Soldering 10s)	300°C

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range	5V $\pm$ 5%
Operating Temperature Range	0°C to +70°C

## D.C. Electrical Specifications

SYMBOL	PARAMETER		MIN	MAX	UNITS	TEST CONDITIONS
I <sub>CCOP</sub>	Power Supply Current		-	160	mA	V <sub>CC</sub> = Max CLK Frequency 20MHz Note 1, Note 3
I <sub>CCSB</sub>	Standby Power Supply Current		-	500	μA	V <sub>CC</sub> = Max, Note 3
I <sub>I</sub>	Input Leakage Current		-10	10	μA	V <sub>CC</sub> = Max, Input = 0V or V <sub>CC</sub>
I <sub>O</sub>	Output Leakage Current		-10	10	μA	V <sub>CC</sub> = Max, Input = 0V or V <sub>CC</sub>
V <sub>IH</sub>	Logical One Input Voltage		2.0	-	V	V <sub>CC</sub> = Max
V <sub>IL</sub>	Logical Zero Input Voltage		-	0.8	V	V <sub>CC</sub> = Min
V <sub>OH</sub>	Logical One Output Voltage		2.6	-	V	I <sub>OH</sub> = -400μA, V <sub>CC</sub> = Min
V <sub>OL</sub>	Logical Zero Output Voltage		-	0.4	V	I <sub>OL</sub> = 2mA, V <sub>CC</sub> = Min
V <sub>IHC</sub>	Clock Input High		3.0	-	V	V <sub>CC</sub> = Max
V <sub>ILC</sub>	Clock Input Low		-	0.8	V	V <sub>CC</sub> = Min
C <sub>IN</sub>	Input Capacitance	PLCC	-	10	pF	CLK Frequency 1MHz All measurements referenced to GND T <sub>A</sub> = 25°C. Note 2
		PGA	-	15	pF	
C <sub>OUT</sub>	Output Capacitance	PLCC	-	10	pF	
		PGA	-	15	pF	

NOTES: 1. Operating supply current is proportional to frequency. Typical rating is 8mA/MHz.

2. Controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.

3. Output load per test load circuit and  $C_L = 40pF$ .

3

1-D FILTERS

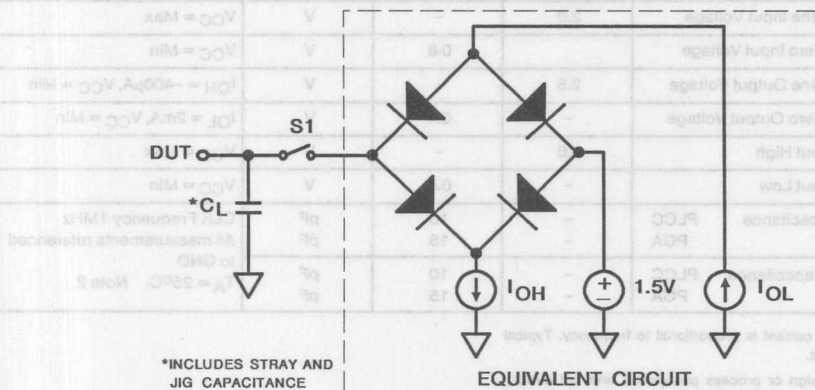
## Specifications HSP43891

### A.C. Electrical Specifications $V_{CC} = 5V \pm 5\%$ , $T_A = 0^\circ C$ to $+70^\circ C$

SYMBOL	PARAMETER	-20 (20MHz)		-25 (25.6MHz)		-30 (30MHz)		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX	MIN	MAX		
$T_{CP}$	Clock Period	50	-	39	-	33	-	ns	
$T_{CL}$	Clock Low	20	-	16	-	13	-	ns	
$T_{CH}$	Clock High	20	-	16	-	13	-	ns	
$T_{IS}$	Input Setup	16	-	14	-	13	-	ns	
$T_{IH}$	Input Hold	0	-	0	-	0	-	ns	
$T_{ODC}$	CLK to Coefficient Output Delay	-	24	-	20	-	18	ns	
$T_{OED}$	Output Enable Delay	-	20	-	15	-	15	ns	
$T_{ODD}$	Output Disable Delay	-	20	-	15	-	15	ns	Note 1
$T_{ODS}$	CLK to SUM Output Delay	-	27	-	25	-	21	ns	
$T_{OR}$	Output Rise	-	6	-	6	-	6	ns	Note 1
$T_{OF}$	Output Fall	-	6	-	6	-	6	ns	Note 1

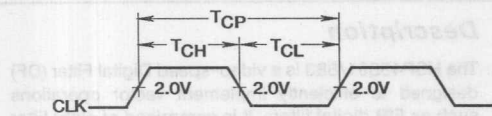
NOTE: 1. Controlled by design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.

### Test Load Circuit

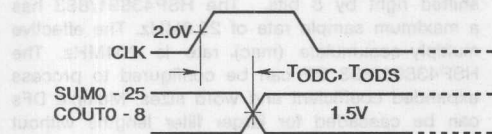


Switch S1 Open for  $I_{CCSB}$  and  $I_{CCOP}$  Tests

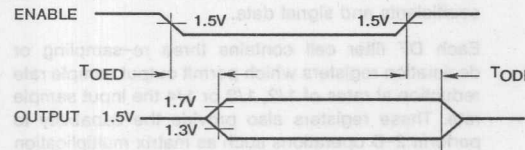
## Waveforms



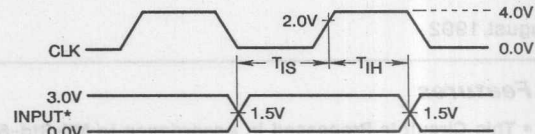
CLOCK AC PARAMETERS



SUM0-25, COUT0-8, OUTPUT DELAYS

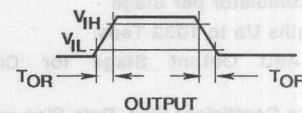


OUTPUT ENABLE, DISABLE TIMING

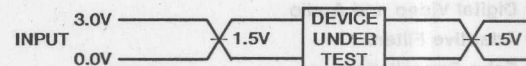


\* Input includes: DINO-7, CINO-7, DIENB, CIENB, ERASE, RESET, DCMO-1, ADRO-1, TCS, TCCI, SHADD

INPUT SETUP AND HOLD



RISE AND FALL TIMES



A.C. Testing: Inputs are driven at 3.0V for a Logic "1" and 0.0V for a Logic "0". Input and output timing measurements are made at 1.5V for both a Logic "1" and "0". CLK is driven at 4.0V and 0V and measured at 2.5V.

A.C. TESTING INPUT, OUTPUT WAVEFORM



**HARRIS**

# HSP43891/883

August 1992

**Digital Filter**

## Features

- This Circuit is Processed in Accordance to Mil-Std-883C and is Fully Conformant Under the Provisions of Paragraph 1.2.1
- 0 to 25.6MHz Sample Rate
- Eight Filter Cells
- 9-Bit Coefficients and Signal Data
- Low Power CMOS Operation
  - ▶  $I_{CCSB} = 500\mu A$  Maximum
  - ▶  $I_{CCOP} = 160\mu A$  Maximum @ 20MHz
- 26-Bit Accumulator per Stage
- Filter Lengths Up to 1032 Taps
- Shift-and-Add Output Stage for Combining Filter Outputs
- Expandable Coefficient Size, Data Size and Filter Length
- Decimation by 2, 3 or 4

## Applications

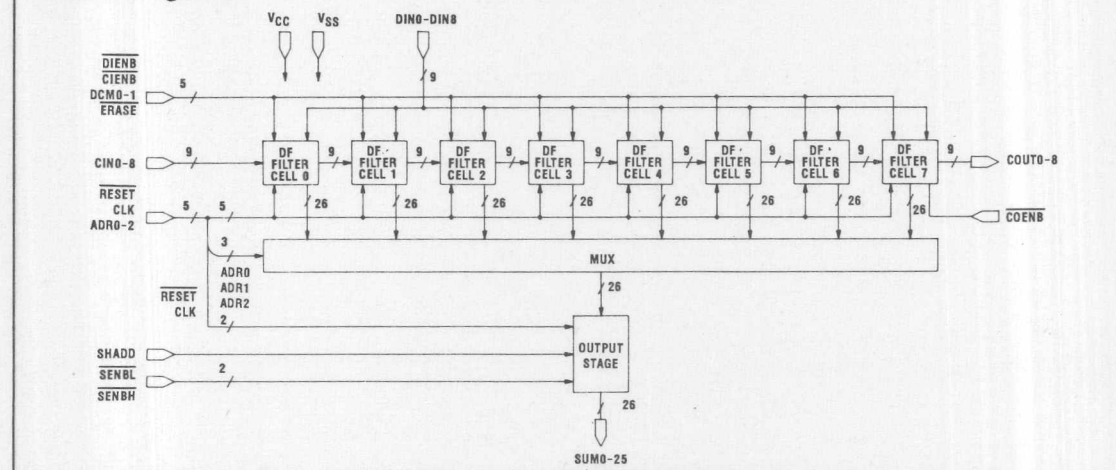
- 1-D and 2-D FIR Filters
- Radar/Sonar
- Digital Video and Audio
- Adaptive Filters
- Echo Cancellation
- Correlation/Convolution
- Complex Multiply-Add
- Butterfly Computation
- Matrix Multiplication
- Sample Rate Converters

## Description

The HSP43891/883 is a video-speed Digital Filter (DF) designed to efficiently implement vector operations such as FIR digital filters. It is comprised of eight filter cells cascaded internally and a shift and add output stage, all in a single integrated circuit. Each filter cell contains a 9x9 two's complement multiplier, three decimation registers and a 26-bit accumulator. The output stage contains an additional 26-bit accumulator which can add the contents of any filter cell accumulator to the output stage accumulator shifted right by 8 bits. The HSP43891/883 has a maximum sample rate of 25.6MHz. The effective multiply-accumulate (mac) rate is 204MHz. The HSP43891/883 DF can be configured to process expanded coefficient and word sizes. Multiple DFs can be cascaded for larger filter lengths without degrading the sample rate or a single DF can process larger filter lengths at less than 25.6MHz with multiple passes. The architecture permits processing filter lengths of over 1000 taps with the guarantee of no overflows. In practice, most filter coefficients are less than 1.0, making even larger filter lengths possible. The DF provides for 8-bit unsigned or 9-bit two's complement arithmetic, independently selectable for coefficients and signal data.

Each DF filter cell contains three re-sampling or decimation registers which permit output sample rate reduction at rates of 1/2, 1/3 or 1/4 the input sample rate. These registers also provide the capability to perform 2-D operations such as matrix multiplication and NxN spatial correlations/convolutions for image processing applications.

## Block Diagram



CAUTION: These devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
Copyright © Harris Corporation 1992

File Number **2451.2**

# Pinouts

## 85 PIN GRID ARRAY (PGA)

	1	2	3	4	5	6	7	8	9	10	11
A	V <sub>SS</sub>	COENB	V <sub>CC</sub>	RESET	DIN7	DIN6	DIN3	DIN0	CIN8	V <sub>CC</sub>	V <sub>SS</sub>
B	V <sub>CC</sub>	COUT7	COUT8	ERASE	DIN8	DIN1	DIN2	CIENB	CIN7	CIN6	CIN4
C	COUT5	COUT6	ALIGN PIN		DIENB	DIN5	DIN4			CIN5	CIN3
D	COUT3	COUT4		<div style="text-align: center;"> <b>HSP43891/883</b>  <b>TOP VIEW</b>  <b>PINS DOWN</b> </div>					CIN2	V <sub>CC</sub>	
E	COUT1	V <sub>SS</sub>	COUT2						CIN1	CIN0	SENBL
F	V <sub>SS</sub>	COUT0	SHADD						SUM0	V <sub>CC</sub>	V <sub>SS</sub>
G	ADR2	DCM0	CLK						SUM1	SUM3	SUM2
H	ADR1	ADR0								SUM5	SUM4
J	V <sub>CC</sub>	SUM25			SUM20	SUM17	SUM16			SUM7	V <sub>SS</sub>
K	SENBH	SUM24	V <sub>SS</sub>	V <sub>CC</sub>	SUM19	V <sub>SS</sub>	SUM15	SUM12	SUM10	SUM8	SUM6
L	DCM1	SUM23	SUM22	SUM21	SUM18	SUM14	V <sub>CC</sub>	SUM13	V <sub>SS</sub>	SUM11	SUM9

	1	2	3	4	5	6	7	8	9	10	11
L	○	○	○	○	○	○	○	○	○	○	○
	DCM1	SUM23	SUM22	SUM21	SUM18	SUM14	V <sub>CC</sub>	SUM13	V <sub>SS</sub>	SUM11	SUM9
K	○	○	○	○	○	○	○	○	○	○	○
	SENBH	SUM24	V <sub>SS</sub>	V <sub>CC</sub>	SUM19	V <sub>SS</sub>	SUM15	SUM12	SUM10	SUM8	SUM6
J	○	○	○	○	○	○	○	○	○	○	○
	V <sub>CC</sub>	SUM25			SUM20	SUM17	SUM16			SUM7	V <sub>SS</sub>
H	○	○	○	○	○	○	○	○	○	○	○
	ADR1	ADR0								SUM5	SUM4
G	○	○	○	○	○	○	○	○	○	○	○
	ADR2	DCM0	CLK							SUM1	SUM3
F	○	○	○	○	○	○	○	○	○	○	○
	V <sub>SS</sub>	COUT0	SHADD							SUM0	V <sub>CC</sub>
E	○	○	○	○	○	○	○	○	○	○	○
	COUT1	V <sub>SS</sub>	COUT2							CIN1	CIN0
D	○	○	○	○	○	○	○	○	○	○	○
	COUT3	COUT4								CIN2	V <sub>CC</sub>
C	○	○	○	○	○	○	○	○	○	○	○
	COUT5	COUT6	ALIGN PIN		DIENB	DIN5	DIN4			CIN5	CIN3
B	○	○	○	○	○	○	○	○	○	○	○
	V <sub>CC</sub>	COUT7	COUT8	ERASE	DIN8	DIN1	DIN2	CIENB	CIN7	CIN6	CIN4
A	○	○	○	○	○	○	○	○	○	○	○
	V <sub>SS</sub>	COENB	V <sub>CC</sub>	RESET	DIN7	DIN6	DIN3	DIN0	CIN8	V <sub>CC</sub>	V <sub>SS</sub>

## HSP43891/883 BOTTOM VIEW PINS UP

3

1-D FILTERS

# Specifications HSP43891/883

## Absolute Maximum Ratings

Supply Voltage ..... +8.0V  
 Input, Output Voltage Applied ..... GND-0.5V to  $V_{CC}+0.5V$   
 Storage Temperature Range ..... -65°C to +150°C  
 Junction Temperature ..... +175°C  
 Lead Temperature (Soldering, Ten Seconds) ..... +300°C  
 ESD Classification ..... Class 1

## Reliability Information

Thermal Resistance  $\theta_{ja}$   $\theta_{jc}$   
 Ceramic PGA Package ..... 34.66°C/W 7.78°C/W  
 Maximum Package Power Dissipation at +125°C  
 Ceramic PGA Package ..... 1.44 Watt  
 Gate Count ..... 17762 Gates

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range ..... +4.5V to +5.5V  
 Operating Temperature Range ..... -55°C to +125°C

TABLE 1. HSP43891/883 D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Devices Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +2.0mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output Leakage Current	$I_O$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Clock Input High	$V_{IHC}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	3.0	-	V
Clock Input Low	$V_{ILC}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ , Outputs Open	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 20.0MHz$ $V_{CC} = 5.5V$ (Note 2)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	160.0	mA
Functional Test	FT	(Note 3)	7, 8	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	-	

NOTES: 1. Interchanging of force and sense conditions is permitted.

2. Operating Supply Current is proportional to frequency, typical rating is 8mA/MHz.

3. Tested as follows:  $f = 1MHz$ ,  $V_{IH} = 2.6$ ,  $V_{IL} = 0.4$ ,  $V_{OH} \geq 1.5V$ ,  $V_{OL} \leq 1.5V$ ,  $V_{IHC} = 3.4V$ , and  $V_{ILC} = 0.4V$ .

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	-20 (20MHz)		-25 (25.6MHz)		UNITS
					MIN	MAX	MIN	MAX	
Clock Period	T <sub>CP</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	50	-	39	-	ns
Clock Low	T <sub>CL</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	16	-	ns
Clock High	T <sub>CH</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	16	-	ns
Input Setup	T <sub>IS</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	20	-	17	-	ns
Input Hold	T <sub>IH</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
CLK to Coefficient Output Delay	T <sub>ODC</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	24	-	20	ns
Output Enable Delay	T <sub>OED</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	20	-	15	ns
CLK to SUM Output Delay	T <sub>ODS</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	31	-	25	ns

NOTE: 1. A.C. Testing: VCC = 4.5V and 5.5V. Inputs are driven at 3.0V for a Logic "1" and 0.0V for a Logic "0". Input and output timing measurements are made at 1.5V for both a Logic "1" and "0". CLK is driven at 4.0V and 0V and measured at 2.0V.

TABLE 3. HSP43891/883 A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETER	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	-20 (20MHz)		-25 (25.6MHz)		UNITS
					MIN	MAX	MIN	MAX	
Input Capacitance	C <sub>IN</sub>	VCC=Open, f=1MHz All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	15	-	15	pF
Output Capacitance	C <sub>OUT</sub>		1	T <sub>A</sub> = +25°C	-	15	-	15	pF
Output Disable Delay	T <sub>ODD</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	20	-	15	ns
Output Rise Time	T <sub>OR</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	7	-	6	ns
Output Fall Time	T <sub>OF</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	7	-	6	ns

NOTES: 1. The parameters listed in Table 3 are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design and after major process and/or design changes.

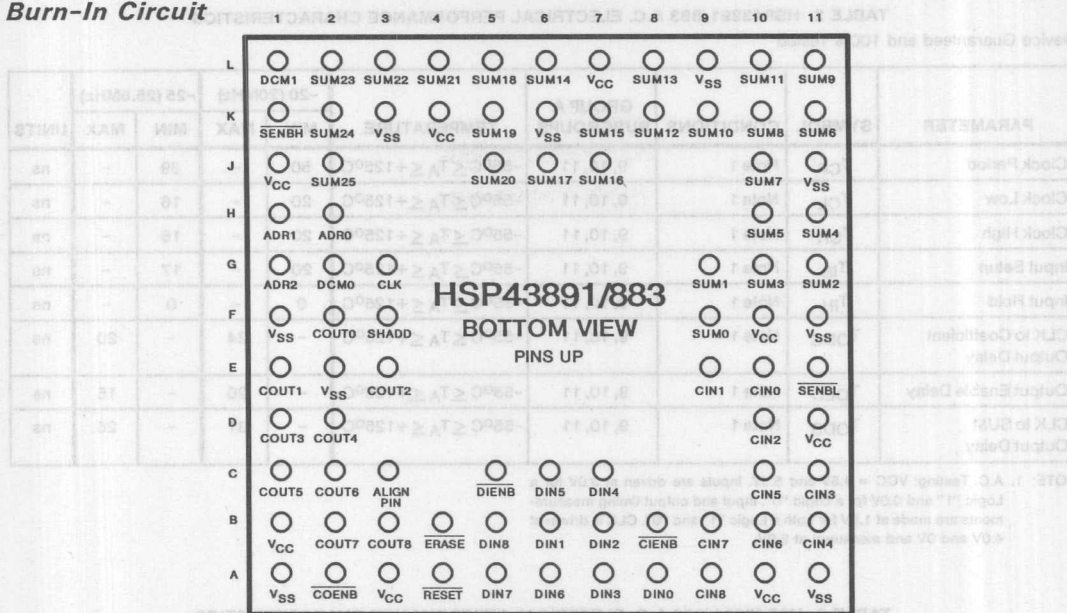
2. Loading is as specified in the test load circuit, C<sub>L</sub> = 40pF.

TABLE 4. APPLICABLE SUBGROUPS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9



### Burn-In Circuit



PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
A1	V <sub>SS</sub>	GND	C1	COUT5	V <sub>CC</sub> /2	F10	V <sub>CC</sub>	V <sub>CC</sub>	K4	V <sub>CC</sub>	V <sub>CC</sub>
A2	COENB	F10	C2	COUT6	V <sub>CC</sub> /2	F11	V <sub>SS</sub>	GND	K5	SUM19	V <sub>CC</sub> /2
A3	V <sub>CC</sub>	V <sub>CC</sub>	C3	ALIGN	NC	G1	ADR2	F2	K6	V <sub>SS</sub>	GND
A4	RESET	F11	C5	DIENB	F10	G2	DCM0	F5	K7	SUM15	V <sub>CC</sub> /2
A5	DIN7	F8	C6	DIN5	F5	G3	CLK	F0	K8	SUM12	V <sub>CC</sub> /2
A6	DIN6	F6	C7	DIN4	F4	G9	SUM1	V <sub>CC</sub> /2	K9	SUM10	V <sub>CC</sub> /2
A7	DIN3	F3	C10	CIN5	F5	G10	SUM3	V <sub>CC</sub> /2	K10	SUM8	V <sub>CC</sub> /2
A8	DIN0	F0	C11	CIN3	F3	G11	SUM2	V <sub>CC</sub> /2	K11	SUM6	V <sub>CC</sub> /2
A9	CIN8/TCCI	F8	D1	COUT3	V <sub>CC</sub> /2	H1	ADR1	F1	L1	DCM1	F6
A10	V <sub>CC</sub>	V <sub>CC</sub>	D2	COUT4	V <sub>CC</sub> /2	H2	ADR0	F0	L2	SUM23	V <sub>CC</sub> /2
A11	V <sub>SS</sub>	GND	D10	CIN2	F2	H10	SUM5	V <sub>CC</sub> /2	L3	SUM22	V <sub>CC</sub> /2
B1	V <sub>CC</sub>	V <sub>CC</sub>	D11	V <sub>CC</sub>	V <sub>CC</sub>	H11	SUM4	V <sub>CC</sub> /2	L4	SUM21	V <sub>CC</sub> /2
B2	COUT7	V <sub>CC</sub> /2	E1	COUT1	V <sub>CC</sub> /2	J1	V <sub>CC</sub>	V <sub>CC</sub>	L5	SUM18	V <sub>CC</sub> /2
B3	COUT8/TCCI	V <sub>CC</sub> /2	E2	V <sub>SS</sub>	GND	J2	SUM25	V <sub>CC</sub> /2	L6	SUM14	V <sub>CC</sub> /2
B4	ERASE	F10	E3	COUT2	V <sub>CC</sub> /2	J5	SUM20	V <sub>CC</sub> /2	L7	V <sub>CC</sub>	V <sub>CC</sub>
B5	DIN8/TCS	F7	E9	CIN1	F1	J6	SUM17	V <sub>CC</sub> /2	L8	SUM13	V <sub>CC</sub> /2
B6	DIN1	F1	E10	CIN0	F0	J7	SUM16	V <sub>CC</sub> /2	L9	V <sub>SS</sub>	GND
B7	DIN2	F2	E11	SENBL	F10	J10	SUM7	V <sub>CC</sub> /2	L10	SUM11	V <sub>CC</sub> /2
B8	CIENB	F10	F1	V <sub>SS</sub>	GND	J11	V <sub>SS</sub>	GND	L11	SUM9	V <sub>CC</sub> /2
B9	CIN7	F7	F2	COUT0	V <sub>CC</sub> /2	K1	SENBH	F10			
B10	CIN6	F6	F3	SHADD	F9	K2	SUM24	V <sub>CC</sub> /2			
B11	CIN4	F4	F9	SUM0	V <sub>CC</sub> /2	K3	V <sub>SS</sub>	GND			

NOTES: 1. V<sub>CC</sub>/2 (2.7V ±10%) used for outputs only.  
 2. 47KΩ (±20%) resistor connected to all pins except V<sub>CC</sub> and GND.  
 3. V<sub>CC</sub> = 5.5 ±0.5V.

4. 0.1μF (min) capacitor between V<sub>CC</sub> and GND per position.  
 5. F0 = 100KHz ±10%, F1 = F0/2, F2 = F1/2, ..., F11 = F10/2, 40% - 60% Duty Cycle.  
 6. Input voltage limits: V<sub>IL</sub> = 0.8V max., V<sub>IH</sub> = 4.5V ±10%

**Metallization Topology****DIE DIMENSIONS:**

328 x 283 x 19 ±1 mils

**METALLIZATION:**

Type: Si - Al or Si-Al-Cu

Thickness: 8kÅ

**GLASSIVATION:**

Type: Nitrox

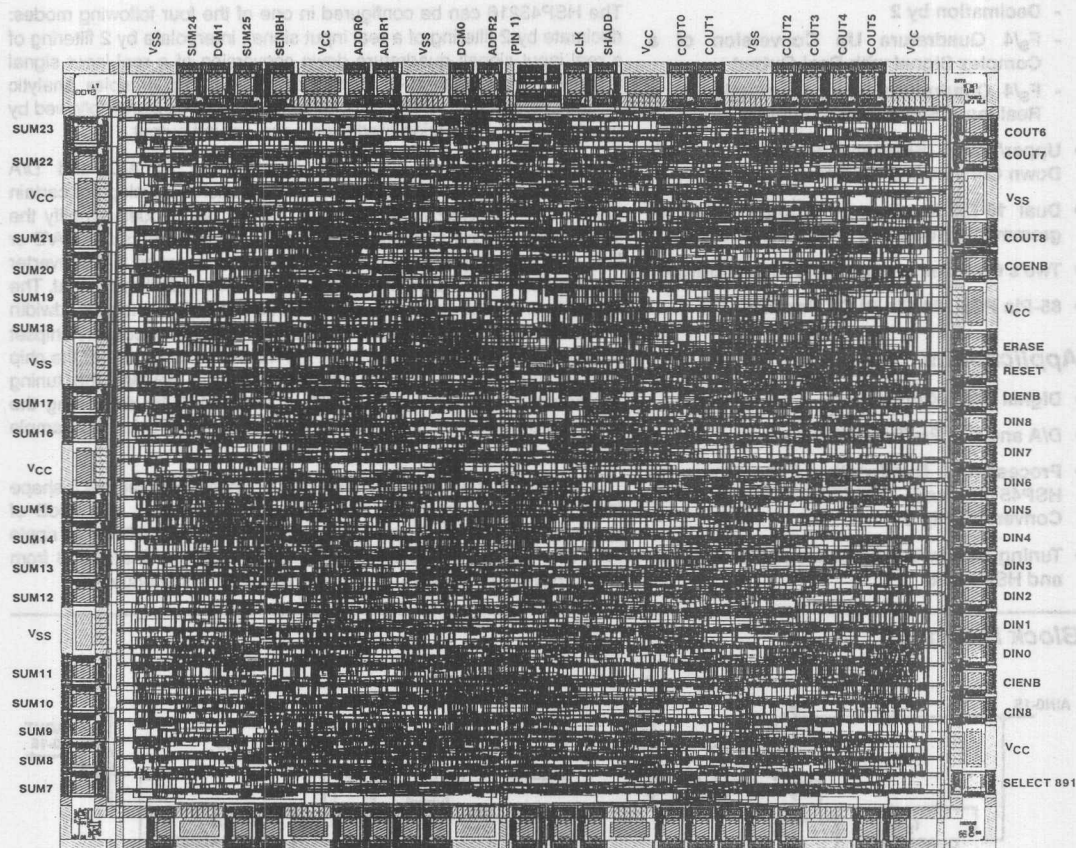
Thickness: 10kÅ

**DIE ATTACH:**

Material: Gold/Silicon Eutectic Alloy or Silver-Glass

**WORST CASE CURRENT DENSITY:** $1.2 \times 10^5 \text{ A/cm}^2$ **Metallization Mask Layout**

HSP43891/883



3

1-D FILTERS

## ADVANCE INFORMATION

August 1992

## Halfband Filter

### Features

- Sample Rates to 75MHz
- External Multiplexing Supported for Processing of Sample Rates to 150MHz
- 67 Tap FIR Filter with 20 Bit Coefficients
- 1.24:1 Filter Shape Factor, > 90dB Stopband Attenuation, < 0.0005dB Stopband Ripple
- Four Modes of Operation:
  - Interpolation by 2
  - Decimation by 2
  - $F_s/4$  Quadrature Up Conversion of a Complex Signal with Real Output
  - $F_s/4$  Quadrature Down Conversion of a Real Input Signal with Complex Output
- Upper/Lower Sideband Selection in both Down Convert and Up Convert Modes
- Dual 16-Bit Inputs and Outputs with Programmable Rounding on the Outputs
- Two's Complement or Offset Binary Output
- 85-Pin PGA, 84-Pin PLCC Package

### Applications

- Digital Down Conversion
- D/A and A/D Pre/Post Filtering
- Processing Bandwidth Expansion for HSP45116 and HSP43220 Digital Down Converter Chip Set
- Tuning Bandwidth Expansion for HSP45116 and HSP45106

### Description

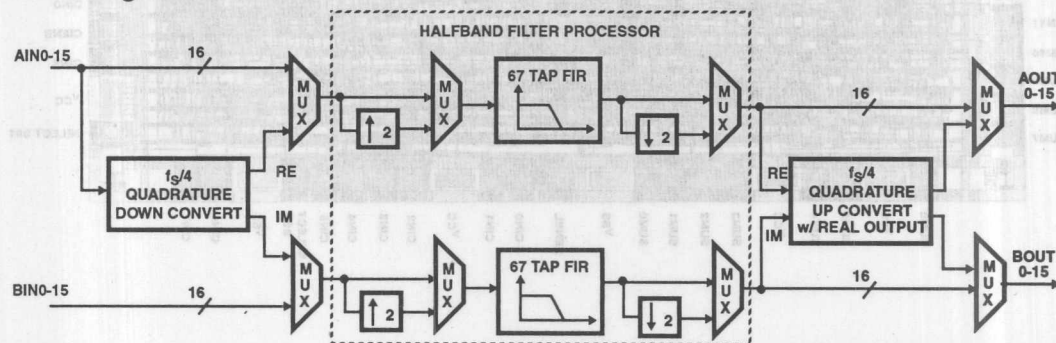
The HSP43216 Halfband Filter addresses a wide variety of applications by combining quadrature up/down conversion circuitry with a fixed coefficient halfband filter processor. The filter processor implements a 67 tap FIR filter with either interpolation or decimation by 2. As shown in the block diagram, the filter processor may be configured to receive output from the  $F_s/4$  quadrature down converter or provide complex input to the  $F_s/4$  quadrature up converter. In either of these two configurations the halfband processor functions as a quadrature filter. Two data inputs and outputs are provided so that an external multiplexer may be used to effectively double the processing speed of the part.

The HSP43216 can be configured in one of the four following modes: decimate by 2 filtering of a real input signal; interpolate by 2 filtering of a real input signal; quadrature down conversion of a real input signal followed by decimate-by-2 filtering of the resulting complex analytic signal; interpolate-by-2 filtering of a complex analytic signal followed by quadrature up conversion producing a real valued output.

Typical applications include the simplification of A/D and D/A subsystem design and extension of the operational envelope of certain parts within the HSPXXXX family. The first two modes simplify the analog anti-aliasing and reconstruction filter requirements of an A/D or D/A subsystem by providing a mechanism to increase the converter sample rate relative to the frequency content of the digitized signal. The quadrature down convert mode doubles the signal bandwidth processed by the HSP45116/HSP43220 digital down convert chipset by providing quadrature samples at the maximum clock rate of the chip set. Similarly, the quadrature up convert mode doubles the tuning bandwidth of either the HSP45116 or HSP45106 by converting the quadrature outputs of these parts to a real signal at twice the sample rate.

The frequency response of the HSP43216's halfband filter has a shape factor, (passband+transition band)/passband, of 1.24:1 with 90dB of stopband attenuation. The passband has less than .0005dB of ripple from 0 to  $0.2F_s$  with stopband attenuation of greater than 90dB from  $0.3F_s$  to Nyquist. At  $.25F_s$  the filter provides 6dB of attenuation.

### Block Diagram



## TWO DIMENSIONAL FILTERS

DATA SHEETS		PAGE
HSP48901	3 x 3 Image Filter.....	4-3
HSP48908	Two Dimensional Convolver.....	4-12
HSP48908/833	Two Dimensional Convolver.....	4-28





August 1992

3 x 3 Image Filter

## Features

- DC to 30MHz Clock Rate
- Configurable for 1-D and 2-D Correlation/Convolution.
- Dual Coefficient Mask Registers, Switchable in a Single Clock Cycle
- Two's Complement or Unsigned 8-Bit Input Data and Coefficients
- 20 Bit Extended Precision Output
- Standard  $\mu$ P Interface
- TTL Compatible Inputs/Outputs
- Low Power CMOS
- Available in 68 Pin PGA and PLCC Packages

## Applications

- Image Filtering
- Edge Detection/Enhancement
- Pattern Matching
- Real Time Video Filters

## Description

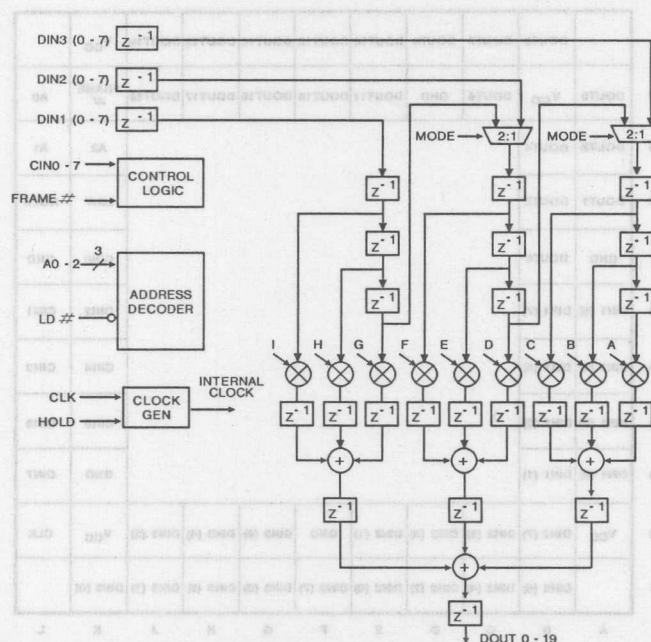
The Harris HSP48901 is a high speed 9-Tap FIR Filter which utilizes 8-bit wide data and coefficients. It can be configured as a one dimensional (1-D) 9-Tap filter for a variety of signal processing applications, or as a two dimensional (2-D) filter for image processing. In the 2-D configuration, the device is ideally suited for implementing 3 x 3 kernel convolution. The 30MHz clock rate allows a large number of image sizes to be processed within the required frame time for real-time video.

Data is provided to the HSP48901 through the use of programmable data buffers such as the HSP9500 or any other programmable shift register. Coefficient and pixel input data are 8-bit signed or unsigned integers, and the 20 bit extended output guarantees no overflow will occur during the filtering operation.

There are two internal register banks for storing independent 3 x 3 filter kernels, thus facilitating the implementation of adaptive filters and multiple filter operations on the same data.

The configuration of the HSP48901 Image Filter is controlled through a standard microprocessor interface and all inputs and outputs are TTL compatible. The HSP48901 is available in 68 pin PGA and PLCC packages.

## Block Diagram



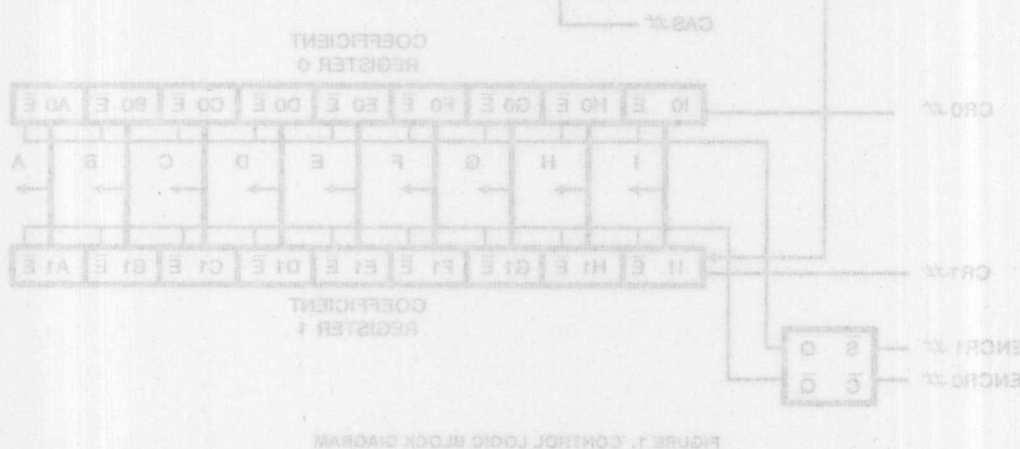


## Pin Descriptions

NAME	PLCC PIN	TYPE	DESCRIPTION
VCC	9, 27, 45, 61		The +5V power supply pins. 0.1 $\mu$ F capacitors between the VCC and GND pins are recommended.
GND	18, 29, 38, 56		The device ground.
CLK	28	I	Input and System clock. Operations are synchronous with the rising edge of this clock signal.
DIN1(7-0)	1-8	I	Pixel Data Input bus #1. These inputs are used to provide 8-bit pixel data to the HSP48901. The data must be provided in a synchronous fashion, and is latched on the rising edge of the CLK signal. The DIN1(0-7) inputs are also used to input data when operating in the 9 Tap FIR mode.
DIN2(7-0)	10-17	I	Pixel Data Input bus #2. Same as above. These inputs should be grounded when operating in the 1D mode.
DIN3(7-0)	19-26	I	Pixel Data Input bus #3. Same as above. These inputs should be grounded when operating in the 1D mode.
CIN7-0	30-37	I	Coefficient Data Input bus. This input bus is used to load the Coefficient Mask register(s) and the Initialization register. The register to be loaded is defined by the register address bits A0-2. The CIN0-7 data is loaded to the addressed register through the use of the LD# input.
DOUT19-0	46-55, 57-60, 62-67	O	Output Data bus. This 20-Bit output port is used to provide the convolution result. The result is the sum of products of the input data samples and their corresponding coefficients.
FRAME#	44	I	Frame# is an asynchronous new frame or vertical sync input. A low on this input resets all internal circuitry except for the Coefficient and INT registers. Thus, after a Frame# reset has occurred, a new frame of pixels may be convolved without reloading these registers.
HOLD	40	I	The Hold Input is used to gate the clock from all of the internal circuitry of the HSP48901. This signal is synchronous, is sampled on the rising edge of CLK and takes effect on the following cycle. While this signal is active (high), the clock will have no effect on the HSP48901 and internal data will remain undisturbed.
A2-0	41-43	I	Control Register Address. These lines are decoded to determine which register in the control logic is the destination for the data on the CIN0-7 inputs. Register loading is controlled by the A0-2 and LD# inputs.
LD#	39	I	Load Strobe. LD# is used for loading the internal registers of the HSP48901. The rising edge of LD# will latch the CIN0-7 data into the register specified by A0-2. The Address on A0-2 must be set up with respect to the falling edge of LD# and must be held with respect to the rising edge of LD#.

4

2-D FILTERS





### Functional Description

The HSP48901 can perform convolution of a 3 x 3 filter kernel with 8-bit image data. It accepts the image data in a raster scan, non-interlaced format, convolves it with the filter kernel and outputs the filtered image. The input and filter kernel data are both 8-bits, while the output data is 20-bits to prevent overflow during the convolution operation. Image data is input via the DIN1, DIN2, and DIN3 busses. This data would normally be provided by programmable data buffer such as the HSP9501 as illustrated in the operations section of this specification. The data is then convolved with the 3 x 3 array of filter coefficients. The resultant output data is then stored in the output register. The HSP48901 may also be used in a one-dimensional mode. In this configuration, it functions as a 1-D 9-tap FIR filter. Data would be input via the DIN1(0-7) bus for operation in this mode.

Initialization of the convolver is done using the CINO-7 bus to load configuration data and the filter kernel(s). The address lines A0-2 are used to address the internal registers for initialization. The configuration data is loaded using the A0-2, CINO-7 and LD# controls as address, data and write enable, respectively. This interface is compatible with standard microprocessors without the use of any additional glue logic.

Filtered image data is output from the convolver over the DOUT0-19 bus. This output bus is 20-bits wide to provide room for growth during the convolution operation.

### 8-Bit Multiplier Array

The multiplier array consists of nine 8 x 8 multipliers. Each multiplier forms the product of a filter coefficient with a corresponding pixel in the input image. Input and coefficient data may be in either two's complement or unsigned integer format. The nine coefficients form a 3 x 3 filter kernel which is multiplied by the input pixel data and summed to form a sum of products for implementation of the convolution operation as shown below:

FILTER KERNEL			8-BIT INPUT DATA		
A	B	C	P1	P2	P3
D	E	F	P4	P5	P6
G	H	I	P7	P8	P9

$$\begin{aligned} \text{OUTPUT} = & (A \times P1) + (B \times P2) + (C \times P3) \\ & + (D \times P4) + (E \times P5) + (F \times P6) \\ & + (G \times P7) + (H \times P8) + (I \times P9) \end{aligned}$$

### Control Logic

The control logic (Figure 1) contains the Initialization Register and the Coefficient Registers. The control logic is updated by placing data on the CINO-7 bus and using the A0-2 and LD# control lines to write to the addressed register (see Address Decoder). All of the control logic registers are unaffected by FRAME#.

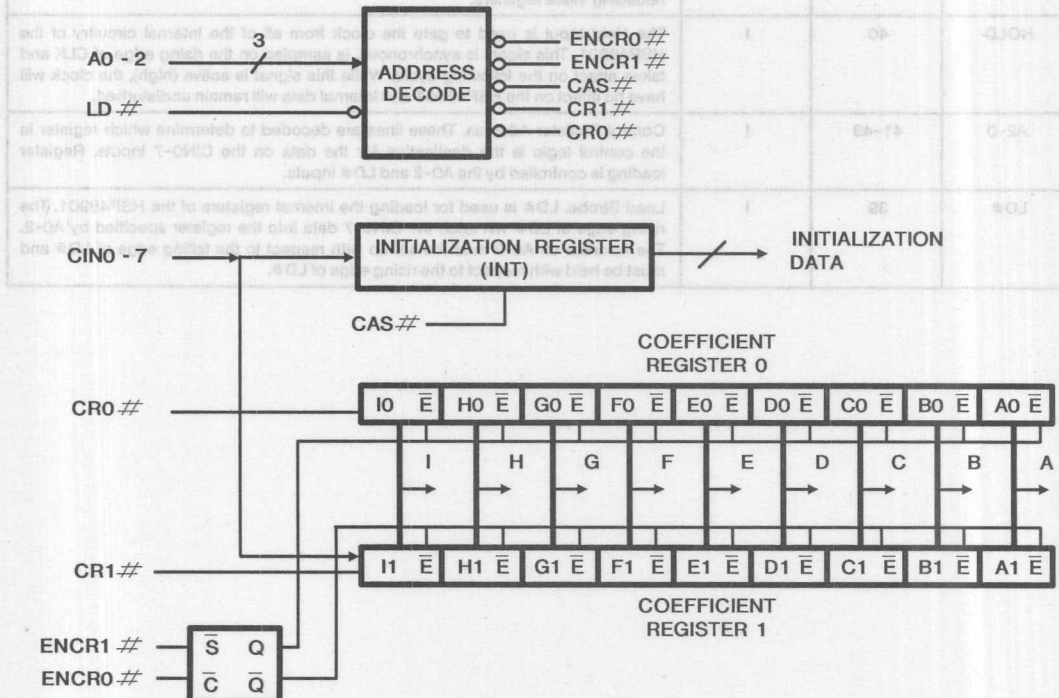


FIGURE 1. CONTROL LOGIC BLOCK DIAGRAM

## Initialization Register

The initialization register is used to appropriately configure the convolver for a particular application. It is loaded through the use of the CINO-7 bus along with the LD# input. Bit 0 defines the input data and coefficients format (unsigned or two's complement); Bit 1 defines the mode of operation (1-D or 2-D); and Bits 2 and 3 determine the type of rounding to occur on the DOUT0-19 bus; The complete definition of the initialization register bits is given in Table 1.

TABLE 1. INITIALIZATION REGISTER DEFINITION

INITIALIZATION REGISTER		
BIT 0		FUNCTION = Input & Coefficient Data Format
0		Unsigned Integer format
1		Two's complement format
BIT 1		FUNCTION = Operating Mode
0		1-D 9-tap filter
1		2-D 3 x 3 filter
3	BIT 2	FUNCTION = Output Rounding
0	0	No Rounding
0	1	Round to 16 bits (i.e. DOUT19-4)
1	0	Round to 8 bits (i.e. DOUT19-12)
1	1	Not Valid

### Coefficient Registers (CREG0, CREG1)

The control logic contains two coefficient register banks, CREG0 and CREG1. Each of these register banks is capable of storing nine 8-bit filter coefficient values (3 x 3 Kernel). The output of the registers are connected to the coefficient input of the corresponding multiplier in the 3 x 3 multiplier array (designated A through I). The register bank to be used for the convolution is selectable by writing to the appropriate address (See address decoder). All registers in a given bank are enabled simultaneously, and one of the banks is always active.

For most applications, only one of the register banks is necessary. The user can simply load CREG0 after power up, and use it for the entire convolution operation. (CREG0 is the default register). The alternate register bank allows the user to maintain two sets of filter coefficients and switch between them in real time. The coefficient masks are loaded via the CINO-7 bus by using A0-2 and LD#. The selection of the particular register bank to be used in processing is also done by writing to the appropriate address (See address decoder). For example, if CREG0 is being used to provide coefficients to the multipliers, CREG1 can be updated at a low rate by an external processor; then, at the proper time, CREG1 can be selected, so that the new coefficient mask is used to process the data. Thus, no clock cycles have been lost when changing between alternate 3 x 3 filter kernels.

The nine coefficients must be loaded sequentially over the CINO-7 bus from A to I. The address of CREG0 or CREG1 is placed on A0-2, and then the coefficients are written to the corresponding coefficient register one at a time by using the LD# input.

### Address Decoder

The address decoder (See Figure 1) is used for writing to the control logic of the HSP48901. Loading an internal register is done by selecting the destination register with the A0-2 address lines, placing the data on CINO-7, and asserting LD# control line. When LD# goes high, the data on CINO-7 is latched into the addressed register. The address map for the A0-2 bus is shown in Table 2.

While loading of the control logic registers is asynchronous to CLK, the target register in the control logic is being read synchronous to the internal clock. Therefore, care must be taken when modifying the convolver setup parameters during processing to avoid changing the contents of the registers near a rising edge of CLK. The required setup time relative to CLK is given by the specification TLCS. For example, in order to change the active coefficient register from CREG0 to CREG1 during an active convolution operation, a write will be performed to the address for selecting CREG1 for internal processing (A0-2 = 110). In order to provide proper uninterrupted operation, LD# should be deasserted at least TLCS prior to the next rising edge of CLK. Failure to meet this setup time may result in unpredictable results on the output of the convolver. Keep in mind that this requirement applies only to the case where changes are being made in the control logic during an active convolution operation. In a typical convolver configuration routine, where the configuration data is loaded prior to the actual convolution operation, this specification would not apply.

TABLE 2. ADDRESS MAP

CONTROL LOGIC ADDRESS MAP			
A2-0			FUNCTION
0	0	0	Reserved for future use
0	0	1	Reserved for future use
0	1	0	Load Coefficient Register 0 (CREG0)
0	1	1	Load Coefficient Register 1 (CREG1)
1	0	0	Load Initialization Register (INT)
1	0	1	Select CREG0 for Internal Processing
1	1	0	Select CREG1 for Internal Processing
1	1	1	No Operation

## Control Signals

### Hold

The HOLD control input provides the ability to disable internal clock and stop all operations temporarily. HOLD is sampled on the rising edge of CLK and takes effect during the following clock cycle (Refer to Figure 2). This signal can be used to momentarily ignore data at the input of the convolver while maintaining its current output data and operational state.

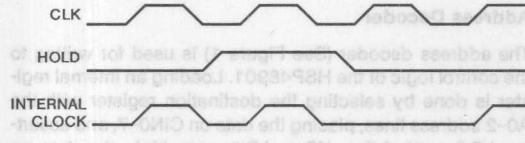


FIGURE 2. HOLD OPERATION

### FRAME#

The FRAME# input initializes all internal flip flops and registers except for the coefficient and initialization registers. It is used as a reset between video frames and eliminates the need to re-initialize the entire HSP48901 or reload the coefficients. The registers and flip flops will remain in a reset state as long as FRAME# is active. FRAME# is an asynchronous input and may occur at any time. However, it must be deasserted at least 10 ns prior to the rising clock edge that is to begin operation for the next frame in order to ensure the new pixel data is properly loaded.

### Operation

A single HSP48901 can be used to perform 3 x 3 convolution on 8-bit image data. A block diagram of this configuration is shown in Figure 3. The inputs of an external data buffer (such as the HSP9501) are connected to the input data in parallel with the DIN1(0-7) lines; the outputs of the data buffer are connected to the DIN2(0-7) bus. A second external data buffer is connected between the outputs of the first buffer and the DIN3(0-7) inputs. To perform the convolution operation, a group of nine image pixels is multiplied by the 3 x 3 array of filter coefficients and their products are summed and sent to the output. For the example in figure 3, the pixel value in the output image at location m,n is given by:

$$\begin{aligned} DOUT(m,n) = & A \times P_{m-1,n-1} + B \times P_{m-1,n} + C \times P_{m-1,n+1} \\ & + D \times P_{m,n-1} + E \times P_{m,n} + F \times P_{m,n+1} \\ & + G \times P_{m+1,n-1} + H \times P_{m+1,n} + I \times P_{m+1,n+1} \end{aligned}$$

This process is continually repeated until the last pixel of the last row of the image has been input. It can then start again with the first row of the next frame. The FRAME# pin is used to clear the internal multiplier registers and DOUT0-19 registers between frames. The row length of the image to be convolved is limited only by the maximum length of the external data buffers.

The setup is straightforward. The user must first setup the HSP48901 by loading a new value into the initialization register. The coefficients can now be loaded one at a time from A to I via the CIN0-7 coefficient bus, and the AO-2 and LD# control lines.

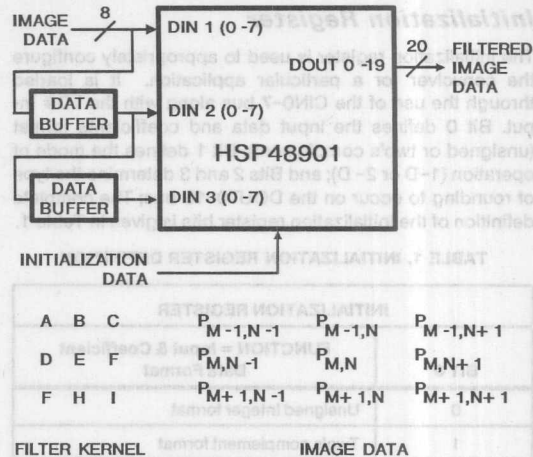


FIGURE 3. 3 x 3 KERNEL ON AN 8-BIT IMAGE

Multiple filter kernels can also be used on the same image data using the dual coefficient registers CREG0 and CREG1. This type of filtering is used when the characteristics of the input pixel data change over the image in such a way that no one filter produces satisfactory results for the entire image. In order to filter such an image, the characteristics of the filter itself must change while the image is being processed. The HSP48901 can perform this function with the use of an external processor. The processor is used to calculate the required new filter coefficients, loads them into the coefficient register not in use, and selects the newly loaded coefficient register at the proper time. The first coefficient register can then be loaded with new coefficients in preparation for the next change. This can be carried out with no interruption in processing, provided that the new register is selected synchronous to the convolver CLK signal.

The HSP48901 can also operate as a one dimensional 9 tap FIR filter by programming the initialization register to 1-D mode (i.e. INT bit 1 = '0'). This configuration will provide for nine sequential input values to be multiplied by the coefficient values in the selected coefficient register and provide the proper filtered output. The input bus to be used when operating in this mode is the DIN1(0-7) inputs.

The equation for the output in the 1-D 9-tap FIR case becomes:

$$\begin{aligned} DOUTn = & A \times Dn-8 + B \times Dn-7 + C \times Dn-6 + D \times Dn-5 \\ & + E \times Dn-4 + F \times Dn-3 + G \times Dn-2 + H \times Dn-1 \\ & + I \times Dn \end{aligned}$$

### Frame Rate

The total time to process an image is given by the formula:

$$T = R \times C / F$$

where:

T = Time to process a frame

R = number of rows in the image

C = number of pixels in a row

F = clock rate of the HSP48901

# Specifications HSP48901

## Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input, Output or I/O Voltage Applied .....	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature Range .....	-65°C to +150°C
Maximum Package Power Dissipation at +70°C .....	PGA Package = 2.56W, PLCC Package = 1.9W
Thermal Impedance Junction To Ambient ( $\theta_{JA}$ ) .....	PGA Package = 41°C/W, PLCC Package = 42.8°C/W
Thermal Impedance Junction To Case ( $\theta_{JC}$ ) .....	PGA Package = 16°C/W, PLCC Package = 14.9°C/W
Gate Count .....	13,594 Gates
Junction Temperature ( $T_J$ ) .....	PGA Package = +175°C, PLCC Package = +150°C
Lead Temperature (Soldering, Ten Seconds) .....	+300°C
ESD Classification .....	Class 1

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range .....	+4.75V to +5.25V
Operating Temperature Range .....	0°C to +70°C

## D.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C)

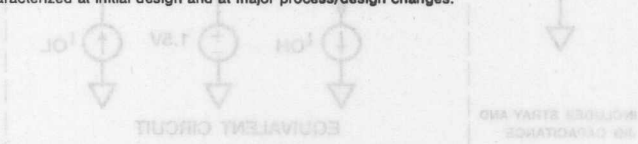
PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Logical One Input Voltage	VIH	2.0	-	V	$V_{CC} = 5.25V$
Logical Zero Input Voltage	VIL	-	0.8	V	$V_{CC} = 4.75V$
High Level Clock Input	VIHC	3.0	-	V	$V_{CC} = 5.25V$
Low Level Clock Input	VILC	-	0.8	V	$V_{CC} = 4.75V$
Output HIGH Voltage	VOH	2.6	-	V	$I_{OH} = -400\mu A$ , $V_{CC} = 4.75V$
Output LOW Voltage	VOL	-	0.4	V	$I_{OL} = +2.0mA$ , $V_{CC} = 4.75V$
Input Leakage Current	II	-10	10	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$
Standby Power Supply Current	ICCSB	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Outputs Open
Operating Power Supply Current	ICCOP	-	120	mA	$f = 20MHz$ , $V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ (Note 1)

## Capacitance ( $T_A = +25^\circ C$ , Note 2)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Input Capacitance	CIN	-	10	pF	FREQ = 1 MHz, $V_{CC}$ = Open, all measurements are referenced to device ground.
Output Capacitance	CO	-	15	pF	

NOTES: 1. Power supply current is proportional to operating frequency. Typical rating for ICCOP is 6mA/MHz.

2. Not tested, but characterized at initial design and at major process/design changes.



CAUTION: These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.



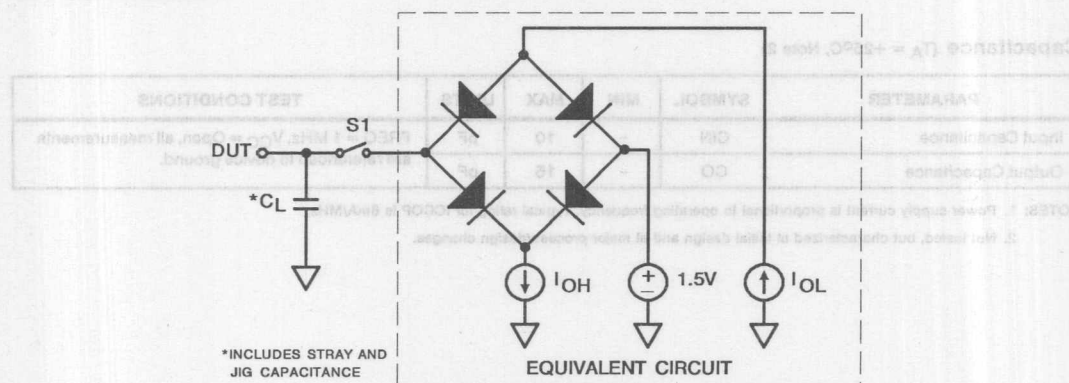
## Specifications HSP48901

### A.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to $+70^\circ C$ )

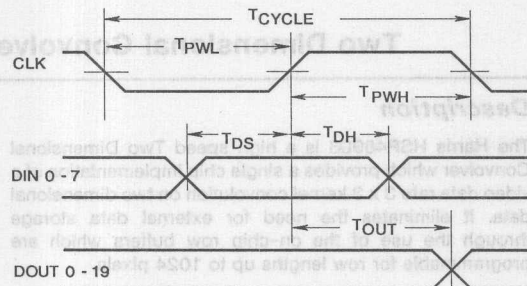
PARAMETER	SYMBOL	-30		-20		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
Clock Period	$T_{CYCLE}$	33	-	50	-	ns	
Clock Pulse Width High	$T_{PWH}$	13	-	20	-	ns	
Clock Pulse Width Low	$T_{PWL}$	13	-	20	-	ns	
Data Input Setup Time	$T_{DS}$	14	-	16	-	ns	
Data Input Hold Time	$T_{DH}$	0	-	0	-	ns	
Clock to Data Out	$T_{OUT}$	-	21	-	30	ns	
Address Setup Time	$T_{AS}$	5	-	5	-	ns	
Address Hold Time	$T_{AH}$	2	-	2	-	ns	
Configuration Data Setup Time	$T_{CS}$	10	-	12	-	ns	
Configuration Data Hold Time	$T_{CH}$	0	-	0	-	ns	
LD# Pulse Width	$T_{LPW}$	13	-	20	-	ns	
LD# Setup Time	$T_{LCS}$	31	$T_{CYCLE}+2$	40	$T_{CYCLE}+2$	ns	Note 1
HOLD Setup Time	$T_{HS}$	10	-	12	-	ns	
HOLD Hold Time	$T_{HH}$	0	-	0	-	ns	
FRAME# Pulse Width	$T_{FPW}$	$T_{CYCLE}$	-	$T_{CYCLE}$	-	ns	
FRAME# Setup Time	$T_{FS}$	28	-	40	-	ns	Note 2
Output Rise Time	$T_R$	-	8	-	8	ns	From 0.8V to 2.0V
Output Fall Time	$T_F$	-	8	-	8	ns	From 2.0V to 0.8V

- NOTES: 1. This specification applies only to the case where a change in the active coefficient register is being selected during a convolution operation. It must be met in order to achieve predictable results at the next rising clock edge. In most applications, this selection will be made asynchronously, and the  $T_{LCS}$  specification may be disregarded.
2. While FRAME# is asynchronous with respect to CLK, it must be deasserted a minimum of  $T_{FS}$  ns prior to the rising clock edge which is to begin loading new pixel data for the next frame.
3. A.C. Testing is performed as follows: Input levels (CLK Input) = 4.0V and 0V; Input levels (All other Inputs) = 0V to 3.0V; Input timing reference levels: (CLK) = 2.0V, (Others) = 1.5V; Other timing references:  $V_{OH} \geq 1.5V$ ,  $V_{OL} \leq 1.5V$ ; Output load per test load circuit with  $C_L = 40pF$ .

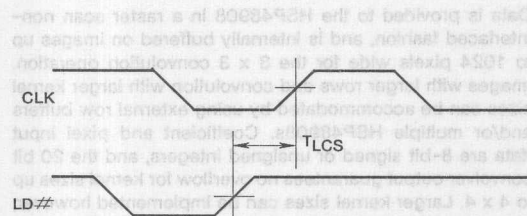
### Test Load Circuit



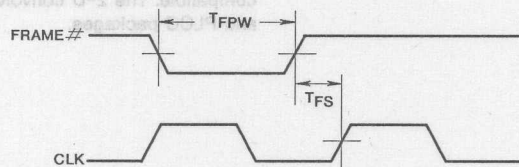
## Timing Waveforms



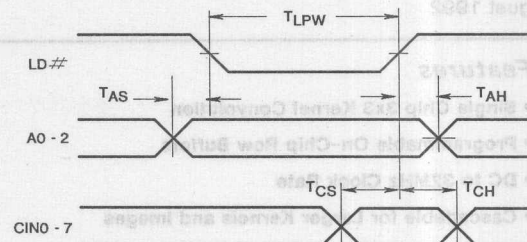
FUNCTIONAL TIMING



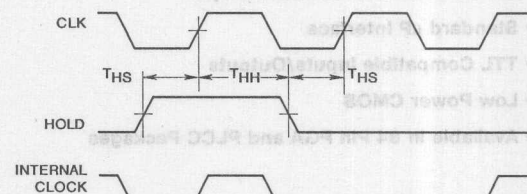
SYNCHRONOUS LOAD TIMING



FRAME# TIMING



CONFIGURATION TIMING



HOLD TIMING

August 1992

## Two Dimensional Convolver

### Features

- Single Chip 3x3 Kernel Convolution
- Programmable On-Chip Row Buffers
- DC to 32MHz Clock Rate
- Cascadable for Larger Kernels and Images
- On-Chip 8-Bit ALU
- Dual Coefficient Mask Registers, Switchable in a Single Clock Cycle
- 8-Bit Signed or Unsigned Input and Coefficient Data
- 20-Bit Extended Precision Output
- Standard  $\mu$ P Interface
- TTL Compatible Inputs/Outputs
- Low Power CMOS
- Available in 84 Pin PGA and PLCC Packages

### Applications

- Image Filtering
- Edge Detection
- Adaptive Filtering
- Real Time Video Filters

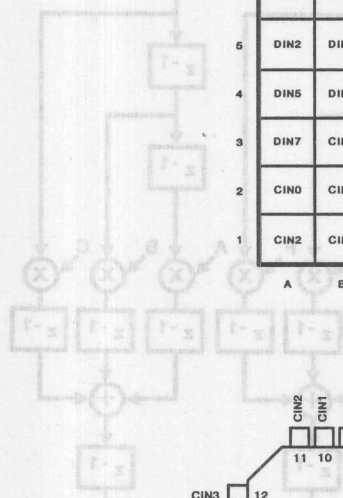
### Description

The Harris HSP48908 is a high speed Two Dimensional Convolver which provides a single chip implementation of a video data rate 3 x 3 kernel convolution on two dimensional data. It eliminates the need for external data storage through the use of the on-chip row buffers which are programmable for row lengths up to 1024 pixels.

There are internal register banks for storing two independent 3 x 3 filter kernels, thus facilitating the implementation of adaptive filters and multiple filter operations on the same data. The pixel data path also includes an on-chip ALU for performing real-time arithmetic and logical pixel point operations.

Data is provided to the HSP48908 in a raster scan non-interlaced fashion, and is internally buffered on images up to 1024 pixels wide for the 3 x 3 convolution operation. Images with larger rows and convolution with larger kernel sizes can be accommodated by using external row buffers and/or multiple HSP48908s. Coefficient and pixel input data are 8-bit signed or unsigned integers, and the 20 bit convolver output guarantees no overflow for kernel sizes up to 4 x 4. Larger kernel sizes can be implemented however, since the filter coefficients will normally be less than their maximum 8-bit values.

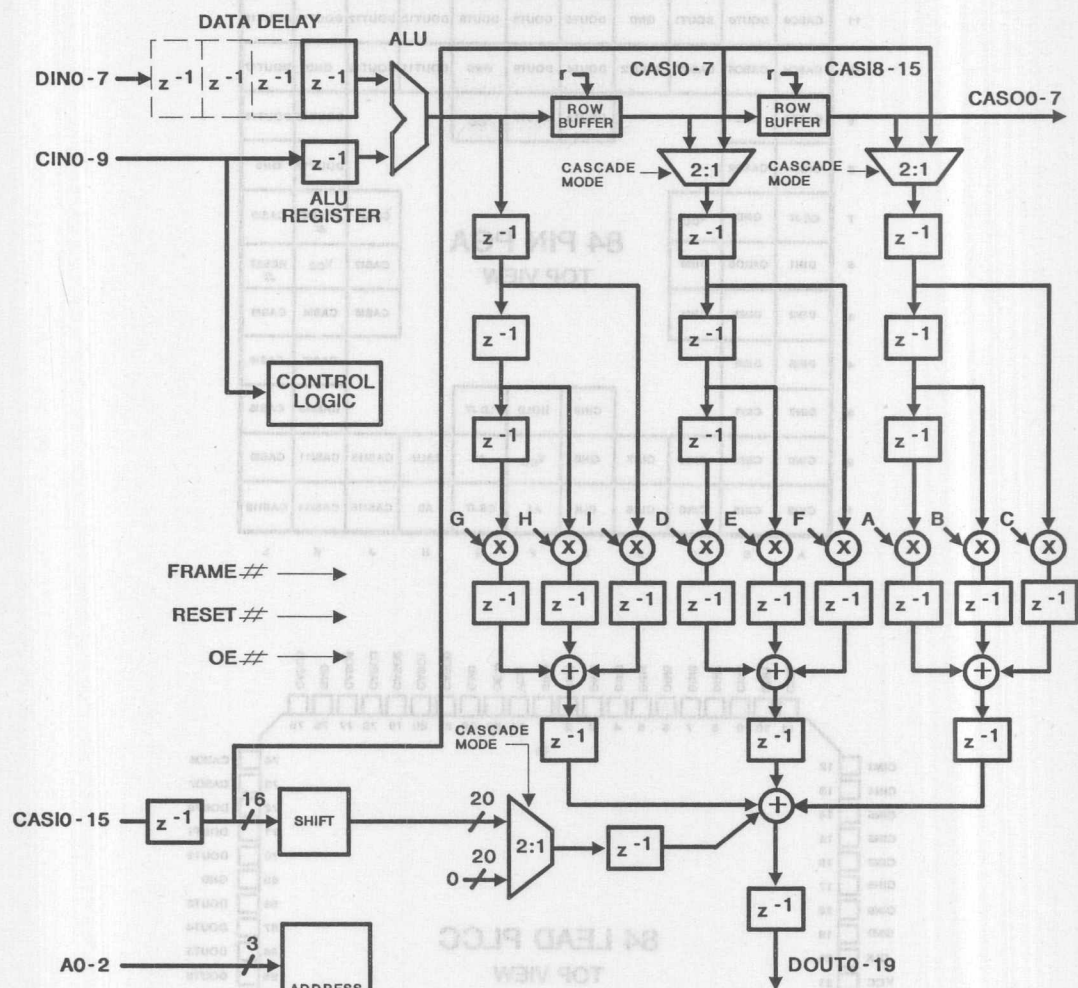
The HSP48908 is manufactured using an advanced CMOS process, and is a low power fully static design. The configuration of the device is controlled through a standard microprocessor interface and all inputs/outputs are TTL compatible. The 2-D convolver is available in 84 pin PGA and PLCC packages.



**84 LEAD PLCC**  
**TOP VIEW**



## Block Diagram



## Pin Descriptions

NAME	PLCC PIN	TYPE	DESCRIPTION
V <sub>CC</sub>	21, 42, 63, 84		The +5V power supply pins. 0.1µF capacitors between the V <sub>CC</sub> and GND pins are recommended.
GND	19, 48, 54, 61, 69, 76, 82		The device ground.
CLK	20	I	Input and System clock. Operations are synchronous with the rising edge of this clock signal.
DINO-7	1-8	I	Pixel Data input bus. This bus is used to provide the 8-bit pixel input data to the HSP48908. The data must be provided in a synchronous fashion, and is latched on the rising edge of the CLK signal.
CINO-9	9-18	I	Coefficient Input bus. This input bus is used to load the Coefficient Mask register(s), the Initialization register, the Row Buffer length register and the ALU microcode. It may also be used to provide a second operand input to the ALU. The definition of the CINO-9 bits is defined by the register address bits A0-2. The CINO-9 data is loaded to the addressed register through the use of the CS# and LD# inputs.
DOUTO-19	49-53, 55-60, 62, 64-68, 70-72	O	Output Data bus. This 20-Bit output port is used to provide the convolution result. The result is the sum of products of the input data samples and their corresponding coefficients. The Cascade inputs CASIO-15 may also be added to the result by selecting the appropriate cascade mode in the Initialization register.
CASIO-15	29-41, 43-45	I	Cascade Input bus. This bus is used for cascading multiple HSP48908s to allow convolution with larger kernels or row sizes. It may also be used to interface to external row buffers. The function of this bus is determined by the Cascade Mode bit (Bit 0) of the Initialization register. When this bit is set to a '0', the value on CASIO-15 is left shifted and added to DOUTO-19. The amount of the shift is determined by bits 7-8 of the Initialization register. While this mode is intended primarily for cascading, it may also be used to add an offset value, such as to increase the brightness of the convolved image.  When the Cascade mode bit is set to a '1', this bus is used for interfacing to external row buffers. In this mode the bus is divided into two 8-bit busses (CASIO-7 and CASIO-15), thus allowing two additional pixel data inputs. The cascade data is sent directly to the internal multiplier array which allows for larger row sizes without using multiple HSP48908s.
CASOO-7	73-75, 77-81	O	Cascade Output bus. This bus is used primarily during cascading to handle larger frames and/or kernel sizes. This output data is the data on DINO-7 delayed by twice the programmed internal row buffer length.
FRAME#	46	I	Frame# is an asynchronous new frame or vertical sync input. A low on this input resets all internal circuitry except for the Coefficient, ALU, AMC, EOR and INT registers. Thus, after a Frame# reset has occurred, a new frame of pixels may be convolved without reloading these registers.
EALU	28	I	Enable ALU Input. This control line gates the clock to the ALU Register. When it is high, the data on CINO-7 is loaded on the next rising clock edge. When EALU is low, the last value loaded remains in the ALU register.
HOLD	22	I	The Hold Input is used to gate the clock from all of the internal circuitry of the HSP48908. This signal is synchronous, is sampled on the rising edge of CLK and takes effect on the following cycle. While this signal is active (high), the clock will have no effect on the HSP48908 and internal data will remain undisturbed.
RESET#	47	I	Reset is an asynchronous signal which resets all internal circuitry of the HSP48908. All outputs are forced low in the reset state.
OE#	83	I	Output Enable. The OE# input controls the state of the Output Data bus (DOUTO-19). A LOW on this control line enables the port for output. When OE# is HIGH, the output drivers are in the high impedance state. Processing is not interrupted by this pin.

## Pin Descriptions (Continued)

NAME	PLCC PIN	TYPE	DESCRIPTION
A0-2	25-27	I	Control Register Address. These lines are decoded to determine which register in the control logic is the destination for the data on the CINO-9 inputs. Register loading is controlled by the A0-2, LD# and CS# inputs.
LD#	23	I	Load Strobe. LD# is used for loading the internal registers of the HSP48908. When CS# and LD# are active, the rising edge of LD# will latch the CINO-7 data into the register specified by A0-2.
CS#	24	I	Chip Select. The Chip Select input enables loading of the internal registers. When CS# is low, the A0-2 address lines are decoded to determine the meaning of the data on the CINO-7 bus. The rising edge of LD# will then load the addressed register.

## Functional Description

The HSP48908 two-dimensional convolver performs convolution of 3 x 3 filter kernels. It accepts the image data in raster scan, non-interlaced format, convolves it with the filter kernel and outputs the filtered image. The input and filter kernel data are both 8-bits, while the output data is 20-bits to prevent overflow during the convolution operation. The HSP48908 has internal storage for two 3 x 3 filter kernels and is capable of buffering two 1024 x 8-bit rows for true single chip operation at video frame rates. An 8-bit ALU in the input pixel data path allows the user to perform arithmetic and logical operations on the input data in real time during the convolution. Multiple devices can also be cascaded together for larger kernel convolution, larger frame sizes and increased precision.

Image data is input to the convolver via the DINO-7 bus. The data is then operated on by the ALU, stored in the row buffers and convolved with the 3 x 3 array of filter coefficients. The resultant output data is then latched into the output register. The row buffers are preprogrammed to the length of one row of the input image to enable the user to input the image data one pixel at a time in raster scan format without having to provide external storage.

Initialization of the convolver is done using the CINO-7 bus to load configuration data, such as the filter kernel(s) and the length of the row buffers. The address lines A0-2 are used to address the internal registers for initialization. The configuration data is loaded using the A0-2, CINO-9, CS# and LD# controls as address, data, chip select and write enable, respectively. This interface is compatible with standard microprocessors without the use of any additional glue logic.

Filtered image data comes out of the convolver over the DOUT0-19 bus. This output bus is 20-bits wide to provide room for growth during the convolution operation. The 20-bit bus will allow the use of up to 4 x 4 kernels (using multiple 48908's) without overflow. However, in practical applications, much larger kernel sizes can be implemented without overflow since the filter coefficients are typically much smaller than 8-bit full scale values. DOUT0-19 is also a registered, three state bus to facilitate cascading multiple chips and to allow the HSP48908 to reside on a standard microprocessor system bus.

Multiple convolvers can also be cascaded together for kernel sizes larger than 3 x 3 and for convolution on images with row lengths longer than 1024 pixels. The maximum kernel size is dependent upon the magnitude of the image data and the coefficients in a given application; care must always be taken with very large kernel sizes to prevent overflow of the 20-bit output.

## Data Input

Image data coming into the 2D Convolver passes through a programmable pipeline delay before being sent to the ALU. The amount of delay (1 to 4 clock cycles) is set in the initialization register during configuration setup (See Control Logic). Delays greater than one are used primarily in cascading multiple HSP48908s to align data sequences for proper output (See Operation).

## Arithmetic Logic Unit

The on-chip ALU provides the user with the capability of performing pixel point operations on incoming image data. Depending on the instruction in the ALU microcode register, the ALU can perform any one of 19 arithmetic and logical functions, and shift the resulting number left or right by up to 3 bits. Tables 1 and 2 show the available ALU functions and the 10-bit associated microcode to be loaded into the ALU microcode register. Note that the shifts take place on the output of the ALU and are completely independent of the logical or arithmetic operation being performed. The first input (A) of the ALU is taken from the pixel input bus (DINO-7). The second input (B) is taken from the ALU Register. The ALU Register is loaded via the CINO-7 bus while the EALU control line is valid (see EALU).

TABLE 1. ALU SHIFT OPERATIONS

ALU MICROCODE REGISTER			
REGISTER BIT			OPERATION
9	8	7	
0	0	0	No Shift (Default)
0	0	1	Shift Right 1
0	1	0	Shift Right 2
0	1	1	Shift Right 3
1	0	0	Shift Left 1
1	0	1	Shift Left 2
1	1	0	Shift Left 3
1	1	1	Not Valid

TABLE 2. ALU PIXEL OPERATIONS

REGISTER BIT							OPERATION
6	5	4	3	2	1	0	
0	0	0	0	0	0	0	Logical (00000000)
1	1	1	1	0	0	0	Logical (11111111)
0	0	1	1	0	0	0	Logical (A) (Default)
0	1	0	1	0	0	0	Logical (B)
1	1	0	0	0	0	0	Logical (A#)
1	0	1	0	0	0	0	Logical (B#)
0	1	1	0	0	0	1	Arithmetic (A + B)
1	0	0	1	0	1	0	Arithmetic (A - B)
1	0	0	1	1	0	0	Arithmetic (B - A)
0	0	0	1	0	0	0	Logical (A AND B)
0	0	1	0	0	0	0	Logical (A AND B#)
0	1	0	0	0	0	0	Logical (A# AND B)
0	1	1	1	0	0	0	Logical (A OR B)
1	0	1	1	0	0	0	Logical (A OR B#)
1	1	0	1	0	0	0	Logical (A# OR B)
1	1	1	0	0	0	0	Logical (A NAND B)
1	0	0	0	0	0	0	Logical (A NOR B)
0	1	1	0	0	0	0	Logical (A XOR B)
1	0	0	1	0	0	0	Logical (A XNOR B)

### EALU

The EALU control pin enables loading of the ALU Register. While the EALU line is high, the data on CINO-7 is latched into the ALU Register on the rising edge of CLK. When EALU goes low, the current value in the ALU register is held until EALU is again asserted. Note that the ALU loading operation makes use of the CINO-7 inputs, but is completely independent of CS# and LD#. Therefore, in order to prevent overwriting an internal register, care must be taken to ensure that CS# and LD# are not active during an EALU cycle.

### Programmable Row Buffers

The programmable row buffers are used for buffering raster input data for the convolution operation. They can be thought of as programmable shift registers which can each store up to 1024 8-bit values, thus delaying each pixel by up to 1024 clock cycles. Functionally, each row buffer can be represented as a set of registers connected as a 1024 x 8-bit serial shift register. The output of each buffer can be

represented by the equation  $Q = D(n-r)$ , where Q is the row buffer output, D is the buffer input, n is the current clock cycle and r is the preprogrammed row length of the input image. Since the two buffers are connected in series, the data at the cascade outputs (CASO0-7) is delayed by two row delays and may be used for cascading multiple convolvers for larger kernel sizes and/or row lengths. The programmable row buffers can also be bypassed by selecting the appropriate cascade mode in the initialization register. This mode allows the use of external row buffers for convolving with row lengths longer than 1024 pixels.

### 8-Bit Multiplier Array

The multiplier array consists of nine 8 x 8 multipliers. Each multiplier forms the product of a filter coefficient with a corresponding pixel in the input image. Input and coefficient data may be in either two's complement or unsigned integer format. The nine coefficients form a 3 x 3 filter kernel which is multiplied by the input pixel data and summed to form a sum of products for implementation of the convolution operation as shown below:

INPUT DATA			FILTER KERNEL
P1	P2	P3	
P4	P5	P6	
P7	P8	P9	

$$\begin{aligned} \text{OUTPUT} = & (A \times P1) + (B \times P2) + (C \times P3) \\ & + (D \times P4) + (E \times P5) + (F \times P6) \\ & + (G \times P7) + (H \times P8) + (I \times P9) \end{aligned}$$

### Control Logic

The control logic (Figure 1) contains the ALU Microcode Register, the Initialization Register, the Row Length Register, and the Coefficient Registers. The control logic is updated by placing data on the CINO-9 bus and using the A0-2, CS# and LD# control lines to write to the addressed register (see Address Decoder). All of the control logic registers are loaded with their default values on RESET#, and are unaffected by FRAME#.

### ALU Microcode Register

The ALU microcode register is used to store the command word for the ALU. The ALU command word is a 10-bit instruction divided into two fields: the lower 7 bits determine the ALU operation and the upper 3 bits specify the number of shifts which occur. The ALU command words are defined in Tables 1 and 2 (See ALU section).



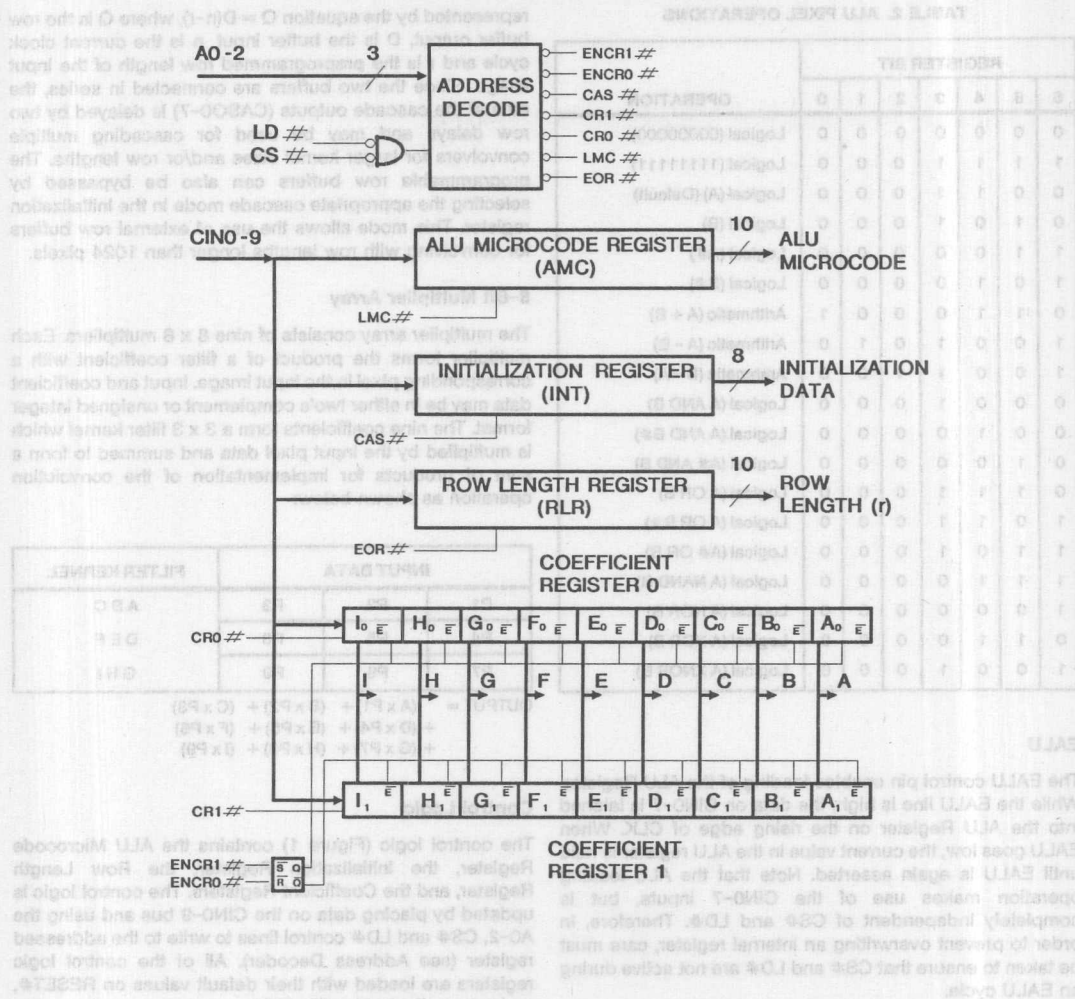


FIGURE 1. CONTROL LOGIC BLOCK DIAGRAM

## Initialization Register

The initialization register is used to appropriately configure the convolver for a particular application. It is loaded through the use of the CINO-7 bus along with the CS# and LD# inputs. Bit 0 defines the type of cascade mode to be used; Bits 1 and 2 select the number of delays to be included in the input pixel data path; Bits 3 and 4 define the input and coefficient data format; Bits 5 and 6 determine the type of rounding to occur on the DOUT0-19 bus; Bits 7 and 8 define the shift applied to the cascade input data. The complete definition of the initialization register bits is given in Table 3.

TABLE 3. INITIALIZATION REGISTER DEFINITION

INITIALIZATION REGISTER		
BIT 0		FUNCTION = CASCADE MODE
0		Multiplier input from internal row buffers
1		Multiplier input from external buffers
2 BIT 1		FUNCTION = INPUT DATA DELAY
0	0	No data delay registers used
0	1	One data delay register used
1	0	Two data delay registers used
1	1	Three data delay registers used
BIT 3		FUNCTION = INPUT DATA FORMAT
0		Unsigned integer format
1		Two's complement format
BIT 4		FUNCTION = COEFFICIENT DATA FORMAT
0		Unsigned integer format
1		Two's complement format
6 BIT 5		FUNCTION = OUTPUT ROUNDING
0	0	No Rounding
0	1	Round to 16 bits (i.e. DOUT19-4)
1	0	Round to 8 bits (i.e. DOUT19-12)
1	1	Not Valid
8 BIT 7		FUNCTION = CASIO-15 INPUT SHIFT
0	0	No Shift
0	1	Shift CASIO-15 left two
1	0	Shift CASIO-15 left four
1	1	Shift CASIO-15 left eight

## Row Length Register

The row length register is used to store the programmed number of delays for the internal row buffers. The programmed delay is set equal to the row length (r) of the input image. The input pixel data is stored in the row buffers to allow corresponding pixels of adjacent rows to be synchronously sent to the multiplier array for the convolution operation. The row length register is programmable with values from 0 to 1023, with 0 defined as a row length of 1024. Row lengths of 1 or 2 lead to meaningless results for a 3 x 3 kernel convolution, while a row length of 3 defines a 1 x 9 filter (See Operation section). The Row Length Register is written through the use of A0-2, CS# and LD#. Once the row length register has been loaded, the convolver must be reset before a new row length can be entered; failure to toggle RESET# before reloading the Row Length Register will result in the new value being ignored. After RESET# returns high, the user has 1024 cycles of CLK to load the Row Length Register. After 1024 CLK cycles, the Row Length Register is automatically set to 0 (row length = 1024) and further writes to this register are ignored.

## Coefficient Registers (CREG0, CREG1)

The control logic contains two coefficient register banks, CREG0 and CREG1. Each of these register banks is capable of storing nine 8-bit filter coefficient values (3 x 3 Kernel). The output of the registers are connected to the coefficient input of the corresponding multiplier in the 3 x 3 multiplier array (designated A through I). The register bank to be used for the convolution is selectable by writing to the appropriate address (See address decoder). All registers in a given bank are enabled simultaneously, and one of the banks is always active.

For most applications, only one of the register banks is necessary. The user can simply load CREG0 after power up, and use it for the entire convolution operation. (CREG0 is the default register). The alternate register bank allows the user to maintain two sets of filter coefficients and switch between them in real time. The coefficient masks are loaded via the CIN bus by using A0-2, CS# and LD#. The selection of the particular register bank to be used in processing is also done by writing to the appropriate address (See address decoder). For example, if CREG0 is being used to provide coefficients to the multipliers, CREG1 can be updated at a low rate by an external processor; then, at the proper time, CREG1 can be selected, so that the new coefficient mask is used to process the data. Thus, no clock cycles have been lost when changing between alternate 3 x 3 filter kernels.

The nine coefficients must be loaded sequentially over the CINO-7 bus from A to I. The address of CREG0 or CREG1 is placed on A0-2, and then the nine coefficients are written to the corresponding coefficient register one at a time by using the CS# and LD# inputs.

### Address Decoder

The address decoder (See Figure 1) is used for writing to the control logic of the HSP48908. Loading an internal register is done by selecting the destination register with the A0-2 address lines, placing the data on CINO-9, and asserting the CS# and LD# control lines. When either CS# or LD# goes high, the data on the CINO-9 lines is latched into the addressed register. The address map for the A0-2 bus is shown in Table 4.

While loading of the control logic registers is asynchronous to CLK, the target register in the control logic is being read synchronous to the internal clock. Therefore, care must be taken when modifying the convolver setup parameters during processing to avoid changing the contents of the registers near a rising edge of CLK. The required setup time relative to CLK is given by the specification TLCS. For example, in order to change the active coefficient register from CREG0 to CREG1 during an active convolution operation, a write will be performed to the address for selecting CREG1 for internal processing (A2=0=110). In order to provide proper uninterrupted operation, LD# should be deasserted at least TLCS prior to the next rising edge of CLK. Failure to meet this setup time may result in unpredictable results on the output of the convolver for one clock cycle. Keep in mind that this requirement applies only to the case where changes are being made in the control logic during an active convolution operation. In a typical convolver configuration routine, this specification would not be applicable.

TABLE 4. ADDRESS MAP

CONTROL LOGIC ADDRESS MAP	
A2-0	Function
0 0 0	Load Row Length Register (RLR)
0 0 1	Load ALU Microcode Register (AMC)
0 1 0	Load Coefficient Register 0 (CREG0)
0 1 1	Load Coefficient Register 1 (CREG1)
1 0 0	Load Initialization Register (INT)
1 0 1	Select CREG0 for Internal Processing
1 1 0	Select CREG1 for Internal Processing
1 1 1	No Operation

### Cascade I/O

#### Cascade Input

The cascade input lines (CASIO-15) have two primary functions. The first is used to allow convolutions with kernel sizes larger than 3 x 3. This can be implemented by connecting the DOUT bus of one convolver to the cascade inputs of another. The second function is for convolution on images wider than 1024 pixels. This type of operation can be implemented by using external row buffers to supply the pixel input data to the CASIO-15 inputs. The cascade input functions are determined by Initialization Register bit 0. When this bit is set to a '0', the cascade input data is added

to the convolver output. In this manner, multiple convolvers can be used to implement larger kernel convolution. When Initialization Register bit 0 is a '1', the data on CASIO-15 is divided into two 8-bit portions and is sent to the 3 x 3 multiplier array (Refer to Block Diagram). This mode of operation allows the use of external row buffers for convolution of images with row sizes larger than 1024. Examples of these configurations are given in the Operations section of this specification.

The data on the cascade inputs (CASIO-15) can also be left shifted by 0, 2, 4, or 8 bits. The amount of shift is determined by bits 7 and 8 of the Initialization Register (See Table 3). CASIO-15 is shifted by the specified number of bits and is added to the 20-bit output DOUT 0-19. The shifting function provides a method for cascading multiple HSP48908s and allowing a selectable amount of output growth while maximizing the resolution of the convolver result.

The cascade inputs can also be used as a simple way to add an offset to the convolved image. Bit 0 of the configuration register would be set to '0', and the desired offset placed on the CASIO-15 inputs. While multiple offsets can be used and changed during the convolution operation, note that the required data setup and hold times with respect to CLK (TDS and TDH) must be met.

#### Cascade Output

The cascade output lines (CASOO-7) are outputs from the second row buffer. Data at these outputs is the input pixel data delayed by two times the preprogrammed value in the row length register. The cascade outputs are used to cascade multiple convolvers by connecting the cascade outputs of one device to the data inputs of another (See Operation section).

### Control Signals

#### HOLD

The HOLD control input provides the ability to disable internal clock and stop all operations temporarily. HOLD is sampled on the rising edge of CLK and takes effect during the following clock cycle (Refer to Figure 2). This signal can be used to momentarily ignore data at the input of the convolver while maintaining its current output data and operational state.

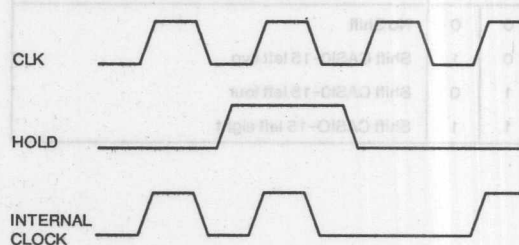


FIGURE 2. HOLD OPERATION



**RESET#**

The RESET# signal initializes all internal flip flops and registers in the HSP48908. It is an asynchronous signal, and the convolver will remain in the reset state as long as RESET# is asserted. On reset, all internal registers are set to zero or their default values, and all outputs are forced low. Following a reset, the default values in the internal registers will define the following mode of operation: internal row buffers used, line length = 1024, no input data delay, logical A operation: output of ALU = A input (DINO-7) output rounding and unsigned input data format.

The convolver can be reset at any time, but must be reset before updating the Row Length register in order to provide proper operation. After RESET# returns high, the user has 1024 cycles of CLK to load the Row Length Register. After 1024 CLK cycles, the Row Length Register is automatically set to 0 (row length = 1024) and further writes to this register are ignored.

**FRAME#**

This FRAME# input initializes all internal flip flops and registers except for the coefficient, ALU, ALU microcode, row length, and initialization registers. It is used to reset the convolver between video frames and eliminates the need to re-initialize the entire convolver or reload the coefficients. FRAME# is an asynchronous input and may occur at any time. However, it must be deasserted at least TFS ns prior to the rising clock edge that is to begin operation for the next frame. While FRAME# is asserted, the registers and flip-flops will remain in the reset state.

**Operation**

The HSP48908 has three basic modes of operation: single chip mode, operation with external row buffers and multiple devices cascaded together for larger convolution kernels and/or longer row lengths. The mode of operation is defined by the contents of the initialization register, and can be modified at any time by a microprocessor or other external means.

**Single Chip Mode**

A single HSP48908 can be used to perform 3 x 3 convolution on 8-bit image data with row lengths up to 1024. A block diagram of this configuration is shown in Figure 3. In this mode of operation, the image data is input into the DINO-7 bus in a raster scan order starting with the upper left pixel. To perform the convolution operation, a group of nine image pixels is multiplied by the 3 x 3 array of filter coefficients and their products are summed and sent to the output. For the example in Figure 3, the pixel value in the output image at location (m, n) is given by:

$$P_{OUT(m,n)} = (A \times P_{m-1,n-1}) + (B \times P_{m-1,n}) + (C \times P_{m-1,n+1}) \\ + (D \times P_{m,n-1}) + (E \times P_{m,n}) + (F \times P_{m,n+1}) \\ + (G \times P_{m+1,n-1}) + (H \times P_{m+1,n}) + (I \times P_{m+1,n+1})$$

This process is continually repeated until the last pixel of the last row of the image has been input. It can then start again with the first row of the next frame. The FRAME# pin is used

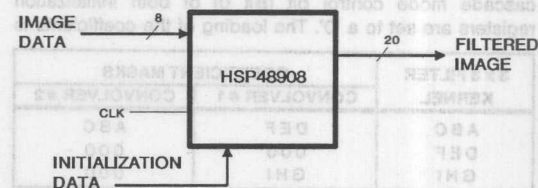
to clear the row buffers, multiplier input latches and DOUT0-19 registers between frames.

The setup for single chip operation is straightforward. After reset, the convolver is configured for row lengths of 1024 pixels, no input data delay, no ALU pixel point operations, no output rounding, and an unsigned input format. The user can change this default setup by loading new values into the ALU microcode, initialization and row length registers. RESET# also clears the coefficient registers and CREG0 is selected for internal processing. The user can now load the coefficients one at a time from A to I via the CINO-7 inputs and the LD# and CS# control lines.

Multiple filter kernels can also be used on the same image data using the dual coefficient registers CREG0 and CREG1. This type of filtering is used when the characteristics of the input pixel data change over the image in such a way that no single filter produces satisfactory results for the entire image. In order to filter such an image, the characteristics of the filter itself must change while the image is being processed. The HSP48908 can perform this function with the use of an external processor. The processor is used to calculate the required new filter coefficients, loads them into the coefficient register not in use, and selects the newly loaded coefficient register at the proper time. The first coefficient register can then be loaded with new coefficients in preparation for the next change. This can be carried out with no interruption in processing, provided that the new register is selected synchronous to the convolver CLK signal.

The HSP48908 can also operate as a one dimensional 9 tap FIR filter by programming the row buffer length register with a value of 3 and setting the initialization register bit 0 to a '0'. This configuration will provide for nine sequential input values in the input to be multiplied by the coefficient values in the selected coefficient register and provide the proper filtered output. The equation for the output then becomes:

$$DOUT_n = A \times D_{n-8} + B \times D_{n-7} + C \times D_{n-6} + D \times D_{n-5} \\ + E \times D_{n-4} + F \times D_{n-3} + G \times D_{n-2} + H \times D_{n-1} \\ + I \times D_n$$



FILTER KERNEL		IMAGE DATA		
A	B	$P_{m-1,n-1}$	$P_{m-1,n}$	$P_{m-1,n+1}$
D	E	$P_{m,n-1}$	$P_{m,n}$	$P_{m,n+1}$
G	H	$P_{m+1,n-1}$	$P_{m+1,n}$	$P_{m+1,n+1}$

FIGURE 3. 3 x 3 KERNEL ON AN 8-BIT, 1024 x N IMAGE



### Use Of External Row Buffers

External row buffers may be used when frames with row sizes larger than 1024 pixels are desired. To use the HSP48908 in this mode, the cascade mode control bit (bit 0) of the initialization register is set to '1' to allow the data on the cascade inputs CASIO-15 to go to the multiplier array. The inputs of one external row buffer (such as the HSP9500) are connected to the input data in parallel with the DINO-7 lines of the convolver; and its outputs are connected to the CASIO-7 inputs (See Figure 4). A second external row buffer is connected between the outputs of the first row buffer and the CASIO-15 inputs of the convolver. The convolution operation can then be performed by the HSP48908 in the same manner as the single chip mode. The row length in this configuration is limited only by the maximum length of the external row buffers. Note that when using the convolver in this configuration, the programmable input data delays and ALU will only operate on the data entering the DINO-7 inputs (i.e. the bottom row of the 3 x 3 sum of products). If higher order filters or pixel point operations are required when using external row buffers, these functions must be implemented externally by the user.

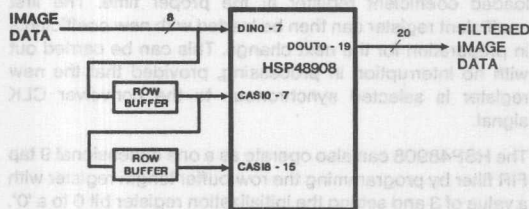


FIGURE 4. USING EXTERNAL ROW BUFFERS WITH THE HSP48908

### Cascading Multiple HSP48908's

Multiple HSP48908s are capable of being cascaded to perform convolution on images with row lengths longer than 1024 pixels and with kernel sizes larger than 3 x 3. Figure 5 illustrates the use of two HSP48908s to perform a 3 x 3 kernel convolution on a 2K x N frame. In this case, the cascade mode control bit (Bit 0) of both initialization registers are set to a '0'. The loading of the coefficients is

3 x 3 FILTER KERNEL	COEFFICIENT MASKS	
	CONVOLVER #1	CONVOLVER #2
ABC	DEF	ABC
DEF	000	000
GHI	GHI	000

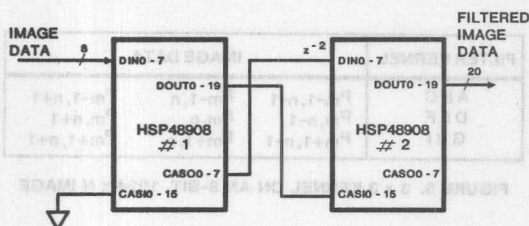


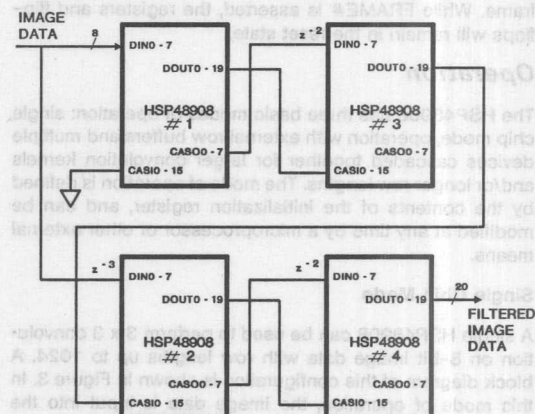
FIGURE 5. 3 x 3 KERNEL CONVOLUTION ON A 2K x N IMAGE

accomplished just as before. However, the 3 x 3 mask is divided into two portions for proper convolution output as follows: Convolver #1 = DEF000GHI and Convolver #2 = ABC000000.

The same configuration can be used to perform 3 x 5 convolution on a 1K x N frame simply by setting up the coefficients of the convolvers to implement the 3 x 5 mask as indicated below:

3 x 5 FILTER KERNEL	COEFFICIENT MASKS	
	CONVOLVER #1	CONVOLVER #2
ABC	GHI	ABC
DEF	JKL	DEF
GHI	MNO	000
JKL		
MNO		

In addition to larger frames, larger kernels can also be addressed through cascading. An example of the configuration for a 5 x 5 kernel convolution on a 1K x N frame is shown in Figure 6. Note that in this configuration, convolver #2 incorporates a 3 clock cycle delay ( $z^{-3}$ ) and convolvers 3 and 4 incorporate 2 clock cycle delays ( $z^{-2}$ ) at their pixel inputs. These delays are required to ensure proper data alignment in the final sum of products output of the cascaded convolvers. The number of delays required at the pixel input is programmable through the use of bits 1 and 2 of the initialization register (Refer to Table 3).



5 x 5 FILTER KERNEL	CONVOLVER COEFFICIENT MASKS	
	CONVOLVER #1	CONVOLVER #2
ABCDE	OKL	OAB
FGHIJ	OPQ	0FG
KLMNO	0UV	000
PQRST		
UVWXY		
	MNO	CDE
	RST	HIJ
	WXY	000

FIGURE 6. 5 x 5 KERNEL CONVOLUTION ON A 1K x N IMAGE

In any of the cascade configurations, only 16 bits of the 20-bit output (DOUT0-19) can be connected to the 16 cascade inputs (CASIO-15) of another convolver. Which 16 bits are chosen depends upon the amount of growth expected at the convolver output. The amount of growth is dependent on the input pixel data and the coefficients selected for the convolution operation. The maximum possible growth is calculated in advance by the user, and the convolvers are set up to appropriately shift the cascade input data through the use of bits 7 and 8 of the initialization register (See Cascade I/O). Referring to Figure 6, if the maximum growth out of convolver #1 extends into bit 16 or 17, then DOUT2-17 are connected to the cascade inputs of convolver #3, which is programmed to shift the input data left by two bits. Likewise, if the data out of convolver #3 grows into bit 18 or 19, then DOUT4-19 are connected to the CASIO-15 inputs of convolver #2, which is programmed to shift the input left by 4 bits.

#### Cascading For Row Sizes Larger Than 1024

Combining large images with large kernels is accomplished by implementing external row buffers, external data delay registers and external adders. Figure 7 illustrates a circuit

for implementation of a  $5 \times 5$  convolution on a  $2K \times N$  image. The  $5 \times 5$  coefficient mask is again distributed among the four HSP48908's. The width of the DOUT path to be used in this case is dependent on the amount of resolution required and the amount of growth expected at the output.

#### Frame Rate

The total time to process an image is given by the formula:

$$T = R \times C / F$$

where:

T = time to process a frame

R = number of rows in the image

C = number of pixels in a row

F = clock rate of the HSP48908

Note that the size of the kernel does not enter into the equation. Convolvers cascaded for larger kernels or larger frame sizes, as in the examples shown, process the image in the same amount of time as a single HSP48908 convolving the image with a  $3 \times 3$  kernel. Therefore, there is no performance degradation when cascading multiple HSP48908s.

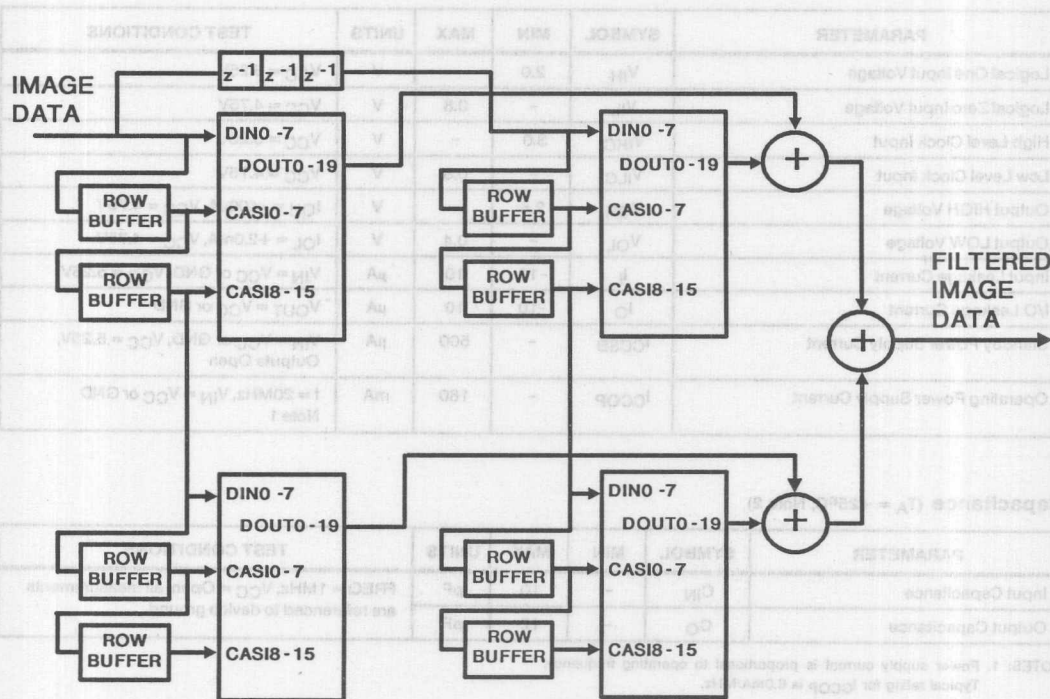


FIGURE 7.  $5 \times 5$  KERNEL CONVOLUTION ON A  $2K \times N$  IMAGE

## Specifications HSP48908

### Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input, Output or I/O Voltage Applied .....	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature Range .....	-65°C to +150°C
Maximum Package Power Dissipation @ 70°C .....	2.46W (PLCC), 3.04W (PGA)
Thermal Impedance Junction To Case ( $\theta_{JC}$ ) .....	10.26°C/W (PLCC), 7.73°C/W (PGA)
Thermal Impedance Junction To Ambient ( $\theta_{JA}$ ) .....	32.47°C/W (PLCC), 34.56°C/W (PGA)
Gate Count .....	190,000 Transistors
Maximum Junction Temperature ( $T_J$ ) .....	150°C (PLCC), 175°C (PGA)
Lead Temperature (Soldering, Ten Seconds) .....	+300°C
ESD Classification .....	Class 1

**CAUTION:** Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### Operating Conditions

Operating Voltage Range .....	+4.75V to +5.25V
Operating Temperature Range .....	0°C to +70°C

### D.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Logical One Input Voltage	$V_{IH}$	2.0	-	V	$V_{CC} = 5.25V$
Logical Zero Input Voltage	$V_{IL}$	-	0.8	V	$V_{CC} = 4.75V$
High Level Clock Input	$V_{IHC}$	3.0	-	V	$V_{CC} = 5.25V$
Low Level Clock Input	$V_{ILC}$	-	0.8	V	$V_{CC} = 4.75V$
Output HIGH Voltage	$V_{OH}$	2.6	-	V	$I_{OH} = -400\mu A$ , $V_{CC} = 4.75V$
Output LOW Voltage	$V_{OL}$	-	0.4	V	$I_{OL} = +2.0mA$ , $V_{CC} = 4.75V$
Input Leakage Current	$I_I$	-10	10	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$
I/O Leakage Current	$I_O$	-10	10	$\mu A$	$V_{OUT} = V_{CC}$ or GND
Standby Power Supply Current	$I_{CCSB}$	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Outputs Open
Operating Power Supply Current	$I_{CCOP}$	-	160	mA	$f = 20MHz$ , $V_{IN} = V_{CC}$ or GND Note 1

### Capacitance ( $T_A = +25^\circ C$ , Note 2)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Input Capacitance	$C_{IN}$	-	10	pF	FREQ = 1 MHz, $V_{CC} =$ Open, all measurements are referenced to device ground.
Output Capacitance	$C_O$	-	12	pF	

NOTES: 1. Power supply current is proportional to operating frequency.  
Typical rating for  $I_{CCOP}$  is 8.0mA/MHz.

2. Not tested, but characterized at initial design and at major process/design changes.

**CAUTION:** These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.

PARAMETER	SYMBOL	MIN	MAX	MIN	MAX	UNITS	CONDITIONS
Clock Period	T <sub>CYCLE</sub>	31	-	50	-	ns	
Clock Pulse Width High	T <sub>PWH</sub>	12	-	20	-	ns	
Clock Pulse Width Low	T <sub>PWL</sub>	13	-	20	-	ns	
Data Input Setup Time	T <sub>DS</sub>	13	-	14	-	ns	
Data Input Hold Time	T <sub>DH</sub>	0	-	0	-	ns	
Clock to Data Out	T <sub>OUT</sub>	-	16	-	22	ns	
Address Setup Time	T <sub>AS</sub>	13	-	13	-	ns	
Address Hold Time	T <sub>AH</sub>	0	-	0	-	ns	
Configuration Data Setup Time	T <sub>CDS</sub>	14	-	16	-	ns	
Configuration Data Hold Time	T <sub>CDH</sub>	0	-	0	-	ns	
LD# Pulse Width	T <sub>LPW</sub>	12	-	20	-	ns	
LD# Setup Time	T <sub>LCS</sub>	25	-	30	-	ns	Note 1
CIN0-7 Setup to CLK	T <sub>Cs</sub>	14	-	16	-	ns	
CS# Setup To LD#	T <sub>CSS</sub>	0	-	0	-	ns	
CIN0-7 Hold Time From CLK	T <sub>CH</sub>	0	-	0	-	ns	
CS# Hold From LD#	T <sub>CSH</sub>	0	-	0	-	ns	
RESET# Pulse Width	T <sub>RPW</sub>	31	-	50	-	ns	
FRAME# Setup To Clock	T <sub>FS</sub>	21	-	25	-	ns	Note 2
FRAME# Pulse Width	T <sub>FPW</sub>	31	-	50	-	ns	
EALU Setup Time	T <sub>ES</sub>	12	-	14	-	ns	
EALU Hold Time	T <sub>EH</sub>	0	-	0	-	ns	
HOLD Setup Time	T <sub>HS</sub>	11	-	12	-	ns	
HOLD Hold Time	T <sub>HH</sub>	1	-	1	-	ns	
Output Enable Time	T <sub>EN</sub>	-	16	-	22	ns	Note 3
Output Disable Time	T <sub>OZ</sub>	-	28	-	32	ns	Note 5
Output Rise Time	T <sub>R</sub>	-	6	-	6	ns	From 0.8 to 2.0 V Note 5
Output Fall Time	T <sub>F</sub>	-	6	-	6	ns	From 2.0 to 0.8 V Note 5

NOTES: 1. This specification applies only to the case where the HSP48908 is being written to during an active convolution cycle. It must be met in order to achieve predictable results at the next rising clock edge. In most applications, the configuration data and coefficients are loaded asynchronously and the T<sub>LCS</sub> specification may be disregarded.

2. While FRAME# is an asynchronous signal, it must be deasserted a minimum of T<sub>FS</sub> ns prior to the rising clock edge which is to begin loading pixel data for a new frame.

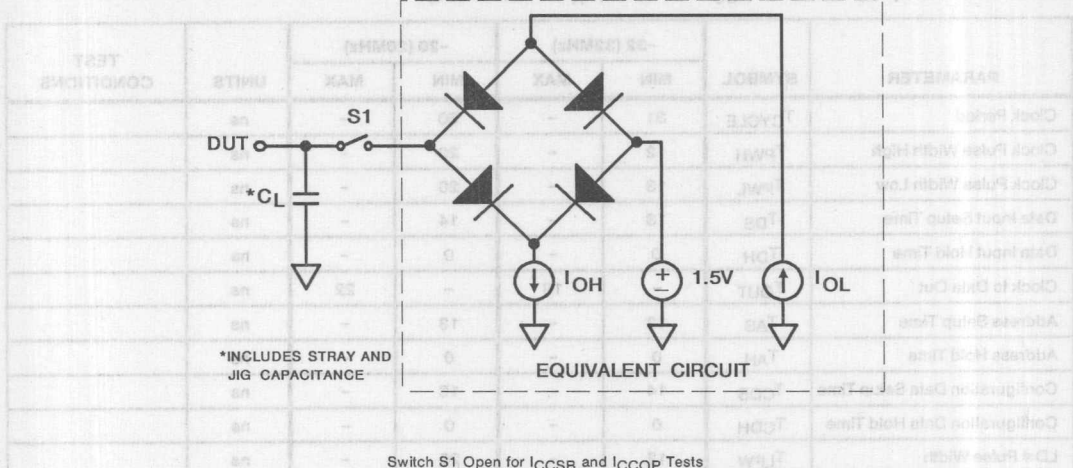
3. Transition is measured at  $\pm 200$  mV from steady state voltage with loading as specified in test load circuit with C<sub>L</sub> = 40pF.

4. A.C. Testing is performed as follows: Input levels (CLK Input) 4.0 and 0V, Input levels (All other Inputs) 0V and 3.0V, Timing reference levels (CLK) = 2.0V, (Others) = 1.5V, Output load per test load circuit with C<sub>L</sub> = 40pF. Output transition is measured at V<sub>OH</sub>  $\geq$  1.5V and V<sub>OL</sub>  $\leq$  1.5V.

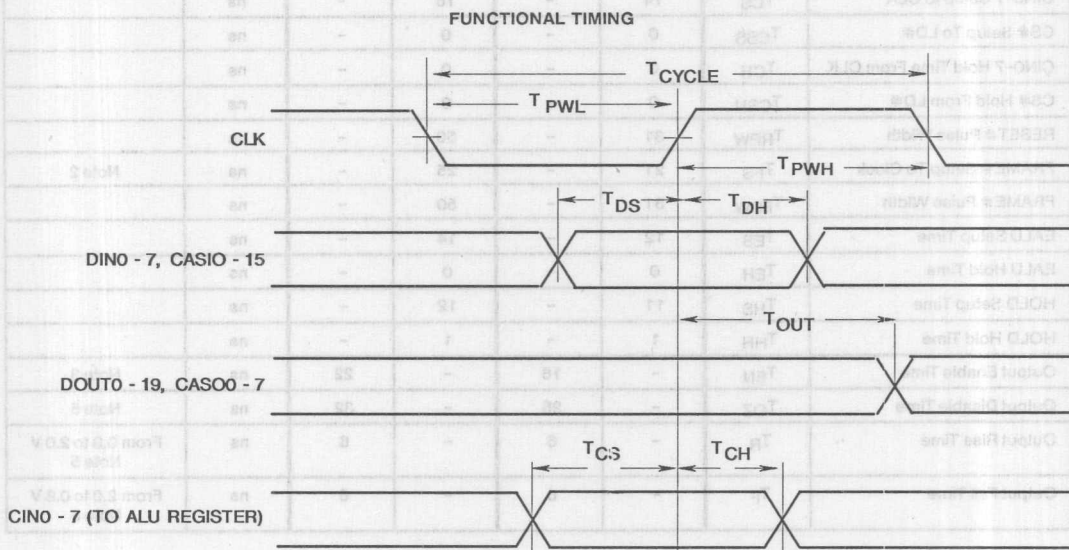
5. Controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.

CAUTION: These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.

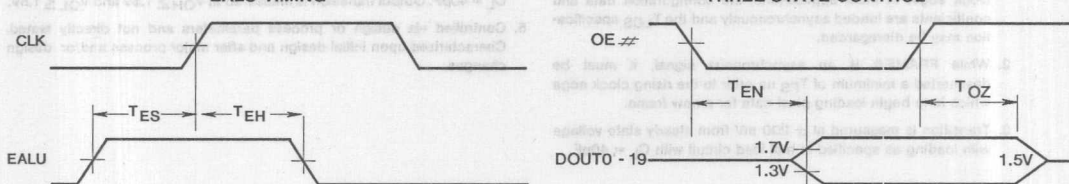




## FUNCTIONAL TIMING

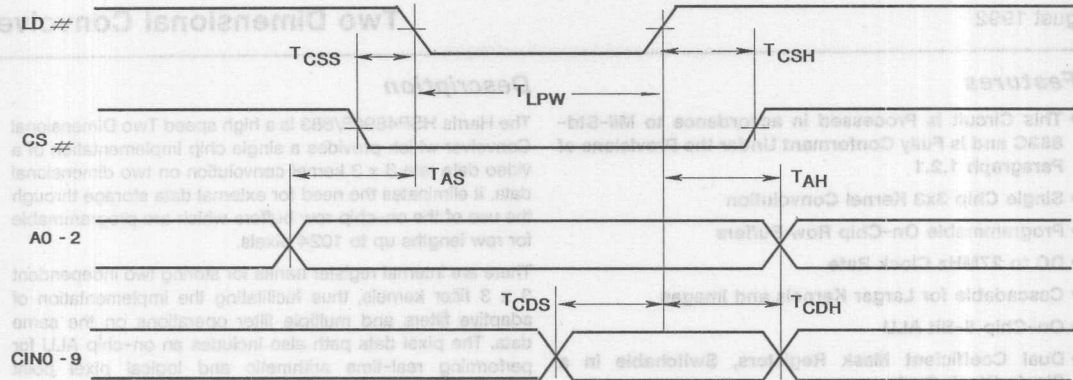


### THREE STATE CONTROL

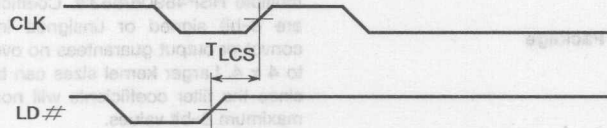


## Timing Waveforms (Continued)

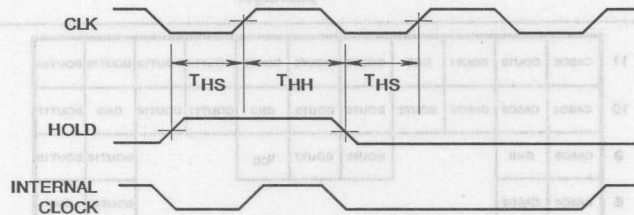
## CONFIGURATION TIMING



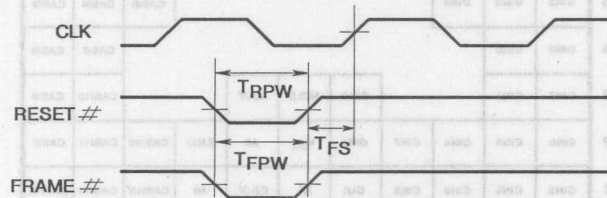
## SYNCHRONOUS LOAD TIMING



## HOLD TIMING



## FRAME#/RESET# TIMING



**HARRIS**

# HSP48908/883

August 1992

## Two Dimensional Convolver

### Features

- This Circuit is Processed in accordance to Mil-Std-883C and is Fully Conformant Under the Provisions of Paragraph 1.2.1
- Single Chip 3x3 Kernel Convolution
- Programmable On-Chip Row Buffers
- DC to 27MHz Clock Rate
- Cascadable for Larger Kernels and Images
- On-Chip 8-Bit ALU
- Dual Coefficient Mask Registers, Switchable in a Single Clock Cycle
- 8-Bit Signed or Unsigned Input and Coefficient Data
- 20-Bit Extended Precision Output
- Standard  $\mu P$  Interface
- TTL Compatible Inputs/Outputs
- Low Power CMOS
- Available in 84 Pin PGA Package

### Applications

- Image Filtering
- Edge Detection
- Adaptive Filtering
- Real Time Video Filters

### Description

The Harris HSP48908/883 is a high speed Two Dimensional Convolver which provides a single chip implementation of a video data rate 3 x 3 kernel convolution on two dimensional data. It eliminates the need for external data storage through the use of the on-chip row buffers which are programmable for row lengths up to 1024 pixels.

There are internal register banks for storing two independent 3 x 3 filter kernels, thus facilitating the implementation of adaptive filters and multiple filter operations on the same data. The pixel data path also includes an on-chip ALU for performing real-time arithmetic and logical pixel point operations.

Data is provided to the HSP48908/883 in a raster scan non-interlaced fashion, and is internally buffered on images up to 1024 pixels wide for the 3 x 3 convolution operation. Images with larger rows and convolution with larger kernel sizes can be accommodated by using external row buffers and/or multiple HSP48908/883's. Coefficient and pixel input data are 8-bit signed or unsigned integers, and the 20 bit convolver output guarantees no overflow for kernel sizes up to 4 x 4. Larger kernel sizes can be implemented however, since the filter coefficients will normally be less than their maximum 8-bit values.

The HSP48908/883 is manufactured using an advanced CMOS process, and is a low power fully static design. The configuration of the device is controlled through a standard microprocessor interface and all inputs/outputs are TTL compatible. The 2-D convolver is available in 84 pin PGA package.

### Pinout

HSP48908/883 (PGA)  
TOP VIEW



CAUTION: These devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
Copyright © Harris Corporation 1992

File Number **2783.2**

# Specifications HSP48908/883

## Absolute Maximum Ratings

Supply Voltage ..... +8.0V  
 Input, Output or I/O Voltage Applied .... GND-0.5V to  $V_{CC}+0.5V$   
 Storage Temperature Range ..... -65°C to +150°C  
 Junction Temperature ..... +175°C  
 Lead Temperature (Soldering 10 sec) ..... +300°C  
 ESD Classification ..... Class 1

## Reliability Information

Thermal Resistance  $\theta_{ja}$   $\theta_{jc}$   
 Ceramic PGA Package ..... 34.56°C/W 7.73°C/W  
 Maximum Package Power Dissipation at +125°C  
 Ceramic PGA Package ..... 1.45W  
 Gate Count ..... 190,000 Transistors

CAUTION: Absolute maximum ratings are limiting values, applied individually beyond which the serviceability of the circuit may be impaired. Functional operability under any of these conditions is not necessarily implied.

## Recommended Operating Conditions

Operating Temperature Range ..... -55°C to +125°C  
 Operating Voltage Range ..... +4.5V to +5.5V

TABLE 1. D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

D.C. PARAMETERS	SYMBOL	CONDITIONS	GROUP A SUBGROUP	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical 1 Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical 0 Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Clock Input High	$V_{IHC}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	3.0	-	V
Clock Input Low	$V_{ILC}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +2.0mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output or I/O Leakage Current	$I_O$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ Outputs Open (Note 4)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 20.0MHz$ $V_{CC} = 5.5V$ Outputs Open, (Notes 2, 4)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	160.0	mA
Functional Test	FT	(Notes 3, 4)	7, 8	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	-	-

NOTES: 1. Interchanging of force and sense conditions is permitted.

2. Operating Supply Current is proportional to frequency, typical rating is 8.0mA/MHz.

3. Tested as follows:  $f = 1MHz$ ,  $V_{IH} = 2.6$ ,  $V_{IL} = 0.4$ ,  $V_{OH} \geq 1.5V$ ,  $V_{OL} \leq 1.5V$ ,  $V_{IHC} = 3.4V$ , and  $V_{ILC} = 0.4V$ .

4. Loading is as specified in the test load circuit with  $C_L = 40pF$ .

4

2-D FILTERS



TABLE 2. A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Tested at:  $V_{CC} = 5.0V \pm 10\%$ ,  $T_A = -55^{\circ}C$  to  $+125^{\circ}C$  (Note 4)

PARAMETERS	SYMBOL	CONDI- TIONS	GROUP A SUBGROUP	TEMPERATURE	LIMITS				UNITS
					-27 (27MHz)		-20 (20MHz)		
					MIN	MAX	MIN	MAX	
Clock Period	T <sub>CYCLE</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	37	-	50	-	ns
Clock Pulse Width High	T <sub>PWH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
Clock Pulse Width Low	T <sub>PWL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
Data Input Setup Time	T <sub>DS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	16	-	17	-	ns
Data Input Hold Time	T <sub>DH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
Clock to Data Out	T <sub>OUT</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	19	-	28	ns
Address Setup Time	T <sub>AS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	15	-	ns
Address Hold Time	T <sub>AH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
Configuration Data Setup Time	T <sub>CDS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	17	-	20	-	ns
Configuration Data Hold Time	T <sub>CDH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
LD# Pulse Width	T <sub>LPW</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
LD# Setup Time	T <sub>LCS</sub>	Note 1	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	30	-	37	-	ns
CIN7-0 Setup to CLK	T <sub>CS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	17	-	20	-	ns
CIN7-0 Hold from CLK	T <sub>CH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
CS# Setup to LD#	T <sub>CSS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
CS# Hold from LD#	T <sub>CSH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
RESET# Pulse Width	T <sub>RPW</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	37	-	50	-	ns
FRAME# Setup to CLK	T <sub>FS</sub>	Note 2	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	25	-	30	-	ns
FRAME# Pulse Width	T <sub>FPW</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	37	-	50	-	ns
EALU Setup Time	T <sub>ES</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	17	-	ns
EALU Hold Time	T <sub>EH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	ns
HOLD Setup Time	T <sub>HS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	13	-	14	-	ns
HOLD Hold Time	T <sub>HH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	2	-	2	-	ns
Output Enable Time	T <sub>EN</sub>	Note 3	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	19	-	28	ns

NOTES: 1. This specification applies only to the case where the HSP48908/883 is being written to during an active convolution cycle. It must be met in order to achieve predictable results at the next rising clock edge. In most applications, the configuration data and coefficients are loaded asynchronously and the  $T_{LCS}$  specification may be disregarded.

2. While FRAME# is an asynchronous signal, it must be deasserted a minimum of  $T_{FS}$  ns prior to the rising clock edge which is to begin loading pixel data for a new frame.

3. Transition is measured at  $\pm 200mV$  from steady state voltage with loading as specified in test load circuit with  $C_L = 40pF$ .

4. A.C. Testing is performed as follows: Input levels (CLK Input) 4.0V and 0V, Input levels (All other Inputs) 0V and 3.0V, Timing Reference Levels (CLK) = 2.0V, (Others) = 1.5V. Output load per test load circuit with  $C_L = 40pF$ . Output transition is measured at  $V_{OH} \geq 1.5V$  and  $V_{OL} \leq 1.5V$ .

TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETERS	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	LIMITS				UNITS
					-27		-20		
					MIN	MAX	MIN	MAX	
Input Capacitance	C <sub>IN</sub>	V <sub>CC</sub> = Open, f = 1 MHz, All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	10	-	10	pF
Output Capacitance	C <sub>O</sub>	V <sub>CC</sub> = Open, f = 1 MHz, All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	12	-	12	pF
Output Disable Time	T <sub>OZ</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	35	-	40	ns
Output Rise Time	T <sub>R</sub>	From 0.8V to 2.0V	1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	6	-	6	ns
Output Fall Time	T <sub>F</sub>	From 2.0V to 0.8V	1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	6	-	6	ns

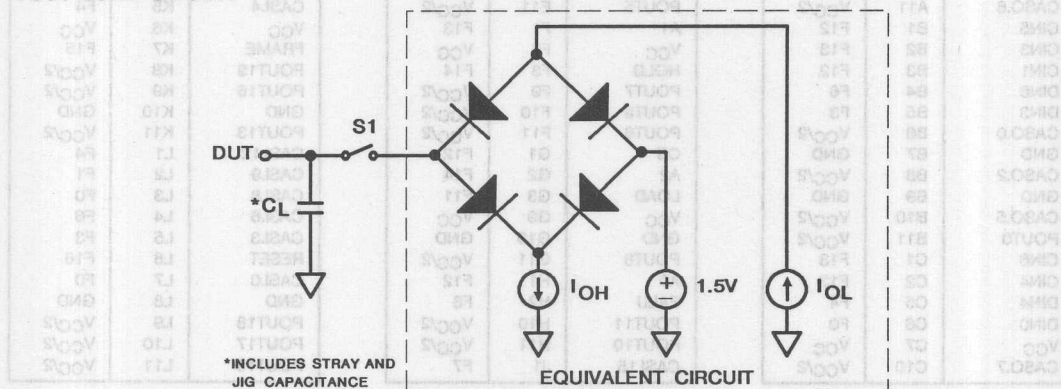
NOTES: 1. Parameters listed in Table 3 are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design and after major process and/or design changes.

2. Loading is as specified in the test load circuit with  $C_L = 40\text{pF}$ .

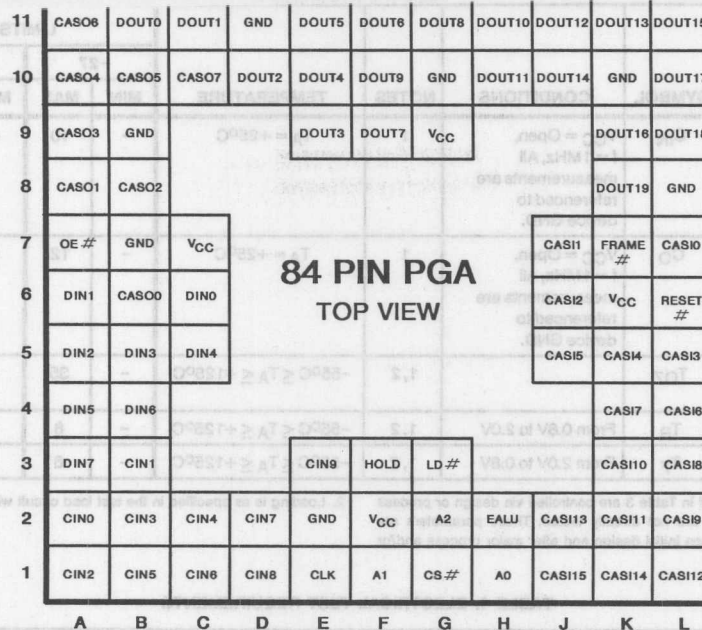
TABLE 4. ELECTRICAL TEST REQUIREMENTS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9

## Test Load Circuit



Switch S1 Open for  $I_{CCSB}$  and  $I_{CCOP}$  Tests



**PGA BURN-IN SCHEMATIC**

PIN NAME	PGA PIN	BURN-IN SIGNAL	PIN NAME	PGA PIN	BURN-IN SIGNAL	PIN NAME	PGA PIN	BURN-IN SIGNAL
CIN2	A1	F13	POUT1	C11	V <sub>CC</sub> /2	CASI.13	J2	F5
CIN0	A2	F12	CIN8	D1	F14	CASI.5	J5	F5
DIN7	A3	F7	CIN7	D2	F12	CASI.2	J6	F2
DIN5	A4	F5	POUT2	D10	V <sub>CC</sub> /2	CASI.1	J7	F1
DIN2	A5	F2	GND	D11	GND	POUT14	J10	V <sub>CC</sub> /2
DIN1	A6	F1	CLK	E1	F0	POUT12	J11	V <sub>CC</sub> /2
OE	A7	F10	GND	E2	GND	CASI.14	K1	F6
CASO.1	A8	V <sub>CC</sub> /2	CIN9	E3	F14	CASI.11	K2	F3
CASO.3	A9	V <sub>CC</sub> /2	POUT3	E9	V <sub>CC</sub> /2	CASI.10	K3	F2
CASO.4	A10	V <sub>CC</sub> /2	POUT4	E10	V <sub>CC</sub> /2	CASI.7	K4	F7
CASO.6	A11	V <sub>CC</sub> /2	POUT5	E11	V <sub>CC</sub> /2	CASI.4	K5	F4
CIN5	B1	F12	A1	F1	F13	V <sub>CC</sub>	K6	V <sub>CC</sub>
CIN3	B2	F13	V <sub>CC</sub>	F2	V <sub>CC</sub>	FRAME	K7	F15
CIN1	B3	F12	HOLD	F3	F14	POUT19	K8	V <sub>CC</sub> /2
DIN6	B4	F6	POUT7	F9	V <sub>CC</sub> /2	POUT16	K9	V <sub>CC</sub> /2
DIN3	B5	F3	POUT9	F10	V <sub>CC</sub> /2	GND	K10	GND
CASO.0	B6	V <sub>CC</sub> /2	POUT6	F11	V <sub>CC</sub> /2	POUT13	K11	V <sub>CC</sub> /2
GND	B7	GND	CS	G1	F12	CASI.12	L1	F4
CASO.2	B8	V <sub>CC</sub> /2	A2	G2	F14	CASI.9	L2	F1
GND	B9	GND	LOAD	G3	F11	CASI.8	L3	F0
CASO.5	B10	V <sub>CC</sub> /2	V <sub>CC</sub>	G9	V <sub>CC</sub>	CASI.6	L4	F6
POUT0	B11	V <sub>CC</sub> /2	GND	G10	GND	CASI.3	L5	F3
CIN6	C1	F13	POUT8	G11	V <sub>CC</sub> /2	RESET	L6	F16
CIN4	C2	F13	A0	H1	F12	CASI.0	L7	F0
DIN4	C5	F4	EALU	H2	F8	GND	L8	GND
DIN0	C6	F0	POUT11	H10	V <sub>CC</sub> /2	POUT18	L9	V <sub>CC</sub> /2
V <sub>CC</sub>	C7	V <sub>CC</sub>	POUT10	H11	V <sub>CC</sub> /2	POUT17	L10	V <sub>CC</sub> /2
CASO.7	C10	V <sub>CC</sub> /2	CASI.15	J1	F7	POUT15	L11	V <sub>CC</sub> /2

- NOTES: 1. V<sub>CC</sub>/2 (2.7V ± 10%) used for outputs only.  
 2. 47KΩ (±20%) resistor connected to all pins except V<sub>CC</sub> and GND.  
 3. V<sub>CC</sub> = 5.5 ± 0.5V.

4. 0.1μF (min) capacitor between V<sub>CC</sub> and GND per position.  
 5. F0 = 100kHz ± 10%, F1 = F0/2, F2 = F1/2 ... F11 = F10/2, 40-60% Duty Cycle.  
 6. Input Voltage Limits: V<sub>IL</sub> = 0.8V max., V<sub>IH</sub> = 4.5V ± 10%.

**Die Characteristics****DIE DIMENSIONS:**

341 x 322 x 19 ± 1 mils

**METALLIZATION:**

Type: Si - Al or Si-Al-Cu

Thickness: 8KÅ

**WORST CASE CURRENT DENSITY:** $2 \times 10^5 \text{A/cm}^2$ **GLASSIVATION:**

Type: Nitrox

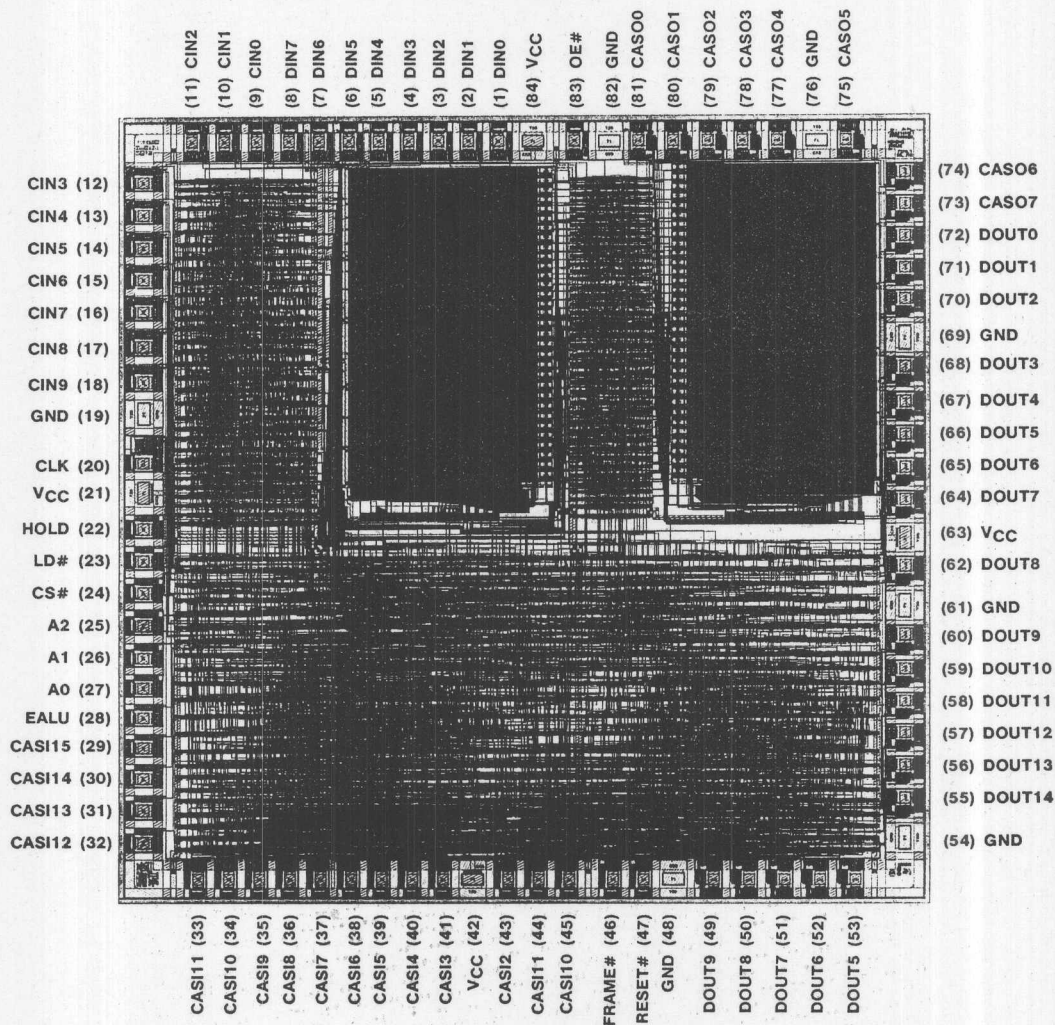
Thickness: 10KÅ

**DIE ATTACH:**

Material: Silver Glass

**Metallization Mask Layout**

HSP48908/883



4

2-D FILTERS





## SIGNAL SYNTHESIZERS

DATA SHEETS		PAGE
HSP45102	12 Bit Numerically Controlled Oscillator .....	5-3
HSP45106	16 Bit Numerically Controlled Oscillator .....	5-10
HSP45106/883	16 Bit Numerically Controlled Oscillator .....	5-20
HSP45116	Numerically Controlled Oscillator/Modulator .....	5-26
HSP45116/883	Numerically Controlled Oscillator/Modulator .....	5-41
HSP50016	Digital Down Converter .....	5-48



# DSP

## SIGNAL SYNTHESIZERS

PAGE

DATA SHEETS

12-Bit Numerically Controlled Oscillator .....	2-3
18-Bit Numerically Controlled Oscillator .....	2-10
16-Bit Numerically Controlled Oscillator .....	2-20
Numerically Controlled Oscillator/Modulator .....	2-26
Numerically Controlled Oscillator/Modulator .....	2-47
Digital Down Converter .....	2-48

2  
SIGNAL  
SYNTHESIZERS

August 1992

## 12-Bit Numerically Controlled Oscillator

### Features

- 33MHz, 40MHz Versions
- 32-Bit Frequency Control
- BFSK, QPSK Modulation
- Serial Frequency Load
- 12-Bit Sine Output
- Offset Binary Output Format
- 0.009Hz Tuning Resolution at 40MHz
- Spurious Frequency Components < -69dBc
- Fully Static CMOS
- Available in 28 Pin DIP and SOIC
- Low Cost

### Applications

- Direct Digital Synthesis
- Modulation

### Description

The Harris HSP45102 is Numerically Controlled Oscillator with 32 bit frequency resolution and 12 bit output. With over 69dB of spurious free dynamic range and worst case frequency resolution of 0.009Hz, the NCO12 provides dramatic improvements in accuracy over other frequency synthesis solutions at a competitive price.

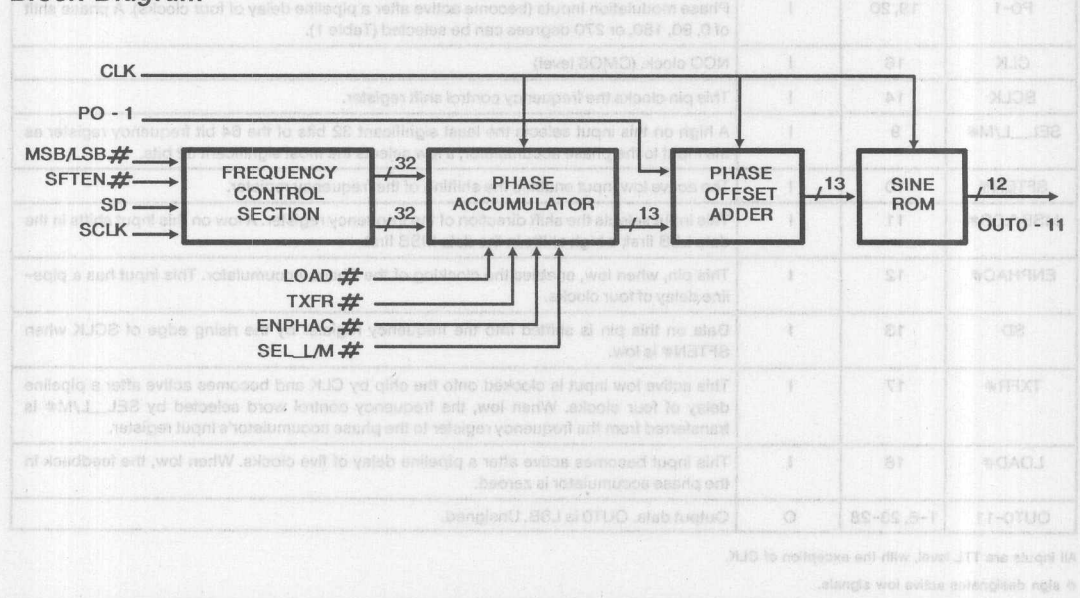
The frequency to be generated is selected from two frequency control words. A single control pin selects which word is used to determine the output frequency. Switching from one frequency to another occurs in one clock cycle, with a 6 clock pipeline delay from the time that the new control word is loaded until the new frequency appears on the output.

Two pins, PO-1, are provided for phase modulation. They are encoded and added to the top two bits of the phase accumulator to offset the phase in 90° increments.

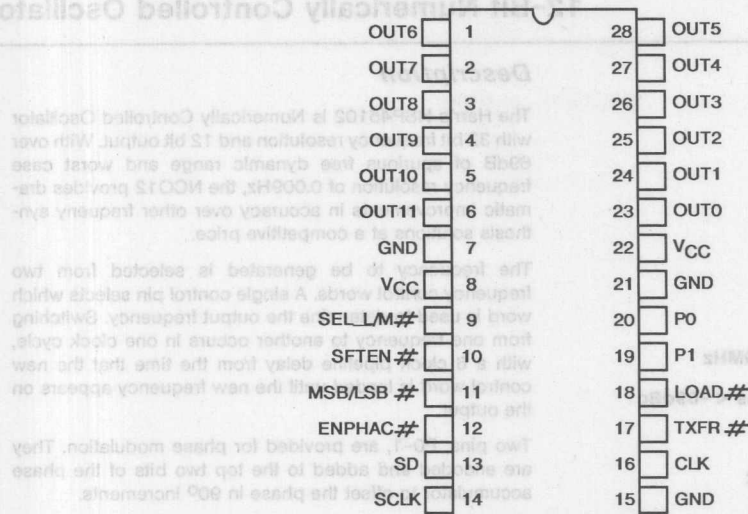
The 13 bit output of the Phase Offset Adder is mapped to the sine wave amplitude via the Sine ROM. The output data format is offset binary to simplify interfacing to D/A converters. Spurious frequency components in the output sinusoid are less than -69dBc.

The NCO12 has applications as a Direct Digital Synthesizer and modulator in low cost digital radios, satellite terminals, and function generators.

### Block Diagram





**Pinout**28 PIN DIP, 28 PIN SOIC  
TOP VIEW**Pin Description**

NAME	PIN NUMBER	TYPE	DESCRIPTION
VCC	8, 22		+5V power supply pin.
GND	7, 15, 21		Ground
P0-1	19, 20	I	Phase modulation inputs (become active after a pipeline delay of four clocks). A phase shift of 0, 90, 180, or 270 degrees can be selected (Table 1).
CLK	16	I	NCO clock. (CMOS level)
SCLK	14	I	This pin clocks the frequency control shift register.
SEL_L/M#	9	I	A high on this input selects the least significant 32 bits of the 64 bit frequency register as the input to the phase accumulator; a low selects the most significant 32 bits.
SFTEN#	10	I	The active low input enables the shifting of the frequency register.
MSB/LSB#	11	I	This input selects the shift direction of the frequency register. A low on this input shifts in the data LSB first; a high shifts in the data MSB first.
ENPHAC#	12	I	This pin, when low, enables the clocking of the Phase Accumulator. This input has a pipeline delay of four clocks.
SD	13	I	Data on this pin is shifted into the frequency register by the rising edge of SCLK when SFTEN# is low.
TXFR#	17	I	This active low input is clocked onto the chip by CLK and becomes active after a pipeline delay of four clocks. When low, the frequency control word selected by SEL_L/M# is transferred from the frequency register to the phase accumulator's input register.
LOAD#	18	I	This input becomes active after a pipeline delay of five clocks. When low, the feedback in the phase accumulator is zeroed.
OUT0-11	1-6, 23-28	O	Output data. OUT0 is LSB. Unsigned.

All inputs are TTL level, with the exception of CLK.

# sign designates active low signals.

## Functional Description

The NCO12 produces a 12 bit sinusoid whose frequency and phase are digitally controlled. The frequency of the sine wave is determined by one of two 32 bit words. Selection of the active word is made by SEL\_L/M#. The phase of the output is controlled by the two bit input P0-1, which is used to select a phase offset of 0°, 90°, 180°, or 270°.

As shown in the Block Diagram, the NCO12 consists of a Frequency Control Section, a Phase Accumulator, a Phase Offset Adder and a Sine ROM. The Frequency Control section serially loads the frequency control word into the frequency register. The Phase Accumulator and Phase Offset Adder compute the phase angle using the frequency control word and the two phase modulation inputs. The Sine ROM generates the sine of the computed phase angle. The format of the 12 bit output is offset binary.

### Frequency Control Section

The Frequency Control Section (Figure 1), serially loads the frequency data into a 64 bit, bidirectional shift register. The shift direction is selected with the MSB/LSB# input. When this input is high, the frequency control word on the SD input is shifted into the register MSB first. When MSB/LSB# is low the data is shifted in LSB first. The register shifts on the rising edge of SCLK when SFTEN# is low. The timing of these signals is shown in Figure 2.

The 64 bits of the frequency register are sent to the Phase Accumulator Section where 32 bits are selected to control the frequency of the sinusoidal output.

### Phase Accumulator Section

The phase accumulator and phase offset adder compute the phase of the sine wave from the frequency control word and the phase modulation bits P0-1. The architecture is shown in Figure 1. The most significant 13 bits of the 32 bit phase accumulator are summed with the two bit phase offset to generate the 13 bit phase input to the Sine Rom. A value of 0 corresponds to 0°, a value of 1000 hexadecimal corresponds to a value of 180°.

The phase accumulator advances the phase by the amount programmed into the frequency control register. The output frequency is equal to  $N \cdot F_{clk} / 2^{32}$ , where N is the selected 32 bits of the frequency control word. For example, if the control word is 20000000 hexadecimal and the clock frequency is 30Mhz, then the output frequency would be  $F_{clk}/8$  or 3.75Mhz.

The frequency control multiplexer selects the least significant 32 bits from the 64 bit frequency control register when SEL\_L/M# is high, and the most significant 32 bits when SEL\_L/M# is low. When only one frequency word is desired, SEL\_L/M# and MSB/LSB# must be either both high or both low. This is due to the fact that when a frequency control word is loaded into the shift register LSB first, it enters through the most significant bit of the register. After 32 bits have been shifted in, they will reside in the 32 most significant bits of the 64 bit register.

When TXFR# is asserted, the 32 bits selected by the frequency control multiplexer are clocked into the phase accumulator input register. At each clock, the contents of this register are summed with the current contents of the accumulator to step to the new phase. The phase accumulator stepping may be inhibited by holding ENPHAC# high. The phase accumulator may be loaded with the value in the input register by asserting LOAD#, which zeroes the feedback to the phase accumulator.

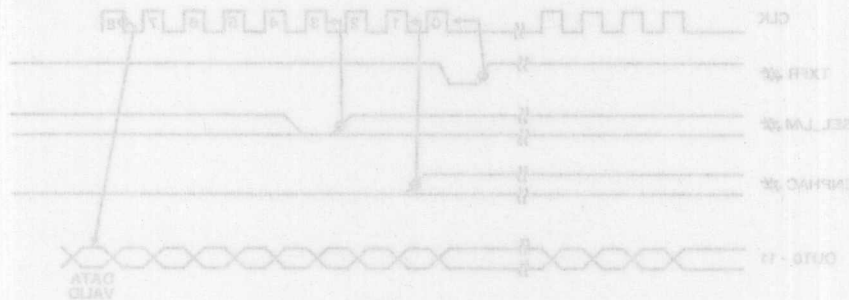
The phase adder sums the encoded phase modulation bits P0-1 and the output of the phase accumulator to offset the phase by 0, 90, 180 or 270 degrees. The two bits are encoded to produce the phase mapping shown in Table 1. This phase mapping is provided for direct connection to the in-phase and quadrature data bits for QPSK modulation.

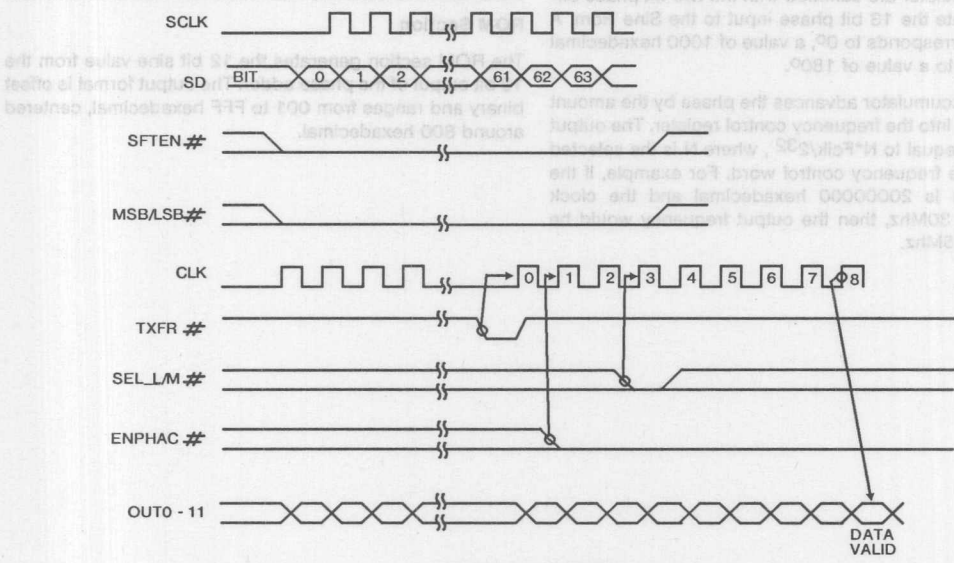
TABLE 1

P0-1 CODING		
P1	P0	PHASE SHIFT (DEGREES)
0	0	0
0	1	90
1	0	270
1	1	180

### ROM Section

The ROM section generates the 12 bit sine value from the 13 bit output of the phase adder. The output format is offset binary and ranges from 001 to FFF hexadecimal, centered around 800 hexadecimal.





5-6

# Specifications HSP45102

## Absolute Maximum Ratings

Supply Voltage	+8.0V
Input, Output or I/O Voltage Applied	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature Range	-65°C to +150°C
Junction Temperature	+150°C
Maximum Package Power Dissipation (Commercial)	1.5W (DIP), 1.1W (SOIC)
Maximum Package Power Dissipation (Industrial)	1.3°C/W (DIP), 0.9°C/W (SOIC)
$\theta_{jc}$	20.3°C/W (DIP), 21.6°C/W (SOIC)
$\theta_{ja}$	50.1°C/W (DIP), 71.4°C/W (SOIC)
Device Count	32,528 Transistors
Lead Temperature (Soldering, Ten Seconds)	+300°C
ESD Classification	Class 1

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range (Commercial, Industrial)	+4.75V to +5.25V
Operating Temperature Range (Commercial)	0°C to +70°C
Operating Temperature Range (Industrial)	-40°C to +85°C

## D.C. Electrical Specifications

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
$V_{IH}$	Logical One Input Voltage	2.0	-	V	$V_{CC} = 5.25V$
$V_{IL}$	Logical Zero Input Voltage	-	0.8	V	$V_{CC} = 4.75V$
$V_{IHC}$	High Level Clock Input	3.0	-	V	$V_{CC} = 5.25V$
$V_{ILC}$	Low Level Clock Input	-	0.8	V	$V_{CC} = 4.75V$
$V_{OH}$	Output HIGH Voltage	2.6	-	V	$I_{OH} = -400\mu A$ , $V_{CC} = 4.75V$
$V_{OL}$	Output LOW Voltage	-	0.4	V	$I_{OL} = +2.0mA$ , $V_{CC} = 4.75V$
$I_I$	Input Leakage Current	-10	10	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$
$I_{CCSB}$	Standby Power Supply Current	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.25V$ , Note 3
$I_{CCOP}$	Operating Power Supply Current	-	99	mA	$f = 33MHz$ , $V_{IN} = V_{CC}$ or GND $V_{CC} = 5.25V$ , Notes 1 and 3

## Capacitance ( $T_A = +25^\circ C$ , Note 2)

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
$C_{IN}$	Input Capacitance	-	10	pF	FREQ = 1MHz, $V_{CC} =$ Open, All measurements are referenced to device ground
$C_O$	Output Capacitance	-	10	pF	

### NOTES:

- Power supply current is proportional to operating frequency. Typical rating for  $I_{CCOP}$  is 3mA/MHz.
- Not tested, but characterized at initial design and at major process/design changes.
- Output load per test load circuit with switch open and  $C_L = 40pF$ .



## Specifications HSP45102

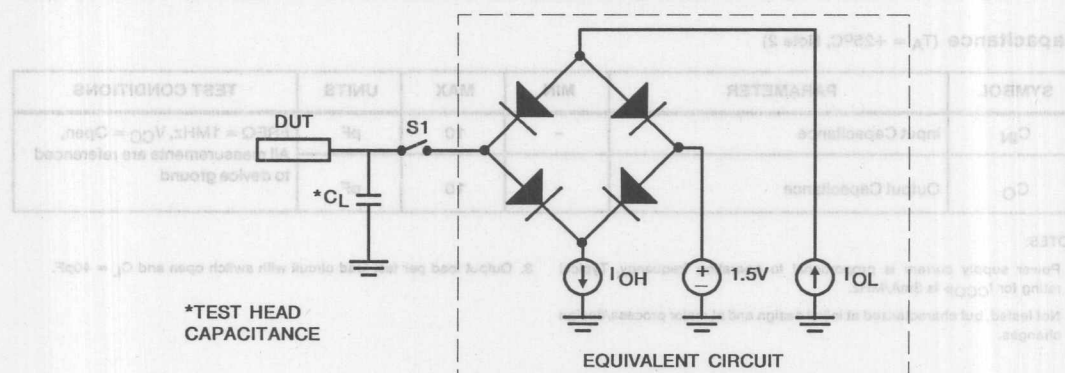
### A.C. Electrical Specifications $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to $+70^\circ C$ , $T_A = -40^\circ C$ to $+85^\circ C$ (Note 1)

SYMBOL	PARAMETER	-33 (33MHz)		-40 (40MHz)		COMMENTS
		MIN	MAX	MIN	MAX	
$T_{CP}$	Clock Period	30	-	25	-	ns
$T_{CH}$	Clock High	12	-	10	-	ns
$T_{CL}$	Clock Low	12	-	10	-	ns
$T_{SW}$	SCLK High/Low	12	-	10	-	ns
$T_{DS}$	Set-up Time SD to SCLK Going High	12	-	12	-	ns
$T_{DH}$	Hold Time SD from SCLK Going High	0	-	0	-	ns
$T_{MS}$	Set-up Time SFTEN#, MSB/LSB# to SCLK Going High	15	-	12	-	ns
$T_{MH}$	Hold Time SFTEN#, MSB/LSB# from SCLK Going High	0	-	0	-	ns
$T_{SS}$	Set-up Time SCLK High to CLK Going High	16	-	15	-	ns, Note 2
$T_{PS}$	Set-up Time P0-1 to CLK Going High	15	-	12	-	ns
$T_{PH}$	Hold Time P0-1 from CLK Going High	1	-	1	-	ns
$T_{ES}$	Set-up Time LOAD#, TXFR#, ENPHAC#, SEL_L/M# to CLK Going High	15	-	13	-	ns
$T_{EH}$	Hold Time LOAD#, TXFR#, ENPHAC#, SEL_L/M# from CLK Going High	1	-	1	-	ns
$T_{OH}$	CLK to Output Delay	2	15	2	13	ns
$T_{RF}$	Output Rise, Fall Time	8	-	8	-	ns, Note 3

#### NOTES

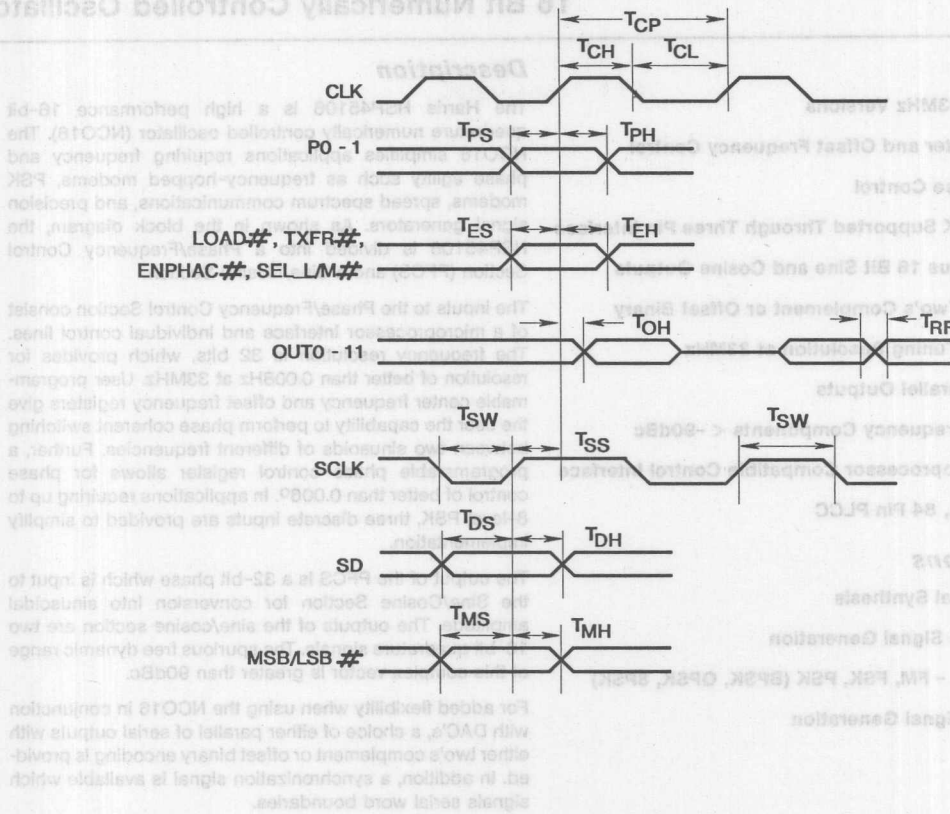
1. A.C. testing is performed as follows: Input levels (CLK Input) 4.0V and 0V; Input levels (all other inputs) 0V and 3.0V; Timing reference levels (CLK) 2.0V; All others 1.5V. Output load per test load circuit with switch closed and  $C_L = 40$  pF. Output transition is measured at  $V_{OH} \geq 1.5V$  and  $V_{OL} \leq 1.5V$ .
2. If TXFR# is active, care must be taken to not violate set-up and hold times as data from the shift registers may not have settled before CLK occurs.
3. Controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.

### A.C. Test Load Circuit

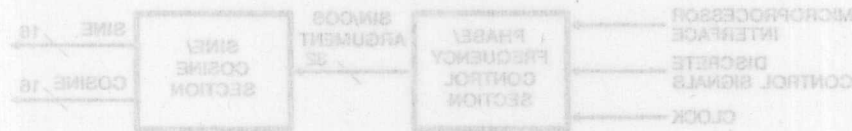


Switch S1 open for  $I_{CCSB}$  and  $I_{CCOP}$

## Waveforms



Block Diagram



August 1992

## 16 Bit Numerically Controlled Oscillator

### Features

- 25.6MHz, 33MHz Versions
- 32-Bit Center and Offset Frequency Control
- 16-Bit Phase Control
- 8 Level PSK Supported Through Three Pin Interface
- Simultaneous 16 Bit Sine and Cosine Outputs
- Output in Two's Complement or Offset Binary
- <0.008Hz Tuning Resolution at 33MHz
- Serial or Parallel Outputs
- Spurious Frequency Components < -90dBc
- 16 Bit Microprocessor Compatible Control Interface
- 85 Pin PGA, 84 Pin PLCC

### Applications

- Direct Digital Synthesis
- Quadrature Signal Generation
- Modulation - FM, FSK, PSK (BPSK, QPSK, 8PSK)
- Precision Signal Generation

### Description

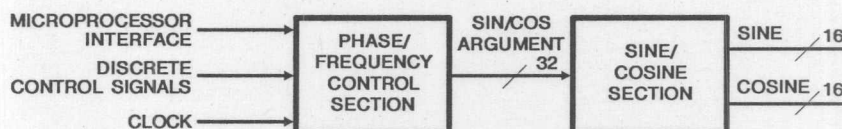
The Harris HSP45106 is a high performance 16-bit quadrature numerically controlled oscillator (NCO16). The NCO16 simplifies applications requiring frequency and phase agility such as frequency-hopped modems, PSK modems, spread spectrum communications, and precision signal generators. As shown in the block diagram, the HSP45106 is divided into a Phase/Frequency Control Section (PFCS) and a Sine/Cosine Section.

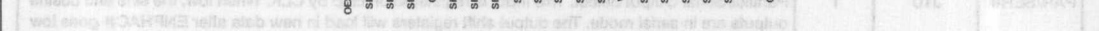
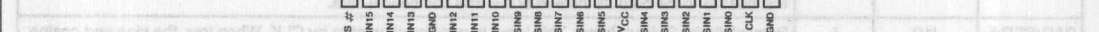
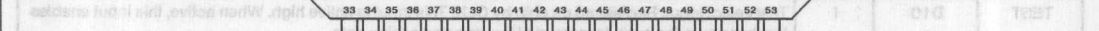
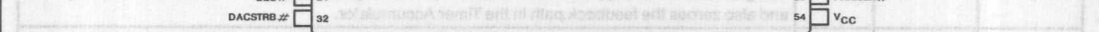
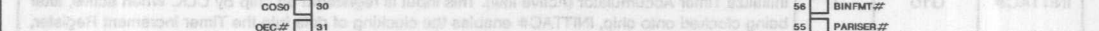
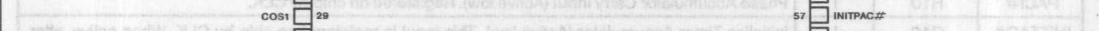
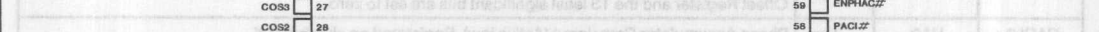
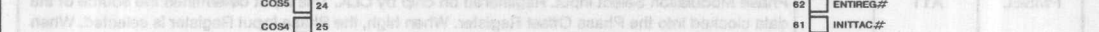
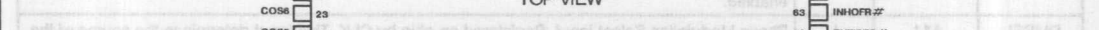
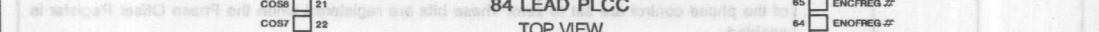
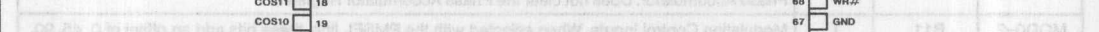
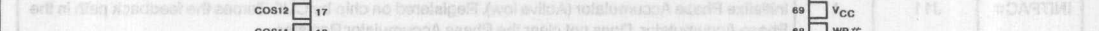
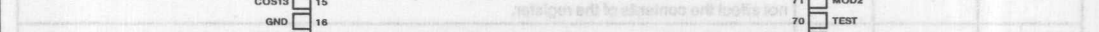
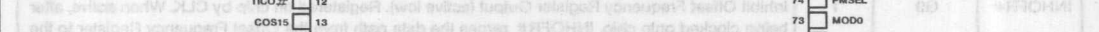
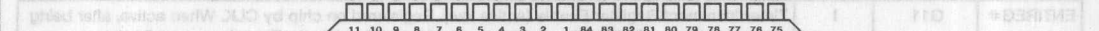
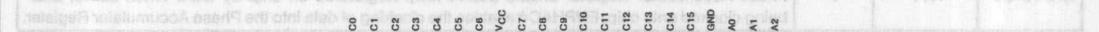
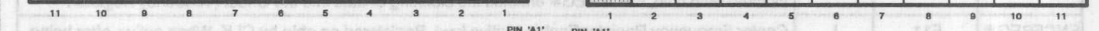
The inputs to the Phase/Frequency Control Section consist of a microprocessor interface and individual control lines. The frequency resolution is 32 bits, which provides for resolution of better than 0.008Hz at 33MHz. User programmable center frequency and offset frequency registers give the user the capability to perform phase coherent switching between two sinusoids of different frequencies. Further, a programmable phase control register allows for phase control of better than 0.006°. In applications requiring up to 8-level PSK, three discrete inputs are provided to simplify implementation.

The output of the PFCS is a 32-bit phase which is input to the Sine/Cosine Section for conversion into sinusoidal amplitude. The outputs of the sine/cosine section are two 16-bit quadrature signals. The spurious free dynamic range of this complex vector is greater than 90dBc.

For added flexibility when using the NCO16 in conjunction with DAC's, a choice of either parallel or serial outputs with either two's complement or offset binary encoding is provided. In addition, a synchronization signal is available which signals serial word boundaries.

### Block Diagram







## Pin Description

NAME	PGA PIN NUMBER	TYPE	DESCRIPTION
VCC	B5, D11, F1, K7, K10		+5 power supply pin.
GND	A9, D2, E10, K4, L11		Ground
C0-15	A1-8, B3-4, B6-8, C5-7	I	Control input bus for loading phase, frequency, and timer data into the PFCS. C0 is LSB.
A0-2	A10, B9-10	I	Address pins for selecting destination of C0-15 data (Table 2).
CS#	E11	I	Chip select (Active low). Enables data to be written into control registers by WR#.
WR#	E9	I	Write enable (Active low). Data is clocked into the register selected by A0-2 on the rising edge of WR# when CS# is low.
CLK	K9	I	Clock. All registers, except the control registers clocked with WR#, are clocked (when enabled) by the rising edge of CLK.
ENPOREG#	F10	I	Phase Offset Register Enable (Active low). Registered on chip by CLK. When active, after being clocked onto chip, ENPOREG# enables the clocking of data into the Phase Offset Register. Allows ROM address to be updated regardless of ENPHAC#.
ENOFREG#	F9	I	Offset Frequency Register Enable (Active low). Registered on chip by CLK. When active, after being clocked onto chip, ENOFREG# enables the clocking of data into the Offset Frequency Register.
ENCFREG#	F11	I	Center Frequency Register Enable (Active low). Registered on chip by CLK. When active, after being clocked onto chip, ENCFREG# enables the clocking of data into the Center Frequency Register.
ENPHAC#	H11	I	Phase Accumulator Register Enable (Active low). Registered on chip by CLK. When active, after being clocked onto chip, ENPHAC# enables the clocking of data into the Phase Accumulator Register.
ENTIREG#	G11	I	Timer Increment Register Enable (Active low). Registered on chip by CLK. When active, after being clocked onto chip, ENTIREG# enables the clocking of data into the Timer Increment Register.
INHOFR#	G9	I	Inhibit Offset Frequency Register Output (active low). Registered on chip by CLK. When active, after being clocked onto chip, INHOFR# zeroes the data path from the Offset Frequency Register to the Frequency Adder. New data can be still clocked into the Offset Frequency Register. INHOFR# does not affect the contents of the register.
INITPAC#	J11	I	Initialize Phase Accumulator (Active low). Registered on chip by CLK. Zeroes the feedback path in the Phase Accumulator. Does not clear the Phase Accumulator Register.
MOD0-2	B11, C10-11	I	Modulation Control Inputs. When selected with the PMSEL line, these bits add an offset of 0, 45, 90, 135, 180, 225, 270, or 315 degrees to the current phase (i.e., modulate the output). The lower 13 bits of the phase control are set to zero. These bits are registered when the Phase Offset Register is enabled.
PMSEL	A11	I	Phase Modulation Select input. Registered on chip by CLK. This input determines the source of the data clocked into the Phase Offset Register. When high, the Phase Input Register is selected. When low, the external modulation pins (MOD0-2) control the three most significant bits of the Phase Offset Register and the 13 least significant bits are set to zero.
PACI#	H10	I	Phase Accumulator Carry Input (Active low). Registered on chip by CLK.
INITTAC#	G10	I	Initialize Timer Accumulator (Active low). This input is registered on chip by CLK. When active, after being clocked onto chip, INITTAC# enables the clocking of data into the Timer increment Register, and also zeroes the feedback path in the Timer Accumulator.
TEST	D10	I	Test select input. Registered on chip by CLK. This input is active high. When active, this input enables test busses to the outputs instead of the sine and cosine data.
PAR/SER#	J10	I	Parallel/Serial Output Select. This input is registered on chip by CLK. When low, the sine and cosine outputs are in serial mode. The output shift registers will load in new data after ENPHAC# goes low and will start shifting the data out after ENPHAC# goes high. When this input is high, the output registers are loaded every clock and no shifting takes place.
BINFMT#	K11	I	Format. This input is registered on chip by CLK. When low, the MSB of the SIN and COS are inverted to form an offset binary (unsigned) number.
OES#	K2	I	Three-state control for bits SIN0-15. Outputs are enabled when OES# is low.
OEC#	J2	I	Three-state control for bits COS0-15. Outputs are enabled when OEC# is low.
TICO#	B2	O	Timer Accumulator Carry Output. Active low, registered. This output goes low when a carry is generated by the Timer Accumulator.

**Pin Description (Continued)**

NAME	PGA PIN NUMBER	TYPE	DESCRIPTION
DACSTRB#	L1	O	DAC Strobe (Active low). In serial mode, this output will go low when the first bit of a new output word is valid at the shift register output. This pin is active only in serial mode.
SINO-15	J5-7, K3, K5-6, K8, L2-10	O	Sine output data. When parallel mode is enabled, data is output on SINO-15. When serial mode is enabled, output data bits are shifted out of SIN15 and SINO. The bit stream on SIN 15 is provided MSB first while the bit stream on SINO is provided LSB first.
COSO-15	B1, C1-2, D1, E1-3, F2-3, G1-3, H1-2, J1, K1	O	Cosine output data. When parallel mode is enabled, data is output on COSO-15. When serial mode is enabled, output data bits are shifted out of COS15 and COS0. The bit stream on COS15 is provided LSB first.
Index Pin	C3		Used to align chip in socket or on circuit board. Must be left as a no connect in circuit.

**Functional Description**

The 16-bit Numerically Controlled Oscillator (NCO16) produces a digital complex sinusoid waveform whose frequency and phase are controlled through a standard microprocessor interface and discrete inputs. The NCO16 generates 16-bit sine and cosine vectors at a maximum sample rate of 40MHz. The NCO16 can be preprogrammed to produce a constant (CW) sine and cosine output for Direct Digital Synthesis (DDS) applications. Alternatively, the phase and frequency inputs can be updated in real time to produce a FM, PSK, FSK, or MSK modulated waveform. To simplify PSK generation, a 3 pin interface is provided to support modulation of up to 8 levels.

As shown in the Block Diagram, the NCO16 is comprised of a Phase and Frequency Control Section (PFCS) and Sine/Cosine Section. The PFCS stores the phase and frequency control inputs and uses them to calculate the phase angle of a rotating complex vector. The Sine/Cosine Section performs a lookup on this phase and generates the appropriate amplitude values for the sine and cosine. These quadrature outputs may be configured as serial or parallel with either two's complement or offset binary format.

**Phase/Frequency Control Section**

The phase and frequency of the quadrature outputs are controlled by the PFCS (Figure 1). The PFCS generates a 32 bit word which represents the instantaneous phase (Sin/Cos argument) of the sine and cosine waves being generated. This phase is incremented on the rising edge of each CLK by the preprogrammed amounts in the phase and frequency control registers. As the instantaneous phase steps from 0 through full scale ( $2^{32} - 1$ ), the phase of the quadrature outputs proceeds from 0° around the unit circle counter clockwise.

The PFCS is comprised of a Phase Accumulator Section, Phase Offset adder, Input Section, and a Timer Accumulator Section. The Phase Accumulator computes the instantaneous phase angle from user programmed values in the Center and Offset Frequency Registers. This angle is then fed into the Phase Offset adder where it is offset by the preprogrammed value in the Phase Offset Register. The Input Section routes data from a microprocessor compatible control bus and discrete input signals into the appropriate configuration registers. The Timer Accumulator

supplies a pulse to mark the passage of a user programmed period of time.

**Input Section**

The Input Section loads the data on C0-15 into one of the seven input registers, the LSB and MSB Center Frequency Input Registers, the LSB and MSB Offset Frequency Registers, the LSB and MSB Timer Input Registers, and the Phase Input Register. The destination depends on the state of A0-2 when CS# and WR# are low (Table 1).

TABLE 1

A2-0 DECODING					
A2	A1	A0	CS#	WR#	FUNCTION
0	0	0	0	↑	Load least significant bits of Center Frequency input.
0	0	1	0	↑	Load most significant bits of Center Frequency input.
0	1	0	0	↑	Load least significant bits of Offset Frequency input.
0	1	1	0	↑	Load most significant bits of Offset Frequency input.
1	0	0	0	↑	Load least significant bits of Timing Interval input.
1	0	1	0	↑	Load most significant bits of Timing Interval input.
1	1	0	0	↑	Load Phase Register
1	1	1	0	↑	Reserved
X	X	X	1	X	Input Disabled

Once the input registers have been loaded, the control inputs ENCFREG#, ENOFREG#, ENTIREG#, ENCTIREG#, and ENPOREG# will allow the input registers to be downloaded to the PFCS control registers with the input CLK. The control inputs are latched on the rising edge of CLK and the control registers are updated on the rising edge of the following CLK. For example, to load the Center Frequency Register, the data is loaded into the LSB and MSB Center Frequency Input Register, and ENCFREG# is set to zero; the next rising edge of CLK will pass the registered version of ENCFREG#, R.ENCFREG#, to the

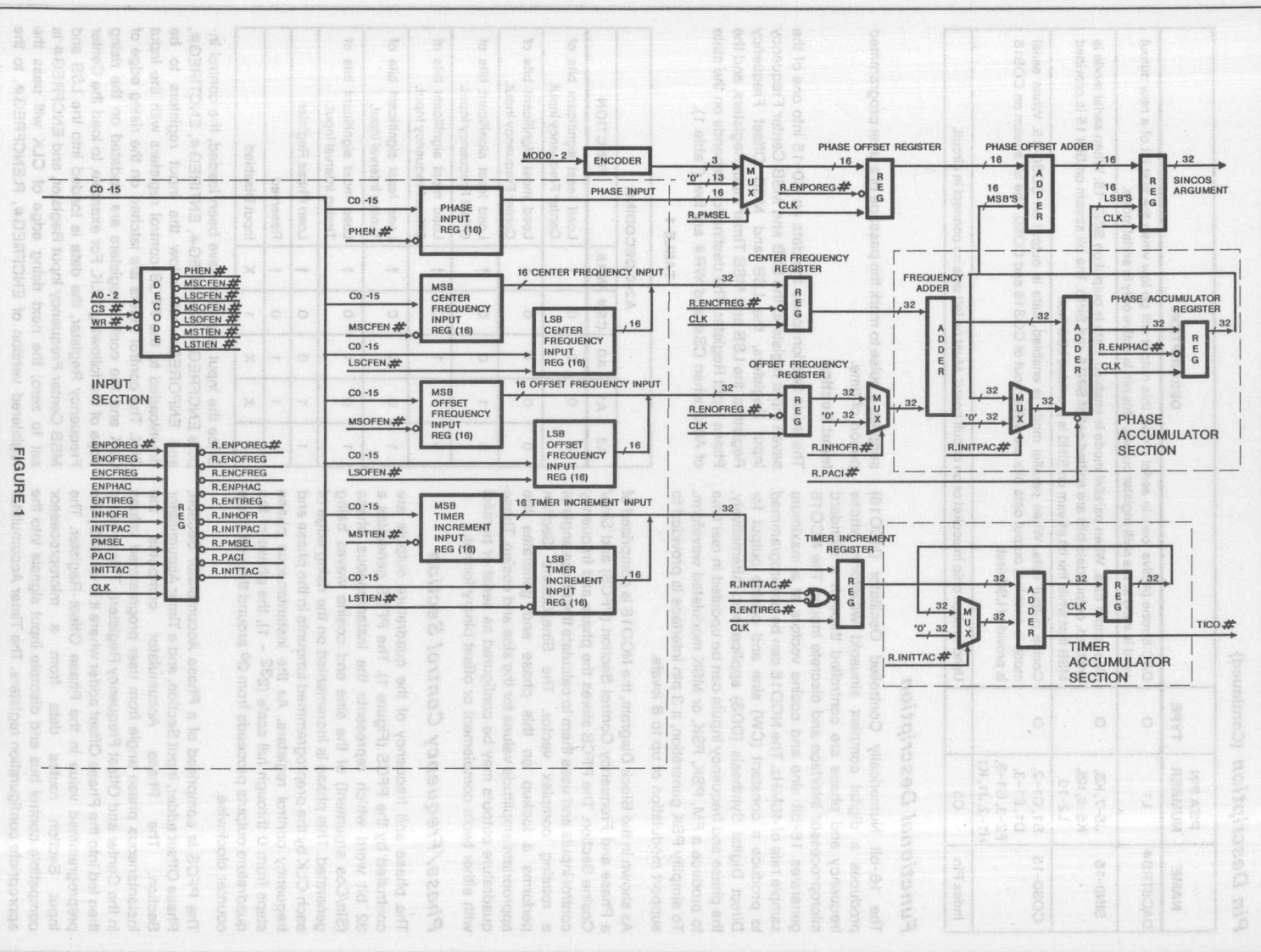


FIGURE 1



clock enable of the Center Frequency Register; this register then gets loaded on the following rising edge of CLK. The contents of the input registers are downloaded to the control registers every clock if the control inputs are enabled.

#### Phase Accumulator Section

The Phase Accumulator adds the 32 bit output of the Frequency Adder with the contents of a 32 bit Phase Accumulator Register on every clock cycle. When the sum causes the adder to overflow, the accumulation continues with the least significant 32 bits of the result.

Initializing the Phase Accumulator Register is done by putting a low on the INITPAC# and ENPHAC# lines. This zeroes the feedback path to the accumulator, so that the register is loaded with the current value of the Frequency Adder on the next clock.

The frequency of the quadrature outputs is based on the number of clock cycles required to step from 0 to full scale. The number of steps required for this transition depends on the phase increment calculated by the frequency adder. For example, if the Center and Offset Frequency registers are programmed such that the output of the Frequency Adder is 4000 0000 hex, the Phase Accumulator will step the phase from 0 to 360 degrees every 4 clock cycles. Thus, for a 30 MHz CLK, the quadrature outputs will have a frequency of 30/4 MHz or 7.5MHz. In general, the frequency of the quadrature output is determined by  $N \times FCLK/2^{32}$ , where N is the output of the Frequency Adder and FCLK is the frequency of CLK.

The Frequency Adder sums the contents of both the Center and Offset Frequency Registers to produce a phase increment. By enabling INHOFR#, the output of the Offset Frequency Register is disabled so that the output frequency is determined from the Center Frequency Register alone. For BFSK modems, INHOFR# can be asserted/de-asserted to toggle the quadrature outputs between two programmed frequencies. Note: enabling/disabling INHOFR# preserves the contents of the Offset Frequency Register.

#### Phase Offset Adder

The output of the Phase Accumulator goes to the Phase Offset Adder, which adds the 16 bit contents of the Phase Offset Register to the 16 MSB's of the phase. The resulting 32-bit number forms the instantaneous phase which is fed to the Sine/Cosine Section.

The user has the option of loading the Phase Offset Registers with the contents of the Phase Input Register or the MOD0-2 inputs depending on the state of PMSEL. When PMSEL is high, the contents of the Phase Input Register are loaded. If PMSEL is low, MOD0-2 encode the upper 3 bits of the Phase Offset Register while the lower 13 bits are cleared. The MOD0-2 inputs simplify PSK modulation by providing a 3 input interface to phase modulate the carrier as shown in Table 2. The control input ENPOREG# acts as a clock enable and must be low to enable clocking of data into the Phase Offset Register.

TABLE 2

MOD2-0 DECODING			
MOD2	MOD1	MOD0	PHASE SHIFT (DEGREES)
0	0	0	0
0	0	1	45
0	1	0	90
0	1	1	135
1	0	0	270
1	0	1	315
1	1	0	180
1	1	1	225

#### Timer Accumulator Section

The Timer Accumulator consists of a register which is incremented on every clock. The amount by which it increments is loaded into the Timer Increment Input Registers and is latched into the Timer Increment Register on rising edges of CLK while ENTIREQ# is low. The output of the Timer Accumulator is the accumulator carry out, TICO#. TICO# can be used as a timer to enable the periodic sampling of the output of the NCO-16. The number programmed into this register equals  $(2^{32} \times \text{CLK period})/(\text{desired time interval})$ .

#### Sine/Cosine Section

The Sine/Cosine Section (Figure 2) converts the instantaneous phase from the PFCS Section into the appropriate amplitude values for the sine and cosine outputs. It takes the most significant 20 bits of the PFCS output and passes them through a Sine/Cosine look up to form the 16 bit quadrature outputs. The sine and cosine values are computed to reduce the amount of ROM needed. The magnitude of the error in the computed value of the complex vector is less than -90.2dB. The error in the sine or cosine alone is approximately 2dB better. The 20 bit phase word maps into  $2\pi$  radians so that the angular resolution is  $(2\pi)/2^{20}$ . An address of zero corresponds to 0 radians and an address of hex FFFF corresponds to  $2\pi - ((2\pi)/2^{20})$  radians. The outputs of the Sine/Cosine Section are two's complement sine and cosine values. The ROM contents have been scaled by  $(2^{16}-1)/(2^{16}+1)$  for symmetry about zero.

To simplify interfacing with D/A converters, the format of the sine/cosine outputs may be changed to offset binary by enabling BINFMT#. When BINFMT# is enabled, The MSB of the Sine and Cosine outputs (SIN15 and COS15 when the outputs are in parallel mode) are inverted. Depending upon the state of BINFMT#, the output is centered around midscale and ranges from 8001H to 7FFFH (two's complement mode) or 0001H to FFFFH (offset binary mode).

Serial output mode may be chosen by enabling PAR/SER#. In this mode the user loads the output shift registers with Sine/Cosine ROM output by enabling ENPHAC#. After ENPHAC# goes inactive the data is shifted out serially. For



example, to clock out one 16 bit sine/cosine output, ENPHAC# would be active for one cycle to load the output shift register, and would then go inactive for the following 15 cycles to clock the remaining bits out. Output bit streams are provided in formats with either MSB first or LSB first. The MSB first format is available on the SIN15 and COS15 output pins. The LSB first format is available on the SINO and COSO output pins. In MSB first format, zero's follow the LSB if a new output word is not loaded into the shift register. In LSB first format, the sine extension bit follows the MSB if

a new data word is not loaded. The output signal DACSTRB# is provided to signal the first bit of a new output word is valid (Figure 3). Note: all unused pins of SINO-15 and COSO-15 should be left floating.

A test mode is supplied which enables the user to access the phase input to the Sine/Cosine ROM. If TEST and PAR/SER# are both high, the 28 MSB's of the phase input to the Sine/Cosine Section are made available on SINO-15 and COSO-15. The SINO-15 outputs represent the MSW of the address.

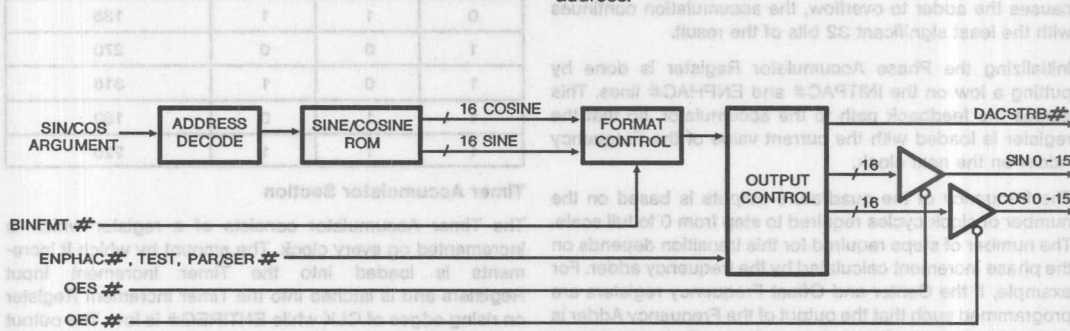


FIGURE 2. SINE/COSINE BLOCK DIAGRAM

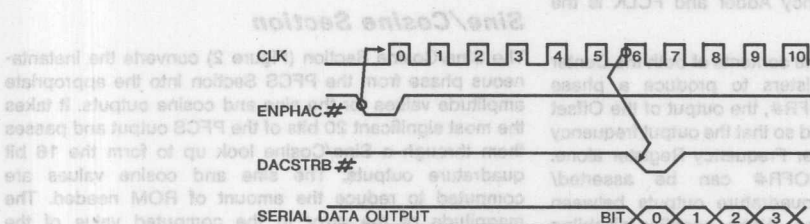


FIGURE 3. SERIAL OUTPUT I/O TIMING DIAGRAM

The output of the Phase Accumulator goes to the Phase Offset Register, which adds the 16 bit contents of the Phase Offset Register to the 16 MSB's of the phase. The resulting 32-bit number forms the instantaneous phase which is fed to the Sine/Cosine Section.

The user has the option of loading the Phase Offset Register with the contents of the Phase Input Register or the MOD-2 inputs depending on the state of PHASEL. When PHASEL is high, the contents of the Phase Input Register are loaded. If PHASEL is low, MOD-2 encodes the 13 bits of the Phase Offset Register while the lower 3 bits of the MOD-2 inputs simply PSK modulation by providing a 3 input interface to phase modulate the carrier as shown in Table 2. The control input ENFORCE# acts as a clock enable and must be low to enable clocking of data into the Phase Offset Register.

To simply interface with D/A converters, the format of the sine/cosine outputs may be changed to offset binary by enabling BINFMT#. When BINFMT# is enabled, the MSB of the sine and cosine outputs (SIN15 and COS15 when the outputs are in parallel mode) are inverted. Depending upon the state of BINFMT#, the output is centered around midscale and ranges from 800H to FFH (two's complement mode) or 000H to FFH (offset binary mode).

Serial output mode may be chosen by enabling PAR/SER#. In this mode the user loads the output shift registers with Sine/Cosine ROM output by enabling ENPHAC#. After ENPHAC# goes inactive the data is shifted out serially. For

# Specifications HSP45106

## Absolute Maximum Ratings

Supply Voltage	+8.0V
Input, Output or I/O Voltage Applied	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature Range	-65°C to +150°C
Maximum Package Power Dissipation	2.3W (PLCC), 2.9W (PGA)
$\theta_{jc}$	11.3°C/W (PLCC), 10.0°C/W (PGA)
$\theta_{ja}$	34.0°C/W (PLCC), 36°C/W (PGA)
Component Count	75,000 Transistors
Junction Temperature	+150°C (PLCC), +175°C (PGA)
Lead Temperature (Soldering, Ten Seconds)	+300°C
ESD Classification	Class 1

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range	+4.75V to +5.25V
Operating Temperature Range	0°C to +70°C

## D.C. Electrical Specifications

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
$V_{IH}$	Logical One Input Voltage	2.0	-	V	$V_{CC} = 5.25V$
$V_{IL}$	Logical Zero Input Voltage	-	0.8	V	$V_{CC} = 4.75V$
$V_{IHC}$	High Level Clock Input	3.0	-	V	$V_{CC} = 5.25V$
$V_{ILC}$	Low Level Clock Input	-	0.8	V	$V_{CC} = 4.75V$
$V_{OH}$	Output HIGH Voltage	2.6	-	V	$I_{OH} = -400\mu A$ , $V_{CC} = 4.75V$
$V_{OL}$	Output LOW Voltage	-	0.4	V	$I_{OL} = +2.0mA$ , $V_{CC} = 4.75V$
$I_I$	Input Leakage Current	-10	10	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$
$I_O$	I/O Leakage Current	-10	10	$\mu A$	$V_{OUT} = V_{CC}$ or GND, $V_{CC} = 5.25V$
$I_{CCSB}$	Standby Power Supply Current	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Note 3
$I_{CCOP}$	Operating Power Supply Current	-	205	mA	$f = 25.6MHz$ , $V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Notes 1 and 3

## Capacitance ( $T_A = +25^\circ C$ , Note 2)

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
$C_{IN}$	Input Capacitance	-	10	pF	FREQ = 1MHz, $V_{CC} =$ Open, All measurements are referenced to device ground
$C_O$	Output Capacitance	-	10	pF	

### NOTES:

- Power supply current is proportional to operating frequency. Typical rating for  $I_{CCOP}$  is 8mA/MHz.
- Not tested, but characterized at initial design and at major process/design changes.
- Output load per test load circuit with switch open and  $C_L = 40pF$ .

## Specifications HSP45106

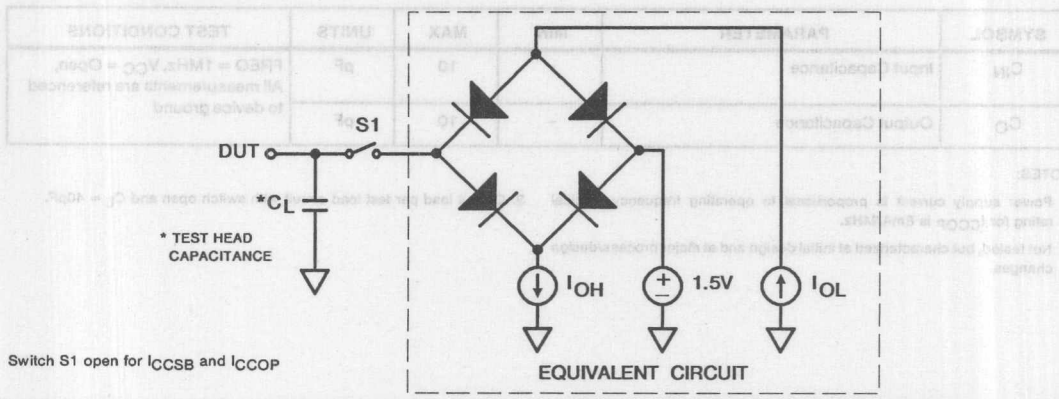
### A.C. Electrical Specifications $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to $+70^\circ C$ (Note 1)

SYMBOL	PARAMETER	25.6MHz		33MHz		COMMENTS
		MIN	MAX	MIN	MAX	
$T_{CP}$	CLK Period	39	-	30	-	ns
$T_{CH}$	CLK High	15	-	12	-	ns
$T_{CL}$	CLK Low	15	-	12	-	ns
$T_{WP}$	WR# Period	39	-	30	-	ns
$T_{WH}$	WR# High	15	-	12	-	ns
$T_{WL}$	WR# Low	15	-	12	-	ns
$T_{AWS}$	Set-up Time A0-2, CS# to WR# Going High	13	-	13	-	ns
$T_{AWH}$	Hold Time A0-2, CS# from WR# Going High	1	-	1	-	ns
$T_{CWS}$	Set-up Time C0-15 to WR# Going High	15	-	15	-	ns
$T_{CWH}$	Hold Time C0-15 from WR# Going High	0	-	0	-	ns
$T_{WC}$	Set-up Time WR# High to CLK High	16	-	12	-	ns, Note 2
$T_{MCS}$	Set-up Time MOD0-2 to CLK Going High	15	-	15	-	ns
$T_{MCH}$	Hold Time MOD0-2 from CLK Going High	0	-	0	-	ns
$T_{ECS}$	Set-up Time ENPREG#, ENOFREG#, ENCFREG#, ENPHAC#, ENTIREG#, INHOFR#, PMSEL#, INITPAC#, BINFMT#, TEST, PAR/SER#, PACI#, INITTAC# to CLK Going High	12	-	12	-	ns
$T_{ECH}$	Hold Time ENPREG#, ENOFREG#, ENCFREG#, ENPHAC#, ENTIREG#, INHOFR#, PMSEL#, INITPAC#, BINFMT#, TEST, PAR/SER#, PACI#, INITTAC# from CLK Going High	0	-	0	-	ns
$T_{DO}$	CLK to Output Delay SINO-15, COSO-15, TICO#	-	18	-	15	ns
$T_{DSO}$	CLK to Output Delay DACSTRB#	2	18	2	15	ns
$T_{OE}$	Output Enable Time	-	12	-	12	ns
$T_{OD}$	Output Disable Time	-	15	-	15	ns, Note 3
$T_{RF}$	Output Rise, Fall Time	-	8	-	8	ns, Note 3

#### NOTES:

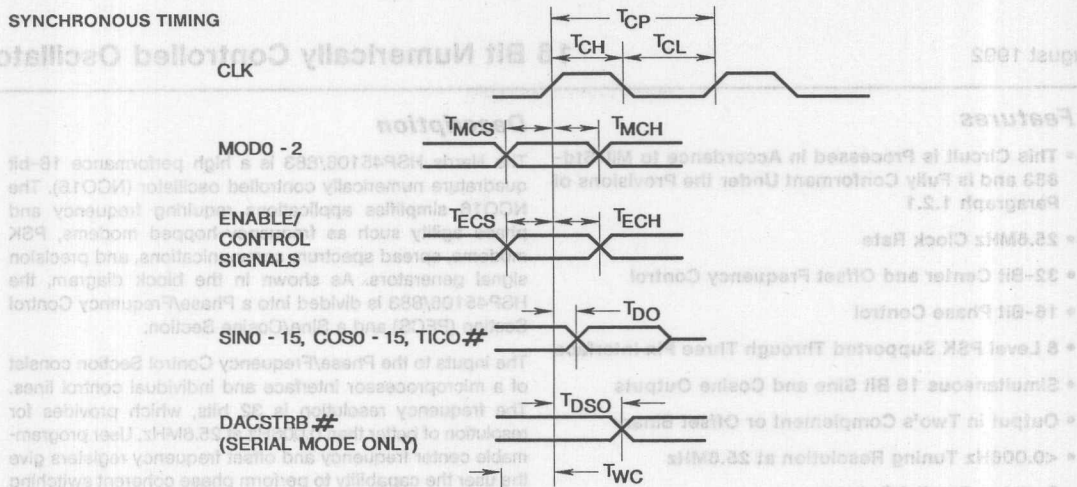
1. A.C. testing is performed as follows: Input levels (CLK Input) 4.0V and 0V; Input levels (all other inputs) 0V and 3.0V; Timing reference levels (CLK) 2.0V; All others 1.5V. Output load per test load circuit with switch closed and  $C_L = 40$  pF. Output transition is measured at  $V_{OH} \geq 1.5V$  and  $V_{OL} \leq 1.5V$ .
2. If ENOFREG#, ENCFREG#, ENTIREG#, OR ENPREG# are active, care must be taken to not violate set-up and hold times to these registers when writing data into the chip via the C0-15 port.
3. Controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or changes.

### A.C. Test Load Circuit

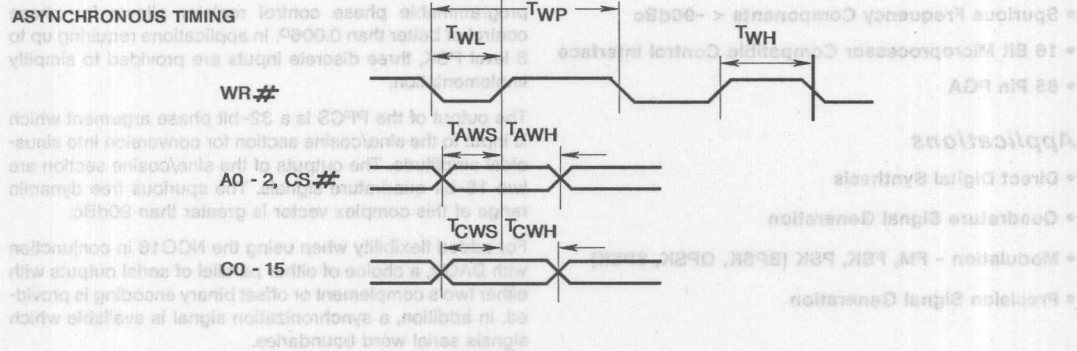


## Waveforms

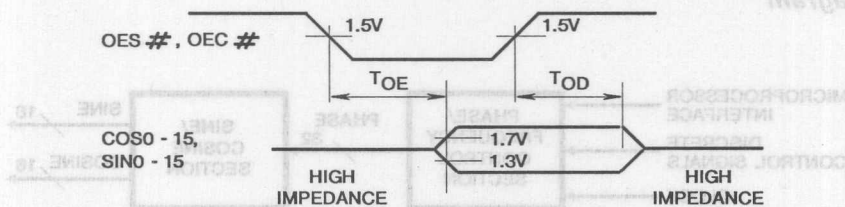
## SYNCHRONOUS TIMING



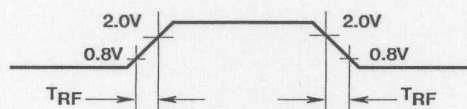
## ASYNCHRONOUS TIMING



## OUTPUT ENABLE, DISABLE TIMING



## OUTPUT RISE AND FALL TIMES





**HARRIS**

# HSP45106/883

August 1992

## 16 Bit Numerically Controlled Oscillator

### Features

- This Circuit is Processed in Accordance to Mil-Std-883 and is Fully Conformant Under the Provisions of Paragraph 1.2.1
- 25.6MHz Clock Rate
- 32-Bit Center and Offset Frequency Control
- 16-Bit Phase Control
- 8 Level PSK Supported Through Three Pin Interface
- Simultaneous 16 Bit Sine and Cosine Outputs
- Output in Two's Complement or Offset Binary
- <0.006Hz Tuning Resolution at 25.6MHz
- Serial or Parallel Outputs
- Spurious Frequency Components < -90dBc
- 16 Bit Microprocessor Compatible Control Interface
- 85 Pin PGA

### Applications

- Direct Digital Synthesis
- Quadrature Signal Generation
- Modulation - FM, FSK, PSK (BPSK, QPSK, 8PSK)
- Precision Signal Generation

### Description

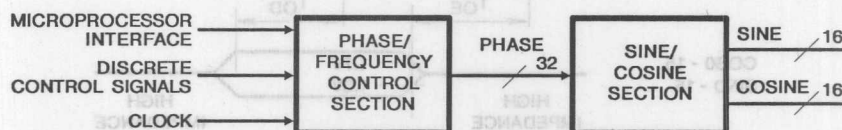
The Harris HSP45106/883 is a high performance 16-bit quadrature numerically controlled oscillator (NCO16). The NCO16 simplifies applications requiring frequency and phase agility such as frequency-hopped modems, PSK modems, spread spectrum communications, and precision signal generators. As shown in the block diagram, the HSP45106/883 is divided into a Phase/Frequency Control Section (PFCS) and a Sine/Cosine Section.

The inputs to the Phase/Frequency Control Section consist of a microprocessor interface and individual control lines. The frequency resolution is 32 bits, which provides for resolution of better than 0.006Hz at 25.6MHz. User programmable center frequency and offset frequency registers give the user the capability to perform phase coherent switching between two sinusoids of different frequencies. Further, a programmable phase control register allows for phase control of better than 0.006°. In applications requiring up to 8 level PSK, three discrete inputs are provided to simplify implementation.

The output of the PFCS is a 32-bit phase argument which is input to the sine/cosine section for conversion into sinusoidal amplitude. The outputs of the sine/cosine section are two 16-bit quadrature signals. The spurious free dynamic range of this complex vector is greater than 90dBc.

For added flexibility when using the NCO16 in conjunction with DAC's, a choice of either parallel of serial outputs with either two's complement or offset binary encoding is provided. In addition, a synchronization signal is available which signals serial word boundaries.

### Block Diagram



CAUTION: Electronic devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
Copyright © Harris Corporation 1992

File Number **2815.1**

# Specifications HSP45106/883

## Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input, Output Voltage Applied .....	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range .....	-65°C to +150°C
Junction Temperature .....	+175°C
Lead Temperature (Soldering, Ten Seconds) .....	+300°C
ESD Classification .....	Class 1

## Reliability Information

Thermal Resistance	$\theta_{ja}$	$\theta_{jc}$
Ceramic PGA Package .....	36.0°C/W	11.6°C/W
Maximum Package Power Dissipation at +125°C		
Ceramic PGA Package .....	1.39 Watt	
Gate Count .....	18,750 Gates	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range .....	+4.5V to +5.5V
Operating Temperature Range .....	-55°C to +125°C

TABLE 1. HSP45106/883 D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Devices Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +2.0mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output Leakage Current	$I_O$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Clock Input High	$V_{IHC}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	3.0	-	V
Clock Input Low	$V_{ILC}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ , (Note 4)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 25.6MHz$ $V_{CC} = 5.5V$ (Notes 2, 4)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	205	mA
Functional Test	FT	(Note 3)	7, 8	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	-	-

### NOTES:

- Interchanging of force and sense conditions is permitted.
- Operating Supply Current is proportional to frequency, typical rating is 8mA/MHz.
- Tested as follows:  $f = 1MHz$ ,  $V_{IH} = 2.6$ ,  $V_{IL} = 0.4$ ,  $V_{OH} \geq 1.5V$ ,  $V_{OL} \leq 1.5V$ ,  $V_{IHC} = 3.4V$ , and  $V_{ILC} = 0.4V$ .
- Loading is as specified in the test load circuit with  $C_L = 40pF$ .

# Specifications HSP45106/883

TABLE 2. A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested.

PARAMETERS	SYMBOL	(NOTE 1) CONDI- TIONS	GROUP A SUBGROUP	TEMPERATURE	LIMITS -25 (25.6MHz)		UNITS
					MIN	MAX	
CLK Period	T <sub>CP</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	39	-	ns
CLK High	T <sub>CH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	ns
CLK Low	T <sub>CL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	ns
WR# Period	T <sub>WP</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	39	-	ns
WR# High	T <sub>WH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	ns
WR# Low	T <sub>WL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	ns
Set-up Time A0-2, CS# to WR# Going High	T <sub>AWS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	13	-	ns
Hold Time A0-2, CS# from WR# Going High	T <sub>AWH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	2	-	ns
Set-up Time C0-15 to WR# Going High	T <sub>CWS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	ns
Hold Time C0-15 from WR# Going High	T <sub>CWH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	1	-	ns
Set-up Time WR# High to CLK High	T <sub>WC</sub>	Note 3	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	16	-	ns
Set-up Time MOD0-2 to CLK Going High	T <sub>MCS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	ns
Hold Time MOD0-2 from CLK Going High	T <sub>MCH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	1	-	ns
Set-up Time ENPOREG#, ENOFREG#, ENCFREG#, ENPHAC#, ENTIREG#, INHOFR#, PMSEL#, INITPAC#, BINFMT#, TEST, PAR/SER#, PACI#, INITTAC# to CLK Going High	T <sub>ECS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	12	-	ns
Hold Time ENPOREG#, ENOFREG#, ENCFREG#, ENPHAC#, ENTIREG#, INHOFR#, PMSEL#, INITPAC#, BINFMT#, TEST, PAR/SER#, PACI#, INITTAC# from CLK Going High	T <sub>ECH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	1	-	ns
CLK to Output Delay SINO-15, COS0-15, TICO#	T <sub>DO</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	18	ns
CLK to Output Delay DACSTRB#	T <sub>DSO</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	2	18	ns
Output Enable Time	T <sub>OE</sub>	Note 2	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	12	ns

NOTES:

1. A.C. Testing: V<sub>CC</sub> = 4.5V and 5.5V. Inputs are driven to 3.0V for a Logic "1" and 0.0V for a Logic "0". Input and output timing measurements are made at 1.5V for both a Logic "1" and "0". CLK is driven at 4.0V and 0V and measured at 2.0V. Output load per test load circuit with switch closed and C<sub>L</sub> = 40pF.
2. Transition is measured at ±200mV from steady state voltage with loading as specified by test load circuit and C<sub>L</sub> = 40pF.
3. If ENOFRCCTL#, ENCFRCCTL#, ENTICTL# or ENPHREG# are active, care must be taken to not violate set-up and hold times to these registers when writing data into the chip via the C0-15 port.

# Specifications HSP45106/883

TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETERS	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	LIMITS		UNITS
					-25 (25.6MHz)		
					MIN	MAX	
Input Capacitance	C <sub>IN</sub>	V <sub>CC</sub> = Open, f = 1MHz, All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	10	pF
Output Capacitance	C <sub>OUT</sub>	V <sub>CC</sub> = Open, f = 1MHz, All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	10	pF
Output Disable Delay	T <sub>OEZ</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	15	ns
Output Rise Time	T <sub>OR</sub>	From 0.8V to 2.0V	1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	8	ns
Output Fall Time	T <sub>OF</sub>	From 2.0V to 0.8V	1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	8	ns

## NOTES:

- Parameters listed in Table 3 are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design and after major process and/or design changes.
- Loading is as specified in the test load circuit with switch closed and C<sub>L</sub> = 40pF.

TABLE 4. ELECTRICAL TEST REQUIREMENTS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9



## Burn-In Circuit

HSP45106/883 PIN GRID ARRAY (PGA)

	11	10	9	8	7	6	5	4	3	2	1	
L	GND	SIN0	SIN1	SIN3	SIN5	SIN4	SIN9	SIN12	SIN13	SIN14	DAC STRB #	L
K	FMT	V <sub>CC</sub>	CLK	SIN2	V <sub>CC</sub>	SIN8	SIN10	GND	SIN15	OES #	COS0	K
J	INITPAC #	PAR/SEL #			SIN6	SIN7	SIN11			OEC #	COS1	J
H	ENPHAC #	PACI #								COS2	COS3	H
G	ENTIREG #	INITTAC #	INHOF R #						COS6	COS4	COS5	G
F	ENCFREG #	ENPOREG #	ENOFREG #						COS7	COS8	V <sub>CC</sub>	F
E	CS #	GND	WR #						COS11	COS10	COS9	E
D	V <sub>CC</sub>	TEST							GND	COS12		D
C	MOD2	MOD0			C10	C9	C6		INDEX PIN	COS15	COS13	C
B	MOD1	A2	A1	C15	C12	C13	V <sub>CC</sub>	C4	C1	TICO #	COS14	B
A	PMSEL	A0	GND	C14	C11	C8	C7	C5	C3	C2	C0	A

85 LEAD PGA  
TOP VIEWA PIN 'A1'  
ID

PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
A1	C0	F7	B11	MOD1	F13	F9	ENOFREG#	F8	K2	OES#	F14
A2	C2	F7	C1	COS13	V <sub>CC</sub> /2	F10	ENPOREG#	F4	K3	SIN15	V <sub>CC</sub> /2
A3	C3	F7	C2	COS15	V <sub>CC</sub> /2	F11	ENCFREG#	F7	K4	GND	GND
A4	C5	F8	C5	C6	F8	G1	COS5	V <sub>CC</sub> /2	K5	SIN10	V <sub>CC</sub> /2
A5	C7	F8	C6	C9	F10	G2	COS4	V <sub>CC</sub> /2	K6	SIN8	V <sub>CC</sub> /2
A6	C8	F10	C7	C10	F10	G3	COS6	V <sub>CC</sub> /2	K7	V <sub>CC</sub>	V <sub>CC</sub>
A7	C11	F10	C10	MOD0	F12	G9	INHOF R #	F11	K8	SIN2	V <sub>CC</sub> /2
A8	C14	F11	C11	MOD2	F14	G10	INITTAC#	F13	K9	CLK	F0
A9	GND	GND	D1	COS12	V <sub>CC</sub> /2	G11	ENTIREG#	F12	K10	V <sub>CC</sub>	V <sub>CC</sub>
A10	A0	F8	D2	GND	GND	H1	COS3	V <sub>CC</sub> /2	K11	BINFMT#	F6
A11	PMSEL	F14	D10	TEST	F14	H2	COS2	V <sub>CC</sub> /2	L1	DACSTRB#	V <sub>CC</sub> /2
B1	COS14	V <sub>CC</sub> /2	D11	V <sub>CC</sub>	V <sub>CC</sub>	H10	PACI#	F11	L2	SIN14	V <sub>CC</sub> /2
B2	TICO#	V <sub>CC</sub> /2	E1	COS9	V <sub>CC</sub> /2	H11	ENPHAC#	F10	L3	SIN13	V <sub>CC</sub> /2
B3	C1	F7	E2	COS10	V <sub>CC</sub> /2	J1	COS1	V <sub>CC</sub> /2	L4	SIN12	V <sub>CC</sub> /2
B4	C4	F8	E3	COS11	V <sub>CC</sub> /2	J2	OEC#	F14	L5	SIN9	V <sub>CC</sub> /2
B5	V <sub>CC</sub>	V <sub>CC</sub>	E9	WR#	F4	J5	SIN11	V <sub>CC</sub> /2	L6	SIN4	V <sub>CC</sub> /2
B6	C13	F11	E10	GND	GND	J6	SIN7	V <sub>CC</sub> /2	L7	SIN5	V <sub>CC</sub> /2
B7	C12	F11	E11	CS#	F6	J7	SIN6	V <sub>CC</sub> /2	L8	SIN3	V <sub>CC</sub> /2
B8	C15	F11	F1	V <sub>CC</sub>	V <sub>CC</sub>	J10	PAR/SER#	F13	L9	SIN1	V <sub>CC</sub> /2
B9	A1	F7	F2	COS8	V <sub>CC</sub> /2	J11	INITPAC#	F12	L10	SIN0	V <sub>CC</sub> /2
B10	A2	F10	F3	COS7	V <sub>CC</sub> /2	K1	COS0	V <sub>CC</sub> /2	L11	GND	GND

## NOTES:

- V<sub>CC</sub>/2 (2.7V ±10%) used for outputs only.
- 47KΩ (±20%) resistor connected to all pins except V<sub>CC</sub> and GND.
- V<sub>CC</sub> = 5.5V ±0.5V.
- 0.1μF (min) capacitor between V<sub>CC</sub> and GND per position.
- F0 = 100kHz ±10%, F1 = F0/2, F2 = F1/2 ..., F11 = F10/2, 40% - 60% Duty Cycle.
- Input voltage limits: V<sub>IL</sub> = 0.8V Max V<sub>IH</sub> = 4.5V ±10%

**Die Characteristics****DIE DIMENSIONS:**

251 x 240 x 19 ±1 mils

**METALLIZATION:**

Type: Si-Al or Si-Al-Cu

Thickness: 8kÅ

**GLASSIVATION:**

Type: Nitrox

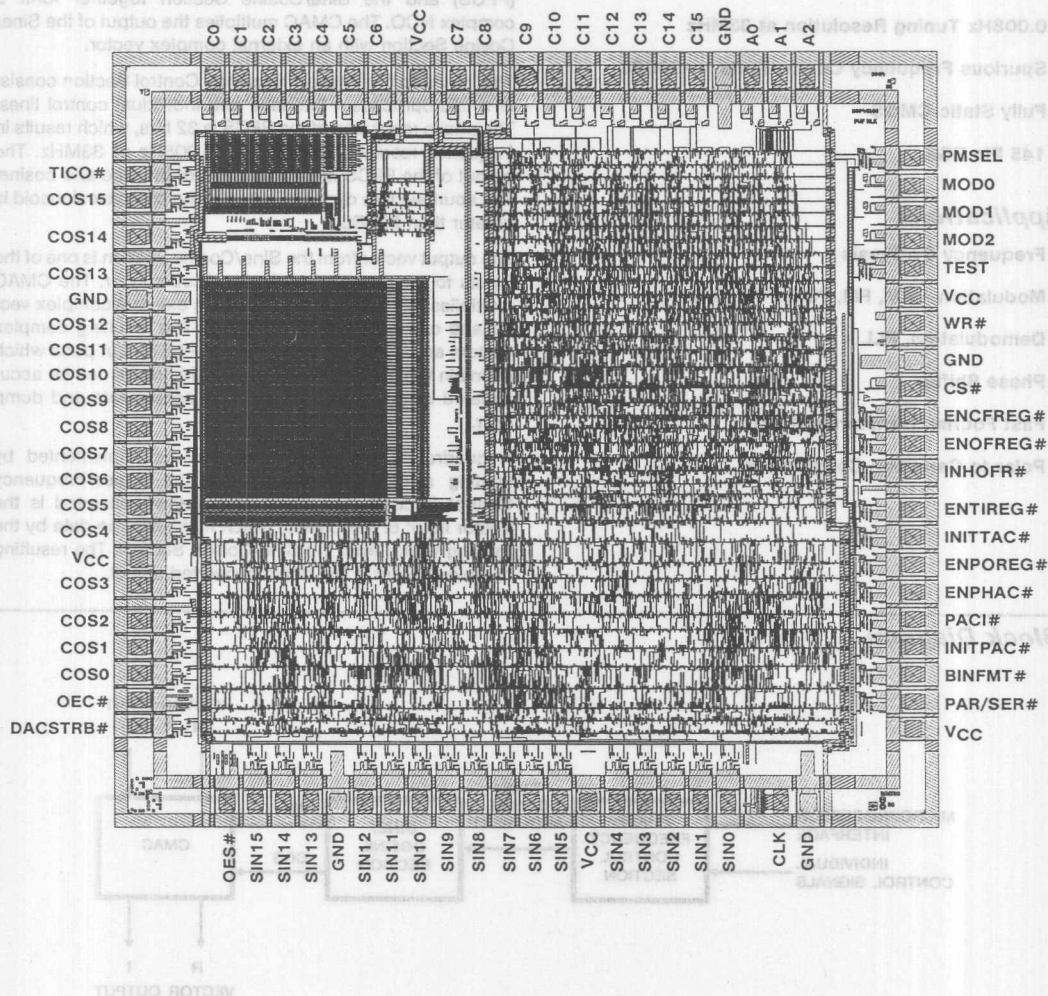
Thickness: 10kÅ

**DIE ATTACH:**

Material: Silicon Au (Gold) Eutectic Alloy or Silver-Glass

**WORST CASE CURRENT DENSITY:** 0.8 X 10<sup>5</sup> A/cm<sup>2</sup>**Metallization Mask Layout**

HSP45106/883



August 1992

### Features

- NCO and CMAC on One Chip
- 15MHz, 25.6MHz, 33MHz Versions
- 32-bit Frequency Control
- 16-bit Phase Modulation
- 16-bit CMAC
- 0.008Hz Tuning Resolution at 33MHz
- Spurious Frequency Components < -90dBc
- Fully Static CMOS
- 145 Pin PGA

### Applications

- Frequency Synthesis
- Modulation - AM, FM, PSK, FSK, QAM
- Demodulation, PLL
- Phase Shifter
- Fast Fourier Transforms (FFT)
- Polar to Cartesian Conversions

### Description

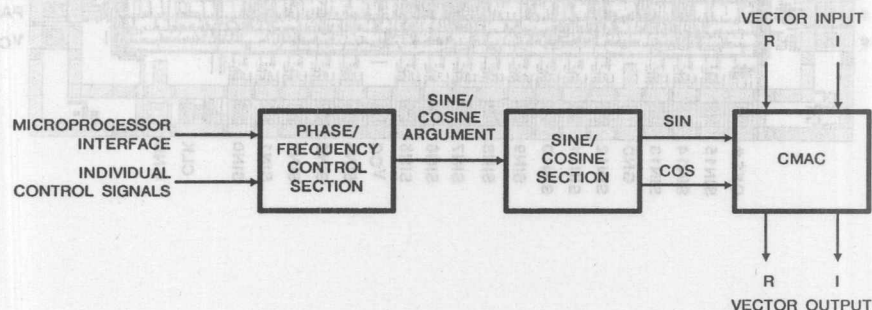
The Harris HSP45116 combines a high performance quadrature numerically controlled oscillator (NCO) and a high speed 16-bit Complex Multiplier/Accumulator (CMAC) on a single IC. This combination of functions allows a complex vector to be multiplied by the internally generated (cos, sin) vector for quadrature modulation and demodulation. As shown in the block diagram, the HSP45116 is divided into three main sections. The Phase/Frequency Control Section (PFCS) and the Sine/Cosine Section together form a complex NCO. The CMAC multiplies the output of the Sine/Cosine Section with an external complex vector.

The inputs to the Phase/Frequency Control Section consist of a microprocessor interface and individual control lines. The phase resolution of the PFCS is 32 bits, which results in frequency resolution better than 0.008Hz at 33MHz. The output of the PFCS is the argument of the sine and cosine. The spurious free dynamic range of the complex sinusoid is greater than 90dBc.

The output vector from the Sine/Cosine Section is one of the inputs to the Complex Multiplier/Accumulator. The CMAC multiplies this (cos, sin) vector by an external complex vector and can accumulate the result. The resulting complex vectors are available through two 20-bit output ports which maintain the 90dB spectral purity. This result can be accumulated internally to implement an accumulate and dump filter.

A quadrature down converter can be implemented by loading a center frequency into the Phase/Frequency Control Section. The signal to be downconverted is the Vector Input of the CMAC, which multiplies the data by the rotating vector from the Sine/Cosine Section. The resulting complex output is the down converted signal.

### Block Diagram



## Pinouts

145 PIN PGA  
TOP VIEW

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	
A	VCC	IMIN 4	IMIN 8	IMIN 9	IMIN 11	IMIN 15	IMIN 16	GND	VCC	IO 18	IO 15	IO 12	IO 10	GND	VCC	A
B	GND	IMIN 1	IMIN 5	IMIN 7	IMIN 10	IMIN 13	IMIN 14	IO 19	IO 16	IO 14	IO 11	IO 8	IO 7	IO 5	IO 2	B
C	RIN 15	RIN 18	IMIN 2	IMIN 3	IMIN 6	IMIN 12	IMIN 17	IMIN 18	IO 17	IO 13	IO 9	IO 6	IO 4	IO 1	RO 18	C
D	RIN 13	RIN 17	IMIN 0	INDEX									IO 3	RO 19	RO 17	D
E	RIN 10	RIN 14	RIN 16										IO 0	RO 16	RO 15	E
F	RIN 7	RIN 11	RIN 12										RO 14	RO 13	RO 11	F
G	VCC	RIN 9	RIN 8										RO 9	RO 12	RO 10	G
H	GND	RIN 6	RIN 5										RO 8	RO 7	GND	H
J	RIN 3	RIN 1	RIN 4										RO 5	RO 4	VCC	J
K	RIN 2	RIN 0	SH 1										RO 1	RO 2	RO 6	K
L	SH 0	ACC	RBVTLD #										PACO #	DET 1	RO 3	L
M	ENPH REG #	PEAK #	MOD 1										OEREXT #	OEI #	RO 0	M
N	ENOF REG #	BINFMT #	MOD 0	LOAD #	ENCF REG #	MODR /PI #	AD 0	C 14	C 13	C 8	C 2	OUT-MUX 1	OUT-MUX 0	OEREXT #	DET 0	N
P	TICO #	PACI #	PMSSEL #	CLROPH #	ENTHREG #	CS #	AD 1	C 15	C 10	C 9	C 6	C 3	C 1	OER #	GND	P
Q	VCC	GND	ENPHAC #	ENI #	CLK	WR	VCC	GND	C 12	C 11	C 7	C 5	C 4	C 0	VCC	Q

## BOTTOM VIEW

	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	
A	VCC	GND	IO 10	IO 12	IO 15	IO 18	VCC	GND	IMIN 16	IMIN 15	IMIN 11	IMIN 9	IMIN 8	IMIN 4	VCC	A
B	IO 2	IO 5	IO 7	IO 8	IO 11	IO 14	IO 16	IO 19	IMIN 14	IMIN 13	IMIN 10	IMIN 7	IMIN 5	IMIN 1	GND	B
C	RO 18	IO 1	IO 4	IO 6	IO 9	IO 13	IO 17	IMIN 18	IMIN 17	IMIN 12	IMIN 6	IMIN 3	IMIN 2	RIN 18	RIN 15	C
D	RO 17	RO 19	IO 3										INDEX	IMIN 0	RIN 17	D
E	RO 15	RO 16	IO 0										RIN 16	RIN 14	RIN 10	E
F	RO 11	RO 13	RO 14										RIN 12	RIN 11	RIN 7	F
G	RO 10	RO 12	RO 9										RIN 8	RIN 9	VCC	G
H	GND	RO 7	RO 8										RIN 5	RIN 6	GND	H
J	VCC	RO 4	RO 5										RIN 4	RIN 1	RIN 3	J
K	RO 6	RO 2	RO 1										SH 1	RIN 0	RIN 2	K
L	RO 3	DET 1	PACO #										RBVTLD #	ACC	SH 0	L
M	RO 0	OEI #	OEREXT #										MOD 1	PEAK #	ENPH REG #	M
N	DET 0	OEREXT #	OUTMUX 0	OUTMUX 1	C 2	C 8	C 13	C 14	AD 0	MODR /PI #	ENCF REG #	LOAD #	MOD 0	BINFMT #	ENOF REG #	N
P	GND	OER #	C 1	C 3	C 6	C 9	C 10	C 15	AD 1	CS #	ENTHREG #	CLROPH #	PMSSEL #	PACI #	TICO #	P
Q	VCC	C 0	C 4	C 5	C 7	C 11	C 12	GND	VCC	WR	CLK	ENI #	ENPHAC #	GND	VCC	Q



## Pin Description

NAME	NUMBER	TYPE	DESCRIPTION
VCC	A1, A9, A15, G1, J15, Q1, Q7, Q15		+5 Power supply input
GND	A8, A14, B1, H1, H15, P15, Q2, Q8		Power supply ground input
C0-15	N8-11, P8-13, Q9-14	I	Control input bus for loading phase and frequency data into the PFCS. C15 is the MSB.
AD0-1	N7, P7	I	Address pins for selecting destination of C0-15 data
CS#	P6	I	Chip select (Active Low)
WR#	Q6	I	Write enable. Data is clocked into the register selected by AD0-1 on the rising edge of WR# when the CS# line is low.
CLK	Q5	I	Clock. All registers, except the control registers clocked with WR#, are clocked (when enabled) by the rising edge of CLK.
ENPHREG#	M1	I	Phase register enable. (Active low) Registered on chip by CLK. When active, after being clocked onto chip, ENPHREG# enables the clocking of data into the phase register.
ENOFREG#	N1	I	Frequency offset register enable. (Active Low) Registered on chip by CLK. When active, after being clocked onto chip, ENOFREG# enables clocking of data into the frequency offset register.
ENCFREG#	N5	I	Center frequency register enable. (Active low) Registered on chip by CLK. When active, after being clocked onto chip, ENCFREG# enables clocking of data into the center frequency register.
ENPHAC#	Q3	I	Phase accumulator register enable. (Active low) Registered on chip by CLK. When active, after being clocked onto chip, ENPHAC# enables clocking of the phase accumulator register.
ENTIREG#	P5	I	Time interval control register enable. (Active low) Registered on chip by CLK. When active, after being clocked onto chip, ENTIREG# enables clocking of data into the time accumulator register.
ENI#	Q4	I	Real and imaginary data input register (RIR, IIR) enable. (Active low) Registered on chip by CLK. When active, after being clocked onto chip, ENI# enables clocking of data into the real and imaginary input data register.
MODPI/2PI#	N6	I	Modulo $\pi/2\pi$ select. When low, the Sine and Cosine ROMs are addressed modulo $2\pi$ (360 degrees). When high, the most significant address bit is held low so that the ROMs are addressed modulo $\pi$ (180 degrees). This input is registered on chip by clock.
CLROFR#	P4	I	Frequency offset register output zero. (Active low) Registered on chip by CLK. When active, after being clocked onto chip, CLROFR# zeros the data path from the frequency offset register to the frequency adder. New data can still be clocked into the frequency offset register; CLROFR# does not affect the contents of the register.
LOAD#	N4	I	Phase accumulator load control. (Active low) Registered on chip by CLK. Zeroes feedback path in the phase accumulator without clearing the phase accumulator register.
MOD0-1	M3, N3	I	External modulation control bits. When selected with the PMSEL line, these bits add a 0, 90, 180, or 270 degree offset to the current phase in the phase accumulator. The lower 14 bits of the phase control path are set to zero. These bits are loaded into the phase register when ENPHREG# is low.
PMSEL	P3	I	Phase modulation select line. This line determines the source of the data clocked into the phase register. When high, the phase control register is selected. When low, the external modulation pins (MOD0-1) are selected for the most significant two bits and the least significant two bits and the least significant 14 bits are set to zero. This control is registered by CLK.
RBYTILD#	L3	I	ROM bypass, timer load. Active low, Registered by CLK. This input bypasses the sine/cosine ROM so that the 16 bit phase adder output and lower 16 bits of the phase accumulator go directly to the CMAC's sine and cosine inputs, respectively. It also enables loading of the timer accumulator register by zeroing the feedback in the accumulator.

## Pin Description (Continued)

NAME	NUMBER	TYPE	DESCRIPTION
PACI#	P2	I	Phase accumulator carry input. (Active low) A low on this pin causes the phase accumulator to increment by one in addition to the values in the phase accumulator register and frequency adder.
PACO#	L13	O	Phase accumulator carry output. Active low and registered by CLK. A low on this output indicates that the phase accumulator has overflowed, i.e., the end of one sine/cosine cycle has been reached.
TICO#	P1	O	Time interval accumulator carry output. Active low, registered by CLK. This output goes low when a carry is generated by the time interval accumulator. This function is provided to time out control events such as synchronizing register clocking to data timing.
RINO-18	C1, C2, D1, D2, E1-3, F1-3, G2, G3, H2, H3, J1-3, K1, K2	I	Real input data bus. This is the external real component into the complex multiplier. The bus is clocked into the real input data register by CLK when ENI# is asserted.
IMINO-18	A2-7, B2-7, C3-8, D3	I	Imaginary input data bus. This is the external imaginary component into the complex multiplier. The bus is clocked into the real input data register by CLK when ENI# is asserted.
SH0-1	K3, L1	I	Shift control inputs. These lines control the input shifters of the RIN and IIN inputs of the complex multiplier. The shift controls are common to the shifters on both of the busses.
ACC	L2	I	Accumulate/dump control. This input controls the complex accumulators and their holding registers. When high, the accumulators accumulate and the holding registers are disabled. When low, the feedback in the accumulators is zeroed to cause the accumulators to load.  The holding registers are enabled to clock in the results of the accumulation. This input is registered by CLK.
BINFMT#	N2	I	This input is used to convert the two's complement output to offset binary (unsigned) for applications using D/A converters. When low, bits RO19 and IO19 are inverted from the internal two's complement representation. This input is registered by CLK.
PEAK#	M2	I	This input enables the peak detect feature of the block floating point detector. When high, the maximum bit growth in the output holding registers is encoded and output on the DET0-1 pins. When the PEAK# input is asserted, the block floating point detector output will track the maximum growth in the holding registers, including the data in the holding registers at the time that PEAK# is activated.
OUTMUX0-1	N12, N13	I	These inputs select the data to be output on RO0-19 and IO0-19.
RO0-19	C15, D14, D15, E14, E15, F13-15, G13-15, H13, H14, J13, J14, K13-15, L15, M15	O	Real output data bus. These three state outputs are controlled by OER# and OEREXT#. OUTMUX0-1 select the data output on the bus.
IO0-19	A10-13, B8-15, C9-14, D13, E13	O	Imaginary output data bus. These three state outputs are controlled by OEI# and OEIEXT#. OUTMUX0-1 select the data output on the bus.
DET0-1	N15, L14	O	These output pins indicate the number of bits of growth in the accumulators. While PEAK# is low, these pins indicate the peak growth. The detector examines bits 15-18, real and imaginary accumulator holding registers and bits 30-33 of the real and imaginary CMAC holding registers. The bits indicate the largest growth of the four registers.
OER#	P14	I	Three state control for bits RO0-15. Outputs are enabled when the line is low.
OEREXT#	M13	I	Three state control for bits RO16-19. Outputs are enabled when the line is low.
OEI#	M14	I	Three state control for bits IO0-15. Outputs are enabled when the line is low.
OEIEXT#	N14	I	Three state control for bits IO16-19. Outputs are enabled when the line is low.

### Functional Description

The Numerically Controlled Oscillator/Modulator (NCOM) produces a digital complex sinusoid waveform whose amplitude, phase and frequency are controlled by a set of input command words. When used as a Numerically Controlled Oscillator (NCO), it generates 16 bit sine and cosine vectors at a maximum sample rate of 33MHz. The NCOM can be preprogrammed to produce a constant (CW) sine and cosine output for Direct Digital Synthesis (DDS) applications. Alternatively, the phase and frequency inputs can be updated in real time to produce a FM, PSK, FSK, or MSK modulated waveform. The Complex Multiplier/Accumulator (CMAC) can be used to multiply this waveform by an input signal for AM and QAM signals. By stepping the phase input, the output of the ROM becomes an FFT twiddle factor; when data is input to the Vector Inputs (see Block Diagram), the NCOM calculates an FFT butterfly.

As shown in the Block Diagram, the NCOM consists of three parts: Phase and Frequency Control Section (PFCS), Sine/Cosine Generator, and CMAC. The PFCS stores the phase and frequency inputs and uses them to calculate the phase angle of a rotating complex vector. The Sine/Cosine Generator performs a lookup on this phase and outputs the appropriate values for the sine and cosine. The sine and cosine form one set of inputs to the CMAC, which multiplies them by the input vector to form the modulated output.

### Phase and Frequency Control Section

The phase and frequency of the internally generated sine and cosine are controlled by the PFCS (Figure 1). The PFCS generates a 32 bit word that represents the current phase of the sine and cosine waves being generated: the Sine/Cosine Argument. Stepping this phase angle from 0 through full scale ( $2^{32} - 1$ ) corresponds to the phase angle of a sinusoid starting at  $0^\circ$  and advancing around the unit circle counterclockwise. The PFCS automatically increments the phase by a preprogrammed amount on every rising edge of the external clock. The value of the phase step (which is the sum of the Center and Offset Frequency Registers) is:

$$\text{Phase Step} = \frac{\text{Signal Frequency}}{\text{Clock Frequency}} \times 2^{32}$$

The PFCS is divided into 2 sections: the Phase Accumulator uses the data on C0-15 to compute the phase angle that is the input to the Sine/Cosine Section (Sine/Cosine Argument); the Time Accumulator supplies a pulse to mark the passage of a preprogrammed period of time.

The Phase Accumulator and Time Accumulator work on the same principle: a 32 bit word is added to the contents of a 32 bit accumulator register every clock cycle; when the sum

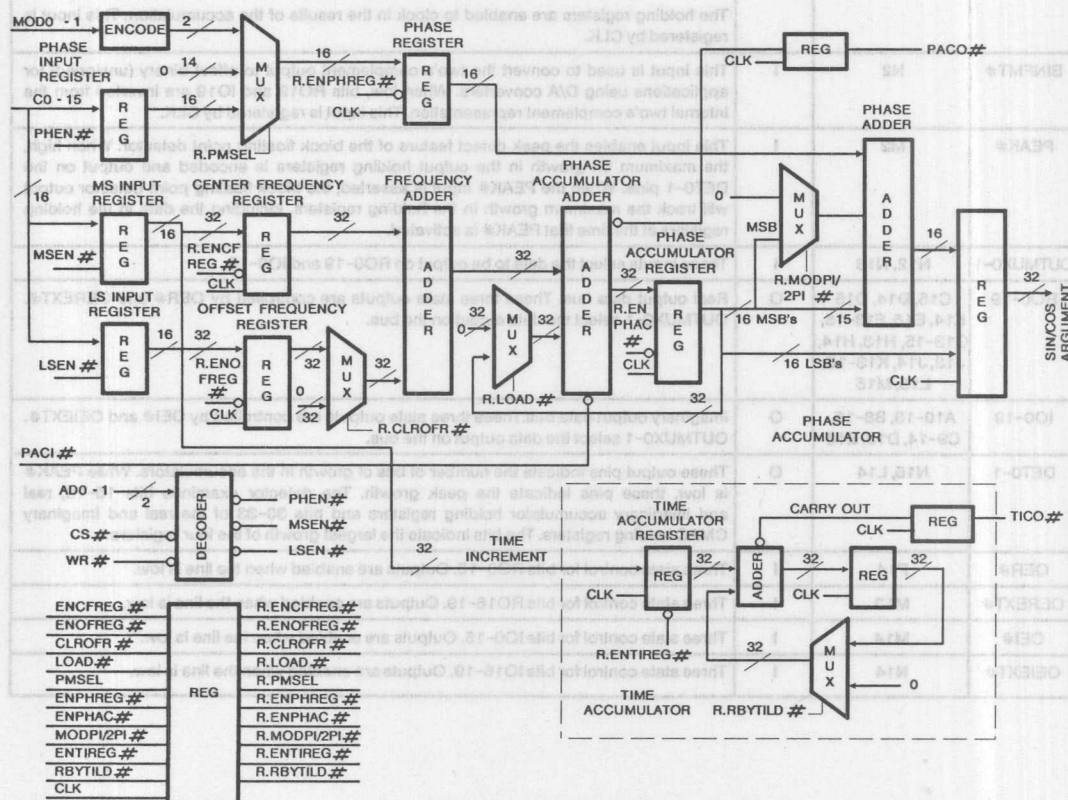


FIGURE 1. PHASE/FREQUENCY CONTROL SECTION BLOCK DIAGRAM



causes the adder to overflow, the accumulation continues with the 32 bits of the adder going into the accumulator register. The overflow bit is used as an output to indicate the timing of the accumulation overflows. In the Time Accumulator, the overflow bit generates TICO#, the Time Accumulator carry out (which is the only output of the Time Accumulator). In the Phase Accumulator, the overflow is inverted to generate the Phase Accumulator Carry Out, PACO#.

The output of the Phase Accumulator goes to the Phase Adder, which adds an offset to the top 16 bits of the phase. This 32 bit number forms the argument of the sine and cosine, which is passed to the Sine/Cosine Generator.

Both accumulators are loaded 16 bits at a time over the C0-15 bus. Data on C0-15 is loaded into one of the three input registers when CS# and WR# are low. The data in the Most Significant Input Register and Least Significant Input Register forms a 32 bit word that is the input to the Center Frequency Register, Offset Frequency Register and Time Accumulator. These registers are loaded by enabling the proper register enable signal; for example, to load the Center Frequency Register, the data is loaded into the LS and MS Input Registers, and ENCFREG# is set to zero; the next rising edge of CLK will pass the registered version of ENCFREG#, R.ENCFREG#, to the clock enable of the Center Frequency Register; this register then gets loaded on the following rising edge of CLK. The contents of the Input Registers will be continuously loaded into the Center Frequency Register as long as R.ENCFREG# is low.

The Phase Register is loaded in a similar manner. Assuming PMSEL is high, the contents of the Phase Input Register is loaded into the Phase Register on every rising clock edge that R.ENPHREG is low. If PMSEL is low, MOD0-1 supply the two most significant bits into the Phase Register (MOD1 is the MSB) and the least significant 14 bits are loaded with 0. MOD0-1 are used to generate a Quad Phase Shift Keying (QPSK) signal (Table 2).

TABLE 1. AD0-1 DECODING

AD1	AD0	CS#	WR#	FUNCTION
0	0	0	↑	Load least significant bits of frequency input
0	1	0	↑	Load most significant bits of frequency input
1	0	0	↑	Load phase register
1	1	X	X	Reserved
X	X	1	X	Reserved

The Phase Accumulator consists of registers and adders that compute the value of the current phase at every clock. It has three inputs: Center Frequency, which corresponds to the carrier frequency of a signal; Offset Frequency, which is the deviation from the Center Frequency; and Phase, which is a 16 bit number that is added to the current phase for

PSK modulation schemes. These three values are used by the Phase Accumulator and Phase Adder to form the phase of the internally generated sine and cosine.

The sum of the values in Center and Offset Frequency Registers corresponds to the desired phase increment (modulo  $2^{32}$ ) from one clock to the next. For example, loading both registers with zero will cause the Phase Accumulator to add zero to its current output; the output of the PFCS will remain at its current value; i.e., the output of the NCOM will be a DC signal. If a hexadecimal 00000001 is loaded into the Center Frequency Control Register, the output of the PFCS will increment by one after every clock. This will step through every location in the Sine/Cosine Generator, so that the output will be the lowest frequency above DC that can be generated by the NCOM, i.e., the clock frequency divided by  $2^{32}$ . If the input to the Center Frequency Control Register is hex 80000000, the PFCS will step through the Generator with half of the maximum step size, so that frequency of the output waveform will be half of the sample rate.

The operation of the Offset Frequency Control Register is identical to that of the Center Frequency Control Register; having two separate registers allows the user to generate an FM signal by loading the carrier frequency in the Center Frequency Control Register and updating the Offset Frequency Control Register with the value of the frequency offset - the difference between the carrier frequency and the frequency of the output signal. A logic low on CLROFR# disables the output of the Offset Frequency Register without clearing the contents of the register.

TABLE 2. MOD0-1 DECODE

MOD1	MOD0	PHASE SHIFT (DEGREES)
0	0	0
0	1	90
1	0	270
1	1	180

Initializing the Phase Accumulator Register is done by putting a low on the LOAD# line. This zeroes the feedback path to the accumulator, so that the register is loaded with the current value of the phase increment summer on the next clock.

The final phase value going to the Generator can be adjusted using MODPI/2PI# to force the range of the phase to be  $0^\circ$  to  $180^\circ$  (modulo  $\pi$ ) or  $0^\circ$  to  $360^\circ$  (modulo  $2\pi$ ). Modulo  $2\pi$  is the mode used for modulation, demodulation, direct digital synthesis, etc. Modulo  $\pi$  is used to calculate FFTs. This is explained in greater detail in the Applications section.

The Phase Register adds an offset to the output of the Phase Accumulator. Since the Phase Register is only 16 bits, it is added to the top 16 bits of the Phase Accumulator.



The Time Accumulator consists of a register which is incremented on every clock. The amount by which it increments is loaded into the Input Registers and is latched into the Time Accumulator Register on rising edges of CLK while ENTIREG# is low. The output of the Time Accumulator is the accumulator carry out, TICO#. TICO# can be used as a timer to enable the periodic sampling of the output of the NCOM. The number programmed into this register equals  $2^{32} \times \text{CLK period/desired time interval}$ . TICO# is disabled and its phase is initialized by zeroing the feedback path of the accumulator with RBYTILD#.

### Sine/Cosine Section

The Sine/Cosine Section (Figure 2) converts the output of the PFCS into the appropriate values for the sine and cosine. It takes the most significant 20 bits of the PFCS output and passes them through a look up table to form the 16 bit sine and cosine inputs to the CMAC.

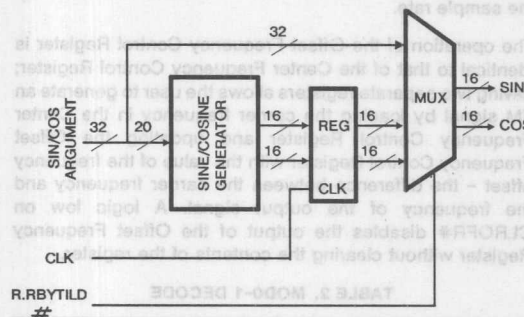


FIGURE 2. SINE/COSINE SECTION

The 20 bit word maps into  $2\pi$  radians so that the angular resolution is  $2\pi/2^{20}$ . An address of zero corresponds to 0 radians and an address of hex FFFF corresponds to  $2\pi(2^{20})$  radians. The outputs of the Generator section are 2's complement sine and cosine values. The sine and cosine outputs range from hexadecimal 8001, which represents negative full scale, to 7FFF, which represents positive full scale. Note that the normal range for two's complement numbers is 8000 to 7FFF; the output range of the SIN/COS generator is scaled by one so that it is symmetric about 0.

The sine and cosine values are computed to reduce the amount of ROM needed. The magnitude of the error in the computed value of the complex vector is less than -90.2dB. The error in the sine or cosine alone is approximately 2dB better.

If RBYTILD# is low, the output of the PFCS goes directly to the inputs of the CMAC. If the real and imaginary inputs of the CMAC are programmed to hex 7FFF and 0 respectively, then the output of the PFCS will appear on output bits 0 through 15 of the NCOM with the output multiplexers set to bring out the most significant bits of the CMAC output (OUTMUX = 00). The most significant 16 bits out of the PFCS appears on IOUT0-15 and the least significant bits come out on ROUT0-15.

### Complex Multiplier/Accumulator

The CMAC (Figure 3) performs two types of functions: complex multiplication/accumulation for modulation and demodulation of digital signals, and the operations necessary to implement an FFT butterfly. Modulation and demodulation are implemented using the complex multiplier and its associated accumulator; the rest of the circuitry in this section, i.e., the complex accumulator, input shifters and growth detect logic are used along with the complex multiplier/accumulator for FFTs. The complex multiplier performs the complex vector multiplication on the output of the Sine/Cosine Section and the vector represented by the real and imaginary inputs RIN and IIN. The two vectors are combined in the following manner:

$$\text{ROUT} = \text{COS} \times \text{RIN} - \text{SIN} \times \text{IIN}$$

$$\text{IOUT} = \text{COS} \times \text{IIN} + \text{SIN} \times \text{RIN}$$

RIN and IIN are latched into the input registers and passed through the shift stages. Clocking of the input registers is enabled with a low on ENI#. The amount of shift on the latched data is programmed with SH0-1 (Table 3). The output of the shifters is sent to the CMAC and the auxiliary accumulators.

TABLE 3. INPUT SHIFT SELECTION

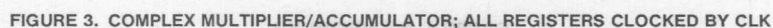
SH1	SH0	SELECTED BITS
0	0	RIN0-15, IMIN0-15
0	1	RIN1-16, IMIN1-16
1	0	RIN2-17, IMIN2-17
1	1	RIN3-18, IMIN3-18

The 33 bit real and imaginary outputs of the Complex Multiplier are latched in the Multiplier Registers and then go through the accumulator section of the CMAC. If the ACC line is high, the feedback to the accumulators is enabled; a low on ACC zeroes the feedback path, so that the next set of real and imaginary data out of the complex multiplier is stored in the CMAC Output Registers.

The data in the CMAC Output Registers goes to the Multiplexer, the output of which is determined by the OUTMUX0-1 lines (Table 4). BINFMT# controls whether the output of the Multiplexer is presented in two's complement or unsigned format; BINFMT# = 0 inverts ROUT19 and IOUT19 for unsigned output, while BINFMT# = 1 selects two's complement.

TABLE 4. OUTPUT MULTIPLEXER SELECTION

OUT MUX	OUT MUX	ROUT16-19	ROUT0-15	IOUT16-19	IOUT0-15
1	0	Real CMAC 31-34	Real CMAC 15-30	Imag CMAC 31-34	Imag CMAC 15-30
0	0	Real CMAC 31-34	Real CMAC 0-14	Imag CMAC 31-34	Imag CMAC 0-14
0	1	Real CMAC 31-34	Real CMAC 0-14	Imag CMAC 31-34	Imag CMAC 0-14
1	0	Real Acc 16-19	Real Acc 0-15	Imag Acc 16-19	Imag Acc 0-15
1	1	Reserved	Reserved	Reserved	Reserved



The Complex Accumulator duplicates the accumulator in the CMAC. The input comes from the data shifters, and its 20 bit complex output goes to the Multiplexer. ACC controls whether the accumulator is enabled or not. OUTMUX0-1 determines whether the accumulator output appears on ROUT and IOUT.

The Growth Detect circuitry outputs a two bit value that signifies the amount of growth on the data in the CMAC and Complex Accumulator. Its output, DET0-1, is encoded as shown in Table 5. If PEAK# is low, the highest value of DET0-1 is latched in the Growth Detect Output Register.

The relative weighting of the bits at the inputs and outputs of the CMAC is shown in figure 4. Note that the binary point of the sine, cosine, RIN and IIN is to the right of the most signif-

icant bit, while the binary point of RO and IO is to the right of the fifth most significant bit. These CMAC external input and output busses are aligned with each other to facilitate cascading NCOM's for FFT applications.

TABLE 5. GROWTH ENCODING

DET 1	DET 0	NUMBER OF BITS OF GROWTH ABOVE 2 <sup>0</sup>
0	0	0
0	1	1
1	0	2
1	1	3

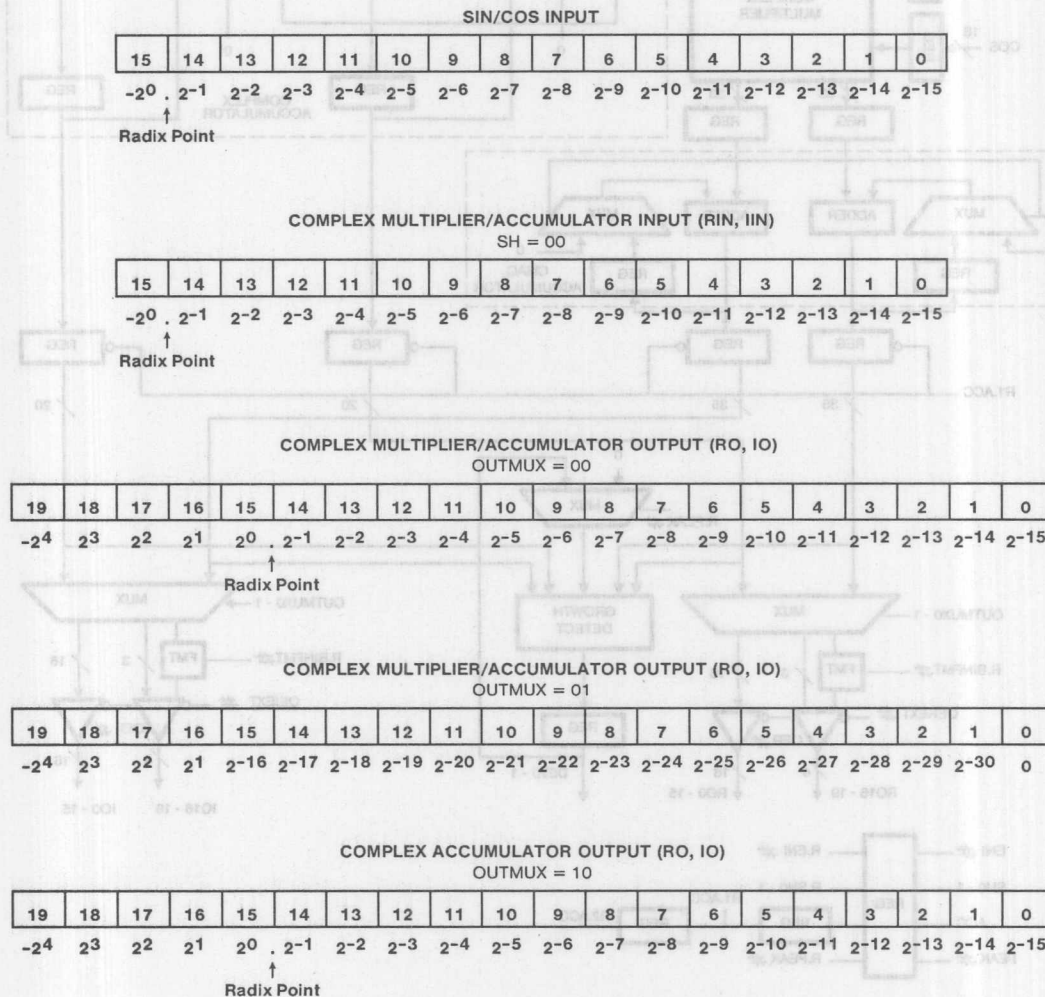


FIGURE 4. BIT WEIGHTING

## Applications

The NCOM can be used for Amplitude, Phase and Frequency modulation, as well as in variations and combinations of these techniques, such as QAM. It is most effective in applications requiring multiplication of a rotating complex sinusoid by an external vector. These include AM and QAM modulators and digital receivers. The NCOM implements AM and QAM modulation on a single chip, and is a element in demodulation, where it performs complex down conversion. It can be combined with the Harris HSP43220 Decimating Digital Filter to form the front end of a digital receiver.

### Modulation/Demodulation

Figure 5 shows a block diagram of an AM modulator. In this example, the phase increment for the carrier frequency is loaded into the center frequency register, and the modulating input is clocked into the real input of the CMAC, with the imaginary input set to 0. The modulated output is obtained at the real output of the CMAC. With a sixteen bit, two's complement signal input, the output will be a 16 bit real number, on ROUT0-15 (with OUTMUX = 00).

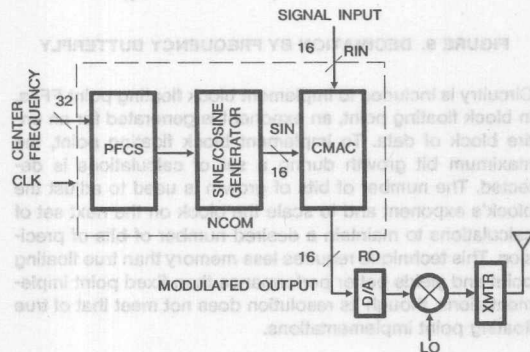


FIGURE 5. AMPLITUDE MODULATION

By replacing the real input with a complex vector, a similar setup can generate QAM signals (Figure 6). In this case, the carrier frequency is loaded into the center frequency register as before, but the modulating vector now carries both amplitude and phase information. Since the input vector and the internally generated sine and cosine waves are both 16 bits, the number of states is only limited by the characteristics of the transmission medium and by the analog electronics in the transmitter and receiver.

The phase and amplitude resolution for the Sine/Cosine section (16 bit output), delivers a spectral purity of greater than 90dBc. This means that the unwanted spectral components due to phase uncertainty (phase noise) will be greater than 90dB below the desired output (dBc, decibels below the carrier). With a 32 bit phase accumulator in the Phase/

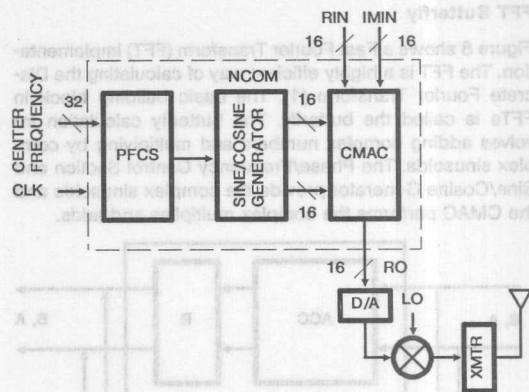


FIGURE 6. QUADRATURE AMPLITUDE MODULATION (QAM)

Frequency Control Section, the frequency tuning resolution equals the clock frequency divided by  $2^{32}$ . For example, a 25MHz clock gives a tuning resolution of 0.006Hz.

The NCOM also works with the HSP43220 Decimating Digital Filter to implement down conversion and low pass filtering in a digital receiver (Figure 7). The NCOM performs complex down conversion on the wideband input signal by multiplying the input vector and the internally generated complex sinusoid. The resulting signal has components at twice the center frequency and at DC. Two HSP43220's, one each on the real and imaginary outputs of the HSP45116, perform low pass filtering and decimation on the down converted data, resulting in a complex baseband signal.

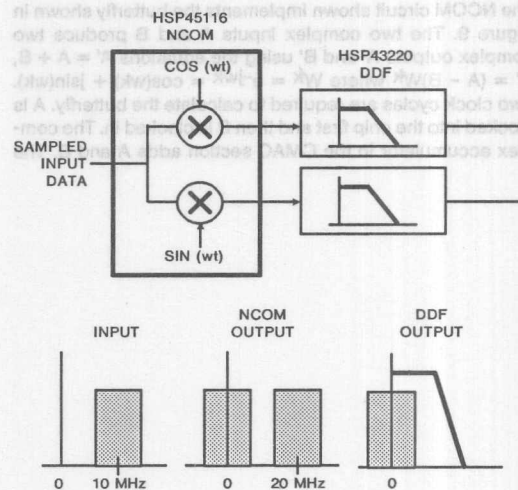


FIGURE 7. CHANNELIZED RECEIVER CHIP SET



## FFT Butterfly

Figure 8 shows a Fast Fourier Transform (FFT) implementation. The FFT is a highly efficient way of calculating the Discrete Fourier Transform [1]. The basic building block in FFTs is called the butterfly. The butterfly calculation involves adding complex numbers and multiplying by complex sinusoids. The Phase/Frequency Control Section and Sine/Cosine Generator provide the complex sinusoids and the CMAC performs the complex multiplies and adds.

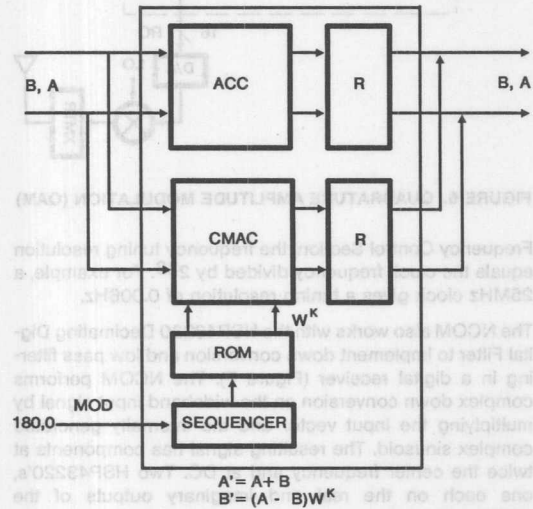


FIGURE 8. RADIX-2 FFT BUTTERFLY

The NCOM circuit shown implements the butterfly shown in Figure 9. The two complex inputs A and B produce two complex outputs A' and B' using the equations  $A' = A + B$ ,  $B' = (A - B)W^k$  where  $W^k = e^{-jwk} = \cos(wk) + j\sin(wk)$ . Two clock cycles are required to calculate the butterfly. A is clocked into the chip first and then B is clocked in. The complex accumulator in the CMAC section adds A and B. The

CMAC calculates  $(A - B)W^k$  as  $AW^k + B(-W^k)$ .  $-W^k$  is generated by phase shifting the ROM address 180 degrees using the phase modulation inputs. For radix-2 decimation in frequency FFTs, the phase of the complex sinusoid starts at 0 degrees and increments by a fixed step size (for each pass) after each butterfly. The phase/frequency section is initialized to 0 degrees and the frequency control loaded with the appropriate phase step size for the pass. The resulting words, A' and B', are held in output registers and multiplexed through the output pins for writing to memory. Using a single NCOM clocked at 25MHz, a 1024 point radix-2 FFT can be computed in  $(\text{CLK period}) \times (N \log_2 N)$ , or 410 microseconds.

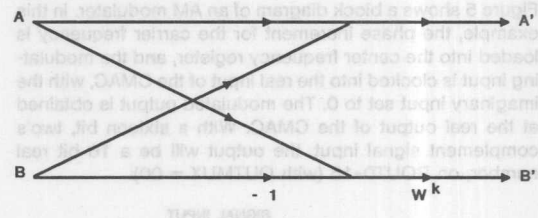


FIGURE 9. DECIMATION BY FREQUENCY BUTTERFLY

Circuitry is included to implement block floating point FFTs. In block floating point, an exponent is generated for an entire block of data. To implement block floating point, the maximum bit growth during a set of calculations is detected. The number of bits of growth is used to adjust the block's exponent and to scale the block on the next set of calculations to maintain a desired number of bits of precision. This technique requires less memory than true floating point and yields better performance than fixed point implementations, though its resolution does not meet that of true floating point implementations.

## References

- [1] Oppenheim, A. V. and Schaffer, R. W., *Discrete Time Signal Processing*, Prentice Hall

# Specifications HSP45116

## Absolute Maximum Ratings

Supply Voltage	+8.0V
Input, Output or I/O Voltage Applied	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature Range	-65°C to +150°C
Maximum Package Power Dissipation	4.55W
$\theta_{jc}$	8.3°C/W
$\theta_{ja}$	23.1°C/W
Component Count	103,000 Transistors
Junction Temperature	+175°C
Lead Temperature (Soldering, Ten Seconds)	+300°C
ESD Classification	Class 1

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range	+4.75V to +5.25V
Operating Temperature Range	0°C to +70°C

## D.C. Electrical Specifications

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
$V_{IH}$	Logical One Input Voltage	2.0	-	V	$V_{CC} = 5.25V$
$V_{IL}$	Logical Zero Input Voltage	-	0.8	V	$V_{CC} = 4.75V$
$V_{IHC}$	High Level Clock Input	3.0	-	V	$V_{CC} = 5.25V$
$V_{ILC}$	Low Level Clock Input	-	0.8	V	$V_{CC} = 4.75V$
$V_{OH}$	Output HIGH Voltage	2.6	-	V	$I_{OH} = -400\mu A$ , $V_{CC} = 4.75V$
$V_{OL}$	Output LOW Voltage	-	0.4	V	$I_{OL} = +2.0mA$ , $V_{CC} = 4.75V$
$I_I$	Input Leakage Current	-10	10	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$
$I_O$	I/O Leakage Current	-10	10	$\mu A$	$V_{OUT} = V_{CC}$ or GND, $V_{CC} = 5.25V$
$I_{CCSB}$	Standby Power Supply Current	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Note 3
$I_{CCOP}$	Operating Power Supply Current	-	150	mA	$f = 15MHz$ , $V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Notes 1 and 3

## Capacitance ( $T_A = +25^\circ C$ , Note 2)

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
$C_{IN}$	Input Capacitance	-	15	pF	FREQ = 1MHz, $V_{CC}$ = Open, All measurements are referenced to device ground
$C_O$	Output Capacitance	-	15	pF	

### NOTES:

- Power supply current is proportional to operating frequency. Typical rating for  $I_{CCOP}$  is 10mA/MHz.
- Not tested, but characterized at initial design and at major process/design changes.
- Output load per test load circuit with switch open and  $C_L = 40pF$ .

# Specifications HSP45116

## A.C. Electrical Specifications $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to $+70^\circ C$ (Note 1)

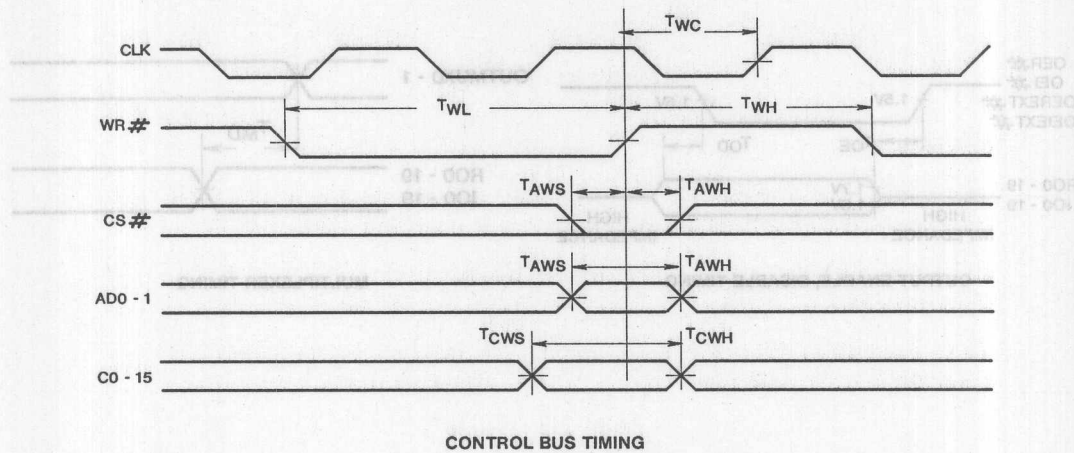
SYMBOL	PARAMETER	-15 (15MHz)		-25 (25.6MHz)		-33 (33MHz)		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX	MIN	MAX		
$T_{CP}$	CLK Period	66		39		30		ns	
$T_{CH}$	CLK High	26		15		12		ns	
$T_{CL}$	CLK Low	26		15		12		ns	
$T_{WL}$	WR# Low	26		15		12		ns	
$T_{WH}$	WR# High	26		15		12		ns	
$T_{AWS}$	Set-up Time; AD0-1, CS# to WR# Going High	18		13		13		ns	
$T_{AWH}$	Hold Time; AD0, AD1, CS# from WR# Going High	0		0		0		ns	
$T_{CWS}$	Set-up Time C0-15 from WR# Going High	20		15		15		ns	
$T_{CWH}$	Hold Time C0-15 from WR# Going High	0		0		0		ns	
$T_{WC}$	Set-up time WR# High to CLK High	20		16		12		ns	Note 3
$T_{MCS}$	Set-up Time MOD0-1 to CLK Going High	20		15		15		ns	
$T_{MCH}$	Hold Time MOD0-1 from CLK Going High	0		0		0		ns	
$T_{PCS}$	Set-up Time PACI# to CLK Going High	25		15		11		ns	
$T_{PCH}$	Hold Time PACI# from CLK Going High	0		0		0		ns	
$T_{ECS}$	Set-up ENPHREG#, ENCFREG#, ENOFREG#, ENPHAC#, ENTIREG#, CLROFR#, PMSEL, LOAD#, ENI#, ACC, BINFMT#, PEAK#, MODPI/2PI#, SH0-1, RBYTILD# from CLK Going High	18		12		12		ns	
$T_{ECH}$	Hold Time ENPHREG#, ENCFREG#, ENOFREG#, ENPHAC#, ENTIREG#, CLROFR#, PMSEL, LOAD#, ENI#, ACC, BINFMT#, PEAK#, MODPI/2PI#, SH0-1, RBYTILD# from CLK Going High	0		0		0		ns	
$T_{DS}$	Set-up Time RINO-18, IMINO-18 to CLK Going High	18		12		12		ns	
$T_{DH}$	Hold Time RINO-18, IMINO-18 from CLK Going High	0		0		0		ns	
$T_{DO}$	CLK to Output Delay RO0-19, IO0-19		40		24		19	ns	
$T_{DEO}$	CLK to Output Delay DET0-1		40		27		20	ns	
$T_{PO}$	CLK to Output Delay PACO#		30		20		12	ns	
$T_{TO}$	CLK to Output Delay TICO#		30		20		12	ns	
$T_{OE}$	Output Enable Time OER#, OEI#, OEREXT#, OEIEXT#		25		20		20	ns	
$T_{MD}$	OUTMUX0-1 to Output Delay		40		28		26	ns	
$T_{OD}$	Output Disable Time		20		15		15	ns	Note 2
$T_{RF}$	Output Rise, Fall Time		8		8		6	ns	Note 2

### NOTES:

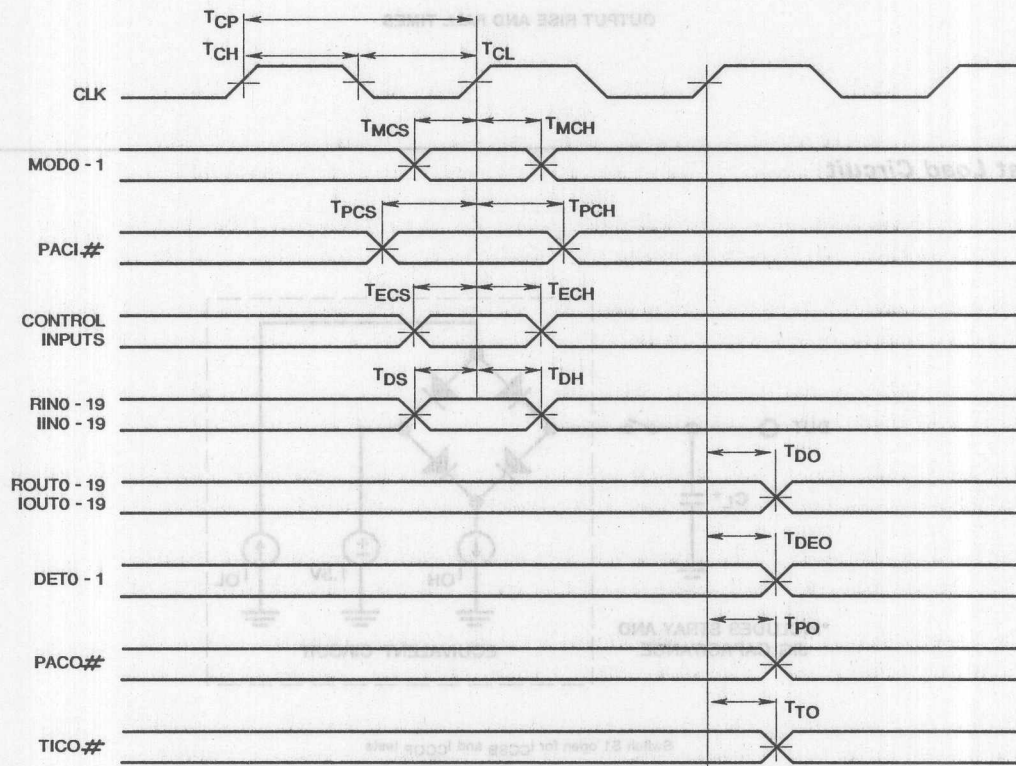
- A.C. testing is performed as follows: Input levels (CLK Input) 4.0V and 0V; Input levels (all other inputs) 0V and 3.0V; Timing reference levels (CLK) 2.0V; All others 1.5V. Output load per test load circuit with switch closed and  $C_L = 40pF$ . Output transition is measured at  $V_{OH} \geq 1.5V$  and  $V_{OL} \leq 1.5V$ .
- Controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.
- Applicable only when outputs are being monitored and ENCFREG#, ENPHREG#, or ENTIREG# is active.

## Waveforms

(Continued)



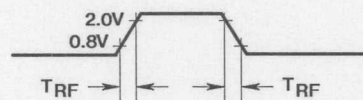
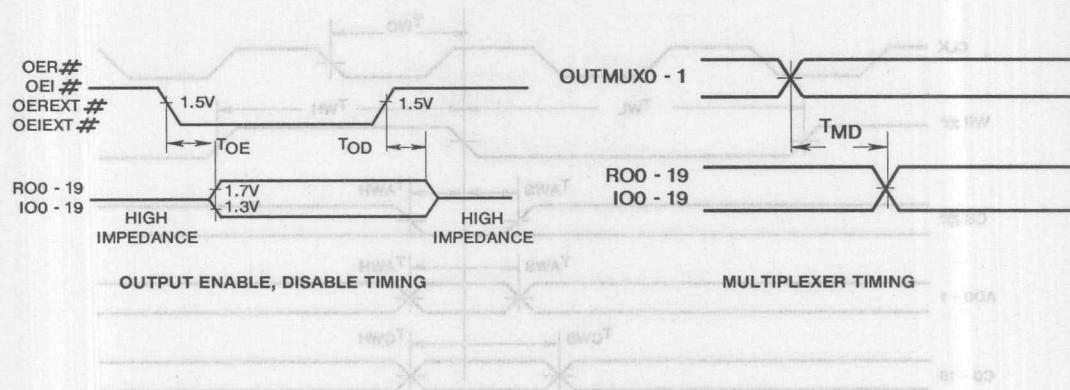
CONTROL BUS TIMING



INPUT AND OUTPUT TIMING

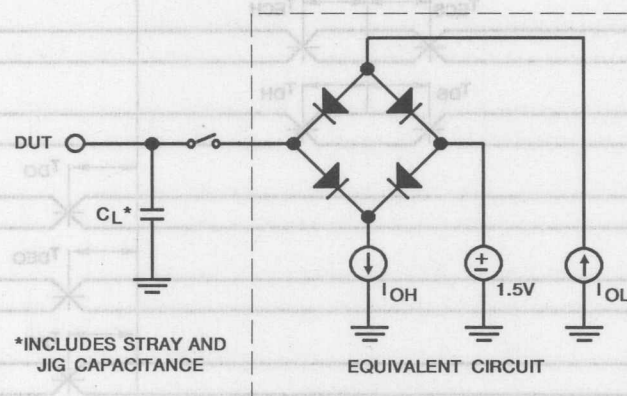


## Waveforms (Continued)



OUTPUT RISE AND FALL TIMES

## Test Load Circuit



\*INCLUDES STRAY AND JIG CAPACITANCE

EQUIVALENT CIRCUIT

Switch S1 open for  $I_{CCSB}$  and  $I_{CCOP}$  tests

EQUIVALENT CIRCUIT

**HARRIS**

# HSP45116/883

## Numerically Controlled Oscillator/Modulator

August 1992

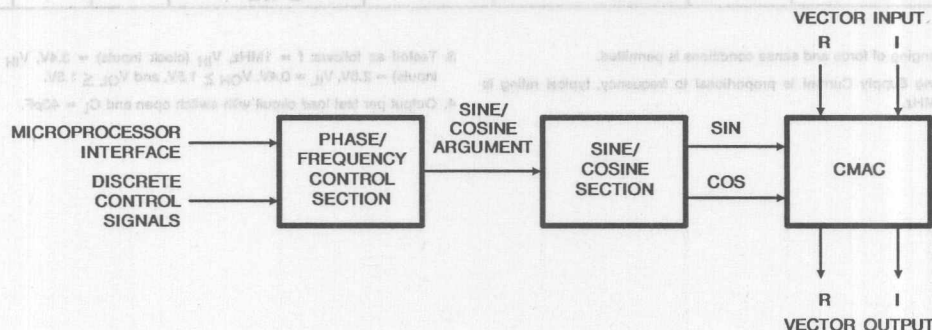
### Features

- This Circuit is Processed in Accordance to Mil-Std-883 and is Fully Conformant Under the Provisions of Paragraph 1.2.1
- NCO and CMAC on One Chip
- 15MHz and 25.6MHz Versions
- 32-bit Frequency Control
- 16-bit Phase Modulation
- 16-bit CMAC
- 0.006Hz Tuning Resolution at 25.6MHz
- Spurious Frequency Components < -90dBc
- Fully Static CMOS
- 145 Pin PGA

### Applications

- Frequency Synthesis
- Modulation - AM, FM, PSK, FSK, QAM
- Demodulation, PLL
- Phase Shifter
- Fast Fourier Transforms (FFT)
- Polar to Cartesian Conversions

### Block Diagram



### Description

The Harris HSP45116/883 combines a high performance quadrature numerically controlled oscillator (NCO) and a high speed 16-bit Complex Multiplier/Accumulator (CMAC) on a single IC. This combination of functions allows a complex vector to be multiplied by the internally generated (cos, sin) vector for quadrature modulation and demodulation. As shown in the block diagram, the HSP45116/883 is divided into three main sections. The Phase/Frequency Control Section (PFCS) and the Sine/Cosine Section together form a complex NCO. The CMAC multiplies the output of the Sine/Cosine Section with an external complex vector.

The inputs to the Phase/Frequency Control Section consist of a microprocessor interface and individual control lines. The phase resolution of the PFCS is 32 bits, which results in frequency resolution better than 0.006Hz at 25.6MHz. The output of the PFCS is the argument of the sine and cosine. The spurious free dynamic range of the complex sinusoid is greater than 90dBc.

The output vector from the Sine/Cosine Section is one of the inputs to the Complex Multiplier/Accumulator. The CMAC multiplies this (cos, sin) vector by an external complex vector and can accumulate the result. The resulting complex vectors are available through two 20-bit output ports which maintain the 90dB spectral purity. This result can be accumulated internally to implement an accumulate and dump filter.

A quadrature down converter can be implemented by loading a center frequency into the Phase/Frequency Control Section. The signal to be downconverted is the Vector Input of the CMAC, which multiplies the data by the rotating vector from the Sine/Cosine Section. The resulting complex output is the down converted signal.

5  
SIGNAL  
SYNTHESIZERS

# Specifications HSP45116/883

## Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input or Output Voltage Applied .....	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range .....	-65°C to +150°C
Junction Temperature .....	+175°C
Lead Temperature (Soldering 10 sec) .....	300°C
ESD Classification .....	Class 1

## Reliability Information

Thermal Resistance	$\theta_{ja}$	$\theta_{jc}$
Ceramic PGA Package .....	23.1°C/W	8.3°C/W
Maximum Package Power Dissipation at +125°C		
Ceramic PGA Package .....	2.16 Watt	
Device Count .....	103,000 Transistors	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range .....	+4.5V to +5.5V
Operating Temperature Range .....	-55°C to +125°C

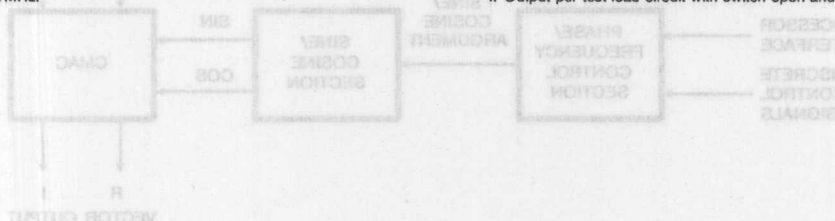
TABLE 1. HSP45116/883 D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Logical One Input Voltage Clock	$V_{IHC}$	$V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	3.0	-	V
Logical Zero Input Voltage Clock	$V_{ILC}$	$V_{CC} = 4.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +2.0mA$ $V_{CC} = 4.5V$ (Note 1)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output or I/O Leakage Current	$I_O$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.5V$	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.5V$ , (Note 4)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 15MHz$ , $V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ (Notes 2, 4)	1, 2, 3	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	150	mA
Functional Test	FT	(Note 3)	7, 8	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$	-	-	

## NOTES:

- Interchanging of force and sense conditions is permitted.
- Operating Supply Current is proportional to frequency, typical rating is 10mA/MHz.
- Tested as follows:  $f = 1MHz$ ,  $V_{IH}$  (clock inputs) = 3.4V,  $V_{IH}$  (all other inputs) = 2.6V,  $V_{IL} = 0.4V$ ,  $V_{OH} \geq 1.5V$ , and  $V_{OL} \leq 1.5V$ .
- Output per test load circuit with switch open and  $C_L = 40pF$ .



CAUTION: These devices are sensitive to electrostatic discharge. Proper IC handling procedures should be followed.

# Specifications HSP45116/883

TABLE 2. HSP45116/883 ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	(NOTE 1) CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	-15 (15MHz)		-25 (25.6MHz)		UNITS
					MIN	MAX	MIN	MAX	
CLK Period	TCP		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	66	-	39	-	ns
CLK High	TCH		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	26	-	15	-	ns
CLK Low	TCL		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	26	-	15	-	ns
WR# Low	TWL		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	26	-	15	-	ns
WR# High	TWH		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	26	-	15	-	ns
Set-up Time; ADO-1, CS# to WR# Going High	TAWS		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	20	-	18	-	ns
Hold Time; ADO, AD1, CS# from WR# Going High	TAWH		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	0	-	0	-	ns
Set-up Time C0-15 from WR# Going High	TCWS		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	20	-	18	-	ns
Hold Time C0-15 from WR# Going High	TCWH		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	0	-	0	-	ns
Set-up Time WR# to CLK High	TWC	(Note 2)	9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	20	-	16	-	ns
Set-up Time MOD0-1 to CLK Going High	TMCS		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	20	-	18	-	ns
Hold Time MOD0-1 from CLK Going High	TMCH		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	0	-	0	-	ns
Set-up Time PACI# to CLK Going High	TPCS		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	25	-	18	-	ns
Hold Time PACI# from CLK Going High	TPCH		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	0	-	0	-	ns
Set-up Time ENPHREG# ENCFRCTL#, ENPHAC#, ENTICTL# CLROFR#, PMSEL#, LOAD#, ENI#, ACC, BINFMT#, PEAK#, MODPI/2PI#, SH0-1, RBYTILD# from CLK Going High	TECS		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	20	-	15	-	ns
Hold Time ENPHREG# ENCFRCTL#, ENPHAC#, ENTICTL# CLROFR#, PMSEL#, LOAD#, ENI#, ACC, BINFMT#, PEAK#, MODPI/2PI#, SH0-1, RBYTILD# from CLK Going High	TECH		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	0	-	0	-	ns
Set-up Time RINO-18, IMINO-18 to CLK Going High	TDS		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	20	-	15	-	ns
Hold Time RINO-18, IMINO-18, to CLK Going High	TDH		9, 10, 11	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	0	-	0	-	ns



# Specifications HSP45116/883

TABLE 2. HSP45116/883 ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	(NOTE 1) CONDITIONS	GROUP A SUBGROUPS	TEMPERATURE	-15		-25		UNITS
					MIN	MAX	MIN	MAX	
CLK to Output Delay ROO-19, IOO-19	T <sub>DO</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	40	-	25	ns
CLK to Output Delay DET0-1	T <sub>DEO</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	40	-	27	ns
CLK to Output Delay PACO#	T <sub>PO</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	30	-	20	ns
CLK to Output Delay TICO#	T <sub>TO</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	30	-	20	ns
Output Enable Time OER#, OEI#, OEREXT#, OEIEXT#	T <sub>OE</sub>	(Note 3)	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	25	-	20	ns
OUTMUX0-1 to Output Delay	T <sub>MD</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	40	-	28	ns

NOTES:

1. A.C. testing is performed as follows: V<sub>CC</sub> = 4.5V and 5.5V. Input levels (CLK Input) 4.0V and 0V; Input levels (all other inputs) 3.0V and 0V; Timing reference levels (CLK) 2.0V; All others 1.5V. Output load per test load circuit with switch closed and C<sub>L</sub> = 40pF. Output transition is measured at V<sub>OH</sub> ≥ 1.5V and V<sub>OL</sub> ≤ 1.5V.
2. Applicable only when outputs are being monitored and ENCFREG#, ENPHREG#, or ENTIREG# is active.
3. Transition is measured at ±200mV from steady state voltage, Output loading per test load circuit, with switch closed and C<sub>L</sub> = 40pF.

TABLE 3. HSP45116/883 ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETER	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	-15		-25		UNITS
					MIN	MAX	MIN	MAX	
Input Capacitance	C <sub>IN</sub>	VCC = Open, f = 1MHz	1	T <sub>A</sub> = +25°C	-	15	-	15	pF
Output Capacitance	C <sub>OUT</sub>	All measurements are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	15	-	15	pF
Output Disable Time	T <sub>OD</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	20	-	15	ns
Output Rise Time	T <sub>R</sub>	From 0.8V to 2.0V	1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	8	-	8	ns
Output Fall Time	T <sub>F</sub>	From 2.0V to 0.8V	1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	8	-	8	ns

NOTES:

1. The parameters in Table 3 are controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.
2. Loading is as specified in the test load circuit with C<sub>L</sub> = 40pF.

TABLE 4. APPLICABLE SUBGROUPS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9



PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
D3	IMIN(0)	F4	Q3	ENPHAC#	F1	K14	RO(2)	V <sub>CC</sub> /2	A10	IO(18)	V <sub>CC</sub> /2
C2	RIN(18)	F9	P5	ENTIREG#	F4	L15	RO(3)	V <sub>CC</sub> /2	B8	IO(19)	V <sub>CC</sub> /2
D2	RIN(17)	F8	Q4	ENI#	F1	J14	RO(4)	V <sub>CC</sub> /2	C8	IMIN(18)	F9
E3	RIN(16)	F7	N6	MODPI/2PI#	F16	J13	RO(5)	V <sub>CC</sub> /2	C7	IMIN(17)	F8
C1	RIN(15)	F6	P6	CS#	F2	K15	RO(6)	V <sub>CC</sub> /2	A7	IMIN(16)	F7
E2	RIN(14)	F5	Q5	CLK	F0	H14	RO(7)	V <sub>CC</sub> /2	A6	IMIN(15)	F6
D1	RIN(13)	F4	P7	AD(1)	F4	H13	RO(8)	V <sub>CC</sub> /2	B7	IMIN(14)	F5
F3	RIN(12)	F16	N7	AD(0)	F3	G13	RO(9)	V <sub>CC</sub> /2	B6	IMIN(13)	F4
F2	RIN(11)	F15	Q6	WR#	F1	G15	RO(10)	V <sub>CC</sub> /2	C6	IMIN(12)	F16
E1	RIN(10)	F14	P8	C(15)	GND	F15	RO(11)	V <sub>CC</sub> /2	A5	IMIN(11)	F15
G2	RIN(9)	F13	N8	C(14)	GND	G14	RO(12)	V <sub>CC</sub> /2	B5	IMIN(10)	F14
G3	RIN(8)	F12	N9	C(13)	GND	F14	RO(13)	V <sub>CC</sub> /2	A4	IMIN(9)	F13
F1	RIN(7)	F11	Q9	C(12)	GND	F13	RO(14)	V <sub>CC</sub> /2	A3	IMIN(8)	F12
H2	RIN(6)	F10	Q10	C(11)	GND	E15	RO(15)	V <sub>CC</sub> /2	B4	IMIN(7)	F11
H3	RIN(5)	F9	P9	C(10)	GND	E14	RO(16)	V <sub>CC</sub> /2	C5	IMIN(6)	F10
J3	RIN(4)	F8	P10	C(9)	GND	D15	RO(17)	V <sub>CC</sub> /2	B3	IMIN(5)	F9
J1	RIN(3)	F7	N10	C(8)	GND	C15	RO(18)	V <sub>CC</sub> /2	A2	IMIN(4)	F8
K1	RIN(2)	F6	Q11	C(7)	GND	D14	RO(19)	V <sub>CC</sub> /2	C4	IMIN(3)	F7
J2	RIN(1)	F5	P11	C(6)	GND	E13	IO(0)	V <sub>CC</sub> /2	C3	IMIN(2)	F6
K2	RIN(0)	F4	Q12	C(5)	GND	C14	IO(1)	V <sub>CC</sub> /2	B2	IMIN(1)	F5
K3	SH(1)	F3	Q13	C(4)	GND	B15	IO(2)	V <sub>CC</sub> /2	A1	V <sub>CC</sub>	None
L1	SH(0)	F2	P12	C(3)	GND	D13	IO(3)	V <sub>CC</sub> /2	A9	V <sub>CC</sub>	V <sub>CC</sub>
L2	ACC	F4	N11	C(2)	GND	C13	IO(4)	V <sub>CC</sub> /2	A15	V <sub>CC</sub>	None
M1	ENPHREG#	F16	P13	C(1)	GND	B14	IO(5)	V <sub>CC</sub> /2	G1	V <sub>CC</sub>	V <sub>CC</sub>
N1	ENOFREG#	F4	Q14	C(0)	V <sub>CC</sub>	C12	IO(6)	V <sub>CC</sub> /2	J15	V <sub>CC</sub>	V <sub>CC</sub>
M2	PEAK#	F8	N12	OUTMUX(1)	F11	B13	IO(7)	V <sub>CC</sub> /2	Q1	V <sub>CC</sub>	None
L3	RBYTILD#	F16	N13	OUTMUX(0)	F10	B12	IO(8)	V <sub>CC</sub> /2	Q7	V <sub>CC</sub>	V <sub>CC</sub>
N2	BINFMT#	F4	P14	OER#	F0	C11	IO(9)	V <sub>CC</sub> /2	Q15	V <sub>CC</sub>	None
P1	TICO#	V <sub>CC</sub> /2	M13	OEREXT#	F0	A13	IO(10)	V <sub>CC</sub> /2	A8	GND	GND
M3	MOD(1)	GND	N14	OIEEXT#	F0	B11	IO(11)	V <sub>CC</sub> /2	A14	GND	None
N3	MOD(0)	GND	M14	OEI#	F0	A12	IO(12)	V <sub>CC</sub> /2	B1	GND	None
P2	PACI#	F4	L13	PACO#	V <sub>CC</sub> /2	C10	IO(13)	V <sub>CC</sub> /2	H1	GND	GND
N4	LOAD#	F15	N15	DET0	V <sub>CC</sub> /2	B10	IO(14)	V <sub>CC</sub> /2	H15	GND	GND
P3	PMSEL	F1	L14	DET1	V <sub>CC</sub> /2	A11	IO(15)	V <sub>CC</sub> /2	P15	GND	None
P4	CLROFR#	F4	M15	RO(0)	V <sub>CC</sub> /2	B9	IO(16)	V <sub>CC</sub> /2	Q2	GND	None
N5	ENCFREG#	F4	K13	RO(1)	V <sub>CC</sub> /2	C9	IO(17)	V <sub>CC</sub> /2	Q8	GND	GND

NOTES:

1. 47K $\Omega$  ( $\pm 20\%$ ) resistor connected to all pins except V<sub>CC</sub> and GND
2. V<sub>CC</sub> = 5.5V  $\pm$  0.5V with 0.1 $\mu$ F (min) capacitor between V<sub>CC</sub> and GND per position
3. F0 = 100kHz  $\pm$  10%, F1 = F0/2, F2 = F1/2 . . . . ., F11 = F10/2, 40% to 60% duty cycle
4. Input Voltage limits: V<sub>IL</sub> = 0.8V max, V<sub>IH</sub> = 4.5V  $\pm$  10%

**Die Characteristics****DIE DIMENSIONS:**

350 x 353 x 19 ±1 mils

**METALLIZATION:**

Type: Si-Al or Si-Al-Cu

Thickness: 8kÅ

**GLASSIVATION:**

Type: Nitrox

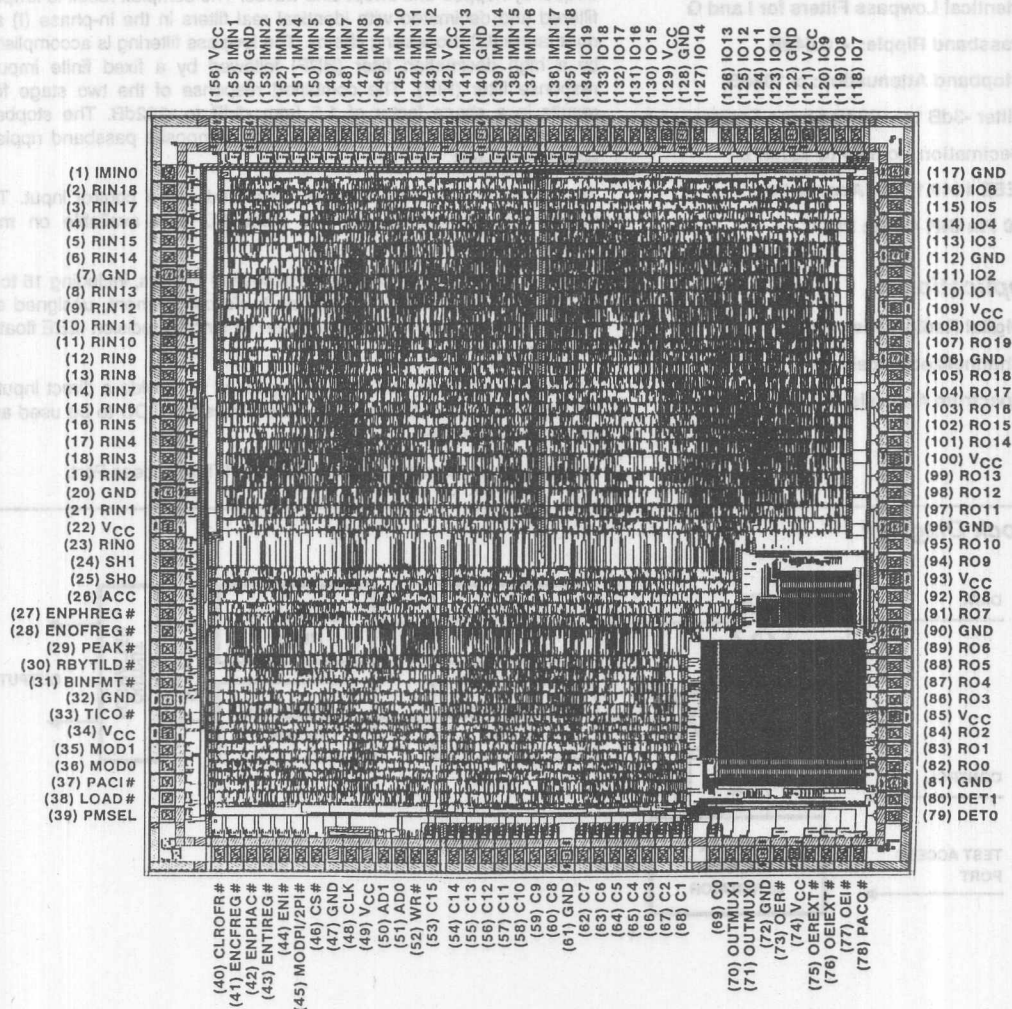
Thickness: 10kÅ

**DIE ATTACH:**

Material: Silver Glass

**WORST CASE CURRENT DENSITY:**  $1.6 \times 10^5 \text{A/cm}^2$ **Metallization Mask Layout**

HSP45116/883





## ADVANCE INFORMATION

August 1992

## Digital Down Converter

### Features

- 75MSPS Input Data Rate
- 16 Bit Data Input
- Spurious Free Dynamic Range: > 102dB
- Frequency Selectivity: < 0.009Hz
- Identical Lowpass Filters for I and Q
- Passband Ripple: < 0.04dB
- Stopband Attenuation: > 106dB
- Filter -3dB to -102dB Shape Factor: < 1.5
- Decimation from 64 to 131,072
- IEEE 1149.1 Test Access Port
- 40 Pin DIP, 44 Pin PLCC

### Applications

- Digital Radio Receivers
- Channelized Receivers
- Spectrum Analysis

### Description

The Digital Down Converter (DDC) is a single chip synthesizer, quadrature mixer and low pass filter. It takes a 16 bit input data stream at a 75MSPS data rate, downconverts it, performs narrowband low pass filtering and decimation to produce a baseband signal.

The internal synthesizer can tune in on a variety of signal, including CW, frequency hopped and swept sine waves. The complex result is lowpass filtered and decimated with identical real filters in the in-phase (I) and quadrature (Q) processing chains. The lowpass filtering is accomplished by a high decimation filter (HDF) followed by a fixed finite impulse response filter (FIR). The combined response of the two stage filter results in a shape factor of 1.5 from -3dB to -102dB. The stopband attenuation is greater than 106 dB. The composite passband ripple is less than 0.04dB.

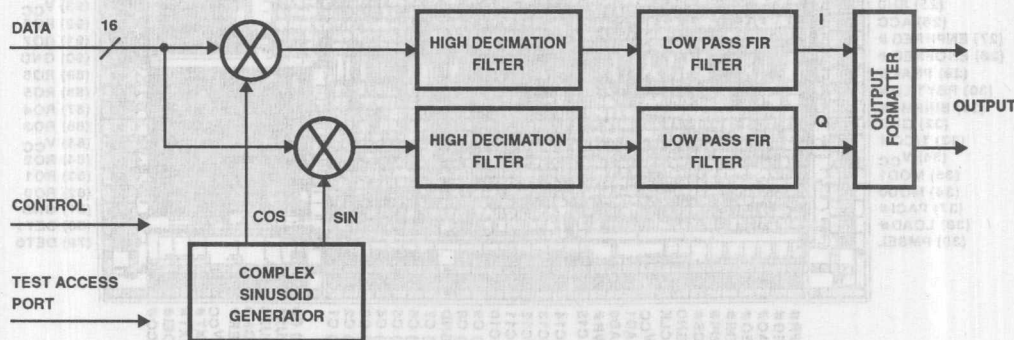
The chip receives forty bit serial commands as a control input. This interface is compatible with the serial I/O port available on most microprocessors.

The output data can be configured in several formats, including 16 to 38 bit fixed point, which is available as two's complement, unsigned and sign magnitude. There is also an option for single precision IEEE floating point format.

The phase generator can also be bypassed to provide a direct input to the high decimation filter section. This allows the DDC to be used as a high decimation filter.

In circuit test is provided by an IEEE 1149.1 Test Access Port.

### Block Diagram



## SPECIAL FUNCTION

DATA SHEETS		PAGE
HSP45240	Address Sequencer .....	6-3
HSP45240/883	Address Sequencer .....	6-15
HSP45256	Binary Correlator .....	6-21
HSP45256/883	Binary Correlator .....	6-34
HSP48410	Histogrammer/Accumulating Buffer .....	6-42
HSP9501	Programmable Data Buffer .....	6-53
HSP9520/9521 ISP9520/9521	Multilevel Pipeline Register .....	6-60

# DSP

# 6

## SPECIAL FUNCTION

PAGE

8-2	Address Sequencer .....
8-15	Address Sequencer .....
8-21	Binary Correlator .....
8-24	Binary Correlator .....
8-42	Histogrammer/Accumulating Buffer .....
8-53	Programmable Data Buffer .....
8-60	Multilevel Pipeline Register .....

### DATA SHEETS

HSP43240
HSP43240/883
HSP43256
HSP43256/883
HSP43410
HSP43601
HSP43601/883
HSP43601/883

JACOBS  
NOTCHUP

August 1992

## Address Sequencer

### Features

- Block Oriented 24-Bit Sequencer
- Configurable as Two Independent 12-Bit Sequencers
- 24 x 24 Crosspoint Switch
- Programmable Delay on 12 Outputs
- Multi-Chip Synchronization Signals
- Standard  $\mu$ P Interface
- TTL Compatible Inputs/Outputs
- 100pF Drive on Outputs
- DC to 50MHz Clock Rate
- Available in 68 Pin PGA and PLCC Packages

### Applications

- 1-D, 2-D Filtering
- Pan/Zoom Addressing
- FFT Processing
- Matrix Math Operations

### Description

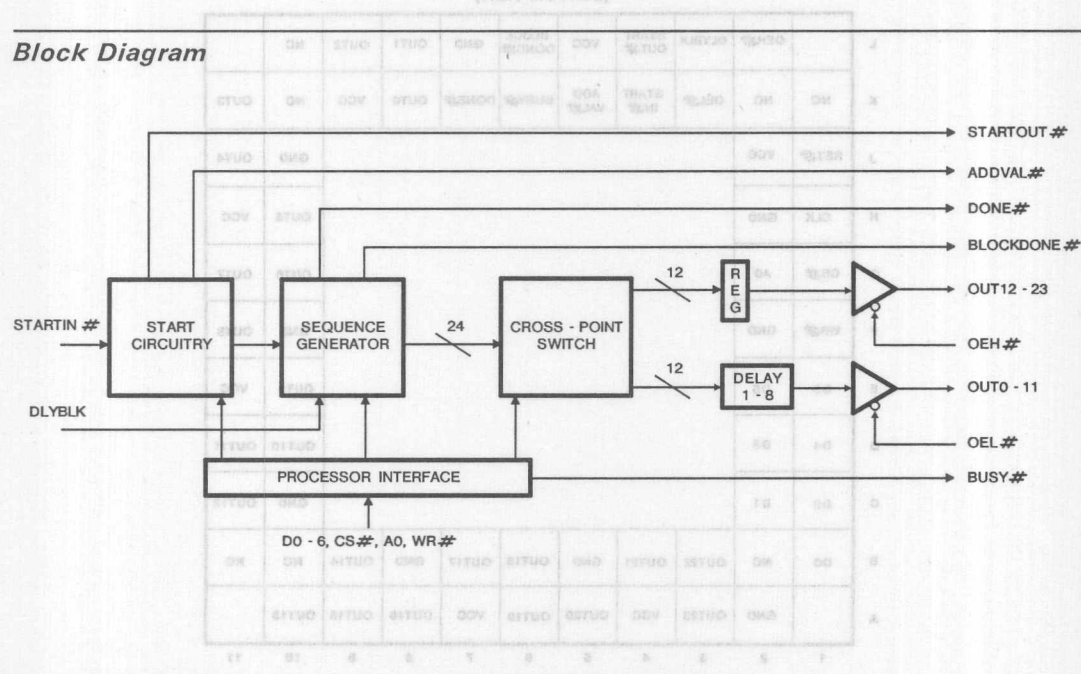
The Harris HSP45240 is a high speed Address Sequencer which provides specialized addressing for functions like FFT's, 1-D and 2-D filtering, matrix operations, and image manipulation. The sequencer supports block oriented addressing of large data sets up to 24 bits at clock speeds up to 50MHz.

Specialized addressing requirements are met by using the onboard 24 x 24 crosspoint switch. This feature allows the mapping of the 24 address bits at the output of the address generator to the 24 address outputs of the chip. As a result, bit reverse addressing, such as that used in FFT's, is made possible.

A single chip solution to read/write addressing is also made possible by configuring the HSP45240 as two 12-bit sequencers. To compensate for system pipeline delay, a programmable delay is provided on 12 of the address outputs.

The HSP45240 is manufactured using an advanced CMOS process, and is a low power fully static design. The configuration of the device is controlled through a standard microprocessor interface and all inputs/outputs, with the exception of clock, are TTL compatible. The Sequencer is available in 68 pin PGA and PLCC packages.

### Block Diagram



CAUTION: Electronic devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
Copyright © Harris Corporation 1992

File Number **2489.2**

**SPECIAL  
FUNCTION**

**6**





## Pin Descriptions

NAME	TYPE	PLCC PIN NUMBER	DESCRIPTION
VCC	I	6,24,34,41 49,55,68	+5V power supply pin.
GND	I	3,9,18,22 38,46,52 58,65	GROUND
RST#	I	25	RESET: This active low input causes a chip reset which lasts for 26 clocks after RST# has been de-asserted. The reset initializes the Crosspoint Switch and some of the configuration registers as described in the Processor Interface section. The chip must be clocked for reset to complete.
CLK	I	23	CLOCK: The "CLK" signal is a CMOS input which provides the basic timing for address generation.
WR#	I	19	WRITE: The rising edge of this input latches the data/address on D0-6 to be latched into the Processor Interface.
CS#	I	21	CHIP SELECT: This active "low" input enables the configuration data/address on D0-6 to be latched into the Processor Interface.
A0	I	20	ADDRESS 0: This input defines D0-6 as a configuration register address if "high", and configuration data if "low", (see Processor Interface text).
D0-6	I	11-17	DATA BUS: Data bus for Processor Interface.
OE#	I	28	OUTPUT ENABLE HIGH: This asynchronous input is used to enable the output buffers for OUT12-23.
OEL#	I	29	OUTPUT ENABLE LOW: This asynchronous input is used to enable the output buffers for OUT0-11.
STARTIN#	I	31	START-IN: This active low input initiates an addressing sequence. May be tied to STARTOUT# of another HSP45240 for multi-chip synchronization. STARTIN# should only be asserted for one CLK because address sequencing begins after STARTIN# is de-asserted.
DLYBLK	I	30	DELAY BLOCK: This active "high" input may be used to halt address generation on address block boundaries (see Sequence Generator text). The required timing relationship of this signal to the end of an address block is shown in Application Note 9205.
OUT0-23	O	39,40,42,45, 47,48,50,51, 53,54,56,57, 59,62-64,66, 67,1,2,4,5, 7,8	OUTPUT BUS: TTL compatible 24-bit Address Sequencer output.
BLOCKDONE#	O	36	BLOCK DONE: This active low output signals when the last address in an address block is on OUT0-23.
DONE#	O	37	DONE: This active low output signals when the last address of an address sequence is on OUT0-23.
ADDVAL#	O	33	ADDRESS VALID: This active low output signals when the first address of an address sequence is on OUT0-23.
STARTOUT#	O	32	START-OUT: This active low output is generated when an address sequence is initiated by a mechanism other than STARTIN#. May be tied to the STARTIN# of other HSP45240's for multichip synchronization.
BUSY#	O	35	BUSY: This active low output is asserted one CLK after RST# is de-asserted and will remain asserted for 25 CLK's. While BUSY# is asserted all writes to the Processor Interface are disabled.

# Denotes active low.

6

SPECIAL  
FUNCTION

## Functional Description

The Address Sequencer is a 24-bit programmable address generator. As shown in the Block Diagram, the sequencer consists of 4 functional blocks: the start circuitry, the sequence generator, the crosspoint switch, and the processor interface. The addresses produced by the sequence generator are input into the crosspoint switch. The crosspoint switch maps 24 bits of address input to a 24 bit output. This allows for addressing schemes like "bit-reverse" addressing for FFT's. A programmable delay block is provided to allow the MSW of the output to be skewed from the LSW. This feature may be used to compensate for processor pipeline delay when the sequence generator is configured as two independent 12 bit sequencers. Address Sequencer operation is controlled by values loaded into configuration registers associated with the sequence generator, crosspoint switch, and start circuitry. The configuration registers are loaded through the processor interface.

### Start Circuitry

The Start Circuitry generates the internal START signal which causes the Sequence Generator to initiate an addressing sequence. The START signal is produced by writing the Processor Interface's "Sequencer Start" address (see Processor Interface text), by asserting the STARTIN# input, or by the terminal address of a sequence generated under "One-Shot Mode with Restart" (see Sequence Generator section). Care should be taken to assert STARTIN# for only one clock cycle to insure proper operation. A programmable delay from 1 to 31 clocks is provided to delay the initiation of an addressing sequence by delaying the internal START signal (see Processor Interface text).

The Start Circuitry generates the output signal ADDVAL# which is asserted when the first valid output address is at the pads. In addition, the Start Circuitry generates the "STARTOUT#" signal for multichip synchronization. Note: STARTOUT# is only generated when an addressing sequence is started by writing the "Sequencer Start" address of the Processor Interface, or an internal START is generated by reaching the end of an addressing sequence produced by "One-Shot Mode with Restart".

### Sequence Generator

The Sequence Generator is a block oriented address generator. This means that the desired address sequence is subdivided into one or more address blocks each containing a user defined number of addresses. User supplied configuration data determines the number of address blocks and the characteristics of the address sequence to be generated.

As shown in Figure 1, the Sequence Generator is subdivided into the an address generation and control section. The address generation section performs an accumulation based on the output of MUX1 and MUX2. The control section governs the operation of the multiplexers, enables loading of the Block Start Address register, and signals completion of an address sequence.

An address sequence is started when the control section of the Sequence Generator receives the internal START signal from the Start Circuitry. When the START signal is received, the control section multiplexes the contents of the Start

Address Register and a "0" to the adder. The result of this summation is the first address in the first block of the address sequence. This value is stored in the Block Start Address register by an enable generated from the control section, and the multiplexers are switched to feed the output of the Holding and Address Increment registers to the adder. Address generation will continue with the Address Increment added to the contents of the Holding Register until the first address block has been completed.

An address block is completed when the number of addresses generated since the beginning of the address block equals the value stored in the Block Size register. When the last address of the block is generated, BLOCKDONE# is asserted to signal the end of the address block (see Application Note 9205). On the following CLK, the multiplexers are configured to pass the contents of the Block Start Address and Block Increment registers to the adder which generates the first address of the next address block. An enable from the control section allows this value to update the Block Start Address register, and the multiplexers are switched to feed the Holding and Address Increment registers to the adder for generation of the remaining addresses in the block.

The address sequence is completed when the number of address blocks generated equals the value loaded into the Number of Blocks register. When the final address in the last address block has been generated, DONE# and BLOCKDONE# are asserted to signal the completion of the address sequence.

The parameters governing address generation are loaded into five 24-bit configuration registers via the Processor Interface. These parameters include the Start Address, the beginning address of the sequence; the Block Size, the number of addresses in the address block; the Address Increment, the increment between addresses in a block; the Number of Blocks, the number of address blocks in a sequence (minimum 1); the Block Increment, the increment between starting addresses of each block. The loading and structure of these registers is detailed in the Processor Interface text.

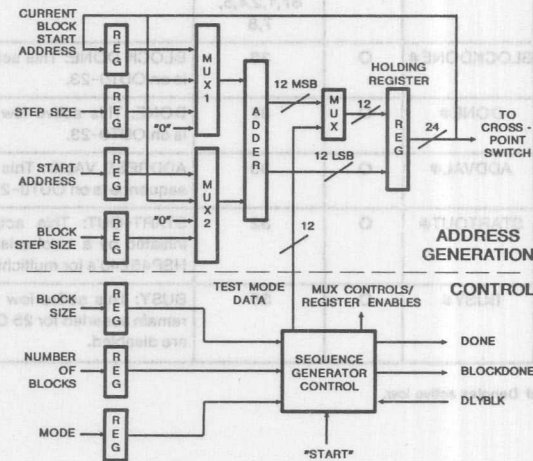


FIGURE 1. SEQUENCE GENERATOR BLOCK

Three modes of operation may be selected by loading the 6-bit Mode Control register (see Processor Interface). The three modes of operation are:

1. One-Shot Mode without Restart: Address generation halts after completion of the user specified address sequence. Address generation will not resume until the internal START signal is generated by the Start Circuitry. When the final address in the final block of the address sequence is generated, both DONE# and BLOCKDONE# are asserted and the last address is held on OUT0-23 (See Application Note 9205).
2. One-Shot Mode with Restart: This mode is identical to One-Shot Mode without Restart with the exception that the Start Circuitry automatically generates an internal START at the end of the user specified sequence to restart address generation. The end of the address sequence is signaled by the assertion of DONE#, BLOCKDONE#, and STARTOUT# as shown in Application Note 9205. In this mode, the first address of the next sequence immediately follows the last address of the current sequence if start delay is disabled.
3. Continuous Mode: Address generation never terminates. Address generation proceeds based on the Start Address, Address Increment, Block Size, and Block Increment Parameters. The Number of Blocks parameter is ignored, and the DONE# signal is never asserted.

The Mode Control register is also used to configure the Sequence Generator for operation as two independent 12-bit address sequencers. In dual sequencer mode, the adder in the sequence generator suppresses the carry from the 12 LSB's to the 12 MSB's. With the carry suppressed, two independent sequences may be produced. These 12-bit address sequences may be delayed relative to each other by programming the Mode Control register for a delay up to 7 clocks. This feature is useful to compensate for pipeline delay when using dual sequencer mode to generate read/write addressing.

The DLYBLK input can be used to halt address generation at the end of any address block within a sequence. In addition, DLYBLK can be used to delay an address sequence from restarting if asserted at the end of the final address block generated under "One-Shot Mode with Restart". See Application Note 9205 for the timing relationship of DLYBLK to the end of the address block required to halt address sequencing.

### Crosspoint Switch

The crosspoint switch is responsible for reordering the address bits output by the sequence generator. The switch allows any of its 24 inputs to be independently connected to any of its 24 outputs. The crosspoint switch outputs can be driven by only one input, however, one input can drive any number of switch outputs. If none of the inputs are mapped to a particular output bit, that output will be "low".

The input to output map is configured through the processor interface. The I/O map is stored in a bank of 24 configuration registers. Each register corresponds to one output bit. The output bit is mapped to the input via a value, 0 to 23, stored in the register. After power-up, the user has the option of configuring the switch in 1:1 mode by using the

reset input, "RST#". In 1:1 mode the cross-point switch outputs are in the same order as the input. More details on configuring the switch registers are contained in the Processor Interface text.

### Processor Interface

The Processor Interface consists of a 10 pin microprocessor interface and a register bank which holds configuration data. The data is loaded into the register bank by first writing the register address to the processor interface and then writing the data. An auto address increment mode is provided so that a base address may be written followed by a number of data writes.

The microprocessor interface consists of a 7 bit data bus (D0-6), a one bit address select (A0) to specify D0-6 as either address or data, a write input (WR#) to latch data into the Processor Interface, and a chip select input (CS#) to enable writing to the interface. The Processor Interface input is decoded as either data or address as shown by the bit map in Table 1.

TABLE 1.

REGISTER ADDRESSES								
	A0	D6	D5	D4	D3	D2	D1	D0
Switch Output Registers	1	x	0	n	n	n	n	n
Sequencer Starting Address	1	x	1	0	0	0	n	n
Sequencer Block Size	1	x	1	0	0	1	n	n
Sequencer Number of Blocks	1	x	1	0	1	0	n	n
Sequencer Block Address Increment	1	x	1	0	1	1	n	n
Sequencer Address Increment	1	x	1	1	0	0	n	n
Mode Control	1	x	1	1	0	1	0	0
Test Control	1	x	1	1	0	1	0	1
Start Delay Control	1	x	1	1	0	1	1	0
Address Sequencer "START"	1	x	1	1	1	1	1	1
DATA WORDS								
	A0	D6	D5	D4	D3	D2	D1	D0
Current Address Data (no address increment)	0	0	n	n	n	n	n	n
Current Address Data (address increment)	0	1	n	n	n	n	n	n

Table 1 "x" means "don't care", and "n" denotes bits which are decoded as an address in address registers and data in data registers.

The register bank consists of a series of 6 bit registers which may be addressed individually as shown in Table 1. The data in these registers is down loaded into configuration registers in the Start Circuitry, Sequence Generator, and Crosspoint Switch when an address sequence is initiated by the internal START signal (see Start Circuitry). This double buffered architecture allows new configuration data to be down loaded to the Processor Interface while an address sequence is being completed using previous configuration data.



Increment, and Address Increment. Each register set maps to one of five 24-bit configuration registers in the Sequence Generator block (see Sequence Generator). The mapping of the 6-bit registers in the register bank to the 24-bit configuration registers is determined by the 2 LSB's of the register address. The higher the value of the 2 LSB's the higher the relative mapping of the 6-bit register to the 24-bit register. For example, if the 2 LSB's of the register address are both 0, the register contents will map to the 6 LSB's of the configuration register.

The register bank has 24 registers which contain the data for Crosspoint Switch I/O mapping. These registers are accessed via the 5 LSB's of the address for the Crosspoint Mapping registers in Table 1. A value from 0 to 23 accesses the mapping registers for OUT0-23 respectively. A value greater than 23 is ignored. The output bit represented by a particular register is mapped to the input by the 6-bit value loaded into the register. If the value loaded into the register exceeds 23, the corresponding output bit will be "0". For example, if the 5 LSB's of the Crosspoint Mapping address are equal to 3, and the value loaded into the register accessed by this address is equal to 23, OUT3 would be mapped to the MSB of the sequence generator output.

After a reset, the Mode Control, Test Control, and Start Delay registers are reset as described in the section describing each register's bit map; the Crosspoint Mapping registers are reset to a 1:1 crosspoint switch mapping; the registers which hold the five address generation parameters are not affected.

To save the user the expense of alternating between address and data writes, an auto address increment mode is provided. The address increment mode is invoked by performing data writes with a "1" in the D6 location of the data word as shown in Table 1. For example, the crosspoint switch could be configured by 25 writes to the Processor Interface (one write for the starting address of the crosspoint mapping registers followed by 24 data writes to those registers).

#### Mode Control Register

The Mode Control Register is used to control the operation of the sequence generator. In addition, it also controls the output delay between the MSW and the LSW of OUT0-23. The following tables illustrate the structure of the mode control register.

TABLE 2. MODE CONTROL REGISTER FORMAT

ADDRESS LOCATION: 1x110100					
D5	D4	D3	D2	D1	D0
OD2	OD1	OD0	DS	M1	M0

OD2	OD1	OD0	
0	0	0	Output Delay of 0
0	0	1	Output Delay of 1
0	1	0	Output Delay of 2
0	1	1	Output Delay of 3
1	0	0	Output Delay of 4
1	0	1	Output Delay of 5
1	1	0	Output Delay of 6
1	1	1	Output Delay of 7

DS - Dual Sequencer Enable; Allows two independent 12-bit sequences to be generated.

0	A 24-bit sequence is generated.
1	Two 12-bit sequences are generated.

Mx - Mode: Sequencer Mode.

M1	M0	
0	0	One-Shot Mode without Restart
0	1	One-Shot Mode with Restart
1	x	Continuous Mode (x = don't care)

During reset, this register will be reset to all zeroes. This will configure the chip as a 24-bit sequencer with zero delays on the outputs. The chip will also be in one-shot mode without restart.

#### Start Delay Control Register

The Start Delay Control Register is used to configure the start circuitry for delayed starts from 1 to 31 clock cycles. Internal "START", external "START", and restarts will be delay by the programmed amount. The structure of the Start Delay Control Register is shown in Table 3.

TABLE 3. START DELAY CONTROL REGISTER FORMAT

ADDRESS LOCATION: 1x110110					
D5	D4	D3	D2	D1	D0
SDE	SD4	SD3	SD2	SD1	SD0

SDE - Start Delay Enable; Enables "START" to be delayed by the programmed amount. When Start Delay is enabled, a minimum of "1" is required for the programmed delay.

0	Start Delay is Disabled.
1	Start Delay is Enabled.

SDx - Start Delay; Delays the "START" by the decoded number of clocks.

SD4	SD3	SD2	SD1	SD0	
0	0	0	0	1	Start Delay of 1
0	0	0	1	0	Start Delay of 2
0	0	0	1	1	Start Delay of 3
1	1	1	1	1	Start Delay of 31

During reset, this register will be reset to all zeros. This will bring the chip up in a mode with Start Delay disabled.

### Test Control Register

A Test Control Register is provided to configure the sequence generator to produce test sequences. In this mode, the sequence generator can be configured to multiplex out the contents of the down counters in the sequence generator control circuitry, Figure 2. These counters are used to determine when a block or sequence is complete. As shown in Figures 1 and 2, the MSW or LSW in the down counters is multiplexed to the MSW of the address generator output. In addition, a test mode is provided in which the sequence generator performs a shifting operation on the contents of the start address register. The structure of the Test Control Register is shown in Table 4.

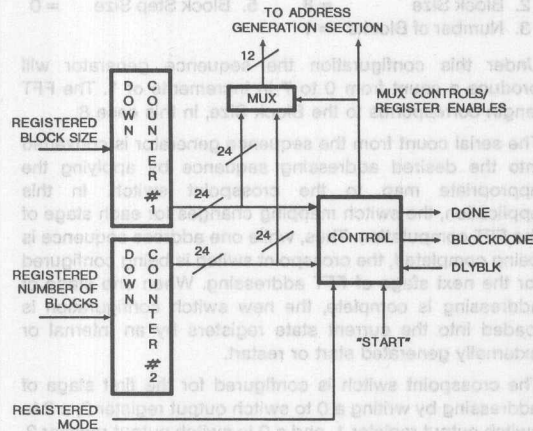


FIGURE 2. SEQUENCE GENERATOR CONTROL

TABLE 4. TEST CONTROL REGISTER FORMAT

ADDRESS LOCATION: 1x110101					
D5	D4	D3	D2	D1	D0
xx	xx	SE	COE	CS1	CS0

Bits "D5" and "D6" are currently not used.

**SE - Shifter Enable:** Input to crosspoint switch is generated by shifting Start Address Register one bit per clock.

0	Sequence Generator Functions Normally
1	Sequence Generator Functions as Shift Register

**COE - Counter Output Enable:** Enable contents of down counters in the sequence generator control circuitry to be muxed to the 12 MSB's of the address generator output.

0	Disable Muxing of down counters
1	Enable Muxing of down counters

**CS - Counter Select:** Selects which 12-bit word of the down counters is muxed to the MSW of the address generator output.

CS1	CS0	
0	0	Select Counter #1, bits 0-11
0	1	Select Counter #1, bits 12-23
1	0	Select Counter #2, bits 0-11
1	1	Select Counter #2, bits 12-23

During reset, this register will be reset to all zeroes. This will bring the chip up in the mode with all of the test features disabled.

### Applications

#### Image Processing

The application shown in Figure 3 uses the HSP45240 Address Sequencer to satisfy the addressing requirements for a simple image processing system. In this example the controller configures the sequencers to generate specialized addressing sequences for reading and writing the frame buffers. A typical mode of operation for this system might be to perform edge detection on a sub-section of an image stored in the frame buffer. In this application, data is fed to the 2-D Convolver by the address sequence driving the input frame buffer.

A graphical interpretation of sub-image addressing is shown in Figure 4. Each dot in the figure corresponds to an image pixel stored in memory. It is assumed that the pixel values are stored by row. For example, the first 16 memory locations would contain the first row of pixel values. The 17th memory location would contain the first pixel of the second row.

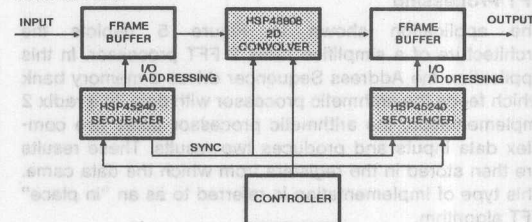


FIGURE 3. IMAGE PROCESSING SYSTEM

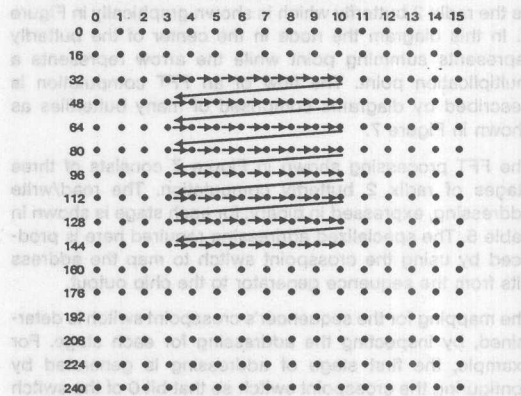


FIGURE 4. SEQUENCER SUB-IMAGE ADDRESSING

The sub-image address sequence shown in Figure 3 is generated by configuring the sequence generator with the following:

1. Start Address = 35      4. Step Size = 1
2. Block Size = 8      5. Block Step Size = 16
3. Number of Blocks = 8

In this example the start address corresponds to the address of the first pixel of the first row. The row length corresponds to the Block Size which is programmed to 8. Within the block, consecutive addresses are generated by programming the Step Size to 1. At the completion of first block of addresses, the Block Step Size of 16 is added to the Start Address to generate the address of the first pixel of the second row. Finally, 8 rows of addressing are generated by setting the Number of Blocks to 8.

In this application, the sub-image is processed one time and then a new sub-image area is chosen. As a result, the Mode Control Register would be configured for One-Shot mode without Restart. Also, the Start Delay Control register of the Sequencer driving the output frame buffer would be configured with a start delay to compensate for the pipeline delay introduced by the 2-D Convolver. Finally, the crosspoint switch would be configured in 1:1 mode so that the sequence generator output has a 1 to 1 mapping to the chip output.

For applications requiring decimation of the original image, the Step Size could be increased to provide addressing which skips over pixels along a row. Similarly, the Block Step Size could be increased such that pixel rows are skipped.

#### FFT Processing

The application shown in Figure 5 depicts the architecture of a simplified radix 2 FFT processor. In this application the Address Sequencer drives a memory bank which feeds the arithmetic processor with data. In a radix 2 implementation, the arithmetic processor takes two complex data inputs and produces two results. These results are then stored in the registers from which the data came. This type of implementation is referred to as an "in place" FFT algorithm.

The arithmetic processing unit performs an operation known as the radix 2 butterfly which is shown graphically in Figure 6. In this diagram the node in the center of the butterfly represents summing point while the arrow represents a multiplication point. The flow of an FFT computation is described by diagrams comprised of many butterflies as shown in Figure 7.

The FFT processing shown in Figure 7 consists of three stages of radix 2 butterfly computation. The read/write addressing, expressed in binary, for each stage is shown in Table 5. The specialized addressing required here is produced by using the crosspoint switch to map the address bits from the sequence generator to the chip output.

The mapping for the sequencer's crosspoint switch is determined, by inspecting the addressing for each stage. For example, the first stage of addressing is generated by configuring the crosspoint switch so that bit 0 of the switch input is mapped to bit 2 of the switch output, bit 1 of the

switch input is mapped to bit 0 of the output, and bit 2 of the switch input is mapped to bit 1 of the switch output. The remainder of the switch I/O map is configured 1:1, i.e. bit 3 of the switch input is mapped to bit 3 of the switch output. Under this configuration, a sequence generator output of 0,1,2,3,4,5,6,7 will produce a crosspoint switch output of 0,4,1,5,2,6,3,7. The switch maps for the other stages as well as a map for the bit-reverse addressing of the FFT result is given in Table 5.

The serial count required as input for the crosspoint switch is generated by configuring the sequence generator with the following:

1. Start Address = 0      4. Step Size = 1
2. Block Size = 8      5. Block Step Size = 0
3. Number of Blocks = 1

Under this configuration the sequence generator will produce a count from 0 to 7 in increments of 1. The FFT length corresponds to the Block Size, in this case 8.

The serial count from the sequence generator is converted into the desired addressing sequence by applying the appropriate map to the crosspoint switch. In this application, the switch mapping changes for each stage of the FFT computation. Thus, while one address sequence is being completed, the crosspoint switch is being configured for the next stage of FFT addressing. When one stage of addressing is complete, the new switch configuration is loaded into the current state registers by an internal or externally generated start or restart.

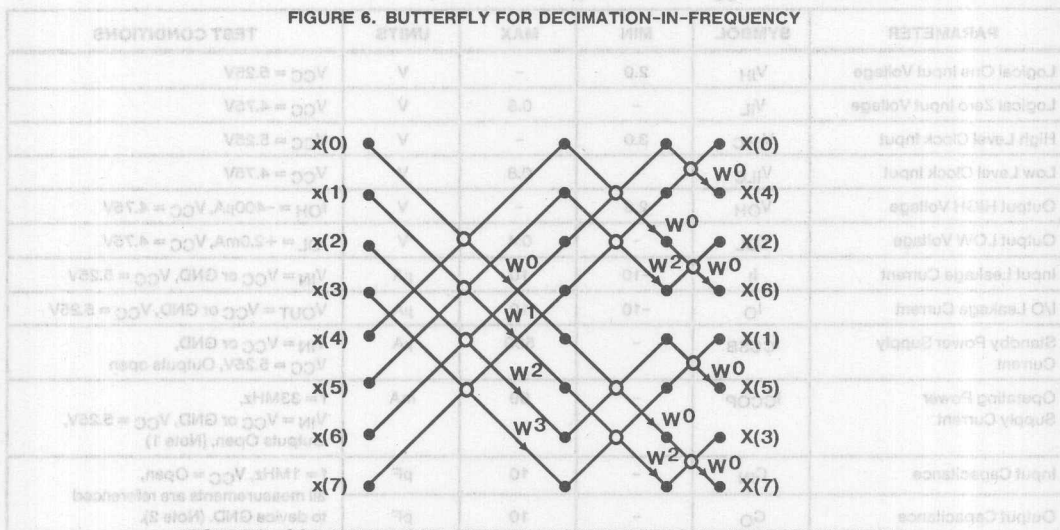
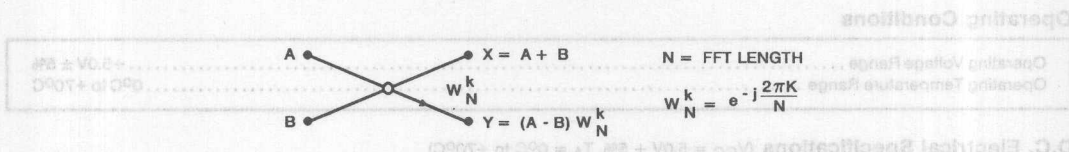
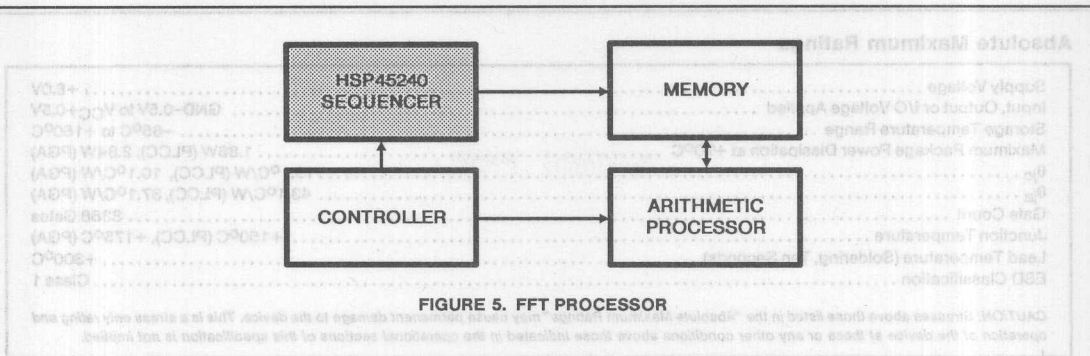
The crosspoint switch is configured for the first stage of addressing by writing a 0 to switch output register 2, a 2 to switch output register 1, and a 0 to switch output register 0. These values are loaded by first writing the address of switch output register 0 and then loading data using auto-address increment mode (see Table 1). The remaining registers are assumed to be configured in 1:1 mode as a result of a prior "RESET". The second and third stages of addressing are generated by reconfiguring the above three registers.

The Address Sequencer can be configured in dual sequencer mode to provide both read and write addressing for each butterfly. Since 2 independent 12 bit sequences can be generated by the Address Sequencer, it can be used to provide read/write addressing for FFT's up to 4096 points. The programmable delay between the MSW and LSW of the Sequencer output is used to compensate for the pipeline delay associated with the arithmetic processor.

TABLE 5. FFT ADDRESSING BY COMPUTATIONAL STAGE

STAGE 1 R/W ADDR.	STAGE 2 R/W ADDR.	STAGE 3 R/W ADDR.	OUTPUT ADDRESSING
000	000	000	000
100	010	001	100
001	001	010	010
101	011	011	110
010	100	100	001
110	110	101	101
011	101	110	011
111	111	111	111
SWITCH MAPPING			
021	201	210	012







## Specifications HSP45240

### Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input, Output or I/O Voltage Applied .....	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range .....	-65°C to +150°C
Maximum Package Power Dissipation at +70°C .....	1.86W (PLCC), 2.84W (PGA)
$\theta_{jc}$ .....	15.1°C/W (PLCC), 10.1°C/W (PGA)
$\theta_{ja}$ .....	43.1°C/W (PLCC), 37.1°C/W (PGA)
Gate Count .....	8388 Gates
Junction Temperature .....	+150°C (PLCC), +175°C (PGA)
Lead Temperature (Soldering, Ten Seconds) .....	+300°C
ESD Classification .....	Class 1

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### Operating Conditions

Operating Voltage Range .....	+5.0V $\pm$ 5%
Operating Temperature Range .....	0°C to +70°C

### D.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Logical One Input Voltage	$V_{IH}$	2.0	-	V	$V_{CC} = 5.25V$
Logical Zero Input Voltage	$V_{IL}$	-	0.8	V	$V_{CC} = 4.75V$
High Level Clock Input	$V_{IHC}$	3.0	-	V	$V_{CC} = 5.25V$
Low Level Clock Input	$V_{ILC}$	-	0.8	V	$V_{CC} = 4.75V$
Output HIGH Voltage	$V_{OH}$	2.6	-	V	$I_{OH} = -400\mu A$ , $V_{CC} = 4.75V$
Output LOW Voltage	$V_{OL}$	-	0.4	V	$I_{OL} = +2.0mA$ , $V_{CC} = 4.75V$
Input Leakage Current	$I_I$	-10	10	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$
I/O Leakage Current	$I_O$	-10	10	$\mu A$	$V_{OUT} = V_{CC}$ or GND, $V_{CC} = 5.25V$
Standby Power Supply Current	$I_{CCSB}$	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Outputs open
Operating Power Supply Current	$I_{CCOP}$	-	99	mA	$f = 33MHz$ , $V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Outputs Open, (Note 1)
Input Capacitance	$C_{IN}$	-	10	pF	$f = 1MHz$ , $V_{CC} =$ Open, all measurements are referenced to device GND. (Note 2).
Output Capacitance	$C_O$	-	10	pF	

#### NOTES:

- Power supply current is proportional to operating frequency. Typical rating for  $I_{CCOP}$  is 3mA/MHz.
- Not tested, but characterized at initial design and at major process/design changes.

## Specifications HSP45240

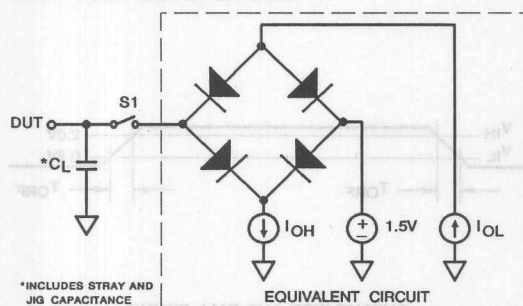
### A.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to $+70^\circ C$ ) (Note 2)

PARAMETER	SYMBOL	-33 (33MHz)		-40 (40MHz)		-50 (50MHz)		UNIT	TEST CONDITIONS
		MIN	MAX	MIN	MAX	MIN	MAX		
Clock Period	$T_{CP}$	30	-	25	-	20	-	ns	
Clock Pulse Width High	$T_{CH}$	12	-	10	-	9	-	ns	
Clock Pulse Width Low	$T_{CL}$	12	-	10	-	9	-	ns	
Setup Time D0-6 to WR# High	$T_{DS}$	14	-	13	-	12	-	ns	
Hold Time D0-6 from WR# High	$T_{DH}$	0	-	0	-	0	-	ns	
Set-up Time A0, CS#, to WR# Low	$T_{AS}$	5	-	5	-	5	-	ns	
Hold Time A0, CS#, from WR# High	$T_{AH}$	0	-	0	-	0	-	ns	
Pulse Width for WR# Low	$T_{WRL}$	13	-	12	-	10	-	ns	
Pulse Width for WR# High	$T_{WRH}$	13	-	12	-	10	-	ns	
WR# Cycle Time	$T_{WP}$	30	-	25	-	20	-	ns	
Set-up Time STARTIN#, DLYBLK, to Clock High	$T_{IS}$	12	-	10	-	8	-	ns	
Hold Time STARTIN#, DLYBLK, to Clock High	$T_{IH}$	0	-	0	-	0	-	ns	
Clock to Output Prop. Delay on OUT0-23	$T_{PDO}$	-	15	-	13	-	12	ns	
Clock to Output Prop. Delay on STARTOUT#, BLKDONE#, DONE#, ADDVAL#, and BUSY#	$T_{PDS}$	-	15	-	13	-	12	ns	
Output Enable Time	$T_{EN}$	-	20	-	15	-	13	ns	
Output Disable Time	$T_{OD}$	-	20	-	15	-	13	ns	Note 1
Output Rise/Fall Time	$T_{ORF}$	-	5	-	3	-	3	ns	Note 1
RST# Low Time	$T_{RST}$	2 Clock Cycles						ns	

#### NOTES:

- Controlled by design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.
- A.C. Testing is performed as follows: Input levels (CLK Input) = 4.0V and 0V; Input levels (All other inputs) = 0V and 3.0V; Input timing reference levels: (CLK) = 2.0V, (Others) = 1.5V; Output timing references:  $V_{OH} \geq 1.5V$ ,  $V_{OL} \leq 1.5V$ .

### A.C. Test Load Circuit



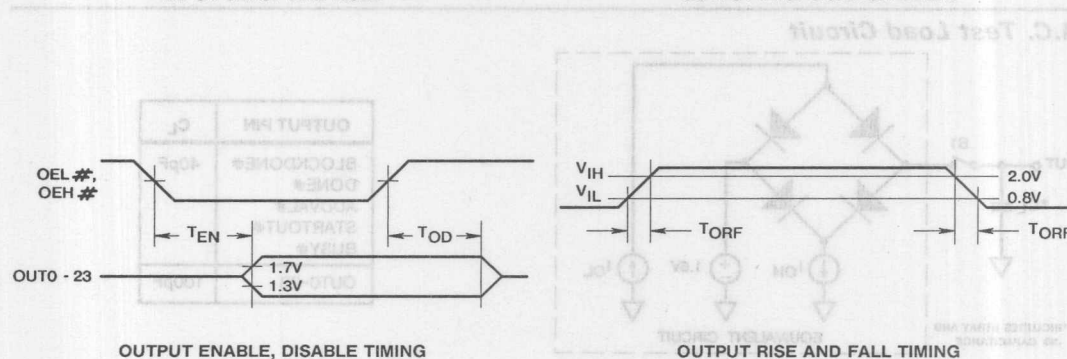
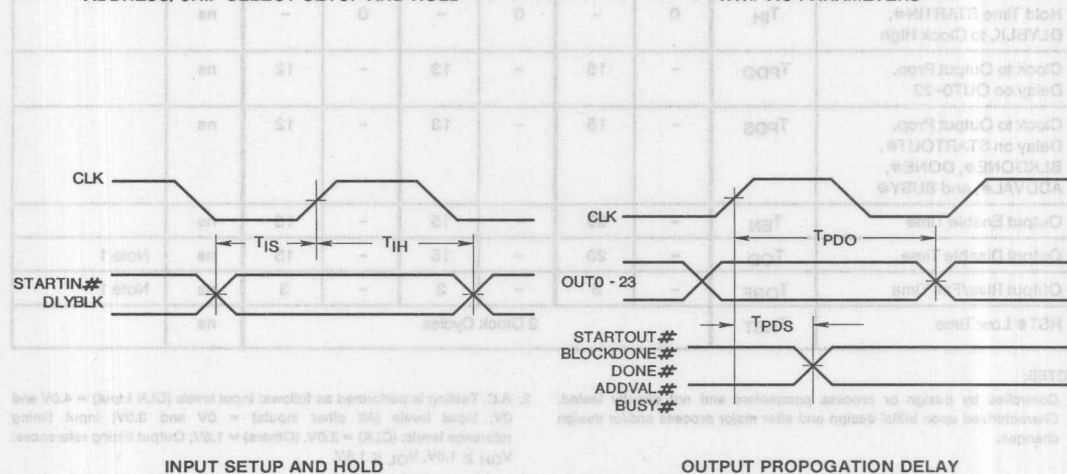
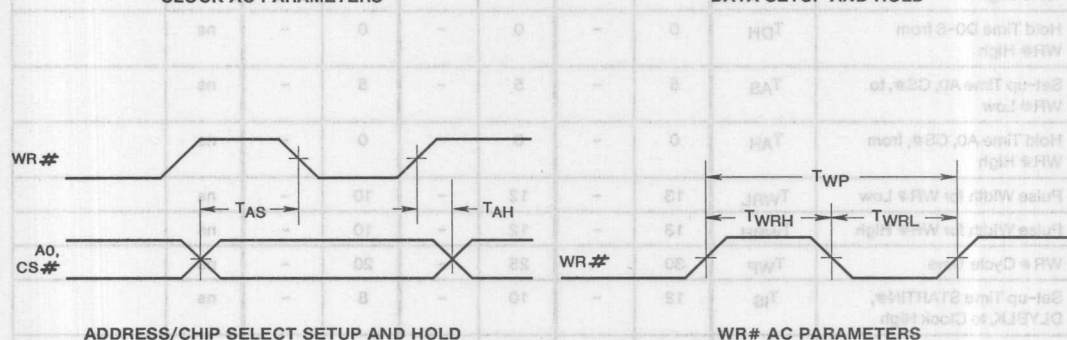
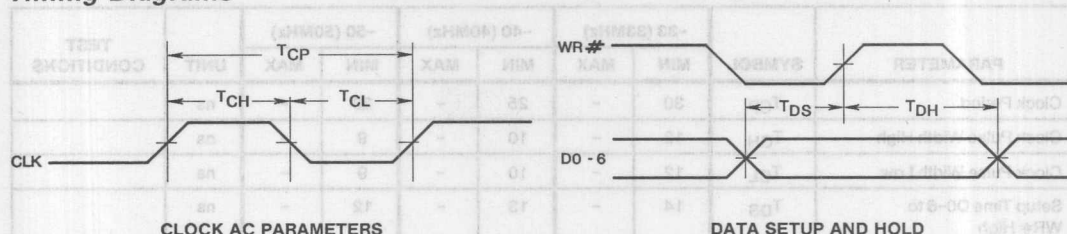
\*Test Head Capacitance  
Switch S1 Open for  $I_{CCSB}$  and  $I_{CCOP}$  Tests.

OUTPUT PIN	$C_L$
BLOCKDONE# DONE# ADDVAL# STARTOUT# BUSY#	40pF
OUT0-23	100pF

6

SPECIAL FUNCTION

# Timing Diagrams





## Address Sequence

## Features

- This Circuit is Processed in Accordance to Mil-Std-883 and is Fully Conformant Under the Provisions of Paragraph 1.2.1.
- Block Oriented 24-Bit Sequencer
- Configurable as Two Independent 12-Bit Sequencers
- 24 x 24 Crosspoint Switch
- Programmable Delay on 12 Outputs
- Multi-Chip Synchronization Signals
- Standard  $\mu$ P Interface
- TTL Compatible Inputs/Outputs
- 100pF Drive on Outputs
- DC to 40MHz Clock Rate
- Available in 68 Pin PGA Package

## Applications

- 1-D, 2-D Filtering
- Pan/Zoom Addressing
- FFT Processing
- Matrix Math Operations

### Block Diagram

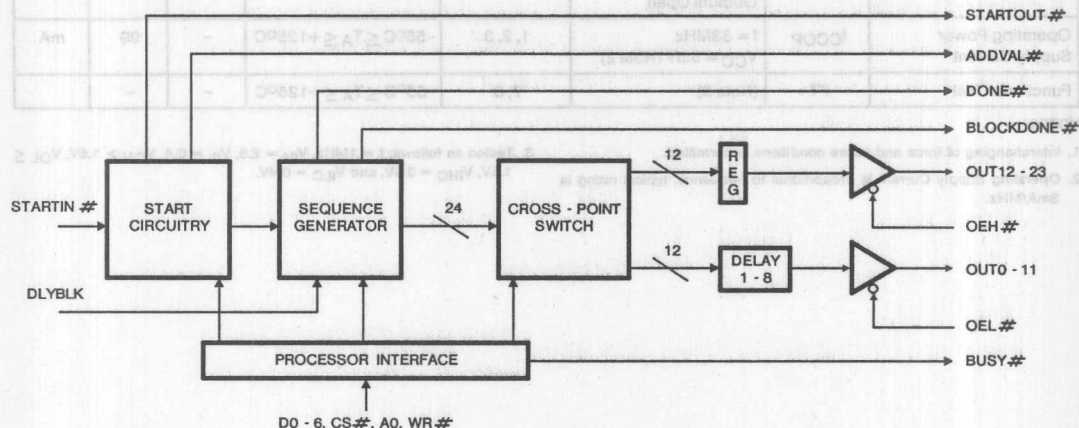
### Description

The Harris HSP45240 is a high speed Address Sequencer which provides specialized addressing for functions like FFT's, 1-D and 2-D filtering, matrix operations, and image manipulation. The sequencer supports block oriented addressing of large data sets up to 24 bits at clock speeds up to 40MHz.

Specialized addressing requirements are met by using the onboard 24 x 24 crosspoint switch. This feature allows the mapping of the 24 address bits at the output of the address generator to the 24 address outputs of the chip. As a result, bit reverse addressing, such as that used in FFT's, is made possible.

A single chip solution to read/write addressing is also made possible by configuring the HSP45240 as two 12-bit sequencers. To compensate for system pipeline delay, a programmable delay is provided on 12 of the address outputs.

The HSP45240 is manufactured using an advanced CMOS process, and is a low power fully static design. The configuration of the device is controlled through a standard microprocessor interface and all inputs/outputs, with the exception of clock, are TTL compatible. The Sequencer is available in a 68 pin PGA package.



CAUTION: Electronic devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
Copyright © Harris Corporation 1992

File Number **2816.1**



1

## Fig. 1

Thermal Resistance	$\theta_{ja}$	$\theta_{jc}$
Ceramic PGA Package	37.1°C/W	10.1°C/W
Maximum Package Power Dissipation at +125°C		
Ceramic PGA Package		1.35 Watt
Gate Count		8,388 Gates

283

of Paragraph 1.2.1. 552 and is Fully Conforming Under the Provisions

--	--	--	--

GROUP A SUBGROUPS	TEMPERATURE	LIMITS		UNITS
		MIN	MAX	
1, 2, 3	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	2.2	-	V
1, 2, 3	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	-	0.8	V
1, 2, 3	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	2.6	-	V
1, 2, 3	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	-	0.4	V
1, 2, 3	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	-10	+10	$\mu\text{A}$
1, 2, 3	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	-10	+10	$\mu\text{A}$
1, 2, 3	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	3.0	-	V
1, 2, 3	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	-	0.8	V
1, 2, 3	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	-	500	$\mu\text{A}$
1, 2, 3	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	-	99	mA
7, 8	$-55^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$	-	-	

3. Tested as follows:  $f = 1\text{MHz}$ ,  $V_{IH} = 2.6$ ,  $V_{IL} = 0.4$ ,  $V_{OH} \geq 1.5\text{V}$ ,  $V_{OL} \leq 1.5\text{V}$ ,  $V_{IHC} = 3.4\text{V}$ , and  $V_{ILC} = 0.4\text{V}$ .

# Specifications HSP45240/883

TABLE 2. A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested (Note 1)

PARAMETERS	SYMBOL	CONDI- TIONS	GROUP A SUB- GROUP	TEMPERATURE	LIMITS						UNITS
					-25 (25MHz)		-33 (33MHz)		-40 (40MHz)		
					MIN	MAX	MIN	MAX	MIN	MAX	
Clock Period	T <sub>CP</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	39	-	30	-	25	-	ns
Clock Pulse Width High	T <sub>CH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	12	-	10	-	ns
Clock Pulse Width Low	T <sub>CL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	12	-	10	-	ns
Setup Time D0-6 to WR# High	T <sub>DS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	17	-	16	-	14	-	ns
Hold Time D0-6 from WR# Low	T <sub>DH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	0	-	ns
Set-up Time A, CS#, to WR# Low	T <sub>AS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	5	-	5	-	5	-	ns
Hold Time A, CS#, from WR# High	T <sub>AH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	0	-	ns
Pulse Width for WR# Low	T <sub>WRL</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	18	-	14	-	12	-	ns
Pulse Width for WR# High	T <sub>WRH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	18	-	14	-	12	-	ns
WR# Cycle Time	T <sub>WP</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	39	-	30	-	25	-	ns
Set-up Time STARTIN#, DLYBLK, to Clock High	T <sub>IS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	15	-	12	-	10	-	ns
Hold Time STARTIN#, DLYBLK, to Clock High	T <sub>IH</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	0	-	0	-	0	-	ns
Clock to Output Prop. Delay on OUT0-23	T <sub>PDO</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	18	-	16	-	14	ns
Clock to Prop. Delay, on STARTOUT#, BLKDONE#, DONE#, ADVAL#, and BUSY#	T <sub>PDS</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	18	-	16	-	14	ns
Output Enable Time	T <sub>EN</sub>	Note 2	9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	22	-	20	-	15	ns
RST# Low Time	T <sub>RST</sub>		9, 10, 11	-55°C ≤ T <sub>A</sub> ≤ +125°C	2 Clock Cycles						ns

NOTES:

1. A.C. Testing: V<sub>CC</sub> = 4.5V and 5.5V, Inputs are driven at 3.0V for Logic "1" and 0.0V for a Logic "0". Input and output timing measurements are made at 1.5V for both a logic "1" and "0". CLK is driven at 4.0V and 0V and measured at 2.0V.
2. Transition is measured at ±200mV from steady state voltage with loading as specified by test load circuit and C<sub>L</sub> = 40pF.

6

SPECIAL  
FUNCTION

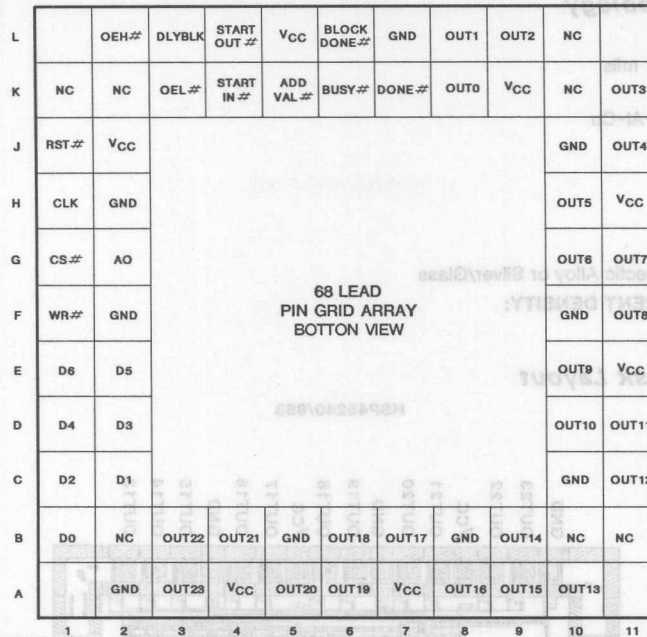
PARAMETERS	SYMBOL	CONDI- TIONS	NOTES	TEMPERATURE	LIMITS						UNITS
					-25 (25MHz)		-33 (33MHz)		-40 (40MHz)		
					MIN	MAX	MIN	MAX	MIN	MAX	
Input Capacitance	C <sub>IN</sub>	V <sub>CC</sub> = Open, f = 1MHz, All measure- ments are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	10	-	10	-	10	pF
Output Capacitance	C <sub>OUT</sub>	V <sub>CC</sub> = Open, f = 1MHz, All measure- ments are referenced to device GND.	1	T <sub>A</sub> = +25°C	-	10	-	10	-	10	pF
Output Disable Delay	T <sub>OEZ</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	22	-	20	-	15	ns
Output Rise Time	T <sub>OR</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	5	-	5	-	3	ns
Output Fall Time	T <sub>OF</sub>		1, 2	-55°C ≤ T <sub>A</sub> ≤ +125°C	-	5	-	5	-	3	ns

NOTES: 1. Parameters listed in Table 3 are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design and after major process and/or design changes.

2. Loading is as specified in the test load circuit with C<sub>L</sub> = 40pF.

TABLE 4. ELECTRICAL TEST REQUIREMENTS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C & D	Samples/5005	1, 7, 9

**Burn-In Circuit**

PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
A2	GND	GND	B9	OUT14	V <sub>CC</sub> /2	F11	OUT8	V <sub>CC</sub> /2	K6	BUSYB	V <sub>CC</sub> /2
A3	OUT23	V <sub>CC</sub> /2	C1	D2	F10	G1	CSB	F5	K7	DONEB	V <sub>CC</sub> /2
A4	V <sub>CC</sub>	V <sub>CC</sub>	C2	D1	F9	G2	A0	F6	K8	OUT0	V <sub>CC</sub> /2
A5	OUT20	V <sub>CC</sub> /2	C10	GND	GND	G10	OUT6	V <sub>CC</sub> /2	K9	V <sub>CC</sub>	V <sub>CC</sub>
A6	OUT19	V <sub>CC</sub> /2	C11	OUT12	V <sub>CC</sub> /2	G11	OUT7	V <sub>CC</sub> /2	K11	OUT3	V <sub>CC</sub> /2
A7	V <sub>CC</sub>	V <sub>CC</sub>	D1	D4	F12	H1	CLK	F0	L2	OEHB	F13
A8	OUT16	V <sub>CC</sub> /2	D2	D3	F11	H2	GND	GND	L3	DLYBLK	F11
A9	OUT15	V <sub>CC</sub> /2	D10	OUT10	V <sub>CC</sub> /2	H10	OUT5	V <sub>CC</sub> /2	L4	STARTOUTB	V <sub>CC</sub> /2
A10	OUT13	V <sub>CC</sub> /2	D11	OUT11	V <sub>CC</sub> /2	H11	V <sub>CC</sub>	V <sub>CC</sub>	L5	V <sub>CC</sub>	V <sub>CC</sub>
B1	D0	F8	E1	D6	F7	J1	RSTB	F14	L6	BLOCKDONEB	V <sub>CC</sub> /2
B3	OUT22	V <sub>CC</sub> /2	E2	D5	F13	J2	V <sub>CC</sub>	V <sub>CC</sub>	L7	GND	GND
B4	OUT21	V <sub>CC</sub> /2	E10	OUT9	V <sub>CC</sub> /2	J10	GND	GND	L8	OUT1	V <sub>CC</sub> /2
B5	GND	GND	E11	V <sub>CC</sub>	V <sub>CC</sub>	J11	OUT4	V <sub>CC</sub> /2	L9	OUT2	V <sub>CC</sub> /2
B6	OUT18	V <sub>CC</sub> /2	F1	WRB	F4	K3	OELB	F12			
B7	OUT17	V <sub>CC</sub> /2	F2	GND	GND	K4	STARTINB	F6			
B8	GND	GND	F10	GND	GND	K5	ADVALB	V <sub>CC</sub> /2			

**NOTES:**

1. V<sub>CC</sub>/2 (2.7V ±10%) used for outputs only.
2. 47KΩ (±20%) resistor connected to all pins except V<sub>CC</sub> and GND.
3. V<sub>CC</sub> = 5.5 ±0.5V.
4. 0.1μF (min) capacitor between V<sub>CC</sub> and GND per position.
5. F0 = 100KHz ±10%, F1 = F0/2, F2 = F1/2, ..., F11 = F10/2, 40% - 60% Duty Cycle.
6. Input voltage limits: V<sub>IL</sub> = 0.8V max., V<sub>IH</sub> = 4.5V ±10%.



**Metallization Topology****DIE DIMENSIONS:**

186 x 222 x 19 ±1 mils

**METALLIZATION:**

Type: Si - Al or Si-Al-Cu

Thickness: 8kÅ

**GLASSIVATION:**

Type: Nitrox

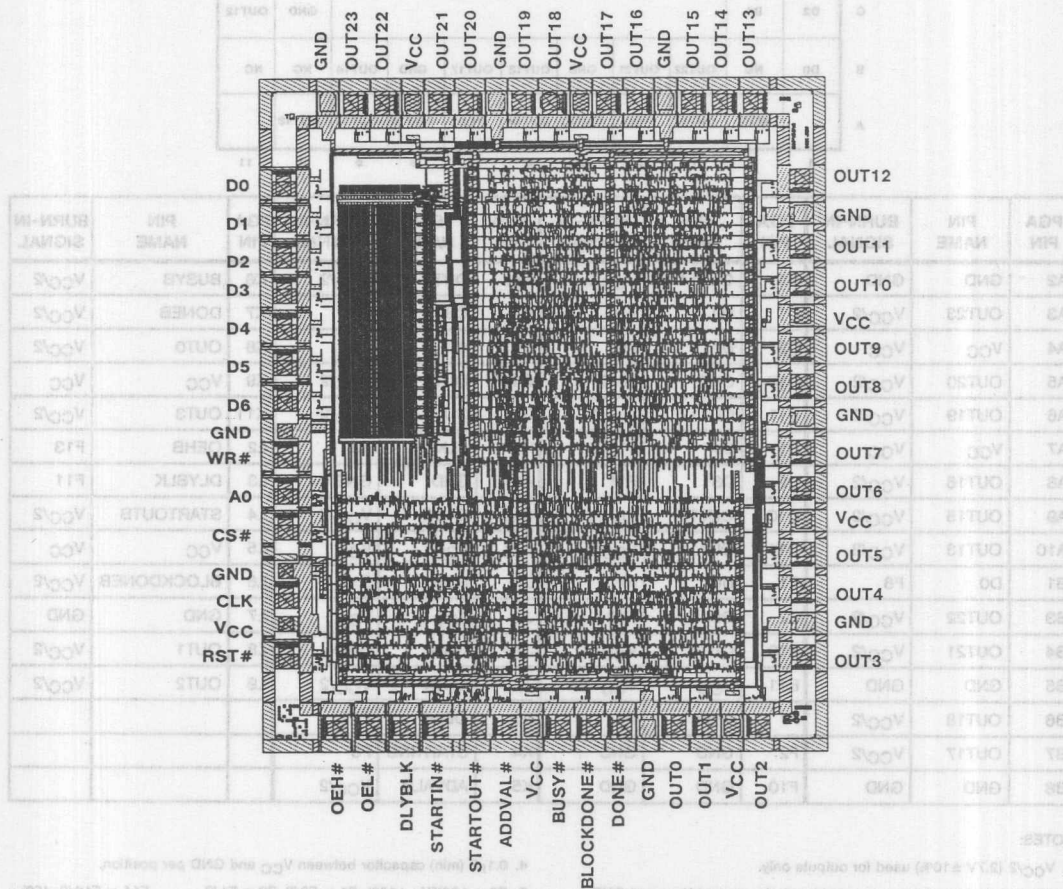
Thickness: 10kÅ

**DIE ATTACH:**

Material: Si-Au Eutectic Alloy or Silver/Glass

**WORST CASE CURRENT DENSITY:** $1.8 \times 10^5 \text{A/cm}^2$ **Metallization Mask Layout**

HSP45240/883



August 1992

## Binary Correlator

### Features

- Reconfigurable 256 Stage Binary Correlator
- 1-Bit Reference x 1, 2, 4, or 8-Bit Data
- Separate Control and Reference Interfaces
- 25.6, 33MHz Versions
- Configurable for 1-D and 2-D Operation
- Double Buffered Mask and Reference
- Programmable Output Delay
- Cascadable
- Standard Microprocessor Interface
- 85-pin PGA, 84-pin PLCC

### Applications

- Radar/Sonar
- Spread Spectrum Communications
- Pattern/Character Recognition
- Error Correction Coding

### Description

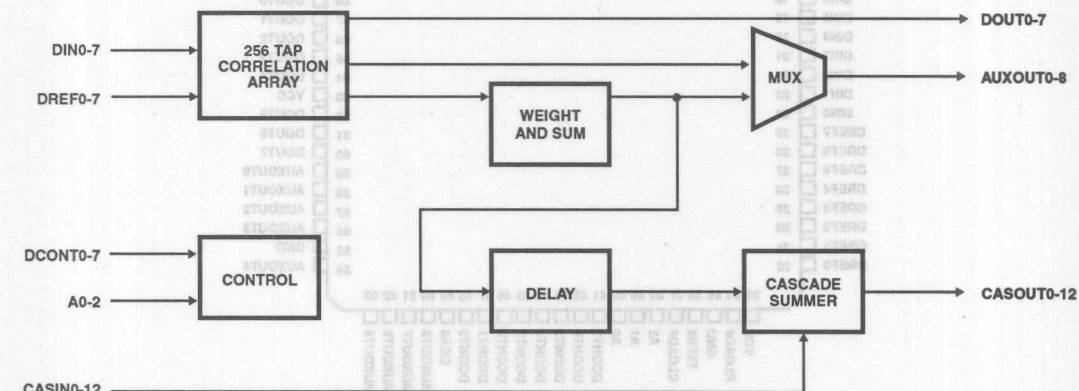
The Harris HSP45256 is a high-speed, 256 tap binary correlator. It can be configured to perform one- or two-dimensional correlations of selectable data precision and length. Multiple HSP45256's can be cascaded for increased correlation length. Unused taps can be masked out for reduced correlation length.

The correlation array consists of eight 32-tap stages. These may be cascaded internally to compare 1, 2, 4 or 8-bit input data with a 1-bit reference. Depending on the number of bits in the input data, the length of the correlation can be up to 256, 128, 64, or 32 taps. The HSP45256 can also be configured as two separate correlators with window sizes from 4 by 32 to 1 by 128 each. The mask register can be used to prevent any subset of the 256 bits from contributing to the correlation score.

The output of the correlation array (correlation score) feeds the weight and sum logic, which gives added flexibility to the data format. In addition, an offset register is provided so that a preprogrammed value can be added to the correlation score. This result is then passed through a user programmable delay stage to the cascade summer. The delay stage simplifies the cascading of multiple correlators by compensating for the latency of previous correlators.

The Binary Correlator is configured by writing a set of control registers via a standard microprocessor interface. To simplify operation, both the control and reference registers are double buffered. This allows the user to load new mask and reference data while the current correlation is in progress.

### Block Diagram



L	DREF0	GND	TXF8#	A2	DCONT	DCONT	DCONT	DCONT	AUXOUT	AUXOUT	AUXOUT
					7	1			8		
K	DREF2	V <sub>cc</sub>	RLOAD#	CLOAD#	A0	DCONT	DCONT	OEA#	AUXOUT	AUXOUT	AUXOUT
									8		
J	DREF3	DREF1		A1	DCONT	DCONT			GND	AUXOUT	
					5	4				2	
H	DREF5	DREF4							AUXOUT	AUXOUT	
									1	0	
G	DINO	DREF7	DIN1					V <sub>cc</sub>	DOUT6	DOUT5	
F	DREF6	DIN3	DIN2						DOUT4	DOUT7	DOUT3
E	DIN4	DIN5	DIN6						DOUT0	DOUT1	DOUT2
D	DIN7	V <sub>cc</sub>							GND	CASOUT	
										12	
C	CLK	CASIN0	INDEX PIN		CASIN	CASIN	OEC#		CASOUT	CASOUT	
					8	12			9	11	
B	GND	CASIN1	CASIN3	CASIN6	CASIN	CASOUT	CASOUT	CASOUT	CASOUT	CASOUT	CASOUT
					9	2	1	4	6	7	10
A	CASIN	CASIN	CASIN	CASIN	CASIN	CASIN	CASOUT	CASOUT	CASOUT	CASOUT	CASOUT
	2	4	5	7	10	11	0	3	5		8
	1	2	3	4	5	6	7	8	9	10	11

	1	2	3	4	5	6	7	8	9	10	11
A	CAS 2	CASIN 4	CASIN 5	CASIN 7	CASIN 10	CASIN 11	CAS OUT 0	CAS OUT 3	CAS OUT 5	GND	CAS OUT 8
B	GND	CASIN 1	CASIN 3	CASIN 6	CASIN 9	CAS OUT 2	CAS OUT 1	CAS OUT 4	CAS OUT 6	CAS OUT 7	CAS OUT 10
C	CLK	CASIN 0	INDEX PIN		CASIN 8	CASIN 12	OE $\overline{A}$			CAS OUT 9	CAS OUT 11
D	DIN7	VCC								GND	CAS OUT 12
E	DIN4	DIN5	DIN6							DOUT	DOUT
F	DREF 6	DIN3	DIN2							DOUT 4	DOUT 3
G	DIN0	DREF 7	DIN1							VCC	DOUT 6
H	DREF 5	DREF 4									AUX OUT 0
J	DREF 3	DREF 1			A1	D $\overline{C}$ ONT 5	D $\overline{C}$ ONT 4			GND	AUX OUT 2
K	DREF 2	VCC	R LOAD $\#$	C LOAD $\#$	A0	D $\overline{C}$ ONT 6	D $\overline{C}$ ONT 2	OE $\overline{A}$	AUX OUT 8	AUX OUT 3	AUX OUT 4
L	DREF 0	GND	TXFR $\#$	A2	D $\overline{C}$ ONT 7	D $\overline{C}$ ONT 1	D $\overline{C}$ ONT 3	D $\overline{C}$ ONT 0	AUX OUT 8	AUX OUT 7	AUX OUT 5

84 PIN PLCC  
TOP VIEW

Pinout details:

- Pins 1-42 (Left side): CASIN1, CASIN0, GND, CLK, VCC, DIN7, DIN6, DIN5, DIN4, DIN3, DIN2, DIN1, DIN0, DREF7, DREF6, DREF5, DREF4, DREF3, DREF2, DREF1, DREF0.
- Pins 43-84 (Right side): VCC, RLOAD#, GND, TXFR#, CLOAD#, A2, A1, A0, DCOUT7, DCOUT6, DCOUT5, DCOUT4, DCOUT3, DCOUT2, DCOUT1, DCOUT0, OE#, AUXOUT7, AUXOUT6, AUXOUT5, AUXOUT4, AUXOUT3, AUXOUT2, AUXOUT1, AUXOUT0.

## Pin Description

SYMBOL	PLCC PIN NUMBER	TYPE	DESCRIPTION
V <sub>cc</sub>	16, 33, 63		The +5V power supply pin.
GND	14, 35, 55, 70, 77		Ground.
DIN0-7	17-24	I	The DIN0-7 bus consists of eight single data input pins. The assignment of the active pins is determined by the configuration. Data is loaded synchronous to the rising edge of CLK. DIN0 is the LSB.
DOUT0-7	60-62, 64-68	O	The DOUT0-7 bus is the data output of the correlation array. The format of the output is dependent on the window configuration and bit weighting. DOUT0 is the LSB.
CLK	15	I	System clock. Positive edge triggered.
CASIN0-12	1-13	I	CASIN0-12 allows multiple correlators to be cascaded by connecting CASOUT0-12 of one correlator to CASIN0-12 of another. The CASIN bus is added internally to the correlation score to form CASOUT. CASIN0 is the LSB.
CASOUT0-12	69, 71-76, 78-83	O	CASOUT0-12 is the output correlation score. This value is the delayed sum of all the 256 taps of one chip and CASIN0-12. When the part is configured to act as two independent correlators, CASOUT0-8 represents the correlation score for the first correlator while the second correlation score is available on the AUXOUT0-8 bus. In this configuration, the cascading feature is no longer an option. CASOUT0 is the LSB.
OEC#	84	I	OEC# is the output enable for CASOUT0-12. When OEC# is high, the output is three-stated. Processing is not interrupted by this pin. (Active low.)
TXFR#	36	I	TXFR# is a synchronous clock enable signal that allows the loading of the reference and mask inputs from the preload register to the correlation array. Data is transferred on the rising edge of CLK while TXFR# is low. (Active low.)
DREF0-7	25-32	I	DREF0-7 is an 8-bit wide data reference input. This is the input data bus used to load the reference data. RLOAD# going active initiates the loading of the reference registers. This input bus is used to load the reference registers of the correlation array. The manner in which the reference data is loaded is determined by the window configuration. If the window configuration is 1 x 256, the reference bits are loaded one at a time over DREF7. When the HSP45256 is configured as an 8 x 32 array, the data is loaded into all stages in parallel. In this case, DREF7 is the reference data for the first stage and DREF0 is the reference data for the eighth stage. The contents of the reference data registers are not affected by changing the window configuration. DREF0 is the LSB.
RLOAD#	34	I	RLOAD# enables loading of the reference registers. Data on DREF0-7 is loaded into the preload registers on the rising edge of RLOAD#. This data is transferred into the correlation array by TXFR#. (Active low.)
DCONT0-7	41-48	I	DCONT0-7 is the control data input, which is used to load the mask bit for each tap as well as the configuration registers. The mask data is sequentially loaded into the eight stages in the same manner as the reference data. DCONT0 is the LSB.
CLOAD#	37	I	CLOAD# enables the loading of the data on DCONT0-7. The destination of this data is controlled by A0-2. (Active low.)
A0-2	38-40	I	A0-2 is a 3-bit address that determines what function will be performed when CLOAD# is active. This address bus is set up with respect to the rising edge of the load signal, CLOAD#. A0 is the LSB.
AUXOUT0-8	50-54, 56-59	O	AUXOUT0-8 is a 9-bit bus that provides either the data reference output or the 9-bit correlation score of the second correlator, depending on the configuration. When the user programs the chip to be two separate correlators, the score of the second correlator is output on this bus. When the user has programmed the chip to be one correlator, AUXOUT0-7 represents the reference data out, with the state of AUXOUT0-8 undefined. AUXOUT0 is the LSB.
OEA#	49	I	The OEA# signal is the output enable for the AUXOUT0-8 output. When OEA# is high, the output is disabled. Processing is not interrupted by this pin. (Active low.)



## Functional Description

The correlation array consists of eight 32-bit stages. The first stage receives data directly from input pin DIN7. The other seven stages receive input data from either an external data pin, DINO-6, or from the shift register output of the previous stage, as determined by the Configuration Register. When the part is configured as a single correlator the sum of correlation score, offset register and cascade input appears on CASOUT0-12. Delayed versions of the data and reference inputs appear on DOUT0-7 and AUXOUT0-7, respectively. The input and output multiplexers of the correlation array are controlled together; for example, in a 1 x 256 correlation, the input data is loaded into DIN7 and the output appears on DOUT7. The configuration of the data bits, the length of the correlation (and in the two-dimensional data, the number of rows), is commonly called the correlation window.

## Correlator Array

The core of the HSP45256 is the correlation array, which consists of eight 32-tap stages. A single correlator cell consists of an XNOR gate for the individual bit comparison; i.e., if the data and reference bits are either both high or both low, the output of the correlator cell is high. In addition, two latches, one for the reference and one for the control data path are contained in this cell. These latches are loaded from the preload registers on the rising edge of CLK when TXFR# is low so that the reference and mask values are updated without interrupting data processing.

The mask function is implemented with an AND gate. When a mask bit is a logic low, the corresponding correlator cell output is low.

The function performed by one correlation cell is:

$$(D_{i,n} \text{ XNOR } R_{i,n}) \text{ AND } M_{i,n}$$

where:

$D_{i,n}$  = Bit i of data register n

$R_{i,n}$  = Bit i of reference register n

$M_{i,n}$  = Bit i of mask register n

The reference and mask bits are loaded sequentially, N bits at a time, where N depends on the current configuration (See Table 3). New reference data is loaded on the rising edge of RLOAD# and new mask data is loaded on the rising edge of CLOAD#. The mask and reference bits are stored internally in shift registers, so that the mask and reference information that was loaded most recently will be used to process the newest data. When new information is loaded in, the previous contents of the mask and reference bits are shifted over by one sample, and the oldest information is lost. There are no registers in the multiplexer array (Figure 1), so the data on DOUT0-7 corresponds to the data in the last element of the correlation array. When monitoring DOUT0-7, AUXOUT0-8, and REFOUT0-7, only those bits listed in Table 3 are valid.

## Weight and Sum Logic

The Weight and Sum Logic provides the bit weighting and final correlator score from the eight stages of the correlation array. For a 1 x 256 1-D configuration, the outputs of each of the stages are given a weight of 1 and then added together. In a 8 x 32 (8-bit data) configuration, the output of each stage will be shifted so that the output data represents an 8-bit word, with stage seven being the MSB.

The 13-bit offset register is loaded from the control data bus. Its output is added to the correlation score obtained from the correlator array. This sum then goes to the programmable delay register data input.

When the chip is configured as dual correlators, the user has the capability of loading two different offset values for the two correlators.

The Programmable Delay Register sets the number of pipeline stages between the output of the weight and sum logic and the input of the Cascade Summer. This delay register is used to align the output of multiple correlators in cascaded configurations (See Applications). The number of delays is programmable from 1 to 16, allowing for up to 16 correlators to be cascaded. When the HSP45256 is configured as dual correlators, the delay must be set to 0000, which specifies a delay of 1.

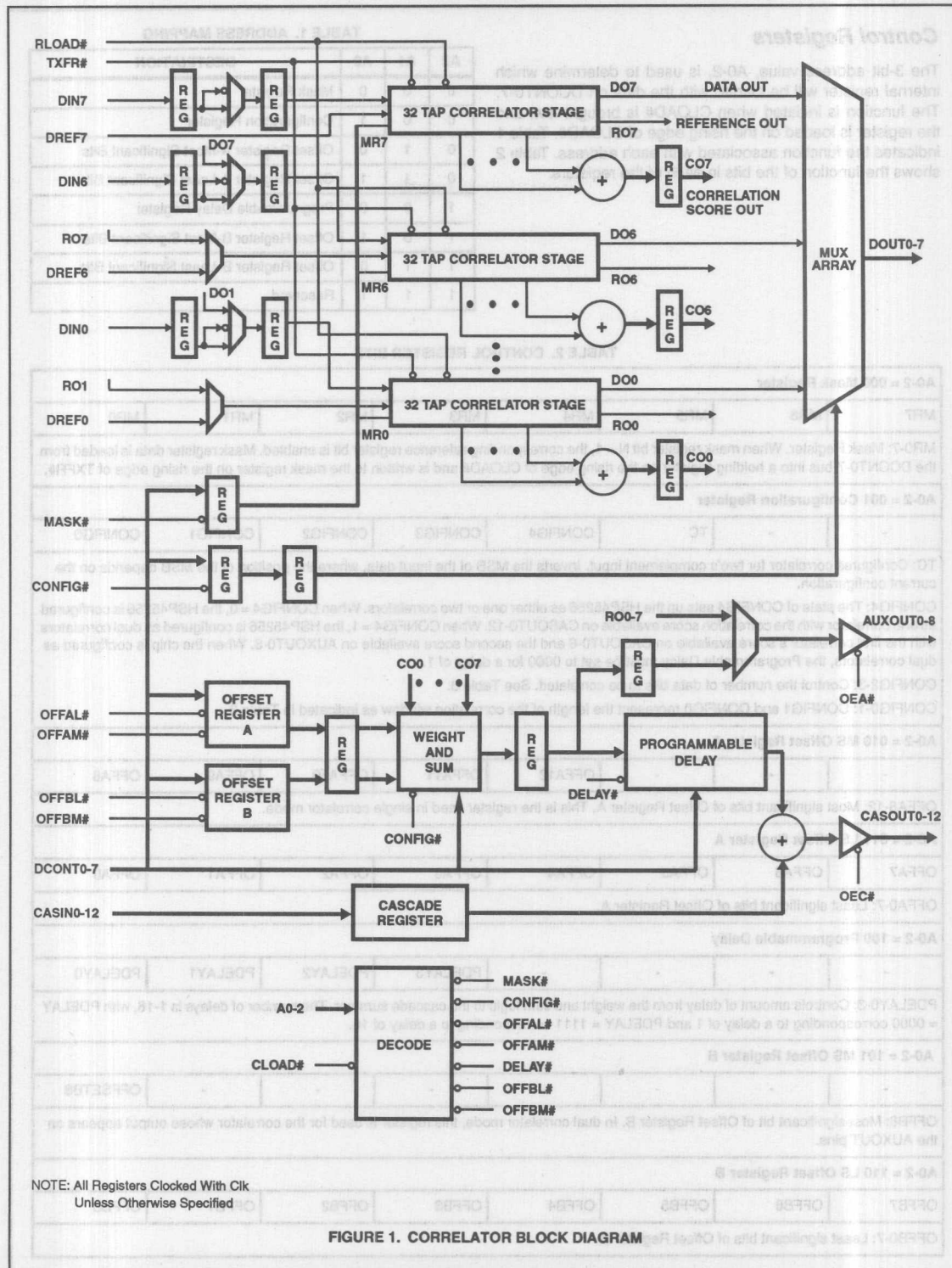
## Cascade Summer

This is used for cascading several correlators together. This value on this bus represents the correlation score from the previous HSP45256 that will be summed with the current score to provide the final correlation score. When several correlators are cascaded, the CASOUT0-12 of each of the other correlators is connected to the CASIN0-12 of the next correlator in the chain. The CASIN0-12 of the first chip is tied low. The following function represents the correlation score seen on CASOUT0-12 of each correlator:

$$\begin{aligned} \text{CASOUT}(n) = & (W7 \times CO7)(n\text{-Delay}) + (W6 \times CO6)(n\text{-Delay}) + \\ & (W5 \times CO5)(n\text{-Delay}) + (W4 \times CO4)(n\text{-Delay}) + \\ & (W3 \times CO3)(n\text{-Delay}) + (W2 \times CO2)(n\text{-Delay}) + \\ & (W1 \times CO1)(n\text{-Delay}) + (W0 \times CO0)(n\text{-Delay}) + \\ & \text{Offset}(n\text{-Delay}) + \text{CASIN}. \end{aligned}$$

where:

CO0-CO7 are the correlation score outputs out of the correlation stages; W0-W7 is the weight given to each stage; n-Delay represents the delay on the weighted and summed correlation score through the Programmable Delay Register; Offset is the value programmed into the Offset register; CASIN is the cascade input.



## Control Registers

The 3-bit address value, A0-2, is used to determine which internal register will be loaded with the data on DCONT0-7. The function is initiated when CLOAD# is brought low, and the register is loaded on the rising edge of CLOAD#. Table 1 indicates the function associated with each address. Table 2 shows the function of the bits in each of the registers.

TABLE 1. ADDRESS MAPPING

A2	A1	A0	DESTINATION
0	0	0	Mask Register
0	0	1	Configuration Register
0	1	0	Offset Register A-Most Significant Bits
0	1	1	Offset Register A-Least Significant Bits
1	0	0	Programmable Delay Register
1	0	1	Offset Register B-Most Significant Bits
1	1	0	Offset Register B-Least Significant Bits
1	1	1	Reserved

TABLE 2. CONTROL REGISTER BITS

<b>A0-2 = 000 Mask Register</b>							
MR7	MR6	MR5	MR4	MR3	MR2	MR1	MR0
MR0-7: Mask Register. When mask register bit N = 1, the corresponding reference register bit is enabled. Mask register data is loaded from the DCONT0-7 bus into a holding register on the rising edge of CLOAD# and is written to the mask register on the rising edge of TXFR#.							
<b>A0-2 = 001 Configuration Register</b>							
-	-	TC	CONFIG4	CONFIG3	CONFIG2	CONFIG1	CONFIG0
TC: Configures correlator for two's complement input. Inverts the MSB of the input data, where the position of the MSB depends on the current configuration.							
CONFIG4: The state of CONFIG4 sets up the HSP45256 as either one or two correlators. When CONFIG4 = 0, the HSP45256 is configured as one correlator with the correlation score available on CASOUT0-12. When CONFIG4 = 1, the HSP45256 is configured as dual correlators with the first correlator's score available on CASOUT0-8 and the second score available on AUXOUT0-8. When the chip is configured as dual correlators, the Programmable Delay must be set to 0000 for a delay of 1.							
CONFIG2-3: Control the number of data bits to be correlated. See Table 3.							
CONFIG0-1: CONFIG1 and CONFIG0 represent the length of the correlation window as indicated in Table 3.							
<b>A0-2 = 010 MS Offset Register A</b>							
-	-	-	OFFA12	OFFA11	OFFA10	OFFA9	OFFA8
OFFA8-12: Most significant bits of Offset Register A. This is the register used in single correlator mode.							
<b>A0-2 = 011 LS Offset Register A</b>							
OFFA7	OFFA6	OFFA5	OFFA4	OFFA3	OFFA2	OFFA1	OFFA0
OFFA0-7: Least significant bits of Offset Register A.							
<b>A0-2 = 100 Programmable Delay</b>							
-	-	-	-	PDELAY3	PDELAY2	PDELAY1	PDELAY0
PDELAY0-3: Controls amount of delay from the weight and sum logic to the cascade summer. The number of delays is 1-16, with PDELAY = 0000 corresponding to a delay of 1 and PDELAY = 1111 corresponding to a delay of 16.							
<b>A0-2 = 101 MS Offset Register B</b>							
-	-	-	-	-	-	-	OFFB8
OFFB8: Most significant bit of Offset Register B. In dual correlator mode, this register is used for the correlator whose output appears on the AUXOUT pins.							
<b>A0-2 = 110 LS Offset Register B</b>							
OFFB7	OFFB6	OFFB5	OFFB4	OFFB3	OFFB2	OFFB1	OFFB0
OFFB0-7: Least significant bits of Offset Register B.							

TABLE 3. CONFIGURATION SETUP

CONFIGURATION					NO. OF CORRE- LATORS	DATA BITS	ROWS	LENGTH	CORRE- LATOR	ACTIVE INPUTS		ACTIVE OUTPUTS			OUTPUT WEIGHTING							
4	3	2	1	0						DIN	DREF	DOUT	AUXOUT	CASOUT	CO7	CO6	CO5	CO4	CO3	CO2	CO1	CO0
0	0	0	0	0	1	1	1	256	-	7	7	7	7	12-0	1	1	1	1	1	1	1	1
0	0	0	0	1	1	1	2	128	-	7, 3	7, 3	7, 3	7, 3	12-0	1	1	1	1	1	1	1	1
0	0	0	1	0	1	1	4	64	-	7, 5, 3, 1	7, 5, 3, 1	7, 5, 3, 1	7, 5, 3, 1	12-0	1	1	1	1	1	1	1	1
0	0	0	1	1	1	1	8	32	-	7-0	7-0	7-0	7-0	12-0	1	1	1	1	1	1	1	1
0	0	1	0	1	1	1	2	128	-	7, 3	7	7, 3	7, 3	12-0	2	2	2	2	1	1	1	1
0	0	1	1	0	1	1	2	64	-	7, 5, 3, 1	7, 5	7, 5, 3, 1	7, 5, 3, 1	12-0	2	2	2	2	1	1	1	1
0	0	1	1	1	1	1	2	32	-	7-0	7, 6, 5, 4	7-0	7-0	12-0	2	2	2	2	1	1	1	1
0	1	0	1	0	1	1	4	64	-	7, 5, 3, 1	7	7, 5, 3, 1	7, 5, 3, 1	12-0	8	8	2	2	4	4	1	1
0	1	0	1	1	1	1	4	32	-	7-0	7, 6	7-0	7-0	12-0	8	8	2	2	4	4	1	1
0	1	1	1	1	1	1	8	32	-	7-0	7	7-0	7-0	12-0	128	8	32	4	64	2	16	1
1	0	0	0	1	2	1	1	128	A B	7 3	7 3	7 3	- 8-0	12-0 -	1 -	1 -	1 -	1 -	- 1	- 1	- 1	- 1
1	0	0	1	0	2	1	2	64	A B	7, 5 3, 1	7, 5 3, 1	7, 5 3, 1	- 8-0	12-0 -	1 -	1 -	1 -	1 -	- 1	- 1	- 1	- 1
1	0	0	1	1	2	1	4	32	A B	7-4 3-0	7-4 3-0	7-4 3-0	- 8-0	12-0 -	1 -	1 -	1 -	1 -	- 1	- 1	- 1	- 1
1	0	1	1	0	2	2	1	64	A B	7, 5 3, 1	7 3	7, 5 3, 1	- 8-0	12-0 -	2 -	2 -	1 -	1 -	- 2	- 2	- 1	- 1
1	0	1	1	1	2	2	2	32	A B	7-4 3-0	7, 6 3, 2	7-4 3-0	- 8-0	12-0 -	2 -	2 -	1 -	1 -	- 2	- 2	- 1	- 1
1	1	0	1	1	2	4	1	32	A B	7-4 3-0	7 3	7-4 3-0	- 8-0	12-0 -	8 -	2 -	4 -	1 -	- 8	- 2	- 4	- 1

SPECIAL  
FUNCTION

6



During reference register loading, the 8-bits, DREF0-7 are used as reference data inputs. The falling edge of RLOAD# initiates reference data loading; when RLOAD# returns high, the data on DREF0-7 is latched into the selected correlation stages. The active bits on DREF0-7 are controlled by the current configuration.

The window configuration is determined by the state of control signals upon programming the control register. Table 3 represents the programming information required for each window configuration. In Table 3, note that the data listed for Output Weighting refers to the weights given to each of the Correlation Sum Outputs (CO0-7 in Figure 1).

During initialization, the loading configuration for the reference data is set by the user. Table 3 shows the loading options. These load controls specify whether the reference data for a given stage comes from the shift register output of the previous stage or from an external data pin.

## Applications

### Single HSP45256 – 1-Bit Data, 256 Samples

A 1 x 256 (1-D configuration) correlation requires only 1 HSP45256. To initialize the correlator, all the reference bits, control bits, the delay value of the variable delay, and the window configuration must be specified.

TABLE 4. REGISTER CONTENTS FOR 1 X 256 CORRELATOR WITH EQUAL WEIGHTING

A0-2	DCONT0-7	NOTES
001	00000000	1 256-tap correlator: 1 x 256 window configuration, reference loaded from DREF7, eight stages weighted equally, DIN 7 and DOUT7 are the data input and output, respectively.
010	00000000	Offset Register A = 0
011	00000000	
100	00000000	Programmable Delay = 0
101	00000000	Offset Register B = 0 (Loading of this register optional in this mode.)
110	00000000	

The loading of the reference and mask registers may be done simultaneously by setting A0-2 = 000, setting the DREF and DCONT inputs to their proper values and pulsing RLOAD# and CLOAD# low. In this configuration, DREF7 loads the reference data and DCONT7 loads the mask information; both sets of data are loaded serially. It will take 256 load pulses (RLOAD#) to load the reference array, and 256 CLOAD# pulses to load the mask array. Upon completion of the mask and register loading, TXFR# is pulsed low, which transfers the reference and control data from the preload registers to the reference and mask registers, updating the data that will be used in the correlation. Reference and mask data can be loaded more quickly by configuring the correlator as an 8 row by 32 sample array, loading the bits eight at a time, then changing the configuration back to 1 x 256 to perform the correlation.

### Single HSP45256 – 8-Bit Data, 32 Samples

An 8 x 32 correlation also requires only 1 HSP45256. To initialize the correlator, all the reference bits, control bits, the value of the programmable delay, and the window configuration must be specified.

Again, the loading of the reference and mask registers can be done simultaneously. Due to the programming initialization, DREF0-7 are used to load the reference data 8-bits at a time. It will take 32 load pulses each of RLOAD# and CLOAD# to load both arrays. Upon completion of the mask and register loading, TXFR# is pulsed low, which transfers the reference and control data from the preload registers to the registers that store the active data.

TABLE 5. REGISTER LOADING FOR 8 X 32 CORRELATOR WITH BINARY WEIGHTING

A0-2	DCONT0-7	NOTES
001	00001111	1 256-tap correlator; 8 x 32 window configuration, 8-bit data stream; reference register is loaded from DREF7 for all stages. Correlator score = $(128 \times CO7) + (64 \times CO3) + (32 \times CO5) + (16 \times CO1) + (8 \times CO6) + (4 \times CO4) + (2 \times CO2) + CO0$
010	00000000	Offset Register A = 0000000010000
011	00010000	
100	00000000	Programmable Delay = 0
101	00000000	Offset Register B = 0 (Loading optional in this mode.)
110	00000000	

This configuration performs correlation of an 8-bit number with a 1-bit reference. Each byte out of the correlation array gives an 8-bit level of confidence that the data corresponds to the reference. The correlation score is the sum of these confidence levels.

### Single HSP45256 – Dual Correlators, 2-Bit Data, 64 Samples

Dual 2 x 64 correlators require only one HSP45256. To initialize the correlator, all the reference bits, control bits, the delay value of the variable delay, and the window configuration must be specified.

In this example, each of the dual correlators compares 2-bit data to a 1-bit reference. It will take 64 load pulses (RLOAD#/CLOAD#) to completely load the reference and mask registers in the array. The programmable delay must be set to 0 for the output of the two correlators to be aligned.

**TABLE 6. REGISTER LOADING FOR DUAL 2 X 64  
CORRELATORS WITH EQUAL WEIGHTING**

AO-2	DCONT0-7	NOTES
001	00010010	Dual correlators: each 2 bit data, 64 taps; reference register for correlation A is loaded from DREF7 and DREF5, the reference register for correlator B is loaded from DREF3 and DREF1. Correlator #1 = $2 \times CO7 + 2 \times CO6 + CO5 + CO4$ , correlator #2 = $2 \times CO3 + 2 \times CO2 + CO1 + CO0$ .
010	00000000	Offset Register A = 0000000010000
011	00010000	
100	00000000	Programmable Delay = 0
101	00000000	Offset Register B = 0
110	00000000	

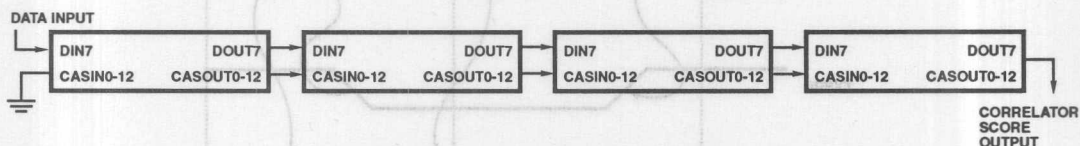
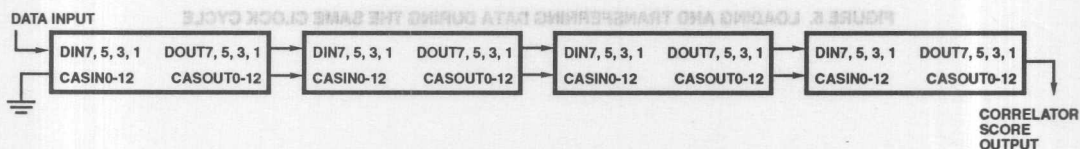
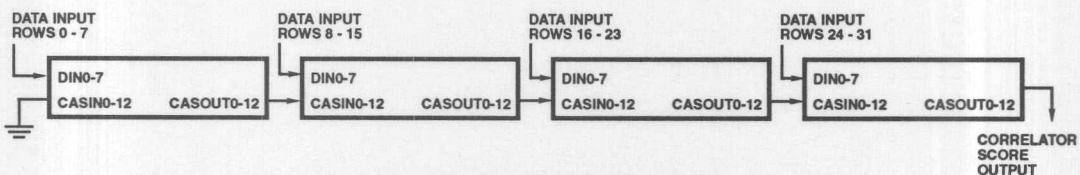
### Cascading Correlators

Correlators can be cascaded in either a serial or parallel fashion. Longer correlations can be achieved by connecting several correlators together as shown in Figure 2. Each correlator is in a one data bit, one row, 256 tap configuration. The number of bits of significance at the CASOUT output of each correlator builds up from one correlation to the next,

that is, the maximum score out of the first correlator is 256, the maximum output of the second correlator is 512, etc. In this configuration, the maximum length of the correlation is 4096. This would be implemented with 16 HSP45256's. The programmable delay register in the first correlator would be set for one delay, the second would be set for two, and so on, with the final HSP45256 being set for a delay of 16.

Correlations of more bits can be calculated by connecting CASOUT of each chip to the CASIN of the following chip (Figure 3). The data on the CASOUT lines accumulates in a similar manner as in the 1 x 256 mode, except that the maximum output of the first correlator is decimal 960, (hexadecimal 3C0); in the general case, the maximum number of correlators that can be cascaded in this manner is eight, since the maximum output of the last one would be 1E00, which nearly uses up the 13-bit range of the cascade summer. More parts could be cascaded together if some bits are to be masked out or if the user has a prior knowledge of the maximum value of the correlation score. As before, the delay in the first correlator would be set to one, the second correlator would be set for a delay of two, and so on.

Multiple HSP45256's can be cascaded for two dimensional one bit data (Figure 4). The maximum output for each chip is the same as in the 1 x 256 case; the only difference is in the manner in which the correlators are connected. The programmable delay registers would be set as before.


**FIGURE 2. 1 BIT, 1024 SAMPLE CONFIGURATION**

**FIGURE 3. 4 BIT, 256 SAMPLE CONFIGURATION**

**FIGURE 4. 1 BIT, 32 X 32 WINDOW CONFIGURATION**

### Reloading Data During Operation

RLOAD# and CLOAD# are asynchronous signals that are designed to be driven by the memory interface signals of a microprocessor. TXFR# is synchronized to CLK so that the mask or reference data is updated on a specific clock cycle. In the normal mode of operation, the user loads the reference and mask memories, then pulses TXFR# to use that data. The correlator uses the new mask or reference information immediately. Loading of the reference and mask data remains asynchronous as long as there is at least one cycle of CLK between the rising edge of RLOAD# or CLOAD# and the TXFR# pulse.

If the system timing makes it necessary for TXFR# and RLOAD# and/or CLOAD# to be active during the same clock cycle, then they must be treated as synchronous signals; the timing for this case is shown in Figure 5 and given in the AC Timing Specifications ( $T_{THCL}$  and  $T_{CLLH}$ ). In this example, data is loaded during clock cycle 1 and transferred on the rising edge of CLK that occurs in clock cycle two. Another set of data is loaded during clock cycle 2, which will be transferred by a later TXFR# pulse. The sequence of events is as follows:

1. In clock cycle 1, TXFR# becomes active at least  $T_{TH}$  nanoseconds after the rising edge of CLK.
2. RLOAD and/or CLOAD# pulses low; the timing is not critical as long as its rising edge occurs before the end of clock cycle 1. If this condition is not met, it is undetermined whether the data loaded by this pulse will be transferred by the current TXFR# pulse.
3. The rising edge of TXFR# occurs while CLK is high during clock cycle 2. The margin between the rising edge of TXFR# and the falling edge of CLK is defined by  $T_{THCL}$ .
4. RLOAD# and/or CLOAD# pulses low. The rising edge of RLOAD# and CLOAD# must occur after the falling edge of CLK. The margin between the two is defined by  $T_{CLLH}$ .

The time from the rising edge of TXFR# to the falling edge of CLK must be greater than  $T_{THCL}$ , and the time from the falling edge of CLK to the rising edge of RLOAD# or CLOAD# must be greater than  $T_{CLLH}$ . If this timing is violated, the data being transferred by the TXFR# pulse shown may or may not include the data loaded in clock cycle 2.

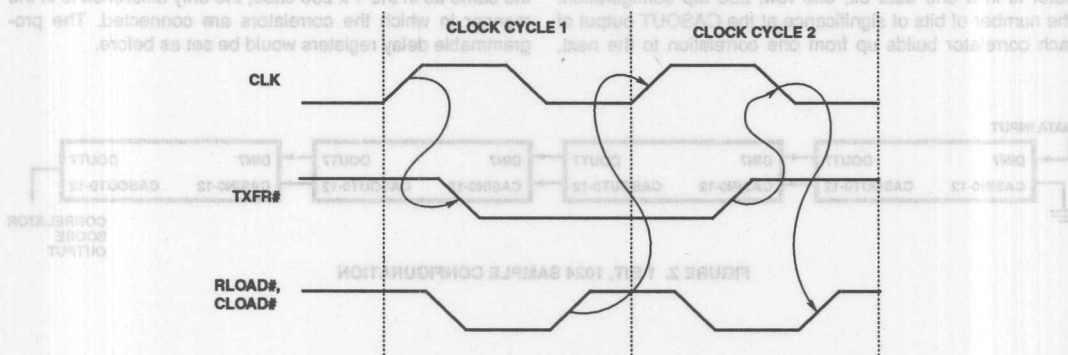
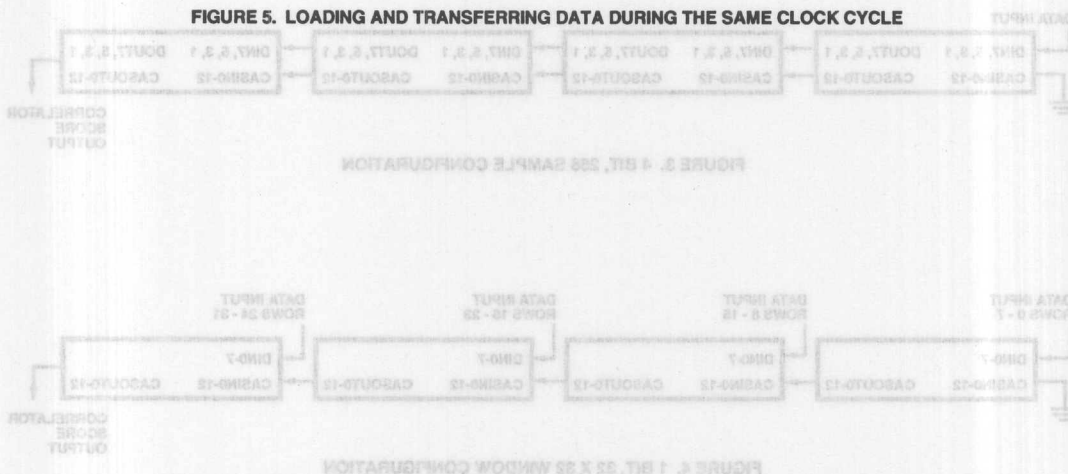


FIGURE 5. LOADING AND TRANSFERRING DATA DURING THE SAME CLOCK CYCLE



## Specifications HSP45256

### Absolute Maximum Ratings

Supply Voltage	.....+8.0V	Thermal Resistance	$\theta_{JA}$	$\theta_{JC}$
Input, Output or I/O Voltage	.....GND-0.5V to $V_{CC}+0.5V$	PLCC Package	34°C/W	11.3°C/W
Storage Temperature Range	.....-65°C to +150°C	PGA Package	36°C/W	10°C/W
Junction Temperature	.....+150°C (PLCC), +175°C (PGA)	Maximum Package Power Dissipation at +125°C		
Lead Temperature (Soldering 10s)	.....+300°C	PLCC Package	.....2.2W	
ESD Classification	.....Class 1	PGA Package	.....2.9W	
		Gate Count	.....13,000 Gates	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### Operating Conditions

Operating Voltage Range	.....+4.75V to +5.25V	Operating Temperature Range	.....0°C to +70°C
-------------------------	-----------------------	-----------------------------	-------------------

### DC Electrical Specifications

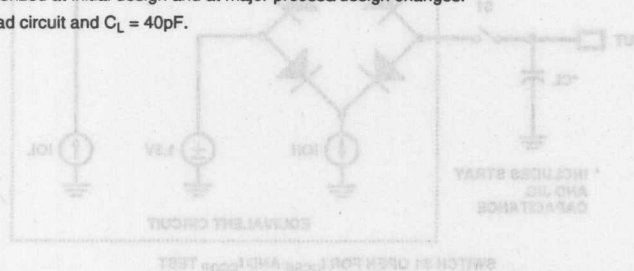
PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Logical One Input Voltage	$V_{IH}$	2.0	-	V	$V_{CC} = 5.25V$
Logical Zero Input Voltage	$V_{IL}$	-	0.8	V	$V_{CC} = 4.75V$
High Level Clock Input	$V_{IHC}$	3.0	-	V	$V_{CC} = 5.25V$
Low Level Clock Input	$V_{ILC}$	-	0.8	V	$V_{CC} = 4.75V$
Output High Voltage	$V_{OH}$	2.6	-	V	$I_{OH} = 400\mu A$ , $V_{CC} = 4.75V$
Output Low Voltage	$V_{OL}$	-	0.4	V	$I_{OL} = +2.0mA$ , $V_{CC} = 4.75V$
Input Leakage Current	$I_I$	-10	10	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$
Output Leakage Current	$I_O$	-10	10	$\mu A$	$V_{OUT} = V_{CC}$ or GND, $V_{CC} = 5.25V$
Standby Power Supply Current	$I_{CCSB}$	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Note 3
Operating Power Supply Current	$I_{CCOP}$	-	179	mA	$f = 25.6MHz$ , $V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Note 1, Note 3

### Capacitance ( $T_A = 25^\circ C$ , Note 2)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Input Capacitance	$C_{IN}$	-	10	pF	Frequency = 1MHz, $V_{CC} = \text{Open}$ All measurements are referenced to device ground.
Output Capacitance	$C_O$	-	10	pF	

#### NOTES:

1. Power supply current is proportional to operating frequency. Typical rating for ICCOP is 7mA/MHz.
2. Not tested, but characterized at initial design and at major process/design changes.
3. Output load per test load circuit and  $C_L = 40pF$ .





## Specifications HSP45256

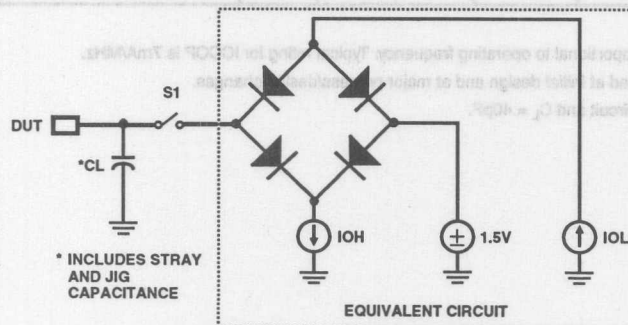
### AC Electrical Specifications $(V_{CC} = 5.0V \pm 5\%, T_A = 0^\circ C \text{ to } +70^\circ C, \text{ Note 1})$

PARAMETER	SYMBOL	33MHz		25.6MHz		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
CLK Period	$T_{CP}$	30	-	39	-	ns	
CLK High	$T_{CH}$	12	-	15	-	ns	
CLK Low	$T_{CL}$	12	-	15	-	ns	
Set-Up Time DIN to CLK High	$T_{DS}$	12	-	13	-	ns	
Hold Time CLK High to DIN	$T_{DH}$	0	-	0	-	ns	
TXFR# Set-Up Time	$T_{TS}$	12	-	13	-	ns	
TXFR# Hold Time	$T_{TH}$	0	-	0	-	ns	
Output Delay DOUT, AUXOUT, CASOUT	$T_{DO}$	-	-	-	20	ns	
CLOAD# Cycle Time	$T_{CLC}$	30	15	39	-	ns	
CLOAD# High	$T_{CLH}$	12	-	15	-	ns	
CLOAD# Low	$T_{CLL}$	12	-	15	-	ns	
Set-Up Time, A to RLOAD#, CLOAD#	$T_{AS}$	12	-	13	-	ns	
Hold Time, RLOAD#, CLOAD# to A	$T_{AH}$	0	-	0	-	ns	
RLOAD# Cycle Time	$T_{RLC}$	30	-	39	-	ns	
RLOAD# High	$T_{RLH}$	12	-	15	-	ns	
RLOAD# Low	$T_{RLL}$	12	-	15	-	ns	
Set-Up Time, DCONT to CLOAD#	$T_{DCS}$	12	-	13	-	ns	
Hold Time, CLOAD# to DCONT	$T_{DCH}$	0	-	0	-	ns	
Set-Up Time, DREF to RLOAD#	$T_{RS}$	12	-	13	-	ns	
Hold Time, RLOAD# to DREF	$T_{RH}$	0	-	0	-	ns	
Output Enable Time	$T_{OE}$	-	15	-	15	ns	
Output Disable Time	$T_{OD}$	-	15	-	15	ns	Note 2
Output Rise, Fall Time	$T_{RF}$	-	6	-	6	ns	Note 2
TXFR# High to CLK Low	$T_{THCL}$	3	-	3	-	ns	Note 2
CLK Low to RLOAD#, CLOAD# High	$T_{CLLH}$	1	-	1	-	ns	Note 2

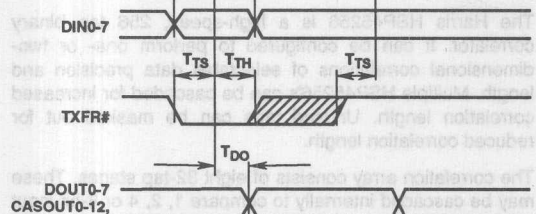
#### NOTES:

1. AC testing is performed as follows: Input levels (CLK Input) 4.0V and 0V; Input levels (all other inputs) 0V and 3.0V; Timing reference levels (CLK) 2.0V; All others 1.5V. Output load per test load circuit with  $C_L = 40pF$ . Output transition is measured at  $V_{OH} > 1.5V$  and  $V_{OL} < 1.5V$ .
2. Controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.

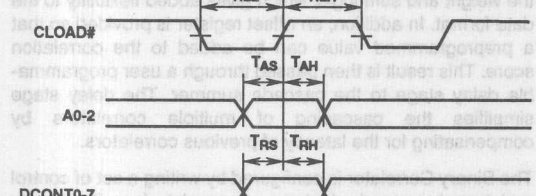
### Test Load Circuit



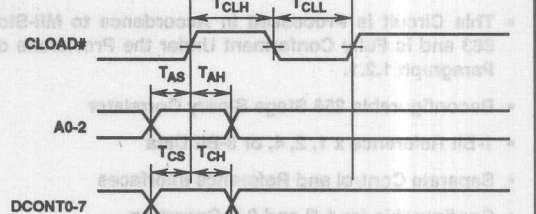
SWITCH S1 OPEN FOR  $I_{CCSB}$  AND  $I_{CCOP}$  TEST



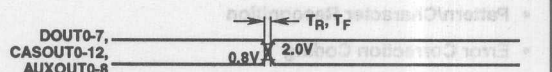
### INPUT, OUTPUT TIMING



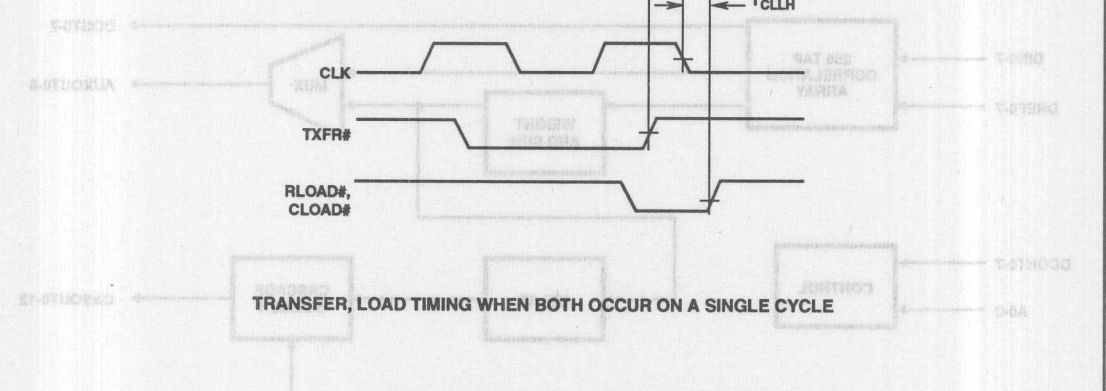
## REFERENCE INPUT TIMING



### CONTROL INPUT TIMING



### OUTPUT TIMING



### TRANSFER, LOAD TIMING WHEN BOTH OCCUR ON A SINGLE CYCLE

August 1992

## Binary Correlator

### Features

- This Circuit is Processed in Accordance to Mil-Std-883 and is Fully Conformant Under the Provisions of Paragraph 1.2.1.
- Reconfigurable 256 Stage Binary Correlator
- 1-Bit Reference x 1, 2, 4, or 8-Bit Data
- Separate Control and Reference Interfaces
- Configurable for 1-D and 2-D Operation
- Double Buffered Mask and Reference
- Programmable Output Delay
- Cascadable
- Standard Microprocessor Interface
- 85-pin PGA

### Applications

- Radar/Sonar
- Spread Spectrum Communications
- Pattern/Character Recognition
- Error Correction Coding

### Description

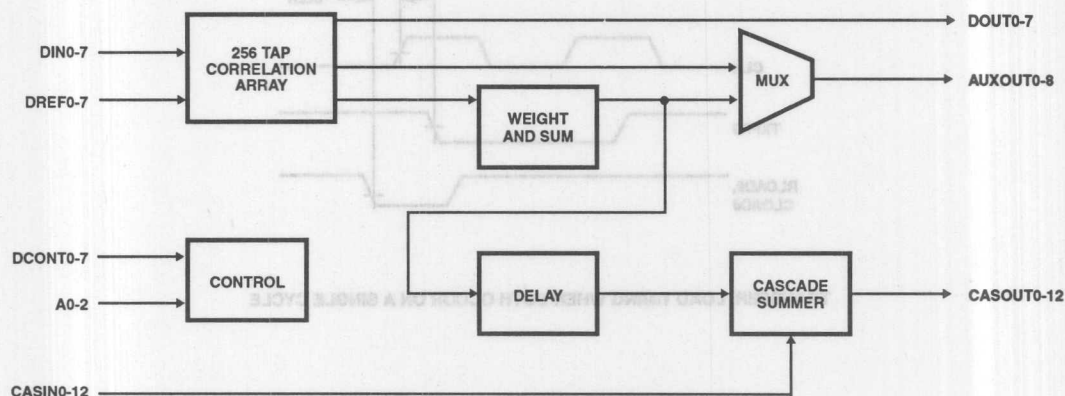
The Harris HSP45256 is a high-speed, 256 tap binary correlator. It can be configured to perform one- or two-dimensional correlations of selectable data precision and length. Multiple HSP45256's can be cascaded for increased correlation length. Unused taps can be masked out for reduced correlation length.

The correlation array consists of eight 32-tap stages. These may be cascaded internally to compare 1, 2, 4 or 8-bit input data with a 1-bit reference. Depending on the number of bits in the input data, the length of the correlation can be up to 256, 128, 64, or 32 taps. The HSP45256 can also be configured as two separate correlators with window sizes from 4 by 32 to 1 by 128 each. The mask register can be used to prevent any subset of the 256 bits from contributing to the correlation score.

The output of the correlation array (correlation score) feeds the weight and sum logic, which gives added flexibility to the data format. In addition, an offset register is provided so that a preprogrammed value can be added to the correlation score. This result is then passed through a user programmable delay stage to the cascade summer. The delay stage simplifies the cascading of multiple correlators by compensating for the latency of previous correlators.

The Binary Correlator is configured by writing a set of control registers via a standard microprocessor interface. To simplify operation, both the control and reference registers are double buffered. This allows the user to load new mask and reference data while the current correlation is in progress.

### Block Diagram



## Pinouts

85 PIN PGA  
TOP VIEW

	1	2	3	4	5	6	7	8	9	10	11
A	CASIN 2	CASIN 4	CASIN 5	CASIN 7	CASIN 10	CASIN 11	CAS OUT 0	CAS OUT 3	CAS OUT 5	GND	CAS OUT 8
B	GND	CASIN 1	CASIN 3	CASIN 6	CASIN 9	CAS OUT 2	CAS OUT 1	CAS OUT 4	CAS OUT 6	CAS OUT 7	CAS OUT 10
C	CLK	CASIN 0	INDEX PIN		CASIN 8	CASIN 12	OEC#			CAS OUT 9	CAS OUT 11
D	DIN7	VCC								GND	CAS OUT 12
E	DIN4	DIN5	DIN6						DOUT0	DOUT1	DOUT2
F	DREF 6	DIN3	DIN2						DOUT 4	DOUT 7	DOUT 3
G	DIN0	DREF 7	DIN1						VCC	DOUT 6	DOUT 5
H	DREF 5	DREF 4								AUX OUT 1	AUX OUT 0
J	DREF 3	DREF 1		A1	DCONT 5	DCONT 4				GND	AUX OUT 2
K	DREF 2	VCC	R LOAD#	C LOAD#	A0	DCONT 6	DCONT 2	OEA#	AUX OUT 6	AUX OUT 4	AUX OUT 3
L	DREF 0	GND	TXFR#	A2	DCONT 7	DCONT 1	DCONT 3	DCONT 0	AUX OUT 8	AUX OUT 7	AUX OUT 5

85 PIN PGA  
BOTTOM VIEW

L	DREF0	GND	TXFR#	A2	DCONT 7	DCONT 1	DCONT 3	DCONT0	AUXOUT 8	AUXOUT 7	AUXOUT 5
K	DREF2	VCC	RLOAD#	CLOAD#	A0	DCONT 6	DCONT 2	OEA#	AUXOUT 6	AUXOUT 4	AUXOUT 3
J	DREF3	DREF1		A1	DCONT 5	DCONT 4				GND	AUXOUT 2
H	DREF5	DREF4								AUXOUT 1	AUXOUT 0
G	DIN0	DREF7	DIN1					VCC	DOUT6	DOUT5	
F	DREF6	DIN3	DIN2					DOUT4	DOUT7	DOUT3	
E	DIN4	DIN5	DIN6					DOUT0	DOUT1	DOUT2	
D	DIN7	VCC							GND	CASOUT 12	
C	CLK	CASIN0	INDEX PIN		CASIN 8	CASIN 12	OEC#		CASOUT 9	CASOUT 11	
B	GND	CASIN1	CASIN3	CASIN6	CASIN 9	CASOUT 2	CASOUT 1	CASOUT 4	CASOUT 6	CASOUT 7	CASOUT 10
A	CASIN 2	CASIN 4	CASIN 5	CASIN 7	CASIN 10	CASIN 11	CASOUT 0	CASOUT 3	CASOUT 5	GND	CASOUT 8



## Pin Description

SYMBOL	PIN NUMBER	TYPE	DESCRIPTION
V <sub>CC</sub>	D2, G9, K2		The +5V power supply pin
GND	A10, B1, D10, J10, L2		Ground.
DIN0-7	D1, E1-E3, F2, F3, G1, G3	I	The DIN0-7 bus consists of eight single data input pins. The assignment of the active pins is determined by the configuration. Data is loaded synchronous to the rising edge of CLK. DIN0 is the LSB.
DOUT0-7	E9-E11, F9-F11, G10, G11	O	The DOUT0-7 bus is the data output of the correlation array. The format of the output is dependent on the window configuration and bit weighting. DOUT0 is the LSB.
CLK	C1	I	System clock. Positive edge triggered.
CASIN0-12	A1-A6, B2-B5, C2, C5, C6	I	CASIN0-12 allows multiple correlators to be cascaded by connecting CASOUT0-12 of one correlator to CASIN0-12 of another. The CASIN bus is added internally to the correlation score to form CASOUT. CASIN0 is the LSB.
CASOUT0-12	A7-A9, A11, B6-B11, C10, C11, D11	O	CASOUT0-12 is the output correlation score. This value is the delayed sum of all the 256 taps of one chip and CASIN0-12. When the part is configured to act as two independent correlators, CASOUT0-8 represents the correlation score for the first correlator while the second correlation score is available on the AUXOUT0-8 bus. In this configuration, the cascading feature is no longer an option. CASOUT0 is the LSB.
OEC#	C7	I	OEC# is the output enable for CASOUT0-12. When OEC# is high, the output is three-stated. Processing is not interrupted by this pin. (Active low.)
TXFR#	L3	I	TXFR# is a synchronous clock enable signal that allows the loading of the reference and mask inputs from the preload register to the correlation array. Data is transferred on the rising edge of CLK while TXFR# is low. (Active low.)
DREF0-7	F1, G2, H1, H2, J1, J2, K1, L1	I	DREF0-7 is an 8-bit wide data reference input. This is the input data bus used to load the reference data. RLOAD# going active initiates the loading of the reference registers. This input bus is used to load the reference registers of the correlation array. The manner in which the reference data is loaded is determined by the window configuration. If the window configuration is 1 x 256, the reference bits are loaded one at a time over DREF7. When the HSP45256 is configured as an 8 x 32 array, the data is loaded into all stages in parallel. In this case, DREF7 is the reference data for the first stage and DREF0 is the reference data for the eighth stage. The contents of the reference data registers are not affected by changing the window configuration. DREF0 is the LSB.
RLOAD#	K3	I	RLOAD# enables loading of the reference registers. Data on DREF0-7 is loaded into the preload registers on the rising edge of RLOAD#. This data is transferred into the correlation array by TXFR#. (Active low.)
DCONT0-7	J6, J7, K6, K7, L5-L8	I	DCONT0-7 is the control data input, which is used to load the mask bit for each tap as well as the configuration registers. The mask data is sequentially loaded into the eight stages in the same manner as the reference data. DCONT0 is the LSB.
CLOAD#	K4	I	CLOAD# enables the loading of the data on DCONT0-7. The destination of this data is controlled by A0-2. (Active low.)
A0-2	J5, K5, L4	I	A0-2 is a 3-bit address that determines what function will be performed when CLOAD# is active. This address bus is set up with respect to the rising edge of the load signal, CLOAD#. A0 is the LSB.
AUXOUT0-8	H10, H11, J11, K9-K11, L9-L11	O	AUXOUT0-8 is a 9-bit bus that provides either the data reference output or the 9-bit correlation score of the second correlator, depending on the configuration. When the user programs the chip to be two separate correlators, the score of the second correlator is output on this bus. When the user has programmed the chip to be one correlator, AUXOUT0-7 represents the reference data out, with the state of AUXOUT0-8 undefined. AUXOUT0 is the LSB.
OEA#	K8	I	The OEA# signal is the output enable for the AUXOUT0-8 output. When OEA# is high, the output is disabled. Processing is not interrupted by this pin. (Active low.)
Index Pin	C3		Used for orienting pin in socket or printed circuit board. Must be left as a no connect in circuit.

# Specifications HSP45256/883

## Absolute Maximum Ratings

Supply Voltage	+8.0V
Input, Output or I/O Voltage	GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range	-65°C to +150°C
Junction Temperature	+175°C
Lead Temperature (Soldering 10s)	+300°C
ESD Classification	Class 1

## Reliability Information

Thermal Resistance	$\theta_{ja}$	$\theta_{jc}$
Ceramic PGA Package	36°C/W	10°C/W
Maximum Package Power Dissipation at +125°C		
Ceramic PGA Package	1.39 W	
Gate Count	13,000 Gates	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range	+4.5V to +5.5V	Operating Temperature Range	-55°C to +125°C
-------------------------	----------------	-----------------------------	-----------------

TABLE 1. DC ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	CONDITIONS	GROUP A SUB- GROUPS	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Logical One Input Voltage	$V_{IH}$	$V_{CC} = 5.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	2.2	-	V
Logical Zero Input Voltage	$V_{IL}$	$V_{CC} = 4.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	0.8	V
Logical One Input Voltage Clock	$V_{IHC}$	$V_{CC} = 5.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	3.0	-	V
Logical Zero Input Voltage Clock	$V_{ILC}$	$V_{CC} = 4.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	0.8	V
Output HIGH Voltage	$V_{OH}$	$I_{OH} = -400\mu A$ $V_{CC} = 4.5V$ (Note 1)	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	2.6	-	V
Output LOW Voltage	$V_{OL}$	$I_{OL} = +2.0mA$ $V_{CC} = 4.5V$ (Note 1)	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	0.4	V
Input Leakage Current	$I_I$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Output Leakage Current	$I_O$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-10	+10	$\mu A$
Standby Power Supply Current	$I_{CCSB}$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.5V$ , Outputs Open	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	500	$\mu A$
Operating Power Supply Current	$I_{CCOP}$	$f = 20 MHz$ , $V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.5V$ (Note 2)	1,2,3	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	140	mA
Functional Test	FT	(Note 3)	7,8	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	-	

### NOTES:

- Interchanging of force and sense conditions is permitted.
- Operating Supply Current is proportional to frequency, typical rating is 7mA/MHz.
- Tested as follows:  $f = 1MHz$ ,  $V_{IH}(\text{clock inputs}) = 3.4V$ ,  $V_{IH}(\text{all other inputs}) = 2.6V$ ,  $V_{IL} = 0.4V$ ,  $V_{OH} \geq 1.5V$ , and  $V_{OL} \leq 1.5V$ .

6

SPECIAL  
FUNCTION

# Specifications HSP45256/883

TABLE 2. AC ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Guaranteed and 100% Tested

PARAMETER	SYMBOL	(NOTE 1) CONDITIONS	GROUP A SUB- GROUPS	TEMPERATURE	-25 (25.6MHz)		-20 (20MHz)		UNITS
					MIN	MAX	MIN	MAX	
CLK Period	T <sub>CP</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	39	-	50	-	ns
CLK High	T <sub>CH</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
CLK Low	T <sub>CL</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
CLOAD# Cycle Time	T <sub>CLC</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	39	-	50	-	ns
CLOAD# High	T <sub>CLH</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
CLOAD# Low	T <sub>CLL</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
RLOAD# Cycle Time	T <sub>RLC</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	39	-	50	-	ns
RLOAD# High	T <sub>RLH</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
RLOAD# Low	T <sub>RLL</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	15	-	20	-	ns
Set-up Time; DIN to CLK High	T <sub>DS</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	13	-	15	-	ns
Hold Time; DIN to CLK High	T <sub>DH</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	1	-	1	-	ns
Set-up Time; DREF to RLOAD High	T <sub>RS</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	14	-	15	-	ns
Hold Time; DREF to RLOAD High	T <sub>RH</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	1	-	1	-	ns
DCONT Set up Time	T <sub>DCS</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	13	-	15	-	ns
DCONT Hold Time	T <sub>DCH</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	1	-	1	-	ns
Address Set up Time	T <sub>AS</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	13	-	15	-	ns
Address Hold Time	T <sub>AH</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	1	-	1	-	ns
TXFR# Set up Time	T <sub>TS</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	13	-	15	-	ns
TXFR# Hold Time	T <sub>TH</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	1	-	1	-	ns
CLK to Output Delay DOUT, AUXOUT, CASOUT	T <sub>DO</sub>		9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	-	20	-	25	ns
Output Enable Time	T <sub>OE</sub>	Note 2	9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	-	20	-	20	ns
TXFR# High to CLK Low	T <sub>THCL</sub>	Note 3	9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	3	-	4	-	ns
CLK Low to RLOAD#, CLOAD# High	T <sub>CLLH</sub>	Note 3	9, 10, 11	-55° ≤ T <sub>A</sub> ≤ +125°C	1	-	1	-	ns

## NOTES:

- AC testing is performed as follows: V<sub>CC</sub> = 4.5V and 5.5V. Input levels (CLK Input) 4.0V and 0V; Input levels (all other inputs) 3.0V and 0V; Timing reference levels (CLK) 2.0V; All others 1.5V. Output load per test load circuit with C<sub>L</sub> = 40pF. Output transition is measured at V<sub>OH</sub> ≥ 1.5V and V<sub>OL</sub> ≤ 1.5V.
- Transition is measured at ±200mV from steady state voltage, Output loading per test load circuit, C<sub>L</sub> = 40pF.
- Applicable only when TXFR# and RLOAD# or CLOAD# are active on the same cycle of CLK.

# Specifications HSP45256/883

TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS

PARAMETER	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	-25		-20		UNITS
					MIN	MAX	MIN	MAX	
Input Capacitance	$C_{IN}$	VCC = Open, f=1 MHz All measurements are referenced to device GND.	1	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	10	-	10	pF
Output Capacitance	$C_{OUT}$		1	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	10	-	10	pF
Output Disable Time	$T_{OD}$		1, 2	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	20	-	20	ns
Output Rise Time	$T_R$	From 0.8V to 2.0V	1, 2	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	8	-	8	ns
Output Fall Time	$T_F$	From 2.0V to 0.8V	1, 2	$-55^{\circ} \leq T_A \leq +125^{\circ}C$	-	8	-	8	ns

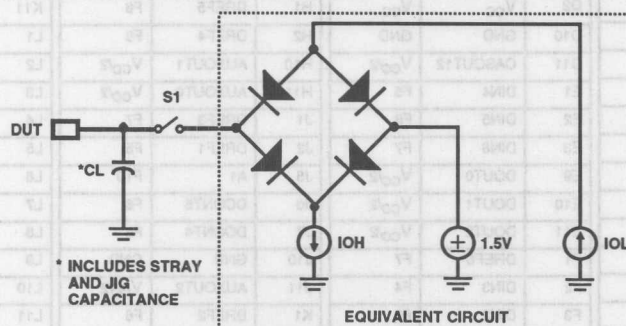
## NOTES:

- The parameters in Table 3 are controlled via design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.
- Loading is as specified in the test load circuit with  $C_L = 40pF$ .

TABLE 4. APPLICABLE SUBGROUPS

CONFORMANCE GROUPS	METHOD	SUBGROUPS
Initial Test	100%/5004	-
Interim Test	100%/5004	-
PDA	100%	1
Final Test	100%	2, 3, 8A, 8B, 10, 11
Group A	-	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Groups C and D	Samples/5005	1, 7, 9

## Test Load Circuit



SWITCH S1 OPEN FOR  $I_{CCSB}$  AND  $I_{CCOP}$  TEST



## Burn-In Circuits

	1	2	3	4	5	6	7	8	9	10	11
A	CASIN 2	CASIN 4	CASIN 5	CASIN 7	CASIN 10	CASIN 11	CAS OUT 0	CAS OUT 3	CAS OUT 5	GND	CAS OUT 8
B	GND	CASIN 1	CASIN 3	CASIN 6	CASIN 9	CAS OUT 2	CAS OUT 1	CAS OUT 4	CAS OUT 6	CAS OUT 7	CAS OUT 10
C	CLK	CASIN 0	INDEX PIN		CASIN 8	CASIN 12	OEC#			CAS OUT 9	CAS OUT 11
D	DIN7	V <sub>CC</sub>								GND	CAS OUT 12
E	DIN4	DIN5	DIN6						DOUT0	DOUT1	DOUT2
F	DREF 4	DIN3	DIN2						DOUT 4	DOUT 7	DOUT 3
G	DIN0	DREF 7	DIN1						V <sub>CC</sub>	DOUT 6	DOUT 5
H	DREF 5	DREF 4								AUX OUT 1	AUX OUT 0
J	DREF 3	DREF 1			A1	DCONT 5	DCONT 4			GND	AUX OUT 2
K	DREF 2	V <sub>CC</sub>	R LOAD#	C LOAD#	A0	DCONT 6	DCONT 2	OEA#	AUX OUT 6	AUX OUT 4	AUX OUT 3
L	DREF 0	GND	TXFR#	A2	DCONT 7	DCONT 1	DCONT 3	DCONT 0	AUX OUT 8	AUX OUT 7	AUX OUT 5

85 PIN PGA  
TOP VIEW

PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL	PGA PIN	PIN NAME	BURN-IN SIGNAL
A1	CASIN2	F3	B11	CASOUT10	V <sub>CC</sub> /2	F9	DOUT4	V <sub>CC</sub> /2	K2	V <sub>CC</sub>	V <sub>CC</sub>
A2	CASIN4	F5	C1	CLK	F0	F10	DOUT7	V <sub>CC</sub> /2	K3	RLOAD#	F3
A3	CASIN5	F6	C2	CASIN0	F1	F11	DOUT3	V <sub>CC</sub> /2	K4	CLOAD#	F3
A4	CASIN7	F1	C5	CASIN8	F2	G1	DIN0	F1	K5	A0	F9
A5	CASIN10	F4	C6	CASIN12	F6	G2	DREF7	F8	K6	DCONT6	F7
A6	CASIN11	F5	C7	OEC#	F11	G3	DIN1	F2	K7	DCONT2	F6
A7	CASOUT0	V <sub>CC</sub> /2	C10	CASOUT9	V <sub>CC</sub> /2	G9	V <sub>CC</sub>	V <sub>CC</sub>	K8	OEA#	F11
A8	CASOUT3	V <sub>CC</sub> /2	C11	CASOUT11	V <sub>CC</sub> /2	G10	DOUT6	V <sub>CC</sub> /2	K9	AUXOUT6	V <sub>CC</sub> /2
A9	CASOUT5	V <sub>CC</sub> /2	D1	DIN7	F8	G11	DOUT5	V <sub>CC</sub> /2	K10	AUXOUT4	V <sub>CC</sub> /2
A10	GND	GND	D2	V <sub>CC</sub>	V <sub>CC</sub>	H1	DREF5	F6	K11	AUXOUT3	V <sub>CC</sub> /2
A11	CASOUT8	V <sub>CC</sub> /2	D10	GND	GND	H2	DREF4	F8	L1	DREF0	F4
B1	GND	GND	D11	CASOUT12	V <sub>CC</sub> /2	H10	AUXOUT1	V <sub>CC</sub> /2	L2	GND	GND
B2	CASIN1	F2	E1	DIN4	F5	H11	AUXOUT0	V <sub>CC</sub> /2	L3	TXFR#	F2
B3	CASIN3	F4	E2	DIN5	F6	J1	DREF3	F7	L4	A2	F11
B4	CASIN6	F7	E3	DIN6	F7	J2	DREF1	F5	L5	DCONT7	F8
B5	CASIN9	F3	E9	DOUT0	V <sub>CC</sub> /2	J5	A1	F10	L6	DCONT1	F5
B6	CASOUT2	V <sub>CC</sub> /2	E10	DOUT1	V <sub>CC</sub> /2	J6	DCONT5	F6	L7	DCONT3	F7
B7	CASOUT1	V <sub>CC</sub> /2	E11	DOUT2	V <sub>CC</sub> /2	J7	DCONT4	F8	L8	DCONT0	F4
B8	CASOUT4	V <sub>CC</sub> /2	F1	DREF6	F7	J10	GND	GND	L9	AUXOUT8	V <sub>CC</sub> /2
B9	CASOUT6	V <sub>CC</sub> /2	F2	DIN3	F4	J11	AUXOUT2	V <sub>CC</sub> /2	L10	AUXOUT7	V <sub>CC</sub> /2
B10	CASOUT7	V <sub>CC</sub> /2	F3	DIN2	F3	K1	DREF2	F6	L11	AUXOUT5	V <sub>CC</sub> /2

## NOTES:

1. V<sub>CC</sub>/2 (2.7V ±10%) used for outputs only.
2. 47kΩ (±20%) resistor connected to all pins except V<sub>CC</sub> and GND.
3. V<sub>CC</sub> = 5.5 ± 0.5V.
4. 0.1μF (min) capacitor between V<sub>CC</sub> and GND per position.
5. FO = 100kHz ± 10%, F1 = F0/2, F2 = F1/2 ... F11 = F10/2, 40 - 60% Duty Cycle.
6. Input Voltage Limits: V<sub>IL</sub> = 0.8V max, V<sub>IH</sub> = 4.5 ± 10%.

**Metal Topology****DIE DIMENSIONS:**

254 x 214 x 19 ± 1mils

**METALLIZATION:**

Type: Si - Al or Si-Al-Cu

Thickness: 8kÅ

**GLASSIVATION:**

Type: Nitrox

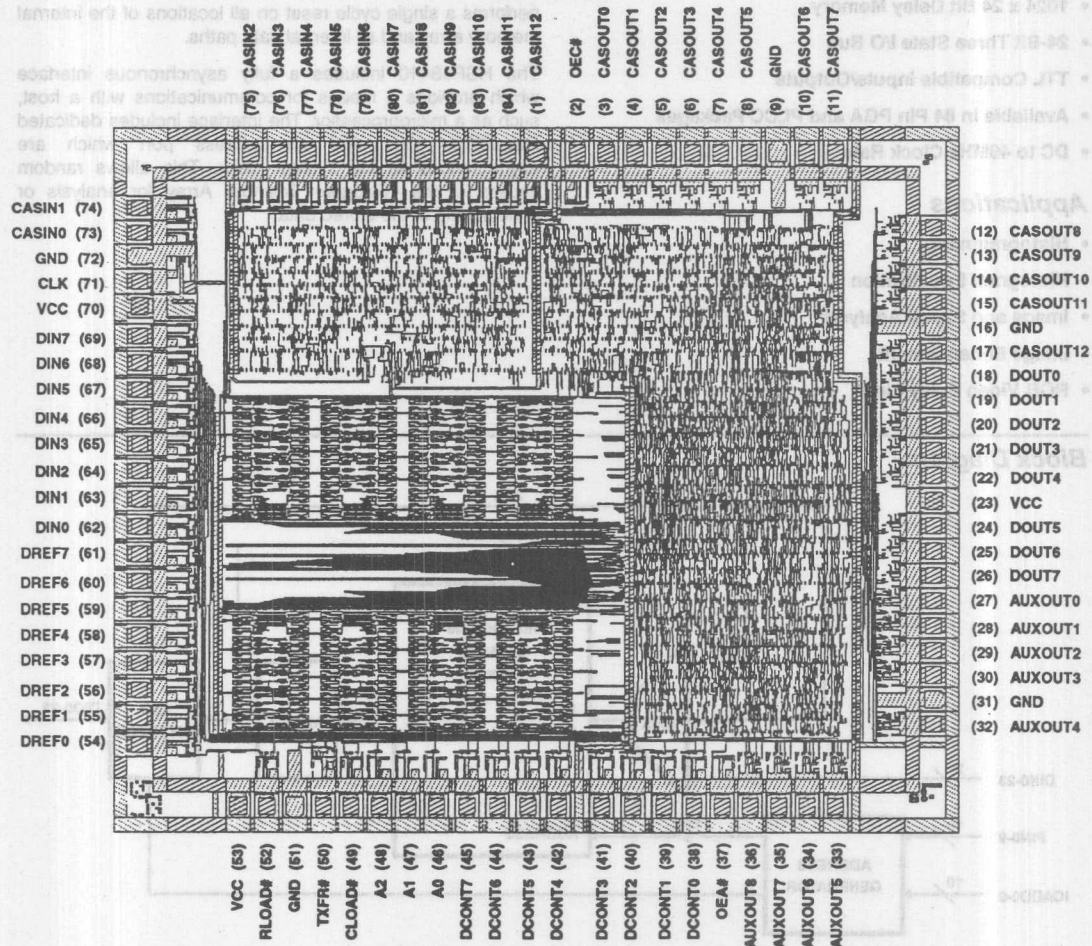
Thickness: 10kÅ

**DIE ATTACH:**

Material: Gold Silicon Eutectic Alloy or Silver-Glass

**WORST CASE CURRENT DENSITY:** $0.96 \times 10^5 \text{ A/cm}^2$ **Metallization Mask Layout**

HSP45256/883



June 1992

## Histogrammer/Accumulating Buffer

### Features

- 10-Bit Pixel Data
- 4k x 4k Frame Sizes
- Asynchronous Flash Clear Pin
- Single Cycle Memory Clear
- Fully Asynchronous 16 or 24-Bit Host Interface
- Generates and Stores Cumulative Distribution Function
- Look Up Table Mode
- 1024 x 24 Bit Delay Memory
- 24-Bit Three State I/O Bus
- TTL Compatible Inputs/Outputs
- Available in 84 Pin PGA and PLCC Packages
- DC to 40MHz Clock Rate

### Applications

- Histogramming
- Histogram Equalization
- Image and Signal Analysis
- Image Enhancement
- RGB Video Delay Line

### Description

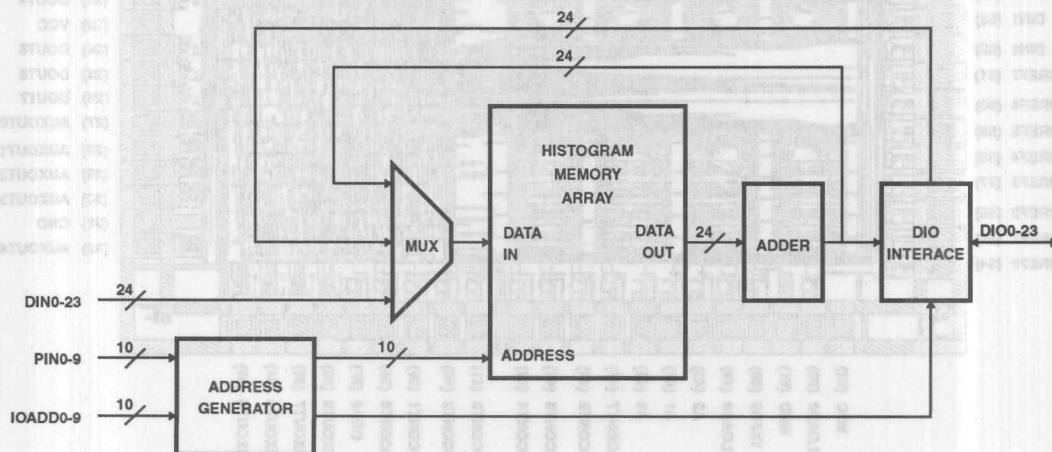
The Harris HSP48410 is an 84 pin Histogrammer IC intended for use in image and signal analysis. The on-board memory is configured as 1024 x 24 array. This translates to a pixel resolution of 10 bits and an image size of 4k x 4k with no possibility of overflow.

In addition to Histogramming, the HSP48410 can generate and store the Cumulative Distribution Function for use in Histogram Equalization applications. Other capabilities of the HSP48410 include: Bin Accumulation, Look Up Table, 24-bit Delay memory, and Delay & Subtract mode.

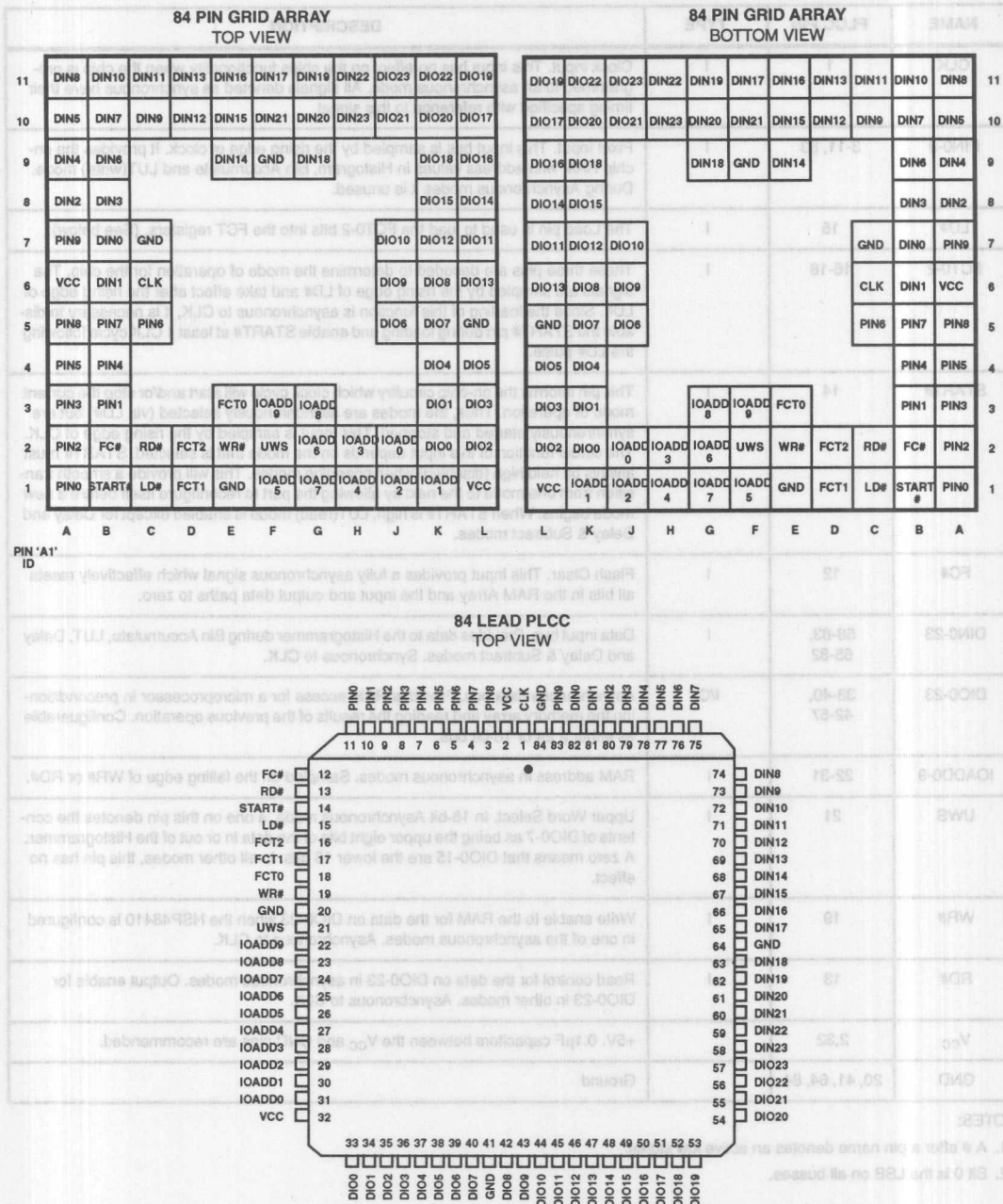
A Flash Clear pin is available in all modes of operation and performs a single cycle reset on all locations of the internal memory array and all internal data paths.

The HSP48410 includes a fully asynchronous interface which provides a means for communications with a host, such as a microprocessor. The interface includes dedicated Read/Write pins and an address port which are asynchronous to the system clock. This allows random access of the Histogram Memory Array for analysis or conditioning of the stored data.

### Block Diagram



## Pinouts





## Pin Description

NAME	PLCC PIN	TYPE	DESCRIPTION
CLK	1	I	Clock input. This input has no effect on the chips functionality when the chip is programmed to an asynchronous mode. All signals denoted as synchronous have their timing specified with reference to this signal.
PIN0-9	3-11, 83	I	Pixel Input. This input bus is sampled by the rising edge of clock. It provides the on-chip RAM with address values in Histogram, Bin Accumulate and LUT(write) mode. During Asynchronous modes it is unused.
LD#	15	I	The Load pin is used to load the FCT0-2 bits into the FCT registers. (See below).
FCT0-2	16-18	I	These three pins are decoded to determine the mode of operation for the chip. The signals are sampled by the rising edge of LD# and take effect after the rising edge of LD#. Since the loading of this function is asynchronous to CLK, it is necessary to disable the START# pin during loading and enable START# at least 1 CLK cycle following the LD# pulse.
START#	14	I	This pin informs the on-chip circuitry which clock cycle will start and/or stop the current mode of operation. Thus, the modes are asynchronously selected (via LD#) but are synchronously started and stopped. This input is sampled by the rising edge of CLK. The actual function of this input depends on the mode that is selected. START# must always be held high (disabled) when changing modes. This will provide a smooth transition from one mode to the next by allowing the part to reconfigure itself before a new mode begins. When START# is high, LUT(read) mode is enabled except for Delay and Delay & Subtract modes.
FC#	12	I	Flash Clear. This input provides a fully asynchronous signal which effectively resets all bits in the RAM Array and the input and output data paths to zero.
DIN0-23	58-63, 65-82	I	Data input bus. Provides data to the Histogrammer during Bin Accumulate, LUT, Delay and Delay & Subtract modes. Synchronous to CLK.
DIO0-23	33-40, 42-57	I/O	Asynchronous data bus. Provides RAM access for a microprocessor in preconditioning the memory array and reading the results of the previous operation. Configurable as either a 24 or 16-bit bus.
IOADD0-9	22-31	I	RAM address in asynchronous modes. Sampled on the falling edge of WR# or RD#.
UWS	21	I	Upper Word Select. In 16-bit Asynchronous mode, a one on this pin denotes the contents of DIO0-7 as being the upper eight bits of the data in or out of the Histogrammer. A zero means that DIO0-15 are the lower 16 bits. In all other modes, this pin has no effect.
WR#	19	I	Write enable to the RAM for the data on DIO0-23 when the HSP48410 is configured in one of the asynchronous modes. Asynchronous to CLK.
RD#	13	I	Read control for the data on DIO0-23 in asynchronous modes. Output enable for DIO0-23 in other modes. Asynchronous to CLK.
V <sub>CC</sub>	2,32		+5V. 0.1µF capacitors between the V <sub>CC</sub> and GND pins are recommended.
GND	20, 41, 64, 84		Ground

## NOTES:

1. A # after a pin name denotes an active low signal.
2. Bit 0 is the LSB on all busses.

## Functional Description

The Histogrammer is intended for use in signal and image processing applications. The on-board RAM is 24 bits by 1024 locations. For histogramming, this translates to an image size of 4k x 4k with 10-bit data. A functional block diagram of the part is shown in Figure 1.

In addition to histogramming, the HSP48410 will also perform Histogram Accumulation while feeding the results back into the memory array. The on-board RAM will then contain the Cumulative Distribution Function and can be used for further operation such as histogram equalization.

Other modes are: Bin Accumulate, Look Up Table (LUT), Delay Memory, and Delay & Subtract. The part can also be accessed as a 24-bit by 1024 word asynchronous RAM for preconditioning or reading the results of the histogram.

The Histogrammer can be accessed both synchronously and asynchronously to the system clock (CLK). It was designed to be configured asynchronously by a microprocessor, then switched to a synchronous mode to process data. The result of the processing can then be read out synchronously, or the part can be switched to one of the asynchronous modes so the data may be read out by a microprocessor. All modes are synchronous except for the Asynchronous 16 and 24 modes.

A Flash Clear operation allows the user to reset the entire RAM array and all input and output data paths in a single cycle.

### Histogram Memory Array

The Histogram Memory Array is a 24-bit by 1024 deep RAM. Depending on the current mode, its input data comes from either the synchronous input DIO0-23, from the asynchronous data bus DIO0-23, or from the output of the adder. The output data goes to the DIO bus in both synchronous and asynchronous modes.

### Address Generator

This section of the circuit determines the source of the RAM address. In the synchronous modes, the address is taken from either the output of the counter or PIN0-9. The pixel input bus is used for Histogram, Bin Accumulate, and LUT(read) modes. All other synchronous modes, i.e. Histogram Accumulate, LUT(write), Delay, and Delay & Subtract use the counter output. The counter is reset on the first rising edge of CLK after a falling edge on START#.

During asynchronous modes, the read and write addresses to the RAM are taken from the IOADD bus on the falling edge of the RD# and WR# signals, respectively.

### Adder Input

The Adder Input Control section contains muxes, registers and other logic that provide the proper data to the adder. The configuration of this section is controlled by the output of the Function Decode section.

### DIO Interface

The DIO Interface Section transfers data between the Histogrammer and the outside world. In the synchronous modes, DIO acts as a synchronous output for the data currently being processed by the chip; RD# acts as the output enable for the DIO bus; WR# and IOADD0-9 have no effect. When either of the Asynchronous modes are selected (16 or 24-bit), the RAM output is passed directly to the DIO bus on read cycles, and on write cycles, data input on DIO goes to the RAM input port. In this case, data reads and writes are controlled by RD#, WR# and IOADD0-9.

### Function Decode

This section provides the signals needed to configure the part for the different modes. The eight modes are decoded from FCT0-2 on the rising edge of LD# (see Table 1). The output of this section is a set of signals which control the path of data through the part.

The mode should only be changed while START# is high. After changing from one mode to another, START# must be clocked high by the rising edge of CLK at least once.

TABLE 1. FUNCTION DECODE

FCT			MODE
2	1	0	
0	0	0	Histogram
0	0	1	Histogram Accumulate
0	1	0	Delay & Subtract
0	1	1	Look Up Table
1	0	0	Bin Accumulate
1	0	1	Delay Memory
1	1	0	Asynchronous 24
1	1	1	Asynchronous 16

### Flash Clear

Flash Clear allows the user to clear the entire RAM with a single pin. When the FC# pin is low, all bits of the RAM and the data path from the RAM to DIO0-23 are set to zero. The FC# pin is asynchronous with respect to CLK: the reset begins immediately following a low on this signal. For synchronous modes, in order to ensure consistent results, FC# should only be active while START# is high. For asynchronous modes, WR# must remain inactive while FC# is low.

## Functional Block Diagram

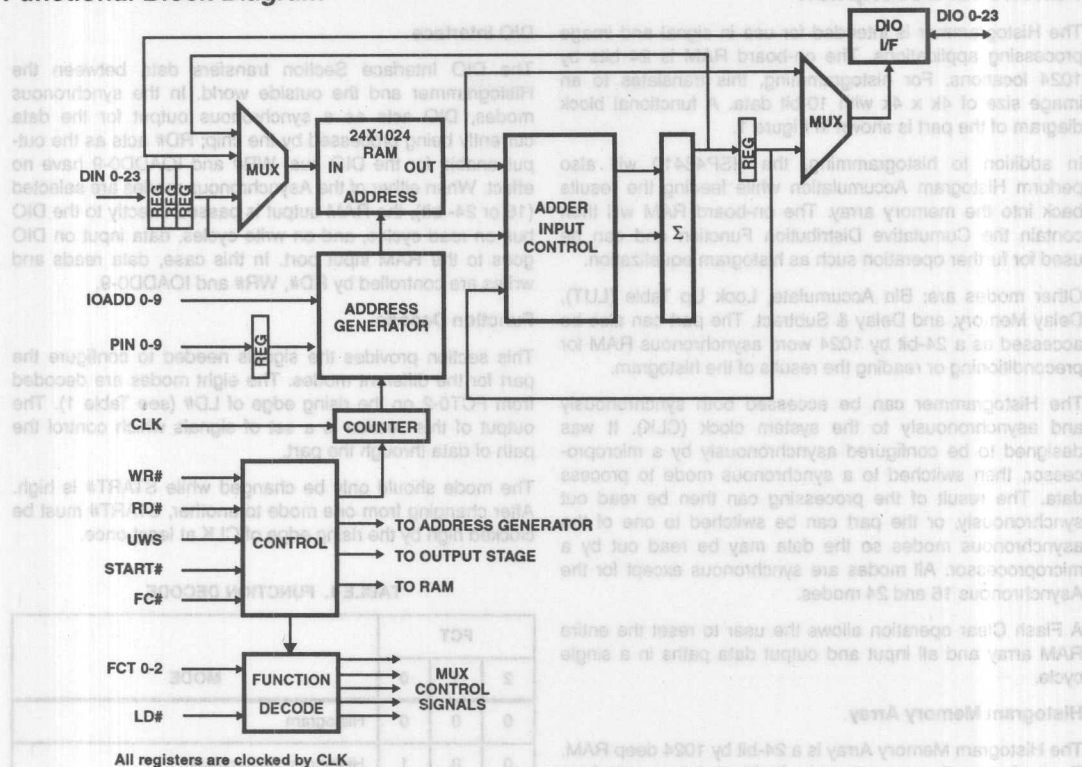


FIGURE 1. FUNCTIONAL BLOCK DIAGRAM

## Histogram Mode

This is the fundamental operation for which this chip was intended. When this mode is selected, the chip configures itself as shown in the block diagram of Figure 2. The pixel data is sampled on the rising edge of clock and used as the read address to the RAM array. The data contained in that address (or bin) is then incremented by 1 and written back into the RAM at the same address.

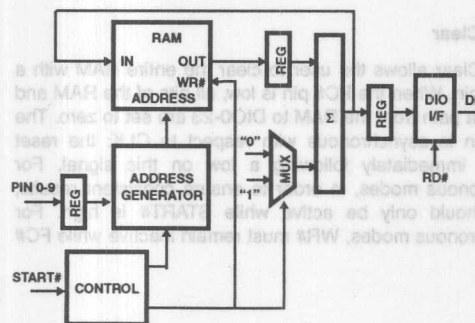


FIGURE 2. HISTOGRAM MODE BLOCK DIAGRAM

At the same time, the new value is also displayed on the DIO bus. This procedure continues until the circuit is interrupted by START# returning high. When START# is high, the RAM write is disabled, the read address is taken from the Pixel Input bus, and the chip acts as if it is in LUT(read) mode. Figure 3 shows histogram mode timing. START# is used to disregard the data on PIN0-9 at DATA2. START# is sampled on the rising edge of clock, but is delayed internally by 3 cycles to match the latency of the Address Generator. Data is clocked onto the DIO bus on the rising edge of CLK. RD# acts as output enable.

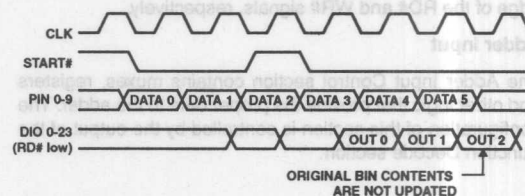
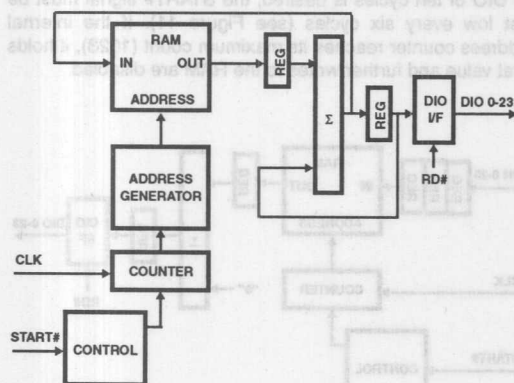


FIGURE 3. HISTOGRAM MODE TIMING

### Histogram Accumulate Mode

This function is very similar to the Histogram function. In this case, a counter is used to provide the address data to the RAM. The RAM is sequentially accessed, and the data from each bin is added to the data from the previous bins. This accumulation of data continues until the function is halted. The results of the accumulation are displayed on the DIO bus while simultaneously being written back to the RAM. When the operation is complete, the RAM will contain the Cumulative Distribution Function (CDF) of the image.

Figure 4 shows the configuration for this mode. Once this function is selected, the START# pin is used to reset the counter and enable writing to the RAM. Write enable is delayed 3 cycles to match the delay in the Address Generator. The START# pin determines when the accumulation will begin. Before this pin is activated, the counter will be in an unknown state and the DIO bus will contain unpredictable data. Once the START# pin is sampled low, the data registers are reset in order to clear the accumulation. The output (DIO bus) will then be zero until a non-zero data value is read from the RAM. Timing for this operation is shown in Figure 5.



**FIGURE 4. HISTOGRAM ACCUMULATE MODE BLOCK DIAGRAM**

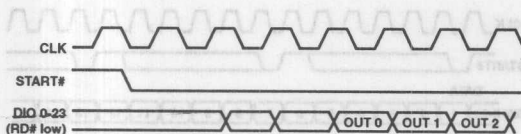


FIGURE 5. HISTOGRAM ACCUMULATE MODE TIMING

The START# pin must remain low in order to allow the accumulated data to overwrite the original histogram data contained in the RAM. When the START# pin returns to a high state, the configuration remains intact, but writing to the

RAM is disabled and the part is in LUT(read) mode. Note that the counter is not reset at this point. The counter will be reset on the first cycle of CLK that START# is detected low. To prevent invalid data from being written to the RAM, when the counter reaches its maximum value (1023), further writing to the RAM is disabled and the counter remains at this value until the mode is changed.

At the end of the histogram accumulation, the DIO output bus will contain the last accumulated value. The chip will remain in this state until START# becomes inactive. The results of the accumulation can then be read out synchronously by keeping START# high, or asynchronously in either of the asynchronous modes.

### Bin Accumulate Mode

The functionality of this mode is also similar to the Histogram function. The only difference is that instead of incrementing the bin data by 1, the bin data is added to the incoming DIN bus data. The DIN bus is delayed internally by 3 cycles to match the latency in the address generator. Figure 6 shows the block diagram of the internal configuration for this mode, while the timing is given in Figure 7. Note that in this figure, START# is used to disregard the data on DIN0-23 during DATA2.

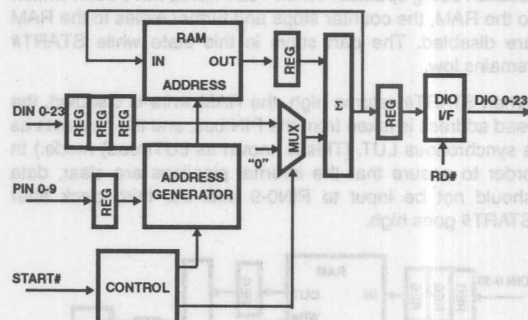


FIGURE 6. BIN ACCUMULATE BLOCK DIAGRAM

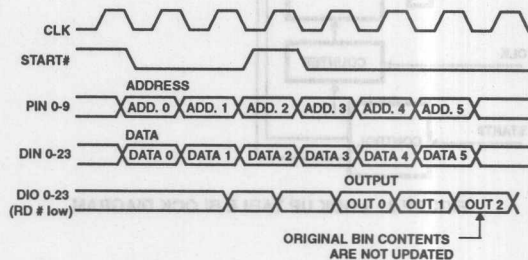


FIGURE 7. BIN ACCUMULATE TIMING



## Look Up Table Mode

A Look Up Table (LUT) is used to perform a fixed transformation function on pixel values. This is particularly useful when the transformation is non-linear and cannot be realized directly with hardware. An example is the remapping of the original pixel values to a new set of values based on the CDF obtained through Histogram Accumulation.

The transformation function can be loaded into the LUT in one of three ways: in LUT mode, through DIN0-23; in either asynchronous mode, over the DIO bus as described below under Asynchronous 16/24 Modes; in the Histogram Accumulate mode the transformation function is calculated internally (see description above). The transformation function can then be utilized by deactivating START#, putting the part in LUT mode and clocking the data to be transformed onto the PIN bus. Note that it is necessary to wait one clock cycle after changing the mode before clocking data into the part.

The block diagram and timing for this mode are shown in Figures 8 and 9. The left half of the timing diagram shows LUT(write) mode. On the first CLK that detects START# low, the counter is reset and the write enable is activated for the RAM. As long as START# remains low, the counter provides the write address to the RAM and data is sequentially loaded through the DIN bus. The DIN bus is delayed internally by 3 cycles to match the latency in the Address Generator. The DIO bus will contain the previous contents of the memory location being updated. When 1024 words have been written to the RAM, the counter stops and further writes to the RAM are disabled. The part stays in this state while START# remains low.

When START# returns high, the RAM write is disabled, the read address is taken from the PIN bus, and the chip acts as a synchronous LUT. (This is known as LUT(read) mode.) In order to ensure that the internal pipelines are clear, data should not be input to PIN0-9 until the third clock after START# goes high.

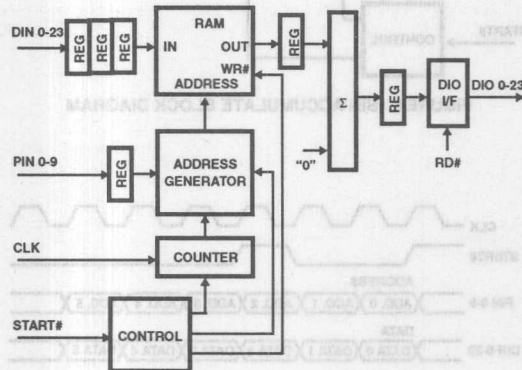
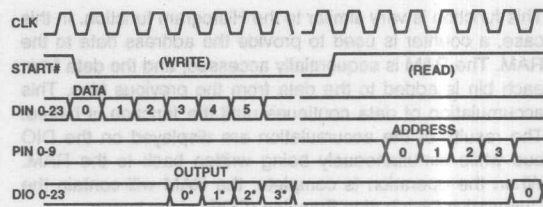


FIGURE 8. LOOK UP TABLE BLOCK DIAGRAM



\* Previous contents of bin location.

FIGURE 9. LOOK UP TABLE MODE TIMING

## Delay Memory (Row Buffer) Mode

As seen by comparing Figures 8 and 10, the configuration for this mode is nearly identical to the LUT mode. In this mode, however, the counter is always providing the address and the write function is always enabled.

In order to force this configuration to act as a row delay register, the START# signal must be used to reset the internal counter each time a new row of pixels is being sampled. Because of the inherent latency in the address and data paths, the counter must be reset every N-4 cycles, where N is the desired delay length. For example, if a delay from DIN to DIO of ten cycles is desired, the START# signal must be set low every six cycles (see Figure 11). If the internal address counter reaches its maximum count (1023), it holds that value and further writes to the RAM are disabled.

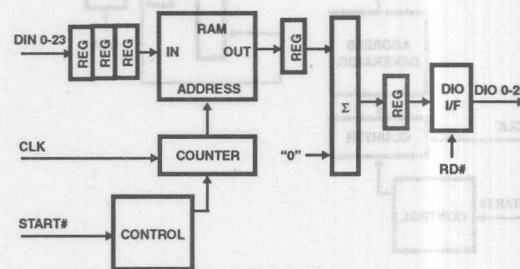


FIGURE 10. DELAY MEMORY BLOCK DIAGRAM

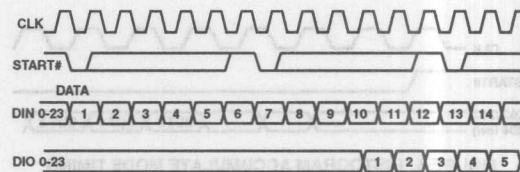


FIGURE 11. DELAY MEMORY MODE TIMING FOR ROW LENGTH OF TEN

## Delay & Subtract Mode

This mode is similar to the Delay Memory mode, except the input data is subtracted from the corresponding data stored in RAM (See Figures 12 and 13).

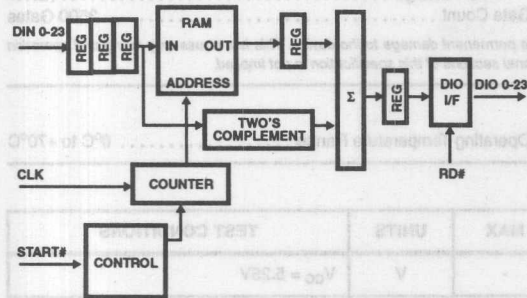


FIGURE 12. DELAY AND SUBTRACT BLOCK DIAGRAM

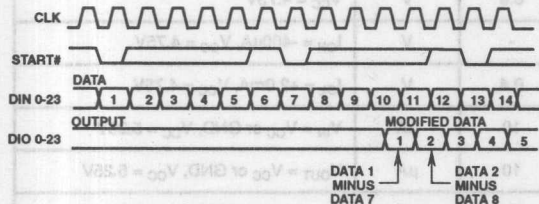


FIGURE 13. DELAY AND SUBTRACT MODE TIMING FOR ROW LENGTH OF TEN

## Asynchronous 16/24 Modes

In the Asynchronous modes, the chip acts like a single port RAM. In this mode, the user can read (access) any bin location on the fly by simply setting the 10-bit IO address to the desired bin location. The RAM is then read or written on the following RD# or WR# pulse. A block diagram for this mode is shown in Figure 14. Note that all registers and pipeline stages are bypassed; START# and CLK have no effect in this mode.

Timing waveforms for this mode are also shown in Figure 15. During reading, the read address is latched (internally) on the falling edge of RD#. During write operations, the address is latched on the falling edge of WR# and data is latched on the rising edge of WR#. Note that reading and writing occur on different ports, so that, in this mode, the write port always latches its address and data values from the WR# signal, while the read port always uses RD# for latching.

The difference between the Async 16 mode and the Async 24 mode is the number of data bits available to the user. In 16-bit mode, the user can connect the system data bus to the lower 16 bits of the Histogrammer's DIO bus. The UWS pin becomes the LSB of the IO address, which determines if the lower 16 bits or upper 8 bits of the 24-bit Histogrammer data is being used. When UWS is low, the data present at DIO0-15 is the lower 16 bits of the data in the IOADD0-9 location. When UWS is high, the upper 8 bits of the IOADD0-9 location are present on DIO0-7. (This is true for both reading and writing.) Thus it takes 2 cycles for an asynchronous 24-bit operation when in Async 16 mode. Unused outputs are zeros.

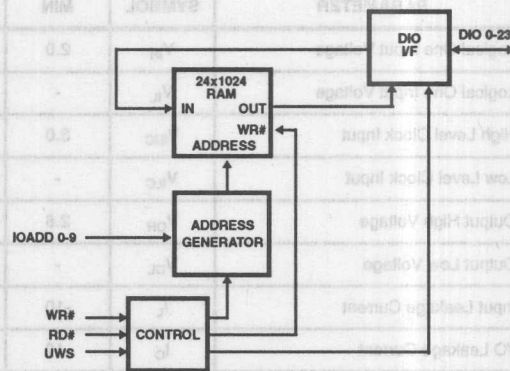
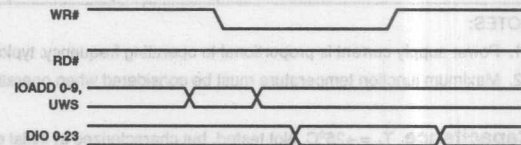


FIGURE 14. ASYNCHRONOUS 16/24 BLOCK DIAGRAM

### WRITE CYCLE TIMING



### READ CYCLE TIMING

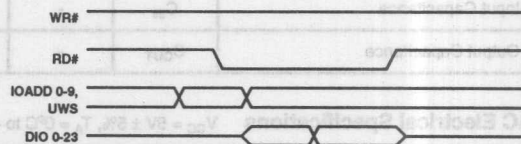


FIGURE 15. ASYNCHRONOUS 16/24 MODE TIMING

## Specifications HSP48410

### Absolute Maximum Ratings

Supply Voltage	.....+8.0V
Input, Output Voltage	.....GND-0.5V to $V_{CC}+0.5V$
Storage Temperature Range	.....-65°C to +150°C
Junction Temperature	.....+175°C (PGA), +150°C (PLCC)
Lead Temperature (Soldering 10s)	.....+300°C
ESD Classification	.....Class 1

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### Thermal Information

Thermal Resistance	.....	$\theta_{JA}$	$\theta_{JC}$
PGA Package	.....	34.3°C/W	8.0°C/W
PLCC Package	.....	33.7°C/W	11.1°C/W
Maximum Package Power Dissipation at +70°C	.....		
PGA Package	.....	3.1W	
PLCC Package	.....	2.4W	
Gate Count	.....	3500 Gates	

### Operating Conditions

Operating Voltage Range	.....+5V $\pm$ 5%	Operating Temperature Range	.....0°C to +70°C
-------------------------	-------------------	-----------------------------	-------------------

### DC Electrical Specifications

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Logical One Input Voltage	$V_{IH}$	2.0	-	V	$V_{CC} = 5.25V$
Logical One Input Voltage	$V_{IL}$	-	0.8	V	$V_{CC} = 4.75V$
High Level Clock Input	$V_{IHC}$	3.0	-	V	$V_{CC} = 5.25V$
Low Level Clock Input	$V_{ILC}$	-	0.8	V	$V_{CC} = 4.75V$
Output High Voltage	$V_{OH}$	2.6	-	V	$I_{OH} = -400\mu A$ , $V_{CC} = 4.75V$
Output Low Voltage	$V_{OL}$	-	0.4	V	$I_{OL} = +2.0mA$ , $V_{CC} = 4.75V$
Input Leakage Current	$I_L$	-10	10	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$
I/O Leakage Current	$I_O$	-10	10	$\mu A$	$V_{OUT} = V_{CC}$ or GND, $V_{CC} = 5.25V$
Standby Supply Current	$I_{CCSB}$	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Outputs Open
Operating Power Supply Current	$I_{CCOP}$	-	396	mA	$f = 33 MHz$ , $V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ (Note 1, 2)

#### NOTES:

- Power supply current is proportional to operating frequency. typical rating for  $I_{CCOP}$  is 12mA/MHz.
- Maximum junction temperature must be considered when operating part at high clock frequencies.

**Capacitance**  $T_A = +25^\circ C$ , Not tested, but characterized at initial design and at major process or design changes.

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Input Capacitance	$C_{IN}$	-	12	pF	FREQ = 1 MHz, $V_{CC} =$ Open, all measurements are referenced to device ground.
Output Capacitance	$C_{OUT}$	-	12	pF	

### AC Electrical Specifications $V_{CC} = 5V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C (Note 1)

PARAMETER	SYMBOL	-40 (40 MHz)		-33 (33 MHz)		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
Clock Period	$T_{CP}$	25	-	30	-	ns	
Clock Low	$T_{CH}$	10	-	12	-	ns	
Clock High	$T_{CL}$	10	-	12	-	ns	
DIN Setup	$T_{DS}$	12	-	13	-	ns	

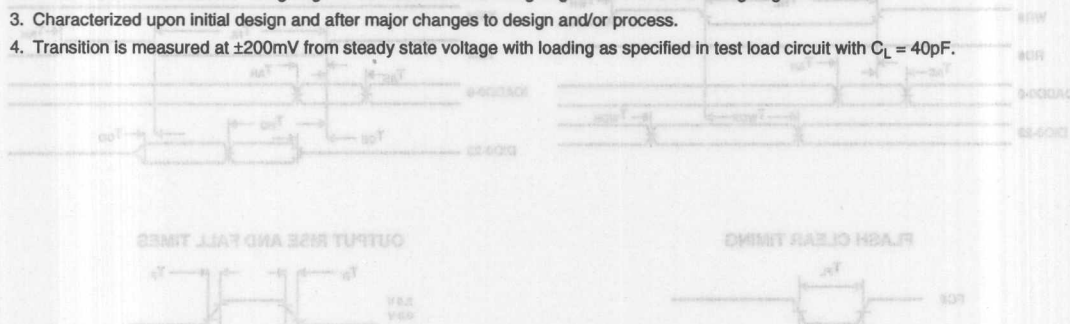
## Specifications HSP48410

**AC Electrical Specifications**  $V_{CC} = 5V \pm 5\%$ ,  $T_A = 0^\circ C$  to  $+70^\circ C$  (Note 1) (Continued)

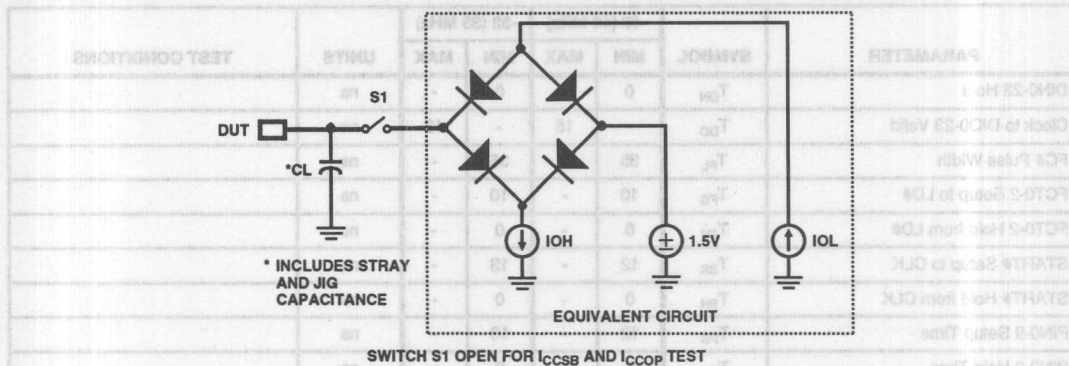
PARAMETER	SYMBOL	-40 (40 MHz)		-33 (33 MHz)		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
DIN0-23 Hold	$T_{DH}$	0	-	0	-	ns	
Clock to DIO0-23 Valid	$T_{DO}$	-	15	-	19	ns	
FC# Pulse Width	$T_{FL}$	35	-	35	-	ns	
FCT0-2 Setup to LD#	$T_{FS}$	10	-	10	-	ns	
FCT0-2 Hold from LD#	$T_{FH}$	0	-	0	-	ns	
START# Setup to CLK	$T_{SS}$	12	-	13	-	ns	
START# Hold from CLK	$T_{SH}$	0	-	0	-	ns	
PIN0-9 Setup Time	$T_{PS}$	12	-	13	-	ns	
PIN0-9 Hold Time	$T_{PH}$	0	-	0	-	ns	
LD# Pulse Width	$T_{LL}$	10	-	12	-	ns	
LD# Setup to START#	$T_{LS}$	$T_{CP}$		$T_{CP}$	-	ns	Note 2
WR# Low	$T_{WL}$	12	-	15	-	ns	
WR# High	$T_{WH}$	12	-	15	-	ns	
Address Setup	$T_{AS}$	13	-	15	-	ns	
Address Hold	$T_{AH}$	1	-	1	-	ns	
DIO Setup to WR#	$T_{WS}$	12	-	15	-	ns	
DIO Hold from WR#	$T_{WH}$	1	-	1	-	ns	
RD# Low	$T_{RL}$	35	-	43	-	ns	
RD# High	$T_{RH}$	15	-	17	-	ns	
RD# Low to DIO Valid	$T_{RD}$	-	35	-	43	ns	
Read/Write Cycle Time	$T_{CY}$	55	-	65	-	ns	
DIO Valid after RD# High	$T_{OH}$	-	0	-	0	ns	Note 3
Output Enable Time	$T_{OE}$	-	18	-	19	ns	Note 4
Output Disable Time	$T_{OD}$	-	18	-	19	ns	Note 3
Output Rise Time	$T_R$	-	6	-	6	ns	From 0.8V to 2.0V, Note 3
Output Fall Time	$T_F$	-	6	-	6	ns	From 2.0V to 0.8V, Note 3

**NOTES:**

1. AC Testing is performed as follows: Input levels (CLK) 0.0V and 4.0V; Input levels (All other inputs) 0V and 3.0V. Timing reference levels (CLK) = 2.0V, (All others) = 1.5V. Output load circuit with  $C_L = 40pF$ . Output transition measured at  $V_{OH} \geq 1.5V$  and  $V_{OL} \leq 1.5V$ .
2. There must be at least one rising edge of CLK between the rising edge of LD# and the falling edge of START#.
3. Characterized upon initial design and after major changes to design and/or process.
4. Transition is measured at  $\pm 200mV$  from steady state voltage with loading as specified in test load circuit with  $C_L = 40pF$ .

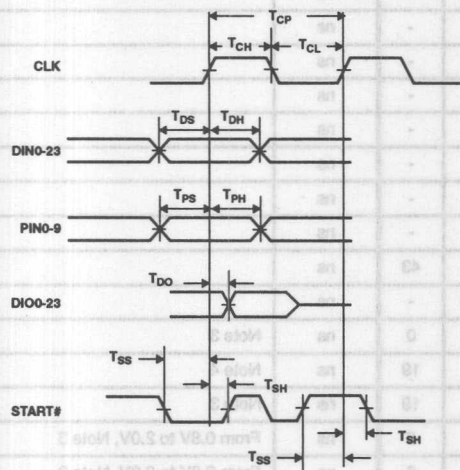




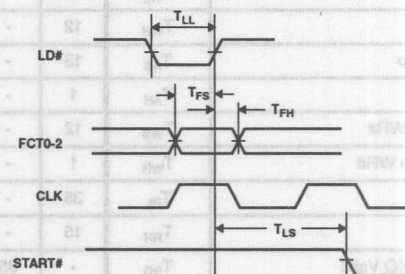


### Waveforms

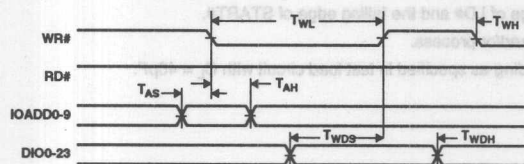
SYNCHRONOUS DATA AND CONTROL TIMING	FUNCTION LOAD TIMING
-------------------------------------	----------------------



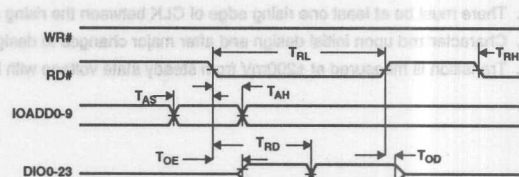
## FUNCTION LOAD TIMING



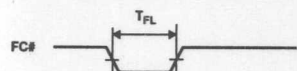
**WRITE CYCLE TIMING** **READ CYCLE TIMING**



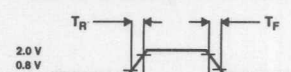
## READ CYCLE TIMING



FLASH CLEAR TIMING	OUTPUT RISE AND FALL TIMES
<p>1. <math>t_{\text{FALL}}</math> is the time from the falling edge of the output to the time when the output is 50% of the initial value.</p> <p>2. <math>t_{\text{RISE}}</math> is the time from the rising edge of the output to the time when the output is 50% of the initial value.</p>	<p>1. <math>t_{\text{RISE}}</math> is the time from the rising edge of the output to the time when the output is 50% of the initial value.</p> <p>2. <math>t_{\text{FALL}}</math> is the time from the falling edge of the output to the time when the output is 50% of the initial value.</p>



### OUTPUT RISE AND FALL TIMES



August 1992

## Programmable Data Buffer

### Features

- DC to 32MHz Operating Frequency
- Programmable Buffer Length from 2 to 1281 Words
- Supports Data Words to 10-Bits
- Clock Select Logic for Positive or Negative Edge System Clocks
- Data Recirculate or Delay Modes of Operation
- Expandable Data Word Width or Buffer Length
- Three-State Outputs
- TTL Compatible Inputs/Outputs
- Low Power CMOS
- Available in 44 Pin PLCC Package

### Applications

- Sample Rate Conversion
- Data Time Compression/Expansion
- Software Controlled Data Alignment
- Programmable Serial Data Shifting
- Audio/Speech Data Processing

### Video/Image Processing

- 1-H Delay Line of 910 NTSC, 1135 PAL or 1280 Samples:
  - ▶ High Resolution Monitor Delay Line
  - ▶ Comb Filter Designs
  - ▶ Progressive Scanning Display
  - ▶ TV Standards Conversion
  - ▶ Image Processing

### Description

The HSP9501 is a 10-Bit wide programmable data buffer designed for use in high speed digital systems. Two different modes of operation can be selected through the use of the MODSEL input. In the delay mode, a programmable data pipeline is created which can provide 2 to 1281 clock cycles of delay between the input and output data. In the data recirculate mode, the output data path is internally routed back to the input to provide a programmable circular buffer.

The length of the buffer or amount of delay is programmed through the use of the 11-bit length control input port (LC0-10) and the length control enable (LCEN#). An 11-bit value is applied to the LC0-10 inputs, LCEN# is asserted, and the next selected clock edge loads the new count value into the length control register. The delay path of the HSP9501 consists of two registers with a programmable delay RAM between them, therefore, the value programmed into the length control register is the desired length - 2. The range of values which can be programmed into the length control register are from 0 to 1279, which in turn results in an overall range of programmable delays from 2 to 1281.

Clock select logic is provided to allow the use of a positive or negative edge system clock as the CLK input to the HSP9501. The active edge of the CLK input is controlled through the use of the CLKSEL input. All synchronous timing (i.e. data setup, hold and output delays) are relative to the clock edge selected by CLKSEL. An additional clock enable input (CLKEN#) provides a means of disabling the internal clock and holding the existing contents temporarily. All outputs of the HSP9501 are three-state outputs to allow direct interfacing to system or multi-use busses.

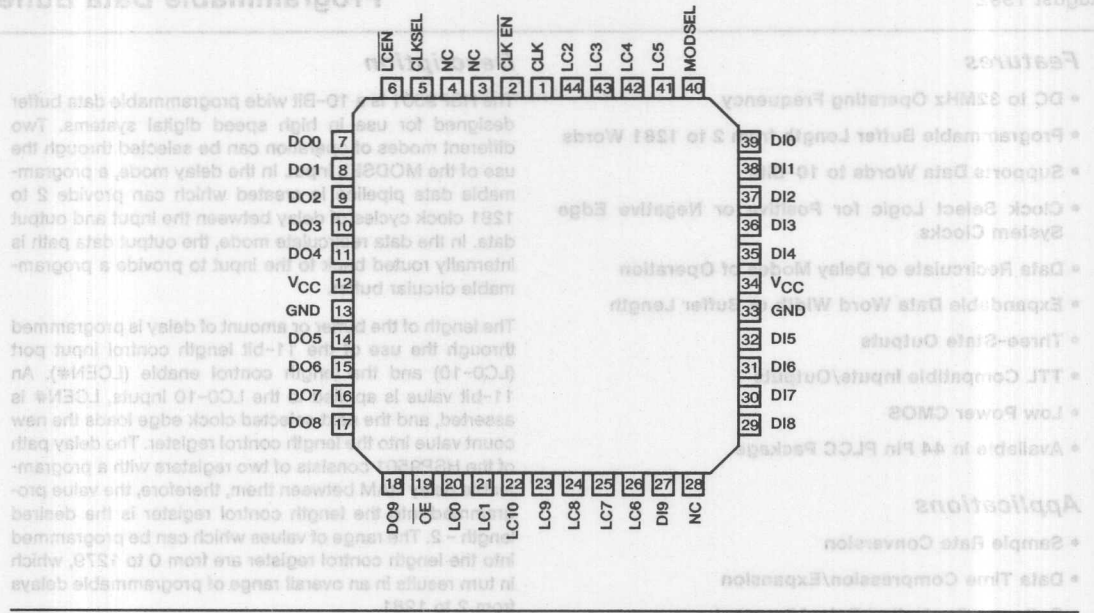
The HSP9501 is recommended for digital video processing or any applications which require a programmable delay or circular data buffer.

SPECIAL  
FUNCTION

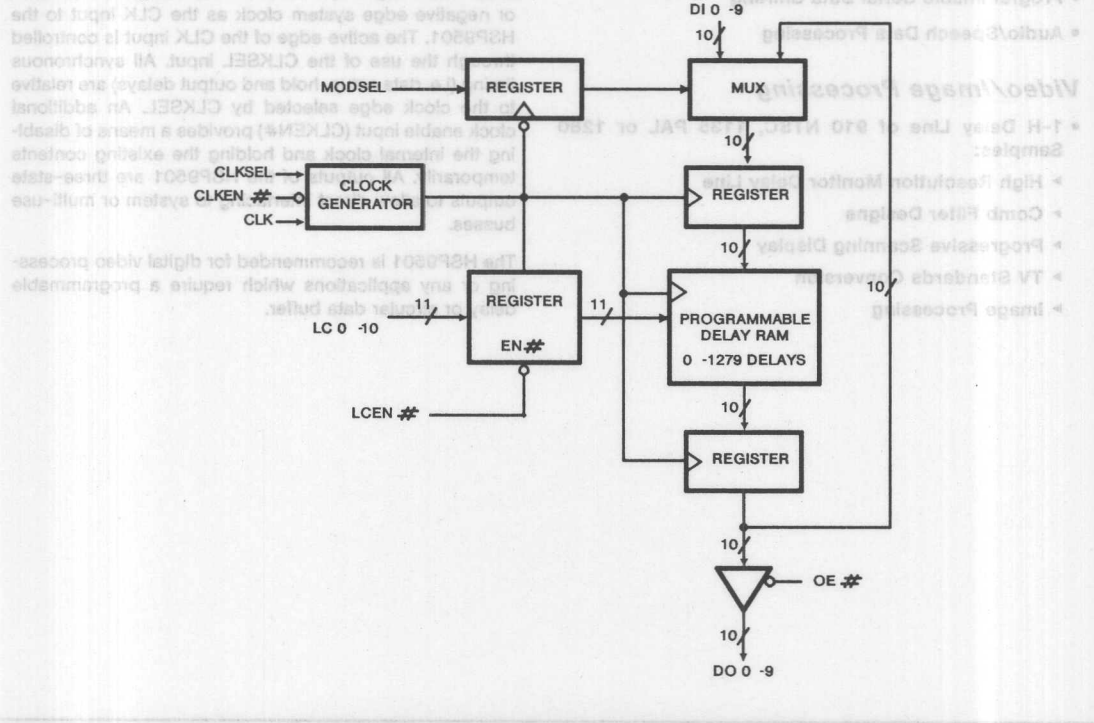
6

Pinout

44 PIN PLASTIC LEADED CHIP CARRIER (PLCC)  
TOP VIEW



Block Diagram



## Pin Descriptions

NAME	PIN NUMBER	TYPE	DESCRIPTION
V <sub>CC</sub>	12, 34		The +5V power supply pin. A 0.1µF capacitor between the V <sub>CC</sub> and GND pin is recommended.
GND	13, 33		The device ground.
CLK	1	I	Input Clock. This clock signal is used to control the data movement through the programmable buffer. It is also the signal which latches the input data, length control word and mode select. Input setup and hold times with respect to the clock must be met for proper operation.
DIO-9	27, 29-32, 35-39	I	Data Inputs. This 10-bit input port is used to provide the input data. When MODSEL is low, data on the DIO-9 inputs is latched on the clock edge selected by CLKSEL.
DOO-9	7-11, 14-18	O	Data Outputs. This 10-bit port provides the output data from the internal delay registers. Data latched into the DIO-9 inputs will appear at the DOO-9 outputs on the Nth clock cycle, where N is the total delay programmed.
LCO-10	20-26, 41-44	I	Length Control Inputs. These inputs are used to specify the number of clock cycles of delay between the DIO-9 inputs and the DOO-9 outputs. An integer value between 0 and 1279 is placed on the LCO-10 inputs, and the total delay length (N) programmed is the LCO-10 value plus 2. In order to properly load an active length control word, the value must be presented to the LCO-10 inputs and LCEN# must be asserted during an active clock edge selected by CLKSEL.
LCEN#	6	I	Length Control Enable. LCEN# is used in conjunction with LCO-10 and CLK to load a new length control word. An 11-bit value is loaded on the LCO-10 inputs, LCEN# is asserted, and the next selected clock edge will load the new count value. Since this operation is synchronous, LCEN# must meet the specified setup/hold times with respect to CLK for proper operation.
OE#	19	I	Output Enable. This input controls the state of the DOO-9 output port. A low on this control line enables the port for output. When OE# is high, the output drivers are in the high impedance state. Internal latching or transfer of data is not affected by this input.
MODSEL	40	I	Mode Select. This input is used to control the mode of operation of the HSP9501. A low on MODSEL causes the device to latch new data at the DIO-9 inputs on every clock cycle, and operate as a programmable pipeline register. When MODSEL is high, the HSP9501 is in the recirculate mode, and will operate as a programmable length circular buffer. This control signal may be used in a synchronous fashion during device operation, however, care must be taken to ensure the required setup/hold times with respect to CLK are met.
CLKSEL	5	I	Clock Select Control. This input is used to determine which edge of the CLK signal is used for controlling all internal events. A low on CLKSEL selects the negative going edge, therefore, all setup, hold, and output delay times are with respect to the negative edge of CLK. When CLKSEL is high, the positive going edge is selected and all synchronous timing is with respect to the positive edge of the CLK signal.
CLKEN#	2	I	Clock Enable. This control signal can be used to enable or disable the CLK input. When low, the CLK input is enabled and will operate in a normal fashion. A high on CLKEN# will disable the CLK input and will "hold" all internal operations and data. This control signal may also be used in a synchronous fashion, however, setup and hold requirements with respect to CLK must be met for proper device operation.

6

SPECIAL  
FUNCTION



## Functional Description

The HSP9501 is a 10-bit wide programmable length data buffer. The length of delay is programmable from 2 to 1281 delays in single delay increments.

Data into the delay line may be selected from the data input bus (DI0-9) or as recirculated output, depending on the state of the mode select (MODSEL) control input.

### Mode Select

The MODSEL control pin selects the source of the data moving into the delay line. When MODSEL is low, the data input bus (DI0-9) is the source of the data. When MODSEL is high, the output of the HSP9501 is routed back to the input to form a circular buffer.

The MODSEL control line is latched at the input by the CLK signal. The edge which latches this control signal is determined by the CLKSEL control line. In either case, the MODSEL line is latched on one edge of the CLK signal with the following edge moving data into and through the HSP9501. Refer to the functional timing waveforms for specific timing references.

### Clock Select Logic

The clock select logic is provided to allow the use of positive or negative edge system clocks. The active edge of the CLK input to the HSP9501 is controlled through the use of the CLKSEL input.

When CLKSEL is low, the negative going edge of CLK is used to control all internal operations. A high on CLKSEL selects the positive going edge of CLK.

All synchronous timing (i.e. setup, hold and output propagation delay times are relative to the CLK edge selected by CLKSEL. Functional timing waveforms for each state of CLKSEL are provided (refer to timing waveforms for details).

### Delay Path Control

The HSP9501 buffer length is programmable from 2 to 1281 data words in one word increments. The minimum number of delays which can be programmed is two, consisting of the input and output buffer registers only.

The Length control inputs (LC0-10) are used to set the length of the programmable delay ram which can vary in length from 0 to 1279. The total length of the HSP9501 data buffer will then be equal to the programmed value on LC0-10 plus 2. The programmed delay is established by the 11-bit integer value of the LC0-10 inputs with LC10 as the MSB and LC0 as the LSB.

For example,

LC10	9	8	7	6	5	4	3	2	1	LC0
0	0	0	0	1	0	0	0	0	0	1

programs a length value of  $2^6 + 2^0 = 65$ . The total length of the delay will be 65 + 2 or 67 delays.

Table 1 indicates several programming values. The decimal value placed on LC0-10 must not exceed 1279. Controlled operation with larger values is not guaranteed.

Values on LC0-10 are latched on the CLK edge selected by the CLKSEL control line, when LCEN# is active. LC0-10 and LCEN# must meet the specified setup and hold times relative to the selected CLK edge for proper device operation.

TABLE 1. LENGTH CONTROL PROGRAMMING EXAMPLES

LC10	LC9	LS8	LC7	LC6	LC5	LC4	LC3	LC2	LC1	LC0	PROGRAMMED LENGTH	TOTAL LENGTH N
2 <sup>10</sup>	2 <sup>9</sup>	2 <sup>8</sup>	2 <sup>7</sup>	2 <sup>6</sup>	2 <sup>5</sup>	2 <sup>4</sup>	2 <sup>3</sup>	2 <sup>2</sup>	2 <sup>1</sup>	2 <sup>0</sup>		
0	0	0	0	0	0	0	0	0	0	0	0	2
0	0	0	0	1	1	1	0	1	1	0	118	120
0	1	1	0	0	1	0	1	0	0	0	808	810
1	0	0	0	0	0	1	1	0	0	1	1049	1051
1	0	0	1	1	1	1	1	1	1	1	1279	1281

# Specifications HSP9501

## Absolute Maximum Ratings

Supply Voltage .....	+8.0V
Input or Output Voltage Applied .....	GND -0.5V to $V_{CC} + 0.5V$
Storage Temperature Range .....	-65°C to +150°C
Junction Temperature .....	+150°C
Maximum Package Power Dissipation .....	1.7W
$\theta_{JC}$ .....	16.4°C/W
$\theta_{JA}$ .....	45.2°C/W
Lead Temperature (Soldering, Ten Seconds) .....	+300°C

CAUTION: Stresses above those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Operating Conditions

Operating Voltage Range .....	+4.75V to +5.25V
Operating Temperature Range .....	0°C to +70°C

## D.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C, Commercial)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Logical One Input Voltage	$V_{IH}$	2.0	-	V	$V_{CC} = 5.25V$
Logical Zero Input Voltage	$V_{IL}$	-	0.8	V	$V_{CC} = 4.75V$
Output HIGH Voltage	$V_{OH}$	2.4	-	V	$I_{OH} = -4mA$ , $V_{CC} = 4.75V$
Output LOW Voltage	$V_{OL}$	-	0.4	V	$I_{OL} = +4.0mA$ , $V_{CC} = 4.75V$
Input Leakage Current	$I_I$	-10	10	$\mu A$	$V_{IN} = GND$ or $V_{CC}$ , $V_{CC} = 5.25V$
Output Leakage Current	$I_O$	-10	10	$\mu A$	$V_{OUT} = GND$ or $V_{CC}$ , $V_{CC} = 5.25V$
Standby Current	$I_{CCSB}$	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Note 2
Operating Power Supply Current	$I_{CCOP}$	-	125	mA	$f = 25MHz$ , $V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$ , Note 1, 2
Input Capacitance	$C_{IN}$	-	10	pF	FREQ = 1MHz, $V_{CC} =$ Open, All measurements are referenced to device GND
Output Capacitance	$C_O$	-	10	pF	

## A.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C, Commercial), (Note 4)

PARAMETER	SYMBOL	-32		-25		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
Clock Period	$T_{CP}$	31	-	40	-	ns	
Clock Pulse Width High	$T_{PWH}$	12	-	15	-	ns	
Clock Pulse Width Low	$T_{PWL}$	12	-	15	-	ns	
Data Input Setup Time	$T_{DS}$	10	-	12	-	ns	
Data Input Hold Time	$T_{DH}$	2	-	2	-	ns	
Output Enable Time	$T_{ENA}$	-	20	-	25	ns	
Output Disable Time	$T_{DIS}$	-	24	-	25	ns	Note 3
CLKEN# to Clock Setup	$T_{ES}$	10	-	12	-	ns	
CLKEN# to Clock Hold	$T_{EH}$	2	-	2	-	ns	
LC0-10 Setup Time	$T_{LS}$	10	-	13	-	ns	
LC0-10 Hold Time	$T_{LH}$	2	-	2	-	ns	
LCEN# to Clock Setup	$T_{LES}$	10	-	13	-	ns	
LCEN# to Clock Hold	$T_{LEH}$	2	-	2	-	ns	
MODSEL Setup Time	$T_{MS}$	10	-	13	-	ns	
MODSEL Hold Time	$T_{MH}$	2	-	2	-	ns	
Clock to Data Out	$T_{OUT}$	-	16	-	22	ns	
Output Hold from Clock	$T_{OH}$	4	-	4	-	ns	
Rise, Fall Time	$T_{RF}$	-	6	-	6	ns	Note 3

### NOTES:

- Power supply current is proportional to operating frequency. Typical rating for  $I_{CCOP}$  is 5mA/MHz.
- Output load per test load circuit with switch open and  $C_L = 40pF$ .

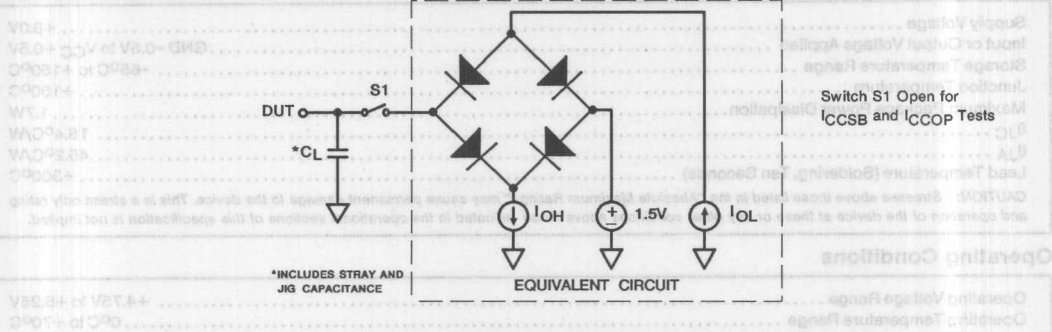
- Controlled by design or process parameters and not directly tested. Characterized upon initial design and after major process and/or design changes.

- A.C. Testing is performed as follows: Input levels: 0V and 3.0V, Timing reference levels = 1.5V, Input rise and fall times driven at 1ns/V, Output load  $C_L = 40pF$ .

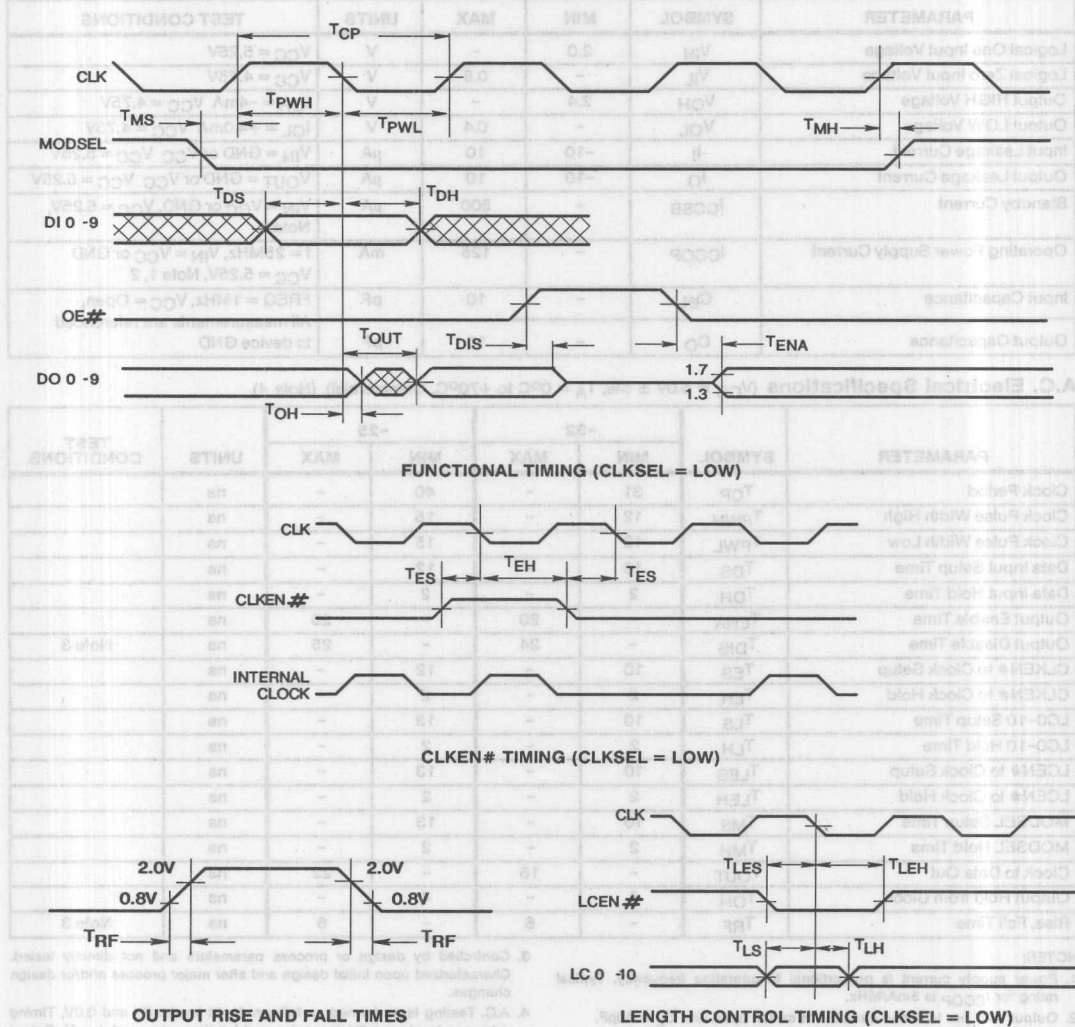
6

SPECIAL  
FUNCTION

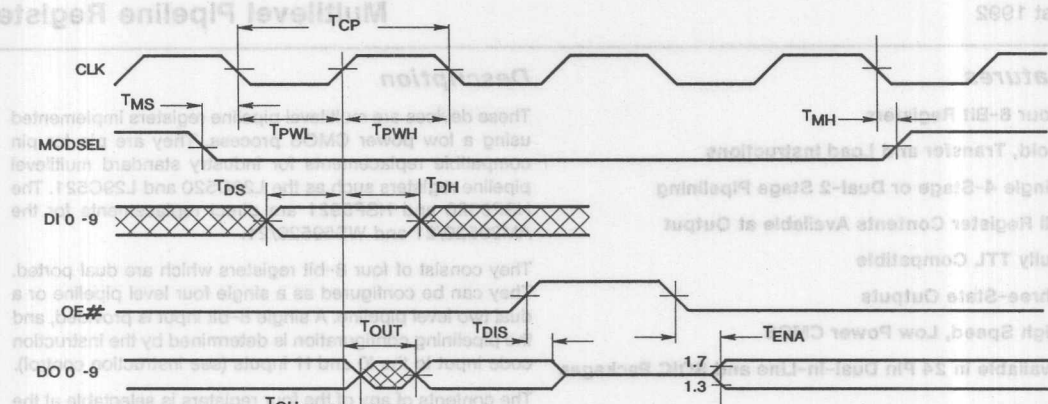
## Test Load Circuit



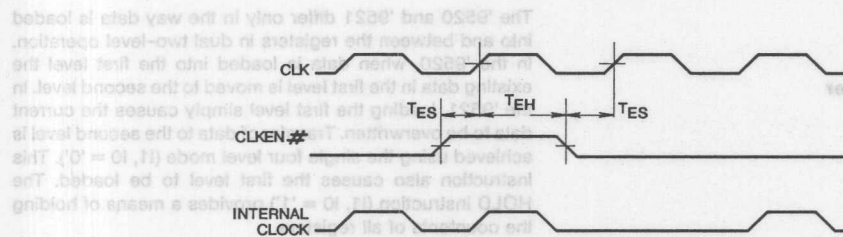
## Timing Waveforms



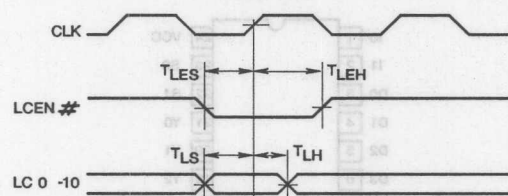
## Timing Waveforms (Continued)



FUNCTIONAL TIMING (CLKSEL = HIGH)



CLKEN# TIMING (CLKSEL = HIGH)



LENGTH CONTROL TIMING (CLKSEL = HIGH)



**HARRIS**

# **HSP9520/HSP9521 ISP9520/ISP9521**

August 1992

## **Multilevel Pipeline Register**

### **Features**

- Four 8-Bit Registers
- Hold, Transfer and Load Instructions
- Single 4-Stage or Dual-2 Stage Pipelining
- All Register Contents Available at Output
- Fully TTL Compatible
- Three-State Outputs
- High Speed, Low Power CMOS
- Available in 24 Pin Dual-In-Line and SOIC Packages

### **Applications**

- Array Processor
- Digital Signal Processor
- A/D Buffer
- Telecommunication
- Byte Wide Shift Register
- Mainframe Computers

### **Description**

These devices are multilevel pipeline registers implemented using a low power CMOS process. They are pin for pin compatible replacements for industry standard multilevel pipeline registers such as the L29C520 and L29C521. The HSP9520 and HSP5921 are direct replacements for the AM29520/21 and WS59520/21.

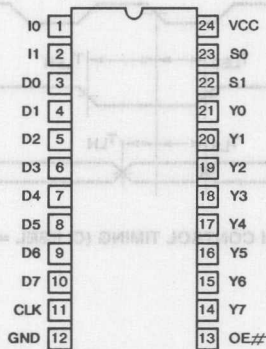
They consist of four 8-bit registers which are dual ported. They can be configured as a single four level pipeline or a dual two level pipeline. A single 8-bit input is provided, and the pipelining configuration is determined by the instruction code input to the I0 and I1 inputs (see instruction control).

The contents of any of the four registers is selectable at the multiplexed outputs through the use of the S0 and S1 multiplexer control inputs (see register select). The output is 8-bits wide and is three-stated through the use of the OE# input.

The '9520 and '9521 differ only in the way data is loaded into and between the registers in dual two-level operation. In the '9520, when data is loaded into the first level the existing data in the first level is moved to the second level. In the '9521, loading the first level simply causes the current data to be overwritten. Transfer of data to the second level is achieved using the single four level mode (I1, I0 = '0'). This instruction also causes the first level to be loaded. The HOLD instruction (I1, I0 = '1') provides a means of holding the contents of all registers.

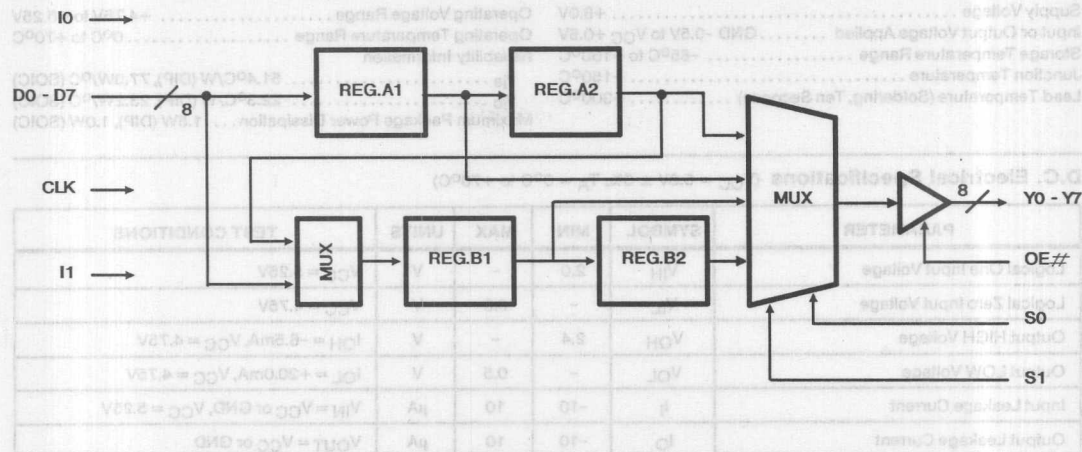
### **Pinout**

**HSP9520/HSP9521 (24 PIN SOIC)  
'9520/'9521 (24 PIN DIP)  
TOP VIEW**



CAUTION: These devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
Copyright © Harris Corporation 1992

File Number **2811.2**

**Block Diagram****Pin Descriptions**

NAME	DIP PIN	TYPE	DESCRIPTION
VCC	24		The +5V power supply pin. A 0.1 $\mu$ F capacitor between the VCC and GND pin is recommended.
GND	12		The device ground.
CLK	11	I	Input Clock. Data is latched on the low to high transition of this clock signal. Input setup and hold times with respect to the clock must be met for proper operation.
D0-7	3-10	I	Data Input Port. These inputs are used to supply the 8 bits of data which will be latched into the selected register on the next rising clock edge.
Y0-7	21-14	O	Data Output Port. This 8-bit port provides the output data from the four internal registers. They are provided in a multiplexed fashion, and are controlled via the multiplexer control inputs (S0 and S1).
I0,I1	1, 2	I	Instruction Control Inputs. These inputs are used to provide the instruction code which determines the internal register pipeline configuration. Refer to the Instruction Control Table for the specific codes and their associated configurations.
S0,S1	23, 22	I	Multiplexer Control Inputs. These inputs select which of the four internal registers' contents will be available at the output port. Refer to the Register Select Table for the codes to select each register.
OE#	13	I	Output Enable. This input controls the state of the output port (Y0-Y7). A LOW on this control line enables the port for output. When OE# is HIGH, the output drivers are in the high impedance state. Internal latching or transfer of data is not affected by this pin.

# Specifications HSP9520/HSP9521

## Absolute Maximum Ratings

Supply Voltage ..... +8.0V  
 Input or Output Voltage Applied ..... GND -0.5V to  $V_{CC} + 0.5V$   
 Storage Temperature Range ..... -65°C to +150°C  
 Junction Temperature ..... +150°C  
 Lead Temperature (Soldering, Ten Seconds) ..... +300°C

## Operating Conditions

Operating Voltage Range ..... +4.75V to +5.25V  
 Operating Temperature Range ..... 0°C to +70°C  
 Reliability Information  
 $\theta_{ja}$  ..... 51.4°C/W (DIP), 77.0W/°C (SOIC)  
 $\theta_{jc}$  ..... 22.3°C/W (DIP), 23.2W/°C (SOIC)  
 Maximum Package Power Dissipation .... 1.5W (DIP), 1.0W (SOIC)

## D.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Logical One Input Voltage	$V_{IH}$	2.0	-	V	$V_{CC} = 5.25V$
Logical Zero Input Voltage	$V_{IL}$	-	0.8	V	$V_{CC} = 4.75V$
Output HIGH Voltage	$V_{OH}$	2.4	-	V	$I_{OH} = -6.5mA$ , $V_{CC} = 4.75V$
Output LOW Voltage	$V_{OL}$	-	0.5	V	$I_{OL} = +20.0mA$ , $V_{CC} = 4.75V$
Input Leakage Current	$I_I$	-10	10	$\mu A$	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.25V$
Output Leakage Current	$I_O$	-10	10	$\mu A$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.25V$
Standby Power Supply Current	$I_{CCSB}$	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.25V$ Outputs Open
Operating Power Supply Current	$I_{CCOP}$	-	12	mA	$f = 5.0MHz$ , $V_{IN} = V_{CC}$ or GND $V_{CC} = 5.25V$ , Outputs Open, Note 1

## Capacitance ( $T_A = +25^\circ C$ , Note 3)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Input Capacitance	$C_{IN}$	-	12	pF	FREQ = 1 MHz, $V_{CC}$ = Open, all measurements are referenced to device ground.
Output Capacitance	$C_O$	-	12	pF	

## A.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C, Note 2)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS (Note 2)
Clock to Data Out	$T_{PD}$	-	21	ns	
Mux Select to Data Out	$T_{SELD}$	-	20	ns	
Input Setup Time (D0-7/I0-7)	$T_S$	10	-	ns	
Input Hold Time (D0-7/I0-7)	$T_H$	3	-	ns	
Output Enable Time	$T_{ENA}$	-	20	ns	
Output Disable Time	$T_{DIS}$	-	13	ns	Note 3
Clock Pulse Width	$T_{PW}$	10	-	ns	

### NOTES:

- Power supply current is proportional to frequency. Typical rating for  $I_{CCOP}$  is 2.4mA/MHz.
- A.C. Testing is performed as follows: Input levels: 0V and 3.0V, Timing reference levels = 1.5V, Input rise and fall times driven at 1ns/V, Output load  $C_L = 40pF$ .
- Controlled by design or process parameters and not directly tested. Characterized upon initial design and after major design and/or process changes.

### Absolute Maximum Ratings

Supply Voltage ..... +8.0V  
 Input or Output Voltage Applied ..... GND -0.5V to  $V_{CC} + 0.5V$   
 Storage Temperature Range ..... -65°C to +150°C  
 Junction Temperature ..... +150°C  
 Lead Temperature (Soldering, Ten Seconds) ..... +300°C

### Operating Conditions

Operating Voltage Range ..... +4.75V to +5.25V  
 Operating Temperature Range ..... 0°C to +70°C  
 Reliability Information  
 $\theta_{JA}$  ..... 51.4°C/W  
 $\theta_{JC}$  ..... 22.3°C/W  
 Maximum Package Power Dissipation ..... 1.5W

### D.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Logical One Input Voltage	$V_{IH}$	2.0	-	V	$V_{CC} = 5.25V$
Logical Zero Input Voltage	$V_{IL}$	-	0.8	V	$V_{CC} = 4.75V$
Output HIGH Voltage	$V_{OH}$	2.4	-	V	$I_{OH} = -2.0mA$ , $V_{CC} = 4.75V$
Output LOW Voltage	$V_{OL}$	-	0.5	V	$I_{OL} = +12.0mA$ , $V_{CC} = 4.75V$
Input Leakage Current	$I_I$	-10	10	$\mu A$	$V_{IN} = GND$ or $V_{CC}$ , $V_{CC} = 5.25V$
Output Leakage Current	$I_O$	-10	10	$\mu A$	$V_{OUT} = V_{CC}$ or GND $V_{CC} = 5.25V$
Standby Power Supply Current	$I_{CCSB}$	-	500	$\mu A$	$V_{IN} = V_{CC}$ or GND $V_{CC} = 5.25V$ Outputs Open
Operating Power Supply Current	$I_{CCOP}$	-	12	mA	$f = 5.0MHz$ , $V_{IN} = V_{CC}$ or GND $V_{CC} = 5.25V$ , Outputs Open, Note 1

### Capacitance ( $T_A = +25^\circ C$ , Note 3)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS
Input Capacitance	$C_{IN}$	-	12	pF	$FREQ = 1MHz$ , $V_{CC} = Open$ , all measurements are referenced to device ground.
Output Capacitance	$C_O$	-	12	pF	

### A.C. Electrical Specifications ( $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0^\circ C$ to +70°C Note 2)

PARAMETER	SYMBOL	MIN	MAX	UNITS	TEST CONDITIONS (Note 2)
Clock to Data Out	$T_{PD}$	-	25	ns	
Mux Select to Data Out	$T_{SELD}$	-	25	ns	
Input Setup Time (D0-7, I0-1)	$T_S$	15	-	ns	
Input Hold Time (D0-7, I0-1)	$T_H$	3	-	ns	
Output Enable Time	$T_{ENA}$	-	25	ns	
Output Disable Time	$T_{DIS}$	-	20	ns	Note 3
Clock Pulse Width	$T_{PW}$	13	-	ns	

#### NOTES:

- Power supply current is proportional to frequency. Typical rating is 2.4mA/MHz.
- A.C. Testing is performed as follows: Input levels: 0V and 3.0V, Timing reference levels = 1.5V, Input rise and fall times driven at 1ns/V, Output load  $C_L = 40pF$ .
- Controlled by design or process parameters and not directly tested. Characterized upon initial design and after major design and/or process changes.



## Timing Waveform

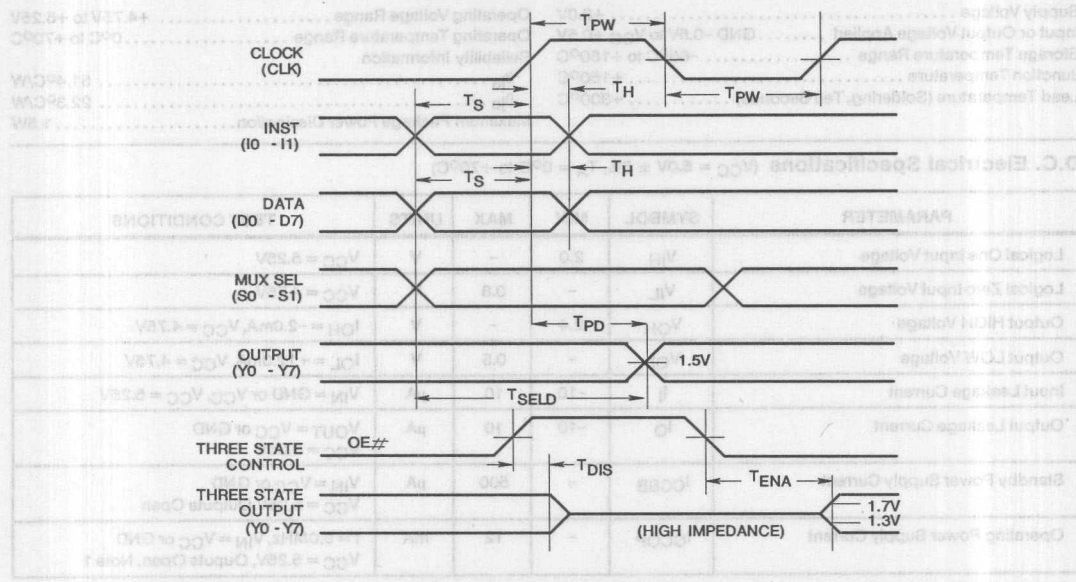


TABLE 1. INSTRUCTION CONTROL

I1	I0	'9520	'9521
0	0	<div style="display: flex; justify-content: space-around;"> <div style="text-align: center;">A1 ↓ A2</div> <div style="text-align: center;">B1 ↓ B2</div> </div>	<div style="display: flex; justify-content: space-around;"> <div style="text-align: center;">A1 ↓ A2</div> <div style="text-align: center;">B1 ↓ B2</div> </div>
0	1	(HSP (952004.GEM)) <div style="display: flex; justify-content: space-around;"> <div style="text-align: center;">A1 ↓ A2</div> <div style="text-align: center;">B1 ↓ B2</div> </div>	<div style="display: flex; justify-content: space-around;"> <div style="text-align: center;">A1 ↓ A2</div> <div style="text-align: center;">B1 ↓ B2</div> </div>
1	0	<div style="display: flex; justify-content: space-around;"> <div style="text-align: center;">A1 ↓ A2</div> <div style="text-align: center;">B1 ↓ B2</div> </div>	<div style="display: flex; justify-content: space-around;"> <div style="text-align: center;">A1 ↓ A2</div> <div style="text-align: center;">B1 ↓ B2</div> </div>
1	1	ALL REGISTERS HOLD	ALL REGISTERS HOLD

TABLE 2. REGISTER SELECT

S1	S0	'9520 OR '9521
0	0	B2
0	1	B1
1	0	A2
1	1	A1

## DEVELOPMENT TOOLS

	PAGE
<b>DATA SHEETS</b>	
Deci • Mate	Harris HSP43220 Decimating Digital Filter Development Software ..... 7-3
HSP-EVAL	DSP Evaluation Platform ..... 7-7
HSP45116-DB	HSP45116 Daughter Board ..... 7-8

# DSP

# 7

## DEVELOPMENT TOOLS

PAGE

DATA SHEETS

Deci-Move

HSP-EVAL

HSP48118-DB

Ham's HSP43250 Decimating Digital Filter Development Software .....

DSP Evaluation Platform .....

HSP48118 Daughter Board .....

TOOLS  
DEVELOPMENT



# HARRIS

# DECI•MATE™

## Harris HSP43220 Decimating Digital Filter Development Software

May 1991

Harris DECI•MATE Development Software assists the design engineer to prototype designs for the Harris HSP43220 Decimating Digital filter (DDF). Developed specifically for the DDF, this software consists of three integrated modules: DDF Design, DDF Simulator and DDF PROM. The Design module designs a filter from a set of user specifications for the DDF. The Simulator module models the DDF's internal operation. The PROM module uses the device configuration created by the Design module to build a PROM data file that can be used to store and download the DDF configuration.

### DDF System Design

The DDF consists of two stages: a High Decimation Filter (HDF) and a Finite Impulse Response (FIR) filter. Together these provide a unique narrow band, low pass filter. Because of this unique architecture, special software is required to configure the device for a given set of filter parameters. This software uses system level filter parameters (listed below) to perform the trade off analysis and calculate the values for the DDF's configuration registers and FIR coefficients.

Design specifications are supplied by the user in terms of:

1. Input sample frequency
2. Required output sample frequency
3. Passband signal bandwidth
4. Transition bandwidth
5. Amount of attenuation allowed in the passband
6. Amount of stopband attenuation required for signals outside of the band of interest.

This information is entered into a menu screen (See Figure 1), providing immediate feedback on the design validity. The design module calculates the order of the HDF, HDF decimation required, the FIR input data rate, minimum clock frequency for the FIR, FIR order and decimation required in the FIR.

The design module will then generate the FIR filter. Four different methods are provided for the FIR design:

1. A Standard FIR automatically designed by the module using the Parks-McClellan method to compute the coefficients of an equiripple (Chebyshev) filter.
2. Any FIR imported into the Design module from another FIR design program.
3. A precompensated FIR which is automatically designed by the module to compensate for the roll-off in the passband of the HDF frequency response.
4. The FIR may also be bypassed in which case the optimal HDF is designed from the user specifications.

Frequency response curves are then displayed showing the resulting responses in the HDF, FIR and for the entire chip using the given filter design. Figure 2 is a typical display. The user may save this frequency response data for further analysis. The design module also creates a report file documenting the filter design and providing the coefficients and setup register values for programming the device.

### DDF Simulator

The simulator provides an accurate simulation of the device before any hardware is built. It can be used to simulate any filter designed with DECI•MATE. The simulator takes into account the fixed point bus widths and pipeline delays for every element in the DDF.

The simulator provides the user with an input signal which can be used to stimulate the filter. This signal is created from the options shown in Table 1. The user can select a pure step, impulse, cosine, chirp, uniform or Gaussian noise as the input signal, or a more complex signal can be generated by combining that data with an option selected from the Signal #2 column, with the combining operator chosen from the middle column. The user can also import a signal from an outside source.

SIGNAL #1	OPERATION	SIGNAL #2
Step		Step
Impulse	No Operation	Impulse
COSINE	Add	COSINE
Chirp	Concatenate	Chirp
Uniform Noise	Multiply	Uniform Noise
Gaussian Noise		Gaussian Noise
Imported From Outside		

Probes are provided to select specific areas to graphically display data values as well as save into data files for further processing. The DDF Simulator has two levels; the DDF Simulator Specification screen and the DDF Simulator Main Screen.

The specification screen (see Figure 3) is used to input the simulation parameters. The users selects display modes in either continuous or decimated format and data formats in either decimal or hexadecimal. The specification screen also provides for selection of the input signal.

The simulator main screen (see Figure 4) defines the simulator test probes and displays the data values per clock cycle. The interactive simulator screen consists of the HSP43220 block diagram, test probes and register contents. The user selects the step size of the input sample clock and also selects the probes to be monitored. The simulator will then clock through the specified number of clock cycles and display the resulting time domain response. Figure 5 shows a typical probe display.



## Monarch 2.0 DSP Design Software

DECI•MATE is fully integrated with Monarch 2.0 professional DSP design software. Monarch is a full-featured DSP package with FIR IIR filter design and analysis, Two dimensional and Three dimensional viewing, a programmable signal/systems laboratory with 100+ DSP/Math functions, extensive fixed-point support and FFTs/IFFTs. Monarch is available separately from The Athena Group, Inc.

When used with Monarch 2.0, DECI•MATE becomes a full feature design environment for a DSP system. Data can easily be transferred from DECI•MATE modules to the Monarch modules for further analysis.

## System Requirements

IBM PC™, XT™, AT™, PS/2™ computer or 100% compatible with 640k RAM running MS/PC-DOS 2.0 or higher. One MegaByte of fixed-disk space with 5.25" or 3.5" floppy drive. CGA, MCGA, EGA, VGA, 8514, or Hercules graphics adapter. A Math co-processor is strongly recommended.

The simulator provides an accurate simulation of the device before any hardware is built. It can be used to simulate any filter designed with DECI•MATE. The simulator takes into account the fixed point bus widths and pipeline delays for every element in the DDF.

The simulator provides the user with an input signal which can be used to simulate the filter. This signal is created by the user and is shown in Table 1.

DESIGN MODULE	SIMULATOR MODULE	PROM MODULE
HSP43220 DDF FILTER SPECIFICATION		
D	Filter File : PRES.DDF	
E	Input Sample Rate : 33 MHz	Design Mode : AUTO
	Output Rate : 100 kHz	Generate Report : YES
	Passband : 5 kHz	Display Response : LOG
C	Transition Band : 700 Hz	Save Freq Responses : YES
	Passband Atten : 1 dB	Save FIR Response : YES
I	Stopband Atten : 96 dB	
•	FIR Type : STANDARD	
M		
A	HDF Order : 4	FIR Input Rate : 100 kHz
T	HDF Decimation : 330	FIR Clock (min) : 33 MHz
E	HDF Scale Factor : 0.6903	FIR Order : 509
		FIR Decimation : 1

FIGURE 1. FILTER SPECIFICATION MENU

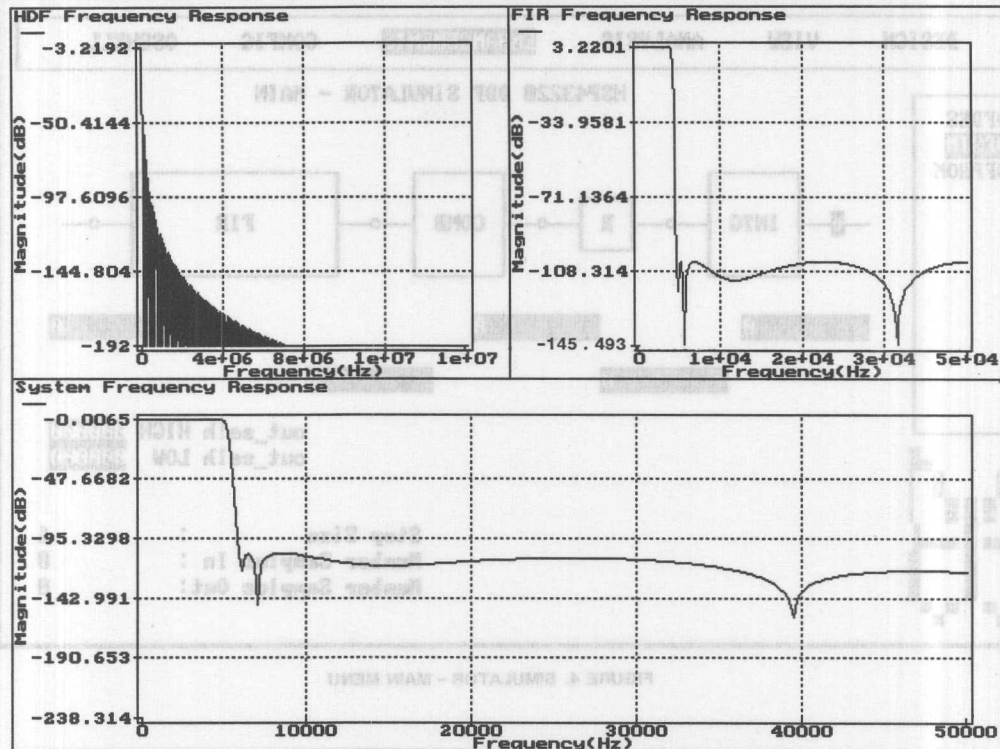


FIGURE 2. FREQUENCY DISPLAY

DESIGN MODULE	SIMULATOR MODULE	PROM MODULE
HSP43220 DDF SIMULATOR SPECIFICATION		
D	Filter File : PRES.DAR	
E	Probe Display : HEX	
E	Save Cont. Output : YES	Input Rate : 33 MHz
C	Display Mode : CONTINUOUS	Output Rate : 100 kHz
I	INPUT SIGNAL SPECIFICATION	
•	Signal Origin : GENERATED	
M	Signal #1 : COSINE	Amplitude 1.00 Frequency 5 kHz Phase 0.00
A	Operator : +	
T	Signal #2 : GAUSS	Mean 0.00 StdDev 0.500000
E		

FIGURE 3. SPECIFICATION MENU

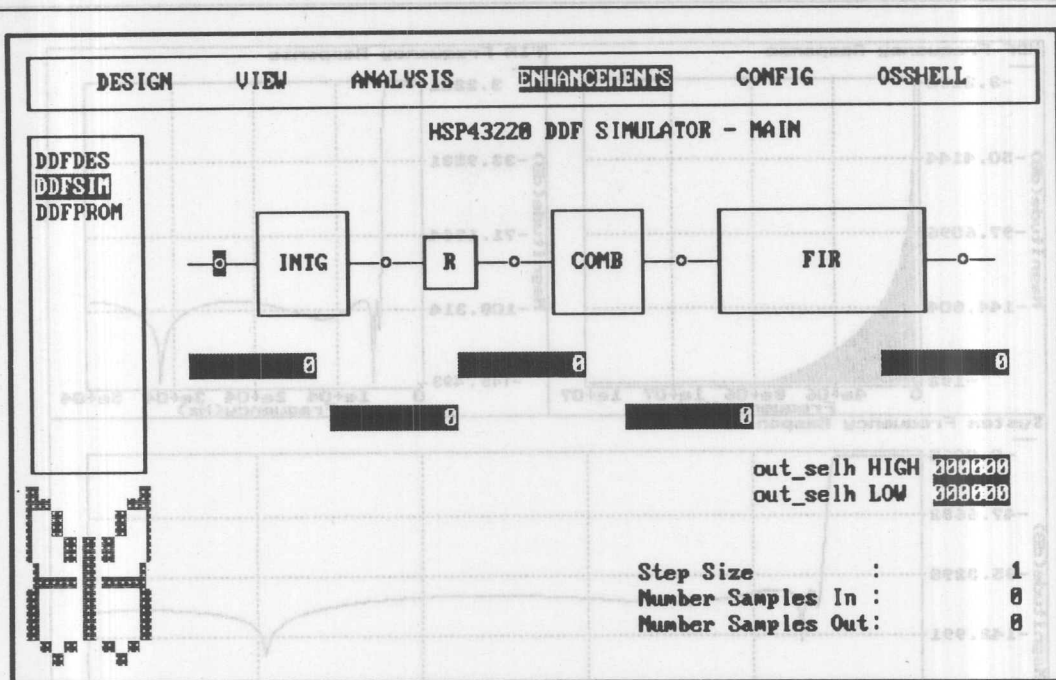


FIGURE 4. SIMULATOR - MAIN MENU

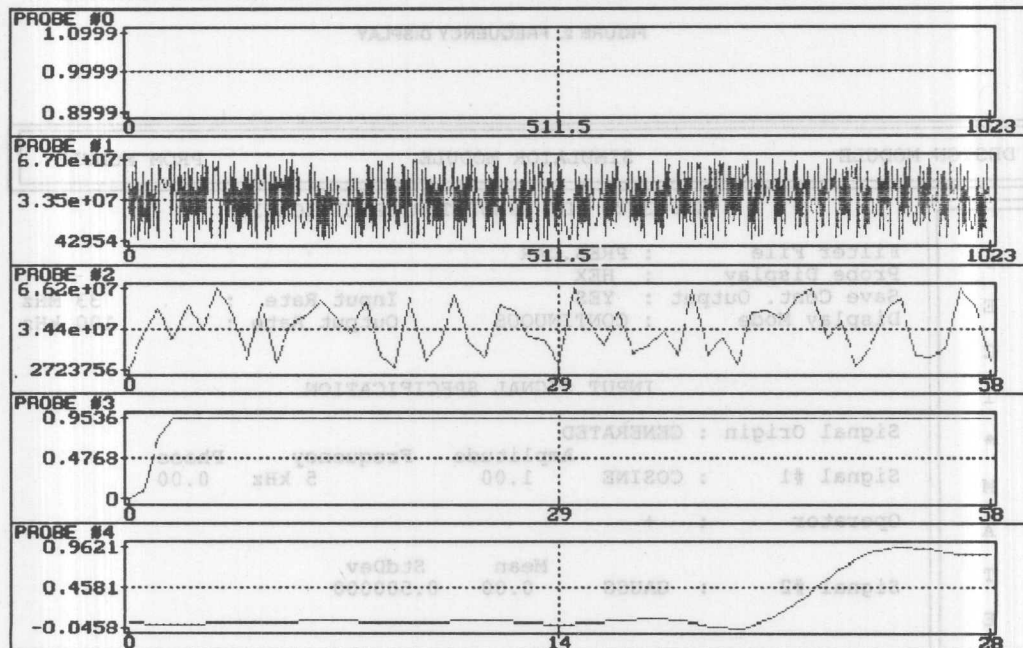


FIGURE 5. SIMULATOR PROBE DISPLAY

August 1992

## DSP Evaluation Platform

### Features

- Single HSP-EVAL May be Used to Evaluate a Variety of Parts within the HSPXXXXX Family
- May be Daisy Chained to Support Evaluation of Multi-chip Solutions
- Parallel Port Interface to IBM PC to Simplify Evaluation Board I/O
- Three Clocking Modes for Flexibility in Performance Analysis and Prototyping
- C Based Software Template for Data I/O Between IBM PC and Evaluation Board
- Dual 96-Pin DIN Connector for High Speed I/O

### Applications

- PC Based Performance Analysis of HSPXXXXX Family of DSP
- Rapid Prototyping

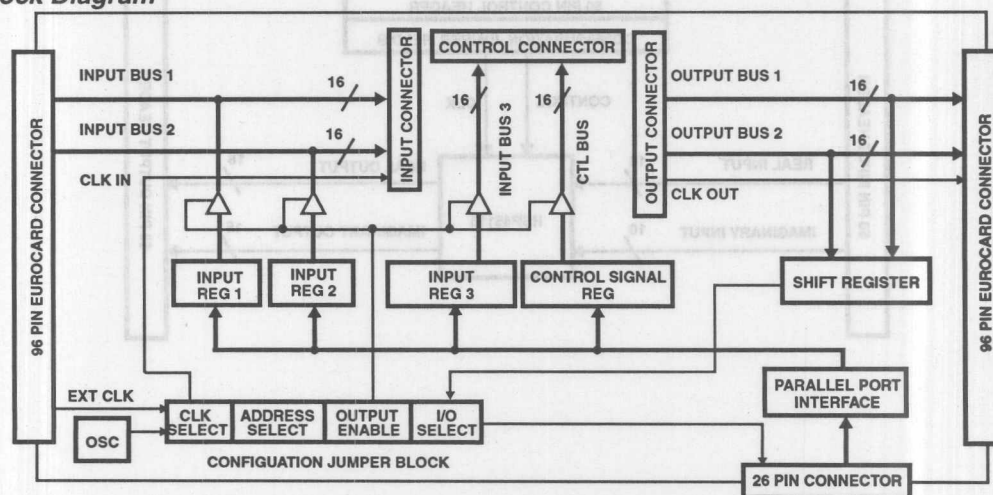
### Description

The HSP-EVAL is the mother board for a set of daughter boards based on the HSPXXXXX family of Digital Signal Processing products. Each product specific daughter board is mated with the HSP-EVAL to provide a mechanism for rapid evaluation and prototyping. As shown in the block diagram, the HSP-EVAL consists of input, control, and output busses which provide I/O data paths to the target daughter board. These busses are brought out through dual 96 Pin connectors to support daisy chaining HSP-EVAL's for multichip prototyping. The input and control busses can be driven by registers which are down loaded with data via the parallel port of an IBM PC or compatible. Besides using the PC to drive the daughter board inputs, the PC can also read daughter board outputs which have been serialized by the shift register on the output bus. For high speed I/O, the VME compatible, 96-Pin DIN, connectors are provided as an alternative data path for HSP-EVAL I/O and control.

Jumper selectable clock sources provide three different methods of clocking the part under evaluation. In mode one, the clock signal is generated under PC based software control. In mode two, the onboard oscillator may be selected as the clock source. In mode three, the user may provide an external clock through a DIN connector.

A PC based software interface is available to simplify I/O to the HSP-EVAL. In modes where the HSP-EVAL is configured to provide the daughter board with a high speed clock, the interface software can be used for real time control and configuration. For modes in which the HSP-EVAL is configured to provide a software generated clock, the interface software can drive the daughter board inputs with a user defined data set while collecting daughter board outputs to the PC's disk.

### Block Diagram



CAUTION: These devices are sensitive to electrostatic discharge. Users should follow proper I.C. Handling Procedures.  
 Copyright © Harris Corporation 1992

File Number 3366



August 1992

## HSP45116 Daughter Board

### Features

- Designed for Use with HSP-EVAL
- Access to HSP45116's Input, Output, and Control Signals Through Three 50 Pin Headers
- Jumper Configuration Field as Alternative for Programming Control Inputs
- C Based Software to Support HSP45116 I/O and Control When Used with HSP-EVAL
- High Speed I/O Supported

### Applications

- PC Based Performance Analysis of HSP45116 When Used with HSP-EVAL
- Rapid Prototyping

### Description

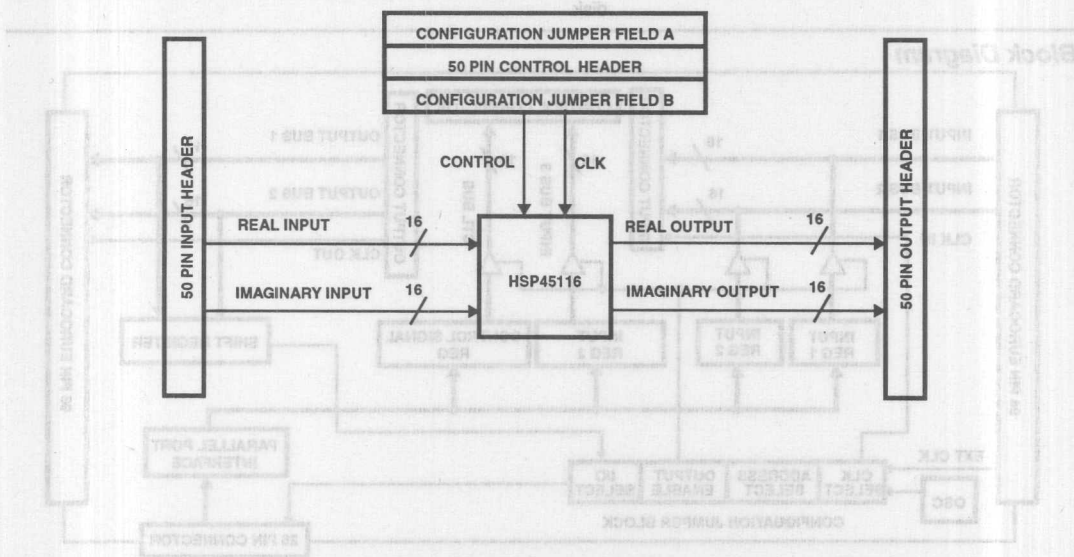
The HSP45116-DB is a daughter board designed to mate with the HSP-EVAL for rapid evaluation and prototyping of the HSP45116 Numerically Controlled Oscillator Modulator. Together this combination of boards provides a mechanism to evaluate HSP45116 operation using IBM PC based I/O and control. As shown in the block diagram, the HSP45116-DB maps the input, output, and control signals of the HSP45116 to three 50 pin connectors. These connectors mate the HSP45116's various I/O and control signals with the HSP-EVAL's data busses. Thus, a path is established for PC based I/O and control.

A IBM PC based software package is provided which controls HSP45116-DB operation through the HSP-EVAL. The software package provides the user with a DOS command line or menu driven interface for daughter board I/O and control. Since the software supports data acquisition from the HSP45116, software based signal analysis may be used to quantify part performance.

The degree of control exerted by the software varies depending upon the clock provided to the HSP45116-DB. If a high speed clock is provided via the HSP-EVAL's on board oscillator or external clock pin, the software can be used to exert real time control. If a software controlled clock is provided, the HSP45116-DB can be driven with a user defined data set while storing results back to the PC for later analysis.

The HSP45116-DB is a 6 layer printed circuit board which comes populated with one HSP45116GC-25. The PC based software required to control the daughter board via the HSP-EVAL is also provided.

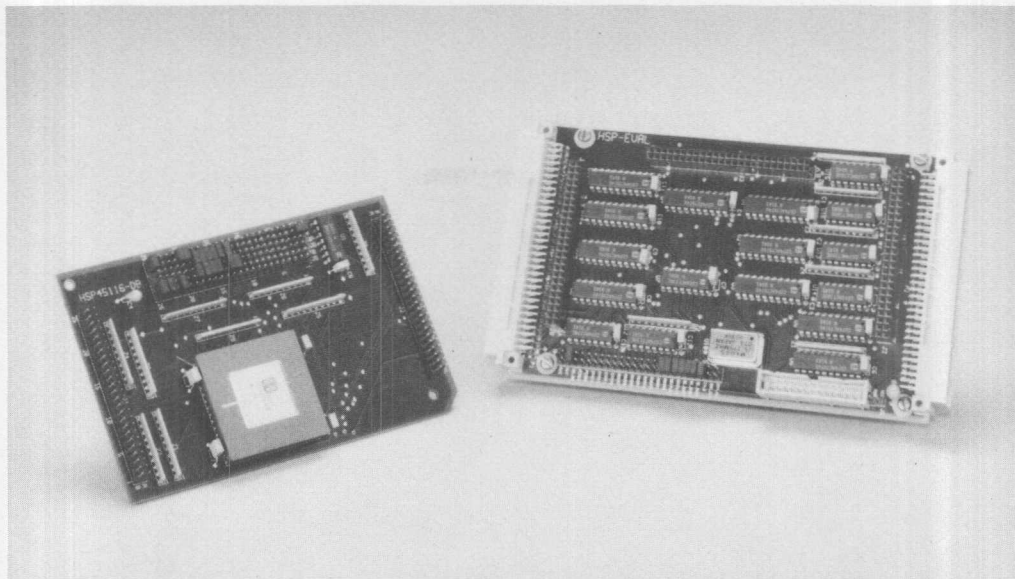
### Block Diagram



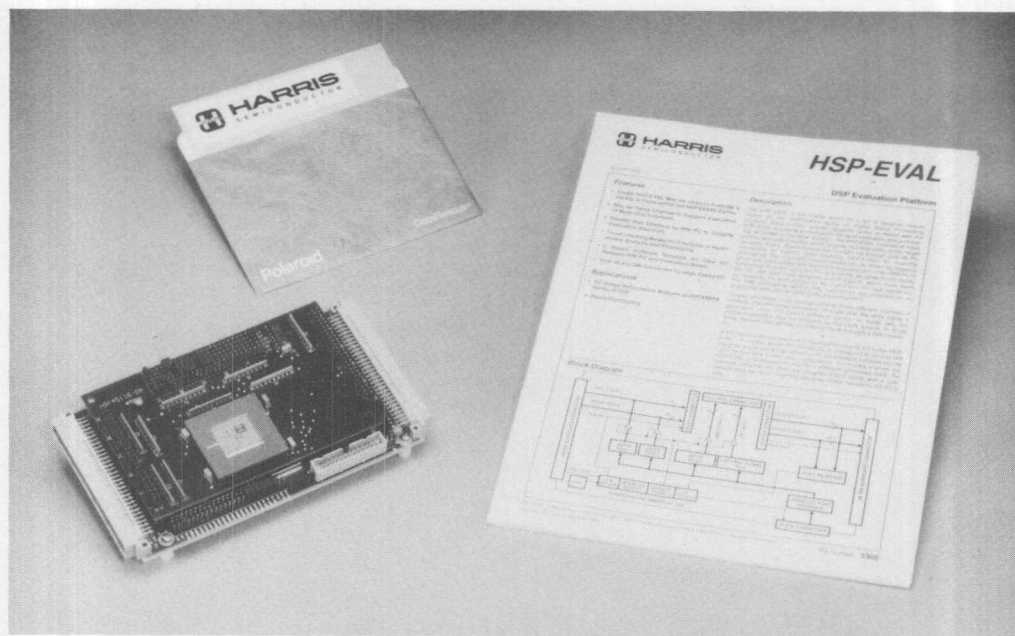
CAUTION: These devices are sensitive to electrostatic discharge. Users should follow proper I.C. Handling Procedures.  
 Copyright © Harris Corporation 1992

 File Number **3367**

## HSP45116-DB



The evaluation hardware for the HSP family of products consists of the motherboard, which forms the interface to the PC, and the daughterboard, which carries the part under evaluation.



The hardware to evaluate the HSP45116 consists of the HSP-EVAL motherboard and the HSP45116-DB daughterboard. Two software packages are provided for the data and control interface between the HSP45116-DB and the PC. One is menu driven and the other accepts DOS command lines.



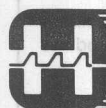
## APPLICATION NOTES

APPLICATION NOTE NUMBER		PAGE
AN116	Extended Digital Filter Configurations .....	8-3
AN9205	Timing Relationships for HSP45240 .....	8-13
AN9206	Correlating on Extended Data Lengths .....	8-15
AN9102	Noise Aspects of Applying Advanced CMOS Semiconductors .....	8-17
AN9207	Temperature Considerations .....	8-26



## APPLICATION NOTES

PAGE	APPLICATION NOTE NUMBER	
8-3	AN118	Extended Digital Filter Configurations
8-13	AN320B	Timing Relationships for HSP43240
8-15	AN320C	Correlating an Extended Data Length
8-17	AN610C	Noise Aspects of Applying Advanced CMOS Semiconductors
8-28	AN330V	Temperature Considerations



# APPNOTE

No. 116 May 1991

## Harris Signal Processing

### EXTENDED DIGITAL FILTER CONFIGURATIONS

#### Introduction

Harris HSP43891/881/481 Digital Filters (DFs) perform high speed sum-of-products operations. These video speed devices operate at 30MHz, offering substantial improvement in processing speed over other available technology. Throughputs in excess of 30MHz are achieved using multiple devices.

The DF data sheet explains how multiple DFs can be easily cascaded to achieve long filters with 8 bit data and coefficients. This note presents extensions of the basic cascaded configuration for:

- Designing Extended Length Filters Using a Single Device (the Number of Taps Exceeds the Number of Cells).
- Implementing Higher Precision (Greater Than 8 or 9 Bits) Full Speed Designs Using Multiple Devices.
- Implementing Higher Precision Designs Using a Single Device.

It is assumed that the reader has a basic knowledge of filter design and some digital hardware experience. Readers who require more detailed information on the electrical characteristics of the DF family devices should refer to the Harris DF engineering data sheets. Harris also provides a comprehensive set of hardware and software development tools.

#### The Finite Impulse Response Filter

The finite impulse response (FIR) filter is simply a finite-length sum-of-products digital filter. Each output sample is a weighted sum of the new input value and the L-1 previous

inputs, where L is the order of the filter. With the tapped delay line architecture (Figure 1) the filter coefficients remain fixed while the input data shifts from cell to cell on each clock cycle.

The DF's architecture (Figure 2) is different from the traditional tapped delay line filter. In the DF the filter coefficients shift from cell to cell with each clock cycle. As each new data sample becomes available it is distributed to all of the cells at the same time. In addition, every DF cell contains its own multiplier and accumulator. This allows each cell to maintain an independent sum-of-products in its accumulator. A new output value becomes available on each clock cycle by properly sequencing the filter coefficients through the cells.

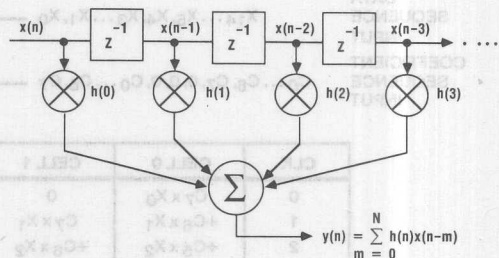


FIGURE 1. DIRECT FORM REPRESENTATION OF FIR FILTER

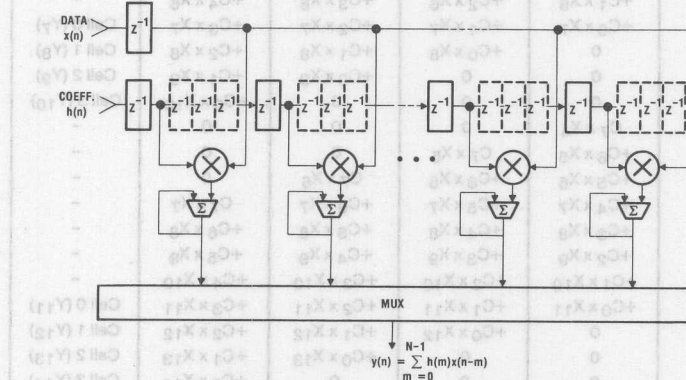


FIGURE 2. DF CELL DIAGRAM

Each cell's accumulator is cleared after its contents are output. This allows accumulation of the next sum-of-products to begin. Note that the filter coefficients enter from the left, shifting one cell to the right with each clock cycle.

A single device may be used to implement filters with a large number of coefficients. In this case the number of filter taps will exceed the number of DF cells. This requires manipulating the input data and filter coefficient sequences, maintaining the proper sum-of-products in each cell's accumulator. This implementation is described in greater detail in the following section.

#### Eight Tap Filter With a Four Cell Device

A simple example is the best way to demonstrate how data and coefficients are properly sequenced. Table 1 illustrates the situation when an eight tap filter is computed in a single 4 cell HSP43481. The table lists information in six columns. The first column shows the initial 21 clock cycles, which is enough to evaluate the example. The next four columns represent the actions taking place in each of the four DF cells as a function of the clock. The final column shows the output results, also a function of the clock.

Within the filter cell are internal pipeline delays. The result is a startup delay of three CLKs before the data and coefficients present at the input of the DF are processed and stored in the accumulator of the first cell. This delay is not

relevant to the sequential operation of the DF and will be ignored in subsequent discussions (also ignored in Table 1).

The basic computational sequence is shown below:

**CLK 0** - Initial data point  $X_0$  is made available to all four cells. At the same time coefficient  $C_7$  enters Cell 0.

- The First Product ( $C_7 \times X_0$ ) is Computed and Stored in Accumulator of Cell 0.

**CLK 1** -  $X_1$  is made available to all four cells. At the same time coefficient  $C_6$  enters Cell 0, shifting  $C_7$  to Cell 1.

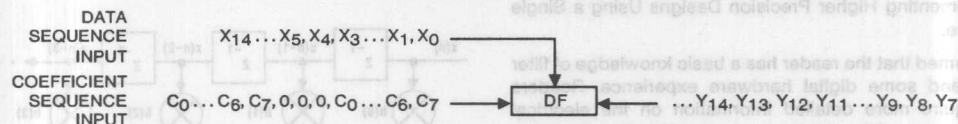
- The Accumulator of Cell 0 is Updated With the Additional Term  $C_6 \times X_1$ .
- The Product  $C_7 \times X_1$  is Computed and Stored in Accumulator of Cell 1.

**CLK 2** -  $X_2$  is made available to all four cells. At the same time coefficient  $C_5$  enters Cell 0, shifting  $C_7$  to Cell 2 and  $C_6$  to Cell 1.

- The Accumulator of Cell 0 is Updated With the Additional Term  $C_5 \times X_2$ .
- The Accumulator of Cell 1 is Updated With the Additional Term  $C_6 \times X_2$ .
- The Product  $C_7 \times X_2$  is Computed and Stored in Accumulator of Cell 2.

•  
•  
•  
etc.

TABLE 1. HSP43481 8 TAP FIR FILTER SEQUENCE USING SINGLE 4 CELL DEVICE



CLK	CELL 0	CELL 1	CELL 2	CELL 3	SUM/CLR
0	$C_7 \times X_0$	0	0	0	-
1	$+C_6 \times X_1$	$C_7 \times X_1$	0	0	-
2	$+C_5 \times X_2$	$+C_6 \times X_2$	$C_7 \times X_2$	0	-
3	$+C_4 \times X_3$	$+C_5 \times X_3$	$+C_6 \times X_3$	$C_7 \times X_3$	-
4	$+C_3 \times X_4$	$+C_4 \times X_4$	$+C_5 \times X_4$	$+C_6 \times X_4$	-
5	$+C_2 \times X_5$	$+C_3 \times X_5$	$+C_4 \times X_5$	$+C_5 \times X_5$	-
6	$+C_1 \times X_6$	$+C_2 \times X_6$	$+C_3 \times X_6$	$+C_4 \times X_6$	-
7	$+C_0 \times X_7$	$+C_1 \times X_7$	$+C_2 \times X_7$	$+C_3 \times X_7$	Cell 0 ( $Y_7$ )
8	0	$+C_0 \times X_8$	$+C_1 \times X_8$	$+C_2 \times X_8$	Cell 1 ( $Y_8$ )
9	0	0	$+C_0 \times X_9$	$+C_1 \times X_9$	Cell 2 ( $Y_9$ )
10	0	0	0	$+C_0 \times X_{10}$	Cell 3 ( $Y_{10}$ )
11	$C_7 \times X_4$	0	0	0	-
12	$+C_6 \times X_5$	$C_7 \times X_5$	0	0	-
13	$+C_5 \times X_6$	$+C_6 \times X_6$	$C_7 \times X_6$	0	-
14	$+C_4 \times X_7$	$+C_5 \times X_7$	$+C_6 \times X_7$	$C_7 \times X_7$	-
15	$+C_3 \times X_8$	$+C_4 \times X_8$	$+C_5 \times X_8$	$+C_6 \times X_8$	-
16	$+C_2 \times X_9$	$+C_3 \times X_9$	$+C_4 \times X_9$	$+C_5 \times X_9$	-
17	$+C_1 \times X_{10}$	$+C_2 \times X_{10}$	$+C_3 \times X_{10}$	$+C_4 \times X_{10}$	-
18	$+C_0 \times X_{11}$	$+C_1 \times X_{11}$	$+C_2 \times X_{11}$	$+C_3 \times X_{11}$	Cell 0 ( $Y_{11}$ )
19	0	$+C_0 \times X_{12}$	$+C_1 \times X_{12}$	$+C_2 \times X_{12}$	Cell 1 ( $Y_{12}$ )
20	0	0	$+C_0 \times X_{13}$	$+C_1 \times X_{13}$	Cell 2 ( $Y_{13}$ )
21	0	0	0	$+C_0 \times X_{14}$	Cell 3 ( $Y_{14}$ )

This process continues until eight taps have been computed and accumulated in each cell. This happens first in Cell 0, followed one CLK later by Cell 1, two CLKs later by Cell 2, and three CLKs later by Cell 3. Output points become available after each cell accumulates the sum of eight taps in the order given above.

After Cell 3's output becomes available, we are ready to begin work on the next four output points. We can cycle the eight filter coefficients in the same fashion as before but the input data is out of sequence. Before computing the fifth output point the DF requires  $X_4$  to be available at the data input. Since  $X_4$  passed by seven CLKs ago (during CLK 4) some method of storing the previous seven data points is necessary.

In order to access the previous seven data values they must have been originally stored in some form of sequential memory. FIFOs work very well and will be discussed in the next section. Starting with CLK 11 the taps once more begin to accumulate in each of the four cells.

The result of re-accessing data after every four output points is to lower the effective throughput. The output rate drops about fifty percent to a rate of four output points for every eleven CLKs.

### ***L Tap Filter With an N Cell Device Where $L > N$***

The example above leads to the more general case of implementing an L tap filter with an N cell device ( $L > N$ ). When an L tap filter is implemented using an N cell DF (where  $L > N$ ), the DF computes a block of N filter output samples at a time. Between these output blocks there are L-1 CLK cycles during which no valid output points are available. Therefore, generating a block of N output points requires L+N-1 CLKs. During these L+N-1 CLKs there are L+N-1 new input samples being clocked into the DIN (Data IN) port.

It can be seen from Table 1 that N outputs are read out of the DF during the last N CLKs of each L+N-1 CLK sequence. After inputting the first L data samples N-1 CLKs are required to flush the coefficients from the cells. The final L-1 of the previous L+N-1 input samples must be re-submitted at the input port. After the outputs are read out an additional L+N-1 samples are fed in and the process repeats itself until no more data is available.

In this paper, throughput is defined as the average rate at which outputs are computed by the DF. When the number of taps exceeds the number of filter cells, the necessity to re-access the data stream determines the maximum throughput. The generalized performance of an L tap, 8x8 FIR filter is shown below. Let:

L = Number of taps

N = Number of filter cells in DF

R = Maximum clock rate of DF (20, 25.6, or 30MHz)

$F_s$  = Desired throughput (MHz) where  $R > F_s$

If L, N, and R are known then:

$$F_s = N \times R / (L + N - 1)$$

If L, R, and  $F_s$  are known then:

$$N = F_s (L - 1) / (R - F_s)$$

Since there are either four (HSP43481) or eight (HSP43881) cells in each DF, the required number of DFs can be computed as:

$$\# \text{ of 4 cell DFs} = N/4 \text{ (round up to next integer value)}$$

$$\# \text{ of 8 cell DFs} = N/8 \text{ (round up to next integer value)}$$

An example design with L = 128 taps,  $F_s$  = 5MHz, and R = 20MHz would yield:

$$N = 5 \times 127/15 = 43 \text{ cells}$$

$$\# \text{ of 4 cell DFs} = 43/4 = 11$$

$$\# \text{ of 8 cell DFs} = 43/8 = 6$$

Optimum arrangement =  $40/8 + 3/4$  = Five 8 cell and one 4 cell DFs.

The sequencing of the input data can be realized in various ways, with the simplest design using FIFOs. Figure 3 shows the block diagram of a design using an eight cell DF. The input data buffered in two FIFOs (each must have three-state outputs).

An 8 bit counter is configured to count modulo L+N-1. To initialize the system, the first L-1 data samples are passed through FIFO #1 and written into FIFO #2. While this occurs N more samples are clocked into FIFO #1. Following that a repetitive steady state sequence begins as shown below:

1. Clock the first L-1 samples from FIFO #2 into the DF.
2. Clock N samples from FIFO #1 into the DF.
3. Clock the last L-1 samples of the sequence in steps 1 and 2 back into FIFO #2.
4. Clock the next N samples into FIFO #1 concurrently with steps 1-3.

This sequence of steps 1 through 4 can be repeated ad infinitum.

The output data is available in blocks of N points separated by L-1 CLK cycles. FIFO #3 acts as a rate buffer for the output and is optional. The coefficient memory contains the L coefficients followed by the necessary N-1 zeros.

A design example using the above technique might include a 57 tap filter with a sample rate of 2.5MHz. This can be done with a single 8 cell device operating at 20MHz.

### ***Higher Precision Filters and Correlators***

Several digital filtering applications require wider wordwidth calculations to maintain precision. The DFs are designed to be flexible in creating filters with input precision levels of 8, 16, 24, 32 bits or greater.

The first step is to restructure the data and/or coefficients into 8 bit quantities which can be processed by the DF.



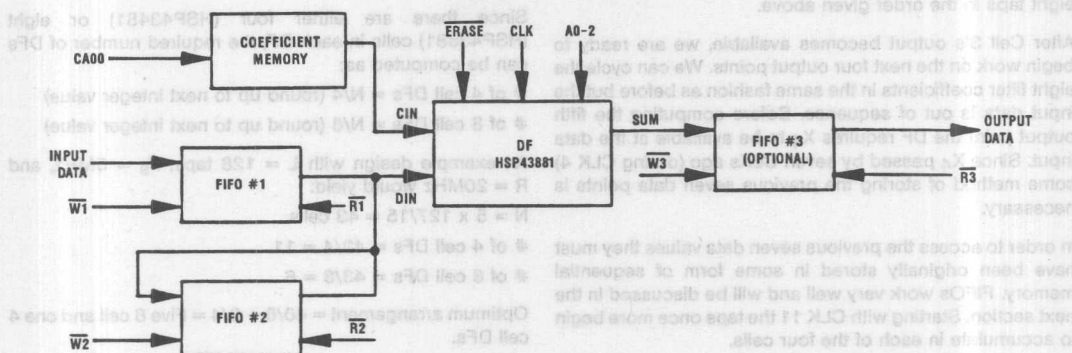


FIGURE 3. BLOCK DIAGRAM OF AN 8 CELL DF CONFIGURED TO IMPLEMENT EXTENDED FILTER LENGTHS (UP TO 249 TAPS)

These quantities are used to form the partial products of the larger multiplication involving the full precision data and coefficients. An example of segmenting the partial products of a 16x8 multiplication (16 bit coefficients and 8 bit data) would be:

$$C(16 \text{ bit}) = C_H \times 2^8 + C_L \times 2^0 \quad H = \text{High Order Byte}$$

$$X(8 \text{ bit}) = X \times 2^0 \quad L = \text{Low Order Byte}$$

Consequently,

$$C \times X = (C_H \times 2^8 + C_L \times 2^0) \times 2^0 \\ = C_H X \times 2^8 + C_L X \times 2^0$$

The process of convolution or correlation requires repeated multiply and accumulate operations. The resulting partial output word widths are a function of the number of MAC operations and of the coefficient scaling. Although each partial product is only 16 bits wide, the sum of the partial products in the output stage is allowed to accumulate up to a maximum width of 26 bits.

Care must be taken when combining the upper and lower partial sums-of-products into each complete output result. Figure 5 illustrates how the upper and lower sums of partial products for each output point must be re-combined. Sign extension must be used if more than 26 bits are required from the output stage representing the least significant sum of partial products.

Two separate techniques can be used in determining higher precision results:

1. Use separate DFs, combining the two partial products using external adders.
  - Throughput equals the clock rate of the DF.
2. Accumulate the two partial products in separate cells of a single DF.
  - The SHADD (Shift and ADD) feature of the output adder allows the data to be properly aligned and combined.
  - Throughput is determined by the number of taps, partial products, and DF cells, as well as the clock rate of the DF.

The equations describing the filtering operation are the same for either technique and can be given as:

$$y(n) = \sum_{i=0}^{N-1} C(i)X(n-i)$$

However:  $(C_H \times 2^8 + C_L)X = C_H X \times 2^8 + C_L X$

$$\text{Therefore: } y(n) = \sum_{i=0}^{N-1} C_H(i)X(n-i) \times 2^8 + \sum_{i=0}^{N-1} C_L(i)X(n-i)$$

Assuming the coefficients are represented as two's complement numbers, the least significant byte has to be treated as a positive (unsigned) number. The TCCI input of the DF is used to take care of this.

### Word-Size Extension at Full Speed

Full performance filters with extended precision data and/or coefficients are easily designed. This is achieved by computing the partial products in *separate* DFs and combining their results with external adders. When external adders are used the system performance is limited only by the throughput of the DF itself.

The filter equations listed directly above can be expanded into their partial products and grouped for processing. An

expansion of the first four output points resulting from the convolution of 16 bit coefficient and 8 bit data is shown in Table 2.

In this case, for a 4 tap filter, each device accumulates four partial products at once, one in each cell. The output adder combines these partial products into the proper result. The sequence table (Table 2) shows the results of the multiply accumulate operations for one device (DF0).

Figure 4 is a block diagram that directly implements the grouping given above. DF0 is generating the  $C_L X$  partial products while DF1 is generating the partial products for  $C_H X$ . The two 8x8 partial products are generated in separate DFs and combined with an external adder. Notice that the lower and upper coefficients bytes are separated and used to supply different DFs. Using this design the throughput is limited only by the DF (up to 30MHz).

The adder stage of Figure 4 merits further discussion. Each 4 cell DF has 26 output lines (SUM0-25). Therefore, if all the available bits were preserved we would have a 34 bit sum as shown in Figure 5. However, many designs require only 16 output bits. Which 16 bits are selected depends on the coefficient scaling and the input signal level.

TABLE 2. HSP43481 4 TAP SINGLE PARTIAL PRODUCT FIR FILTER

$$\begin{array}{ll}
 y(0) = C_H(0)X(0) \times 2^8 + C_L(0)X(0) & y(1) = C_H(0)X(1) \times 2^8 + C_L(0)X(1) \\
 + C_H(1)X(1) \times 2^8 + C_L(1)X(1) & + C_H(1)X(2) \times 2^8 + C_L(1)X(2) \\
 + C_H(2)X(2) \times 2^8 + C_L(2)X(2) & + C_H(2)X(3) \times 2^8 + C_L(2)X(3) \\
 + C_H(3)X(3) \times 2^8 + C_L(3)X(3) & + C_H(3)X(4) \times 2^8 + C_L(3)X(4) \\
 \begin{array}{|c|c|} \hline \text{DF1} & \text{DF0} \\ \hline \text{Cell 0} & \text{Cell 0} \end{array} & \begin{array}{|c|c|} \hline \text{DF1} & \text{DF0} \\ \hline \text{Cell 1} & \text{Cell 1} \end{array} \\
 \\
 y(2) = C_H(0)X(2) \times 2^8 + C_L(0)X(2) & y(3) = C_H(0)X(3) \times 2^8 + C_L(0)X(3) \\
 + C_H(1)X(3) \times 2^8 + C_L(1)X(3) & + C_H(1)X(4) \times 2^8 + C_L(1)X(4) \\
 + C_H(2)X(4) \times 2^8 + C_L(2)X(4) & + C_H(2)X(5) \times 2^8 + C_L(2)X(5) \\
 + C_H(3)X(5) \times 2^8 + C_L(3)X(5) & + C_H(3)X(6) \times 2^8 + C_L(3)X(6) \\
 \begin{array}{|c|c|} \hline \text{DF1} & \text{DF0} \\ \hline \text{Cell 2} & \text{Cell 2} \end{array} & \begin{array}{|c|c|} \hline \text{DF1} & \text{DF0} \\ \hline \text{Cell 3} & \text{Cell 3} \end{array} \\
 \vdots & \\
 \text{etc.} &
 \end{array}$$

CLK	CELL 0	CELL 1	CELL 2	CELL 3	OUTPUT
0	$C_{L3} \times X_{L0}$	0	0	0	
1	$+C_{L2} \times X_{L1}$	$C_{L3} \times X_{L1}$	0	0	
2	$+C_{L1} \times X_{L2}$	$+C_{L2} \times X_{L2}$	$C_{L3} \times X_{L3}$	0	
3	$+C_{L0} \times X_{L3}$	$+C_{L1} \times X_{L3}$	$+C_{L2} \times X_{L3}$	$C_{L3} \times X_{L3}$	Cell 0 (Y <sub>L3</sub> )
4	$C_{L3} \times X_{L4}$	$+C_{L0} \times X_{L4}$	$+C_{L1} \times X_{L4}$	$+C_{L2} \times X_{L4}$	Cell 0 (Y <sub>L4</sub> )
5	$+C_{L2} \times X_{L5}$	$C_{L3} \times X_{L5}$	$+C_{L0} \times X_{L5}$	$+C_{L1} \times X_{L5}$	Cell 0 (Y <sub>L5</sub> )
6	$+C_{L1} \times X_{L6}$	$+C_{L2} \times X_{L6}$	$C_{L3} \times X_{L6}$	$+C_{L0} \times X_{L6}$	Cell 0 (Y <sub>L6</sub> )
7	$+C_{L0} \times X_{L7}$	$+C_{L1} \times X_{L7}$	$+C_{L2} \times X_{L7}$	$C_{L3} \times X_{L7}$	Cell 0 (Y <sub>L7</sub> )

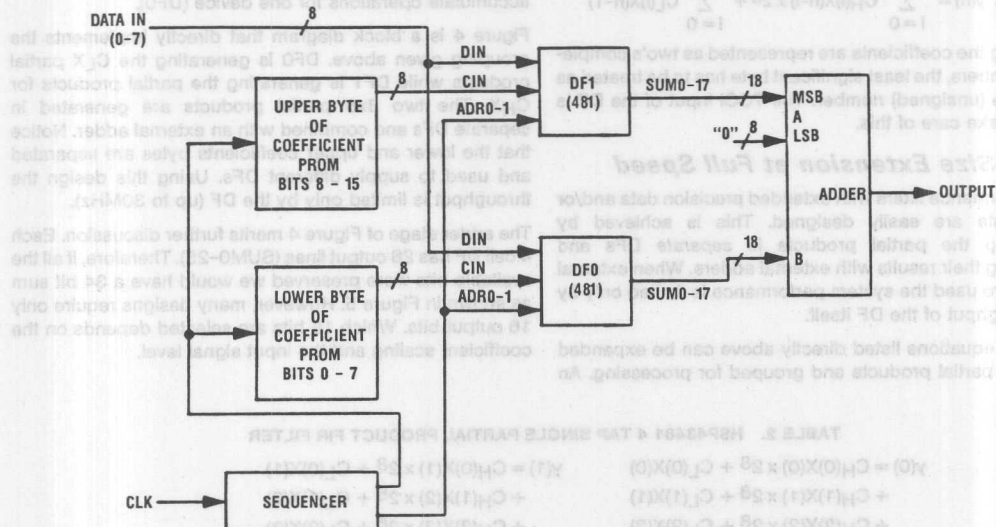


FIGURE 4. BLOCK DIAGRAM OF A 30MHz, 4 TAP, 16x8 FIR FILTER

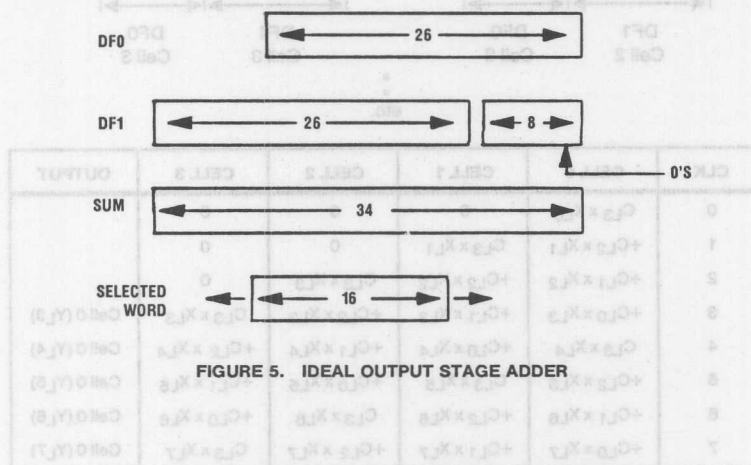


FIGURE 5. IDEAL OUTPUT STAGE ADDER

The results for the 16x8 example can be extended to the general case of more than four taps. Let:

$L$  = Number of taps

$N$  = Total number of filter cells required

$R$  = Maximum clock rate of DF (20, 25.6, or 30MHz)

$F_S$  = Desired throughput (MHz)

For a full speed ( $F_S = R$ ) 16x8 design:  $N = 2L$

There are either four (HSP43481) or eight (HSP43881) cells in each DF. Therefore, the number of DFs can be computed as:

# of 4 cell DFs =  $2 \times \lceil L/4 \rceil$  (rounded up to next integer value)

# of 8 cell DFs =  $2 \times \lceil L/8 \rceil$  (rounded up to next integer value)

An example design with  $L=15$  taps and  $F_S = R = 25\text{MHz}$  would yield:

# of 4 cell DFs =  $2 \times \lceil 15/4 \rceil = 8$

# of 8 cell DFs =  $2 \times \lceil 15/8 \rceil = 4$

#### Word-Size Extension Using One Device

The second technique for extending the word width accumulates the partial products in separate cells of a

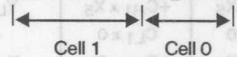
single device. An expansion of the first four output points resulting from the convolution of 16 bit coefficient and 8 bit data is shown below.

The groupings are the same as in the earlier case using multiple DFs. However, in this case individual cells within one DF are responsible for generating the partial products. This method of processing eliminates the need for an external adder in exchange for lower throughput.

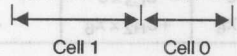
The sequence table (Table 3) shows the results of the multiply accumulate operation for the separate cells of a 4 tap 16x8 FIR filter. Cells 1 and 3 accumulate the partial products  $C_H X$ . Cells 0 and 2 accumulate the partial products  $C_L X$ .

After computing and outputting the first result Cell 0 is ready to accumulate the next partial products. At this point (CLK 11) Cell 0 needs to re-access  $X_2$ , which was last available during CLK 5. In order to accomplish this a temporary storage, sequential memory (such as a FIFO) is necessary. The design of Figure 6 shows such a FIFO based design.

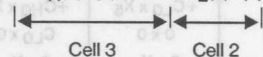
$$y(0) = C_H(0)X(0) \times 2^8 + C_L(0)X(0) \\ + C_H(1)X(1) \times 2^8 + C_L(1)X(1) \\ + C_H(2)X(2) \times 2^8 + C_L(2)X(2) \\ + C_H(3)X(3) \times 2^8 + C_L(3)X(3)$$



$$y(2) = C_H(0)X(2) \times 2^8 + C_L(0)X(2) \\ + C_H(1)X(3) \times 2^8 + C_L(1)X(3) \\ + C_H(2)X(4) \times 2^8 + C_L(2)X(4) \\ + C_H(3)X(5) \times 2^8 + C_L(3)X(5)$$



$$y(1) = C_H(0)X(1) \times 2^8 + C_L(0)X(1) \\ + C_H(1)X(2) \times 2^8 + C_L(1)X(2) \\ + C_H(2)X(3) \times 2^8 + C_L(2)X(3) \\ + C_H(3)X(4) \times 2^8 + C_L(3)X(4)$$



$$y(3) = C_H(0)X(3) \times 2^8 + C_L(0)X(3) \\ + C_H(1)X(4) \times 2^8 + C_L(1)X(4) \\ + C_H(2)X(5) \times 2^8 + C_L(2)X(5) \\ + C_H(3)X(6) \times 2^8 + C_L(3)X(6)$$

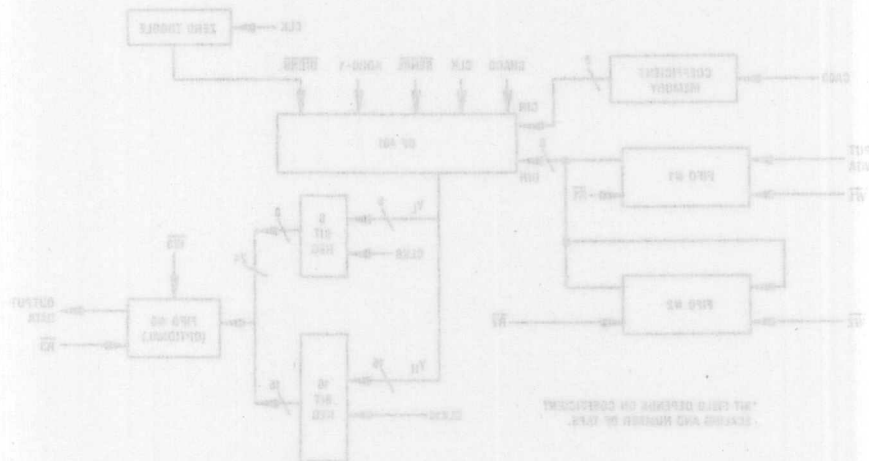
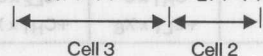


FIGURE 6. 16x8 4-TAP FIR FILTER BLOCK DIAGRAM



# Application Note 116

TABLE 3. HSP43481 4 TAP, 16x8 FIR FILTER SEQUENCE

INPUT DATA SEQUENCE  $X_8, \dots, X_4, X_6, \dots, X_2, X_4, X_3, X_2, X_1, X_0$

COEFFICIENT SEQUENCE  $CL_3, CH_3, 0, 0, CL_0, CH_0, CL_1, CH_1, CL_2, CH_2, CL_3, CH_3$

DF

$Y(5) \dots Y(4) \dots Y(3)$

CLK	CELL 0	CELL 1	CELL 2	CELL 3	OUTPUT
0	$CH_3 \times 0$	-	-	-	-
1	$CL_3 \times X_0$	$CH_3 \times X_0$	-	-	-
2	$CH_2 \times 0$	$CL_3 \times 0$	$CH_3 \times 0$	-	-
3	$+CL_2 \times X_1$	$+CH_2 \times X_1$	$CL_3 \times X_1$	$CH_3 \times X_1$	-
4	$CH_1 \times 0$	$CL_2 \times 0$	$CH_2 \times 0$	$CL_3 \times 0$	-
5	$+CL_1 \times X_2$	$+CH_1 \times X_2$	$+CL_2 \times X_2$	$+CH_2 \times X_2$	-
6	$CH_0 \times 0$	$CL_1 \times 0$	$CH_1 \times 0$	$CL_2 \times 0$	-
7	$+CL_0 \times X_3$	$+CH_0 \times X_3$	$+CL_1 \times X_3$	$+CH_1 \times X_3$	$Y_L(3)$
8	$0 \times 0$	$CL_0 \times 0$	$CH_0 \times 0$	$CL_1 \times 0$	-
9	$0 \times X_4$	$0 \times X_4$	$+CL_0 \times X_4$	$+CH_0 \times X_4$	$Y_H(3)$
10	$CH_3 \times 0$	$0 \times 0$	$0 \times 0$	$CL_0 \times 0$	-
11	$CL_3 \times X_2$	$CH_3 \times X_2$	$0 \times X_2$	$0 \times X_2$	$Y_L(4)$
12	$CH_2 \times 0$	$CL_3 \times 0$	$CH_3 \times 0$	$0 \times 0$	-
13	$+CL_2 \times X_3$	$+CH_2 \times X_3$	$CL_3 \times X_3$	$CH_3 \times X_3$	$Y_H(4)$
14	$CH_1 \times 0$	$CL_2 \times 0$	$CH_2 \times 0$	$CL_3 \times 0$	-
15	$+CL_1 \times X_4$	$+CH_1 \times X_4$	$+CL_2 \times X_4$	$+CH_2 \times X_4$	-
16	$CH_0 \times 0$	$CL_1 \times 0$	$CH_1 \times 0$	$CL_2 \times 0$	-
17	$+CL_0 \times X_5$	$+CH_0 \times X_5$	$+CL_1 \times X_5$	$+CH_1 \times X_5$	$Y_L(5)$
18	$0 \times 0$	$CL_0 \times 0$	$CH_0 \times 0$	$CL_1 \times 0$	-
19	$0 \times X_6$	$0 \times X_6$	$+CL_0 \times X_6$	$+CH_0 \times X_6$	$Y_H(5)$
20	$CH_3 \times 0$	$0 \times 0$	$0 \times 0$	$CL_0 \times 0$	-
21	$CL_3 \times X_4$	$CH_3 \times X_4$	$0 \times X_4$	$0 \times X_4$	$Y_L(6)$
22	$CH_2 \times 0$	$CL_3 \times 0$	$CH_3 \times 0$	$0 \times 0$	-
23	$+CL_2 \times X_5$	$+CH_2 \times X_5$	$CL_3 \times X_5$	$CH_3 \times X_5$	$Y_H(6)$
24	$CH_1 \times 0$	$CL_2 \times 0$	$CH_2 \times 0$	$CL_3 \times 0$	-
25	$+CL_1 \times X_6$	$+CH_1 \times X_6$	$+CL_2 \times X_6$	$+CH_2 \times X_6$	-

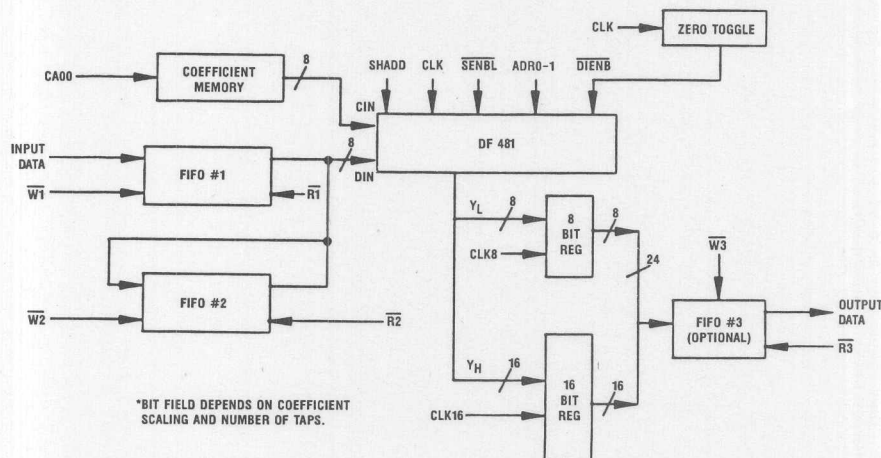


FIGURE 6. 16x8 4 TAP FIR FILTER BLOCK DIAGRAM

In order to interlace the necessary zeros between data samples we must toggle the  $\overline{\text{DIENB}}$  control line. This line is driven low when passing a valid data sample to the X register and set high when loading the X register with zero. The sequencing of the input data through the FIFOs is similar to the example given in Figure 3.

The output stage (Figure 7) plays a key role in determining the final results. In the output stage there are several control signals. The most important signals controlling the output stage are SHADD (SHift and ADD), ADRO-1 (cell Address), SENBL (Sum0-15 ENaBled), and SENBH (Sum16-25 ENaBled). SENBL and SENBH are always asserted in this example, enabling the three-state output buffer and allowing the external register to clock in data at the proper time. SHADD and ADRO-1 are used to control the flow of data through the output stage.

The contents of a selected cell (ADRO-1) are routed to two separate locations within the output stage; the 26 bit adder and the output mux. From the output mux the 26 bit cell

contents are available to the outside world as either the 16 LSBs ( $\overline{\text{SENBH}}$ ), 10 MSBs ( $\overline{\text{SENBH}}$ ), or all 26 bits ( $\overline{\text{SENBH}} + \overline{\text{SENBH}}$ ).

The 26 bit adder feeding the output buffer has two possible inputs. The first input represents the contents of the selected cell. The zero mux determines whether the other input to the adder is zero or the 18 MSBs of the output buffer. A high on the SHADD input selects the 18 MSBs of the output buffer and a low on the SHADD input selects zero. The results from the adder are immediately stored in the output buffer.

Data reaches the three-state buffer by one of two separate paths. The first path routes the data directly from the cell result multiplexer through the output multiplexer and onto the output bus. The second path is from the cell result multiplexer, through the adder, and finally onto the output bus. Both of these routes will be used in order to create the final result from the partial products.

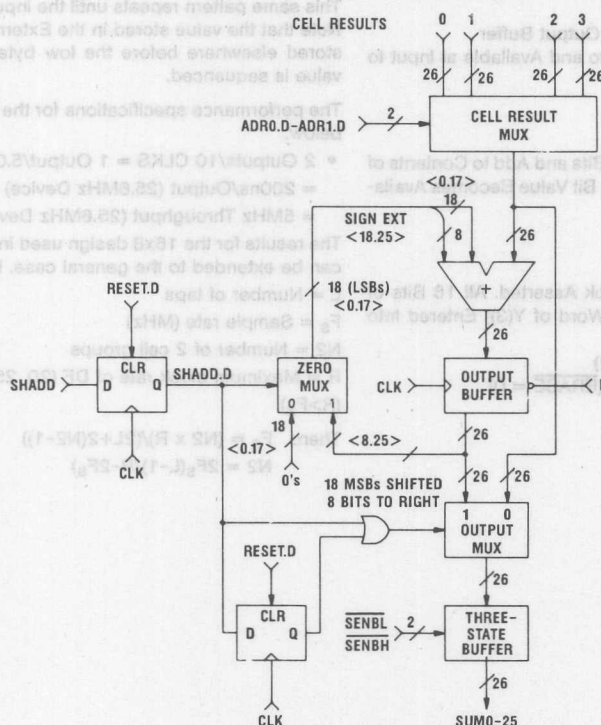


FIGURE 7. DF OUTPUT STAGE





# APPNOTE

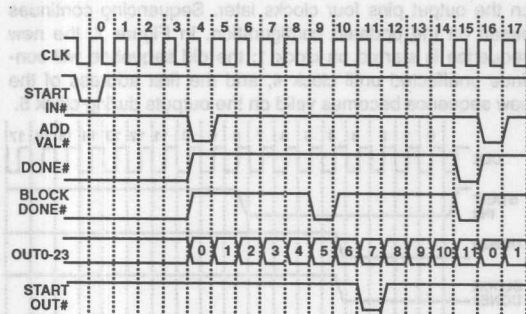
No. 9205 August 1992

Harris Signal Processing

## TIMING RELATIONSHIPS FOR HSP45240

Author: Mike Petrowski

The timing diagram in Figure 1 shows the timing relationship between the various output signals of the HSP45240 when the sequence generator is programmed for **One-Shot Mode with Restart** (see Sequence Generator Section of Datasheet). In this example, the HSP45240 is configured to generate a sequence consisting of two address blocks. Each block is 6 addresses long, and the end of a block is denoted by the assertion of BLOCKDONE#. As the final address in the second block is generated, both DONE# and BLOCKDONE# are asserted to signal the end of the address sequence. On the next clock, a new address sequence is started (see assertion of ADDVAL#) because the Sequencer was configured to restart. In this mode the STARTOUT# signal is asserted prior to the end of the address sequence for the synchronization of multiple HSP45240's.



NOTE: Asserting STARTIN# after an addressing sequence has been started will cause the sequencer to restart from the beginning of the sequence.

FIGURE 1. SIGNAL RELATIONSHIPS FOR ONE-SHOT MODE WITH RESTART

The timing diagram in Figure 2 shows the timing relationship between the various output signals of the HSP45240 when the sequence generator is programmed for **One-Shot Mode without Restart** (see Sequence Generator Section of Datasheet). As in the above example, the HSP45240 is configured to generate a sequence consisting of two address blocks. Each block is 6 addresses long, and the end of a block is denoted by the assertion of BLOCKDONE#. As

the final address in the second block is generated, both DONE# and BLOCKDONE# are asserted and addressing is halted.

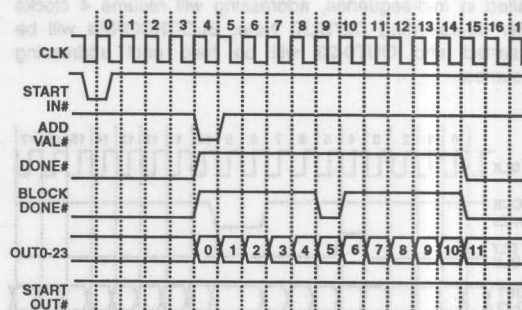


FIGURE 2. SIGNAL RELATIONSHIPS FOR ONE-SHOT MODE WITHOUT RESTART

The timing diagram in Figure 3 shows the timing relationship between the various output signals of the HSP45240 when the sequence generator is internally started by writing the Sequencer "START" address (see Table 1 of Datasheet). The output signals are shown with respect to the rising edge of WR# responsible for the internal START. The address generation parameters are as above.

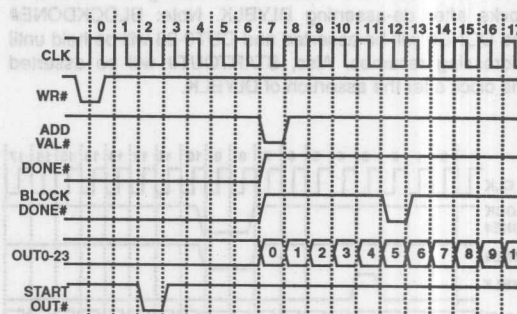


FIGURE 3. SIGNAL RELATIONSHIPS FOR INTERNALLY GENERATED START

8

APPLICATION  
NOTES



### DLYBLK Operation

Address generation can be halted by assertion of DLYBLK prior to the completion of an address block (Figure 4 & 5). Addressing will resume once DLYBLK is de-asserted. Since there is a pipeline delay between the assertion of DLYBLK at the pin and when it is internally active, DLYBLK must be asserted prior to the end of an address block. The pipeline delay associated with DLYBLK differs for halting address generation in mid-sequence and halting address generation after the final address block of a sequence.

For halting address generation in mid-sequence, DLYBLK must be asserted 3 clocks prior to the end of the addressing block as shown in Figure 4. In this example, DLYBLK is asserted for one clock cycle which delays the generation of the next address block by one clock. If addressing has been halted in mid-sequence, addressing will resume 4 clocks after de-asserting DLYBLK. Note: BLOCKDONE# will be asserted and OUT0-23 will be held until addressing resumes.

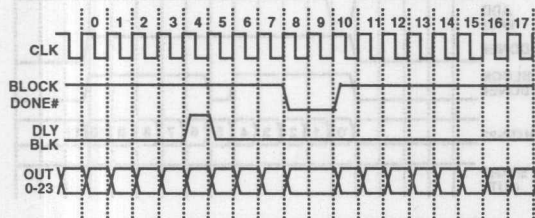


FIGURE 4. SIGNAL RELATIONSHIPS FOR A ONE CYCLE BLOCK DELAY IN MID-SEQUENCE

For halting address generation after the final block of addresses in a sequence, DLYBLK must be asserted 4 clocks prior to the end of the addressing block as shown in Figure 5. In this example, DLYBLK is asserted for one clock cycle which delays the start of a new address sequence by one clock. The part is assumed to be configured for One-Shot Mode with Restart. Addressing will resume 5 clocks after de-asserting DLYBLK. Note: BLOCKDONE# and DONE# will be asserted and OUT0-23 will be held until addressing resumes. Also, STARTOUT# will be asserted one clock after the assertion of DLYBLK.

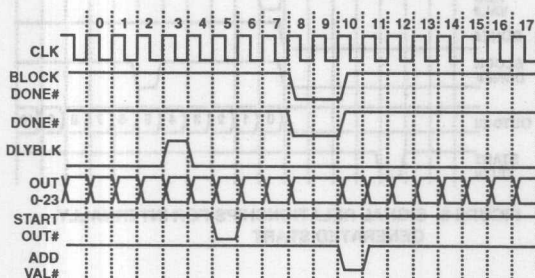


FIGURE 5. SIGNAL RELATIONSHIPS FOR A ONE CYCLE BLOCK DELAY AFTER FINAL BLOCK IN AN ADDRESSING SEQUENCE

### STARTIN# Operation

The STARTIN# pin has two functions: first, it downloads the configuration data in the processor interface into the register bank that controls the operation of the part; second, it starts the address sequence using the updated configuration. When STARTIN# is deasserted, the part continues on with the new sequence. Note that there are four stages of pipeline delay between the sequence generator and the output of the part; all of the output signals will continue on using the original sequence for those four clock cycles.

After the assertion of STARTIN#, the first value in the sequence appears on the output after four pipeline delays. The part will remain in this state for the remainder of the time that STARTIN# is low, and for four clocks after STARTIN# returns high. This is shown in Figure 6, note that the old sequence ends at clock 3; the first address of the new sequence goes from clock 4 to clock 12; the second address of the new sequence appears on clock 13.

Asserting STARTIN# in the middle of a sequence demonstrates the sequence restart function as described above. The internal count of the HSP45240 returns to the starting point (the value in the Start Address Register - not the Current Block Start Address Register) on the first rising edge of CLK that STARTIN# is low. The first address of the sequence is output four clocks after the assertion of STARTIN#. The Sequencer goes to the second address in the sequence when STARTIN# goes away; this address appears on the output pins four clocks later. Sequencing continues based on the updated configuration. In Figure 7, the new sequence is started on clock 1; the old sequence will continue unaffected until clock 4, and the first address of the new sequence becomes valid on the outputs during clock 5.

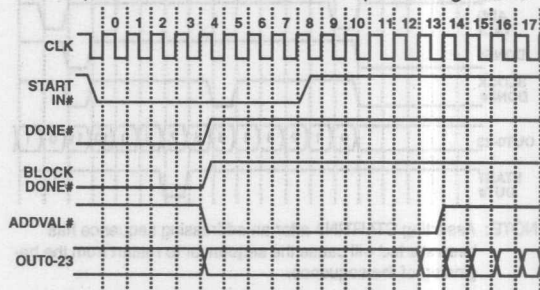


FIGURE 6. INPUT, OUTPUT SIGNALS WHEN STARTIN# IS LONGER THAN ONE CLOCK CYCLE.

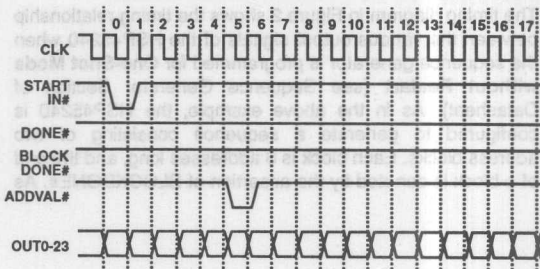
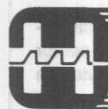


FIGURE 7. USING STARTIN# TO RESTART SEQUENCE DURING OPERATION



# APPNOTE

No. 9206 August 1992

Harris Signal Processing

## CORRELATING ON EXTENDED DATA LENGTHS

Author: Clay Olmstead

Correlations of data sets longer than the maximum length of the HSP45256 are implemented in one of two ways. The first method is to use multiple correlator chips in the manner shown in the HSP45256 data sheet. This will perform a classical correlation on data sets up to 4096 samples of one bit data with no external logic. The limitation on the number of samples is the 16 stage programmable delay register. The advantage of this method is that the user will be guaranteed of finding the data set that best matches the reference no matter where that set lies in the data stream.

The second method involves using external logic to perform a piecewise correlation. The data and reference are each divided into blocks of  $N$  samples, and the data is processed block by block. By reloading the reference memory while processing, the correlation can be carried out at the full data rate while using fewer correlators than would be necessary with the first method. This method will work for any length data sets, but the user must have an initial estimate of the offset between the data and the reference. The true correlation peak will only be found if the data and the corresponding reference fall within the same block. If this block is longer than 256 samples, then multiple correlators are used.

A block diagram of a circuit to perform correlation with a 512 sample reference is shown in Figure 1. The reference is divided into two blocks; the first block is loaded into the reference memory prior to data being sent into the part. The correlation of the data with the current block of the reference is calculated with the HSP45256; as each correlation score comes out, it is stored in the HSP9501, which is set for a delay of 256 clocks. The output of the HSP9501 is sent to the cascade input of the HSP45256 such that the correlation score for each sample in the current block is added to the score from the corresponding sample of the previous block. While the first block is being processed, the reference for the second block is being loaded into the shadow registers of the reference memory of the HSP45256. At the end of the first block, the TXFR# line is pulsed to load the shadow registers into the operating reference memory, and correlation of the second block takes place. At the end of the second block, the HSP9501 will contain the correlation scores for the entire set of data. This method will work up to the highest correlation score that can be stored in the 10 bit data word of

the HSP9501:  $2^{10} - 1$ , or 1023. See Figure 2 for an example of data that has been processed by the circuit shown. This method could be extended to 8191 samples by using two HSP9501's in parallel to store the full 13 bit output of the Correlator. For longer correlations, an external adder would be necessary. Figure 3 is a block diagram for a circuit with a maximum correlation score of  $2^{20} - 1$ .

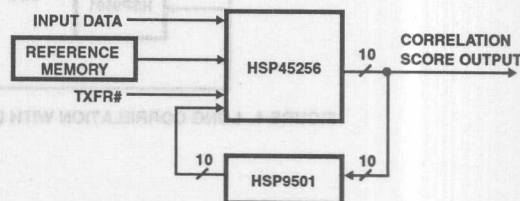


FIGURE 1. CORRELATION OF LENGTH UP TO 1023

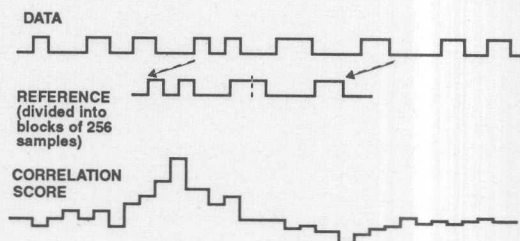


FIGURE 2. CORRELATION RESULTS

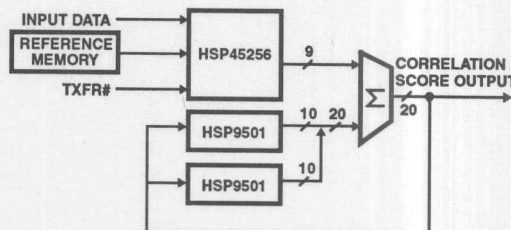


FIGURE 3. CORRELATION OF LENGTH GREATER THAN 8191

8

APPLICATION  
NOTES

Figure 4 shows an implementation of a M tap correlation where the uncertainty in the data alignment is greater than 256 samples. The reference is divided into blocks and the correlation is performed one block at a time. The results of these partial correlations are then added to form a piecewise correlation. The amount of hardware required depends on

the length of the correlation desired and the initial misalignment of the data. The total delay in the HSP9501's is set for a delay of one block of data; the correlators compute the correlation score for one block of data at a time, where one correlator is needed for every 256 samples in the block.

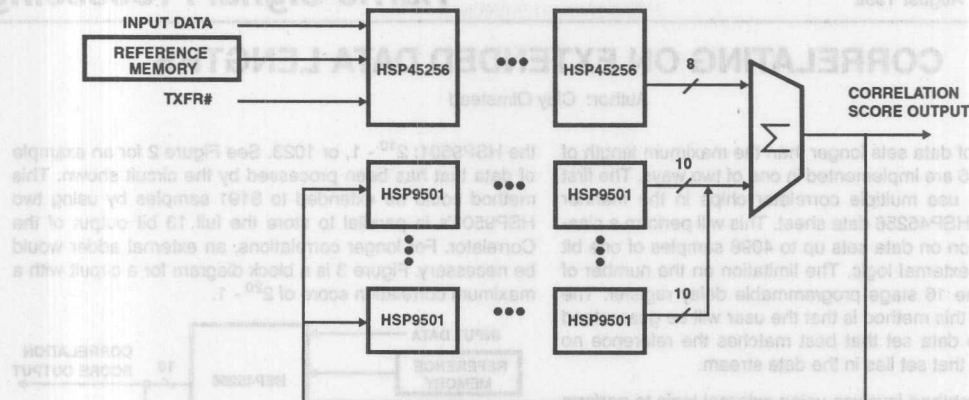
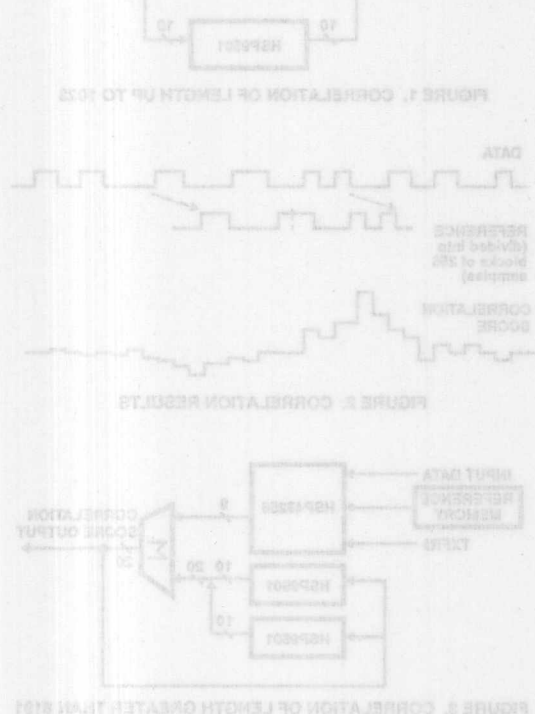
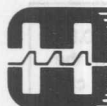


FIGURE 4. LONG CORRELATION WITH LARGE DATA/REFERENCE MISALIGNMENT





No. 9102 May 1991

## Harris Signal Processing

# NOISE ASPECTS OF APPLYING ADVANCED CMOS SEMICONDUCTORS

By: R. Kenneth Keenan, Ph.D.  
and David F. Bennett

## Introduction and Summary

This report is about noise aspects of high-speed logic, with a focus on Advanced CMOS semiconductor applications. The present report pertains to suppression of ringing for both short and long traces, with experimental evidence provided for long traces.

Although termination and decoupling techniques cited here minimize ringing for all semiconductor technologies (AC/ACT, LSTTL, HCMOS, AS, etc.), external resistive termination is usually not required for slower semiconductor technologies. Decoupling is an important aspect of design for all semiconductor technologies.

The preferred termination technique is a resistor,  $R_T$ , equal in value to the trace's characteristic impedance,  $Z_0$ , in series with a trace at the driving end of that trace. For AC/ACT, series termination results in a modest (1ns to 3ns) increase in propagation and transition times. The increase in transition times incurred with series termination helps to minimize interference generation.

The length of traces with distributed loading to which series termination can be applied is limited by the increased transition times at intermediate points along those traces.

For long traces with distributed loading, AC shunt termination—a resistor in series with a small-value capacitor—is used from a trace to ground at the receiving end of a trace. The value of the capacitor depends on clock frequency, but it is typically 50pF to 200pF. Larger values result in improved pulse fidelity at the expense of increased power dissipation in the terminating resistor. At the expense of a capacitor, AC shunt termination consumes much less power than purely resistive shunt termination. AC shunt termination does not appear to materially effect propagation and transition times, except insofar as it removes the ringing contributing to shorter transition and propagation times.

## Series Termination with a Single Receiver

### Resistive Termination

Figure 1 illustrates the waveforms at the receiver for the case of no termination and for the case where the line is terminated at the driver end of the line. The termination resistor is  $80\Omega$ , approximately equal to the  $78\Omega$  characteristic impedance of the line on the board. In this and all succeeding Figures, the line is 12 inches long.

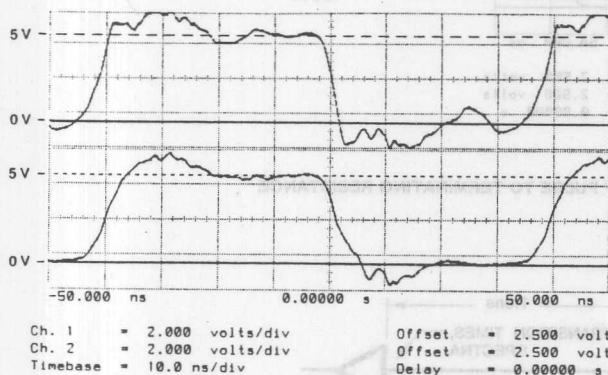


FIGURE 1. UNTERMINATED AND TERMINATED ( $R_T \approx Z_0$ ) LINES

This work was supported by Harris Semiconductor (Harris) and The Keenan Corporation (TKC). The authors thank the external reviewers, Mr. Richard E. Funk, Manager, Applications Engineering, Harris Semiconductor, and Dr. Leonard Rosi, EMC Engineer, of Hewlett-Packard's Corvallis Workstation Operation, for their helpful comments.

Copyright Notice: Copyright 1989, TKC. Reprinted by Harris Semiconductor, April 1989, with permission of TKC.



Zero and five-volt reference lines are shown in each of the above oscillograms. It is clear from Figure 1 that termination assists in reducing both the undershoot for the low-to-high transition and the overshoot for the high-to-low transition. The noise immunity limits for CMOS are given in Table 1.

TABLE 1. NOISE IMMUNITIES AND MARGINS

D.C. SPECIFICATION	VOLTAGE LEVEL (V)
Maximum Low-Level Input Voltage (Max $V_{IL}$ )	0.8
Minimum High-Level Input Voltage (Min $V_{IH}$ )	2.0
Maximum Low-Level Output Voltage (Max $V_{OL}$ )	0.4
Minimum High-Level Output Voltage (Min $V_{OH}$ )	2.4
Low-Level Noise Margin ( $V_{NML} = V_{IL} - V_{OL}$ )	0.4
High-Level Noise Margin ( $V_{NMH} = V_{OH} - V_{IH}$ )	0.4

For the unterminated line in Figure 1, the maximum  $V_{IL}$  0.8V is breached. Therefore, CMOS gates driven with the unterminated-line (upper) waveform in Figure 1 can mistake the "bump" between  $t = 20\text{ns}$  and  $t = 30\text{ns}$  for a "high". Thus, for the unterminated-line waveform, CMOS gates are subject to logic errors. The terminated line rings less and provides a signal which is well within the noise immunity limits for AC/ACT.

The relative sensitivity of the value of termination resistor was assessed. Figure 2 illustrates experimental results.

From Figure 2, the pulse waveform is marginally improved for termination resistance greater than the characteristic impedance, but it becomes more unterminated-like when a terminating resistance less than the characteristic impedance is used.

Table 1 summarizes the effects of terminating resistance on transition times and propagation delays. The propagation delay of the line, 1.8ns, has been subtracted from the experimentally-measured propagation delay in the data in Table 1. The propagation delay was measured as illustrated in Figure 3.

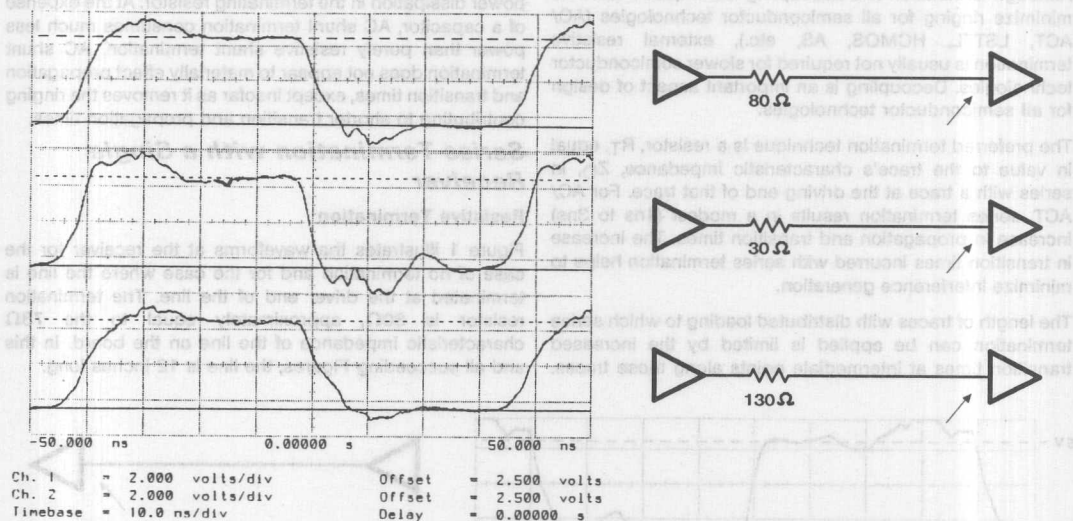


FIGURE 2. SENSITIVITY OF PULSE TO TERMINATING RESISTANCE

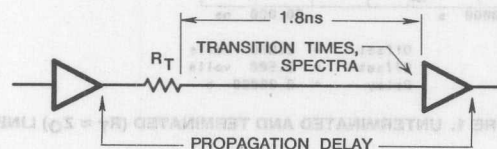


FIGURE 3. MEASUREMENTS

**TABLE 2. SUMMARY OF TRANSITION TIMES AND PROPAGATION DELAYS**

$R_T$ ( $\Omega$ )	TRANSITION TIMES (ns)		PROPAGATION DELAYS (ns)	
	$t_r$	$t_f$	$t_{pih}$	$t_{phi}$
0	4.0	2.6	3.1	5.0
30	4.6	3.6	3.8	6.0
80 (= $Z_0$ )	5.4	5.8	4.8	8.0
130	8.4	7.4	5.6	10.6

Transition times are measured in the conventions 10%/90% and 90%/10%, and, similarly, propagation delay is measured between the 50% points of the waveforms.

Termination with a resistor equal to the characteristic impedance of the line adds 1.7ns to 3.0ns to the propagation delays and increases the transition times. From the perspective of the emissions problems discussed in Section 9.0, an increase in transition times is good. However, increased propagation delays may be undesirable from a functional standpoint. With AC/ACT, some termination resistance must be used to prevent ringing which could exceed the noise immunity limits.

### Shunt Termination with a Single Receiver

AC shunt termination is a means of approximating a resistive termination without incurring the power dissipation of resistive termination. In laptop computers, power drain is a battery life issue. In computers and other powerline-powered digital equipment, power drain causes heat dissipation and implies a diminution in reliability. CMOS, in spite of its speed, consumes relatively little power while operating and near zero power while in standby (or high-Z) states. Therefore, in a total power "budget", it is important to consider the power dissipation of termination resistors.

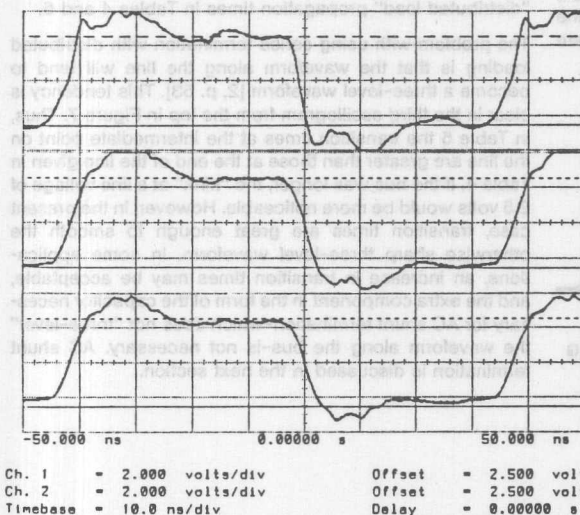

**FIGURE 4. AC SHUNT TERMINATION AT RECEIVER**

Figure 4 illustrates the effects of AC shunt termination for two different values of capacitors.

In designing an AC shunt termination, the value of the resistor is equal to the characteristic impedance of the line:  $R_T = Z_0$ . To allow for complete charging and discharging of the terminating capacitor ( $C_1$ ) during one-half the clock period:  $C_1 < 1/6Z_0f_C$ . Then the power dissipated in  $R_T$  is  $V_{CC}^2 f_C C_1$  (see Table 7). For the present case of  $f_C = 12\text{MHz}$ , and  $Z_0 = 80\Omega$ ,  $C_1 < 1/6Z_0f_C = 174\text{pF}$ . At the extreme, where  $C_1 \rightarrow \infty$ , the power dissipation approaches that of a resistive terminator:  $V_{CC}^2/2Z_0$  for a 50% duty cycle clock.

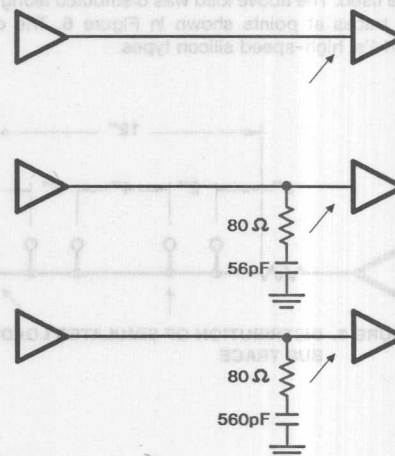
For the case  $C_1 = 56\text{pF}$ , the power dissipation in the terminating resistor is relatively small: 16.8mW. For the case  $C_1 = 560\text{pF}$ , the power dissipation approaches that of a resistive terminator: 156mW (the power dissipation in the driver is approximately 30mW). However, the waveform with  $C_1 = 560\text{pF}$  is somewhat better than that with  $C_1 = 56\text{pF}$ . In shunt termination, one is always trading power dissipation in the terminating resistor for pulse fidelity.

Table 3 summarizes propagation and transition times for AC shunt termination.

**TABLE 3. PROPAGATION AND TRANSITION TIMES**

TERMINATION	TRANSITION TIMES (ns)		PROPAGATION DELAYS (ns)	
	$t_r$	$t_f$	$t_{pih}$	$t_{phi}$
None	4.0	2.6	3.1	5.0
80 $\Omega$ /56pF	5.0	4.2	4.6	7.2
80 $\Omega$ /560pF	5.8	4.6	4.2	7.0

AC shunt termination at the sending end (only) was not tried. However, in the context of distributed loads with both ends of the bus AC shunt terminated, the driving-end termination did not improve the waveform.



Since computer bus lines may be in the active high state for relatively long periods of time, the DC blocking capacitor,  $C_1$  (56pF and 560pF in Figure 4), can be of considerable benefit when driving CMOS logic. However, when driving bipolar logic, the current required by the inputs of driven gates can total much more than that required by a terminating resistor without a DC blocking capacitor. Then, AC termination offers insignificant advantages over conventional resistive termination.

## Terminations Applicable to Distributed Loads

### Description of Board with Simulated Load

The circuit shown in Figure 5 is the simulated load used along the bus-like structure on the test board. It is patterned after the equivalent input circuitry. The inductor was formed by a small loop of wire.

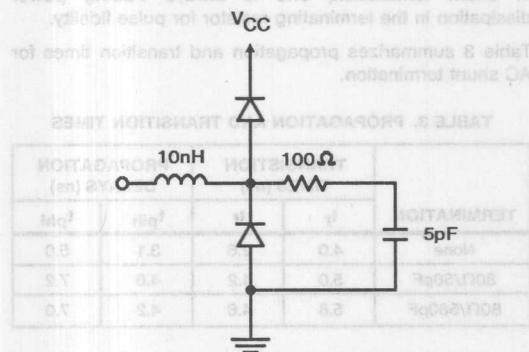


FIGURE 5. SIMULATED CMOS LOAD

The average value of the input capacitance of a CMOS gate is 7.5pF. That value was not available, so 5pF capacitors were used. The above load was distributed along one of the bus traces at points shown in Figure 6. The diodes are 1N914's, high-speed silicon types.

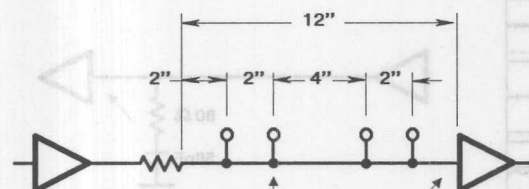


FIGURE 6. DISTRIBUTION OF SIMULATED LOADS ALONG BUS TRACE

The measurements and waveforms cited below were made at the gate four inches from the driver and at the gate at the end of the line. The points designated by arrows in the figure are referred to as the "intermediate gate" and "end gate" in the measurements to follow. In all cases, the waveform at the end gate was the worst case with respect to ringing.

When a load is distributed along a trace, the characteristic impedance of that trace is modified in accordance with [2, p. 148]

$$Z_0 = Z_{00} / [1 + \text{distributed load capacitance on line} / \text{capacitance of line}]^{1/2} \quad (1)$$

$Z_{00}$  = Characteristic impedance of line without distributed loading.

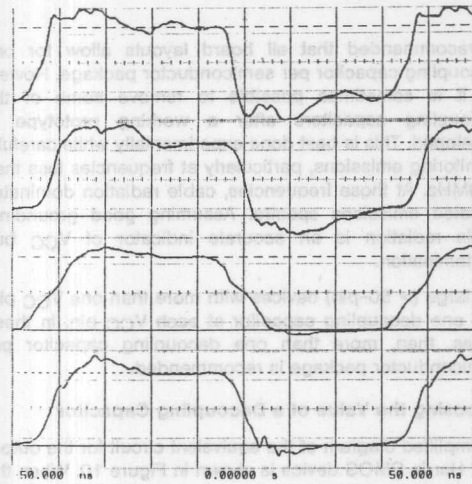
In the case of the test board, the capacitance along the unloaded line of 0.72pF/in. x 12in. = 8.6pF, and the distributed load, including that at the last gate, was (4 x 5pF) + 7.5pF = 27.5pF. Then,  $Z_0 = 80 / [1 + 27.5pF / 8.6pF]^{1/2} \approx 40\Omega$ .

### Series Termination

Figure 7 illustrates waveforms along the line for unterminated lines, with and without distributed loading, and for the series-terminated line with  $R_T = Z_0$ . It is clear from a comparison of the top two oscillograms that the presence of distributed loading—even without termination—tends to smooth the waveforms. At least in part, this is probably due to the diodes in the simulated loads, which are also present in CMOS input gates.

Distributed loading increases line propagation delays by the same factor by which the characteristic impedance is decreased, which is a factor of approximately two in the present case. Propagation delay measurements were taken as indicated in Figure 2, with  $2 \times 1.8 = 3.6ns$  subtracted from the measured propagation delays to provide the "distributed load" propagation times in Tables 4 and 5.

The problem with using series termination with distributed loading is that the waveform along the line will tend to become a three-level waveform [2, p. 53]. This tendency is clear in the third oscillogram from the top in Figure 7. Thus, in Table 5 the transition times at the intermediate point on the line are greater than those at the end of the line given in Table 4. If the bus was longer, the "kink" at a line voltage of 2.5 volts would be more noticeable. However, in the present case, transition times are great enough to smooth the otherwise sharp three-level waveform. In some applications, an increase in transition times may be acceptable, and the extra component in the form of the capacitor necessary for AC shunt termination—which does not "three-level" the waveform along the bus—is not necessary. AC shunt termination is discussed in the next section.



Ph. 1 = 2.000 volts/div Offset = 2.500 volts  
Ch. 2 = 2.000 volts/div Offset = 2.500 volts  
Timebase = 10.0 ns/div Delay = 0.00000 s

FIGURE 7. WAVEFORMS FOR DISTRIBUTED LOADING

TABLE 4. TRANSITION AND PROPAGATION TIMES-END GATE

$R_T$ ( $\Omega$ )	TRANSITION TIMES (ns)		PROPAGATION DELAYS (ns)	
	$t_r$	$t_f$	$t_{plh}$	$t_{phi}$
0 (No Dist. load)	4.0	2.6	3.1	5.0
0 (Dist. load only)	4.4	3.6	4.4	6.4
40 ( $=Z_0$ ) + Dist. load	4.8	5.2	5.2	7.8

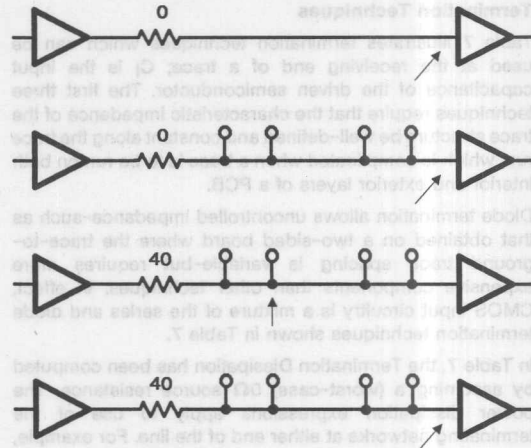
TABLE 5. TRANSITION TIMES-INTERMEDIATE GATE

$R_T$ ( $\Omega$ )	TRANSITION TIMES (ns)		PROPAGATION DELAYS (ns)	
	$t_r$	$t_f$	$t_{plh}$	$t_{phi}$
0 (Dist. load only)	6.6	5.6	Not measured	
40 ( $=Z_0$ ) + Dist. load	8.0	7.8	Not measured	

#### AC Shunt Termination

This termination technique was previously explored in the context of a single load. For the case of loads distributed along a single line, the advantage of shunt termination is that the tendency toward a three-level waveform with series termination is absent. Figure 8 illustrates the waveforms obtained with AC shunt termination. As previously discussed, the corrected (for distributed loading) value of the characteristic impedance is  $40\Omega$ .

The discussion of trading off waveform integrity for power dissipation also applies here. The power consumed by



the terminating resistor when  $C = 560\text{pF}$  is substantially greater than when  $C = 56\text{pF}$ .

Table 6 summarizes propagation and transition time data. As in the preceding section, gate propagation delay = measured delay -  $3.6\text{ns}$ .

TABLE 6. SUMMARY OF TRANSITION TIMES AND PROPAGATION DELAYS

R <sub>T</sub> (Ω)	TRANSITION TIMES (ns)		PROPAGATION DELAYS (ns)	
	T <sub>R</sub>	T <sub>F</sub>	T <sub>PLH</sub>	T <sub>PHL</sub>
40Ω/56pF				
End Gate	6.0	6.0	3.3	4.4
Int Gate	9.0	8.3	Not measured	
40Ω/560pF				
End Gate	8.0	8.3	3.7	8.0
Int Gate	8.8	9.0	Not measured	

As is evident from a comparison of Tables 5 and 6, shunt termination with a small capacitor ( $56\text{pF}$ ) does not extract as much propagation delay "penalty" as does series termination—nor does a  $56\text{pF}$  shunt termination cause a tendency toward a three-level waveform on the bus. With a  $560\text{pF}$  capacitor, the waveform is better in the sense that there is less ringing, but, as indicated earlier, the power dissipation of the terminating resistor is substantially increased.

From a comparison of Figures 7 and 8, series termination appears to suppress ringing better than shunt termination—at least that shunt termination where, in order to reduce power consumed by termination resistors, the value of the capacitor is relatively small. Also, the increased transition times associated with series termination are very desirable from the standpoint of minimizing both ringing and ground bounce.



### Termination Techniques

Table 7 illustrates termination techniques which can be used at the receiving end of a trace;  $C_I$  is the input capacitance of the driven semiconductor. The first three techniques require that the characteristic impedance of the trace structure be well-defined and constant along the trace run, which is complicated when a trace is to be run on both interior and exterior layers of a PCB.

Diode termination allows uncontrolled impedance—such as that obtained on a two-sided board where the trace-to-ground trace spacing is variable—but requires more expensive components than other techniques. In effect, CMOS input circuitry is a mixture of the series and diode termination techniques shown in Table 7.

In Table 7, the Termination Dissipation has been computed by assuming a (worst-case)  $0\Omega$  source resistance. The power dissipation expressions apply to use of the terminating networks at either end of the line. For example, the expression given for the dissipation of a series termination applies whether the termination is used on the sending (proper) end of the line or the receiving (improper) end of the line.

**Series termination** has been analyzed in some detail. For use at either the receiving or sending end, maximum clock frequency is determined by assuming that, after a high-to-low transition, the input capacitor,  $C_I$ , must discharge to a voltage below 5% of  $V_{CC}$  before the next clock low-to-high transition. This requires that three  $Z_0 C_I$  time constants occur during one-half of the clock period, which leads to the clock-frequency limitation shown for series termination in Table 7.

The relatively large power consumed in termination resistors can be a problem. **AC shunt termination**, as defined in Table 7 and used in Figures 4 and 8, provides a worthwhile low-power alternative, to be applied at the receiving end of a trace. In AC shunt termination, pulse fidelity is traded off for power dissipation: the larger the value of the DC blocking capacitor,  $C_1$ , the better the pulse, but the higher the power consumption of the terminating resistor.

In the limit as the value of  $C_1$  is made very large, the power dissipation of the terminating network approaches that of purely resistive termination. The improved pulse fidelity with larger values of  $C_1$  is apparent from Figure 8. The maximum value of  $C_1$  which still permits adequate charging/discharging of the shunt termination network over one-half of the clock cycle is  $C_1 < 1/6fCZ_0$ ; this inverse clock-frequency limitation is given in the "Max  $f_C$ " column of Table 7. However, for  $C_1 \gg 1/6fCZ_0$ , the network is slow enough that full charging never occurs, the network begins to approach a purely resistive shunt terminator, and clock frequencies are limited only by the driver.

AC shunt termination should be used whenever the DC drive capability of the driving device is approached via heavy TTL loading.

### Decoupling CMOS

Clock-related noise on the  $V_{CC}$  bus can arise if too few decoupling capacitors are used [5, p.3.11-1]. It

is recommended that all board layouts allow for one decoupling capacitor per semiconductor package. However, it is sometimes possible to remove some of the decoupling capacitors after a working prototype is developed. This is best done experimentally while carefully monitoring emissions, particularly at frequencies less than 200MHz. At those frequencies, cable radiation dominates radiated emissions spectra. Assuming good grounding, cable radiation is an accurate indicator of  $V_{CC}$  bus contamination.

On large (> 50-pin) devices with more than one  $V_{CC}$  pin, use one decoupling capacitor at each  $V_{CC}$  pin. In these cases, then, more than one decoupling capacitor per semiconductor package is recommended.

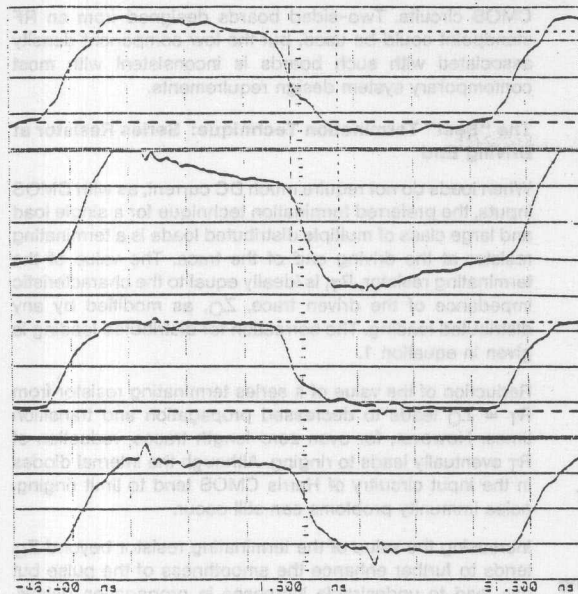
### Choosing the Value of a Decoupling Capacitor

A simplified diagram of the equivalent circuit for the output of a Harris CMOS device is shown in Figure 10. When the circuit shown transitions from low to high, switch  $S_1$  connects to terminal A and current is drawn from the  $V_{CC}$  bus to charge the capacitor. On a high to low transition, the switch connects to B; current is sourced by the capacitor as it discharges into ground through  $S_1$ . Note that the switch is, in the ideal case, a "break before make" circuit, so that no current is drawn from A to B as  $S_1$  changes state – a common source of current consumption in early CMOS logic.

Departures from ideality include the **totem-pole effect**: for time intervals which are smaller than the transition time, both the upper (PMOS) and lower (NMOS) transistors are partially "on". Then, during both the low-to-high and high-to-low transitions, there is a pulse of current drawn from the  $V_{CC}$  bus. This is in addition to the current pulse required—and predicted by the model—for the charging of  $C_S$  when making the low-to-high transition. Also, the internal gates—those which precede the output gate—require both totem-pole and charging currents (charging currents for internal gates are much smaller than that required for the output gate, as the source capacitance associated with those gates is on the order of tens of femptofarads [ $1 \text{ femptofarad} = 10^{-15} \text{ farad}$ ]).

A decoupling capacitor is the  $V_{CC}$  bus for the purpose of supplying current during transitions. The inductance of a  $V_{CC}$  trace or plane precludes those sources from supplying all of the rapidly-changing current required during a transition. Between clock pulse transitions, a trace or plane supplies recharge current to decoupling capacitors. Recharging can take place over the much longer time of one-half of the clock period.

A value of  $0.1\mu\text{F}$  will adequately decouple all known AC/ACT glue logic and VLSI circuits (even heavily loaded/fanned out), but the use of that relatively large value should be resisted in order to maintain the highest possible self-resonant frequency of the decoupling capacitor. Use  $0.001\mu\text{F}$  and  $0.01\mu\text{F}$ , not so much for reduced cost as for the purpose of increasing the self-resonant frequency of the decoupling capacitor.



Ch. 1 = 2.000 volts/div Offset = 2.500 volts  
 Ch. 2 = 2.000 volts/div Offset = 2.500 volts  
 Timebase = 10.0 ns/div Delay = 1.500 ns  
 Delta V = 5.000 volts

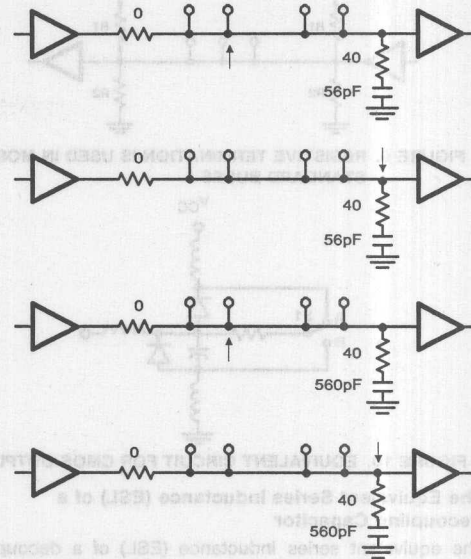
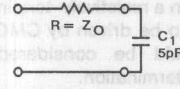
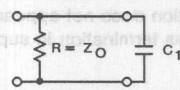
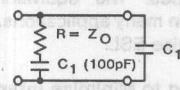
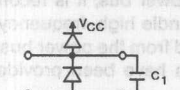


FIGURE 8. WAVEFORMS FOR AC SHUNT TERMINATION

TABLE 7. RECEIVING END TERMINATION TECHNIQUES

TERMINATION	MAX $f_c$	TERMINATION DISSIPATION	PULSE INTEGRITY	NOTES
 <p>Series (Controlled <math>Z_0</math>)</p>	$\frac{1}{6Z_0C_1}$ (667MHz*)	Very Low: $P = V_{CC}^2 f_c C_1$ (3.8mW)	Improves with small $Z_0, C_1$	Transition times increased.  Want Low $Z_0$
 <p>Shunt (Controlled <math>Z_0</math>)</p>	Driver-Limited	Very High: $\frac{V_{CC}^2}{2Z_0}$ (250mW)	Good Reflected % $= \frac{4.4Z_0C_1}{r_f - 4.4Z_0C_1}$	Drive current $= \frac{V_{CC}}{Z_0} = (100mA)$
 <p>AC Shunt (Controlled <math>Z_0</math>)</p>	$\frac{1}{6Z_0C_1}$ (33.3MHz, see text)	Low to Moderate, increasing with $C_1$ $P = V_{CC}^2 f_c C_1$ (75mW, about same as device)	Best with largest possible value of $C_1 = 1/6Z_0f_c$ Integrity improves with $C_1$	Must use low-ESL $C_1$ with short leads  Want Low $Z_0$
 <p>Diode (Uncontrolled <math>Z_0</math>)</p>	Driver-Limited	Low	Good with high-speed Schotky diodes or built-in protection diodes of some semiconductors	External diodes costly

\* Examples are for  $Z_0 = 50$ ,  $C_1 = 5pF$ ,  $V_{CC} = 5$ ,  $f_c = 30MHz$ , Duty Cycle = 50%

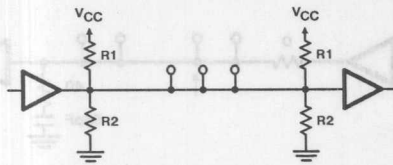


FIGURE 9. RESISTIVE TERMINATION IS USED IN MOST STANDARD BUSES

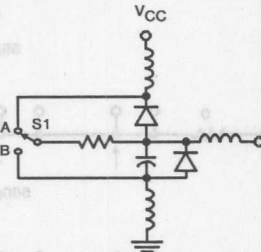


FIGURE 10. EQUIVALENT CIRCUIT FOR CMOS OUTPUT

#### The Equivalent Series Inductance (ESL) of a Decoupling Capacitor

The equivalent series inductance (ESL) of a decoupling capacitor and the inductance of the leads/planes used to connect the decoupling capacitor to a semiconductor package should be as small as economics and manufacturing practicalities permit. This decreases both ringing and emissions. It is shown in [5, pp. 3.9-7 through 3.9-10] that maximum attenuation of noise on the power bus occurs at the self-resonant frequency of the decoupling capacitor. To have that attenuation occur at frequencies where ringing and emissions suppression is otherwise difficult (generally 35MHz to 90MHz) using a capacitor value chosen according to the previous section requires ESL's less than 10nH. Surface-mount ("chip") capacitors on a multilayer board with both  $V_{CC}$  and ground planes are particularly desirable.

The ESL of a decoupling capacitor is at least as important as its capacitance. Above the self-resonant frequency of a decoupling capacitor which provides filtering; that inductance should be as small as manufacturing techniques and economy permit.

#### Placement of Decoupling Capacitor on a Board

A decoupling capacitor should always be placed on that end of the semiconductor package which points toward the power entry point on a board. One of the purposes of decoupling is to minimize  $V_{CC}$  noise at the power-entry point, and the filtration implied by a decoupling capacitor should be between the semiconductor package and the power entry point.

#### Conclusions and Recommendations

##### Use Multilayer Boards

The inductances associated with two-sided boards are often too large for successful application of high speed

CMOS circuits. Two-sided boards designed from an RF standpoint could be used, but the low component density associated with such boards is inconsistent with most contemporary system design requirements.

#### The "Best" Termination Technique: Series Resistor at Driving End

When loads do not require much DC current, as with CMOS inputs, the preferred termination technique for a single load and large class of multiple distributed loads is a terminating resistor at the driving end of the trace. The value of the terminating resistor,  $R_T$ , is ideally equal to the characteristic impedance of the driven trace,  $Z_0$ , as modified by any distributed loading. The correction for distributed loading is given in equation 1.

Reduction of the value of a series terminating resistor from  $R_T = Z_0$  leads to decreased propagation and transition times. However, for even zero-length traces, reduction of  $R_T$  eventually leads to ringing. Although the internal diodes in the input circuitry of Harris CMOS tend to limit ringing, noise immunity problems can still occur.

Increasing the value of the terminating resistor beyond  $Z_0$  tends to further enhance the smoothness of the pulse but can lead to undesirable increases in propagation delays. The resulting increased transition times tend to suppress emissions.

For driving-end series termination with distributed loading on lines 12 inches long, transition times at intermediate loads are doubled relative to those at the end of the bus. Longer buses lead to even greater increases in transition times at intermediate bus points. Should this not be tolerable, the alternative AC shunt termination discussed below should be used.

#### An Alternative Termination Technique

In the above case and/or when a resistively-terminated bus and/or heavy TTL loads are to be driven by CMOS gates, AC shunt termination should be considered as an alternative to purely resistive termination.

At least for the driven-end terminated case considered in this report, AC shunt termination does not appear quite as effective as sending-end series termination in suppressing ringing.

When terminating high-speed traces, SIP resistors and capacitors should be avoided. The equivalent series inductance (ESL) is too large in many applications. Discrete SMD's are preferred to minimize ESL.

#### Minimize Power Bus Ringing to Minimize Interference

To minimize ringing on the power bus, it is recommended that CMOS devices which handle high-frequency periodic signals be carefully decoupled from the power bus. Specific decoupling recommendations have been provided in this report.

## Bibliography

- [1] R.K. Keenan, FCC Emissions and Power Bus Noise (Second Edition), Pinellas Park, Florida: TKC, February 1988.
- [2] William R. Blood, Jr., MECL System Design Handbook (Fourth Edition, Rev. 1), Phoenix, Arizona: Motorola Inc., 1988.
- [3] RCA/GE/Harris Semiconductor, GE Solid State Data Book (for) RCA Advanced CMOS Logic ICs, Somerville, N.J.: GE Corporation, 1987.
- [4] J.D. Kraus, Electromagnetics (Third Edition), New York: McGraw Hill, 1984.
- [5] R.K. Keenan, Decoupling and Layout of Digital Printed Circuits, Pinellas Park, Florida: TKC, 1987.
- [6] R.K. Keenan, Digital Design for Interference Specifications, Pinellas Park, Florida: TKC, 1983.
- [7] H.H. Skilling, Electrical Engineering Circuits, New York: Wiley, 1958.

The energy expended by an integrated circuit (and hence power) as heat in a CMOS system, current (and hence power) increase proportionally with switching frequency. With the advent of fast CMOS circuits, the attendant rise in temperature causes a variety of problems. In some cases, the current and/or temperature constraints placed on the device by its operating environment are the limiting factors on the clock rate. The increased die temperature due to the switching speed produces a number of secondary effects. The propagation delay time of a CMOS gate increases, causing a decline in the overall performance of the system. In addition, the effects of various failure mechanisms are accelerated (see Reliability Fundamentals). Depending on the failure mechanism, the lifetime of the product can be decreased by a factor of two for every 10°C rise in junction temperature.

The internal temperature of a semiconductor device is defined as junction temperature,  $T_J$ . Harris products are designed to operate with a 10 year lifetime under the stated operating conditions. For parts in ceramic packages, these include a maximum junction temperature of 175°C. For plastic packages, the maximum  $T_J$  is 180°C - this is to maintain the integrity of the package, not the device itself. Note that the 175°C limit is set according to military standards; many users in specific industries set this limit higher or lower, depending on their individual requirements.

Determining  $T_J$  Junction Temperature

Once the designer has selected an IC and calculated the clock frequency that meets the needs of the application, the operating temperature of the die (junction temperature) must be calculated to determine whether it exceeds reliability guidelines. This involves the concept of thermal resistance: the temperature differential across a body that is dissipating a given amount of energy. There are two common sets of reference points for thermal resistance: 6°C is the temperature differential between the p-n junction of a semiconductor device and the outside surface of the package (case); 6°C is measured from the junction to ambient conditions. Other reference points for measuring thermal resistance are defined depending on specific requirements.

To calculate whether a device will exceed its maximum junction temperature, the first step is to multiply the clock rate by the frequency coefficient (given in mW/MHz) for that product. This is listed in the D.C. Electrical Specifications section of the data sheet under logic.

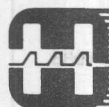
It is important to note that the maximum junction temperature is not the same as the maximum ambient temperature. The maximum ambient temperature is the temperature of the air surrounding the device. The maximum junction temperature is the temperature of the die itself. The junction temperature is calculated by adding the heat flow out of the package by adding a heat sink and/or forcing airflow across the package. Moving air lowers the effective  $\theta_{JA}$  of the part as shown in Figure 1. The required value for the effective thermal resistance is calculated by solving equation 1 for  $\theta_{JA}$ .

Equation 3

$$\theta_{JA} = (T_J - T_A) / P$$

Once the necessary value for  $\theta_{JA}$  is known, Figure 1 is used to locate the corresponding air flow for the package of





# APPNOTE

No. 9207 August 1992

## Harris Signal Processing

### TEMPERATURE CONSIDERATIONS

Author: Clay Olmstead

#### Junction Temperature

The energy expended by an integrated circuit is dissipated as heat. In a CMOS system, current (and hence power) increase proportionally with switching frequency. With the advent of fast CMOS circuits, the attendant rise in temperature causes a variety of problems. In some cases, the current and/or temperature constraints placed on the device by its operating environment are the limiting factors on the clock rate. The increased die temperature due to the switching speed produces a number of secondary effects. The propagation delay time of a CMOS gate increases, causing a decline in the overall performance of the system. In addition, the effects of various failure mechanisms are accelerated (see Reliability Fundamentals). Depending on the failure mechanism, the lifetime of the product can be decreased by a factor of two for every 10°C rise in junction temperature.

The internal temperature of a semiconductor device is defined as junction temperature,  $T_J$ . Harris products are designed to operate with a 10 year lifetime under the stated operating conditions. For parts in ceramic packages, these include a maximum junction temperature of 175°C. For plastic packages, the maximum  $T_J$  is 150°C - this is to maintain the integrity of the package, not the device inside. Note that the 175°C limit is set according to military standards; many users in specific industries set this limit higher or lower, depending on their individual requirements.

#### Determination Of Junction Temperature

Once the designer has selected an IC and calculated the clock frequency that meets the needs of the application, the operating temperature of the die (junction temperature) must be calculated to determine whether it exceeds reliability guidelines. This involves the concept of thermal resistance: the temperature differential across a body that is dissipating a given amount of energy. There are two common sets of reference points for thermal resistance:  $\theta_{JC}$  is the temperature differential between the p-n junction of a semiconductor device and the outside surface of the package (case);  $\theta_{JA}$  is measured from the junction to ambient conditions. Other reference points for measuring thermal resistance are defined depending on specific requirements.

To calculate whether a device will exceed its maximum junction temperature, the first step is to multiply the clock rate by the frequency coefficient (given in mA/MHz) for that product. This is listed in the D.C. Electrical Specifications section of

the data sheet under  $I_{CCOP}$ . The total package power dissipation is calculated by multiplying that current by the maximum  $V_{CC}$ . If this figure is less than the Maximum Package Power Dissipation listed in the data sheet, then the operating conditions meet Harris specifications. In some applications, it is necessary to operate the part using a higher junction temperature (for applications that can absorb the penalty in expected lifetime) or lower temperature (for high reliability applications). Users with these requirements calculate their actual junction temperature using one of the following equations. Given the maximum ambient temperature, the proper equation is:

$$T_J = (\theta_{JA} \times P) + T_A \quad \text{Equation 1}$$

Where:

 $T_J$  = Junction Temperature of the Part In °C $\theta_{JA}$  = Thermal Resistance from Junction to Ambient In °C/W $P = I_{CCOP} \times V_{CC}$  $T_A$  = Ambient Temperature

The junction temperature for a given case temperature is:

$$T_J = (\theta_{JC} \times P) + T_C \quad \text{Equation 2}$$

Where:

 $T_J$  = Junction Temperature of the Part In °C $\theta_{JC}$  = Thermal Resistance from Junction to Case In °C/W $P = I_{CCOP} \times V_{CC}$  $T_C$  = Case Temperature

#### Reducing Junction Temperature

If, after going through the above equations, the junction temperature exceeds the allowable limit, there are several possible solutions. With some types of parts, such as digital filters, the user can replace a single part running at a high data rate with multiple parts, each operating at a reduced clock rate. Using this method, the junction temperature of each IC is reduced but the throughput of the entire circuit is unaffected. In most cases, the optimum solution is to improve the heat flow out of the package by adding a heat sink and/or forcing airflow across the package. Moving air lowers the effective  $\theta_{JA}$  of the part as shown in Figure 1. The required value for the effective thermal resistance is calculated by solving equation 1 for  $\theta_{JA}$ :

$$\theta_{JA} = (T_J - T_A) / P \quad \text{Equation 3}$$

Once the necessary value for  $\theta_{JA}$  is known, Figure 1 is used to locate the corresponding air flow for the package of

interest. Note that the improvement in thermal impedance is a function of the airflow measured in linear feet per minute (lfm), but fan manufacturers measure airflow in cubic feet per minute (cfm). Assuming 100% efficiency, lfm is converted to cfm by multiplying the required lfm by the cross sectional area of the path of moving air. In reality, obstructions in the airflow cause back pressure, which diminish the fan output to between 60% and 80% of its free air capacity; divide the lfm figure derived from Figure 1 by this compensation factor to obtain the required fan output.

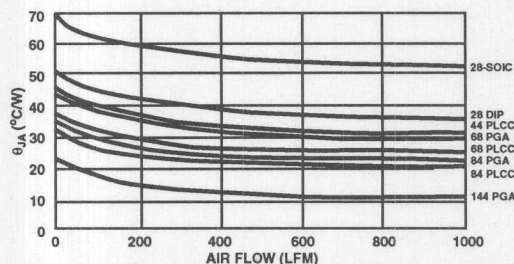


FIGURE 1. TYPICAL RELATIONSHIP BETWEEN  $\theta_{JA}$  AND AIR FLOW FOR VARIOUS PACKAGES

Another viable solution is to use a heat sink, either by itself (natural convection) or with moving air (forced convection). There is a wide range of heat sinks available for virtually any package type. Note, however, that a heat sink is much more effective when used in combination with a ceramic package. This is due to the greater thermal efficiency of the ceramic material: most of the flow of thermal energy is from the die directly into the package, where the entire surface of the part acts as a radiating surface to let the heat escape. Some energy flows from the die through the bond wires and pins and out through the copper traces in the board, but this effect is negligible due to the fact that the bond wires are only 1 mil in diameter and thus their thermal impedance is relatively high. In a plastic package, the main path for the heat flow is from the die through the paddle and the plastic molding compound and on to the outside world. Since plastic is a relatively poor thermal conductor, other paths, such as the bond wires, take on a greater proportion of the total heat transfer so that their contribution is no longer negligible. For this reason, a heat sink mounted to a plastic package dissipates less heat than Equation 2 would indicate. Harris recommends the use of a ceramic package for operating conditions that require a heat sink.

Addition of a heat sink puts two additional elements in path of thermal transfer: the heat sink and the thermal joint compound that attaches it to the package. The total value for  $\theta_{JA}$  is divided into its component parts: the thermal resistance from the junction to the surface of the package, from the package to the heat sink, and from the heat sink to ambient:

$$\theta_{JA} = \theta_{JC} + \theta_{CS} + \theta_{SA} \quad \text{Equation 4}$$

Where CS is the thermal resistance from the IC package to the heat sink, which is controlled by the mounting technique and thermal joint compound used.  $\theta_{SA}$  is the thermal resistance from the heat sink to ambient.

Under natural convection, heat sink dissipation is a function of the power dissipation of the chip. The heat sink manufac-

turer's catalog will specify the performance for their products using a chart similar to that shown in Figure 2. Starting with the power dissipated by the device on the x axis, find the corresponding temperature rise of the package on the y axis. Add this value to the ambient temperature,  $T_A$ , to find the elevated case temperature. Use Equation 2 to find the new junction temperature.

If a fan is to be used, then the following procedure is recommended. Use Equation 3 to calculate the required total thermal resistance. Solving Equation 4 for  $\theta_{SA}$ , calculate the maximum thermal resistance allowable for the heat sink. The literature from the maker of the heat sink will have a chart similar to Figure 3; find  $\theta_{SA}$  on the right axis and find the air flow that corresponds to that value on the top axis. (The placement of the axes is to allow Figures 2 and 3 to be combined into one graph.) Convert lfm to cfm and divide that value by the compensation factor for back pressure mentioned above; use that figure to select a fan.

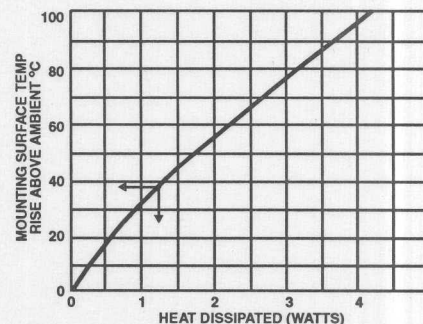


FIGURE 2. PACKAGE TEMPERATURE INCREASE AS A FUNCTION OF POWER FOR A TYPICAL HEAT SINK UNDER NATURAL CONVECTION

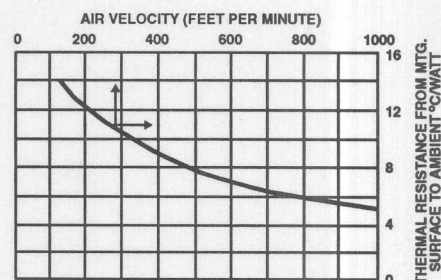


FIGURE 3. THERMAL RESISTANCE VERSUS AIR VELOCITY FOR TYPICAL HEAT SINK UNDER FORCED CONVECTION

## For Further Reading

The discussion above outlines the overall method for calculating the thermal parameters of a circuit. the interested reader may refer to the following references for further information.

MIL STD 883 Method 1012.1; JEDEC ENG. Bulletin No. 20, January 1975; 1992 Semi Std. Vol. 4, Methods G30-86, G32-86, G42-88, G43-87



## HARRIS QUALITY AND RELIABILITY

	PAGE
INTRODUCTION .....	9-3
THE ROLE OF THE QUALITY ORGANIZATION .....	9-3
THE IMPROVEMENT PROCESS .....	9-3
HARRIS STANDARD FLOWS .....	9-3
MEASUREMENT .....	9-6
Analytical Services Laboratory .....	9-6
Calibration Laboratory .....	9-6
FIELD RETURN PRODUCT ANALYSIS SYSTEM .....	9-6
Failure Analysis Laboratory .....	9-7
PFAST Action Request Form .....	9-8
RELIABILITY .....	9-9
Reliability Assessment and Enhancement .....	9-9
Qualifications .....	9-9
In-Line Reliability Monitors .....	9-9
PRODUCT/PACKAGE RELIABILITY MONITORS .....	9-9
Matrix I, II, III .....	9-9
RELIABILITY FUNDAMENTALS .....	9-9
Failure Rate Calculations .....	9-9
Acceleration Factors .....	9-11
Activation Energy .....	9-12
QUALIFICATION PROCEDURES .....	9-12
Document Control .....	9-13
/883 DATA SHEET HIGHLIGHTS .....	9-13
GENERAL TEST PHILOSOPHY .....	9-15
NON-STANDARD PRODUCT OFFERINGS .....	9-15
IC HANDLING PROCEDURES .....	9-16
Handling Rules .....	9-16
ESD HANDLING PROCEDURES .....	9-17
Measures of Protection and Prevention .....	9-17
Technical Brief #52 - Electrostatic Discharge Control .....	9-18





# Harris Quality & Reliability

## Introduction

Success in the integrated circuit industry means more than simply meeting or exceeding the demands of today's market. It also includes anticipating and accepting the challenges of the future. It results from a process of continuing improvement and evolution, with perfection as the constant goal.

Harris Semiconductor's commitment to supply only top value integrated circuits has made quality improvement a mandate for every person in our work force — from circuit designer to manufacturing operator, from hourly employee to corporate executive. Price is no longer the only determinant in marketplace competition. Quality, reliability, and performance enjoy significantly increased importance as measures of value in integrated circuits.

Quality in integrated circuits cannot be added on or considered after the fact. It begins with the development of capable process technology and product design. It continues in manufacturing, through effective controls at each process or step. It culminates in the delivery of products which meet or exceed the expectations of the customer.

## The Role of The Quality Organization

The emphasis on building quality into the design and manufacturing processes of a product has resulted in a significant refocus of the role of the Quality organization. In addition to facilitating the development of SPC and DOX programs and working with manufacturing to establish control charts, Quality professionals are involved in the measurement of equipment capability, standardization of inspection equipment and processes, procedures for chemical controls, analysis of inspection data and feedback to the manufacturing areas, coordination of efforts for process and product improvement, optimization of environmental or raw materials quality, and the development of quality improvement programs with vendors.

At critical manufacturing operations, process and product quality is analyzed through random statistical sampling and product monitors. The Quality organization's role is changing from policing quality to leadership and coordination of quality programs or procedures through auditing, sampling, consulting, and managing Quality Improvement projects.

To support specific market requirements, or to ensure conformance to military or customer specifications, the Quality organization still performs many of the conventional quality functions (e.g., group testing for military products or wafer lot acceptance). But, true to the philosophy that quality is everyone's job, much of the traditional on-line measurement and control of quality characteristics is where it belongs — with the people who make the product. The

Quality organization is there to provide leadership and assistance in the deployment of quality techniques, and to monitor progress.

## The Improvement Process

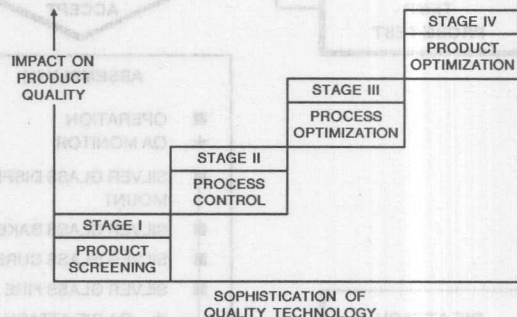


FIGURE 1. STAGES OF STATISTICAL QUALITY TECHNOLOGY

Harris Semiconductor's quality methodology is evolving through the stages shown in Figure 1. In 1981 we embarked on a program to move beyond Stage I, and we are currently in the transition from Stage II to Stage III, as more and more of our people become involved in quality activities. The traditional "quality" tasks of screening, inspection, and testing are being replaced by more effective and efficient methods, putting new tools into the hands of all employees. Table 1 illustrates how our quality systems are changing to meet today's needs.

## Harris Standard Flows

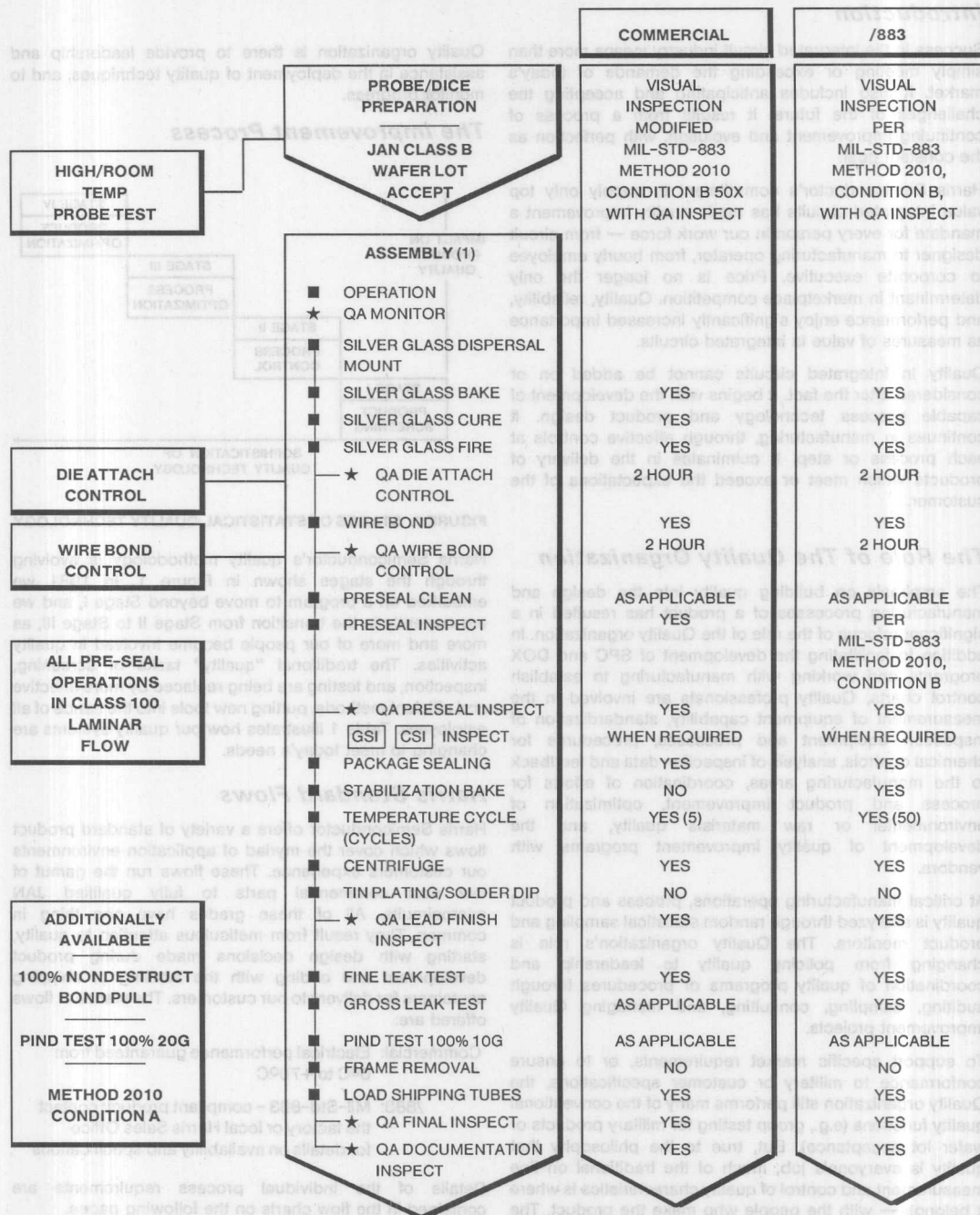
Harris Semiconductor offers a variety of standard product flows which cover the myriad of application environments our customers experience. These flows run the gamut of low cost commercial parts to fully qualified JAN microcircuits. All of these grades have one thing in common. They result from meticulous attention to quality, starting with design decisions made during product development and ending with the labeling of shipping containers for delivery to our customers. The standard flows offered are:

Commercial: Electrical performance guaranteed from 0°C to +70°C

/883: Mil-Std-883 - compliant product: contact the factory or local Harris Sales Office for details on availability and specifications

Details of the individual process requirements are contained in the flow charts on the following pages.

# Harris Semiconductor Standard Processing Flows



(1) Example for a PGA Package Part

## Harris Semiconductor Standard Processing Flows (Continued)

		COMMERCIAL	/883
	TEST		
	■ OPERATION		
	★ QA MONITOR		
AC/DC SINGLE INSERTION TEST CAPABILITY; HIGH/LOW TEMP	■ ELECTRICAL TEST	YES	YES
	— SORTING OPERATION		
BURN-IN	★ QA MONITOR	YES	NO
	■ SERIALIZE	NO	QUAL SAMPLES
QUALITY CONFORMANCE BY MIL-STD-883 METHOD 5005, GROUPS A, B, C AND D AS REQUIRED	■ PREBURN-IN ELECTRICAL TEST	NO	YES
	■ BURN-IN (2)	NO	160 HOURS @ +125°C, OR
DELTA PER SLASH SHEET REQUIREMENT IF APPLICABLE	■ POST BURN-IN TEST	NO	PER SLASH SHEET
IN HOUSE PACKAGE MOISTURE MONITOR CAPABILITY	■ APPLY BURN-IN TEST	NO	YES
	■ APPLY BURN-IN PDA (AS APPLICABLE)	NO	YES
COMPUTERIZED LOT TRACEABILITY MONITORING SYSTEM	■ BRAND	YES	YES
	■ EXTERNAL VISUAL	YES	YES
	★ QUALITY CONFORMANCE INSPECTION	GROUP A	GROUP A, B; C, D (AS APPLICABLE)
	■ FINAL DATA REVIEW	NO	YES
	PACKAGE & SHIP OR STOCK		

(2) Burn-in test temperatures can be increased and time reduced per regression tables in Mil-Std-883, Method 1015

### Advantages of Standard Flows

Wherever feasible, and in accordance with good value engineering practice, the IC user should specify device grades based on one of the five standard Harris manufacturing flows. These are more than adequate for the overwhelming majority of applications and may be utilized quite effectively if the user engineer bases designs on the standard data sheet, military drawing or slash sheet (as applicable) electrical limits.

Some of the more important advantages gained by using standard as opposed to custom flows are as follows:

- Lower cost than the same or an equivalent flow executed on a custom basis. This results from the higher efficiency achieved with a constant product flow and the elimination of such extra cost items as special fixturing, test programs, additional handling and added documentation.
- Faster delivery. The manufacturer often can supply many items from inventory and, in any case, can establish and

maintain a better product flow when there is no need to restructure process and/or test procedures.

- Increased confidence in the devices. A continuing flow of a given product permits the manufacturer to monitor trends which may bear on end-product performance or reliability and to implement corrective action, if necessary.
- Reduction of risk. Since each product is processed independent of specific customer orders, the manufacturer absorbs production variability within its scheduling framework without major impact on deliveries. In a custom flow, a lot failure late in the production cycle can result in significant delays in delivery due to the required recycling time.

Despite the advantages of using standard flows, there are cases where a special or custom flow is mandatory to meet design or other requirements. In such cases, the Harris Marketing groups stand ready to discuss individual customer needs and, where indicated, to accommodate appropriate custom flows.



## Measurement

### Analytical Services Laboratory

Harris facilities, engineering, manufacturing, and product assurance are supported by the Analytical Services Laboratory. Organized into chemical or microbeam analysis methodology, staff and instrumentation from both labs cooperate in fully integrated approaches necessary to complete analytical studies. The capabilities of each area are shown below.

**SPECTROSCOPIC METHODS:** Colorimetry, Optical Emission, Ultraviolet Visible, Fourier Transform-Infrared, Flame Atomic Absorption, Furnace Organic Carbon Analyzer, Mass Spectrometer.

**CHROMATOGRAPHIC METHODS:** Gas Chromatography, Ion Chromatography.

**THERMAL METHODS:** Differential Scanning Colorimetry, Thermogravimetric Analysis, Thermomechanical Analysis.

**PHYSICAL METHODS:** Profilometry, Microhardness, Rheometry.

**CHEMICAL METHODS:** Volumetric, Gravimetric, Specific Ion Electrodes.

**ELECTRON MICROSCOPE:** Transmission Electron Microscopy, Scanning Electron Microscope.

**X-RAY METHODS:** Energy Dispersive X-ray Analysis (SEM), Wavelength Dispersive X-ray Analysis (SEM), X-ray Fluorescence Spectrometry, X-ray Diffraction Spectrometry.

**SURFACE ANALYSIS METHODS:** Scanning Auger Microprobe, Electron Spectroscopy/Chemical Analysis, Secondary Ion Mass Spectrometry, Ion Scattering Spectrometry, Ion Microprobe.

The department also maintains ongoing working arrangements with commercial, university, and equipment manufacturers' technical service laboratories, and can obtain any materials analysis in cases where instrumental capabilities are not available in our own facility.

### Calibration Laboratory

Another important resource in the product assurance system is Harris Semiconductor's Calibration Lab. This area is responsible for calibrating the electronic, electrical, electro/mechanical, and optical equipment used in both the production and engineering areas. The accuracy of instruments used at Harris in calibration is traceable to the National Bureau of Standards. The lab maintains a system which conforms to the current revision of MIL-STD-45662, "Calibration System Requirements."

Each instrument requiring calibration is assigned a calibration interval based upon stability, purpose, and degree of use. The equipment is labeled with an identification tag on which is specified both the date of the last calibration and of the next required calibration. The Calibration Lab reports on a regular basis to each user department. Equipment out of calibration is taken out of

service until calibration is performed. The Quality organization performs periodic audits to assure proper control in the using areas. Statistical procedures are used where applicable in the calibration process.

### Field Return Product Analysis System

The purpose of this system is to enable Harris' Field Sales and Quality operations to properly route, track and respond to our customers' needs as they relate to product analysis.

The Product Failure Analysis Solution Team (PFAST) consists of the group of people who must act together to provide timely, accurate and meaningful results to customers on units returned for analysis. This team includes the salesman or applications engineer who gets the parts from the customer, the PFAST controller who coordinates the response, the Product or Test Engineering people who obtain characterization and/or test data, the analysts who failure analyze the units, and the people who provide the ultimate corrective action. It is the coordinated effort of this team, through the system described in this document that will drive the Customer responsiveness and continuous improvement that will keep Harris on the forefront of the semiconductor business.

The system and procedures define the processing of product being returned by the customer for analysis performed by Product Engineering, Reliability Failure Analysis and/or Quality Engineering. This system is designed for processing "sample" returns, not entire lot returns or lot replacements.

The philosophy is that each site analyzes its own product. This applies the local expertise to the solutions and helps toward the goal of quick turn time.

Goals: quick, accurate response, uniform deliverable (consistent quality) from each site, traceability.

The PFAST system is summarized in the following steps:

- 1) Customer calls the sales rep about the unit(s) to return.
- 2) Fill out PFAST Action Request - see the PFAST form in this section. This form is all that is required to process a Field Return of samples for failure analysis. This form contains essential information necessary to perform root cause analysis. (See Figure 2).
- 3) The units must be packaged in a manner that prevents physical damage and prevents ESD. Send the units and PFAST form to the appropriate PFAST controller. This location can be determined at the field sales office or rep using "look-up" tables in the PFAST document.
- 4) The PFAST controller will log the units and route them to ATE testing for data log.
- 5) Test results will be reviewed and compared to customer complaint and a decision will be made to route the failure to the appropriate analytical group.
- 6) The customer will be contacted with the ATE test results and interim findings on the analysis. This may relieve a line down situation or provide a rapid disposition of material. The customer contact is valuable in analytical process to insure root cause is found.

- 7) A report will be written and sent directly to the customer with copies to sales, rep, responsible individuals with corrective actions and to the PFAST controller so that the records will capture the closure of the cycle.
- 8) Each report will contain a feedback form (stamped and preaddressed) so that the PFAST team can assess their performance based on the customers assessment of quality and cycle time.
- 9) The PFAST team objectives are to have a report in the customers hands in 28 days, or 14 days based on agreements. Interim results are given realtime.

#### Failure Analysis Laboratory

The Failure Analysis Laboratory's capabilities encompass the isolation and identification of all failure modes/failure mechanisms, preparing comprehensive technical reports, and assigning appropriate corrective actions. Research vital to understanding the basic physics of the failure is also undertaken.

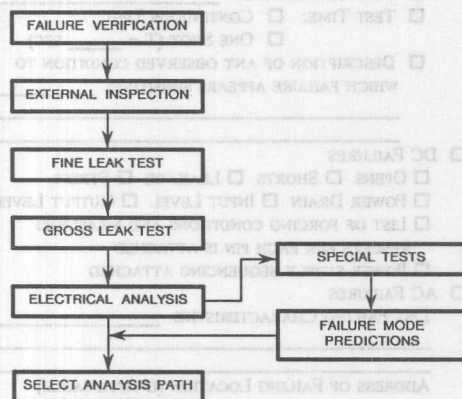


FIGURE 3. NON-DESTRUCTIVE

Failure analysis is a method of enhancing product reliability and determining corrective action. It is the final and crucial step used to isolate potential reliability problems that may have occurred during reliability stressing. Accurate analysis results are imperative to assess effective corrective actions. To ensure the integrity of the analysis, correlation of the failure mechanism to the initial electrical failure is essential.

A general failure analysis procedure has been established in accordance with the current revision of MIL-STD-883, Section 5003. The analysis procedure was designed on the premise that each step should provide information on the failure without destroying information to be obtained from subsequent steps. The exact steps for an analysis are determined as the situation dictates. (See Figures 3 and 4). Records are maintained by laboratory personnel and contain data, the failure analyst's notes, and the formal Product Analysis Report.

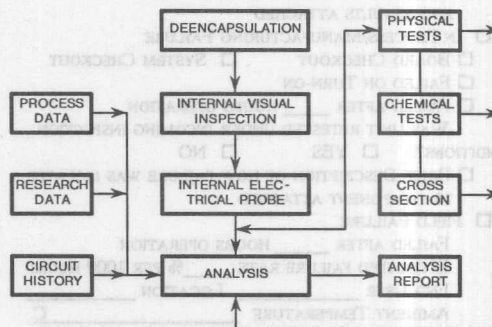


FIGURE 4. DESTRUCTIVE



## PFAST ACTION REQUEST

Request # \_\_\_\_\_  
Customer Analysis # \_\_\_\_\_

Date: \_\_\_\_\_

ORIGINATOR \_\_\_\_\_  
LOCATION/PHONE No. \_\_\_\_\_  
DEVICE TYPE/PART No. \_\_\_\_\_  
No. SAMPLES RETURNED \_\_\_\_\_

CUSTOMER \_\_\_\_\_  
LOCATION \_\_\_\_\_  
PURCHASE ORDER No. \_\_\_\_\_  
QUANTITY RECEIVED \_\_\_\_\_

THE COMPLETENESS AND TIMELY RESPONSE OF THE EVALUATION IS DIRECTLY RELATED TO THE COMPLETENESS OF THE DATA PROVIDED. PLEASE PROVIDE ALL PERTINENT DATA. ATTACH ADDITIONAL SHEETS IF NECESSARY.

### TYPE OF PROBLEM

1. ☐ INCOMING INSPECTION  
☐ 100% SCREEN ☐ SAMPLE INSPECTION  
No. TESTED \_\_\_\_\_ No. OF REJECTS \_\_\_\_\_  
ARE RESULTS REPRESENTATIVE OF PREVIOUS LOTS?  
☐ YES ☐ NO  
☐ BRIEF DESCRIPTION OF EVALUATION  
AND RESULTS ATTACHED
2. ☐ IN PROCESS/MANUFACTURING FAILURE  
☐ BOARD CHECKOUT ☐ SYSTEM CHECKOUT  
☐ FAILED ON TURN-ON  
☐ FAILED AFTER \_\_\_\_\_ HOURS OPERATION  
WAS UNIT RETESTED UNDER INCOMING INSPECTION  
CONDITIONS? ☐ YES ☐ NO  
☐ BRIEF DESCRIPTION OF HOW FAILURE WAS ISOLATED  
TO COMPONENT ATTACHED
3. ☐ FIELD FAILURE  
FAILED AFTER \_\_\_\_\_ HOURS OPERATION  
ESTIMATED FAILURE RATE \_\_\_\_\_ % PER 1000 HOURS  
END USER \_\_\_\_\_ LOCATION \_\_\_\_\_  
AMBIENT TEMPERATURE \_\_\_\_\_ C  
Min. \_\_\_\_\_ C Max. \_\_\_\_\_ C  
REL. HUMIDITY \_\_\_\_\_ %  
☐ END USER FAILURE CORRESPONDENCE ATTACHED

### ACTION REQUESTED BY CUSTOMER

SPECIFIC ACTION REQUESTED \_\_\_\_\_  
IMPACT OF FAILED UNITS ON CUSTOMER'S SITUATION: \_\_\_\_\_  
CUSTOMER CONTACTS WITH SPECIFIC KNOWLEDGE OF REJECTS  
NAME \_\_\_\_\_  
POSITION \_\_\_\_\_ PHONE \_\_\_\_\_

Additional Comments:

### DETAILS OF REJECT

(Where appropriate serialize units and specify for each)

- TEST CONDITIONS RELATING TO FAILURE
- ☐ TESTER USED (MFG/MODEL) \_\_\_\_\_
  - ☐ TEST TEMPERATURE \_\_\_\_\_
  - ☐ TEST TIME: ☐ CONTINUOUS TEST  
☐ ONE SHOT (T = \_\_\_\_\_ SEC)
  - ☐ DESCRIPTION OF ANY OBSERVED CONDITION TO  
WHICH FAILURE APPEARS SENSITIVE: \_\_\_\_\_

1. ☐ DC FAILURES  
☐ OPENS ☐ SHORTS ☐ LEAKAGE ☐ STRESS  
☐ POWER DRAIN ☐ INPUT LEVEL ☐ OUTPUT LEVEL  
☐ LIST OF FORCING CONDITIONS AND MEASURED  
RESULTS FOR EACH PIN IS ATTACHED  
☐ POWER SUPPLY SEQUENCING ATTACHED
2. ☐ AC FAILURES  
LIST FAILING CHARACTERISTICS \_\_\_\_\_

ADDRESS OF FAILING LOCATION (IF APPLICABLE) \_\_\_\_\_

ATTACHED:

- ☐ LIST OF POWER SUPPLY AND DRIVER LEVELS  
(Include pictures of waveforms).
  - ☐ LIST OF OUTPUT LEVELS AND LOADING CONDITIONS
  - ☐ INPUT AND OUTPUT TIMING DIAGRAMS
  - ☐ DESCRIPTION OF PATTERNS USED  
(If not standard patterns, give very complete  
description including address sequence).
3. ☐ PROM PROGRAMMING FAILURES  
ADDRESS OF FAILURES \_\_\_\_\_  
PROGRAMMER USED (MFG/MODEL/REV. No.) \_\_\_\_\_
  4. ☐ PHYSICAL/ASSEMBLY RELATED FAILURES  
☐ SEE COMMENTS BELOW ☐ SEE ATTACHED

FIGURE 2. PFAST ACTION REQUEST

## Reliability

### Reliability Assessment and Enhancement

At Harris Semiconductor, reliability is built into every product by emphasizing quality throughout manufacturing. This starts by ensuring the excellence of the design, layout, and manufacturing process. The quality of the raw materials and workmanship is monitored using statistical process control (SPC) to preserve the reliability of the product. The primary and ultimate goal of these efforts is to provide full performance to the product specification throughout its useful life. Product reliability is maintained through the following sources: Qualifications, In-Line Reliability Monitors, Failure Analysis.

### Qualifications

Qualifications at Harris de-emphasize the sole dependence on production product which is only available late in the development cycle. The focus is primarily on the use of test vehicles to establish design ground rules for the product and the process that will eliminate any wearout mechanisms during the useful life of the product. However, to comply with the military requirements concerning reliability, product qualifications are performed. (See Figure 5).

### In-line Reliability Monitors

In-line reliability monitors provide immediate feedback to manufacturing regarding the quality of workmanship, quality of raw materials, and the ultimate reliability implications. The rudimentary implementation of this monitoring is the "First Line of Defense," which is a pass/fail acceptance procedure based on control charts and trend analysis. The second level of monitoring is referred to as the "Early Warning System" and incorporates wafer level reliability concepts for extensive diagnostic and characterization capabilities of various components that may impact the device reliability or stability. The quick feedback from these schemes allows more accurate correlation to process steps and corrective actions.

### Product/Package Reliability Monitors

Reliability of finished product is monitored extensively under a program called Matrix I, II, III monitor. All major technologies are monitored.

**Matrix I** - Has a higher sampling size and rate per week and uses short duration test, usually less than 48 hours to assess day to day, week to week reliability. High volume types are prevalent in this data. Stresses - Operating Life, Static Life and HAST.  $T_A = +125^{\circ}\text{C}$  to  $+200^{\circ}\text{C}$

**Matrix II** - Longer duration test, much like requalification. The sample sizes are reduced in number and frequency, yet meet or exceed the JEDEC Standard 29. Stresses Operating Life, Storage, THB, Autoclave, Temp Cycle, and Thermal Shock.

**Matrix III** - Package specific test. Tests Solderability, Lead Fatigue, Physical Dimensions, Brand Adhesion, Flammability, Bond Pull, Constant Acceleration, and Hermeticity.

Data from these Monitor Stress Test provides the following information:

- Routine reliability monitoring of products by die technology and package styles.

- Data base for determining FIT Rates and Failures Mode trends used drive Continuous Improvement.
- Major source of reliability data for customers.
- Customers have used this data to qualify Harris products.

## Reliability Fundamentals

Reliability, by its nature, is a mixture of engineering and probability statistics. This combination has derived a vocabulary of terms essential for describing the reliability of a device or system. Since reliability involves a measurement of time, it is necessary to accelerate the failures which may occur. This, then, introduces terms like "activation energy" and "acceleration factor," which are needed to relate results of stressing to normal operating conditions (see Table 1). Also, to assess product reliability requires failures. Therefore, only a statistical sample can be used to determine the model of the failure distribution for the entire population of product.

### Failure Rate Calculations

Reliability data for products may be composed of several different failure mechanisms and requires careful combining of diverse failure rates into one comprehensive failure rate. Calculating the failure rate is further complicated because failure mechanisms are thermally accelerated at varying rates and thereby have differing accelerating factors. Additionally, this data is usually obtained a variety of life tests at unique stress temperatures. The equation below accounts for these considerations and then inserts a statistical factor to obtain the confidence interval for the failure rate.

$$\text{FIT} = \left( \frac{B}{\sum_{i=1}^B \frac{X_i}{K \sum_{j=1}^K \text{TDG}_j \text{AF}_{ij}}} \right) \times 10^9 \times M$$

$B$  = # of distinct possible failure mechanisms

$K$  = # of life tests being combined

$X_i$  = # of failures for a given failure mechanism  $i = 1, 2, \dots B$

$\text{TDG}_j$  = Total device hours of test time (unaccelerated) for Life Test  $j$

$\text{AF}_{ij}$  = Acceleration factor for appropriate failure mechanism  $i = 1, 2, \dots K$

$M$  = Statistical factor for calculating the upper confidence limit ( $M$  is a function of the total number of failures and an estimate of the standard deviation of the failure rates)

In the failure rate calculation, Acceleration Factors ( $\text{AF}_{ij}$ ) are used to derate the failure rate from thermally accelerated Life Test conditions to a failure rate indicative of use temperatures. Though no standards exist, a temperature of  $+55^{\circ}\text{C}$  has been popular and allows some comparison of product failure rates. All Harris Semiconductor Reliability Reports will derate to  $+55^{\circ}\text{C}$  at both the 60% and 95% confidence intervals.





FIGURE 5. NEW PROCESS PRODUCT DEVELOPMENT AND LIFE CYCLE

## Acceleration Factors

The Acceleration Factors (AF) are determined from the Arrhenius Equation. This equation is used to describe physiochemical reaction rates and is an appropriate model for expressing the thermal acceleration of semiconductor failure mechanisms.

$$AF = \exp \left[ \frac{E_a}{K} \left( \frac{1}{T_{use}} - \frac{1}{T_{stress}} \right) \right]$$

AF = Acceleration Factor

$E_a$  = Thermal Activation Energy in eV from Table 8

K = Boltzmann's Constant ( $8.62 \times 10^{-5}$  eV/°K)

Both  $T_{use}$  and  $T_{stress}$  (in degrees Kelvin) include the internal temperature rise of the device and therefore represent the junction temperature. With the use of the Arrhenius Equation, the thermal Activation Energy ( $E_a$ ) term is a major influence on the result. This term is usually empirically derived and can vary widely.

TABLE 1. FAILURE RATE PRIMER

## GLOSSARY OF TERMS

TERMS/DEFINITION	UNITS/DESCRIPTION
<b>FAILURE RATE <math>\lambda</math></b>  For Semiconductors, usually expressed in FITs.  Represents useful life failure rate (which implies a constant failure rate).  FITs are not applicable for infant mortality or wearout failure rate expressions.	<b>FIT - Failure In Time</b>  1 FIT = 1 failure in $10^9$ device hours. Equivalent to 0.0001%/1000 hours FITs = $\frac{\# \text{ Failures}}{\# \text{ Devices} \times \# \text{ hours stress} \times AF}$ m - Factor to establish Confidence Interval 10 <sup>9</sup> - Establishes in terms of FITs AF - Acceleration Factor at temperature for a given failure mechanism
<b>MTTF - Mean Time To Failure</b>  For semiconductors, MTTF is the average or mean life expectancy of a device.  If an exponential distribution is assumed then the mean time to fail of the population will be when 63% of the parts have failed.	Mean Time is measured usually in hours or years.  1 Year = 8760 hours  When working with a constant failure rate the MTTF can be calculated by taking the reciprocal of the failure rate. MTTF = $1/\lambda$ (exponential model)  Example: =10 FITs at +55°C The MTTF is: MTTF = $1/\lambda = 0.1 \times 10^9$ hours = 100M hours
<b>CONFIDENCE INTERVAL (C.I.)</b>  Establishes a Confidence Interval for failure rate predictions. Usually the upper limit is most significant in expressing failure rates.	Example: "10 FITs @ a 95% C.I. @ 55°C" means only that you are 95% certain the FITs <10 at +55°C use conditions.

TABLE 2. HIGH TEMPERATURE OPERATING LIFE TEST SUMMARY

GENERIC GROUP	PROCESS DESCRIPTION	QUANTITY	QUANTITY FAILURE	HOURS @ 125°C	FAILURE RATE @ 55°C (PPM)
C-102-2 Microprocessors and Peripherals	5ALCMC817	1422	0	8,72 ± 68	2

## Activation Energy

To determine the Activation Energy ( $E_a$ ) of a mechanism (see Table 2) you must run at least two (preferably more) tests at different stresses (temperature and/or voltage). The stresses will provide the time to failure ( $T_f$ ) for the populations which will allow the simultaneous solution for the Activation Energy by putting the experimental results into the following equations.

$$\ln(t_{f1}) = C + \frac{E_a}{KT_1} \quad \ln(t_{f2}) = C + \frac{E_a}{KT_2}$$

Then, by subtracting the two equations, the Activation Energy becomes the only variable, as shown.

$$\ln(t_{f1}) - \ln(t_{f2}) = E_a/k(1/T_1 - 1/T_2)$$

$$E_a = K * ((\ln(t_{f1}) - \ln(t_{f2})) / (1/T_1 - 1/T_2))$$

The Activation Energy may be estimated by graphical analysis plots. Plotting  $\ln$  time and  $\ln$  temperature then provides a convenient nomogram that solves (estimates) the Activation Energy.

Table 3 is a summary for the L7 process.

All Harris Reliability Reports from qualifications and Group C1 (all high temperature operating life tests) will provide the

data on all factors necessary to calculate and verify the reported failure rate (in FITs) using the methods outlined in this primer.

## Qualification Procedures

New products are reliably introduced to market by the proper use of design techniques and strict adherence to process layout ground rules. Each design is reviewed from its conception through early production to ensure compliance to minimum failure rate standards. Ongoing monitoring of reliability performance is accomplished through compliance to 883C and standard Quality Conformance Inspection as defined in Method 5005.

New process/product qualifications have two major requirements imposed. First is a check to verify the proper use of process methodology, design techniques, and layout ground rules. Second is a series of stress tests designed to accelerate failure mechanisms and demonstrate the reliability of integrated circuits.

From the earliest stages of a new product's life, the design phase, through layout, and in every step of the manufacturing process, reliability is an integral part of every Harris Semiconductor product. This kind of attention to detail "from the ground up" is the reason why our customers can expect the highest quality for any application.

TABLE 2. FAILURE MECHANISM

FAILURE MECHANISM	ACTIVATION ENERGY	SCREENING AND TESTING METHODOLOGY	CONTROL METHODOLOGY
Oxide Defects	0.3 - 0.5eV	High temperature operating life (HTOL) and voltage stress. Defect density test vehicles.	Statistical Process Control of oxide parameters, defect density control, and voltage stress testing.
Silicon Defects (Bulk)	0.3 - 0.5eV	HTOL & voltage stress screens.	Vendor Statistical Quality Control programs, and Statistical Process Control on thermal processes.
Corrosion	0.45eV	Highly accelerated stress testing (HAST)	Passivation dopant control, hermetic seal control, improved mold compounds, and product handling.
Assembly Defects	0.5 - 0.7eV	Temperature cycling, temperature and mechanical shock, and environmental stressing.	Vendor Statistical Quality Control programs, Statistical Process Control of assembly processes proper handling methods.
Electromigration - Al Line - Contact	0.6eV 0.9eV	Test vehicle characterizations at highly elevated temperatures.	Design ground rules, wafer process statistical process steps, photoresist, metals and passivation
Mask Defects/ Photoresist Defects	0.7eV	Mask FAB comparator, print checks, defect density monitor in FAB, voltage stress test and HTOL.	Clean room control, clean mask, pellicles Statistical Process Control or photoresist- etch processes.
Contamination	1.0eV	C-V stress at oxide/interconnect, wafer FAB device stress test (EWS) and HTOL.	Statistical Process Control of C-V data, oxide/ interconnect cleans, high integrity glassivation and clean assembly processes.
Charge Injection	1.3eV	HTOL & oxide characterization.	Design ground rules, wafer level Statistical Process Control and critical dimensions for oxides.

TABLE 3. HIGH TEMPERATURE OPERATING LIFE TEST SUMMARY

GENERIC GROUP	GROUP NAME	PROCESS DESCRIPTION	QUANTITY	QUANTITY FAILURE	HOURS @ 125°C	FAILURE RATE FITs @ 55°C 60% CI
C-105-5	Microprocessor and Peripherals	SAJI CMOS L7	1452	0	5.72 E + 06	2

## Harris High Reliability Product Specification Highlights

Harris Semiconductor is a leading supplier of high reliability integrated circuits to the military and aerospace community and takes pride in offering products tailored to the most demanding applications requirements. Our Manufacturing facilities are JAN-Certified to MIL-M-38510 and provide JAN-qualified and MIL-STD-883 compliant products as standard data book items. This DSP Data Book contains detailed information on high-reliability integrated circuits presently available from Harris Semiconductor.

The intent of the /883 data sheet is to provide to our customers a clear understanding of the testing being performed in conformance with MIL-STD-883 requirements. Additionally, it is our intent to provide the most effective and comprehensive testing feasible.

### Document Control

Harris has established each of the /883 data sheets as an internally revised controlled document. Any product revision or modification must be approved and signed-off throughout the manufacturing and engineering sections. Harris has made every effort to ensure accuracy of the information in this data book through quality control methods. Harris reserves the right to make changes to the products contained in this data book to improve performance, reliability and producibility. Each data sheet will use the printed date as the revision control identification. Contact Harris for the latest available specifications and performance data.

### /883 Data Sheet Highlights

Each specific /883 data sheet documents the features, description, pinouts, tested electrical parameters, test circuits, burn-in circuits, die characteristics, packaging and design information. The following are notes and clarifications that will help in applying the information provided in the data sheet.

**Absolute Maximum Ratings:** These ratings are provided as maximum stress ratings and should be taken into consideration during system design to prevent conditions which may cause permanent damage to the device. Operation of the device at or above the "Absolute Maximum Ratings" is not intended, and extended exposure may affect the device reliability.

**Reliability Information:** Each /883 data sheet contains thermal information relating to the package and die. This information is intended to be used in system design for determining the expected device junction temperatures for overall system reliability calculations.

**Packaging:** Harris utilizes MIL-M-38510, Appendix C for packages used for /883 products. The mechanical dimensions and materials used are shown for each individual product to complete each data sheet as a self contained document.

**D.C. and A.C. Electrical Parameters:** Tables 1 and 2 define the D.C. and A.C. Electrical Parameters that are 100% tested in production to guarantee compliance to MIL-STD-883. The subgroups used are defined in MIL-STD-883, Method 5005 and designated under the provisions of Paragraph 1.2.1a. Test Conditions and Test Circuits are provided for specific parameter testing.

Table 3 provides additional device limits that are guaranteed by characterization of the device and are not directly tested in production. Characterization takes place at initial device design and after any major process or design changes. The characterization data is on file and available demonstrating the test limits established.

Table 4 provides a summary of the test requirements and the applicable MIL-STD-883 subgroups.

**Burn-in Circuits:** The Burn-in circuits defined in the individual data sheets are those used in the actual production process. Burn-in is conducted per MIL-STD-883, Method 1015.

**Design Information Sections:** Harris provides an additional Design Information Section in many of the data sheets to assist in system application and design. This information may be in the form of applications circuits, typical device parameters, or additional device related user information such as programming information. While this information cannot be guaranteed, it is based on actual characterization of the product and is representative of the data sheet device.



## High Reliability Products Information

Harris' High Reliability Products are all produced in accordance with military specifications and standards, primarily MIL-M-38510 (General Specifications for Microcircuits) and MIL-STD-883 (Test Methods and Procedures for Microelectronics).

MIL-STD-883 contains test methods and procedures for various electrical, mechanical and environmental tests as well as requirements for screening, qualification and quality conformance inspection. Method 5004 of MIL-STD-883 lists the 100% screening tests which are required for each of the product assurance classes defined above.

Following the device screening, samples are removed from the production lot(s) for Quality Conformance Inspection testing. This testing is divided into four inspection groups: A, B, C and D, which are performed at prescribed intervals per MIL-M-38510 to assure the processes are in control and to ensure the continued quality level of the product being produced.

**Group A** electrical inspection involves dynamic, static, functional and switching tests at maximum, minimum and room operating temperatures. Sample sizes and specific tests performed depend upon the particular product assurance class chosen. Electrical test sampling is performed on all subgroups as defined in MIL-STD-883, Method 5005.

**Group B** inspection includes tests for marking permanency, internal visual and mechanical correctness, bond strength, and solderability. It is intended to provide assurance of the absence of lot-to-lot fabrication and manufacturing variances. Group B tests are again defined in test Method 5005.

**Group C** is oriented toward die integrity and consists of operating life testing as defined in MIL-STD-883, Method 5005.

**Group D** environmental testing is provided to verify die and package reliability. Among the Group D tests are lead integrity, hermeticity, temperature cycling, thermal and mechanical shock, and constant acceleration.

MIL-M-38510 requires that Group A and Group B inspection be performed on each lot, while Group C inspection must be done every 3 months and Group D every 6 months to be in compliance with MIL-M-38510 JAN requirements. To limit the amount of testing, MIL-M-38510 allows the multitude of micro-circuits to be grouped by technology, commonly known as "generic families". Thus, one group C performed will cover all parts included in that generic family for three months. For Group D, which is package related, although there are some restrictions, one Group D performed on a 24-pin ceramic dual-in-line packaged part will cover all devices in the same package regardless of the technology group.

For MIL-STD-883 products, Groups A and B are required on each lot, Groups C and D are required every 52 weeks by generic die family and package fabricated and manufactured from the same plant as the die and package represented.

## General Test Philosophy

The general philosophy for test set development is to supply test software that guarantees the high performance and quality of the products being designed and manufactured by Harris. The general final test set includes a guardbanded initial test program and a QA test program for the quality test step. Characterization software is an additional test program that parametrically measures and records the performance of the device under test. This test set is used to evaluate the performance of a product and to determine the acceptability of non-standard Source Control Drawings. BSPEC and RSPEC test programs are custom final test programs written to conform to customer specifications.

The general test development strategy is to develop software using a "shell" programming technique which creates standard test program flows, and reduces test development and execution times. Statistically derived guardbands are utilized in the "shell" programs to null out test system variability. High performance hardware interface designs are incorporated for maximized test effectiveness, and efficient fault graded vector sets are utilized for functional and AC testing.

The initial step in generating the test set is the test vector generation. The test vectors are the binary stimulus applied to the device under test to functionally test the operation of the product. The vectors are developed against a behavioral model that is a software representation of the device functionality. The output of the behavioral model can be translated directly to ATE test vectors or prepared for CAD simulation.

The philosophy in the generation of test vectors is to develop efficient fault graded patterns with a goal of greater than 90% fault coverage. There is no intent to generate a worst case or best case noise vector set. The intent is to maximize fault coverage through efficient vector use. Generally only one vector set will be required to enable complete test coverage within a given test program.

Exceptions to this would be vector generation to test certain identified critical AC speed paths or DC vectors for testing VIH/VIL parameters. These vector sets typically will not increase fault coverage and can not be substituted for fault graded vector sets.

The ultimate goal for testing all /883 products is data sheet compliancy, thoroughness, and quality of testing. By taking this approach to test set generation, Harris is capable of supplying high performance semiconductors of the highest quality to the marketplace.

### Non-Standard Product Offerings

Harris understands the need for customer generated Source Control Drawings with non-standard parameter and/or screening requirements. A Customer Engineering Department is responsible for efficiently expediting your SCDs through a comprehensive review process. The Customer Engineering Group compares your SCD to its closest equivalent grade device type and works closely with the Product Engineer, Manufacturing Engineer, Design Engineer, or applicable individual to compare Harris' screening ability against your non-standard requirement(s). For product processed to non-standard requirements, a unique part number suffix is assigned.

Harris shares the military's objective to utilize standards wherever possible. We recommend using our /883 data sheet as the guideline for your SCD's. In instances where an available military specification or Harris /883 datasheet is inappropriate, it is Harris' sincerest wish to work closely with the buyer in establishing an acceptable procurement document. For this reason, the customer is requested to contact the nearest Harris Sales Office or Representative before finalizing the Source Control Drawing. Harris looks forward to working with the customer prior to implementation of the formal drawing so that both parties may create a mutually acceptable procurement document.

rugged products on the market. However, no semiconductor is immune from damage resulting from the sudden application of many thousands of volts of static electricity. While the phenomenon of catastrophic failure of devices containing MOS transistors or capacitors is well known, even bipolar circuits can be damaged by static discharge, with altered electrical properties and diminished reliability. None of the common IC internal protection networks operate quickly enough to positively prevent damage.

It is suggested that all semiconductors be handled, tested, and installed using standard "MOS handling techniques" of proper grounding of personnel and equipment. Parts and subassemblies should not be in contact with untreated plastic bags or wrapping material. High impedance IC inputs wired to a P.C. connector should have a path to ground on the card.

#### HANDLING RULES

Since the introduction of integrated circuits with MOS structures and high quality junctions, a safe and effective means of handling these devices has been of primary importance. One method employed to protect gate oxide structures is to incorporate input protection diodes directly on the monolithic chip. However, there is no completely foolproof system of chip input protection in existence in the industry. In addition, most compensation networks in linear circuits are located at high impedance nodes, where protection networks would disturb normal circuit operation. If static discharge occurs at sufficient magnitude (2kV or more), some damage or degradation will usually occur. It has been found that handling equipment and personnel can generate static potentials in excess of 10kV in a low humidity environment. Thus it becomes necessary for additional measures to be implemented to eliminate or reduce static charge. It is evident, therefore, that proper handling procedures or rules should be adopted.

accomplished as follows:

- Use static-free work stations. Static-dissipative mats on work benches and floor, connected to common point ground through a 1M $\Omega$  resistor, help eliminate static build-up and discharge. Do not use metallic surfaces.
- Ground all handling equipment.
- Ground all handling personnel with a conductive bracelet through 1M $\Omega$  to ground (the 1M $\Omega$  resistor will prevent electroshock injury to personnel). Transient product personnel should wear grounding heel straps when conductive flooring is present.
- Smocks and clothing of certain insulating materials (notably nylon) should not be worn in areas where devices are handled. These materials, highly dielectric in nature, will hold, or aid in the generation of a static charge. Where they cannot be eliminated, natural materials such as cotton should be used to minimize charge generation capacity. Conductive smocks are also available as an alternative.
- Control relative humidity to as high a level as practical. 50% is generally considered sufficient. (Operations should cease if R.H. falls below 25%).
- Ionized air blowers reduce charge build-up in areas where grounding is not possible or practical.
- Devices should be in conductive static-shielded containers during all phases of transport. Leads may be shorted by tubular metallic carriers, conductive foam, or foil.
- In automated handling equipment, the belts, chutes, or other surfaces should be of conducting non-metal material. If this is not possible, ionized air blowers or ionizing bars may be a good alternative.

## ESD Handling Procedures

Harris has developed a static control program that enables employees to detect problems generated by static electricity whether on site, in transit, or in the field. Controlling the requirements, methods, materials, and training for static protection of our products is ongoing and updated with new developments in electrostatic prevention. Harris has responded with controls and procedures as part of daily operations to be followed in all areas.

The challenge is to insure all electrostatic control procedures are followed throughout the system — from manufacturing through end use. Unprotected integrated circuits can be destroyed or functionally altered by merely passing them through the electrostatic field of something as simple as Styrofoam™ or human contact.

### Measures of Protection and Prevention

When handling static sensitive devices, three standard procedures must be followed:

1. Prior to any handling of static-sensitive components, the individual must be properly grounded.
2. All static-sensitive components must be handled at static safeguarded work stations.
3. Containers and packing materials that are static-protective must be used when transporting all static-sensitive components.

Special handling equipment (static-safeguarded work stations, conductive wrist straps, static-protected packaging, ionized air blowers) should be used to reduce damaging effects of electrostatic fields and charges.

**Static-safeguarded work station** is an area that is free from all damaging electricity, including people. To accomplish this, static on conductors and nonconductors must be controlled.

Controlling electrically conductive items can be accomplished by bonding and grounding techniques. The human body is considered a conductor of electricity and is by far the greatest generator of static electricity. Personnel handling ICs must use conductive wrist straps to ground themselves. Simple body moves act like a variable capacitor, and can create static charges. In addition, conductive clothing is recommended for minimizing electrostatic build up.

**Static protective packaging** prevents electric field from influencing or damaging ICs. An effective static-protective package exhibits three types of features:

1. Antistatic protection that prevents triboelectric or frictional charging,
2. Dielectric protection that insulates discharging, and
3. Shielding or Faraday cage protection that prevents transient field penetration.

Harris uses only packaging that exhibits all three features. Employees are required to adhere to the same static-protective packaging techniques during handling and shipment to assure device integrity is maintained.

**Ionized air blowers** aid in neutralizing charges on nonconductors such as synthetic clothing, plastics, and Styrofoam™. The blowers are placed at the work site and in close proximity to the IC handling area, since nonconductors do not lose or drain charges using normal grounding techniques.

By using wrist straps, static-protected work stations and static-protected containers, Harris product quality is maintained throughout the product cycle.

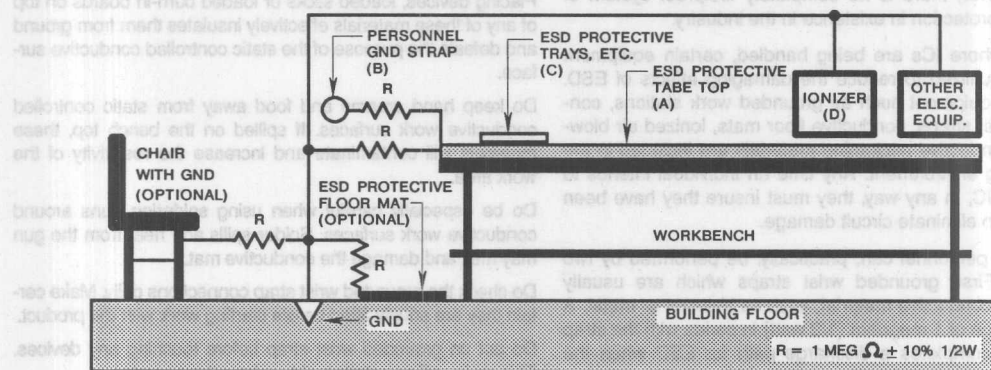
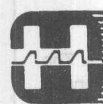


FIGURE 2. STATIC-SAFEGUARDED WORK STATION

- NOTE 1. All electrical equipment on the conductive table top must be hard grounded and isolated from the table top.
2. Earth ground is not computer ground or RF ground or any other limited ground.





## ELECTROSTATIC DISCHARGE CONTROL A GUIDE TO HANDLING INTEGRATED CIRCUITS

This paper discusses methods and materials recommended for protection of ICs against ESD damage or degradation during manufacturing operations vulnerable to ESD exposure. Areas of concern include dice prep and handling, dice and package inspection, packing, shipping, receiving, testing, assembly and all operations where ICs are involved.

All integrated circuits are sensitive to electrostatic discharge (ESD) to some degree. Since the introduction of integrated circuits with MOS structures and high quality junctions, safe and effective means of handling these devices have been of primary importance.

If static discharge occurs at a sufficient magnitude, 2kV or greater, some damage or degradation will usually occur. It has been found that handling equipment and personnel can generate static potentials in excess of 10kV in a low humidity environment; thus it becomes necessary for additional measures to be implemented to eliminate or reduce static charge. Avoiding any damage or degradation by ESD when handling devices during the manufacturing flow is therefore essential.

### ESD Protection and Prevention Measures

One method employed to protect gate oxide structures is to incorporate input protection diodes directly on the monolithic chip. However, there is no completely foolproof system of chip input protection in existence in the industry.

In areas where ICs are being handled, certain equipment should be utilized to reduce the damaging effects of ESD. Typically, equipment such as grounded work stations, conductive wrist straps, conductive floor mats, ionized air blowers and conductive packaging materials are included in the IC handling environment. Any time an individual intends to handle an IC, in any way, they must insure they have been grounded to eliminate circuit damage.

Grounding personnel can, practically, be performed by two methods. First, grounded wrist straps which are usually made of a conductive material, such as Velostat or metal. A resistor value of 1 megohm (1/2 watt) in series with the strap to ground completes a discharge path for ESD when the operator wears the strap in contact with the skin. Another method is to insure direct physical contact with a grounded, conductive work surface.

This consists of a conductive surface like Velostat, covering the work area. The surface is connected to a 1 megohm (1/2 watt) resistor in series with ground.

In addition to personnel grounding, areas where work is being performed with ICs, should be equipped with an ionized air blower. Ionized air blowers force positive and negative ions simultaneously over the work area so that any nonconductors that are near the work surface would have their static charge neutralized before it would cause device damage or degradation.

Relative humidity in the work area should be maintained as high as practical. When the work environment is less than 40% RH, a static build-up condition can exist on nonconductors allowing stored charges to remain near the ICs causing possible static electricity discharge to ICs.

Integrated circuits that are being shipped or transported require special handling and packaging materials to eliminate ESD damage. Dice or packaged devices should be in conductive carriers during all phases of transport and handling. Leads of packaged devices can be shorted by tubular metallic carriers, conductive foam or foil.

### Do's and Don'ts for Integrated Circuit Handling

#### Do's

Do keep paper, nonconductive plastic, plastic foams and films or cardboard off the static controlled conductive bench top. Placing devices, loaded sticks or loaded burn-in boards on top of any of these materials effectively insulates them from ground and defeats the purpose of the static controlled conductive surface.

Do keep hand creams and food away from static controlled conductive work surfaces. If spilled on the bench top, these materials will contaminate and increase the resistivity of the work area.

Do be especially careful when using soldering guns around conductive work surfaces. Solder spills and heat from the gun may melt and damage the conductive mat.

Do check the grounded wrist strap connections daily. Make certain they are snugly fitted before starting work with the product.

Do put on grounded wrist strap before touching any devices. This drains off any static build-up from the operator.

Do know the ESD caution symbols.

Do remove devices or loaded sticks from shielding bags only when grounded via wrist strap at grounded work station. This also applies when loading or removing devices from the antistatic sticks or the loading on or removing from the burn-in boards.

Do wear grounded wrist straps in direct contact with the bare skin never over clothing.

Do use the same ESD control with empty burn-in boards as with loaded boards if boards contain permanently mounted ICs as part of driver circuits.

Do insure electrical test equipment and solder irons at an ESD control station are grounded and only uninsulated metal hand tools be used. Ordinary plastic solder suckers and other plastic assembly aids shall not be used.

Do use ionizing air blowers in static controlled areas when the use of plastic (nonconductive) materials cannot be avoided.

#### Don'ts

Don't allow anyone not grounded to touch devices, loaded sticks or loaded burn-in boards. To be grounded they must be standing on a conductive floor mat with conductive heel straps attached to footwear or must wear a grounded wrist strap.

Don't touch the devices by the pins or leads unless grounded since most ESD damage is done at these points.

Don't handle devices or loaded sticks during transport from work station to work station unless protected by shielding bags. These items must never be directly handled by anyone not grounded.

Don't use freon or chlorinated cleaners at a grounded work area.

Don't wax grounded static controlled conductive floor and bench top mats. This would allow build-up of an insulating layer and thus defeating the purpose of a conductive work surface.

Don't touch devices or loaded sticks or loaded burn-in boards with clothing or textiles even though grounded wrist strap is worn. This does not apply if conductive coats are worn.

Don't allow personnel to be attached to hard ground. There must always be 1 megohm series resistance (1/2 watt between the person and the ground).

Don't touch edge connectors of loaded burn-in boards or empty burn-in boards containing permanently mounted

driver circuits when not grounded. This also applies to burn-in programming cards containing ICs.

Don't unload stick on a metal bench top allowing rapid discharge of charged devices.

Don't touch leads. Handle devices by their package even though grounded.

Don't allow plastic "snow or peanut" polystyrene foam or other high dielectric materials to come in contact with devices or loaded sticks or loaded burn-in boards.

Don't allow rubber/plastic floor mats in front of static controlled work benches.

Don't solvent-clean devices when loaded in antistatic sticks since this will remove antistatic inner coating from sticks.

Don't use antistatic sticks for more than one throughput process. Used sticks should not be reused unless recoated.

### Recommended Maintenance Procedures

#### Daily:

Perform visual inspection of ground wires and terminals on floor mats, bench tops, and grounding receptacles to ensure that proper electrical connections via 1 megohm resistor (1/2 watt) exist.

Clean bench top mats with a soft cloth or paper towel dampened with a mild solution of detergent and water.

#### Weekly:

Damp mop conductive floor mats to remove any accumulated dirt layer which causes high resistivity.

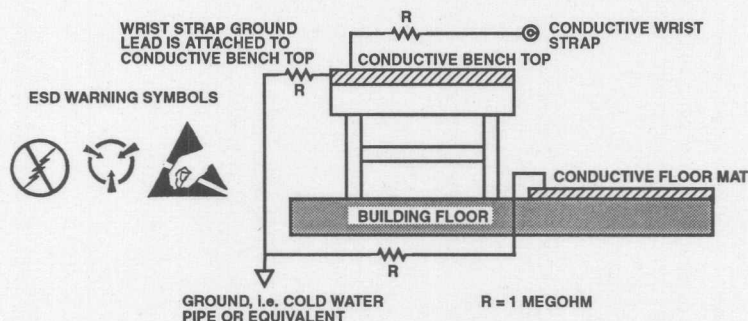
#### Annually:

Replace nuclear elements for ionized air blowers.

Review ESD protection procedures and equipment for updating and adequacy.

### Static Controlled Work Station

The figure below shows an example of a work bench properly equipped to control electro-static discharge. Note that the wrist strap is connected to a 1 megohm resistor. This resistor can be omitted in the setup if the wrist strap has a 1 megohm assembled on the cable attached.





## PACKAGING AND ORDERING INFORMATION

	PAGE
PACKAGING AVAILABILITY .....	10-3
PACKAGE OUTLINES .....	10-4
ORDERING INFORMATION .....	10-9
AVAILABLE PRODUCT CODES .....	10-10



10

DSP

# PACKAGING AND ORDERING INFORMATION

PAGE	
10-8	PACKAGING AVAILABILITY
10-4	PACKAGE OUTLINES
10-0	ORDERING INFORMATION
10-10	AVAILABLE PRODUCT CODES

ORDERING INFO  
10

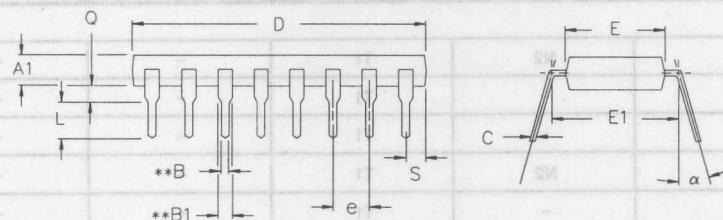
## Package Availability

PART NUMBER	PLCC	PGA	PLASTIC DIP	SOIC
MULTIPLIERS				
HMU16/17	N2	T1	-	-
HMU16/883	-	T1	-	-
HMU17/883	-	T1	-	-
HMA510	N2	T1	-	-
HMA510/883	-	T1	-	-
ONE DIMENSIONAL FILTERS				
HSP43168	N3	T2	-	-
HSP43168/883	-	T2	-	-
HSP43220	N3	T2	-	-
HSP43220/883	-	T2	-	-
HSP43481	N2	T1	-	-
HSP43481/883	-	T1	-	-
HSP43881	N3	T3	-	-
HSP43881/883	-	T3	-	-
HSP43891	N3	T3	-	-
HSP43891/883	-	T3	-	-
TWO DIMENSIONAL FILTERS				
HSP48901	N2	T1	-	-
HSP48908	N3	T2	-	-
HSP48908/883	-	T2	-	-
SIGNAL SYNTHESIZERS				
HSP45102	-	-	E2	M1
HSP45106	N3	T3	-	-
HSP45106/883	-	T3	-	-
HSP45116	-	T4	-	-
HSP45116/883	-	T4	-	-
SPECIAL FUNCTION				
HSP45240	N2	T1	-	-
HSP45240/883	-	T1	-	-
HSP45256	N3	T3	-	-
HSP45256/883	-	T3	-	-
HSP48410	N3	T2	-	-
HSP9501	N1	-	-	-
HSP9520/21	-	-	E1	M2
ISP9520/21	-	-	E1	-

# Package Outlines

E1 E2

## PLASTIC DUAL-IN-LINE



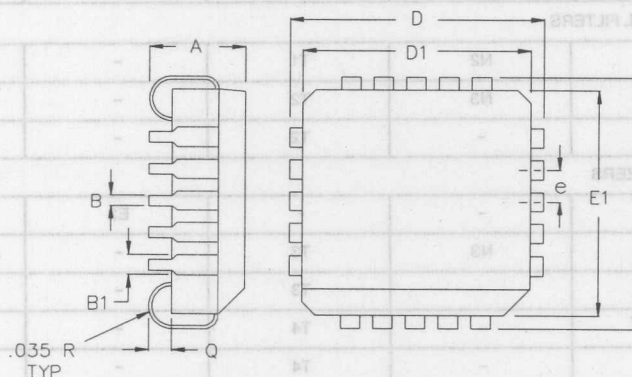
PKG CODE	LEAD COUNT	DIM A1	DIM B*	DIM B1*	DIM C*	DIM D	DIM E	DIM E1	DIM e	DIM L	DIM S	DIM Q	DIM α	JEDEC OUTLINE
E1	24	.130	.016	.050	.008	1.22	.255	.270	.100	.115	.060	.015	0°	MS001AF
	300	.145	.023	.070	.015	1.26	.275	.315	BSC	.150	.080	.040	15°	
E2	28	.145	.016	.050	.008	1.44	.540	.590	.100	.115	.070	.015	0°	MS011AB
	600	.160	.023	.070	.015	1.48	.560	.610	BSC	.150	.090	.040	15°	

\*Solder DIP Finish Add +0.003 Inches

NOTE: All Dimensions Are  $\frac{\text{Min}}{\text{Max}}$ , Dimensions Are In Inches.

N1 N2 N3

## PLASTIC LEADED CHIP CARRIER - ALL LEAD COUNTS

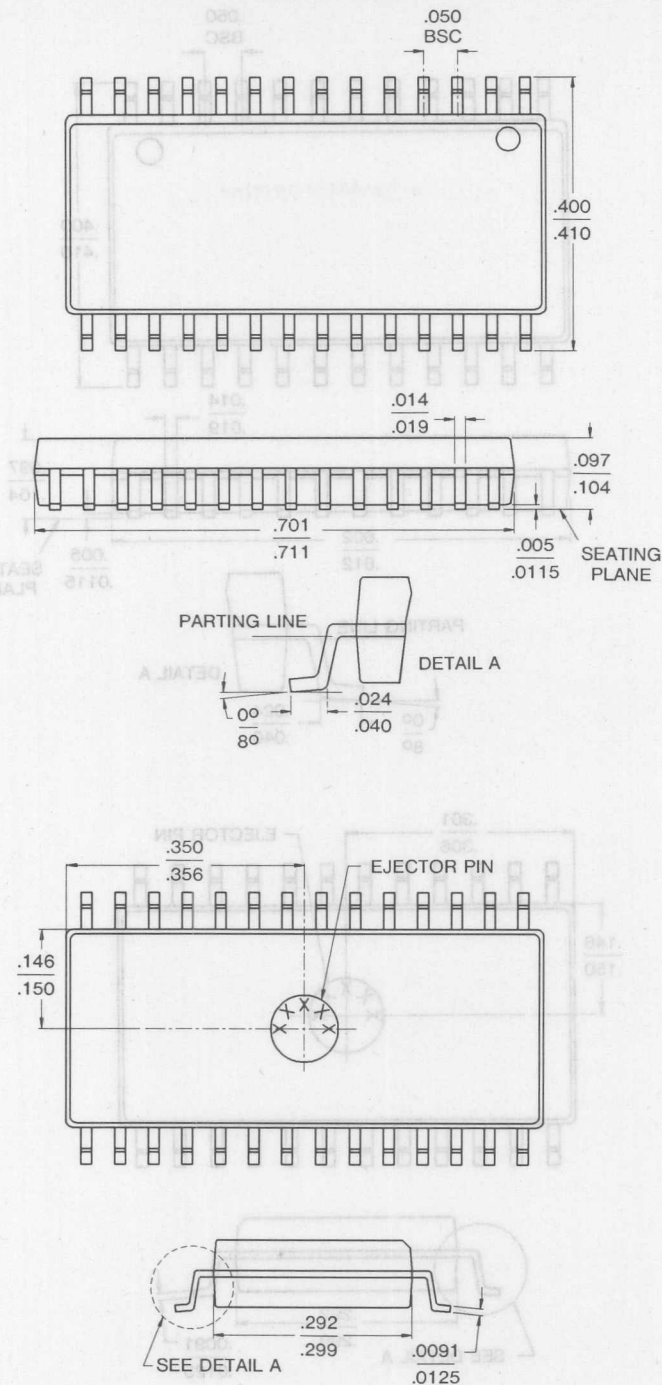


PKG CODE	LEAD COUNT	DIM A	DIM B	DIM B1	DIM D/E	DIM D1/E1	DIM E	DIM Q	JEDEC OUTLINE MO47XX
N1	44	.165	.013	.026	.685	.650	.050	.020	AC
		.180	.021	.032	.695	.656	BSC	-	
N2	68	.165	.013	.026	.985	.950	.050	.020	AE
		.200	.021	.032	.995	.958	BSC	-	
N3	84	.165	.013	.026	1.185	1.150	.050	.020	AF
		.200	.021	.032	1.195	1.158	BSC	-	

NOTE: All Dimensions Are  $\frac{\text{Min}}{\text{Max}}$ , Dimensions Are In Inches.

# Package Outlines

M1 SOIC

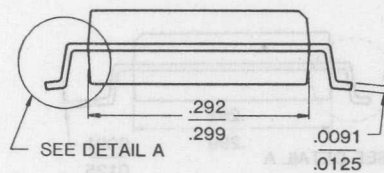
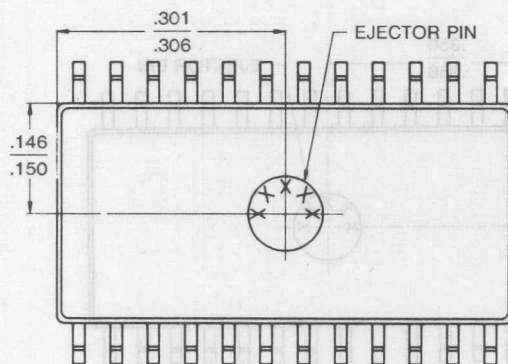
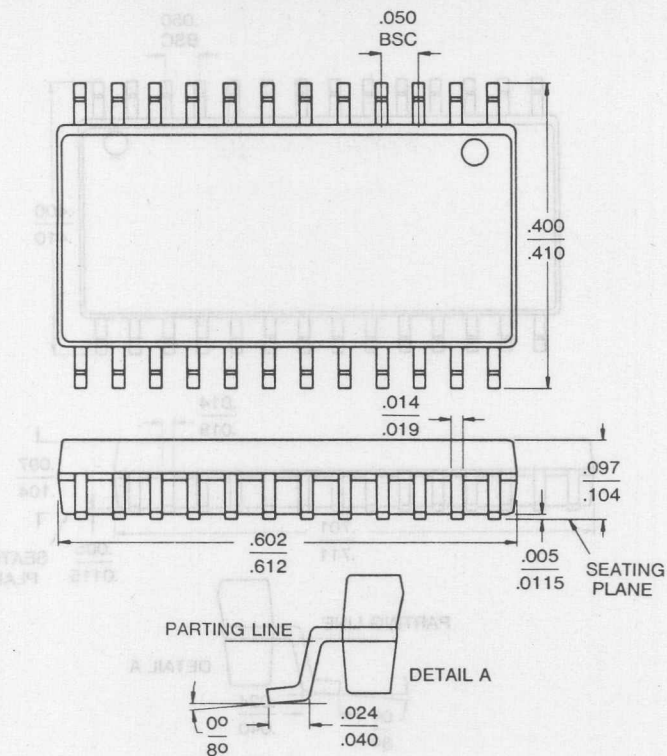


NOTE: All Dimensions Are  $\frac{\text{Min}}{\text{Max}}$ , Dimensions Are In Inches.



# Package Outlines

M2 SOIC

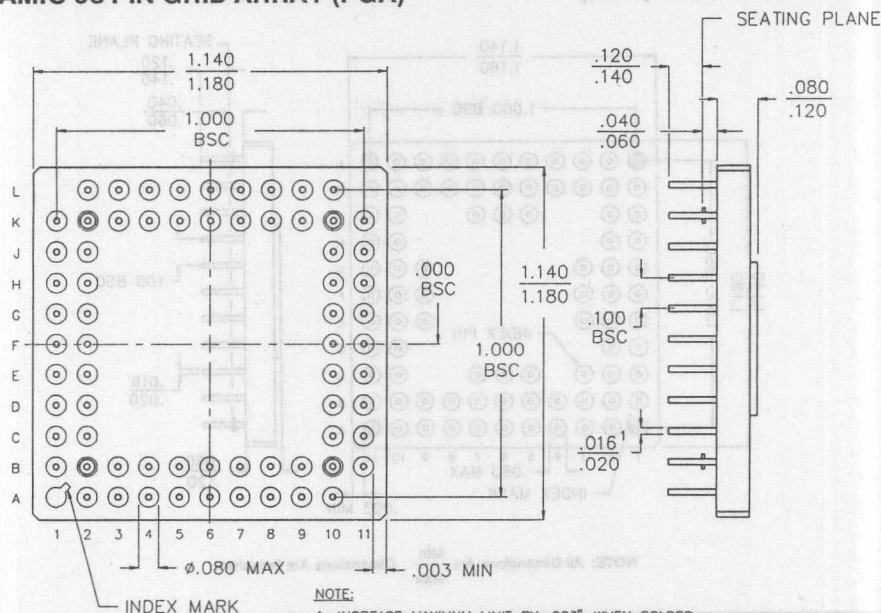


NOTE: All Dimensions Are  $\frac{\text{Min}}{\text{Max}}$ , Dimensions Are In Inches.

## Package Outlines

T1

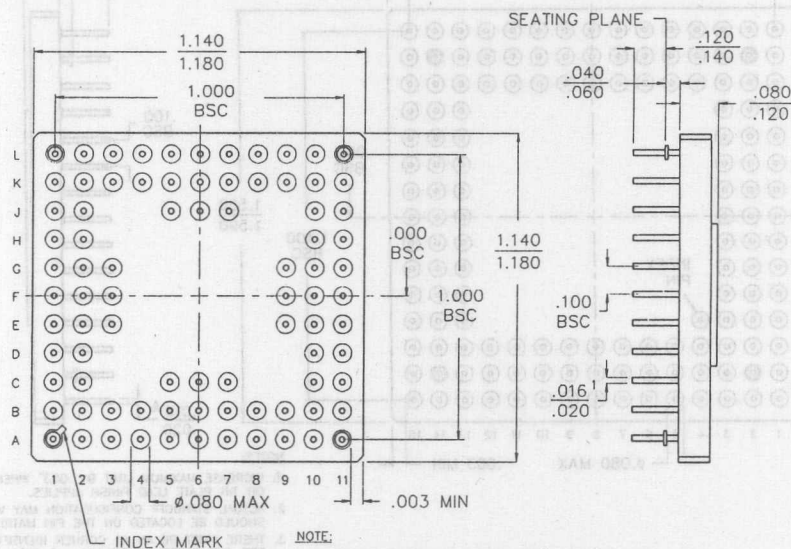
### CERAMIC 68 PIN GRID ARRAY (PGA)



NOTE: All Dimensions Are  $\frac{\text{Min}}{\text{Max}}$ , Dimensions Are In Inches.

T2

### 84 LEAD PIN GRID ARRAY (PGA)

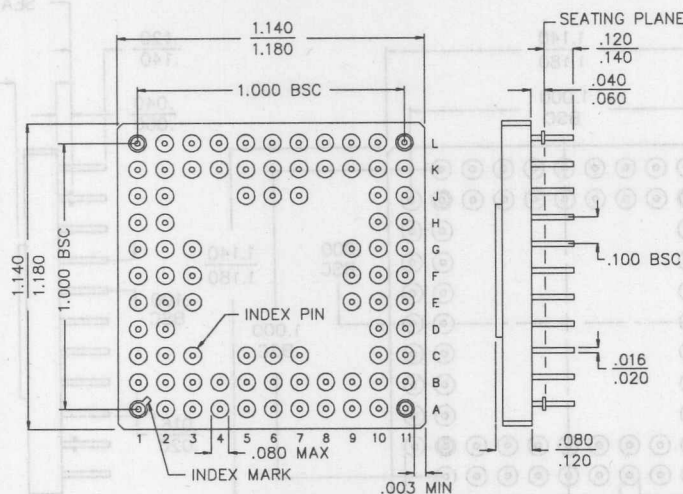


NOTE: All Dimensions Are  $\frac{\text{Min}}{\text{Max}}$ , Dimensions Are In Inches.

10  
PACKAGING AND  
ORDERING INFO

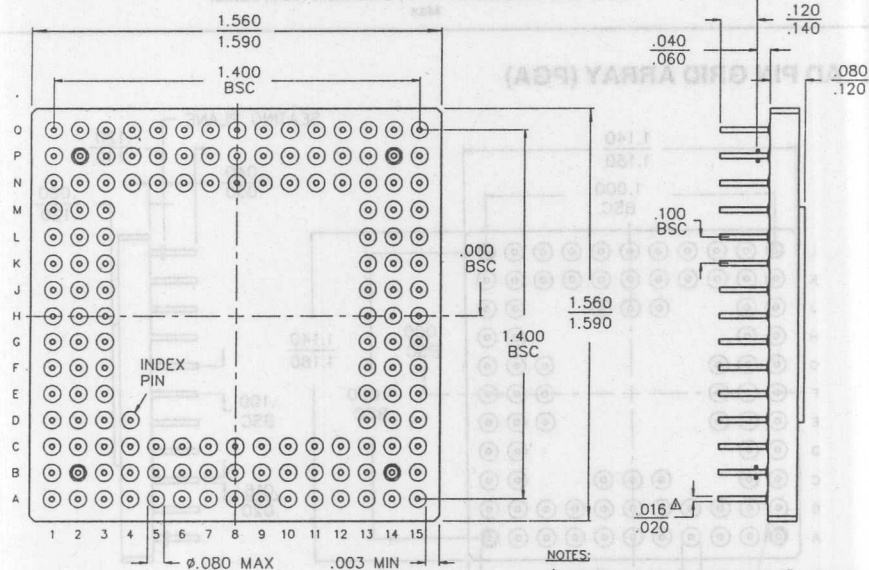
## Package Outlines

### T3 85 PIN GRID ARRAY (PGA)



NOTE: All Dimensions Are  $\frac{\text{Min}}{\text{Max}}$ , Dimensions Are In Inches.

### T4 145 PIN GRID ARRAY (PGA)



- NOTES:
1.  $\Delta$  INCREASE MAXIMUM LIMIT BY .003" WHEN SOLDER DIP OR TIN PLATE LEAD FINISH APPLIES.
  2. ACTUAL STANDOFF CONFIGURATION MAY VARY. STANDOFFS SHOULD BE LOCATED ON THE PIN MATRIX DIAGONALS.
  3. THERE MUST BE AN A1 CORNER IDENTIFIER ON BOTH TOP AND BOTTOM SURFACES. ID TYPE IS OPTIONAL AND MAY CONSIST OF NOTCHES, METALLIZED MARKINGS OR OTHER FEATURES.

NOTE: All Dimensions Are  $\frac{\text{Min}}{\text{Max}}$ , Dimensions Are In Inches.

## Ordering Information

### Product Code

Harris products are designated by a "Product Code". This code includes designators for the product family, device type, performance grade, temperature grade and package style. An example of the Product Code is shown below:

### HARRIS PRODUCT CODE EXAMPLE

**H SP 45116 G M -25 /883**

#### PREFIX:

H (Harris)

#### FAMILY:

SP (Signal Processing)  
MU (Multiplier)  
MA (Multiplier/Accumulator)

#### DEVICE TYPE:

#### PACKAGE:

G: PGA  
J: PLCC  
S, SX: SOIC  
P, PX: Plastic DIP

Processed in accordance to MIL-STD-883 and is fully compliant under the provisions of paragraph 1.2.1.

#### SPEED GRADE:

Indicates Maximum Clock Frequency, or for HMA/HMU, Maximum  $T_{MC}$

#### TEMPERATURE RANGE:

M: Military  
-55°C to +125°C  
C: Commercial  
0°C to +70°C  
I: Industrial  
-40°C to +85°C

For Valid Option Configurations, See Available Product Code, Next Page.



## Available Product Codes

DEVICE TYPE	PACKAGE	TEMPERATURE	SPEED	SCREENING
HMA510	J	C	-45,-55	
	G	C	-55	
	G	M	-55,-65,-75	/883
HMU16/17	J	C	-35,-45	
	G	C	-35,-45	
	G	M	-45,-60	/883
HSP43168	J	C	-33,-45	
	G	C	-33,-45	
	G	M	-25,-33	/883
HSP43220	J	C	-15,-25,-33	
	G	C	-15,-25,-33	
	G	M	-15,-25	/883
HSP43481	J	C	-20,-25,-30	
	G	C	-20,-25,-30	
	G	M	-20,-25	/883
HSP43881/891	J	C	-20,-25,-30	
	G	C	-20,-25,-30	
	G	M	-20,-25	/883
HSP45102	P	C	-33,-40	
	P	I	-33,-40	
	S	C	-33,-40	
	S	I	-33,-40	
HSP45106	J	C	-25,-33	
	G	C	-25,-33	
	G	M	-25	/883
HSP45116	G	C	-15,-25,-33	
	G	M	-15,-25	/883
HSP45240	J	C	-33,-40,-50	
	G	C	-33,-40,-50	
	G	M	-33,-40	/883
HSP45256	J	C	-25,-33	
	G	C	-25,-33	
	G	M	-20,-25	/883
HSP48410	J	C	-33,-40	
	G	C	-33,-40	
HSP48901	J	C	-20,-30	
	G	C	-20,-30	
HSP48908	J	C	-20,-32	
	G	C	-20,-32	
	G	M	-20,-27	/883
HSP9501	J	C	-25,-32	

DEVICE TYPE	TEMPERATURE	PACKAGE	SPEED	SCREENING
HSP9520/21	C	P, S		
ISP9520/21	C	PX		